

PHILIPS

Data handbook



Electronic
components
and materials

Semiconductors

Part 7 December 1980

Microminiature semiconductors

for hybrid circuits

SEMICONDUCTORS

PART 7 - DECEMBER 1980

MICROMINIATURE SEMICONDUCTORS FOR HYBRID CIRCUITS

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DEVICE DATA



DATA HANDBOOK SYSTEM

Our Data Handbook System is a comprehensive source of information on electronic components, sub-assemblies and materials; it is made up of four series of handbooks each comprising several parts.

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|--------------------------|--------|
| ELECTRON TUBES | BLUE |
| SEMICONDUCTORS | RED |
| INTEGRATED CIRCUITS | PURPLE |
| COMPONENTS AND MATERIALS | GREEN |

The several parts contain all pertinent data available at the time of publication, and each is revised and reissued periodically.

Where ratings or specifications differ from those published in the preceding edition they are pointed out by arrows. Where application information is given it is advisory and does not form part of the product specification.

If you need confirmation that the published data about any of our products are the latest available, please contact our representative. He is at your service and will be glad to answer your inquiries.

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ELECTRON TUBES (BLUE SERIES)

Starting in 1980, new part numbers and corresponding codes are being introduced. The former code of the preceding issue is given in brackets under the new code.

| | | | |
|---------|----------------|--------------------------|--|
| Part 1 | February 1980 | T1 02-80 (ET1a 12-75) | Tubes for r.f. heating |
| Part 2 | April 1980 | T2 04-80 (ET1b 08-77) | Transmitting tubes for communications |
| Part 2b | May 1978 | ET2b 05-78 | Microwave semiconductors and components Gunn, Impatt and noise diodes, mixer and detector diodes, backward diodes, varactor diodes, Gunn oscillators, sub-assemblies, circulators and isolators. |
| Part 3 | June 1980 | T3 06-80 (ET2a 11-77) | Klystrons, travelling-wave tubes, microwave diodes |
| Part 3 | January 1975 | ET3 01-75 | Special Quality tubes, miscellaneous devices |
| Part 4 | September 1980 | T4 09-80 (ET2a 11-77) | Magnetrons |
| Part 5a | October 1979 | ET5a 10-79 | Cathode-ray tubes Instrument tubes, monitor and display tubes, C.R. tubes for special applications. |
| Part 5b | December 1978 | ET5b 12-78 | Camera tubes and accessories, image intensifiers |
| Part 6 | July 1980 | T6 07-80 (ET6 01-77) | Geiger-Müller tubes |
| Part 7a | March 1977 | ET7a 03-77 | Gas-filled tubes Thyratrons, industrial rectifying tubes, ignitrons, high-voltage rectifying tubes. |
| Part 7b | May 1979 | ET7b 05-79 | Gas-filled tubes Segment indicator tubes, indicator tubes, switching diodes, dry reed contact units. |
| Part 8 | July 1979 | ET8 07-79 | Picture tubes and components Colour TV picture tubes, black and white TV picture tubes, monitor tubes, components for colour television, components for black and white television. |
| Part 9 | June 1980 | T9 06-80 (ET9 03-78) | Photo and electron multipliers Photomultiplier tubes, phototubes, single channel electron multipliers, channel electron multiplier plates. |

SEMICONDUCTORS (RED SERIES)

Starting in 1980, new part numbers and corresponding codes are being introduced. The former code of the preceding issue is given in brackets under the new code.

| | | | |
|---------|----------------|--|--|
| Part 1 | March 1980 | S1 03-80 (SC1b 05-77) | Diodes Small-signal germanium diodes, small-signal silicon diodes, special diodes, voltage regulator diodes (< 1,5 W), voltage reference diodes, tuner diodes, rectifier diodes |
| Part 2 | May 1980 | S2 05-80 (SC1a 08-78) | Power diodes, thyristors, triacs Rectifier diodes, voltage regulator diodes (> 1,5 W), rectifier stacks, thyristors, triacs |
| Part 2 | June 1979 | SC2 06-79 | Low-frequency power transistors |
| Part 3 | January 1978 | SC3 01-78 | High-frequency, switching and field-effect transistors* |
| Part 3 | April 1980 | S3 04-80 (SC2 11-77, partly) (SC3 01-78, partly) | Small-signal transistors |
| Part 4a | December 1978 | SC4a 12-78 | Transmitting transistors and modules |
| Part 4b | September 1978 | SC4b 09-78 | Devices for optoelectronics Photosensitive diodes and transistors, light-emitting diodes, photocouplers, infrared sensitive devices, photoconductive devices |
| Part 5 | October 1980 | S5 10-80 (SC3 01-78) | Field-effect transistors |
| Part 7 | December 1980 | S7 12-80 (SC4c 07-78) | Discrete semiconductors for hybrid circuits |

* Wideband transistors will be transferred to S10. The old book SC3 01-78 should be kept until then.

INTEGRATED CIRCUITS (PURPLE SERIES)

Starting in 1980, new part numbers and corresponding codes are being introduced. The former code of the preceding issue is given in brackets under the new code. Books with the purple cover will replace existing red covered editions as each is revised.

| | | | |
|--------------------------------------|----------------------|---|---|
| Part 1 | May 1980 | IC1 05-80 (SC5b 03-77) | Bipolar ICs for radio and audio equipment |
| Part 2 | May 1980 | IC2 05-80 (SC5b 03-77) | Bipolar ICs for video equipment |
| Part 5a | November 1976 | SC5a 11-76 | Professional analogue integrated circuits |
| Part 4 | October 1980 | IC4 10-80 (SC6 10-77) | Digital integrated circuits LOC MOS HE4000B family |
| Part 6b | August 1979 | SC6b 08-79 | ICs for digital systems in radio and television receivers |
| Signetics integrated circuits | | | Bipolar and MOS memories 1979 Bipolar and MOS microprocessors 1978 Analogue circuits 1979 Logic - TTL 1978 |

COMPONENTS AND MATERIALS (GREEN SERIES)

Starting in 1980, new part numbers and corresponding codes are being introduced. The former code of the preceding issue is given in brackets under the new code.

| | | | |
|---------|----------------|---------------------------|---|
| Part 1 | July 1979 | CM1 07-79 | Assemblies for industrial use PLC modules, high noise immunity logic FZ/30 series, NORbits 60-series, 61-series, 90-series, input devices, hybrid integrated circuits, peripheral devices |
| Part 3a | September 1978 | CM3a 09-78 | FM tuners, television tuners, surface acoustic wave filters |
| Part 3b | October 1978 | CM3b 10-78 | Loudspeakers |
| Part 4a | November 1978 | CM4a 11-78 | Soft Ferrites Ferrites for radio, audio and television, beads and chokes, Ferroxcube potcores and square cores, Ferroxcube transformer cores |
| Part 4b | February 1979 | CM4b 02-79 | Piezoelectric ceramics, permanent magnet materials |
| Part 6 | April 1977 | CM6 04-77 | Electric motors and accessories Small synchronous motors, stepper motors, miniature direct current motors |
| Part 7a | January 1979 | CM7a 01-79 | Assemblies Circuit blocks 40-series and CSA70 (L), counter modules 50-series, input/output devices |
| Part 8 | June 1979 | CM8 06-79 | Variable mains transformers |
| Part 9 | August 1979 | CM9 08-79 | Piezoelectric quartz devices Quartz crystal units, temperature compensated crystal oscillators |
| Part 10 | October 1980 | C10 10-80 | Connectors |
| Part 11 | December 1979 | CM11 12-79 | Non-linear resistors Voltage dependent resistors (VDR), light dependent resistors (LDR), negative temperature coefficient thermistors (NTC), positive temperature coefficient thermistors (PTC) |
| Part 12 | November 1979 | CM12 11-79 | Variable resistors and test switches |
| Part 13 | December 1979 | CM13 12-79 | Fixed resistors |
| Part 14 | April 1980 | C14 04-80 (CM2b 02-78) | Electrolytic and solid capacitors |
| Part 15 | May 1980 | C15 05-80 (CM2b 02-78) | Film capacitors, ceramic capacitors, variable capacitors |

SEMICONDUCTOR INDEX



INDEX OF TYPE NUMBERS

Data Handbooks S1 to S7

The inclusion of a type number in this publication does not necessarily imply its availability.

| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| AA119 | S1 | PC | BAS21 | S7 | Mm | BB110G | S1 | T |
| AAZ13 | S1 | GB | BAT17 | S7 | Mm | BB119 | S1 | T |
| AAZ15 | S1 | GB | BAT18 | S7 | Mm | BB204B | S1 | T |
| AAZ17 | S1 | GB | BAV10 | S1 | WD | BB204G | S1 | T |
| AAZ18 | S1 | GB | BAV18 | S1 | WD | BB212 | S1 | T |
| BA182 | S1 | T | BAV19 | S1 | WD | BB405B | S1 | T |
| BA220 | S1 | WD | BAV20 | S1 | WD | BB405G | S1 | T |
| BA221 | S1 | WD | BAV21 | S1 | WD | BBY31 | S7 | Mm |
| BA223 | S1 | T | BAV45 | S1 | Sp | BBY40 | S7 | Mm |
| BA243 | S1 | T | BAV70 | S7 | Mm | BC107 | S3 | Sm |
| BA244 | S1 | T | BAV99 | S7 | Mm | BC108 | S3 | Sm |
| BA280 | S1 | T | BAW56 | S7 | Mm | BC109 | S3 | Sm |
| BA314 | S1 | Vrg | BAW62 | S1 | WD | BC140 | S3 | Sm |
| BA315 | S1 | Vrg | BAX12 | S1 | WD | BC141 | S3 | Sm |
| BA316 | S1 | WD | BAX12A | S1 | WD | BC146 | S3 | Sm |
| BA317 | S1 | WD | BAX13 | S1 | WD | BC147 | S3 | Sm |
| BA318 | S1 | WD | BAX14A | S1 | WD | BC148 | S3 | Sm |
| BA379 | S1 | T | BAX16 | S1 | WD | BC149 | S3 | Sm |
| BA482 | S1 | T | BAX17 | S1 | WD | BC157 | S3 | Sm |
| BA483 | S1 | T | BAX18A | S1 | WD | BC158 | S3 | Sm |
| BAS11 | S1 | WD | BB105B | S1 | T | BC159 | S3 | Sm |
| BAS16 | S7 | Mm | BB105G | S1 | T | BC160 | S3 | Sm |
| BAS17 | S7 | Mm | BB106 | S1 | T | BC161 | S3 | Sm |
| BAS19 | S7 | Mm | BB109G | S1 | T | BC177 | S3 | Sm |
| BAS20 | S7 | Mm | BB110B | S1 | T | BC178 | S3 | Sm |

GB = Germanium gold bonded diodes
Mm = Microminiature semiconductors
for hybrid circuits
PC = Germanium point contact diodes

Sm = Small-signal transistors
Sp = Special diodes
T = Tuner diodes
Vrg = Voltage regulator diodes
WD = Silicon whiskerless diodes

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| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BC179 | S3 | Sm | BCW31;R | S7 | Mm | BD135 | SC2 | P |
| BC200 | S3 | Sm | BCW32;R | S7 | Mm | BD136 | SC2 | P |
| BC264A | S5 | FET | BCW33;R | S7 | Mm | BD137 | SC2 | P |
| BC264B | S5 | FET | BCW60* | S7 | Mm | BD138 | SC2 | P |
| BC264C | S5 | FET | BCW61* | S7 | Mm | BD139 | SC2 | P |
| | | | BCW69;R | S7 | Mm | | | |
| BC264D | S5 | FET | BCW70;R | S7 | Mm | BD140 | SC2 | P |
| BC327 | S3 | Sm | BCW71;R | S7 | Mm | BD181 | SC2 | P |
| BC328 | S3 | Sm | BCW72;R | S7 | Mm | BD182 | SC2 | P |
| BC337 | S3 | Sm | BCW81;R | S7 | Mm | BD183 | SC2 | P |
| BC338 | S3 | Sm | BCW89;R | S7 | Mm | BD201 | SC2 | P |
| | | | BCX17;R | S7 | Mm | | | |
| BC368 | S3 | Sm | BCX18;R | S7 | Mm | BD202 | SC2 | P |
| BC369 | S3 | Sm | BCX19;R | S7 | Mm | BD203 | SC2 | P |
| BC375 | S3 | Sm | BCX20;R | S7 | Mm | BD204 | SC2 | P |
| BC376 | S3 | Sm | BCX51 | S7 | Mm | BD226 | SC2 | P |
| BC546 | S3 | Sm | BCX52 | S7 | Mm | BD227 | SC2 | P |
| | | | BCX53 | S7 | Mm | | | |
| BC547 | S3 | Sm | BCX54 | S7 | Mm | BD228 | SC2 | P |
| BC548 | S3 | Sm | BCX55 | S7 | Mm | BD229 | SC2 | P |
| BC549 | S3 | Sm | BCX56 | S7 | Mm | BD230 | SC2 | P |
| BC550 | S3 | Sm | BCX70* | S7 | Mm | BD231 | SC2 | P |
| BC556 | S3 | Sm | BCX71* | S7 | Mm | BD232 | SC2 | P |
| | | | | | | | | |
| BC557 | S3 | Sm | BCY30A | S3 | Sm | BD233 | SC2 | P |
| BC558 | S3 | Sm | BCY31A | S3 | Sm | BD234 | SC2 | P |
| BC559 | S3 | Sm | BCY32A | S3 | Sm | BD235 | SC2 | P |
| BC560 | S3 | Sm | BCY33A | S3 | Sm | BD236 | SC2 | P |
| BC635 | S3 | Sm | BCY34A | S3 | Sm | BD237 | SC2 | P |
| | | | | | | | | |
| BC636 | S3 | Sm | BCY56 | S3 | Sm | BD238 | SC2 | P |
| BC637 | S3 | Sm | BCY57 | S3 | Sm | BD291 | SC2 | P |
| BC638 | S3 | Sm | BCY58 | S3 | Sm | BD292 | SC2 | P |
| BC639 | S3 | Sm | BCY59 | S3 | Sm | BD293 | SC2 | P |
| BC640 | S3 | Sm | BCY70 | S3 | Sm | BD294 | SC2 | P |
| | | | | | | | | |
| BCF29;R | S7 | Mm | BCY71 | S3 | Sm | BD295 | SC2 | P |
| BCF30;R | S7 | Mm | BCY72 | S3 | Sm | BD296 | SC2 | P |
| BCF32;R | S7 | Mm | BCY78 | S3 | Sm | BD329 | SC2 | P |
| BCF33;R | S7 | Mm | BCY79 | S3 | Sm | BD330 | SC2 | P |
| BCF70;R | S7 | Mm | BCY87 | S3 | Sm | BD331 | SC2 | P |
| | | | | | | | | |
| BCF81;R | S7 | Mm | BCY88 | S3 | Sm | BD332 | SC2 | P |
| BCV71;R | S7 | Mm | BCY89 | S3 | Sm | BD333 | SC2 | P |
| BCV72;R | S7 | Mm | BD131 | SC2 | P | BD334 | SC2 | P |
| BCW29;R | S7 | Mm | BD132 | SC2 | P | BD335 | SC2 | P |
| BCW30;R | S7 | Mm | BD133 | SC2 | P | BD336 | SC2 | P |

* = Series
FET = Field-effect transistors

Mm = Microminiature semiconductors
for hybrid circuits

| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BD337 | SC2 | P | BD947 | SC2 | P | BDX62A | SC2 | P |
| BD338 | SC2 | P | BD948 | SC2 | P | BDX62B | SC2 | P |
| BD433 | SC2 | P | BD949 | SC2 | P | BDX62C | SC2 | P |
| BD434 | SC2 | P | BD950 | SC2 | P | BDX63 | SC2 | P |
| BD435 | SC2 | P | BD951 | SC2 | P | BDX63A | SC2 | P |
| BD436 | SC2 | P | BD952 | SC2 | P | BDX63B | SC2 | P |
| BD437 | SC2 | P | BD953 | SC2 | P | BDX63C | SC2 | P |
| BD438 | SC2 | P | BD954 | SC2 | P | BDX64 | SC2 | P |
| BD645 | SC2 | P | BD955 | SC2 | P | BDX64A | SC2 | P |
| BD646 | SC2 | P | BD956 | SC2 | P | BDX64B | SC2 | P |
| BD647 | SC2 | P | BDT62 | SC2 | P | BDX64C | SC2 | P |
| BD648 | SC2 | P | BDT62A | SC2 | P | BDX65 | SC2 | P |
| BD649 | SC2 | P | BDT62B | SC2 | P | BDX65A | SC2 | P |
| BD650 | SC2 | P | BDT62C | SC2 | P | BDX65B | SC2 | P |
| BD651 | SC2 | P | BDT63 | SC2 | P | BDX65C | SC2 | P |
| BD652 | SC2 | P | BDT63A | SC2 | P | BDX66 | SC2 | P |
| BD675 | SC2 | P | BDT63B | SC2 | P | BDX66A | SC2 | P |
| BD676 | SC2 | P | BDT63C | SC2 | P | BDX66B | SC2 | P |
| BD677 | SC2 | P | BDT91 | SC2 | P | BDX66C | SC2 | P |
| BD678 | SC2 | P | BDT92 | SC2 | P | BDX67 | SC2 | P |
| BD679 | SC2 | P | BDT93 | SC2 | P | BDX67A | SC2 | P |
| BD680 | SC2 | P | BDT94 | SC2 | P | BDX67B | SC2 | P |
| BD681 | SC2 | P | BDT95 | SC2 | P | BDX67C | SC2 | P |
| BD682 | SC2 | P | BDT96 | SC2 | P | BDX77 | SC2 | P |
| BD683 | SC2 | P | BDV64 | SC2 | P | BDX78 | SC2 | P |
| BD684 | SC2 | P | BDV64A | SC2 | P | BDX91 | SC2 | P |
| BD933 | SC2 | P | BDV64B | SC2 | P | BDX92 | SC2 | P |
| BD934 | SC2 | P | BDV65 | SC2 | P | BDX93 | SC2 | P |
| BD935 | SC2 | P | BDV65A | SC2 | P | BDX94 | SC2 | P |
| BD936 | SC2 | P | BDV65B | SC2 | P | BDX95 | SC2 | P |
| BD937 | SC2 | P | BDX35 | SC2 | P | BDX96 | SC2 | P |
| BD938 | SC2 | P | BDX36 | SC2 | P | BDY20 | SC2 | P |
| BD939 | SC2 | P | BDX37 | SC2 | P | BDY90 | SC2 | P |
| BD940 | SC2 | P | BDX42 | SC2 | P | BDY91 | SC2 | P |
| BD941 | SC2 | P | BDX43 | SC2 | P | BDY92 | SC2 | P |
| BD942 | SC2 | P | BDX44 | SC2 | P | BDY93 | SC2 | P |
| BD943 | SC2 | P | BDX45 | SC2 | P | BDY94 | SC2 | P |
| BD944 | SC2 | P | BDX46 | SC2 | P | BDY96 | SC2 | P |
| BD945 | SC2 | P | BDX47 | SC2 | P | BDY97 | SC2 | P |
| BD946 | SC2 | P | BDX62 | SC2 | P | BF115 | S3 | Sm |

P = Low-frequency power transistors

Sm = Small-signal transistors

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| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BF180 | S3 | Sm | BF469 | SC2 | P | BFQ32 | SC3 | HFSW |
| BF181 | S3 | Sm | BF470 | SC2 | P | BFQ34 | SC3 | HFSW |
| BF182 | S3 | Sm | BF471 | SC2 | P | BFQ42 | 4a | Tra |
| BF183 | S3 | Sm | BF472 | SC2 | P | BFQ43 | 4a | Tra |
| BF194 | S3 | Sm | BF480 | S3 | Sm | BFR29 | S5 | FET |
| BF195 | S3 | Sm | BF494 | S3 | Sm | BFR30 | S7 | Mm |
| BF196 | S3 | Sm | BF495 | S3 | Sm | BFR31 | S7 | Mm |
| BF197 | S3 | Sm | BF496 | S3 | Sm | BFR49 | SC3 | HFSW |
| BF198 | S3 | Sm | BF510 | S7 | Mm | BFR53;R | S7 | Mm |
| BF199 | S3 | Sm | BF511 | S7 | Mm | BFR54 | S3 | Sm |
| BF200 | S3 | Sm | BF512 | S7 | Mm | BFR64 | SC3 | HFSW |
| BF240 | S3 | Sm | BF513 | S7 | Mm | BFR65 | SC3 | HFSW |
| BF241 | S3 | Sm | BF536 | S7 | Mm | BFR84 | S5 | FET |
| BF245A | S5 | FET | BF550;R | S7 | Mm | BFR90 | SC3 | HFSW |
| BF245B | S5 | FET | BF569 | S7 | Mm | BFR91 | SC3 | HFSW |
| BF245C | S5 | FET | BF579 | S7 | Mm | BFR92;R | S7 | Mm |
| BF246A | S5 | FET | BF622 | S7 | Mm | BFR93;R | S7 | Mm |
| BF246B | S5 | FET | BF623 | S7 | Mm | BFR94 | SC3 | HFSW |
| BF246C | S5 | FET | BF660;R | S7 | Mm | BFR95 | SC3 | HFSW |
| BF256A | S5 | FET | BF767 | S7 | Mm | BFR96 | SC3 | HFSW |
| BF256B | S5 | FET | BF926 | S3 | Sm | BFS17;R | S7 | Mm |
| BF256C | S5 | FET | BF936 | S3 | Sm | BFS18;R | S7 | Mm |
| BF324 | S3 | Sm | BF939 | S3 | Sm | BFS19;R | S7 | Mm |
| BF336 | S3 | Sm | BF960 | S5 | FET | BFS20;R | S7 | Mm |
| BF337 | S3 | Sm | BF967 | S3 | Sm | BFS21 | S5 | FET |
| BF338 | S3 | Sm | BF970 | S3 | Sm | BFS21A | S5 | FET |
| BF362 | S3 | Sm | BF979 | S3 | Sm | BFS22A | 4a | Tra |
| BF363 | S3 | Sm | BF981 | S5 | FET | BFS23A | 4a | Tra |
| BF410A | S5 | FET | BFQ10 | S5 | FET | BFS28 | S5 | FET |
| BF410B | S5 | FET | BFQ11 | S5 | FET | BFT24 | SC3 | HFSW |
| BF410C | S5 | FET | BFQ12 | S5 | FET | BFT25;R | S7 | Mm |
| BF410D | S5 | FET | BFQ13 | S5 | FET | BFT44 | S3 | Sm |
| BF419 | SC2 | P | BFQ14 | S5 | FET | BFT45 | S3 | Sm |
| BF422 | S3 | Sm | BFQ15 | S5 | FET | BFT46 | S7 | Mm |
| BF423 | S3 | Sm | BFQ16 | S5 | FET | BFT92;R | S7 | Mm |
| BF450 | S3 | Sm | BFQ17 | S7 | Mm | BFT93;R | S7 | Mm |
| BF451 | S3 | Sm | BFQ18A | S7 | Mm | BFW10 | S5 | FET |
| BF457 | SC2 | P | BFQ19 | S7 | Mm | BFW11 | S5 | FET |
| BF458 | SC2 | P | BFQ23 | SC3 | HFSW | BFW12 | S5 | FET |
| BF459 | SC2 | P | BFQ24 | SC3 | HFSW | BFW13 | S5 | FET |

FET = Field-effect transistors
HFSW = High-frequency and switching transistors

Mm = Microminiature semiconductors
for hybrid circuits

P = Low-frequency power transistors

| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BFW16A | SC3 | HFSW | BLW60C | 4a | Tra | BLY89C | 4a | Tra |
| BFW17A | SC3 | HFSW | BLW64 | 4a | Tra | BLY90 | 4a | Tra |
| BFW30 | SC3 | HFSW | BLW75 | 4a | Tra | BLY91A | 4a | Tra |
| BFW45 | SC3 | HFSW | BLW76 | 4a | Tra | BLY91C | 4a | Tra |
| BFW61 | S5 | FET | BLW77 | 4a | Tra | BLY92A | 4a | Tra |
| BFW92 | SC3 | HFSW | BLW78 | 4a | Tra | BLY92C | 4a | Tra |
| BFW93 | SC3 | HFSW | BLW79 | 4a | Tra | BLY93A | 4a | Tra |
| BFX29 | S3 | Sm | BLW80 | 4a | Tra | BLY93C | 4a | Tra |
| BFX30 | S3 | Sm | BLW81 | 4a | Tra | BLY94 | 4a | Tra |
| BFX34 | S3 | Sm | BLW82 | 4a | Tra | BPW22 | 4b | PDT |
| BFX84 | S3 | Sm | BLW83 | 4a | Tra | BPW34 | 4b | PDT |
| BFX85 | S3 | Sm | BLW84 | 4a | Tra | BPX25 | 4b | PDT |
| BFX86 | S3 | Sm | BLW85 | 4a | Tra | BPX29 | 4b | PDT |
| BFX87 | S3 | Sm | BLW86 | 4a | Tra | BPX40 | 4b | PDT |
| BFX88 | S3 | Sm | BLW87 | 4a | Tra | BPX41 | 4b | PDT |
| BFX89 | SC3 | HFSW | BLW95 | 4a | Tra | BPX42 | 4b | PDT |
| BFY50 | S3 | Sm | BLW98 | 4a | Tra | BPX47A | 4b | PDT |
| BFY51 | S3 | Sm | BLX13 | 4a | Tra | BPX70 | 4b | PDT |
| BFY52 | S3 | Sm | BLX13C | 4a | Tra | BPX71 | 4b | PDT |
| BFY55 | S3 | Sm | BLX14 | 4a | Tra | BPX72 | 4b | PDT |
| BFY90 | SC3 | HFSW | BLX15 | 4a | Tra | BPX94 | 4b | PDT |
| BGY22 | 4a | Tra | BLX39 | 4a | Tra | BPX95B | 4b | PDT |
| BGY22A | 4a | Tra | BLX65 | 4a | Tra | BR100/03 | S2 | Th |
| BGY23 | 4a | Tra | BLX66 | 4a | Tra | BR101 | S3 | Sm |
| BGY23A | 4a | Tra | BLX67 | 4a | Tra | BRY39P | S3 | Sm |
| BGY32 | 4a | Tra | BLX68 | 4a | Tra | BRY39S | S3 | Sm |
| BGY33 | 4a | Tra | BLX69A | 4a | Tra | BRY39T | S2 | Th |
| BGY35 | 4a | Tra | BLX91A | 4a | Tra | BRY39T | S3 | Sm |
| BGY36 | 4a | Tra | BLX92A | 4a | Tra | BRY56 | S3 | Sm |
| BGY37 | SC3 | HFSW | BLX93A | 4a | Tra | BRY61 | S7 | Mm |
| BLV10 | 4a | Tra | BLX94A | 4a | Tra | BSR12;R | S7 | Mm |
| BLV11 | 4a | Tra | BLX95 | 4a | Tra | BSR13;R | S7 | Mm |
| BLV20 | 4a | Tra | BLX96 | 4a | Tra | BSR14;R | S7 | Mm |
| BLV21 | 4a | Tra | BLX97 | 4a | Tra | BSR15;R | S7 | Mm |
| BLW29 | 4a | Tra | BLX98 | 4a | Tra | BSR16;R | S7 | Mm |
| BLW31 | 4a | Tra | BLY87A | 4a | Tra | BSR17;R | S7 | Mm |
| BLW32 | 4a | Tra | BLY87C | 4a | Tra | BSR30 | S7 | Mm |
| BLW33 | 4a | Tra | BLY88A | 4a | Tra | BSR31 | S7 | Mm |
| BLW34 | 4a | Tra | BLY88C | 4a | Tra | BSR32 | S7 | Mm |
| BLW60 | 4a | Tra | BLY89A | 4a | Tra | | | |

PDT = Photodiodes or transistors
 Sm = Small-signal transistors

Th = Thyristors
 Tra = Transmitting transistors and modules

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| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BSR33 | S7 | Mm | BSX46 | S3 | Sm | BU209A | SC2 | P |
| BSR40 | S7 | Mm | BSX47 | S3 | Sm | BU326 | SC2 | P |
| BSR41 | S7 | Mm | BSX59 | S3 | Sm | BU326A | SC2 | P |
| BSR42 | S7 | Mm | BSX60 | S3 | Sm | BU426 | SC2 | P |
| BSR43 | S7 | Mm | BSX61 | S3 | Sm | BU426A | SC2 | P |
| BSR50 | S3 | Sm | BSY95A | S3 | Sm | BU433 | SC2 | P |
| BSR51 | S3 | Sm | BT136 * | S2 | Tri | BUW84 | SC2 | P |
| BSR52 | S3 | Sm | BT137 * | S2 | Tri | BUW85 | SC2 | P |
| BSR56 | S7 | Mm | BT138 * | S2 | Tri | BUX80 | SC2 | P |
| BSR57 | S7 | Mm | BT139 * | S2 | Tri | BUX81 | SC2 | P |
| BSR58 | S7 | Mm | BT151 * | S2 | Th | BUX82 | SC2 | P |
| BSR60 | S3 | Sm | BT152 * | S2 | Th | BUX83 | SC2 | P |
| BSR61 | S3 | Sm | BT153 | S2 | Th | BUX84 | SC2 | P |
| BSR62 | S3 | Sm | BT154 | S2 | Th | BUX85 | SC2 | P |
| BSS38 | S3 | Sm | BTW23 * | S2 | Th | BUX86 | SC2 | P |
| BSS50 | S3 | Sm | BTW24 * | S2 | Th | BUX87 | SC2 | P |
| BSS51 | S3 | Sm | BTW30S* | S2 | Th | BY126M | S1 | R |
| BSS52 | S3 | Sm | BTW31W* | S2 | Th | BY127M | S1 | R |
| BSS60 | S3 | Sm | BTW33 * | S2 | Th | BY164 | S2 | R |
| BSS61 | S3 | Sm | BTW34 * | S2 | Tri | BY179 | S2 | R |
| BSS62 | S3 | Sm | BTW38 * | S2 | Th | BY184 | S1 | R |
| BSS63;R | S7 | Mm | BTW40 * | S2 | Th | BY206 | S1 | R |
| BSS64;R | S7 | Mm | BTW41 * | S2 | Tri | BY207 | S1 | R |
| BSS68 | S3 | Sm | BTW42 * | S2 | Th | BY208 * | S1 | R |
| BSV15 | S3 | Sm | BTW43 * | S2 | Tri | BY210 | S1 | R |
| BSV16 | S3 | Sm | BTW45 * | S2 | Th | BY223 | S2 | R |
| BSV17 | S3 | Sm | BTW47 * | S2 | Th | BY224 * | S2 | R |
| BSV52;R | S7 | Mm | BTW92 * | S2 | Th | BY225 * | S2 | R |
| BSV64 | S3 | Sm | BTX18 * | S2 | Th | BY226 | S1 | R |
| BSV78 | S5 | FET | BTX94 * | S2 | Tri | BY227 | S1 | R |
| BSV79 | S5 | FET | BTY79 * | S2 | Th | BY228 | S1 | R |
| BSV80 | S5 | FET | BTY87 * | S2 | Th | BY229 * | S2 | R |
| BSV81 | S5 | FET | BTY91 * | S2 | Th | BY256 | S2 | R |
| BSW66A | S3 | Sm | BU126 | SC2 | P | BY257 | S2 | R |
| BSW67A | S3 | Sm | BU133 | SC2 | P | BY260 * | S2 | R |
| BSW68A | S3 | Sm | BU204 | SC2 | P | BY261 * | S2 | R |
| BSX19 | S3 | Sm | BU205 | SC2 | P | BY277 * | S2 | R |
| BSX20 | S3 | Sm | BU206 | SC2 | P | BY409 | S1 | R |
| BSX21 | S3 | Sm | BU207A | SC2 | P | BY409A | S1 | R |
| BSX45 | S3 | Sm | BU208A | SC2 | P | BY438 | S1 | R |

* = series

FET = Field-effect transistors

GB = Germanium gold bonded diodes

I = Infrared devices

LED = Light-emitting diodes

Mm = Microminiature semiconductors
for hybrid circuits

P = Low-frequency power transistors

PC = Germanium point contact diodes

Ph = Photoconductive devices

| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| BY448 | S1 | R | BYX55 * | S1 | R | CNY42 | 4b | PhC |
| BY458 | S1 | R | BYX56 * | S2 | R | CNY43 | 4b | PhC |
| BY476 | S1 | R | BYX71 * | S2 | R | CNY44 | 4b | PhC |
| BY477 | S1 | R | BYX90 | S1 | R | CNY46 | 4b | PhC |
| BY478 | S1 | R | BYX91 * | S1 | R | CNY47 | 4b | PhC |
| BY509 | S1 | R | BYX94 | S1 | R | CNY47A | 4b | PhC |
| BYV21 * | S2 | R | BYX96 * | S2 | R | CNY48 | 4b | PhC |
| BYV30 * | S2 | R | BYX97 * | S2 | R | CQY 11B | 4b | LED |
| BYV92 * | S2 | R | BYX98 * | S2 | R | CQY 11C | 4b | LED |
| BYV95A | S1 | R | BYX99 * | S2 | R | CQY24A | 4b | LED |
| BYV95B | S1 | R | BZV10 | S1 | Vrf | CQY46A | 4b | LED |
| BYV95C | S1 | R | BZV11 | S1 | Vrf | CQY47A | 4b | LED |
| BYV96D,E | S1 | R | BZV12 | S1 | Vrf | CQY49B | 4b | LED |
| BYW19* | S2 | R | BZV13 | S1 | Vrf | CQY49C | 4b | LED |
| BYW25 | S2 | R | BZV14 | S1 | Vrf | CQY50 | 4b | LED |
| BYW29 * | S2 | R | BZV15 * | S2 | Vrg | CQY52 | 4b | LED |
| BYW30 * | S2 | R | BZV46 | S1 | Vrg | CQY54 | 4b | LED |
| BYW31 * | S2 | R | BZV85 | S1 | Vrg | CQY58 | 4b | LED |
| BYW54 | S1 | R | BZW10 | S2 | TS | CQY88 | 4b | LED |
| BYW55 | S1 | R | BZW70 * | S2 | TS | CQY89 | 4b | LED |
| BYW56 | S1 | R | BZW86 * | S2 | TS | CQY94 | 4b | LED |
| BYW92 * | S2 | R | BZW91 * | S2 | TS | CQY95 | 4b | LED |
| BYW95A | S1 | R | BZX61 * | S1 | Vrg | CQY96 | 4b | LED |
| BYW95B | S1 | R | BZX70 * | S2 | Vrg | CQY97 | 4b | LED |
| BYW95C | S1 | R | BZX78 * | S7 | Mm | OA47 | S1 | GB |
| BYW96D,E | S1 | R | BZX79 * | S1 | Vrg | OA90 | S1 | PC |
| BYX10 | S1 | R | BZX84 * | S7 | Mm | OA91 | S1 | PC |
| BYX22 * | S2 | R | BZX87 * | S1 | Vrg | OA95 | S1 | PC |
| BYX25 * | S2 | R | BZX90 | S1 | Vrf | OA200 | S1 | WD |
| BYX30 * | S2 | R | BZX91 | S1 | Vrf | OA202 | S1 | WD |
| BYX32 * | S2 | R | BZX92 | S1 | Vrf | OM931 | SC2 | P |
| BYX36 * | S1 | R | BZX93 | S1 | Vrf | OM961 | SC2 | P |
| BYX38 * | S2 | R | BZX94 | S1 | Vrf | ORP10 | 4b | I |
| BYX39 * | S2 | R | BZY88 * | S1 | Vrg | ORP13 | 4b | I |
| BYX42 * | S2 | R | BZY91 * | S2 | Vrg | ORP23 | 4b | Ph |
| BYX45 * | S2 | R | BZY93 * | S2 | Vrg | ORP52 | 4b | Ph |
| BYX46 * | S2 | R | BZY95 * | S2 | Vrg | ORP60 | 4b | Ph |
| BYX49 * | S2 | R | BZY96 * | S2 | Vrg | ORP61 | 4b | Ph |
| BYX50 * | S2 | R | CNY22 | 4b | PhC | ORP62 | 4b | Ph |
| BYX52 * | S2 | R | CNY23 | 4b | PhC | ORP66 | 4b | Ph |

PhC = Photocouplers
 R = Rectifier diodes
 Sm = Small-signal transistors
 St = Rectifier stacks
 Th = Thyristors

Tri = Triacs
 TS = Transient suppressor diodes
 Vrf = Voltage reference diodes
 Vrg = Voltage regulator diodes
 WD = Silicon whiskerless diodes

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| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|------|---------|----------|------|---------|
| ORP68 | 4b | Ph | SD306 | S5 | FET | 2N1613 | S3 | Sm |
| ORP69 | 4b | Ph | 1N821 | S1 | Vrf | 2N1711 | S3 | Sm |
| OSB9110 | S2 | St | 1N823 | S1 | Vrf | 2N1893 | S3 | Sm |
| OSB9210 | S2 | St | 1N825 | S1 | Vrf | 2N2218 | S3 | Sm |
| OSB9310 | S2 | St | 1N827 | S1 | Vrf | 2N2218A | S3 | Sm |
| OSB9410 | S2 | St | 1N829 | S1 | Vrf | 2N2219 | S3 | Sm |
| OSM9110 | S2 | St | 1N914 | S1 | WD | 2N2219A | S3 | Sm |
| OSM9210 | S2 | St | 1N916 | S1 | WD | 2N2221 | S3 | Sm |
| OSM9310 | S2 | St | 1N3879 | S2 | R | 2N2221A | S3 | Sm |
| OSM9410 | S2 | St | 1N3880 | S2 | R | 2N2222 | S3 | Sm |
| OSM9510 | S2 | St | 1N3881 | S2 | R | 2N2222A | S3 | Sm |
| OSM9511 | S2 | St | 1N3882 | S2 | R | 2N2297 | S3 | Sm |
| OSM9512 | S2 | St | 1N3889 | S2 | R | 2N2368 | S3 | Sm |
| OSS9110 | S2 | St | 1N3890 | S2 | R | 2N2369 | S3 | Sm |
| OSS9210 | S2 | St | 1N3891 | S2 | R | 2N2369A | S3 | Sm |
| OSS9310 | S2 | St | 1N3892 | S2 | R | 2N2483 | S3 | Sm |
| OSS9410 | S2 | St | 1N3899 | S2 | R | 2N2484 | S3 | Sm |
| PH2369 | S3 | Sm | 1N3900 | S2 | R | 2N2904 | S3 | Sm |
| RPY58A | 4b | Ph | 1N3901 | S2 | R | 2N2904A | S3 | Sm |
| RPY71 | 4b | Ph | 1N3902 | S2 | R | 2N2905 | S3 | Sm |
| RPY76A | 4b | I | 1N3903 | S2 | R | 2N2905A | S3 | Sm |
| RPY82 | 4b | Ph | 1N3909 | S2 | R | 2N2906 | S3 | Sm |
| RPY84 | 4b | Ph | 1N3910 | S2 | R | 2N2906A | S3 | Sm |
| RPY85 | 4b | Ph | 1N3911 | S2 | R | 2N2907 | S3 | Sm |
| RPY86 | 4b | I | 1N3912 | S2 | R | 2N2907A | S3 | Sm |
| RPY87 | 4b | I | 1N3913 | S2 | R | 2N3019 | S3 | Sm |
| RPY88 | 4b | I | 1N4001 | | | 2N3020 | S3 | Sm |
| RPY89 | 4b | I | to 4007 | S1 | R | 2N3053 | S3 | Sm |
| SD205 | S5 | FET | 1N4148 | S1 | WD | 2N3055 | SC2 | P |
| SD210 | S5 | FET | 1N4150 | S1 | WD | 2N3375 | 4a | Tra |
| SD211 | S5 | FET | 1N4151 | S1 | WD | 2N3439 | S3 | Sm |
| SD212 | S5 | FET | 1N4154 | S1 | WD | 2N3440 | S3 | Sm |
| SD213 | S5 | FET | 1N4446 | S1 | WD | 2N3442 | SC2 | P |
| SD214 | S5 | FET | 1N4448 | S1 | WD | 2N3553 | 4a | Tra |
| SD215 | S5 | FET | 1N5060 | S1 | R | 2N3632 | 4a | Tra |
| SD217 | S5 | FET | 1N5061 | S1 | R | 2N3822 | S5 | FET |
| SD220 | S5 | FET | 1N5062 | S1 | R | 2N3823 | S5 | FET |
| SD222 | S5 | FET | 2N918 | SC3 | HFSW | 2N3866 | 4a | Tra |
| SD226 | S5 | FET | 2N929 | S3 | Sm | 2N3903 | S3 | Sm |
| SD304 | S5 | FET | 2N930 | S3 | Sm | 2N3904 | S3 | Sm |

A = Accessories
 DH = Diecast heatsinks
 FET = Field-effect transistors

HE = Heatsink extrusions
 HFSW = High-frequency and switching transistors
 I = Infrared devices

| type no. | part | section | type no. | part | section | type no. | part | section |
|----------|------|---------|----------|-------|---------|----------|--------|---------|
| 2N3924 | 4a | Tra | 56230 | S2 | HE | 56348 | S2 | DH |
| 2N3926 | 4a | Tra | 56231 | S2 | HE | 56349 | S2 | DH |
| 2N3927 | 4a | Tra | 56233 | S2 | A | 56350 | S2 | DH |
| 2N3966 | S5 | FET | 56234 | S2 | A | 56352 | SC2 | A |
| 2N4030 | S3 | Sm | 56245 | S3,4a | A | 56353 | SC2 | A |
| 2N4031 | S3 | Sm | 56246 | S2,S3 | A | 56354 | SC2 | A |
| 2N4032 | S3 | Sm | 56253 | S2 | DH | 56359b | SC2 | A |
| 2N4033 | S3 | Sm | 56256 | S2 | DH | 56359c | SC2 | A |
| 2N4091 | S5 | FET | 56261a | SC2 | A | 56359d | SC2 | A |
| 2N4092 | S5 | FET | 56262A | S2 | A | 56360a | SC2 | A |
| 2N4093 | S5 | FET | 56264A | S2 | A | 56363 | S2,SC2 | A |
| 2N4123 | S3 | Sm | 56268 | S2 | DH | 56364 | S2,SC2 | A |
| 2N4124 | S3 | Sm | 56271 | S2 | DH | 56366 | S2 | A |
| 2N4347 | SC2 | P | 56278 | S2 | DH | 56367 | S2,SC2 | A |
| 2N4391 | S5 | FET | 56280 | S2 | DH | 56368a | SC2 | A |
| 2N4392 | S5 | FET | 56290 | S2 | HE | 56368b | SC2 | A |
| 2N4393 | S5 | FET | 56293 | S2 | HE | 56369 | S2,SC2 | A |
| 2N4427 | 4a | Tra | 56295 | S2 | A | 56378 | SC2 | A |
| 2N4856 | S5 | FET | 56312 | S2 | DH | 56379 | SC2 | A |
| 2N4857 | S5 | FET | 56313 | S2 | DH | | | |
| 2N4858 | S5 | FET | 56314 | S2 | DH | | | |
| 2N4859 | S5 | FET | 56315 | S2 | DH | | | |
| 2N4860 | S5 | FET | 56316 | S2 | A | | | |
| 2N4861 | S5 | FET | 56317 | S2 | A | | | |
| 2N5415 | S3 | Sm | 56318 | S2 | DH | | | |
| 2N5416 | S3 | Sm | 56319 | S2 | DH | | | |
| 61SV | 4b | I | 56326 | SC2 | A | | | |
| 56201c | SC2 | A | 56333 | SC2 | A | | | |
| 56201d | SC2 | A | 56334 | S2 | DH | | | |
| 56201j | SC2 | A | 56339 | SC2 | A | | | |

P = Low-frequency power transistors
 Ph = Photoconductive devices
 R = Rectifier diodes
 Sm = Small-signal transistors

St = Rectifier stacks
 Tra = Transmitting transistors and modules
 Vrf = Voltage reference diodes
 WD = Silicon whiskerless diodes

SELECTION GUIDE



GENERAL PURPOSE TRANSISTORS in SOT-23/SOT-89*

| type | RATINGS | | | | h_{FE} | | V_{CEsat} | | f_T typ. MHz |
|--------------|----------------|----------------|-------------|-----------------|-----------------------------------|------------------------|-------------|---------|----------------------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at I_C/V_{CE} mA/V | max. at I_C/I_B V | mA | | |
| P-N-P | | | | | | | | | |
| BCW29;R | 32 | 32 | 100 | 350 | 120/260 | 2/5 | 0,30 | 10/0,5 | 150 |
| BCW30;R | | | | | 215/500 | | | | |
| BCW61A | 32 | 32 | 200 | 150 | 120/220 | 2/5 | 0,25 | 10/0,25 | 180 |
| BCW61B | | | | | 180/310 | | | | |
| BCW61C | | | | | 250/460 | | | | |
| BCW61D | | | | | 380/630 | | | | |
| BCW69R | 50 | 45 | 100 | 350 | 120/260 | 2/5 | 0,30 | 10/0,5 | 150 |
| BCW70;R | | | | | 215/500 | | | | |
| BCW89;R | 80 | 60 | | | 120/260 | | | | |
| BCX17;R | 50 | 45 | 500 | 425 | 100/600 | 100/1 | 0,62 | 500/50 | 100 |
| BCX18;R | 30 | 25 | | | | | | | |
| BCX51* | 45 | 45 | 1000 | 1000 | 40/250 | 150/2 | 0,50 | 500/60 | 50 |
| BCX52* | 60 | 60 | | | 40/160 | | | | |
| BCX53* | 100 | 80 | | | 40/160 | | | | |
| BCX71G | 45 | 45 | 200 | 150 | 120/220 | 2/5 | 0,25 | 10/0,25 | 180 |
| BCX71H | | | | | 180/310 | | | | |
| BCX71J | | | | | 250/460 | | | | |
| BCX71K | | | | | 380/630 | | | | |
| N-P-N | | | | | | | | | |
| BCV71 | 80 | 60 | 100 | 350 | 110/220 | 2/5 | 0,25 | 10/0,5 | 300 |
| BCV72 | | | | | 200/450 | | | | |
| BCW31;R | 32 | 32 | 100 | 350 | 110/220 | 2/5 | 0,25 | 10/0,5 | 300 |
| BCW32;R | | | | | 200/450 | | | | |
| BCW33;R | | | | | 420/800 | | | | |
| BCW60A | 32 | 32 | 200 | 150 | 120/220 | 2/5 | 0,35 | 10/0,25 | 250 |
| BCW60B | | | | | 180/310 | | | | |
| BCW60C | | | | | 250/460 | | | | |
| BCW60D | | | | | 380/630 | | | | |
| BCW71;R | 50 | 45 | 100 | 350 | 110/220 | 2/5 | 0,25 | 10/0,5 | 300 |
| BCW72;R | | | | | 220/450 | | | | |
| BCW81;R | | | | | 420/800 | | | | |
| BCX19;R | 50 | 45 | 500 | 425 | 100/600 | 100/1 | 0,62 | 500/50 | 200 |
| BCX20;R | 30 | 25 | | | | | | | |
| BCX54* | 45 | 45 | 1000 | 1000 | 45/250 | 150/2 | 0,50 | 500/50 | 130 |
| BCX55* | 60 | 60 | | | 40/160 | | | | |
| BCX56* | 100 | 80 | | | 40/160 | | | | |
| BCX70G | 45 | 45 | 200 | 150 | 120/220 | 2/5 | 0,35 | 10/0,25 | 250 |
| BCX70H | | | | | 180/310 | | | | |
| BCX70J | | | | | 250/460 | | | | |
| BCX70K | | | | | 380/630 | | | | |

* Types in SOT-89 package are denoted by an asterisk (*).

SELECTION GUIDE

HIGH-FREQUENCY TRANSISTORS in SOT-23

| type | RATINGS | | | | h_{FE} | | F | | f_T | C_{re} |
|--------------|----------------|----------------|-------------|-----------------|--------------|----------------------|-----------|-----|-------------|------------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at | I_C/V_{CE} mA/V | typ. at f | MHz | typ. MHz | typ. pF |
| P-N-P | | | | | | | | | | |
| BF536 | 30 | 30 | 25 | 200 | 25/- | 1/10 | 5 | 200 | 350 | - |
| BF550;R | 40 | 40 | 25 | 200 | 50/- | 1/10 | 2 | 0,1 | 325 | 0,5 |
| BF569 | 40 | 35 | 30 | 200 | 25/- | 3/10 | 4,5 | 800 | 900 | 0,33 |
| BF579 | 20 | 20 | 25 | 150 | 20/- | 10/10 | 4,5 | 800 | 1350 | 0,46 |
| BF660 | 40 | 30 | 25 | 200 | 30/- | 3/10 | - | - | 650 | 0,65 |
| BF767 | 30 | 30 | 20 | 200 | 15/- | 3/10 | 4 | 800 | 900 | 0,3 |
| N-P-N | | | | | | | | | | |
| BFS18;R | 30 | 20 | 30 | 250 | 35/125 | 1/10 | 4 | 100 | 200 | 0,85 |
| BFS19;R | 30 | 20 | 30 | 250 | 65/225 | 1/10 | 4 | 100 | 260 | 0,85 |
| BFS20;R | 30 | 20 | 25 | 250 | 40/85 | 7/10 | - | - | 450 | 0,35 |

BROAD-BAND TRANSISTORS in SOT-23/SOT-89*

| type | RATINGS | | | | h_{FE} | | d_{im} | | f_T | C_{re} |
|--------------|----------------|----------------|-------------|-----------------|--------------|----------------------|-----------|--------|-------------|------------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at | I_C/V_{CE} mA/V | typ. at f | MHz | typ. GHz | typ. pF |
| P-N-P | | | | | | | | | | |
| BFT92;R | 20 | 15 | 25 | 200 | 20/- | 14/10 | 60 | 493,25 | 5 | 0,7 |
| BFT93;R | 15 | 12 | 35 | 200 | 20/- | 30/5 | 60 | 493,25 | 5 | 1,0 |
| N-P-N | | | | | | | | | | |
| BFQ17* | 40 | 25 | 150 | 1000 | 25/- | 150/5 | - | - | 1,2 | 1,9 |
| BFQ18A* | 25 | 15 | 150 | 1000 | 25/- | 100/10 | 60 | 793,25 | 3,6 | 1,2 |
| BFQ19* | 20 | 15 | 75 | 500 | 25/- | 75/10 | - | - | 5,0 | 1,3 |
| BFR53;R | 18 | 10 | 50 | 250 | 25/- | 50/5 | 60 | 217,0 | 2,0 | 0,9 |
| BFR92;R | 20 | 15 | 25 | 200 | 25/- | 14/10 | 60 | 493,25 | 5,0 | 0,7 |
| BFR93;R | 15 | 12 | 35 | 200 | 25/- | 30/5 | 60 | 493,25 | 5,0 | 0,8 |
| BFS17;R | 25 | 15 | 25 | 250 | 20/150 | 2/1 | 45 | 217 | 1,3 | 0,65 |
| BFT25;R | 8 | 5 | 2,5 | 50 | 20/- | 1/1 | - | - | 2,3 | 0,45 |

TRIGGER DEVICE in SOT-23

| | |
|----------------|--|
| P-N-P-N | |
| BRY61 | V_{GA} max. 70 V; I_A max. 175 mA; $I_P = 5/1 \mu A$; $I_V = 30/50 \mu A$ |

* Types in SOT-89 package are denoted by an asterisk (*).

SWITCHING TRANSISTORS in SOT-23/SOT-89*

| type | RATINGS | | | | h_{FE} | | V_{CEsat} | | t (max.) | |
|--------------|----------------|----------------|-------------|-----------------|---------------------------|---------------------------|-------------------|-------------------|---------------------|--------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at I_C/V_{CE} | min./max. at I_C/V_{CE} | max. at I_C/I_B | max. at I_C/I_B | on/off at I_C/I_B | ns |
| P-N-P | | | | | | | | | | |
| BSR12;R | 15 | 15 | 100 | 250 | 30/120 | 50/1 | 0,45 | 100/10 | 20/30 | 30/3 |
| BSR15;R | 60 | 40 | 600 | 425 | 100/300 | 150/10 | 1,6 | 500/50 | 45/100 | 150/15 |
| BSR16;R | 60 | 60 | | | | | | | | |
| BSR30* | 70 | 60 | 1000 | 1000 | 40/120 | 100/5 | 0,5 | 500/50 | 500/650 | 100/5 |
| BSR31* | 70 | 60 | | | 100/300 | | | | | |
| BSR32* | 90 | 80 | | | 40/120 | | | | | |
| BSR33* | 90 | 80 | | | 100/300 | | | | | |
| BSS63;R | 110 | 100 | 100 | 350 | 30/- | 25/1 | 0,25 | 25/2,5 | - | - |
| N-P-N | | | | | | | | | | |
| BSR13;R | 60 | 30 | 800 | 425 | 100/300 | 150/10 | 1,6 | 500/50 | 35/285 | 150/- |
| BSR14;R | 75 | 40 | | | | | 1,0 | | | |
| BSR17;R | 60 | 40 | 200 | 350 | 100/300 | 10/1 | 0,3 | 50/5 | -/250 | 10/1 |
| BSR40* | 70 | 60 | 1000 | 1000 | 40/120 | 100/5 | 0,5 | 500/50 | 250/1000 | 100/5 |
| BSR41* | | | | | 100/300 | | | | | |
| BSR42* | 90 | 80 | 1000 | 1000 | 40/120 | 100/5 | 0,5 | 500/50 | 250/1000 | 100/5 |
| BSR43* | | | | | 100/300 | | | | | |
| BSS64;R | 120 | 80 | 100 | 350 | 20/80 | 10/1 | 0,2 | 50/15 | /1000 | 15/1 |
| BSV52;R | 20 | 12 | 100 | 250 | 40/120 | 10/1 | 0,4 | 50/5 | 12/18 | 10/3 |

FIELD-EFFECT TRANSISTORS in SOT-23

| type | RATINGS | | | | $-I_{GSS}$ | I_{DSS} | $-V(P)GS$ | $ y_{fs} $ | C_{rs} | V_n |
|-------|-------------------|-----------------|-------------|-----------------|------------|-----------------|-----------|--------------|------------|-----------------|
| | $\pm V_{DS}$ V | $-V_{GSO}$ V | I_D mA | P_{tot} mW | max. nA | min./max. mA | max. V | min. mA/V | max. pF | max. μF |
| BF510 | 20 | - | 30 | 300 | 10 | 0,7/3,0 | 0,8 | 2,5 | 0,4 | - |
| BF511 | | | | | | 2,5/7,0 | 1,5 | 4 | | |
| BF512 | | | | | | 6/12 | 2,2 | 6 | | |
| BF513 | | | | | | 10/18 | 3 | 7 | | |
| BFR30 | 25 | 25 | 10 | 250 | 0,2 | 4/10 | 5 | 1 | 1,5 | 0,5 |
| BFR31 | | | | | | 1/5 | 2,5 | 1,5 | | |
| BFT46 | 25 | 25 | 10 | 250 | 0,2 | 0,2/1,5 | 1,0 | 1,0 | 1,5 | 0,5 |
| BSR56 | 40 | 40 | - | 250 | 1 | 50/- | 10 | - | 5 | - |
| BSR57 | | | | | | 20/100 | 6 | | | |
| BSR58 | | | | | | 8/80 | 4 | | | |

* Types in SOT-89 package are denoted by an asterisk (*).

SELECTION GUIDE

VIDEO OUTPUT TRANSISTORS (SOT-89)

| type | RATINGS | | | | h_{FE} | | V_{CEK} | | f_T min. MHz |
|-----------------------|----------------|----------------|-------------|-----------------|---------------------------|-------|---------------|----|----------------------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at I_C/V_{CE} | mA/V | typ. at I_C | mA | |
| P-N-P BF623 | 250 | 250 | 20 | 1000 | 50/- | 25/20 | 20 | 25 | 60 |
| N-P-N BF622 | 250 | 250 | 20 | 1000 | 50/- | 25/20 | 20 | 25 | 60 |

LOW NOISE TRANSISTORS in SOT-23 (F < 4 dB at f = 1 kHz; B = 200 Hz)

| type | RATINGS | | | | h_{FE} | | V_{CEsat} | | f_T typ. MHz |
|--------------|----------------|----------------|-------------|-----------------|---------------------------|------|-------------------|---------|----------------------|
| | V_{CBO} V | V_{CEO} V | I_C mA | P_{tot} mW | min./max. at I_C/V_{CE} | mA/V | max. at I_C/I_B | V mA | |
| P-N-P | | | | | | | | | |
| BCF29 | 32 | 32 | 100 | 350 | 120/260 | 2/5 | 0,3 | 10/0,5 | 150 |
| BCF30 | 32 | 32 | 100 | 350 | 215/500 | 2/5 | 0,3 | 10/0,5 | 150 |
| BCF70 | 50 | 45 | 100 | 350 | 215/500 | 2/5 | 0,3 | 10/0,5 | 150 |
| N-P-N | | | | | | | | | |
| BCF32 | 32 | 32 | 100 | 350 | 200/450 | 2/5 | 0,25 | 10/0,5 | 300 |
| BCF33 | 32 | 32 | 100 | 350 | 420/800 | 2/5 | 0,25 | 10/0,5 | 300 |
| BCF81 | 50 | 45 | 100 | 350 | 420/800 | 2/5 | 0,25 | 10/0,5 | 300 |

DIODES (SOT-23)

| type | description | RATINGS | | t_{rr} max. ns | V_F max. (mV) at $I_F =$ mA 10/100-150 | C_d max. pF |
|-------|-----------------------------|------------|-------------|------------------------|--|---------------------|
| | | V_R V | I_F mA | | | |
| BAS16 | high-speed switch | 75 | 250 | 6 | 855/- - 1250 | 2 |
| BAS17 | low-voltage stabilizer | - | 250 | - | 830/960 - | 140 |
| BAS19 | high-speed switch | 100 | 200 | 50 | - /1000 - | 5 |
| BAS20 | high-speed switch | 150 | 200 | 50 | - /1000 - | 5 |
| BAS21 | high-speed switch | 200 | 200 | 50 | - /1000 - | 5 |
| BAT17 | Schottky barrier | 4 | 30 | - | 600/- - | 1 |
| BAT18 | band switch | 35 | 100 | - | /1200 - | 1 |
| BAV70 | common cathode double diode | 70 | 250 | 6 | 855/- - 1250 | 1,5 |
| BAV99 | two diodes in series | 70 | 250 | 6 | 855/- - 1250 | 1,5 |
| BAW56 | common anode double diode | 70 | 250 | 6 | 855/- - 1250 | 2 |

VARIABLE CAPACITANCE DIODES (SOT-23)

| type | RATINGS | | CHARACTERISTICS | | | | | |
|-------|---------|-------|-----------------|----|-------------------------------------|--------------|------------------------------|-------|
| | V_R | I_F | I_R at V_R | | C_d at V_R | | capacitance ratio typ. | r_D |
| | V | mA | nA | V | pF | V | | |
| BBY31 | 28 | 20 | < 50 | 28 | typ. 17,5 typ. 11,5 1,8 – 2,8 | 1 3 25 | 5 | < 1,2 |
| BBY40 | 28 | 20 | < 50 | 28 | 26 – 32 4,3 – 6 | 3 25 | 5 to 5,6 | < 0,6 |

VOLTAGE REGULATOR DIODES

| type | case | range (V) | voltage tolerance % | P_{tot} mW | I_{ZRM} mA | I_{FRM} mA | V_F at I_F | |
|-------|--------|-----------|---------------------------|-----------------|-----------------|-----------------|----------------|-----|
| | | | | | | | V | mA |
| BZX78 | SOT-89 | 5,1 to 75 | 5 | 1000 | — ** | 400 | 1 | 200 |
| BZX84 | SOT-23 | 2,4 to 75 | 5 * | 350 | 250 | 250 | 0,9 | 10 |

* Types with 2% voltage tolerance available on request.

** I_{ZRM} limited by P_{ZRMmax} .

TYPE NUMBER SURVEY

Numerical index

Conversion conventional types

Marking and marking code



NUMERICAL TYPE LIST

| type number | mark | reverse type mark | device type | SOT-23 | SOT-89 | nearest conventional type(s) | complement |
|-------------|------|-------------------------|----------------|--------|--------|---------------------------------|------------|
| BAS16 | A6 | | D | • | | BAW62/1N4148 | |
| BAS17 | A91 | | D | • | | BA314 | |
| BAS19 | A8 | | D | • | | BAV19 | |
| BAS20 | A81 | | D | • | | BAV20 | |
| BAS21 | A82 | | D | • | | BAV21 | |
| BAT17 | A3 | | D | • | | BA280 | |
| BAT18 | A2 | | D | • | | BA182/BA243/BA482 | |
| BAV70 | A4 | | D | • | | BAW62/1N4148 (double) | |
| BAV99 | A7 | | D | • | | BAW62/1N4148 (double) | |
| BAW56 | A1 | | D | • | | BAW62/1N4148 (double) | |
| BBY31 | S1 | | D | • | | BB105G/BB405G | |
| BBY40 | S2 | | D | • | | BB109G/BB809 | |
| BCF29;R | C7 | C77 | PNP | • | | BC559A/BCY78/BC179 | |
| BCF30;R | C8 | C9 | PNP | • | | BC559B/BCY78 | |
| BCF32;R | D7 | D77 | NPN | • | | BC549B/BCY58/BC109 | |
| BCF33;R | D8 | D81 | NPN | • | | BC549C/BCY58 | |
| BCF70;R | H7 | H71 | PNP | • | | BC560B/BCY79 | |
| BCF81;R | K9 | K91 | NPN | • | | BC550C | |
| BCV71;R | K7 | K71 | NPN | • | | BC546A | |
| BCV72;R | K8 | K81 | NPN | • | | BC546B | |
| BCW29;R | C1 | C4 | PNP | • | | BC178A/BC558A | BCW31;R |
| BCW30;R | C2 | C5 | PNP | • | | BC178B/BC558B | BCW32;R |
| BCW31;R | D1 | D4 | NPN | • | | BC108A/BC548A | BCW29;R |
| BCW32;R | D2 | D5 | NPN | • | | BC108B/BC548B | BCW30;R |
| BCW33;R | D3 | D6 | NPN | • | | BC108C/BC548C | |
| BCW60A | AA | | NPN | • | | BC108/BC548 | |
| BCW60B | AB | | NPN | • | | BC108/BC548 | |
| BCW60C | AC | | NPN | • | | BC108/BC548 | |
| BCW60D | AD | | NPN | • | | BC108/BC548 | |
| BCW61A | BA | | PNP | • | | BC178/BC558 | |
| BCW61B | BB | | PNP | • | | BC178/BC558 | |
| BCW61C | BC | | PNP | • | | BC178/BC558 | |
| BCW61D | BD | | PNP | • | | BC178/BC558 | |
| BCW69;R | H1 | H4 | PNP | • | | BC177A/BC557A | BCW71;R |
| BCW70;R | H2 | H5 | PNP | • | | BC177B/BC557B | BCW72;R |

TYPE NUMBER SURVEY

| type number | mark | reverse type mark | device type | SOT-23 | SOT-89 | nearest conventional type(s) | complement |
|-------------|------|-------------------------|----------------|--------|--------|---------------------------------|------------|
| BCW71;R | K1 | K4 | NPN | ● | | BC 107A/BC547A | BCW69;R |
| BCW72;R | K2 | K5 | NPN | ● | | BC 107B/BC547B | BCW70;R |
| BCW81;R | K3 | K31 | NPN | ● | | BC547C | |
| BCW89;R | H3 | H31 | PNP | ● | | BC556A | |
| BCX17;R | T1 | T4 | PNP | ● | | BC327 | BCX19;R |
| BCX18;R | T2 | T5 | PNP | ● | | BC328 | BCX20;R |
| BCX19;R | U1 | U4 | NPN | ● | | BC337 | BCX17;R |
| BCX20;R | U2 | U5 | NPN | ● | | BC338 | BCX18;R |
| BCX51 | | | PNP | | ● | BC636 | BCX54 |
| BCX52 | | | PNP | | ● | BC638 | BCX55 |
| BCX53 | | | PNP | | ● | BC640 | BCX56 |
| BCX54 | | | NPN | | ● | BC635 | BCX51 |
| BCX55 | | | NPN | | ● | BC637 | BCX52 |
| BCX56 | | | NPN | | ● | BC639 | BCX53 |
| BCX70G | AG | | NPN | ● | | BC 107/BC547 | |
| BCX70H | AH | | NPN | ● | | BC 107/BC547 | |
| BCX70J | AJ | | NPN | ● | | BC 107/BC547 | |
| BCX70K | AK | | NPN | ● | | BC 107/BC547 | |
| BCX71G | BG | | PNP | ● | | BC 177/BC557 | |
| BCX71H | BH | | PNP | ● | | BC 177/BC557 | |
| BCX71J | BJ | | PNP | ● | | BC 177/BC557 | |
| BCX71K | BK | | PNP | ● | | BC 177/BC557 | |
| BF510 | S6 | | FET | ● | | BF410A | |
| BF511 | S7 | | FET | ● | | BF410B | |
| BF512 | S8 | | FET | ● | | BF410C | |
| BF513 | S9 | | FET | ● | | BF410D | |
| BF536 | G3 | | PNP | ● | | BF936 | |
| BF550;R | G2 | G5 | PNP | ● | | BF450 | |
| BF569 | G6 | | PNP | ● | | BF970 | |
| BF579 | G7 | | PNP | ● | | BF979 | |
| BF622 | | | NPN | | ● | BF422 | BF623 |
| BF623 | | | PNP | | ● | BF423 | BF622 |
| BF660;R | G8 | G81 | PNP | ● | | BF606A | |
| BF767 | G9 | | PNP | ● | | BF967 | |
| BFQ17 | | | NPN | | ● | BFW16A | |
| BFQ18A | | | NPN | | ● | BFQ34 | |
| BFQ19 | | | NPN | | ● | BFR96 | |
| BFR30 | M1 | | FET | ● | | BFW11/BF245 | |
| BFR31 | M2 | | FET | ● | | BFW12/BF245 | |
| BFR53;R | N1 | N4 | NPN | ● | | BFW30/BFW93 | |
| BFR92;R | P1 | P4 | NPN | ● | | BFR90 | BFT92;R |
| BFR93;R | R1 | R4 | NPN | ● | | BFR91 | BFT93;R |
| BFS17;R | E1 | E4 | NPN | ● | | BFY90/BFW92 | |
| BFS18;R | F1 | F4 | NPN | ● | | BF 185/BF495 | |
| BFS19;R | F2 | F5 | NPN | ● | | BF 184/BF494 | |



TYPE NUMBER SURVEY

| type number | mark | reverse type mark | device type | SOT-23 | SOT-89 | nearest conventional type(s) | complement |
|-------------|------|-------------------------|----------------|--------|--------|---------------------------------|------------|
| BFS20;R | G1 | G4 | NPN | ● | | BF199 | |
| BFT25;R | V1 | V4 | NPN | ● | | BFT24 | |
| BFT46 | M3 | | FET | ● | | BFW13/BF245 | |
| BFT92;R | W1 | W4 | PNP | ● | | BFQ51/52 | BFR92;R |
| BFT93;R | X1 | X4 | PNP | ● | | BFQ23/24 | BFR93;R |
| BRY61 | A5 | | PNPN | ● | | BRY56/BRY39PUT | |
| BSR12;R | B5 | B8 | PNP | ● | | 2N2894A | BSV52 |
| BSR13;R | U7 | U71 | NPN | ● | | 2N2222 | |
| BSR14;R | U8 | U81 | NPN | ● | | 2N2222A | |
| BSR15;R | T7 | T71 | PNP | ● | | 2N2907 | |
| BSR16;R | T8 | T81 | PNP | ● | | 2N2907A | |
| BSR17;R | U9 | U91 | NPN | ● | | 2N3904 | |
| BSR30 | | | PNP | | ● | | BSR40 |
| BSR31 | | | PNP | | ● | BSV16/17 | BSR41 |
| BSR32 | | | PNP | | ● | 2N4030 to 4033 | BSR42 |
| BSR33 | | | PNP | | ● | | BSR43 |
| BSR40 | | | NPN | | ● | | BSR30 |
| BSR41 | | | NPN | | ● | BSX46/47 | BSR31 |
| BSR42 | | | NPN | | ● | 2N3019/3020 | BSR32 |
| BSR43 | | | NPN | | ● | | |
| BSR56 | M4 | | FET | ● | | 2N4856 | |
| BSR57 | M5 | | FET | ● | | 2N4857 | |
| BSR58 | M6 | | FET | ● | | 2N4858 | |
| BSS63;R | T3 | T6 | PNP | ● | | BSS68 | BSS64;R |
| BSS64;R | U3 | U6 | NPN | ● | | BSS38 | BSS63;R |
| BSV52;R | B2 | B4 | NPN | ● | | BSX20/2N2369 | BSR12 |

TYPE NUMBER SURVEY

| type device type nearest conventional type | BZX78- SOT-89 diode BZX87 series | BZX84- SOT-23 diode BZX79 series |
|--|---|---|
| type number suffix | mark | mark |
| C2V4 | - | Z11 |
| C2V7 | - | Z12 |
| C3V0 | - | Z13 |
| C3V3 | - | Z14 |
| C3V6 | - | Z15 |
| C3V9 | - | Z16 |
| C4V3 | - | Z17 |
| C4V7 | - | Z1 |
| C5V1 | 5Z1 | Z2 |
| C5V6 | 5Z6 | Z3 |
| C6V2 | 6Z2 | Z4 |
| C6V8 | 6Z8 | Z5 |
| C7V5 | 7Z5 | Z6 |
| C8V2 | 8Z2 | Z7 |
| C9V1 | 9Z1 | Z8 |
| C10 | 10Z | Z9 |
| C11 | 11Z | Y1 |
| C12 | 12Z | Y2 |
| C13 | 13Z | Y3 |
| C15 | 15Z | Y4 |
| C16 | 16Z | Y5 |
| C18 | 18Z | Y6 |
| C20 | 20Z | Y7 |
| C22 | 22Z | Y8 |
| C24 | 24Z | Y9 |
| C27 | 27Z | Y10 |
| C30 | 30Z | Y11 |
| C33 | 33Z | Y12 |
| C36 | 36Z | Y13 |
| C39 | 39Z | Y14 |
| C43 | 43Z | Y15 |
| C47 | 47Z | Y16 |
| C51 | 51Z | Y17 |
| C56 | 56Z | Y18 |
| C62 | 62Z | Y19 |
| C68 | 68Z | Y20 |
| C75 | 75Z | Y21 |



CONVERSION LIST

| conventional type | microminiature type | conventional type | microminiature type | conventional type | microminiature type |
|----------------------|------------------------|----------------------|------------------------|----------------------|------------------------|
| BA182 | BAT18 | BC546B | BCF72 | BF410A | BF510 |
| BA243 | BAT18 | BC547A | BCW71 | BF410B | BF511 |
| BA280 | BAT17 | BC547B | BCW72 | BF410C | BF512 |
| BA314 | BAS17 | BC547C | BCW81 | BF410D | BF513 |
| BAV19 | BAS19 | BC548A | BCW31 | BF422 | BF622 |
| BAV20 | BAS20 | BC548B | BCW32 | BF423 | BF623 |
| BAV21 | BAS21 | BC548C | BCW33 | BF450 | BF550 |
| BAW62 | BAS16 | BC549B | BCF32 | BF494 | BFS19 |
| | BAV70 | BC549C | BCF33 | BF495 | BFS18 |
| | BAV99 | BC550C | BCF81 | BF606A | BF660 |
| | BAW56 | | | | |
| | | BC556A | BCW89 | BF936 | BF536 |
| BB105G | BBY31 | BC557A | BCW69 | BF967 | BF767 |
| BB109 | BBY40 | BC557B | BCW70 | BF970 | BF569 |
| BC107A | BCW71 | BC558A | BCW29 | BF979 | BF579 |
| BC107B | BCW72 | BC558B | BCW30 | BFQ23 | BF793 |
| BC108A | BCW31 | BC559A | BCF29 | BFQ24 | BFT93 |
| BC108B | BCW32 | BC559B | BCF30 | BFQ34 | BFQ18A |
| BC108C | BCW33 | BC560B | BCF70 | BFR90 | BFR92 |
| BC109 | BCF32 | BC635 | BCX54 | BFR91 | BFR93 |
| BC177A | BCW69 | BC636 | BCX51 | BFR96 | BFQ19 |
| BC177B | BCW70 | BC637 | BCX55 | BFT24 | BFT25 |
| BC178A | BCW29 | BC638 | BCX52 | BFW11 | BFR30 |
| BC178B | BCW30 | BC639 | BCX56 | BFW12 | BFR31 |
| BC179 | BCF29 | BC640 | BCX53 | BFW13 | BFT46 |
| BC327 | BCX17 | BCY58 | BCF32/33 | BFW16A | BFQ17 |
| BC328 | BCX18 | BCY78 | BCF29/30 | BFW30 | BFR53 |
| BC337 | BCX19 | BCY79 | BCF29/30 | BFW92 | BFS17 |
| BC338 | BCX20 | BF184 | BCF70 | BFW93 | BFR53 |
| BC369 | BCX69 | BF185 | BFS19 | BFY90 | BFS17 |
| BC546A | BCF71 | BF199 | BFS18 | BRY39 (PUT) | BRY61 |

TYPE NUMBER SURVEY

| conventional type | microminiature type | conventional type | microminiature type | conventional type | microminiature type |
|-------------------|---------------------|-------------------|---------------------|-------------------|---------------------|
| BRY56 | BRY61 | 2N2222A | BSR 14 | 2N3019 | BSR43 |
| BSS38 | BSS64 | 2N2369 | BSV52 | 2N3020 | BSR42 |
| BSS68 | BSS63 | 2N2894A | BSR12 | 2N3904 | BSR17 |
| BSV16 | BSR30-33 | 2N2907 | BSR15 | 2N3906 | BSR18 |
| BSV17 | BSR30-33 | 2N2907A | BSR16 | 2N4030 | BSR30 |
| BSX20 | BSV52 | 1N4148 | BAS16 | 2N4031 | BSR32 |
| BSX46 | BSR40-43 | | BAV70 | 2N4032 | BSR31 |
| BSX47 | BSR40-43 | | BAV99 | 2N4033 | BSR33 |
| BZX87 | BZX78 | | BAW56 | 2N4856 | BSR56 |
| BZX79 | BZX84 | 2N2222 | BSR13 | 2N4857 | BSR57 |
| | | | | 2N4858 | BSR58 |



MARKING LIST

Types in SOT-23 envelopes are marked with a code as listed below. The actual type number and date code are on the packing.

Types in SOT-89 usually have the type number marked in full on the envelope. An exception to this is the BZX78 series. These envelopes are coded as indicated opposite.

SOT-23

| mark | type no. | mark | type no. | mark | type no. | mark | type no. |
|------|----------|------|----------|------|----------|------|----------|
| A1 | BAW56 | BJ | BCX71J | F4 | BFS18R | K71 | BCV71R |
| A2 | BAT18 | BK | BCX71K | F5 | BFS19R | K8 | BCV72 |
| A3 | BAT17 | C1 | BCW29 | F6 | | K81 | BCV72R |
| A4 | BAV70 | C2 | BCW30 | F7 | | K9 | BCF81 |
| A5 | BRY61 | C3 | | F8 | | K91 | BCF81R |
| A6 | BAS16 | C4 | BCW29R | F9 | | M1 | BFR30 |
| A7 | BAV99 | C5 | BCW30R | G1 | BFS20 | M2 | BFR31 |
| A8 | BAS19 | C6 | | G2 | BF550 | M3 | BFT46 |
| A81 | BAS20 | C7 | BCF29 | G3 | BF536 | M4 | BSR56 |
| A82 | BAS21 | C77 | BCF29R | G4 | BFS20R | M5 | BSR57 |
| A9 | | C8 | BCF30 | G5 | BF550R | M6 | BSR58 |
| A91 | BAS17 | C9 | BCF30R | G6 | BF569 | M7 | |
| AA | BCW60A | D1 | BCW31 | G7 | BF579 | M8 | |
| AB | BCW60B | D2 | BCW32 | G8 | BF660 | M9 | |
| AC | BCW60C | D3 | BCW33 | G81 | BF660R | N1 | BFR53 |
| AD | BCW60D | D4 | BCW31R | G9 | BF767 | N2 | |
| AG | BCX70G | D5 | BCW32R | H1 | BCW69 | N3 | |
| AH | BCX70H | D6 | BCW33R | H2 | BCW70 | N4 | BFR53R |
| AJ | BCX70J | D7 | BCF32 | H3 | BCW89 | N5 | |
| AK | BCX70K | D77 | BCF32R | H31 | BCW89R | N6 | |
| B1 | | D8 | BCF33 | H4 | BCW69R | N7 | |
| B2 | BSV52 | D81 | BCF33R | H5 | BCW70R | N8 | |
| B3 | | D9 | | H6 | | N9 | |
| B4 | BSV52R | E1 | BFS17 | H7 | BCF70 | P1 | BFR92 |
| B5 | BSR12 | E2 | | H71 | BCF70R | P2 | |
| B6 | | E3 | | H8 | | P3 | |
| B7 | | E4 | BFS17R | H9 | | P4 | BFR92R |
| B8 | BSR12R | E5 | | K1 | BCW71 | P5 | |
| B9 | | E6 | | K2 | BCW72 | P6 | |
| BA | BCW61A | E7 | | K3 | BCW81 | P7 | |
| BB | BCW61B | E8 | | K31 | BCW81R | P8 | |
| BC | BCW61C | E9 | | K4 | BCW71R | P9 | |
| BD | BCW61D | F1 | BFS18 | K5 | BCW72R | R1 | BFR93 |
| BG | BCX71G | F2 | BFS19 | K6 | | R2 | |
| BH | BCX71H | F3 | | K7 | BCV71 | R3 | |



SOT-23

SOT-89

| SOT-23 | | SOT-23 | | SOT-89 | | SOT-89 | |
|--------|----------|--------|-----------|--------|------------|--------|------------|
| mark | type no. | mark | type no. | mark | type no. | mark | type no. |
| R4 | BFR93R | V3 | | Y16 | BZX84-C47 | 5Z1 | BZX78-C5V1 |
| R5 | | V4 | BFT25R | Y17 | -C51 | 5Z6 | -C5V6 |
| R6 | | V5 | | Y18 | -C56 | 6Z2 | -C6V2 |
| R7 | | V6 | | Y19 | -C62 | 6Z8 | -C6V8 |
| R8 | | V7 | | Y20 | -C68 | 7Z5 | -C7V5 |
| R9 | | V8 | | Y21 | BZX84-C75 | 8Z2 | BZX78-C8V2 |
| S1 | BBY31 | V9 | | Z1 | -C4V7 | 9Z1 | -C9V1 |
| S2 | BBY40 | W1 | BFT92 | Z2 | -C5V1 | 10Z | -C10 |
| S3 | | W2 | | Z3 | -C5V6 | 11Z | -C11 |
| S4 | | W3 | | Z4 | -C6V2 | 12Z | -C12 |
| S5 | | W4 | BFT92R | Z5 | BZX84-C6V8 | 13Z | BZX78-C13 |
| S6 | BF510 | W5 | | Z6 | -C7V5 | 15Z | -C15 |
| S7 | BF511 | W6 | | Z7 | -C8V2 | 16Z | -C16 |
| S8 | BF512 | W7 | | Z8 | -C9V1 | 18Z | -C18 |
| S9 | BF513 | W8 | | Z9 | -C10 | 20Z | -C20 |
| T1 | BCX17 | W9 | | Z11 | BZX84-C2V4 | 22Z | BZX78-C22 |
| T2 | BCX18 | X1 | BFT93 | Z12 | -C2V7 | 24Z | -C24 |
| T3 | BSS63 | X2 | | Z13 | -C3V0 | 27Z | -C27 |
| T4 | BCX17R | X3 | | Z14 | -C3V3 | 30Z | -C30 |
| T5 | BCX18R | X4 | BFT93R | Z15 | -C3V6 | 33Z | -C33 |
| T6 | BSS63R | X5 | | Z16 | BZX84-C3V9 | 36Z | BZX78-C36 |
| T7 | BSR15 | X6 | | Z17 | -C4V3 | 39Z | -C39 |
| T71 | BSR15R | X7 | | Z18 | | 43Z | -C43 |
| T8 | BSR16 | X8 | | Z19 | | 47Z | -C47 |
| T81 | BSR16R | X9 | | | | 51Z | -C51 |
| T9 | | Y1 | BZX84-C11 | | | 56Z | BZX78-C56 |
| U1 | BCX19 | Y2 | -C12 | | | 62Z | -C62 |
| U2 | BCX20 | Y3 | -C13 | | | 68Z | -C68 |
| U3 | BSS64 | Y4 | -C15 | | | 75Z | -C75 |
| U4 | BCX19R | Y5 | -C16 | | | | |
| U5 | BCX20R | Y6 | BZX84-C18 | | | | |
| U6 | BSS64R | Y7 | -C20 | | | | |
| U7 | BSR13 | Y8 | -C22 | | | | |
| U71 | BSR13R | Y9 | -C24 | | | | |
| U8 | BSR14 | Y10 | -C27 | | | | |
| U81 | BSR14R | Y11 | BZX84-C30 | | | | |
| U9 | BSR17 | Y12 | -C33 | | | | |
| U91 | BSR17R | Y13 | -C36 | | | | |
| V1 | BFT25 | Y14 | -C39 | | | | |
| V2 | | Y15 | -C43 | | | | |



GENERAL

Pro Electron Type designation
Rating Systems
Letter Symbols
S-parameters



PRO ELECTRON TYPE DESIGNATION CODE
FOR SEMICONDUCTOR DEVICES

This type designation code applies to discrete semiconductor devices — as opposed to integrated circuits —, multiples of such devices and semiconductor chips.

A basic type number consists of:

TWO LETTERS FOLLOWED BY A SERIAL NUMBER

FIRST LETTER

The first letter gives information about the material used for the active part of the devices.

- A. GERMANIUM or other material with band gap of 0,6 to 1,0 eV.
- B. SILICON or other material with band gap of 1,0 to 1,3 eV.
- C. GALLIUM-ARSENIDE or other material with band gap of 1,3 eV or more.
- R. COMPOUND MATERIALS (e.g. Cadmium-Sulphide).

SECOND LETTER

The second letter indicates the function for which the device is primarily designed.

- A. DIODE; signal, low power
- B. DIODE; variable capacitance
- C. TRANSISTOR; low power, audio frequency ($R_{th\ j-mb} > 15\ ^\circ C/W$)
- D. TRANSISTOR; power, audio frequency ($R_{th\ j-mb} \leq 15\ ^\circ C/W$)
- E. DIODE; tunnel
- F. TRANSISTOR; low power, high frequency ($R_{th\ j-mb} > 15\ ^\circ C/W$)
- G. MULTIPLE OF DISSIMILAR DEVICES — MISCELLANEOUS; e.g. oscillator
- H. DIODE; magnetic sensitive
- L. TRANSISTOR; power, high frequency ($R_{th\ j-mb} \leq 15\ ^\circ C/W$)
- N. PHOTO-COUPLER
- P. RADIATION DETECTOR; e.g. high sensitivity phototransistor
- Q. RADIATION GENERATOR; e.g. light-emitting diode (LED)
- R. CONTROL AND SWITCHING DEVICE; e.g. thyristor, low power ($R_{th\ j-mb} > 15\ ^\circ C/W$)
- S. TRANSISTOR; low power, switching ($R_{th\ j-mb} > 15\ ^\circ C/W$)
- T. CONTROL AND SWITCHING DEVICE; e.g. thyristor, power ($R_{th\ j-mb} \leq 15\ ^\circ C/W$)
- U. TRANSISTOR; power, switching ($R_{th\ j-mb} \leq 15\ ^\circ C/W$)
- X. DIODE: multiplier, e.g. varactor, step recovery
- Y. DIODE; rectifying, booster
- Z. DIODE; voltage reference or regulator (transient suppressor diode, with third letter W)

SERIAL NUMBER

Three figures, running from 100 to 999, for devices primarily intended for consumer equipment. One letter (Z, Y, X, etc.) and two figures, running from 10 to 99, for devices primarily intended for industrial/professional equipment.

This letter has no fixed meaning except W, which is used for transient suppressor diodes.

VERSION LETTER

It indicates a minor variant of the basic type either electrically or mechanically. The letter never has a fixed meaning, except letter R, indicating reverse voltage, e.g. collector to case or anode to stud.

SUFFIX

Sub-classification can be used for devices supplied in a wide range of variants called associated types. Following sub-coding suffixes are in use:

1. VOLTAGE REFERENCE and VOLTAGE REGULATOR DIODES: *ONE LETTER and ONE NUMBER*

The LETTER indicates the nominal tolerance of the Zener (regulation, working or reference) voltage

- A. 1% (according to IEC 63: series E96)
- B. 2% (according to IEC 63: series E48)
- C. 5% (according to IEC 63: series E24)
- D. 10% (according to IEC 63: series E12)
- E. 20% (according to IEC 63: series E6)

The number denotes the typical operating (Zener) voltage related to the nominal current rating for the whole range.

The letter 'V' is used instead of the decimal point.

2. TRANSIENT SUPPRESSOR DIODES: *ONE NUMBER*

The NUMBER indicates the maximum recommended continuous reversed (stand-off) voltage V_R . The letter 'V' is used as above.

3. CONVENTIONAL and CONTROLLED AVALANCHE RECTIFIER DIODES and THYRISTORS: *ONE NUMBER*

The NUMBER indicates the rated maximum repetitive peak reverse voltage (V_{RRM}) or the rated repetitive peak off-state voltage (V_{DRM}), whichever is the lower. Reversed polarity is indicated by letter R, immediately after the number.

4. RADIATION DETECTORS: *ONE NUMBER*, preceded by a hyphen (-)

The NUMBER indicates the depletion layer in μm . The resolution is indicated by a version LETTER.

5. ARRAY OF RADIATION DETECTORS and GENERATORS: *ONE NUMBER*, preceded by a stroke (/).

The NUMBER indicates how many basic devices are assembled into the array.

RATING SYSTEMS

The rating systems described are those recommended by the International Electrotechnical Commission (IEC) in its Publication 134.

DEFINITIONS OF TERMS USED

Electronic device. An electronic tube or valve, transistor or other semiconductor device.

Note

This definition excludes inductors, capacitors, resistors and similar components.

Characteristic. A characteristic is an inherent and measurable property of a device. Such a property may be electrical, mechanical, thermal, hydraulic, electro-magnetic, or nuclear, and can be expressed as a value for stated or recognized conditions. A characteristic may also be a set of related values, usually shown in graphical form.

Bogey electronic device. An electronic device whose characteristics have the published nominal values for the type. A bogey electronic device for any particular application can be obtained by considering only those characteristics which are directly related to the application.

Rating. A value which establishes either a limiting capability or a limiting condition for an electronic device. It is determined for specified values of environment and operation, and may be stated in any suitable terms.

Note

Limiting conditions may be either maxima or minima.

Rating system. The set of principles upon which ratings are established and which determine their interpretation.

Note

The rating system indicates the division of responsibility between the device manufacturer and the circuit designer, with the object of ensuring that the working conditions do not exceed the ratings.

ABSOLUTE MAXIMUM RATING SYSTEM

Absolute maximum ratings are limiting values of operating and environmental conditions applicable to any electronic device of a specified type as defined by its published data, which should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking no responsibility for equipment variations, environmental variations, and the effects of changes in operating conditions due to variations in the characteristics of the device under consideration and of all other electronic devices in the equipment.

The equipment manufacturer should design so that, initially and throughout life, no absolute maximum value for the intended service is exceeded with any device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, equipment control adjustment, load variations, signal variation, environmental conditions, and variations in characteristics of the device under consideration and of all other electronic devices in the equipment.

DESIGN MAXIMUM RATING SYSTEM

Design maximum ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking responsibility for the effects of changes in operating conditions due to variations in the characteristics of the electronic device under consideration.

The equipment manufacturer should design so that, initially and throughout life, no design maximum value for the intended service is exceeded with a bogey device under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, variation in characteristics of all other devices in the equipment, equipment control adjustment, load variation, signal variation and environmental conditions.

DESIGN CENTRE RATING SYSTEM

Design centre ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under normal conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device in average applications, taking responsibility for normal changes in operating conditions due to rated supply voltage variation, equipment component variation, equipment control adjustment, load variation, signal variation, environmental conditions, and variations in the characteristics of all electronic devices.

The equipment manufacturer should design so that, initially, no design centre value for the intended service is exceeded with a bogey electronic device in equipment operating at the stated normal supply voltage.



LETTER SYMBOLS FOR TRANSISTORS AND SIGNAL DIODES

based on IEC Publication 148

LETTER SYMBOLS FOR CURRENTS, VOLTAGES AND POWERS

Basic letters

The basic letters to be used are:

I, i = current
V, v = voltage
P, p = power.

Lower-case basic letters shall be used for the representation of instantaneous values which vary with time.

In all other instances upper-case basic letters shall be used.

Subscripts

| | |
|--------------|--|
| A, a | Anode terminal |
| (AV), (av) | Average value |
| B, b | Base terminal, for MOS devices: Substrate |
| (BR) | Breakdown |
| C, c | Collector terminal |
| D, d | Drain terminal |
| E, e | Emitter terminal |
| F, f | Forward |
| G, g | Gate terminal |
| K, k | Cathode terminal |
| M, m | Peak value |
| O, o | As third subscript: The terminal not mentioned is open circuited |
| R, r | As first subscript: Reverse. As second subscript: Repetitive. As third subscript: With a specified resistance between the terminal not mentioned and the reference terminal. |
| (RMS), (rms) | R. M. S. value |
| S, s | { As first or second subscript: Source terminal (for FETS only) As second subscript: Non-repetitive (not for FETS) As third subscript: Short circuit between the terminal not mentioned and the reference terminal |
| X, x | Specified circuit |
| Z, z | Replaces R to indicate the actual working voltage, current or power of voltage reference and voltage regulator diodes. |

Note: No additional subscript is used for d. c. values.

Upper-case subscripts shall be used for the indication of:

- a) continuous (d. c.) values (without signal)
Example I_B
- b) instantaneous total values
Example i_B
- c) average total values
Example $I_{B(AV)}$
- d) peak total values
Example I_{BM}
- e) root-mean-square total values
Example $I_{B(RMS)}$

Lower-case subscripts shall be used for the indication of values applying to the varying component alone :

- a) instantaneous values
Example i_b
- b) root-mean-square values
Example $I_{b(rms)}$
- c) peak values
Example I_{bm}
- d) average values
Example $I_{b(av)}$

Note: If more than one subscript is used, subscript for which both styles exist shall either be all upper-case or all lower-case.

Additional rules for subscripts

Subscripts for currents

Transistors : If it is necessary to indicate the terminal carrying the current, this should be done by the first subscript (conventional current flow from the external circuit into the terminal is positive).

Examples : I_B, i_B, i_b, I_{bm}

Diodes : To indicate a forward current (conventional current flow into the anode terminal) the subscript F or f should be used; for a reverse current (conventional current flow out of the anode terminal) the subscript R or r should be used.

Examples : $I_F, I_R, i_F, I_{f(rms)}$

Subscripts for voltages

Transistors: If it is necessary to indicate the points between which a voltage is measured, this should be done by the first two subscripts. The first subscript indicates the terminal at which the voltage is measured and the second the reference terminal or the circuit node. Where there is no possibility of confusion, the second subscript may be omitted.

Examples: V_{BE} , v_{BE} , v_{be} , V_{bem}

Diodes: To indicate a forward voltage (anode positive with respect to cathode), the subscript F or f should be used; for a reverse voltage (anode negative with respect to cathode) the subscript R or r should be used.

Examples: V_F , V_R , v_F , V_{rm}

Subscripts for supply voltages or supply currents

Supply voltages or supply currents shall be indicated by repeating the appropriate terminal subscript.

Examples: V_{CC} , I_{EE}

Note: If it is necessary to indicate a reference terminal, this should be done by a third subscript

Example: V_{CCE}

Subscripts for devices having more than one terminal of the same kind

If a device has more than one terminal of the same kind, the subscript is formed by the appropriate letter for the terminal followed by a number; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples: I_{B2} = continuous (d.c.) current flowing into the second base terminal

V_{B2-E} = continuous (d.c.) voltage between the terminals of second base and emitter

Subscripts for multiple devices

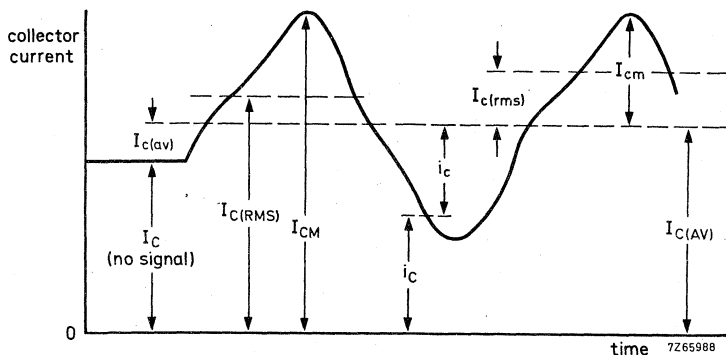
For multiple unit devices, the subscripts are modified by a number preceding the letter subscript; in the case of multiple subscripts, hyphens may be necessary to avoid misunderstanding.

Examples: I_{2C} = continuous (d.c.) current flowing into the collector terminal of the second unit

V_{1C-2C} = continuous (d.c.) voltage between the collector terminals of the first and the second unit.

Application of the rules

The figure below represents a transistor collector current as a function of time. It consists of a continuous (d. c.) current and a varying component.



LETTER SYMBOLS FOR ELECTRICAL PARAMETERS

Definition

For the purpose of this Publication, the term "electrical parameter" applies to four-pole matrix parameters, elements of electrical equivalent circuits, electrical impedances and admittances, inductances and capacitances.

Basic letters

The following is a list of the most important basic letters used for electrical parameters of semiconductor devices.

- B, b = susceptance; imaginary part of an admittance
- C = capacitance
- G, g = conductance; real part of an admittance
- H, h = hybrid parameter
- L = inductance
- R, r = resistance; real part of an impedance
- X, x = reactance; imaginary part of an impedance
- Y, y = admittance;
- Z, z = impedance;

Upper-case letters shall be used for the representation of:

- a) electrical parameters of external circuits and of circuits in which the device forms only a part;
- b) all inductances and capacitances.

Lower-case letters shall be used for the representation of electrical parameters inherent in the device (with the exception of inductances and capacitances).

Subscripts

General subscripts

The following is a list of the most important general subscripts used for electrical parameters of semiconductor devices:

| | |
|-------------|-----------------------------|
| F, f | = forward; forward transfer |
| I, i (or 1) | = input |
| L, l | = load |
| O, o (or 2) | = output |
| R, r | = reverse; reverse transfer |
| S, s | = source |

Examples: Z_S , h_f , h_F

The upper-case variant of a subscript shall be used for the designation of static (d.c.) values.

Examples: h_{FE} = static value of forward current transfer ratio in common-emitter configuration (d.c. current gain)

R_E = d.c. value of the external emitter resistance.

Note: The static value is the slope of the line from the origin to the operating point on the appropriate characteristic curve, i.e. the quotient of the appropriate electrical quantities at the operating point.

The lower-case variant of a subscript shall be used for the designation of small-signal values.

Examples: h_{fe} = small-signal value of the short-circuit forward current transfer ratio in common-emitter configuration

$Z_e = R_e + jX_e$ = small-signal value of the external impedance

Note: If more than one subscript is used, subscripts for which both styles exist shall either be all upper-case or all lower-case

Examples: h_{FE} , y_{RE} , h_{fe}

Subscripts for four-pole matrix parameters

The first letter subscript (or double numeric subscript) indicates input, output, forward transfer or reverse transfer

Examples: h_i (or h_{11})
 h_o (or h_{22})
 h_f (or h_{21})
 h_r (or h_{12})

A further subscript is used for the identification of the circuit configuration. When no confusion is possible, this further subscript may be omitted.

Examples: h_{fe} (or h_{21e}), h_{FE} (or h_{21E})

Distinction between real and imaginary parts

If it is necessary to distinguish between real and imaginary parts of electrical parameters, no additional subscripts should be used. If basic symbols for the real and imaginary parts exist, these may be used.

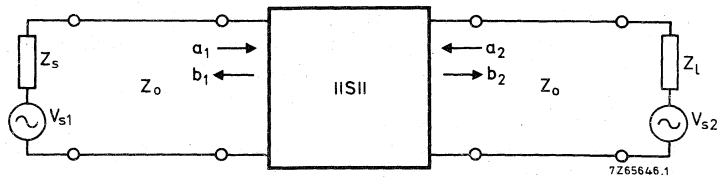
Examples: $Z_i = R_i + jX_i$
 $y_{fe} = g_{fe} + jb_{fe}$

If such symbols do not exist or if they are not suitable, the following notation shall be used:

Examples: $\text{Re}(h_{ib})$ etc. for the real part of h_{ib}
 $\text{Im}(h_{ib})$ etc. for the imaginary part of h_{ib}

SCATTERING PARAMETERS

In distinction to the conventional h, y and z-parameters, s-parameters relate to traveling wave conditions. The figure below shows a two-port network with the incident and reflected waves a_1 , b_1 , a_2 and b_2 .



$$a_1 = \frac{V_{i1}}{\sqrt{Z_0}}$$

$$a_2 = \frac{V_{i2}}{\sqrt{Z_0}}$$

$$b_1 = \frac{V_{r1}}{\sqrt{Z_0}}$$

$$b_2 = \frac{V_{r2}}{\sqrt{Z_0}}$$

1)

Z_0 = characteristic impedance of the transmission line in which the two-port is connected.

V_i = incident voltage

V_r = reflected (generated) voltage

The four-pole equations for s-parameters are:

$$b_1 = s_{11}a_1 + s_{12}a_2$$

$$b_2 = s_{21}a_1 + s_{22}a_2$$

Using the subscripts i for 11, r for 12, f for 21 and o for 22, it follows that:

$$s_i = s_{11} = \left. \frac{b_1}{a_1} \right|_{a_2 = 0}$$

$$s_r = s_{12} = \left. \frac{b_1}{a_2} \right|_{a_1 = 0}$$

$$s_f = s_{21} = \left. \frac{b_2}{a_1} \right|_{a_2 = 0}$$

$$s_o = s_{22} = \left. \frac{b_2}{a_2} \right|_{a_1 = 0}$$

1) The squares of these quantities have the dimension of power.

S-PARAMETERS

The s-parameters can be named and expressed as follows:

$s_i = s_{11}$ = Input reflection coefficient.

The complex ratio of the reflected wave and the incident wave at the input, under the conditions $Z_1 = Z_o$ and $V_{s2} = 0$.

$s_r = s_{12}$ = Reverse transmission coefficient.

The complex ratio of the generated wave at the input and the incident wave at the output, under the conditions $Z_s = Z_o$ and $V_{s1} = 0$.

$s_f = s_{21}$ = Forward transmission coefficient.

The complex ratio of the generated wave at the output and the incident wave at the input, under the conditions $Z_1 = Z_o$ and $V_{s2} = 0$.

$s_o = s_{22}$ = Output reflection coefficient.

The complex ratio of the reflected wave and the incident wave at the output, under the conditions $Z_s = Z_o$ and $V_{s1} = 0$.

SOLDERING RECOMMENDATIONS
THERMAL CHARACTERISTICS



SOLDERING RECOMMENDATIONS SOT-23 AND SOT-89

SOT-23 and SOT-89 devices are ideally suited for placement onto thick and thin film substrates and printed circuit boards.

To assure reliable and consistent connections particular attention should be paid to:

1. Flux

A non-active flux is recommended. Where active fluxes are employed, great care in subsequent substrate cleaning must be exercised.

2. Metal-alloy solder or solder paste

Correct choice of solder alloy or solder paste to be employed e.g. 62% Sn, 36% Pb, 2% Ag or 60% Sn/40% Pb. Any paste used should contain at least 85% metal dry weight.

3. Soldering temperature

This will vary according to the actual method employed.

REFLOW SOLDERING

The preferred technique for mounting microminiature components on hybrid thick and thin-film is the method of reflow soldering.

The tags of both SOT-23 and SOT-89 envelopes are pre-tinned and the best results are obtained if a similar solder is applied to the corresponding soldering areas on the substrate. This can be done by either dipping the substrate in a solder bath or by screen printing a solder paste.

The maximum temperature of the leads or tab during the soldering cycle should not exceed 285 °C. The most economic method of soldering is a process in which all different components are soldered simultaneously for example SOT-23 or SOT-89 devices, capacitors and resistors.

Having first been fluxed, all components are positioned on the substrate. The slight adhesive force of the flux is sufficient to keep the components in place. Solder paste contains a flux and has therefore good inherent adhesive properties which eases positioning of the components.

With the components in position the substrate is heated to a point where the solder begins to flow. This can be done on a heating plate or on a conveyor belt running through an infrared tunnel. The maximum allowed temperature of the plastic body of a device must be kept below 280 °C during the soldering cycle. For further temperature behaviour during the soldering process see Figs 2 and 3.

The surface tension of the liquid solder tends to draw the tags of the device towards the centre of the soldering area and has thus a correcting effect on slight mispositionings. However, if the layout leaves something to be desired the same effect can result in undesirable shifts; particularly if the soldering areas on the substrate and the components are not concentrically arranged. This problem can be solved using a standard contact pattern, which leaves sufficient scope for the self-positioning effect (see Figs 4 and 5).

After cooling the connections may be visually inspected and, where necessary, repaired with a light soldering iron. Finally any remaining flux must be removed carefully.

IMMERSION SOLDERING

Where a complete substrate or printed circuit board is immersed in solder:

- The temperature of the soldering bath should not exceed 280 °C.
- The duration of the soldering cycle should not exceed 10 seconds.
- Forced cooling may be applied (see Fig. 1).

HAND SOLDERING

It is possible to solder microminiature devices with a light hand-held soldering iron, but this method has obvious drawbacks and should therefore be restricted to laboratory use and/or incidental repairs on production circuits.

- It is time-consuming and expensive.
- The device cannot be positioned accurately and therefore the connecting tags may come into contact with the substrate and damage it.
- There is a great risk of breaking either substrate or even internal connections inside the encapsulation.
- The envelope may be damaged by the iron.

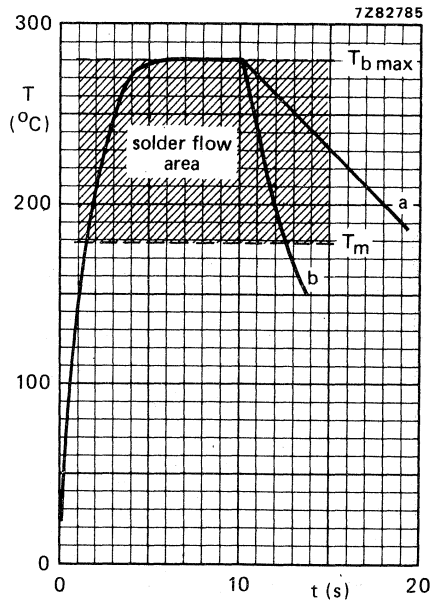


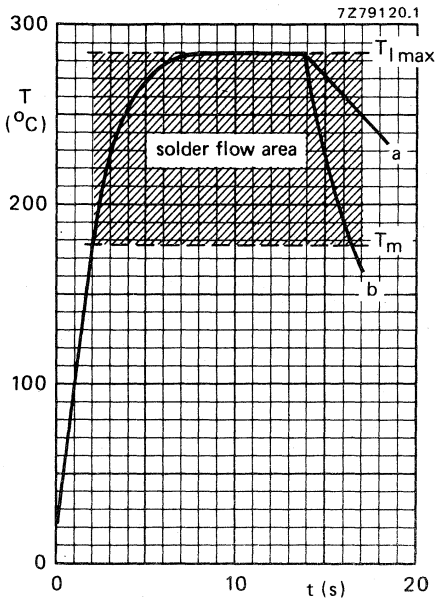
Fig. 1 Device temperature during *immersion* soldering.

Maximum time of immersion in soldering bath is 10 seconds at an ambient temperature of 25 °C.

a = free convection cooling; b = forced cooling.

$T_{b \text{ max}}$ = maximum bath temperature (280 °C).

T_m = melting temperature of solder (179 °C).



- a = free convection cooling.
- b = permissible forced cooling.
- $T_{I \max}$ = Maximum lead or tab temperature = 285 °C.
- T_m = Melting point of the solder is 179 °C.
- T_{amb} = 25 °C.

Time of heat supply:
without preheating max. 14 s
with preheating max. 10 s
Maximum time of preheating 45 s

Fig. 2 Reflow soldering without preheating.

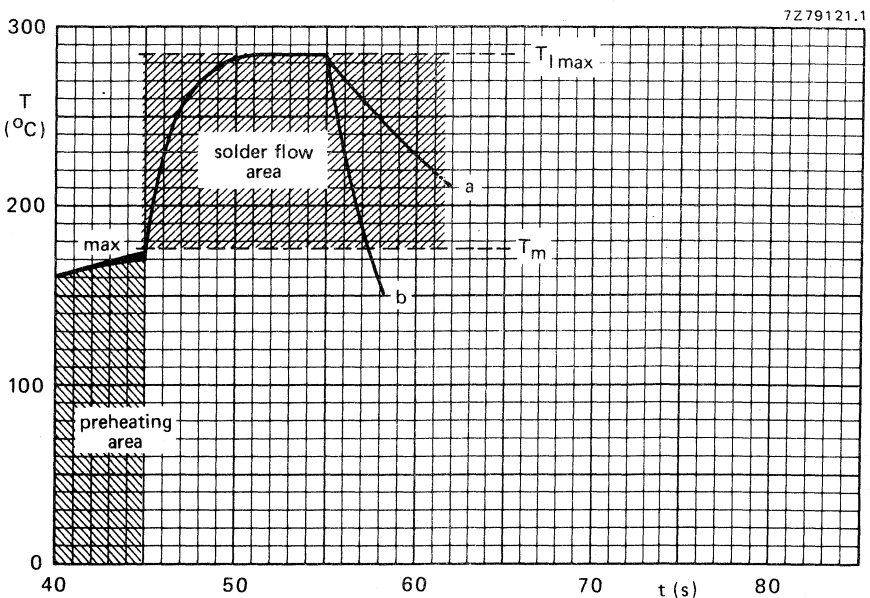


Fig. 3 Reflow soldering with preheating.

Minimum required dimensions of metal
connection pads on hybrid thick and thin-film
substrates.

Dimensions in mm

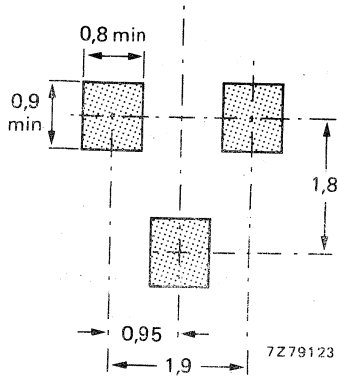


Fig. 4 SOT-23 pattern.

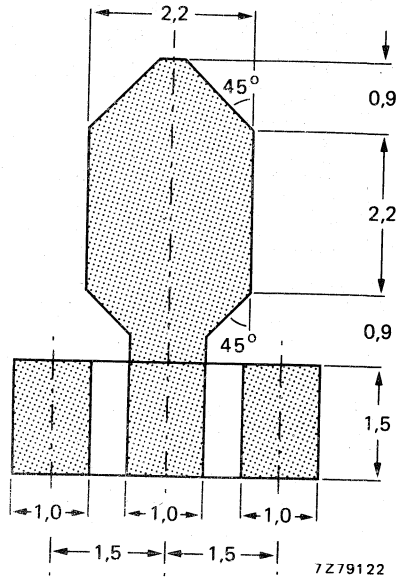


Fig. 5 SOT-89 pattern.

THERMAL CHARACTERISTICS OF SOT-23 ENVELOPES

The heat generated in a semiconductor chip normally flows by various paths to the surroundings (ambient).

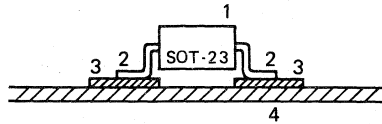


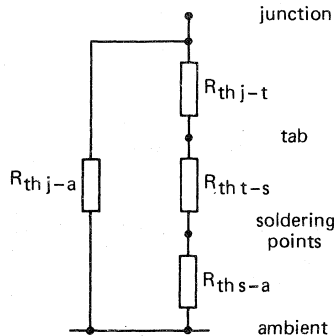
Fig. 1.

7Z89072

1. Heat radiation from the envelope to ambient (1).

This heat transfer can be neglected when the envelope is mounted on a substrate or printed circuit board.

2. Heat transmission via leads (2) soldering points (3) and substrate (4).



7Z89073

Fig. 2 Thermal behaviour of heat flow when the device is mounted on a substrate or printed circuit board.

$R_{th\ j-t}$ = Thermal resistance from junction to tab.

$R_{th\ t-s}$ = Thermal resistance from tab to soldering points.

$R_{th\ s-a}$ = Thermal resistance from soldering points to ambient.

$R_{th\ j-a}$ = Thermal resistance from junction to ambient.

Heat transfer directly from envelope to ambient

This depends on the difference between the temperatures of envelope and the surroundings. When the device is mounted on a substrate or printed circuit board direct heat flow can usually be neglected in relation to the heat flow via leads and substrate. Thus the thermal model can be as in Fig. 3.

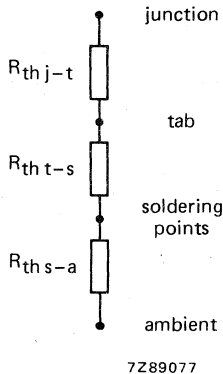


Fig. 3 Basic thermal model.

Heat transfer from junction to tab

This is an internal heat transfer and has been measured for SOT-23 envelopes. In general it is:

- for high-frequency transistors 60 K/W
- for low-frequency and switching transistors 50 K/W
- and also for low power diodes 30 K/W
- for low-frequency medium-power transistors 30 K/W

Heat transfer from tab to soldering points

This value has also been measured for SOT-23 and for all types of semiconductors in this envelope is 260 K/W

Heat transfer from soldering points to ambient

This depends on the shape and material of tracks and substrate. In figures 4 and 5 standard mounting conditions are given to set up the maximum power ratings for SOT-23 encapsulation.

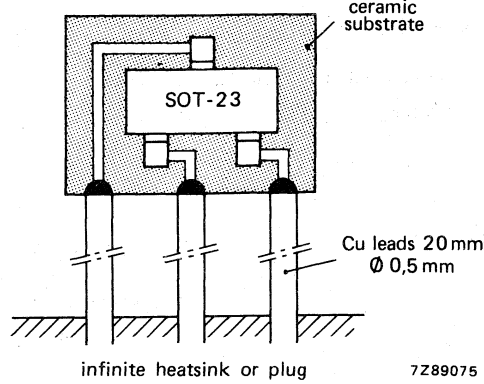


Fig. 4 Test circuit SOT-23 mounting conditions on a ceramic substrate.

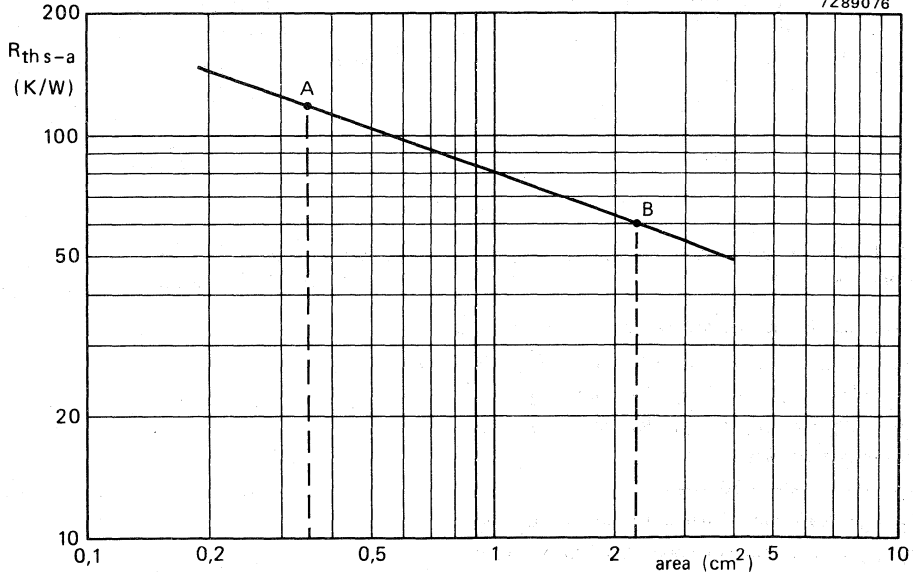


Fig. 5 Thermal resistance.

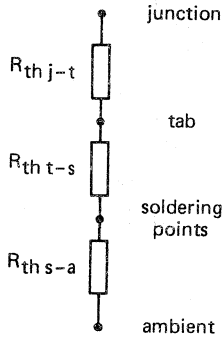
Point A on the curve in Fig. 5 is for an area of the ceramic substrate of 7 mm x 5 mm x 0,6 mm for the maximum rating of all high-frequency, low-frequency and switching transistors and also for all diodes in SOT-23 encapsulation.

Point B on the curve in Fig. 5 is for an area of the ceramic substrate of 15 mm x 15 mm x 0,6 mm for the maximum rating of low-frequency medium-power semiconductors.

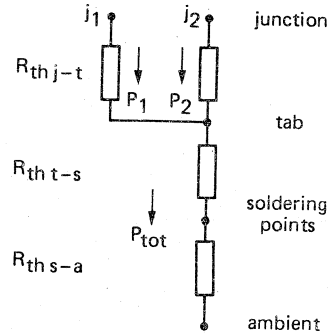
The values for the thermal resistance from junction to tab, and tab to soldering points, are mentioned on page 2 and Fig. 5.

The formula for devices in SOT-23 with one crystal can be generalized:

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$



7Z89077



7Z89074

Fig. 6 Thermal model of SOT-23 envelopes with one crystal.

Fig. 7 Thermal model of SOT-23 envelopes with two crystals (double diode).

The formulae for devices with two crystals (double diodes) are:

$$T_{tab} = P_{tot} \cdot (R_{th\ t-s} + R_{th\ s-a}) + T_{amb} = P_{tot} (260 + 120) + T_{amb}$$

$$T_{j1} = (P_1 \times R_{th\ j-t}) + T_{tab} = P_1 \cdot 50 + T_{tab}$$

$$T_{j2} = (P_2 \times R_{th\ j-t}) + T_{tab} = P_2 \cdot 50 + T_{tab}$$

As mentioned on page 2:

$R_{th\ j-t}$ for diodes is 50 K/W.

$R_{th\ s-a}$ (area 7 mm x 5 mm x 0,6 mm) = 120 K/W.

$R_{th\ t-s}$ for all semiconductors in SOT-23 = 260 K/W.

Thus:

$$T_{j1} = 50 P_1 + 380 P_{tot} + T_{amb}$$

$$T_{j2} = 50 P_2 + 380 P_{tot} + T_{amb}$$

DEVICE DATA



SILICON PLANAR EPITAXIAL HIGH-SPEED DIODE

Silicon epitaxial high-speed diode in a microminiature plastic envelope. It is intended for high-speed switching in hybrid thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|-----------|------|--------|
| Continuous reverse voltage | V_R | max. | 75 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 85 V |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Junction temperature | T_j | max. | 175 °C |
| Forward voltage at $I_F = 50$ mA | V_F | < | 1,0 V |
| Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA | t_{rr} | < | 6 ns |
| Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$ | Q_s | < | 45 pC |

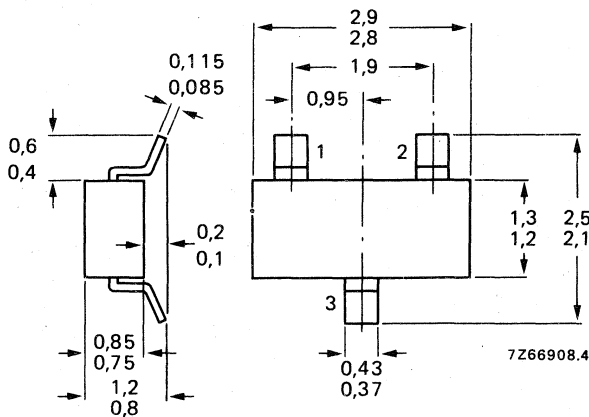
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAS16 = A6



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-------------|-------------|--------|
| Continuous reverse voltage | V_R | max. | 75 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 85 V |
| Average rectified forward current [▲] (averaged over any 20 ms period) | $I_{F(AV)}$ | max. | 250 mA |
| Forward current (d.c.) | I_F | max. | 250 mA |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| → Storage temperature | T_{stg} | -65 to +175 | °C |
| → Junction temperature | T_j | max. | 175 °C |

THERMAL CHARACTERISTICS *

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified.

Forward voltage

| | | | |
|----------------|-------|---|---------|
| $I_F = 1$ mA | V_F | < | 715 mV |
| $I_F = 10$ mA | V_F | < | 855 mV |
| $I_F = 50$ mA | V_F | < | 1000 mV |
| $I_F = 150$ mA | V_F | < | 1250 mV |

Reverse current

| | | | |
|------------------------------|-------|---|------------|
| $V_R = 25$ V; $T_j = 150$ °C | I_R | < | 30 μ A |
| $V_R = 75$ V | I_R | < | 1 μ A |
| $V_R = 75$ V; $T_j = 150$ °C | I_R | < | 50 μ A |

Diode capacitance

| | | | |
|-------------------------|-------|---|------|
| $V_R = 0$; $f = 1$ MHz | C_d | < | 2 pF |
|-------------------------|-------|---|------|

Forward recovery voltage (see also Fig. 2)

| | | | |
|---|----------|---|--------|
| when switched to $I_F = 10$ mA; $t_p = 20$ ns | V_{fr} | < | 1,75 V |
|---|----------|---|--------|

Reverse recovery time (see also Fig. 3)

| | | | |
|---|----------|---|------|
| when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA | t_{rr} | < | 6 ns |
|---|----------|---|------|

Recovery charge (see also Fig. 4)

| | | | |
|--|-------|---|-------|
| when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$ | Q_s | < | 45 pC |
|--|-------|---|-------|

[▲] Measured under pulse conditions. $t_p \leq 0,5$ ms. $I_{F(AV)} = 150$ mA, $t_{(av)} \leq 1$ ms, for sinusoidal operation.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

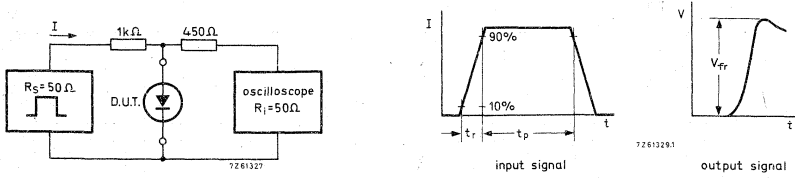


Fig. 2 Forward recovery voltage test circuit and waveforms.

Input signal: forward pulse rise time = $t_r = 20$ ns; forward current pulse duration $t_p = 120$ ns; duty factor = $\delta = 0,01$.
 Oscilloscope: rise time = $t_r = 0,35$ ns.
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).

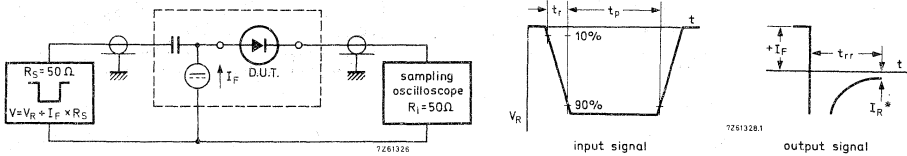


Fig. 3 Reverse recovery time test circuit and waveforms.

Input signal: reverse pulse rise time = $t_r = 0,6$ ns; reverse pulse duration = $t_p = 100$ ns; duty factor = $\delta = 0,05$. * t_{rr} up to $I_R = 1$ mA.
 Oscilloscope: rise time = $t_r = 0,35$ ns.
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).

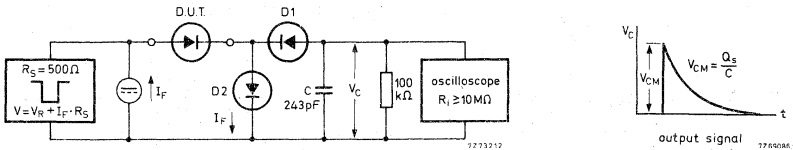


Fig. 4 Recovery charge test circuit and waveform.

D1 = BAW62; D2 = diode with minority carrier life time at 10 mA: < 200 ps

Input signal

Rise time of the reverse pulse

Reverse pulse duration

Duty factor

$$\begin{aligned} t_r &= 2 \text{ ns} \\ t_p &= 400 \text{ ns} \\ \delta &= 0,02 \end{aligned}$$

Circuit capacitance $C \leq 7$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).

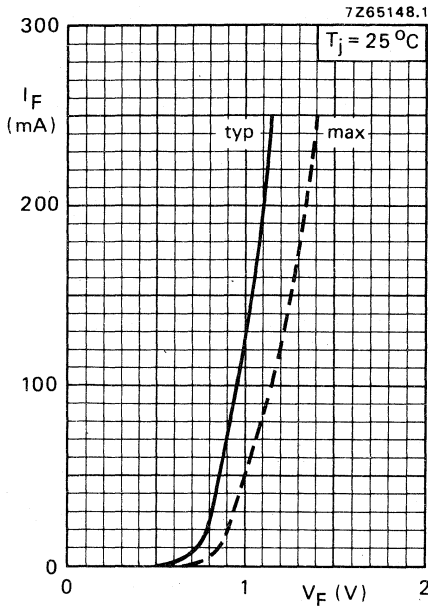


Fig. 5.

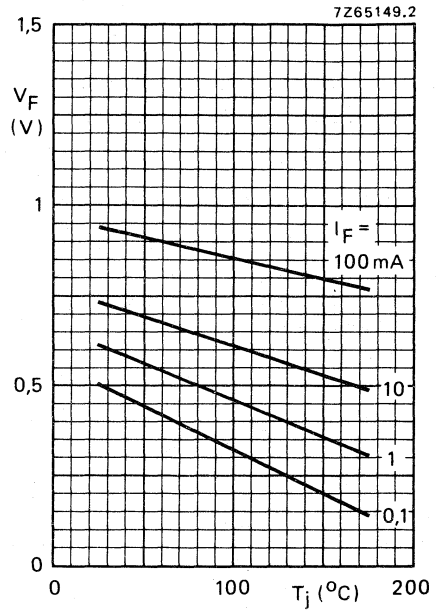


Fig. 6 Typical values.

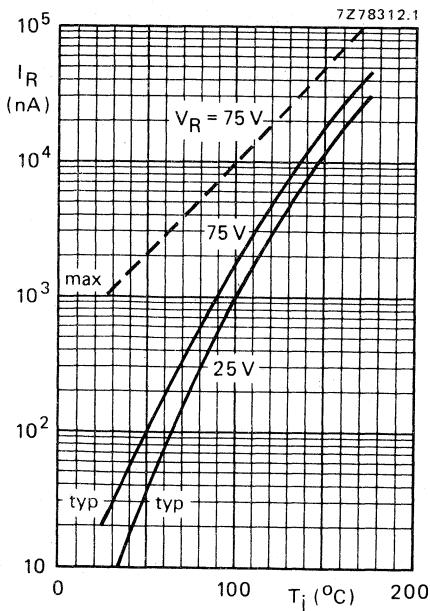


Fig. 7.

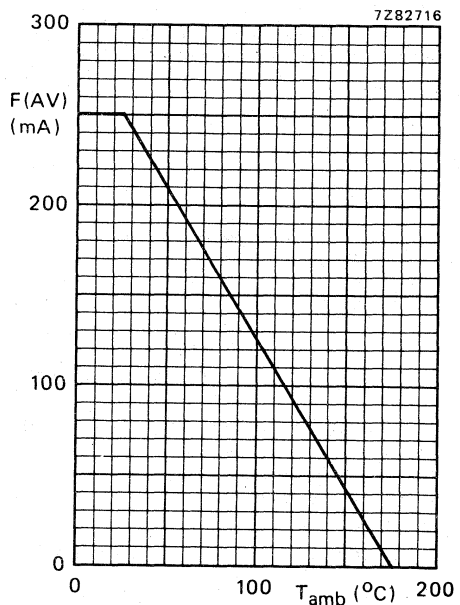


Fig. 8 Current derating curve.

LOW VOLTAGE STABISTOR

Silicon planar epitaxial diode in SOT-23 envelope. This diode is intended for low voltage stabilizing e.g. bias stabilizer in class-B output stages, clipping, clamping and meter protection.

QUICK REFERENCE DATA

| | | | |
|---|---------------|-------------|---------------|
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Storage temperature | T_{stg} | -65 to +150 | °C |
| Junction temperature | T_j | max. | 150 °C |
| Thermal resistance from junction to ambient | $R_{th\ j-a}$ | = | 0,62 K/mW |
| Forward voltage | | | |
| $I_F = 0,1$ mA | V_F | | 610 to 690 mV |
| $I_F = 1,0$ mA | V_F | | 680 to 760 mV |
| $I_F = 10$ mA | V_F | | 750 to 830 mV |
| $I_F = 100$ mA | V_F | | 870 to 960 mV |
| Diode capacitance | | | |
| $V_R = 0$; $f = 1$ MHz | C_d | < | 140 pF |

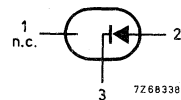
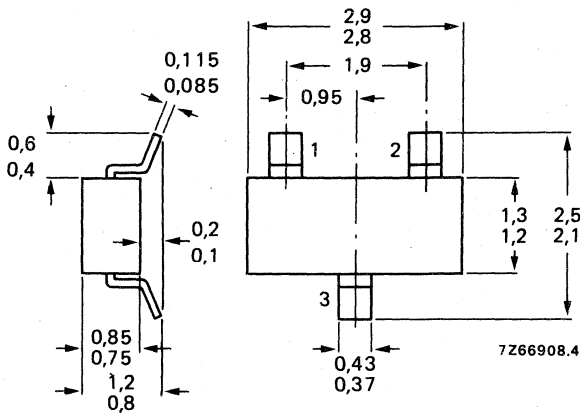
MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BAS17 = A91



See also chapter *Soldering Recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---------------------------------|-----------|-----------------|--------|
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Storage temperature | T_{stg} | -65 to + 150 °C | |
| Junction temperature | T_j | max. | 150 °C |

THERMAL RESISTANCE

From junction to ambient in free air
mounted on a ceramic substrate of
7 mm x 5 mm x 0,5 mm

$$R_{th\ j-a} = 0,62\ K/mW$$

CHARACTERISTICS

$T_j = 25\ ^\circ C$ unless otherwise specified

Forward voltage

$$I_F = 0,1\ mA$$

$$I_F = 1,0\ mA$$

$$I_F = 5,0\ mA$$

$$I_F = 10\ mA$$

$$I_F = 100\ mA$$

| | |
|-------|---------------|
| V_F | 610 to 690 mV |
| V_F | 680 to 760 mV |
| V_F | 730 to 810 mV |
| V_F | 750 to 830 mV |
| V_F | 870 to 960 mV |

Reverse current

$$V_R = 4\ V$$

$$I_R < 5\ \mu A$$

Temperature coefficient

$$I_F = 1\ mA$$

$$S_F\ \text{typ.}\ -1,8\ mV/K$$

Diode capacitance

$$V_R = 0; f = 1\ MHz$$

$$C_d < 140\ pF$$



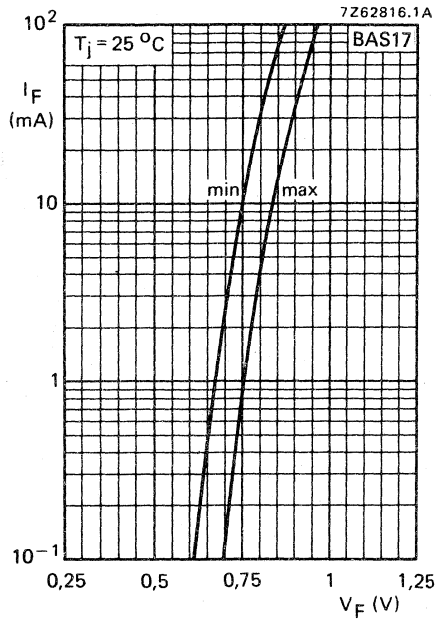


Fig. 2 Forward current as a function of forward voltage.



SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

Silicon epitaxial high-speed diodes in a microminiature plastic envelope. They are intended for switching and general purposes.

QUICK REFERENCE DATA

| | | | BAS19 | BAS20 | BAS21 | |
|--|-----------|------|-------|-------|-------|----|
| Continuous reverse voltage | V_R | max. | 100 | 150 | 200 | V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 120 | 200 | 250 | V |
| Repetitive peak forward current | I_{FRM} | max. | | 625 | | mA |
| Junction temperature | T_j | max. | | 150 | | °C |
| Forward voltage at $I_F = 100$ mA | V_F | < | | 1 | | V |
| Reverse recovery time when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100 \Omega$ measured at $I_R = 3$ mA | t_{rr} | < | | 50 | | ns |

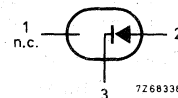
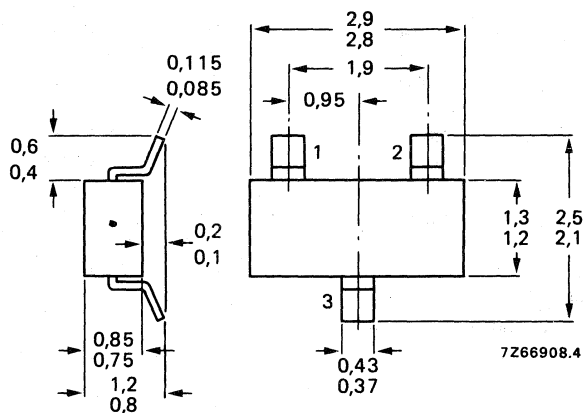
MECHANICAL DATA

Dimensions in mm

Marking code

BAS19 = A8
BAS20 = A81
BAS21 = A82

Fig. 1 SOT-23.



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | BAS19 | BAS20 | BAS21 | |
|---|-----------|----------|--------------|-------|----|
| Continuous reverse voltage | V_R | max. 100 | 150 | 200 | V |
| Repetitive peak reverse peak | V_{RRM} | max. 120 | 200 | 250 | V |
| Average rectified forward current (1) (averaged over any 20 ms period) | $I_F(AV)$ | max. | 200 | | mA |
| Forward current (d.c.) | I_F | max. | 200 | | mA |
| Repetitive peak forward current | I_{FRM} | max. | 625 | | mA |
| Storage temperature | T_{stg} | | -65 to + 150 | | °C |
| Junction temperature | T_j | max. | 150 | | °C |
| Total power dissipation up to $T_{amb} = 25$ °C | P_{tot} | max. | 200 | | mW |

THERMAL RESISTANCE

From junction to ambient
mounted on a ceramic substrate
of 7 mm x 5 mm x 0,5 mm

$$R_{th\ j-a} = 0,62 \text{ } ^\circ\text{C/mW}$$

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified.

| | | | | |
|---|-------------|------|------|----------|
| Forward voltage | V_F | < | 1,0 | V |
| $I_F = 100$ mA | V_F | < | 1,25 | V |
| $I_F = 200$ mA | | | | |
| Reverse breakdown voltage (1) | $V_{(BR)R}$ | > | 120 | V |
| BAS19; $I_R = 100$ μ A | $V_{(BR)R}$ | > | 200 | V |
| BAS20; $I_R = 100$ μ A | $V_{(BR)R}$ | > | 250 | V |
| BAS21; $I_R = 100$ μ A (2) | | | | |
| Reverse current | I_R | < | 100 | nA |
| $V_R = V_{Rmax}$ | I_R | < | 100 | μ A |
| $V_R = V_{Rmax}; T_j = 150$ °C | | | | |
| Differential resistance | r_{diff} | typ. | 5 | Ω |
| $I_F = 10$ mA | | | | |
| Diode capacitance | C_d | < | 5 | pF |
| $V_R = 0; f = 1$ MHz | | | | |
| Reverse recovery time (see Figs 2 and 3) when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100$ Ω ; measured at $I_R = 3$ mA | t_{rr} | < | 50 | ns |

(1) Measured under pulse conditions; Pulse time = $t_p \leq 0,3$ ms.

(2) At zero life time, measured under pulse conditions to avoid excessive dissipation and voltage limited to 275 V.

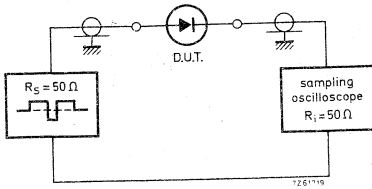


Fig. 2 Test circuit.

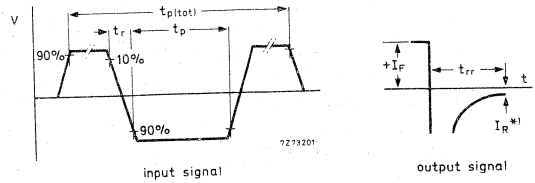


Fig. 3 Waveforms; $I_R = 3 \text{ mA}$.

Input signal

| | |
|----------------------------|-----------------------------------|
| total pulse duration | $t_p(\text{tot}) = 2 \mu\text{s}$ |
| duty factor | $\delta = 0,0025$ |
| rise time of reverse pulse | $t_r = 0,6 \text{ ns}$ |
| reverse pulse duration | $t_p = 100 \text{ ns}$ |

Oscilloscope

| | |
|----------------------|-------------------------|
| rise time | $t_r = 0,35 \text{ ns}$ |
| circuit capacitance* | $C < 1 \text{ pF}$ |

*C = oscilloscope input capacitance + parasitic capacitance.

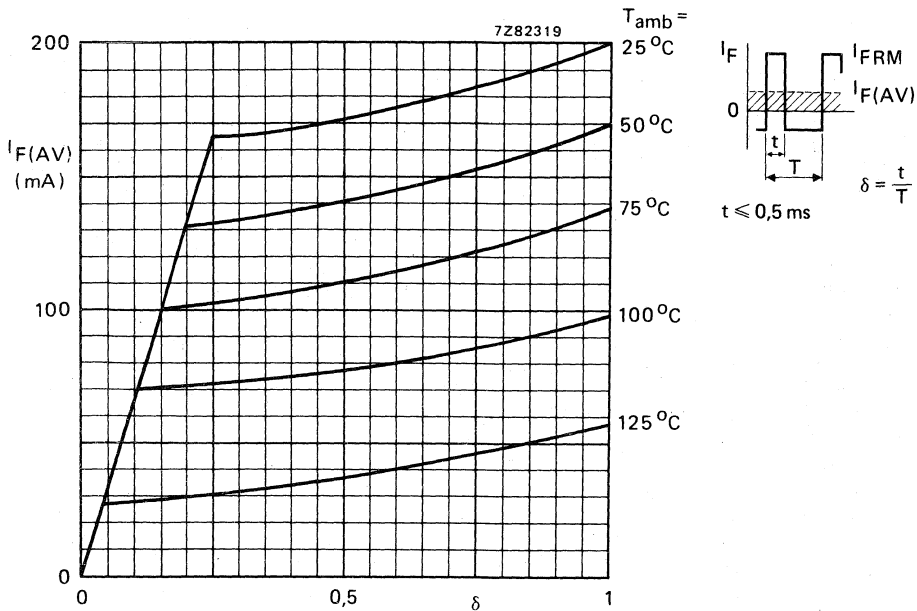


Fig. 4 BAS19; maximum permissible average rectified forward current for pulse operation as a function of the duty factor at $V_R = 100 \text{ V}$.

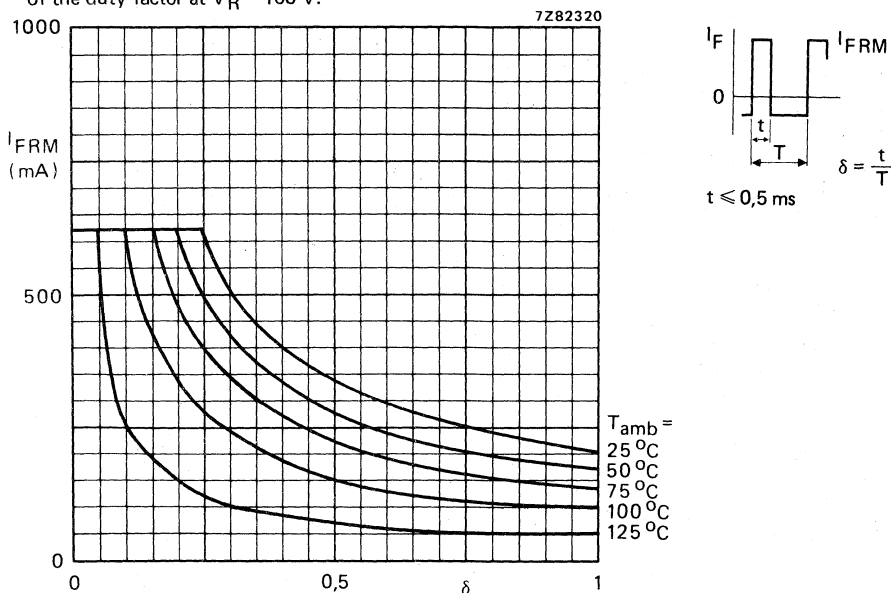


Fig. 5 BAS19; maximum permissible repetitive peak forward current for pulse operation as a function of the duty factor at $V_R = 100 \text{ V}$.

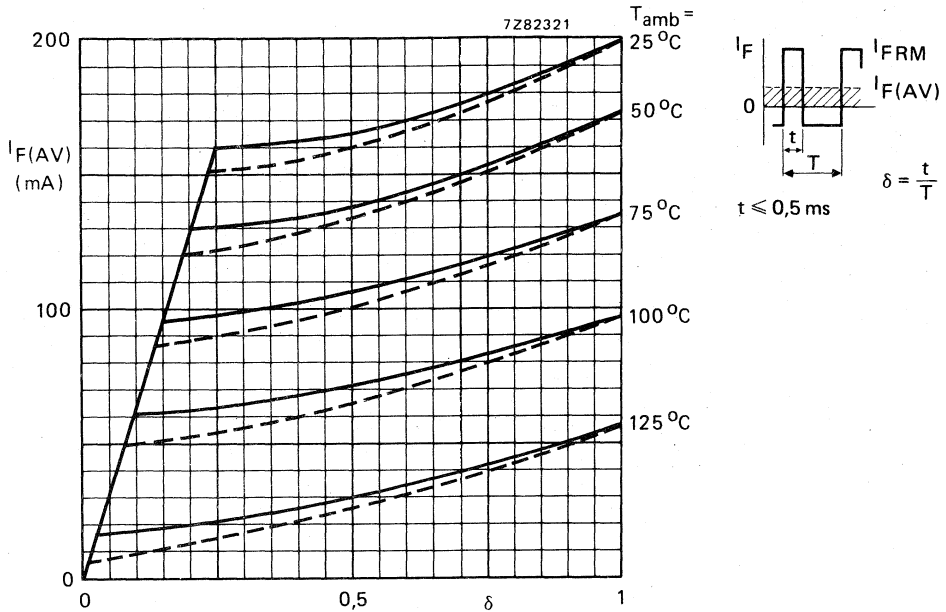


Fig. 6 BAS20/21; maximum permissible average rectified forward current for pulse operation as a function of the duty factor.

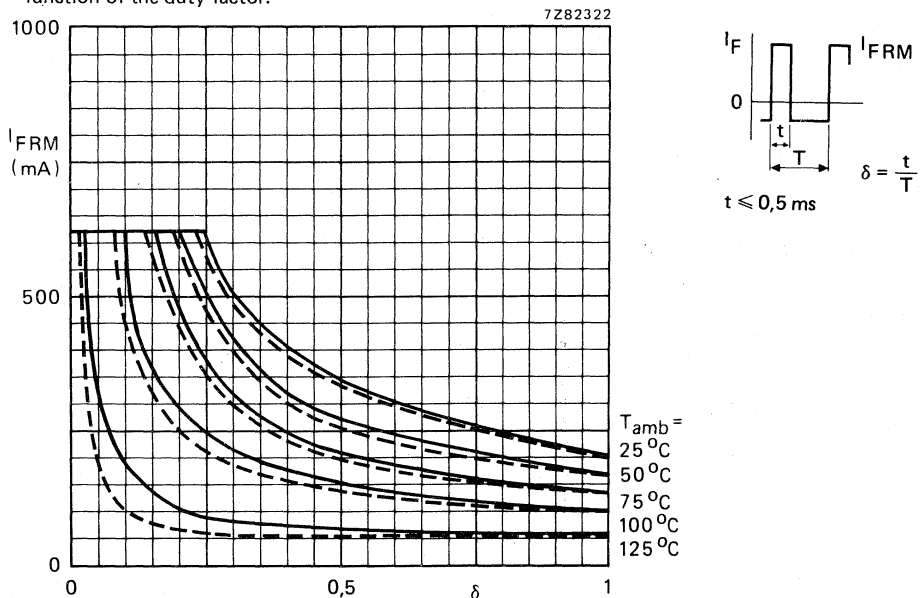


Fig. 7 BAS20/21; maximum permissible repetitive peak forward current for pulse operation as a function of the duty factor.

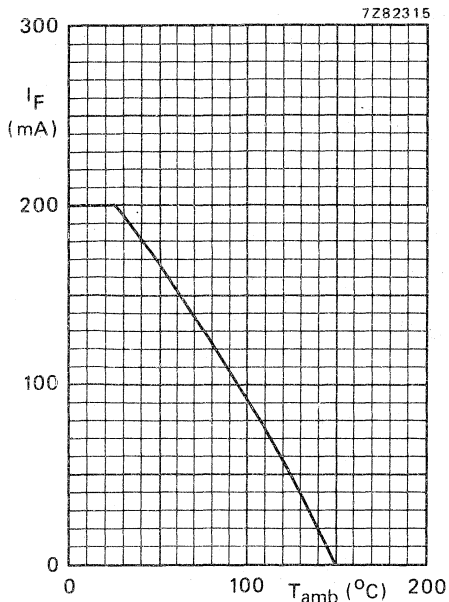


Fig. 8.

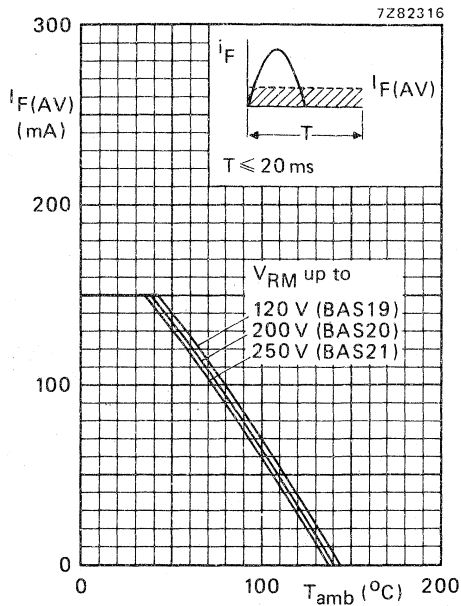


Fig. 9.

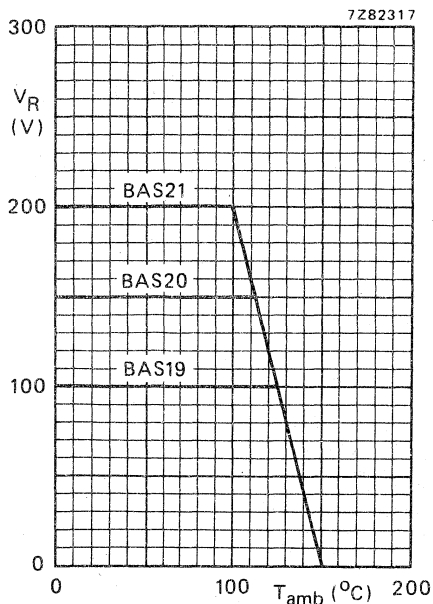


Fig. 10.

Fig. 8 Maximum permissible continuous forward current as a function of the ambient temperature.

Fig. 9 Maximum permissible average rectified forward current as a function of the ambient temperature.

Fig. 10 Maximum permissible continuous reverse voltage as a function of the ambient temperature.

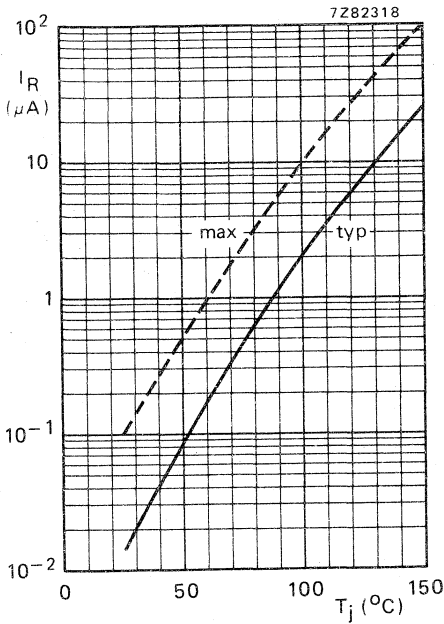


Fig. 11.

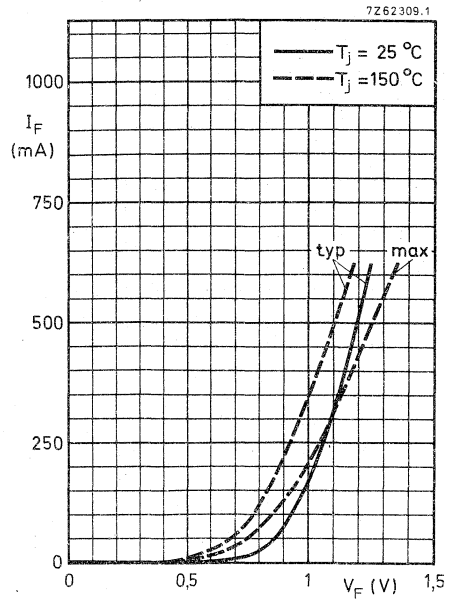


Fig. 12.

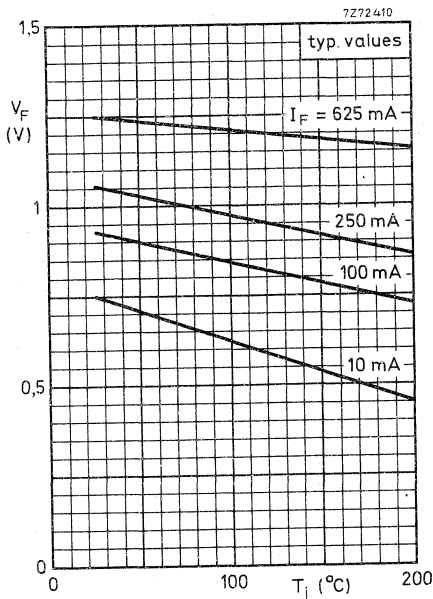


Fig. 13.

Fig. 11 Continuous reverse current as a function of the junction temperature.

Fig. 12 Forward current as a function of forward voltage.

Fig. 13 Forward voltage as a function of the junction temperature.

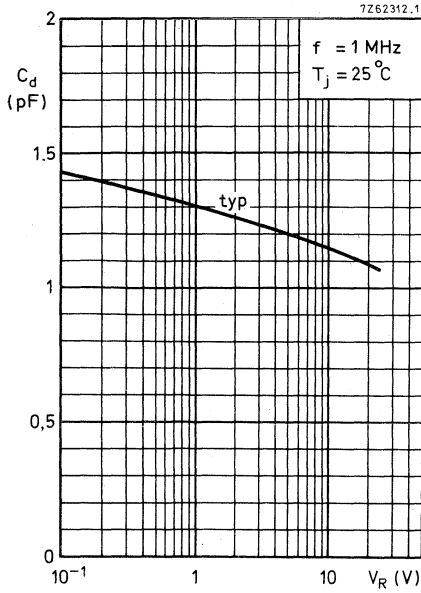


Fig. 14.

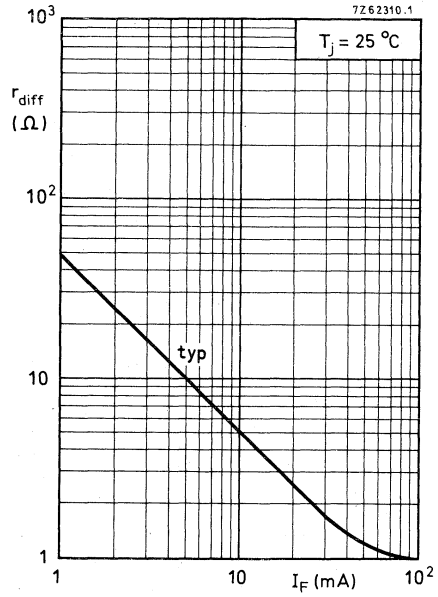


Fig. 15.



SCHOTTKY BARRIER DIODE

Silicon epitaxial diode in a microminiature plastic envelope. Intended for u.h.f. mixer and fast switching applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|-------------|------|------------|
| Continuous reverse voltage | V_R | max. | 4 V |
| Forward current (d.c.) | I_F | max. | 30 mA |
| Junction temperature | T_j | max. | 100 °C |
| Thermal resistance from junction to ambient | R_{thj-a} | = | 0,62 °C/mW |
| Forward voltage at $I_F = 10$ mA | V_F | < | 600 mV |
| Diode capacitance at $V_R = 0$; $f = 1$ MHz | C_d | < | 1,0 pF |
| Noise figure at $f = 900$ MHz | F | < | 8,0 dB |

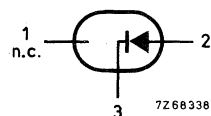
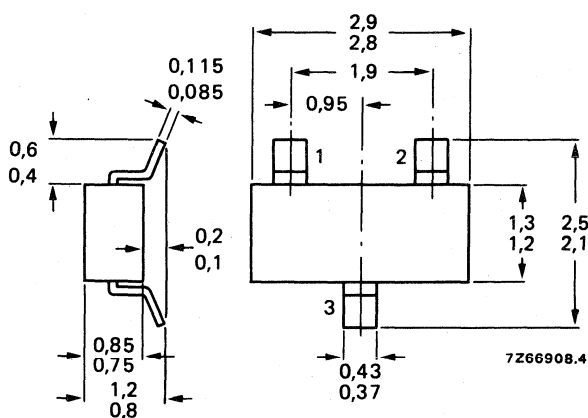
MECHANICAL DATA

Dimensions in mm

Marking code

BAT17 = A3

Fig.1 SOT-23.



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|----------------------------|-----------|------|----------------|
| Continuous reverse voltage | V_R | max. | 4 V |
| Forward current (d.c.) | I_F | max. | 30 mA |
| Storage temperature | T_{stg} | | -65 to +100 °C |
| Junction temperature | T_j | max. | 100 °C |

THERMAL RESISTANCE

From junction to ambient mounted on a ceramic substrate of 7 mm x 5 mm x 0,5 mm

$$R_{th\ j-a} = 0,62 \text{ } ^\circ\text{C/mW}$$

CHARACTERISTICS

$T_{amb} = 25 \text{ } ^\circ\text{C}$ unless otherwise specified

Reverse current

$$V_R = 3 \text{ V}$$

$$I_R < 0,25 \text{ } \mu\text{A}$$

$$V_R = 3 \text{ V}; T_{amb} = 60 \text{ } ^\circ\text{C}$$

$$I_R < 1,25 \text{ } \mu\text{A}$$

Reverse breakdown voltage

$$I_R = 10 \text{ } \mu\text{A}$$

$$V_{(BR)R} > 4 \text{ V}$$

Forward voltage

$$I_F = 0,1 \text{ mA}$$

$$V_F < 350 \text{ mV}$$

$$I_F = 1,0 \text{ mA}$$

$$V_F < 450 \text{ mV}$$

$$I_F = 10 \text{ mA}$$

$$V_F < 600 \text{ mV}$$

Diode capacitance

$$V_R = 0; f = 1 \text{ MHz}$$

$$C_d < 1,0 \text{ pF}$$

Noise figure at $f = 900 \text{ MHz}$ *

$$F < 8,0 \text{ dB}$$

Series resistance at $f = 1 \text{ kHz}$

$$I_F = 5 \text{ mA}$$

$$r_D < 15 \text{ } \Omega$$

* The local oscillator is adjusted for a diode current of 2 mA. I.F. amplifier noise $F_{if} = 1,5 \text{ dB}$; $f = 35 \text{ MHz}$.

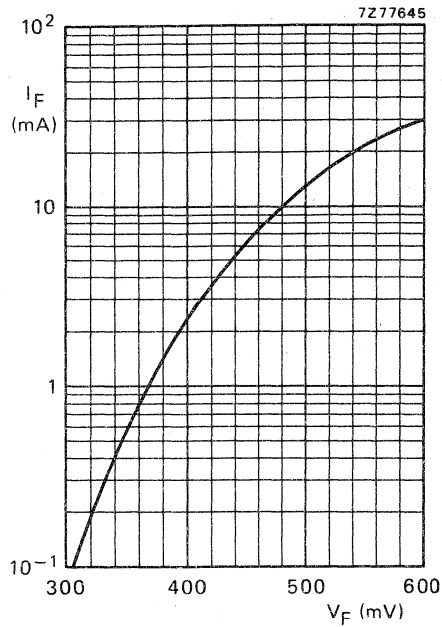


Fig. 2 Typical values.



SILICON PLANAR DIODE

Switching diode in a microminiature plastic envelope. Intended for thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|-------|-----------|------------------------------|
| Continuous reverse voltage | V_R | max. | 35 V |
| Forward current (d.c.) | I_F | max. | 100 mA |
| Junction temperature | T_j | max. | 100 °C |
| Diode capacitance at $f = 1$ MHz $V_R = 20$ V | C_d | typ. < | 0,8 pF 1,0 pF |
| Series resistance at $f = 200$ MHz $I_F = 5$ mA | r_D | typ. < | 0,5 Ω 0,7 Ω |

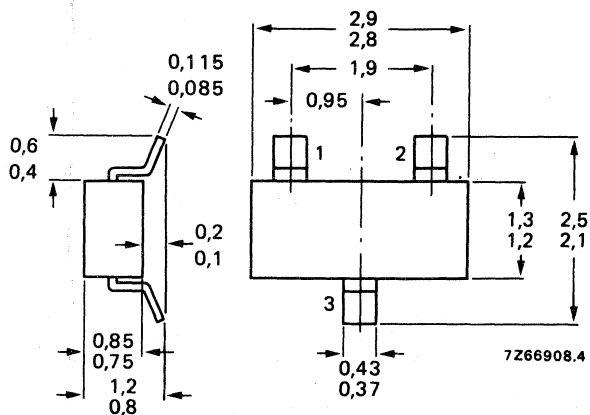
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAT18 = A2



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|----------------------------|-----------|------|----------------|
| Continuous reverse voltage | V_R | max. | 35 V |
| Forward current (d.c.) | I_F | max. | 100 mA |
| Storage temperature | T_{stg} | | -55 to +100 °C |
| Junction temperature | T_j | max. | 100 °C |

THERMAL RESISTANCE

From junction to ambient mounted on a ceramic substrate of 7 mm x 5 mm x 0,5 mm

$$R_{thj-a} = 0,62 \text{ °C/mW}$$

CHARACTERISTICS

$T_j = 25 \text{ °C}$ unless otherwise specified

Forward voltage at $I_F = 100 \text{ mA}$

$$V_F < 1,2 \text{ V}$$

Reverse current

$$V_R = 20 \text{ V}$$

$$I_R < 100 \text{ nA}$$

$$V_R = 20 \text{ V}; T_j = 60 \text{ °C}$$

$$I_R < 1 \text{ } \mu\text{A}$$

Diode capacitance at $f = 1 \text{ MHz}$

$$V_R = 20 \text{ V}$$

$$C_d \begin{matrix} \text{typ.} & 0,8 \text{ pF} \\ < & 1,0 \text{ pF} \end{matrix}$$

Series resistance at $f = 200 \text{ MHz}$

$$I_F = 5 \text{ mA}$$

$$r_D \begin{matrix} \text{typ.} & 0,5 \text{ } \Omega \\ < & 0,7 \text{ } \Omega \end{matrix}$$

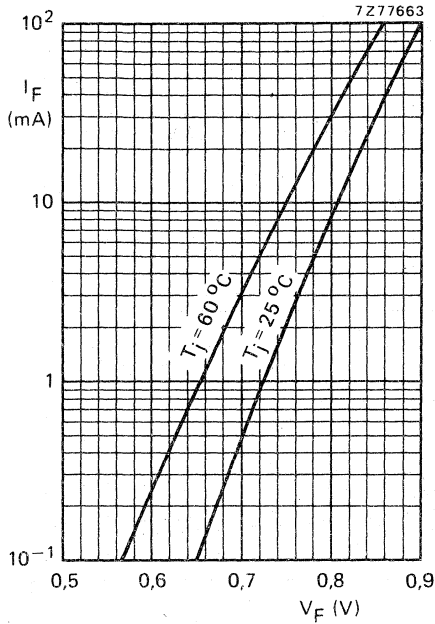


Fig. 2 Typical values.

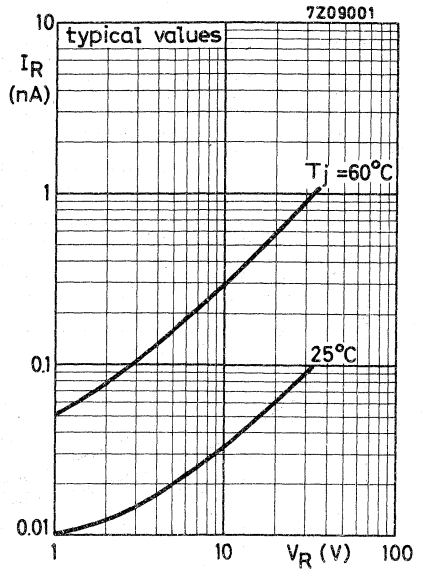


Fig. 3.

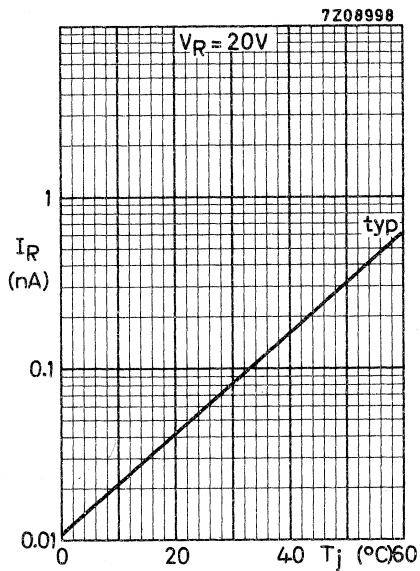


Fig. 4.

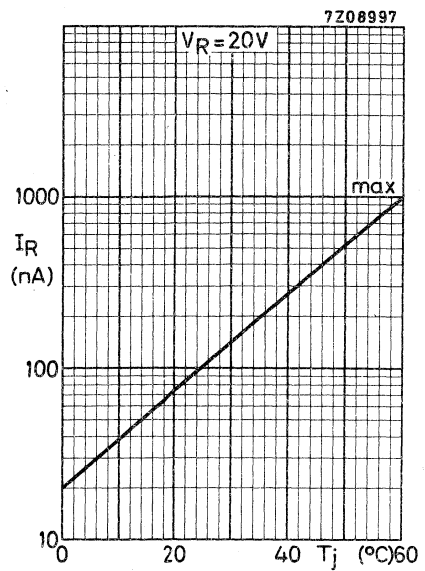


Fig. 5.

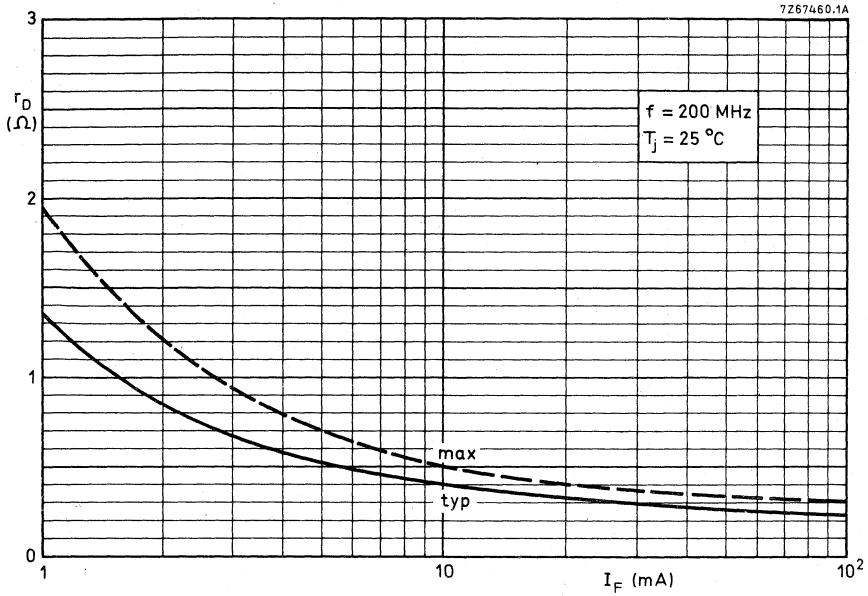


Fig. 6.



SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAV70 consists of two diodes in a microminiature plastic envelope. The cathodes are commoned and the unit is intended for high-speed switching in thick and thin-film circuits.

QUICK REFERENCE DATA (per diode)

| | | | | |
|--|-----------|------|--------|---|
| Continuous reverse voltage | V_R | max. | 70 V | |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V | |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA | ← |
| Junction temperature | T_j | max. | 175 °C | ← |
| Forward voltage at $I_F = 50$ mA | V_F | < | 1,0 V | ← |
| Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA | t_{rr} | < | 6 ns | |
| Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$ | Q_s | < | 45 pC | |

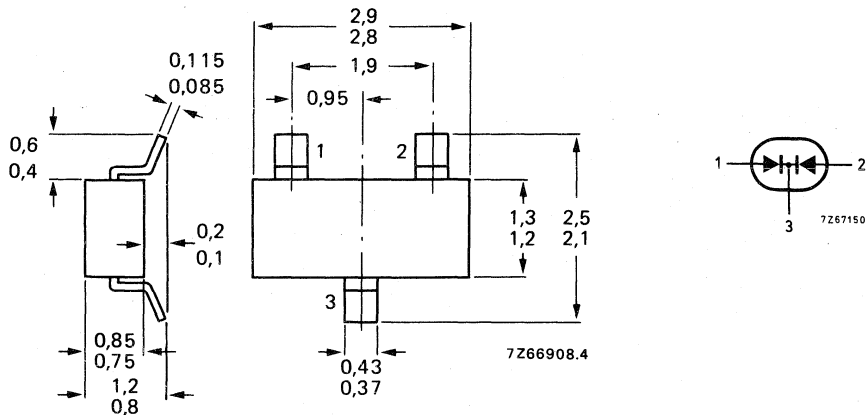
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAV70 = A4



See also *Soldering recommendations*.

RATINGS (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-------------|----------|--------|
| Continuous reverse voltage | V_R | max. | 70 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V |
| Average rectified forward current [▲] → (averaged over any 20 ms period) | $I_{F(AV)}$ | max. | 250 mA |
| → Forward current (d.c.) | I_F | max. | 250 mA |
| → Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| → Storage temperature | T_{stg} | -65 to + | 175 °C |
| → Junction temperature | T_j | max. | 175 °C |

THERMAL CHARACTERISTICS*

→ $T_{j1} = P_1 (R_{th\ j-t}) + T_{tab}$
 $T_{j2} = P_2 (R_{th\ j-t}) + T_{tab}$
 $T_{tab} = P_{tot} (R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS (per diode)

 $T_j = 25\text{ °C}$ unless otherwise specified

Forward voltage

| | | | |
|-----------------------|-------|---|---------|
| $I_F = 1\text{ mA}$ | V_F | < | 715 mV |
| $I_F = 10\text{ mA}$ | V_F | < | 855 mV |
| $I_F = 50\text{ mA}$ | V_F | < | 1000 mV |
| $I_F = 150\text{ mA}$ | V_F | < | 1250 mV |

Reverse current

| | | | |
|--|-------|---|-------------------|
| $V_R = 25\text{ V}; T_j = 150\text{ °C}$ | I_R | < | 60 μA |
| $V_R = 70\text{ V}$ | I_R | < | 5 μA |
| $V_R = 70\text{ V}; T_j = 150\text{ °C}$ | I_R | < | 100 μA |

Diode capacitance

| | | | |
|-----------------------------|-------|---|--------|
| $V_R = 0; f = 1\text{ MHz}$ | C_d | < | 1,5 pF |
|-----------------------------|-------|---|--------|

Forward recovery voltage when switched to

| | | | |
|--|----------|---|--------|
| $I_F = 10\text{ mA}; t_r = 20\text{ ns}$ | V_{fr} | < | 1,75 V |
|--|----------|---|--------|

▲ Measured under pulse conditions : pulse time $t_p \leq 0,5\text{ ms}$.For sinusoidal operation $I_{F(AV)} = 150\text{ mA}$; averaging time $t_{(av)} \leq 1\text{ ms}$.* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,2 mm.

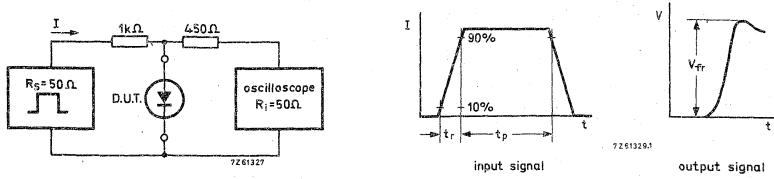


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal : Rise time of the forward pulse $t_r = 20$ ns; Forward current pulse duration $t_p = 120$ ns; Duty factor $\delta = 0,01$

Oscilloscope : Rise time $t_r = 0,35$ ns

Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance)

Reverse recovery time when switched from

$I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$;
measured at $I_R = 1$ mA

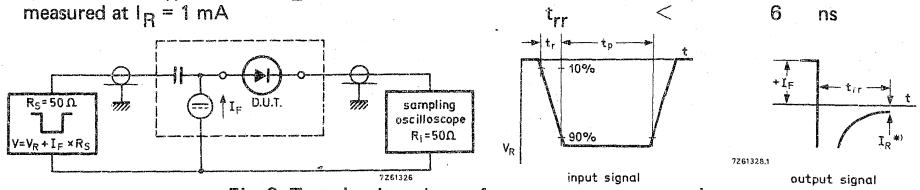


Fig. 3 Test circuit and waveforms; reverse recovery time.

*) $I_R = 1$ mA

Input signal : Rise time of the reverse pulse $t_r = 0,6$ ns; reverse pulse duration $t_p = 100$ ns; duty factor $\delta = 0,05$

Oscilloscope : Rise time $t_r = 0,35$ ns

Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance)

Recovery charge when switched from

$I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$

$Q_s < 45$ pC

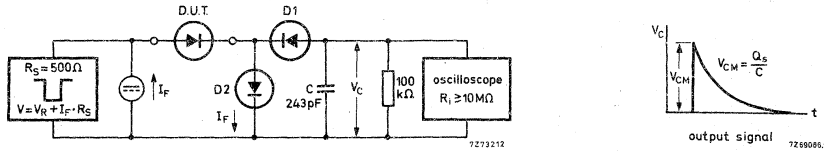


Fig. 4 Test circuit and waveform; recovery charge.

D1 = BAW62

D2 = diode with minority carrier life time at 10 mA: < 200 ps

Input signal : Rise time of the reverse pulse = $t_r = 2$ ns; Reverse pulse duration = $t_p = 400$ ns; Duty factor = $\delta = 0,02$

Circuit capacitance $C \leq 7$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance)

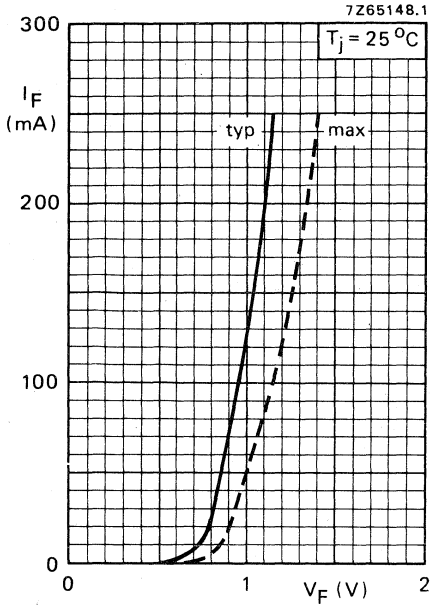


Fig. 5

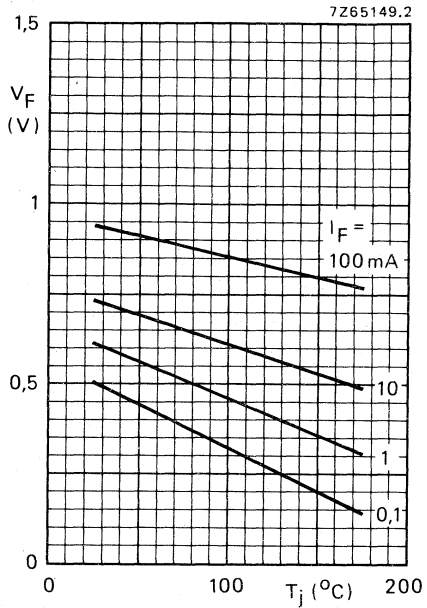


Fig. 6

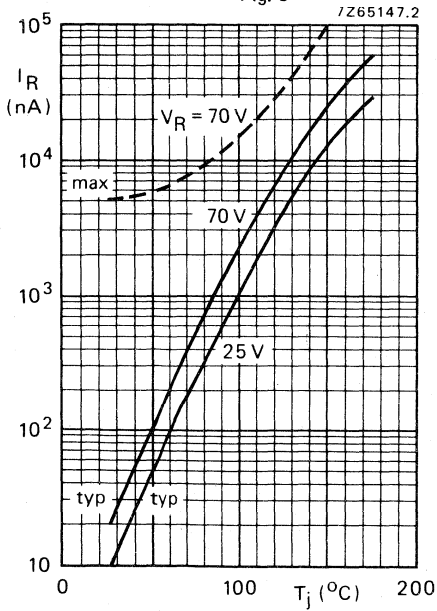


Fig. 7

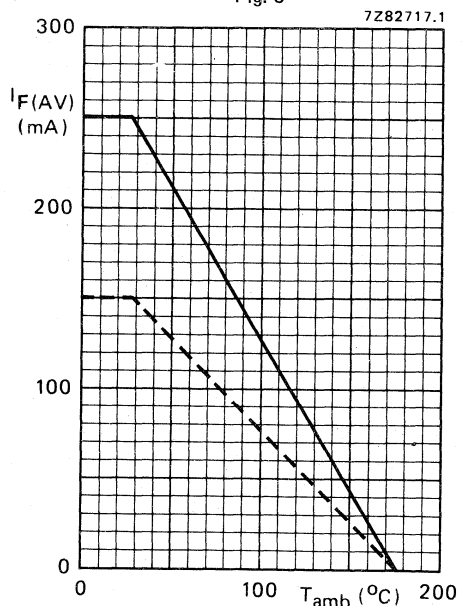


Fig. 8 — single diode
 - - - double diode, equally loaded.

SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAV99 consists of two diodes in a microminiature plastic envelope. The diodes are connected in series and the unit is intended for high-speed switching in thick and thin-film circuits.

QUICK REFERENCE DATA (per diode)

| | | | |
|--|-----------|------|----------|
| Continuous reverse voltage | V_R | max. | 70 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Junction temperature | T_j | max. | 175 °C ← |
| Forward voltage at $I_F = 50$ mA | V_F | < | 1,0 V |
| Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA | t_{rr} | < | 6 ns |
| Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$ | Q_s | < | 45 pC |

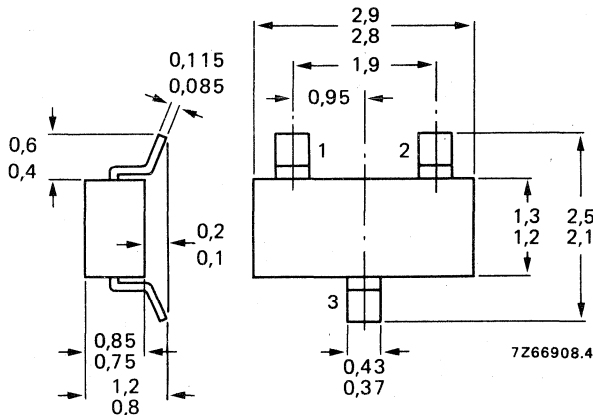
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAV99 = A7



See also *Soldering recommendations*.

RATINGS (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-------------|-------------|--------|
| Continuous reverse voltage | V_R | max. | 70 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V |
| Average rectified forward current [▲] (averaged over any 20 ms period) | $I_{F(AV)}$ | max. | 250 mA |
| Forward current (d.c.) | I_F | max. | 250 mA |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| → Storage temperature | T_{stg} | -65 to +175 | °C |
| → Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_{j1} = P_1 (R_{th\ j-t}) + T_{tab}$$

$$T_{j2} = P_2 (R_{th\ j-t}) + T_{tab}$$

$$T_{tab} = P_{tot} (R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS (per diode) $T_j = 25\text{ °C}$ unless otherwise specified

Forward voltage

| | | | |
|-----------------------|-------|---|---------|
| $I_F = 1\text{ mA}$ | V_F | < | 715 mV |
| $I_F = 10\text{ mA}$ | V_F | < | 855 mV |
| $I_F = 50\text{ mA}$ | V_F | < | 1000 mV |
| $I_F = 150\text{ mA}$ | V_F | < | 1250 mV |

Reverse current

| | | | |
|--|-------|---|-------------------|
| $V_R = 25\text{ V}; T_j = 150\text{ °C}$ | I_R | < | 30 μA |
| $V_R = 70\text{ V}$ | I_R | < | 2,5 μA |
| $V_R = 70\text{ V}; T_j = 150\text{ °C}$ | I_R | < | 50 μA |

Diode capacitance

| | | | |
|-----------------------------|-------|---|--------|
| $V_R = 0; f = 1\text{ MHz}$ | C_d | < | 1,5 pF |
|-----------------------------|-------|---|--------|

Forward recovery voltage when switched to

| | | | |
|--|----------|---|--------|
| $I_F = 10\text{ mA}; t_r = 20\text{ ns}$ | V_{fr} | < | 1,75 V |
|--|----------|---|--------|

▲ Measured under pulse conditions: pulse time $t_p \leq 0,5\text{ ms}$.For sinusoidal operation $I_{F(AV)} = 150\text{ mA}$; averaging time $t_{(av)} \leq 1\text{ ms}$.* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm

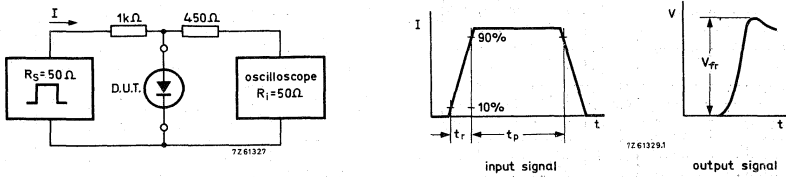


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal: Rise time of the forward pulse $t_r = 20$ ns;
 Forward current pulse duration $t_p = 120$ ns. Duty factor $\delta = 0,01$.
 Oscilloscope: Rise time $t_r = 0,35$ ns.
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).
 Reverse recovery time when switched from
 $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$;
 measured at $I_R = 1$ mA

$$t_{rr} < 6 \text{ ns}$$

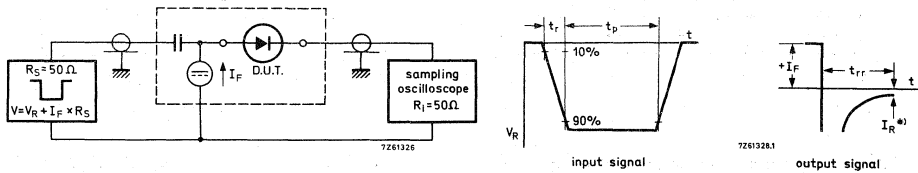


Fig. 3 Test circuit and waveforms; reverse recovery time.

Input signal: Rise time of the reverse pulse $t_r = 0,6$ ns
 Reverse pulse duration $t_p = 100$ ns. Duty factor $\delta = 0,05$.
 Oscilloscope: Rise time $t_r = 0,35$ ns.
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).
 Recovery charge when switched from
 $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$

$$*) I_R = 1 \text{ mA}$$

$$Q_s < 45 \text{ pC}$$

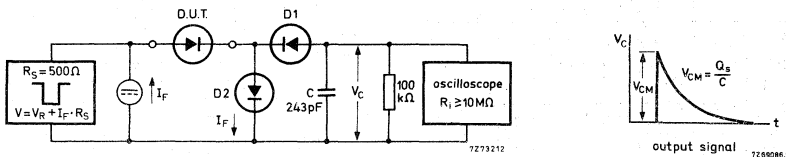


Fig. 4 Test and waveform; recovery charge.

D2 = diode with minority carrier life time at 10 mA: < 200 ps; D1 = BAW62.
 Input signal: Rise time of the reverse pulse $t_r = 2$ ns
 Reverse pulse duration $t_p = 400$ ns. Duty factor $\delta = 0,02$.
 Circuit capacitance $C \leq 7$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).

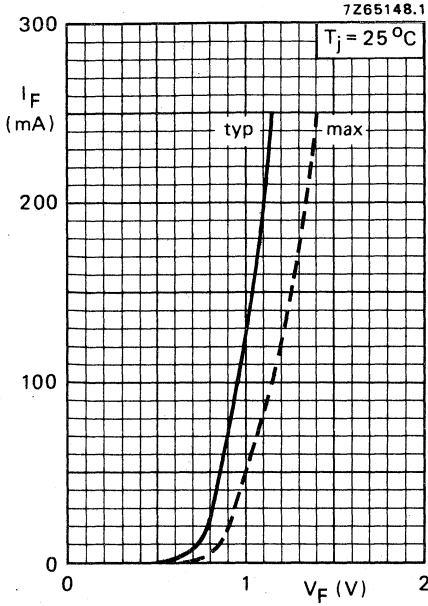


Fig. 5.

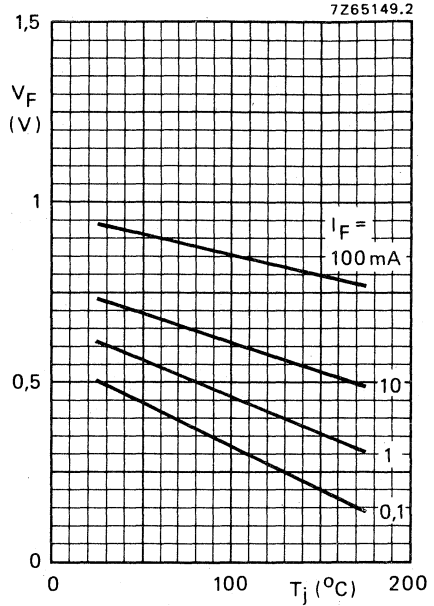


Fig. 6 Typical values.

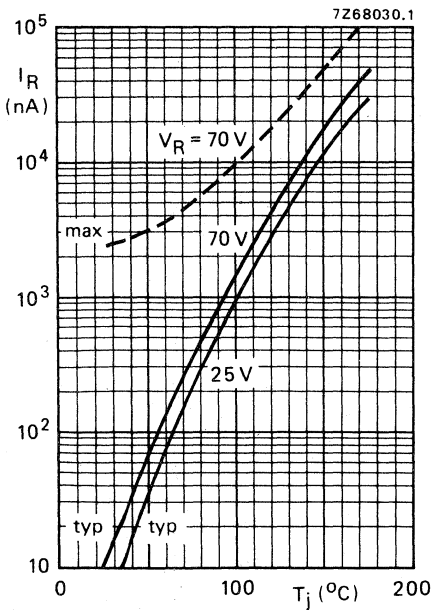


Fig. 7.

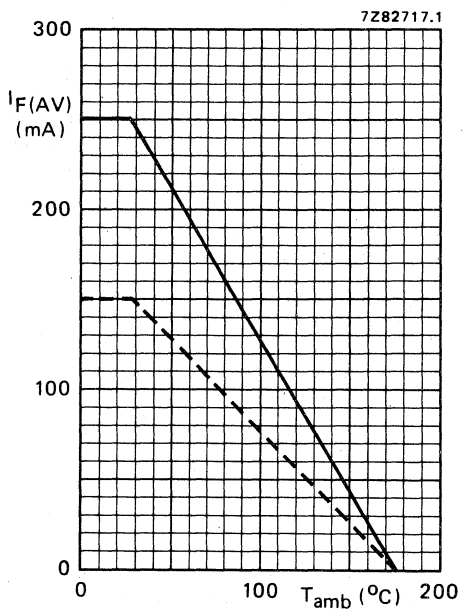


Fig. 8 — single diode
----- double diode; equally loaded.

SILICON PLANAR EPITAXIAL HIGH-SPEED DIODES

The BAW56 consists of two diodes in a microminiature plastic envelope. The anodes are commoned and the unit is intended for high-speed switching in thick and thin-film circuits.

QUICK REFERENCE DATA (per diode)

| | | | |
|--|-----------|------|--------|
| Continuous reverse voltage | V_R | max. | 70 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Junction temperature | T_j | max. | 175 °C |
| Forward voltage at $I_F = 50$ mA | V_F | < | 1,0 V |
| Reverse recovery time when switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$; measured at $I_R = 1$ mA | t_{rr} | < | 6 ns |
| Recovery charge when switched from $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$ | Q_s | < | 45 pC |

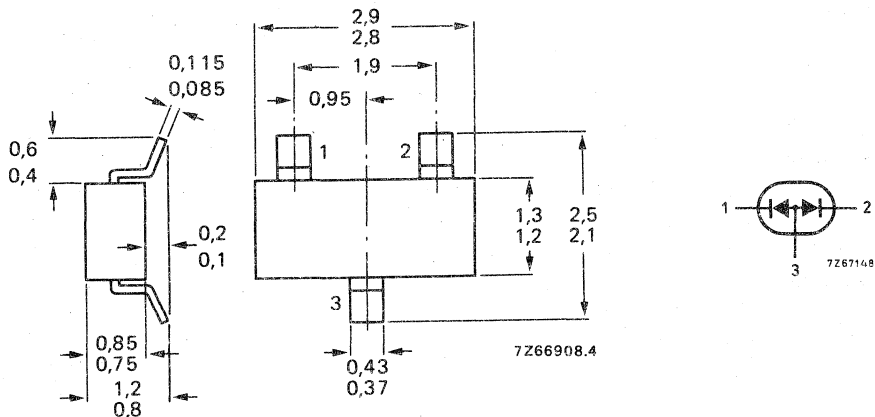
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BAW56 = A1



See also *Soldering recommendations*.

RATINGS (per diode)

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-------------|-------------|--------|
| Continuous reverse voltage | V_R | max. | 70 V |
| Repetitive peak reverse voltage | V_{RRM} | max. | 70 V |
| Average rectified forward current [▲] (averaged over any 20 ms period) | $I_{F(AV)}$ | max. | 250 mA |
| Forward current (d.c.) | I_F | max. | 250 mA |
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| → Storage temperature | T_{stg} | -65 to +175 | °C |
| → Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_{j1} = P_1 (R_{th j-t}) + T_{tab}$$

$$T_{j2} = P_2 (R_{th j-t}) + T_{tab}$$

$$T_{tab} = P_{tot} (R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|--------------|---|-------------|
| From junction to tab | $R_{th j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 2 x 260 K/W |
| From soldering points to ambient ** | $R_{th s-a}$ | = | 2 x 120 K/W |

CHARACTERISTICS (per diode)

$T_j = 25$ °C unless otherwise specified

Forward voltage

| | | | |
|----------------|-------|---|---------|
| $I_F = 1$ mA | V_F | < | 715 mV |
| $I_F = 10$ mA | V_F | < | 855 mV |
| $I_F = 50$ mA | V_F | < | 1000 mV |
| $I_F = 150$ mA | V_F | < | 1250 mV |

Reverse current

| | | | |
|------------------------------|-------|---|-------------|
| $V_R = 25$ V; $T_j = 150$ °C | I_R | < | 30 μ A |
| $V_R = 70$ V | I_R | < | 2,5 μ A |
| $V_R = 70$ V; $T_j = 150$ °C | I_R | < | 50 μ A |

Diode capacitance

| | | | |
|-------------------------|-------|---|------|
| $V_R = 0$; $f = 1$ MHz | C_d | < | 2 pF |
|-------------------------|-------|---|------|

Forward recovery voltage when switched to

| | | | |
|------------------------------|----------|---|--------|
| $I_F = 10$ mA; $t_r = 20$ ns | V_{fr} | < | 1,75 V |
|------------------------------|----------|---|--------|

▲ Measured under pulse conditions: pulse time $t_p \leq 0,5$ ms.
 For sinusoidal operation $I_{F(AV)} = 150$ mA; averaging time $t_{(av)} \leq 1$ ms.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

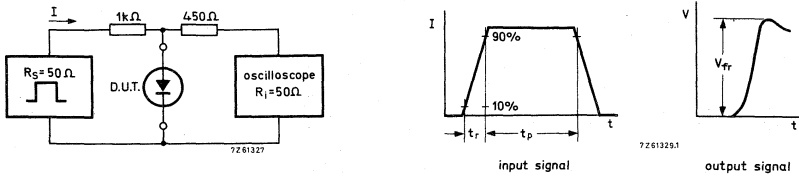


Fig. 2 Test circuit and waveforms; forward recovery voltage.

Input signal: Rise time of the forward pulse $t_r = 20$ ns
 Forward current pulse duration $t_p = 120$ ns. Duty factor $\delta = 0,01$
 Oscilloscope: Rise time $t_r = 0,35$ ns.
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance)
 Reverse recovery time when switched from
 $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100 \Omega$;
 measured at $I_R = 1$ mA

$$t_{rr} < 6 \text{ ns}$$

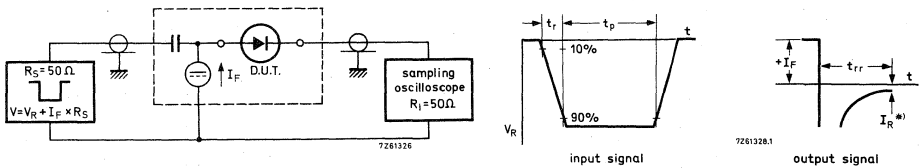


Fig. 3 Test circuit and waveforms; reverse recovery time.

Input signal: Rise time of the reverse pulse $t_r = 0,6$ ns
 Reverse pulse duration $t_p = 100$ ns. Duty factor $\delta = 0,05$.
 Oscilloscope: Rise time $t_r = 0,35$ ns
 Circuit capacitance $C \leq 1$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance)
 Recovery charge when switched from
 $I_F = 10$ mA to $V_R = 5$ V; $R_L = 500 \Omega$

$$Q_s < 45 \text{ pC}$$

*) $I_R = 1$ mA

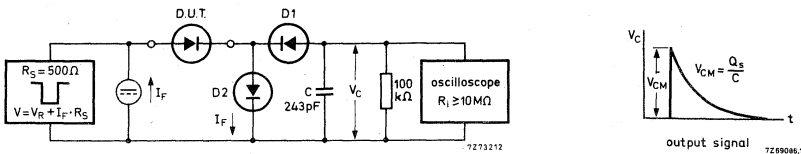


Fig. 4 Test circuit and waveform; recovery charge.

D2 = diode with minority carrier life time at 10 mA: < 200 ps. D1 = BAW62.
 Input signal: Rise time of the reverse pulse $t_r = 2$ ns
 Reverse pulse duration $t_p = 400$ ns. Duty factor $\delta = 0,02$
 Circuit capacitance $C \leq 7$ pF ($C =$ oscilloscope input capacitance + parasitic capacitance).

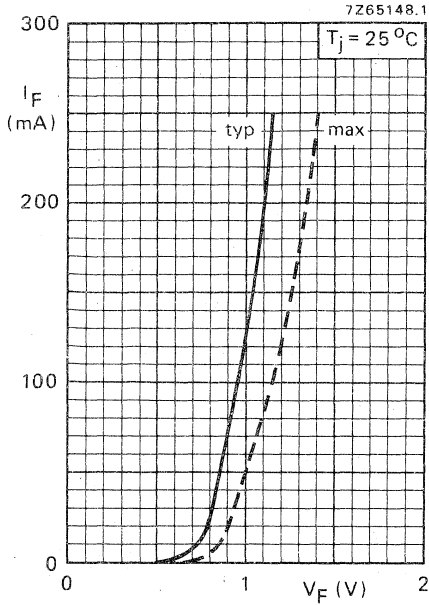


Fig. 5.

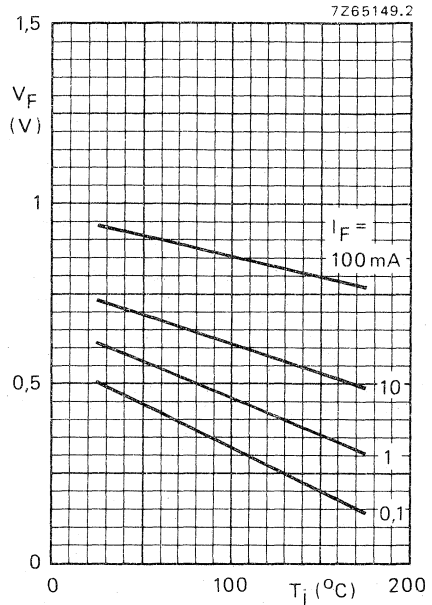


Fig. 6 Typical values.

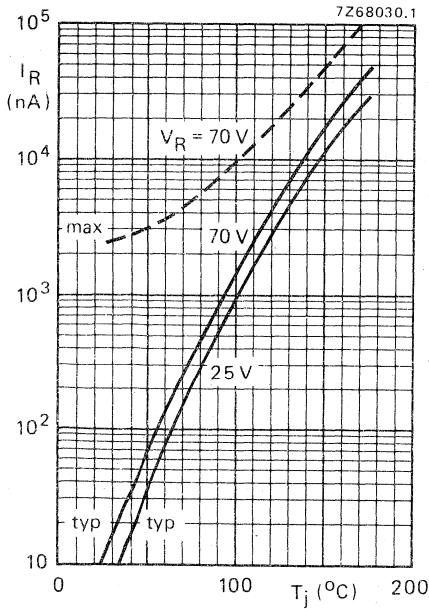


Fig. 7.

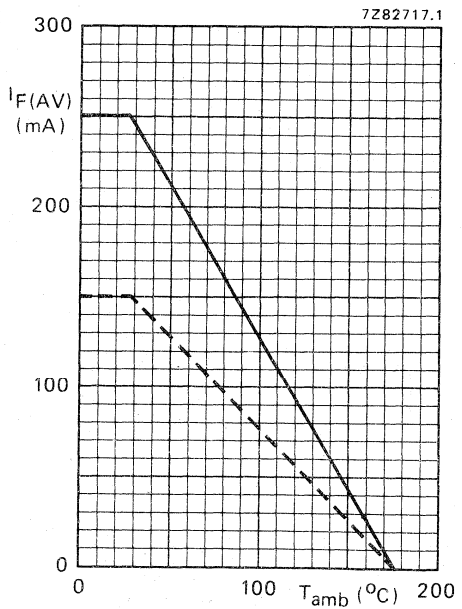


Fig. 8 — single diode;
----- double diode, equally loaded.

VARIABLE CAPACITANCE DIODE

Silicon planar variable capacitance diode in a microminiature envelope. It is intended for electronic tuning applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|--|------|---------------|
| Reverse voltage | V_R | max. | 28 V |
| Reverse current at $V_R = 28$ V | I_R | < | 50 nA |
| Diode capacitance at $f = 1$ MHz $V_R = 25$ V | C_d | | 1,8 to 2,8 pF |
| Capacitance ratio at $f = 1$ MHz | $\frac{C_d (V_R = 3 \text{ V})}{C_d (V_R = 25 \text{ V})}$ | typ. | 5 |
| Series resistance at $f = 470$ MHz $V_R =$ that value at which $C_d = 9$ pF | r_D | < | 1,2 Ω |

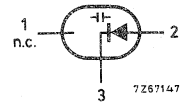
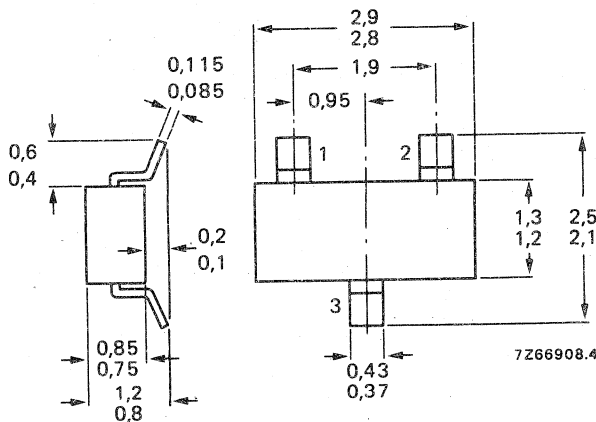
MECHANICAL DATA

Dimensions in mm

Marking code

BBY31 = S1

Fig. 1 SOT-23.



See also *Soldering recommendations*.

RATINGS Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | | |
|----------------------------------|-----------|------|-------------|----|
| Continuous reverse voltage | V_R | max. | 28 | V |
| Reverse voltage (peak value) | V_{RM} | max. | 30 | V |
| Forward current (d. c.) | I_F | max. | 20 | mA |
| Storage temperature | T_{stg} | | -65 to +100 | °C |
| → Operating junction temperature | T_j | max. | 85 | °C |

THERMAL RESISTANCE

From junction to ambient
 mounted on a ceramic substrate of
 7 mm x 5 mm x 0,5 mm

$$R_{th\ j-a} = 0,62\ \text{°C/mW}$$

CHARACTERISTICS

$T_j = 25\ \text{°C}$ unless otherwise specified

Reverse current

| | | | | |
|---|-------|---|------|----|
| $V_R = 28\ \text{V}$ | I_R | < | 50 | nA |
| → $V_R = 28\ \text{V}; T_j = 85\ \text{°C}$ | I_R | < | 1000 | nA |

Diode capacitance at f = 1 MHz

| | | | | |
|----------------------|-------|------|------------|----|
| $V_R = 1\ \text{V}$ | C_d | typ. | 17,5 | pF |
| $V_R = 3\ \text{V}$ | C_d | typ. | 11,5 | pF |
| $V_R = 25\ \text{V}$ | C_d | | 1,8 to 2,8 | pF |

Capacitance ratio at f = 1 MHz

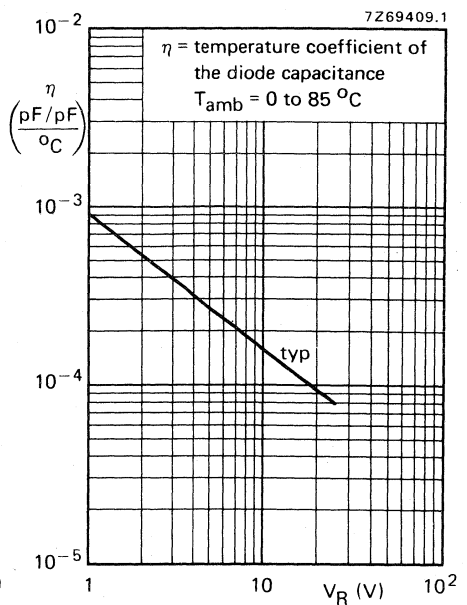
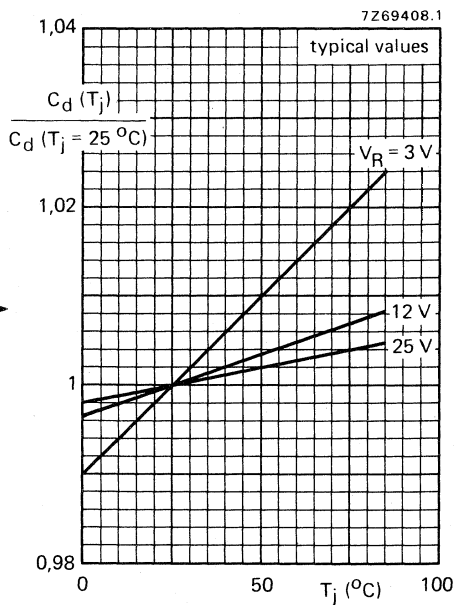
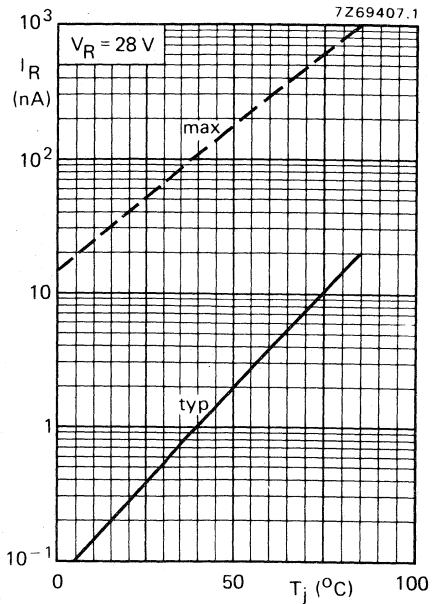
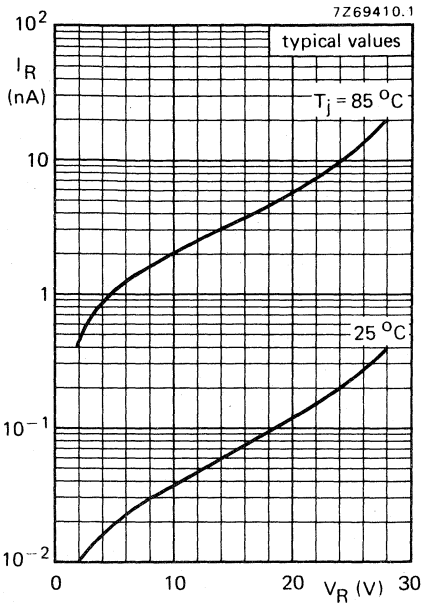
$$\frac{C_d(V_R = 3\ \text{V})}{C_d(V_R = 25\ \text{V})} \text{ typ. } 5$$

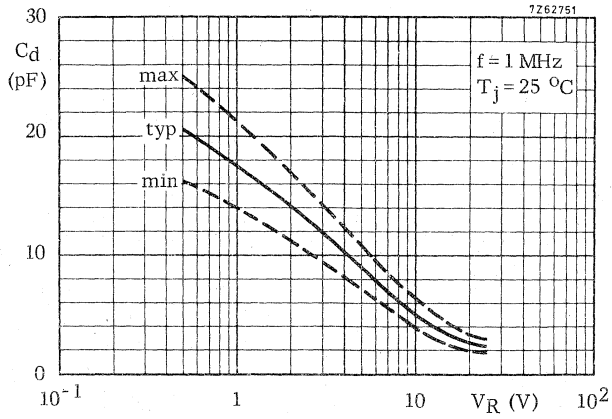
Series resistance

at f = 470 MHz and at that value
 of V_R at which $C_d = 9\ \text{pF}$

$$r_D < 1,2\ \Omega$$







BBY31
BBY31
BBY31
BBY31
BBY31
BBY31

DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not form part of our data handbook system and does not necessarily imply that the device will go into production

BBY40

SILICON PLANAR VARIABLE CAPACITANCE DIODE

The BBY40 is a variable capacitance diode in a plastic envelope intended for electronic tuning in v.h.f. television tuners with extended band I (FCC and OIRT-norm).

QUICK REFERENCE DATA

| | | | |
|--|--|------|--------------|
| Continuous reverse voltage | V_R | max. | 28 V |
| Reverse current at $V_R = 28$ V | I_R | < | 50 nA |
| Diode capacitance at $f = 1$ MHz | C_d | | 26 to 32 pF |
| $V_R = 3$ V | C_d | | 4,3 to 6 pF |
| $V_R = 25$ V | C_d | | 4,3 to 6 pF |
| Capacitance ratio at $f = 1$ MHz | $\frac{C_d(V_R = 3\text{ V})}{C_d(V_R = 25\text{ V})}$ | | 5 to 6,5 |
| Series resistance at $f = 200$ MHz | r_D | < | 0,6 Ω |
| V_R is that value at which $C_d = 25$ pF | | | |

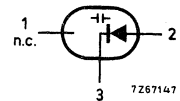
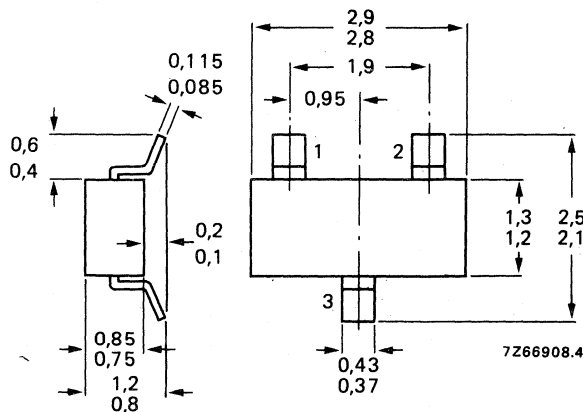
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BBY40 = S2



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|-----------------|
| Continuous reverse voltage | V_R | max. | 28 V |
| Reverse voltage (repetitive peak value) | V_{RRM} | max. | 30 V |
| Forward current (d.c.) | I_F | max. | 20 mA |
| Storage temperature | T_{stg} | | -55 to + 100 °C |
| Operating junction temperature | T_j | max. | 85 °C |

CHARACTERISTICS

$T_{amb} = 25$ °C unless otherwise specified

Reverse current

$V_R = 28$ V

| | | |
|-------|------|--------|
| I_R | typ. | 0,1 nA |
| | < | 50 nA |

$V_R = 28$ V; $T_{amb} = 60$ °C

| | | |
|-------|---|--------|
| I_R | < | 500 nA |
|-------|---|--------|

Diode capacitance at $f = 1$ MHz

$V_R = 3$ V

| | | |
|-------|--|-------------|
| C_d | | 26 to 32 pF |
|-------|--|-------------|

$V_R = 25$ V

| | | |
|-------|--|-------------|
| C_d | | 4,3 to 6 pF |
|-------|--|-------------|

Capacitance ratio at $f = 1$ MHz

$\frac{C_d (V_R = 3 \text{ V})}{C_d (V_R = 25 \text{ V})}$

5 to 6,5

Series resistance at $f = 200$ MHz

V_R is that value at which $C_d = 25$ pF

| | | |
|-------|------|--------------|
| r_D | typ. | 0,4 Ω |
| | < | 0,6 Ω |

DEVELOPMENT SAMPLE DATA

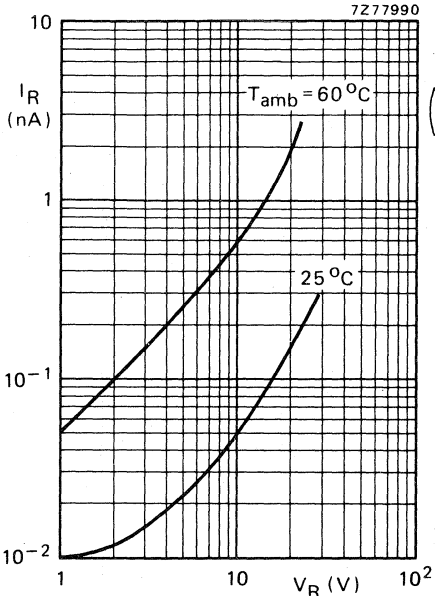


Fig. 2 Typical values

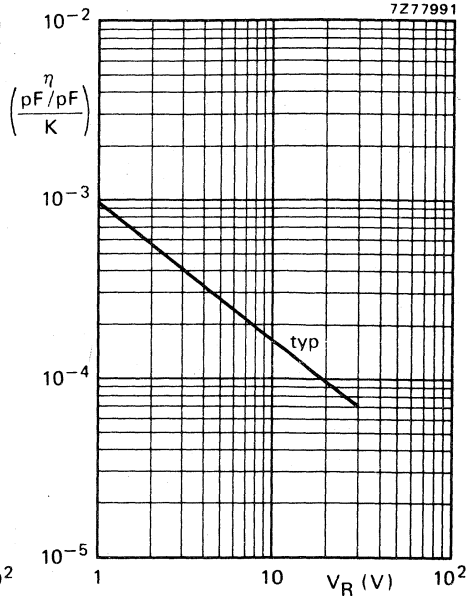


Fig. 3 Temperature coefficient of the diode capacitance; $T_{amb} = 0$ to 85°C .

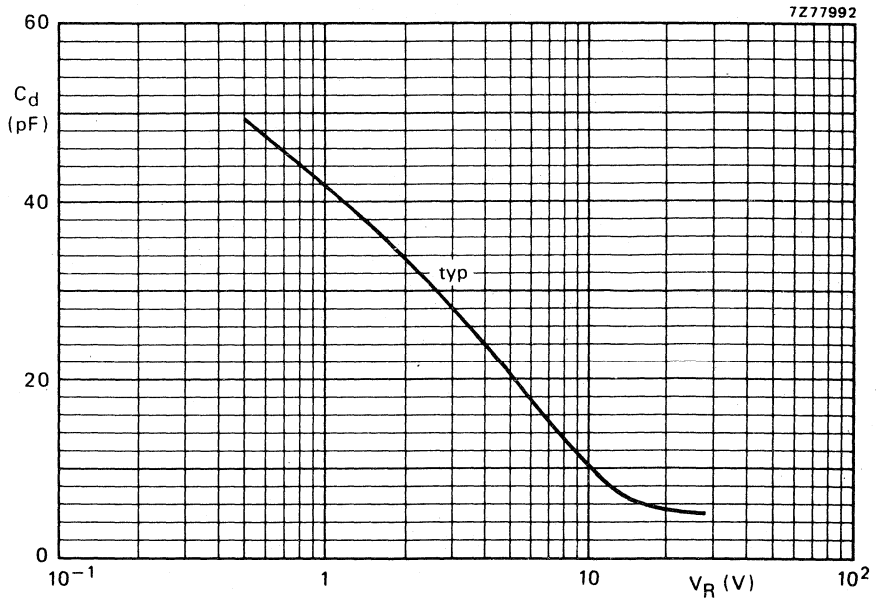


Fig. 4 $f = 1$ MHz; $T_{amb} = 25^\circ\text{C}$.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level, low noise general purpose applications in thick and thin-film circuits.

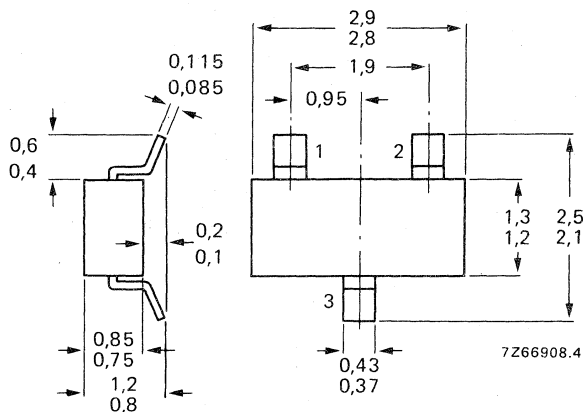
QUICK REFERENCE DATA

| | | BCF29 BCF29R | BCF30 BCF30R | |
|---|------------|-----------------|-----------------|--------------------|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | > | 120 | 215 |
| | | < | 260 | 500 |
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 32 | V ← |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 32 | V ← |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 350 | mW ← |
| Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ ← |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T | typ. | 150 | MHz |
| | | | | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 4 | dB |
| | | | | |

MECHANICAL DATA

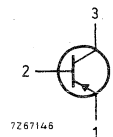
Fig. 1 SOT-23.

Dimensions in mm

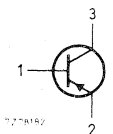


Marking code

BCF29 = C7
BCF30 = C8



BCF29R = C77
BCF30R = C9



See also *Soldering recommendations*.

→ RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

| | | | |
|--|------------|------|----------------|
| Collector-base voltage (open emitter) | $-V_{CB0}$ | max. | 32 V |
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 32 V |
| Collector-emitter voltage (open base) | | | |
| $-I_C = 2$ mA | $-V_{CEO}$ | max. | 32 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 100 mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25$ °C mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 °C |
| Junction temperature | T_j | max. | 175 °C |

→ THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

→ Collector cut-off current

$I_E = 0; -V_{CB} = 32$ V $-I_{CB0} < 100$ nA

$I_E = 0; -V_{CB} = 32$ V; $T_j = 100$ °C $-I_{CB0} < 10$ μA

Base-emitter voltage

$-I_C = 2$ mA; $-V_{CE} = 5$ V $-V_{BE}$ 600 to 750 mV

Saturation voltages

$-I_C = 10$ mA; $-I_B = 0,5$ mA $-V_{CEsat}$ typ. 80 mV
< 300 mV

$-I_C = 50$ mA; $-I_B = 2,5$ mA $-V_{BEsat}$ typ. 720 mV

$-I_C = 50$ mA; $-I_B = 2,5$ mA $-V_{CEsat}$ typ. 150 mV
 $-V_{BEsat}$ typ. 810 mV

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

$-I_C = 2 mA; -V_{CE} = 5 V$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

Transition frequency at $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

Noise figure at $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

| | | BCF29 BCF29R | BCF30 BCF30R |
|----------|------|-----------------|-----------------|
| h_{FE} | typ. | 90 | 150 |
| h_{FE} | > | 120 | 215 |
| h_{FE} | < | 260 | 500 |
| C_c | < | 7,0 | pF |
| f_T | typ. | 150 | MHz |
| F | < | 4 | dB |
| | typ. | 1 | dB |

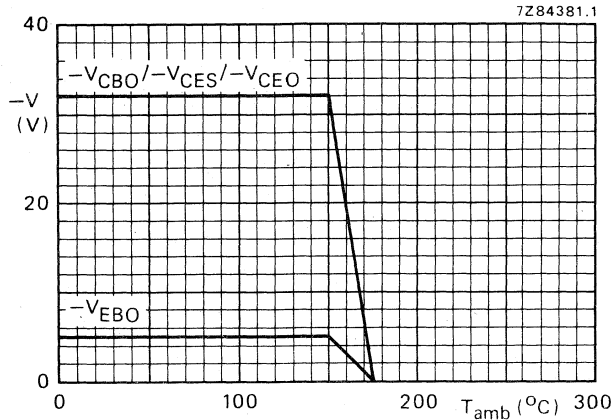


Fig. 2 Voltage derating curves.

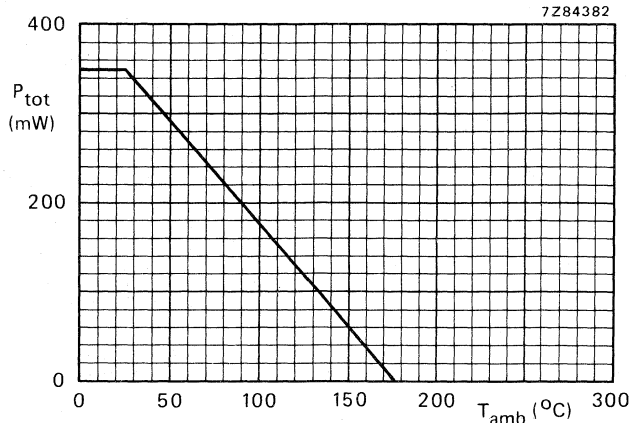


Fig. 3 Power derating curve.

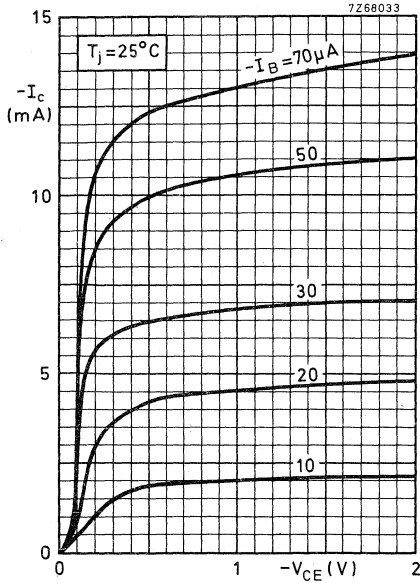


Fig. 4.

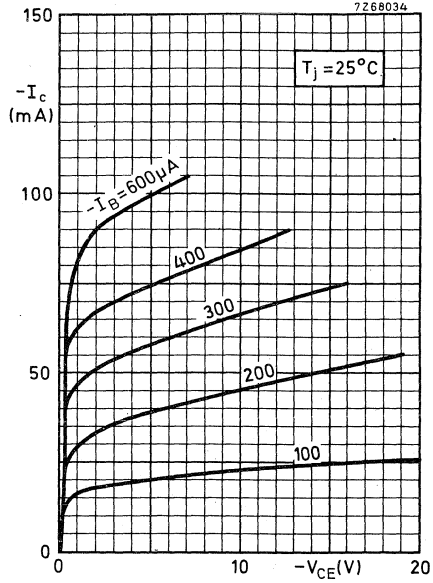


Fig. 5.

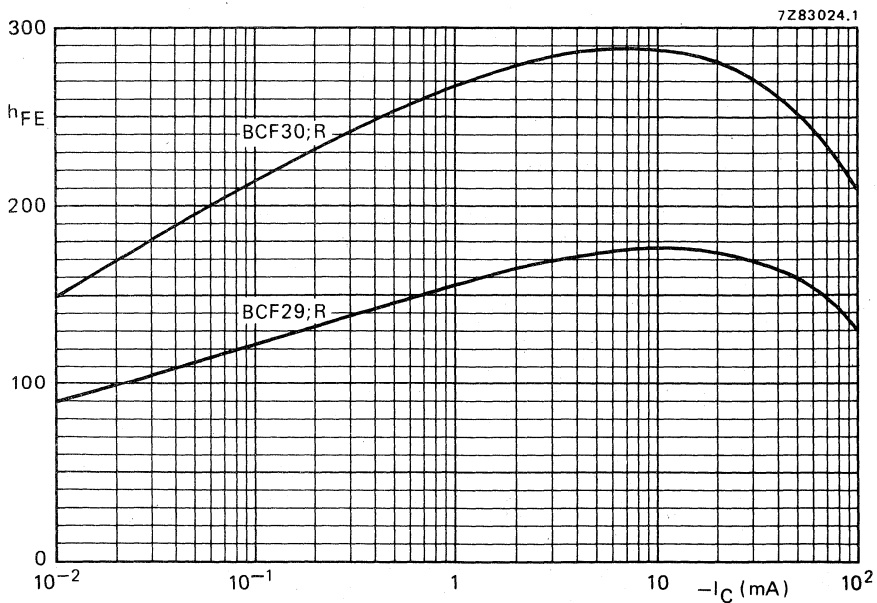
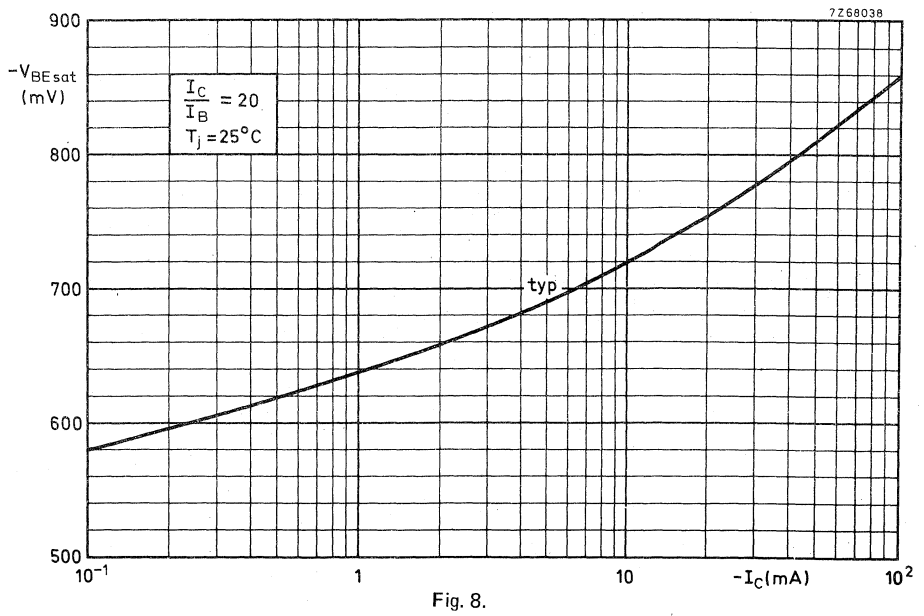
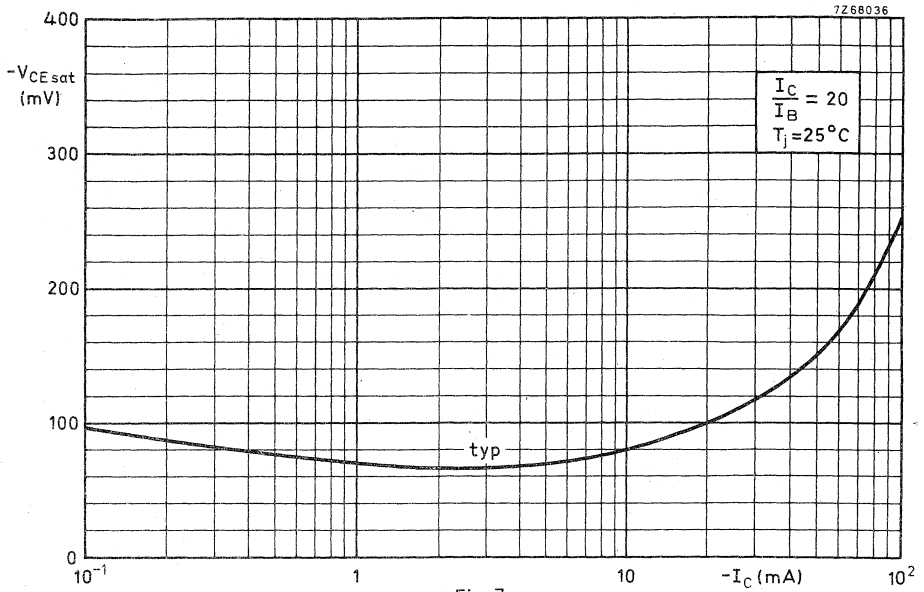


Fig. 6 Typical values of d.c. current gain. $-V_{CE} = 5\text{ V}$; $T_j = 25^\circ\text{C}$.



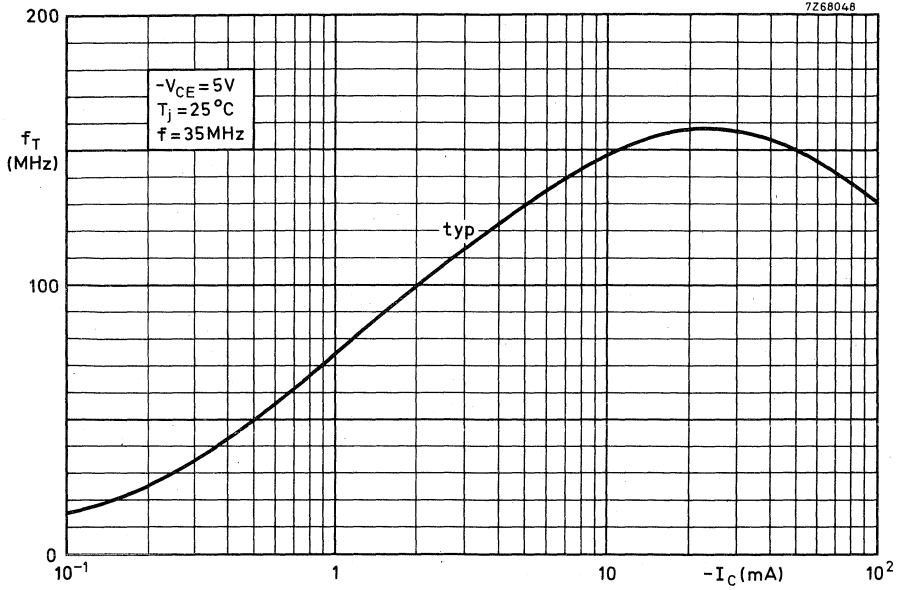


Fig. 9.

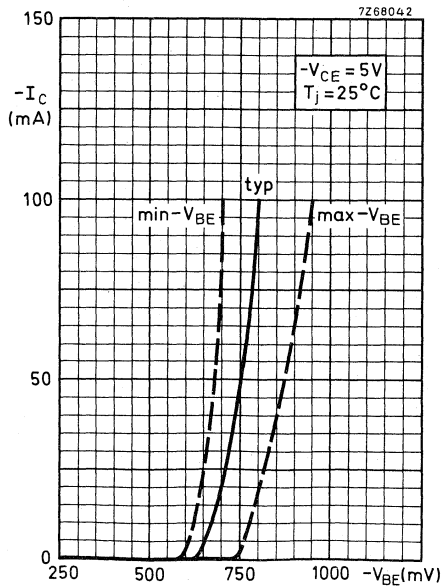


Fig. 10.

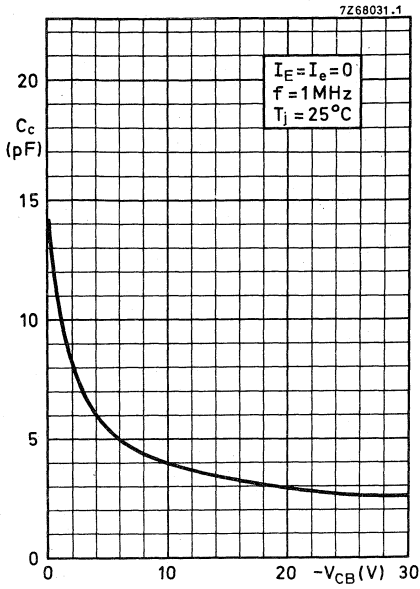


Fig. 11.

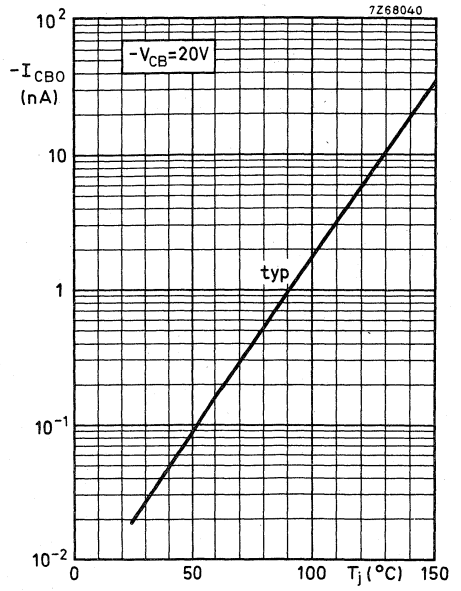


Fig. 12.

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a microminiature plastic envelope. They are intended for low level, low noise general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

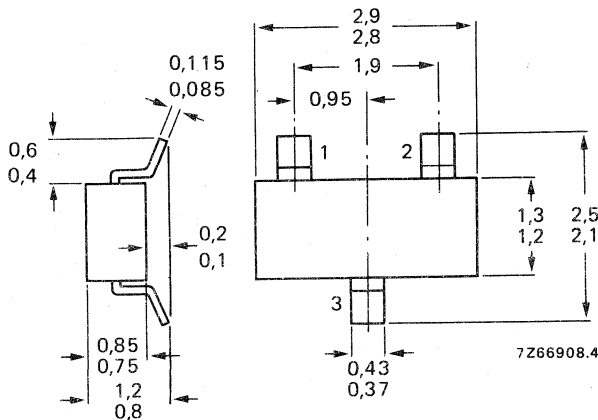
| | | BCF32 BCF32R | BCF33 BCF33R | |
|---|-----------|-----------------|------------------|---|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | > 200 < 450 | 420 800 | |
| Collector-base voltage (open emitter) | V_{CBO} | max. 32 | V | ← |
| Collector-emitter voltage (open base) | V_{CEO} | max. 32 | V | ← |
| Collector current (peak value) | I_{CM} | max. 200 | mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. 350 | mW | ← |
| Junction temperature | T_j | max. 175 | $^\circ\text{C}$ | ← |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | f_T | typ. 300 | MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < 4 | dB | |

MECHANICAL DATA

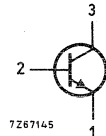
Dimensions in mm

Marking code

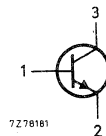
Fig. 1 SOT-23.



BCF32 = D7
BCF33 = D8



BCF32R = D77
BCF33R = D81



See also *Soldering recommendations*.

→ RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|-------------------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 32 V |
| Collector-emitter voltage (open base) $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 32 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 100 mA |
| Collector current (peak value) | I_{CM} | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to + 175 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

→ Collector cut-off current

| | | | |
|--|-----------|---|------------------|
| $I_E = 0; V_{CB} = 32 \text{ V}$ | I_{CBO} | < | 100 nA |
| $I_E = 0; V_{CB} = 32 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$ | I_{CBO} | < | 10 μA |

Base-emitter voltage

| | | | |
|--|----------|--|---------------|
| $I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$ | V_{BE} | | 550 to 700 mV |
|--|----------|--|---------------|

Saturation voltages

| | | | |
|---|-------------|------|--------|
| $I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$ | V_{CEsat} | typ. | 120 mV |
| | | < | 250 mV |
| | V_{BEsat} | typ. | 750 mV |
| | V_{CEsat} | typ. | 210 mV |
| | V_{BEsat} | typ. | 850 mV |

$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$I_C = 2 mA; V_{CE} = 5 V$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

Transition frequency at $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

Noise figure at $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

| | | BCF32 BCF32R | BCF33 BCF33R |
|----------|------|-----------------|-----------------|
| h_{FE} | typ. | 150 | 270 |
| | > | 200 | 420 |
| | < | 450 | 800 |
| C_c | < | 4,0 pF | |
| f_T | typ. | 300 MHz | |
| F | < | 4 dB | |
| | typ. | 1,2 dB | |

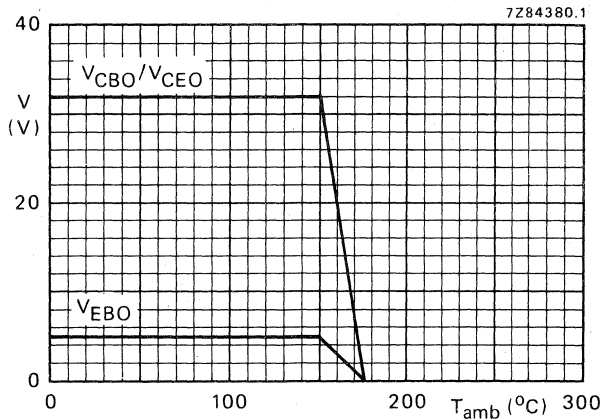


Fig. 2 Voltage derating curves.

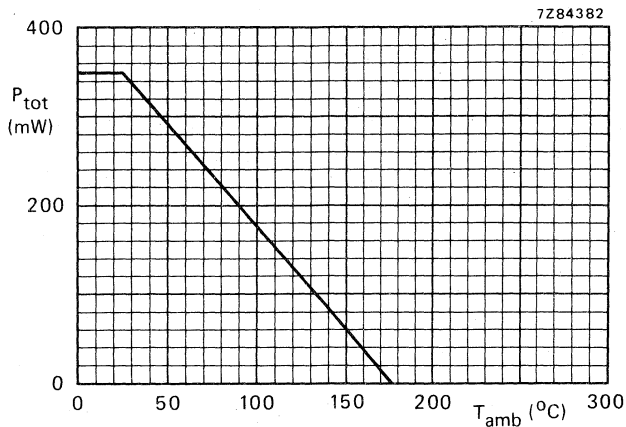


Fig. 3 Power derating curve.

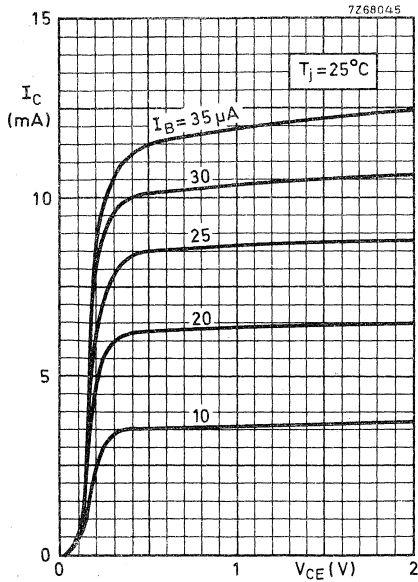


Fig. 4.

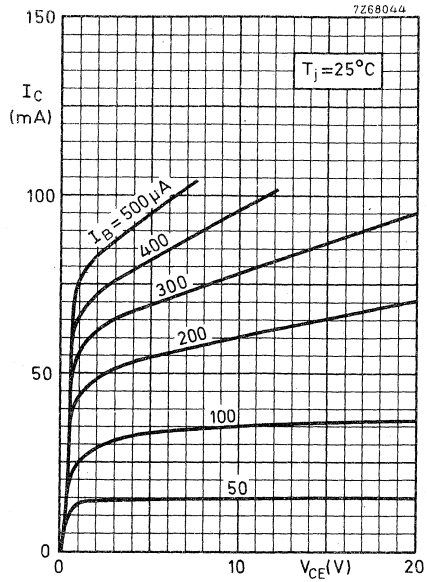


Fig. 5.

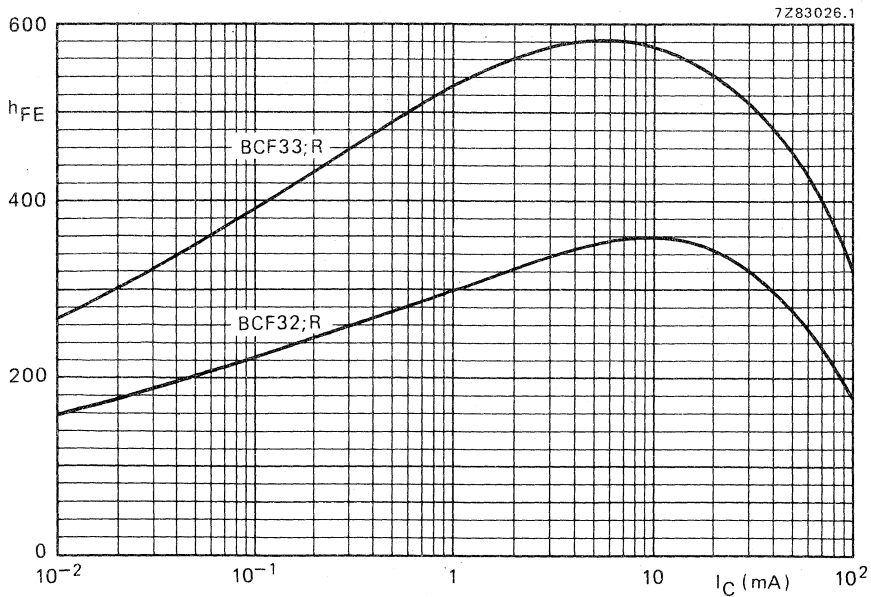


Fig. 6 Typical values d.c. current gain. $V_{CE} = 5 \text{ V}$; $T_j = 25^\circ\text{C}$.

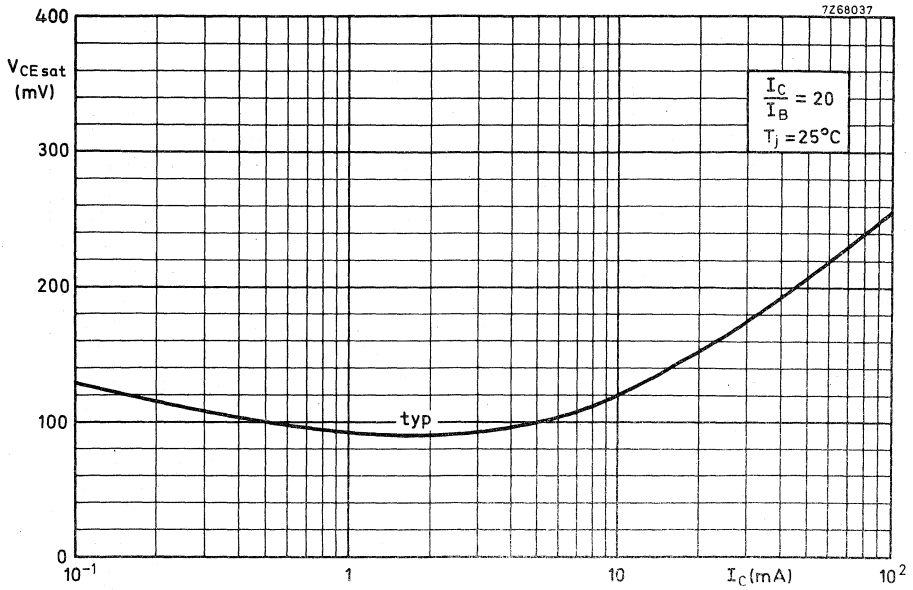


Fig. 7.

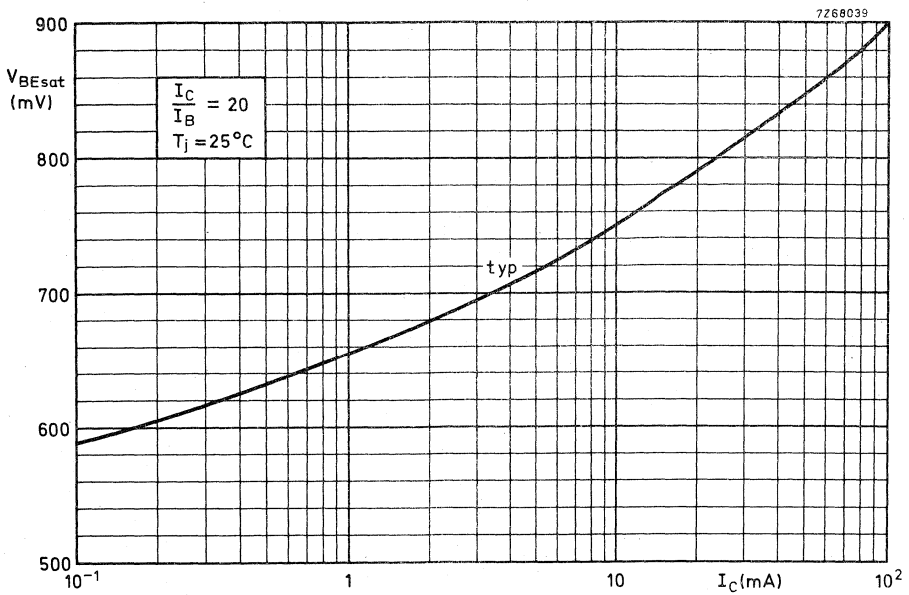


Fig. 8.

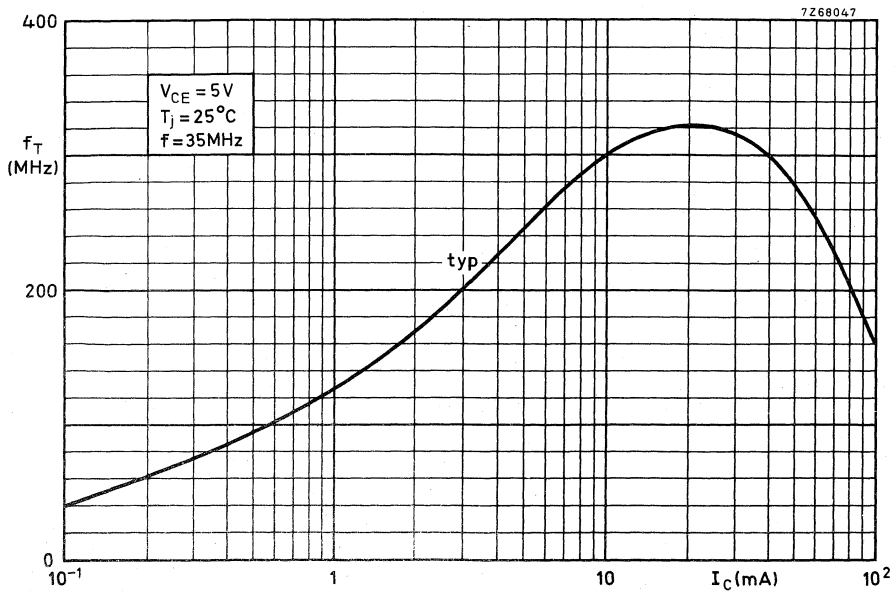


Fig. 9.

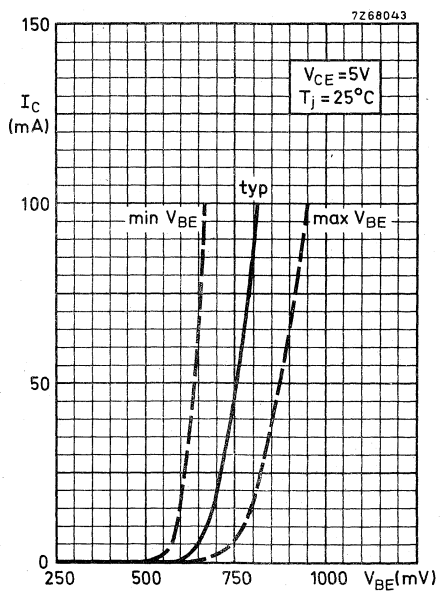


Fig. 10.

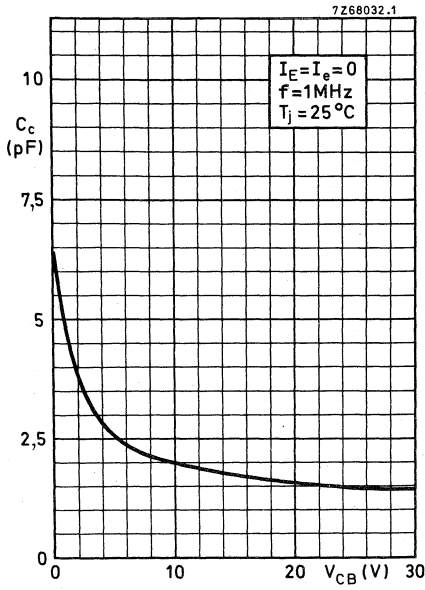


Fig. 11.

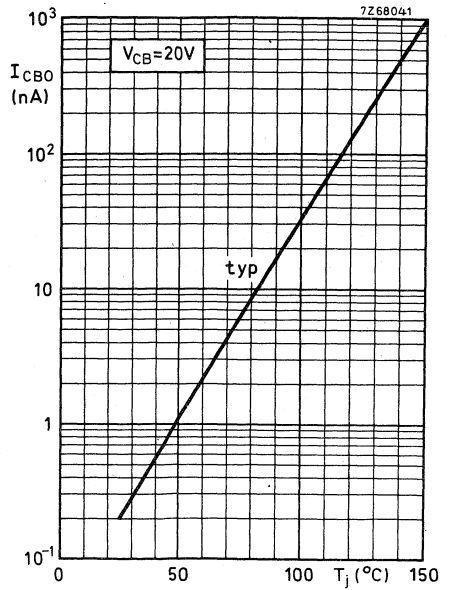


Fig. 12.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level, low noise applications in thick and thin-film circuits:

QUICK REFERENCE DATA

| | | | | |
|---|------------|------|----------------------|---|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | $>$ | 215 | |
| | | $<$ | 500 | |
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 50 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 45 V | |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ | ← |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T | typ. | 150 MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | $<$ | 4 dB | |

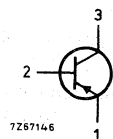
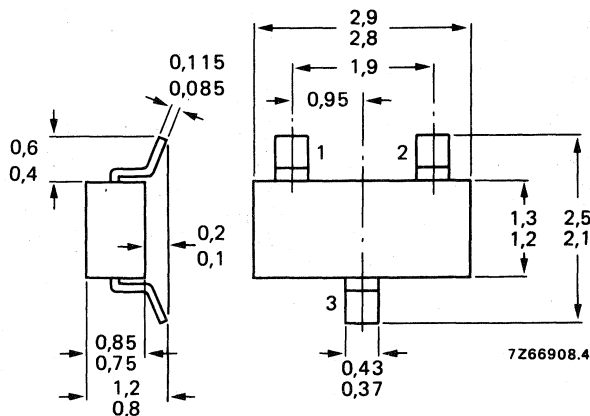
MECHANICAL DATA

Fig. 1 SOT-23.

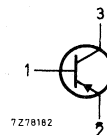
Dimensions in mm

Marking code

BCF70 = H7



BCF70R = H71



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|------------|------|----------------|
| Collector-base voltage (open emitter) see Fig. 2 | $-V_{CBO}$ | max. | 50 V |
| Collector-emitter voltage ($V_{BE} = 0$) see Fig. 2 | $-V_{CES}$ | max. | 50 V |
| Collector-emitter voltage (open base) see Fig. 2 $-I_C = 2$ mA | $-V_{CEO}$ | max. | 45 V |
| Emitter-base voltage (open collector) see Fig. 2 | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 100 mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25$ °C mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 °C |
| Junction temperature | T_j | max. | 175 °C |

→ THERMAL CHARACTERISTICS*

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified

$$I_E = 0; -V_{CB} = 20$$
 V; $T_j = 25$ °C
 $T_j = 100$ °C

Base-emitter voltage

$$-I_C = 2$$
 mA; $-V_{CE} = 5$ V; $T_j = 25$ °C

Saturation voltages

$$-I_C = 10$$
 mA; $-I_B = 0,5$ mA

$$-I_C = 50$$
 mA; $-I_B = 2,5$ mA

| | | |
|--------------|------|---------------|
| $-I_{CBO}$ | < | 100 nA |
| $-I_{CBO}$ | < | 10 μ A |
| $-V_{BE}$ | | 600 to 750 mV |
| $-V_{CEsat}$ | typ. | 80 mV |
| | < | 300 mV |
| $-V_{BEsat}$ | typ. | 720 mV |
| $-V_{CEsat}$ | typ. | 150 mV |
| $-V_{BEsat}$ | typ. | 810 mV |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$-I_C = 10 \mu\text{A}; -V_{CE} = 5 \text{ V}$

h_{FE} typ. 150

$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$

h_{FE} $>$ 215
 h_{FE} $<$ 500

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

C_c $<$ 7,0 pF

Transition frequency at $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

f_T typ. 150 MHz

Noise figure at $R_S = 2 \text{ k}\Omega$

$-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V}$

F $<$ 4 dB

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

F typ. 1 dB

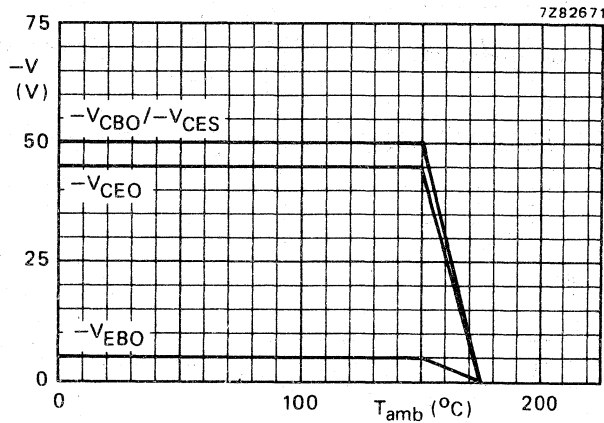


Fig. 2 Voltage derating curves.

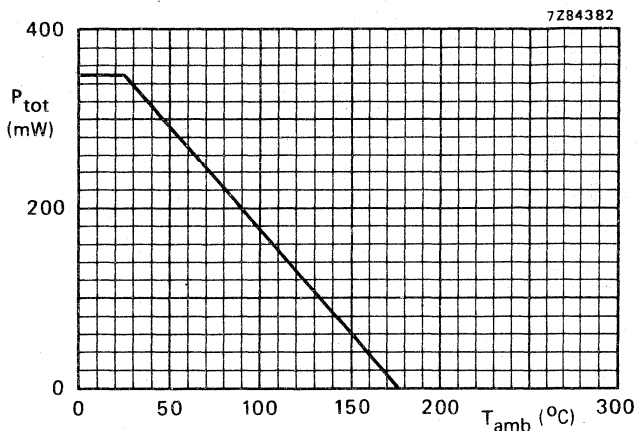


Fig. 3 Power derating curve.

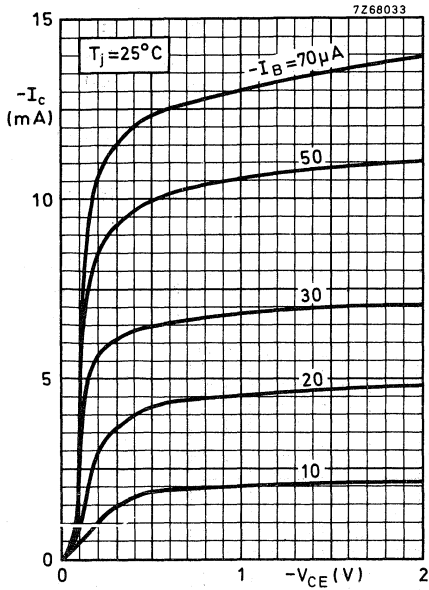


Fig. 4.

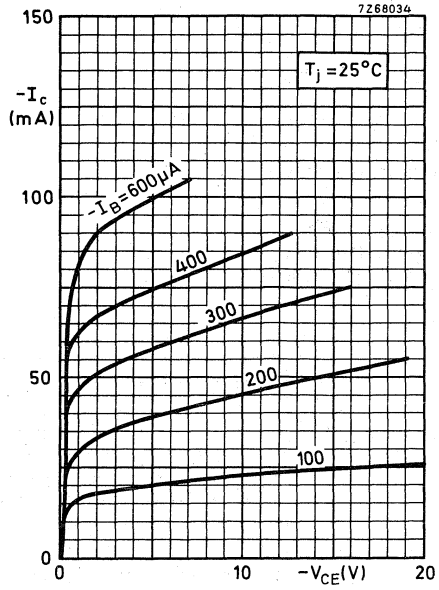


Fig. 5.

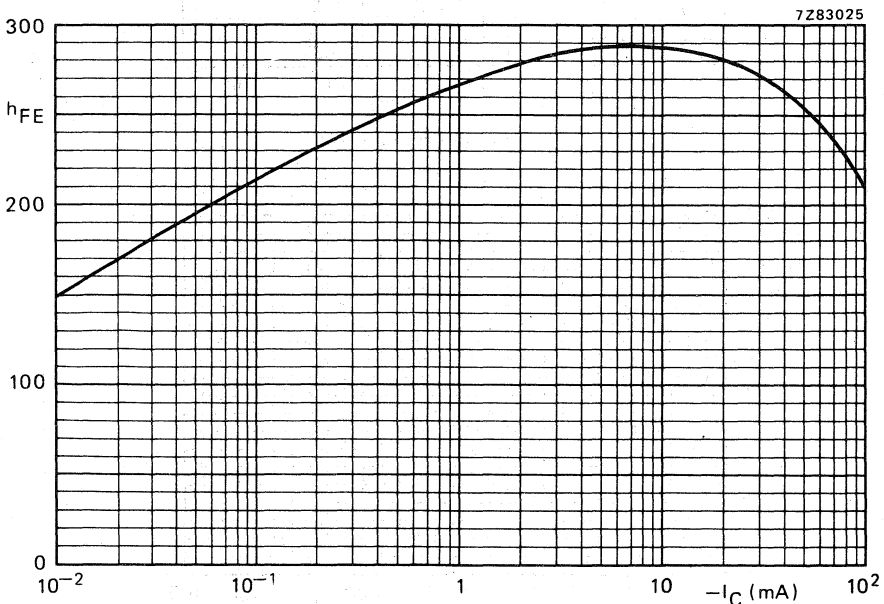


Fig. 6 Typical values of d.c. current gain. $-V_{CE} = 5\text{ V}$; $T_j = 25^\circ\text{C}$.

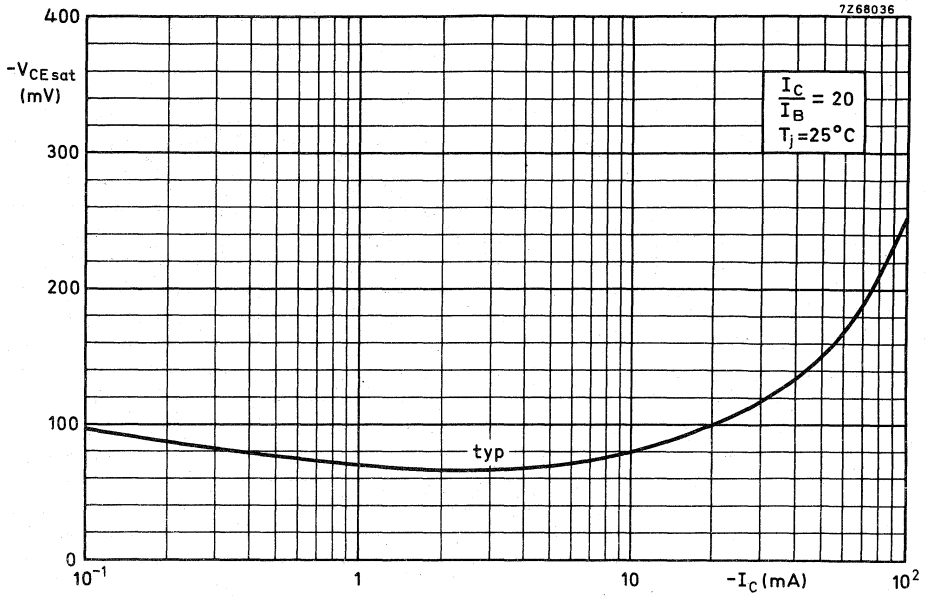


Fig. 7.

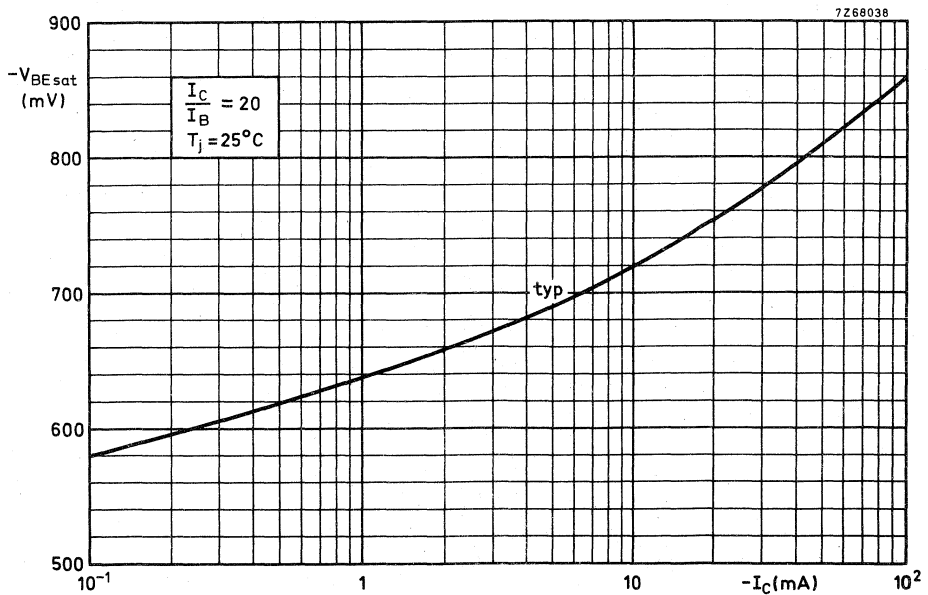


Fig. 8.

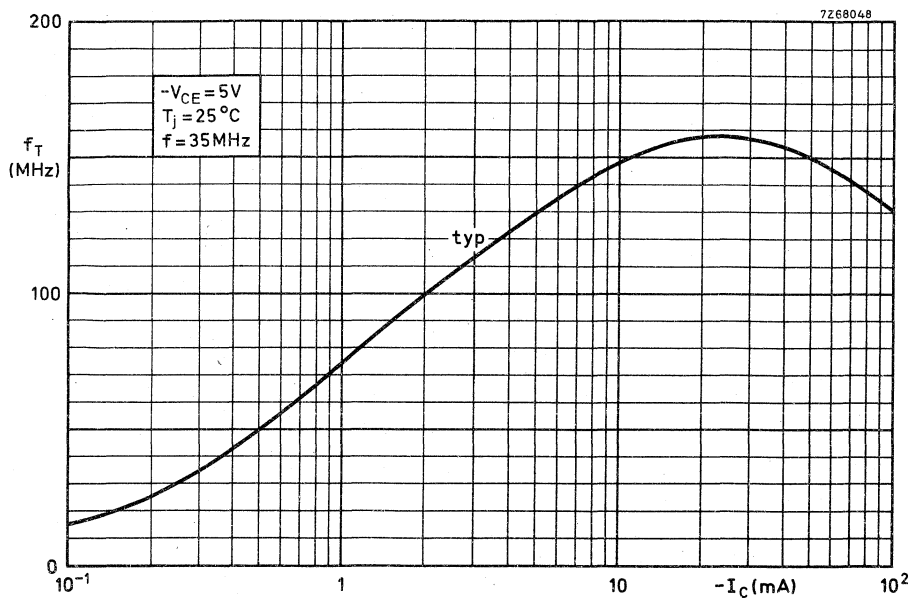


Fig. 9.

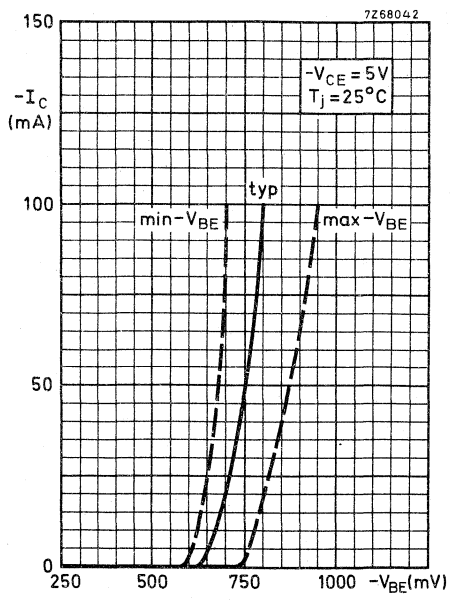


Fig. 10.

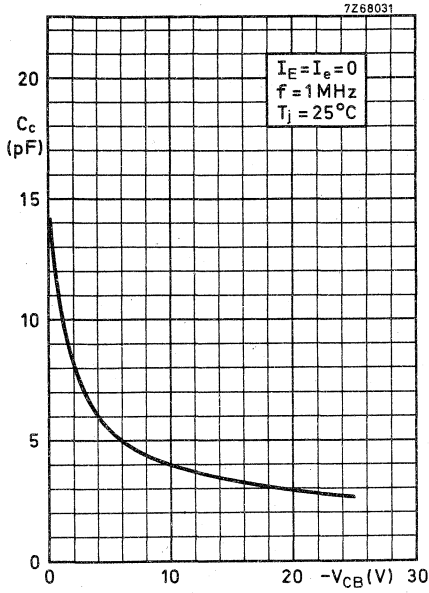


Fig. 11.

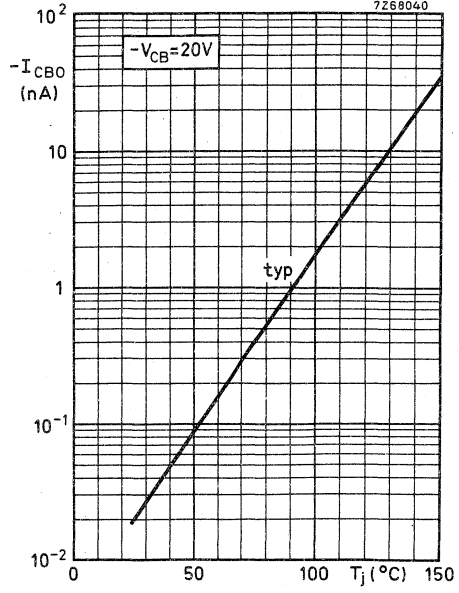


Fig. 12.



SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a microminiature plastic envelope, intended for low level, low noise general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|---|-----------|------|------------------------|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 50 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 V | |
| Collector current (peak value) | I_{CM} | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | > | 420 | |
| | | < | 800 | |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$ | f_T | typ. | 300 MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 4 dB | |

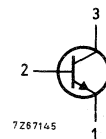
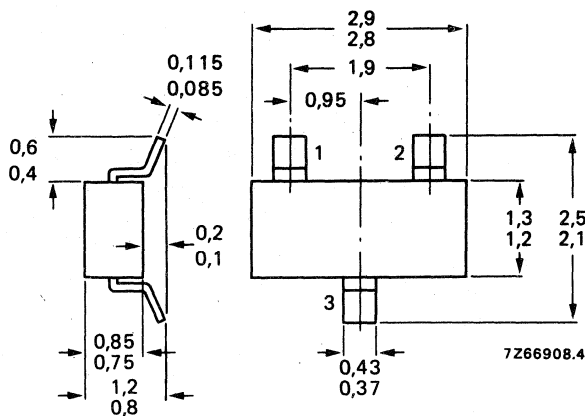
MECHANICAL DATA

Dimensions in mm

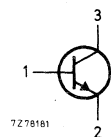
Marking code

Fig. 1 SOT-23.

BCF81 = K9



BCF81R = K91



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|-------------------------------|
| Collector-base voltage (open emitter) see Fig. 2 | V_{CBO} | max. | 50 V |
| Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 45 V |
| Emitter-base voltage (open collector) see Fig. 2 | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 100 mA |
| Collector current (peak value) | I_{CM} | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to + 175 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ THERMAL CHARACTERISTICS*

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ. } 120 \text{ mV}$$

$$V_{CEsat} < 250 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{BEsat} \quad \text{typ. } 750 \text{ mV}$$

$$V_{CEsat} \quad \text{typ. } 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ. } 850 \text{ mV}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$

| | | |
|----------|-----|-----|
| h_{FE} | $>$ | 420 |
| | $<$ | 800 |

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

| | | |
|-------|-----|--------|
| C_c | $<$ | 4,0 pF |
|-------|-----|--------|

Transition frequency at $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

| | | |
|-------|------|---------|
| f_T | typ. | 300 MHz |
|-------|------|---------|

Noise figure at $R_S = 2 \text{ k}\Omega$

$I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

| | | |
|-----|------|--------|
| F | $<$ | 4 dB |
| | typ. | 1,2 dB |

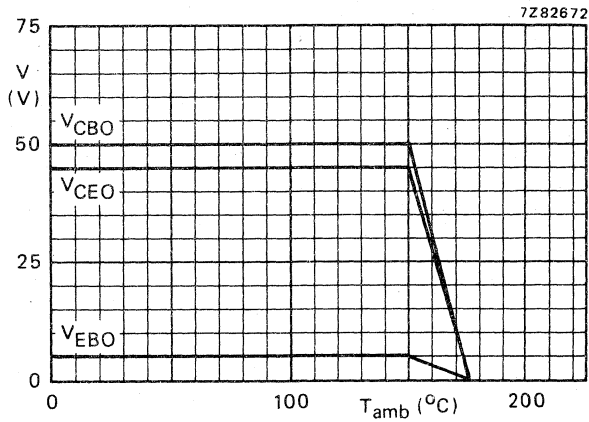


Fig. 2 Voltage derating curves.

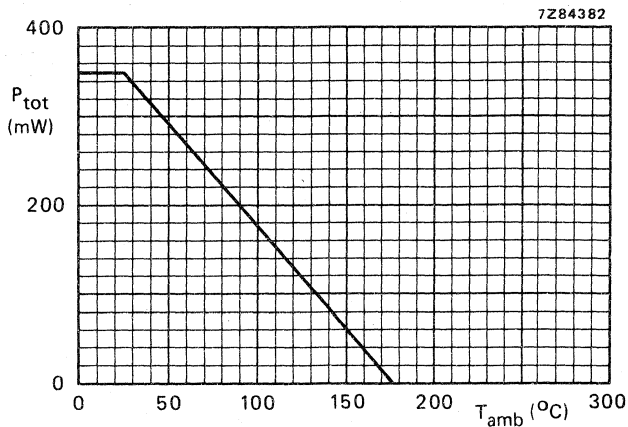


Fig. 3 Power derating curve.

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

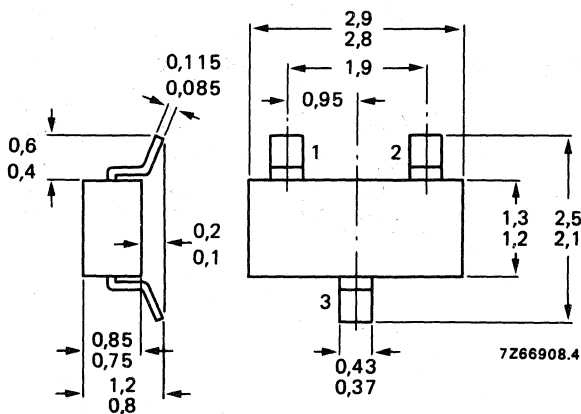
QUICK REFERENCE DATA

| | | BCV71 BCV71R | BCV72 BCV72R | |
|---|----------------|-----------------|------------------|---|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | 110 220 | 200 450 | |
| Collector-base voltage (open emitter) | V_{CBO} max. | 80 | V | ← |
| Collector-emitter voltage (open base) | V_{CEO} max. | 60 | V | |
| Collector current (peak value) | I_{CM} max. | 200 | mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} max. | 350 | mW | ← |
| Junction temperature | T_j max. | 175 | $^\circ\text{C}$ | ← |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$ | f_T typ. | 300 | MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < 10 | dB | |

MECHANICAL DATA

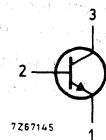
Fig. 1 SOT-23.

Dimensions in mm

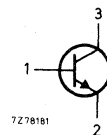


Marking code

BCV71 = K7
BCV72 = K8



BCV71R = K71
BCV72R = K81



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | | |
|--|-----------|------|--------------|------------------|
| Collector-base voltage (open emitter) see Fig. 2 | V_{CBO} | max. | 80 | V |
| Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 60 | V |
| Emitter-base voltage (open collector) see Fig. 2 | V_{EBO} | max. | 5 | V |
| Collector current (d.c.) | I_C | max. | 100 | mA |
| Collector current (peak value) | I_{CM} | max. | 200 | mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 | mW |
| Storage temperature | T_{stg} | | -65 to + 175 | $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | | |
|------------------------------------|--------------|---|-----|-----|
| From junction to tab | $R_{th j-t}$ | = | 50 | K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 | K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 | K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

| | | | | |
|--|-----------|---|-----|---------------|
| $I_E = 0; V_{CB} = 20 \text{ V}$ | I_{CBO} | < | 100 | nA |
| $I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$ | I_{CBO} | < | 10 | μA |

Base emitter voltage

| | | | | |
|--|----------|--|------------|----|
| $I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$ | V_{BE} | | 550 to 700 | mV |
|--|----------|--|------------|----|

Saturation voltages

| | | | | |
|---|-------------|------|-----|----|
| $I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$ | V_{CEsat} | typ. | 120 | mV |
| | | < | 250 | mV |

$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$

| | | | | |
|--|-------------|------|-----|----|
| | V_{BEsat} | typ. | 750 | mV |
| | V_{CEsat} | typ. | 210 | mV |
| | V_{BEsat} | typ. | 850 | mV |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$I_C = 2 mA; V_{CE} = 5 V$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

Transition frequency at $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

Noise figure at $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

| | | BCV71 BCV71R | BCV72 BCV72R |
|----------|------|-----------------|-----------------|
| h_{FE} | typ. | 90 | 150 |
| h_{FE} | > | 110 | 200 |
| h_{FE} | < | 220 | 450 |
| C_c | < | 4,0 | pF |
| f_T | typ. | 300 | MHz |
| F | < | 10 | dB |

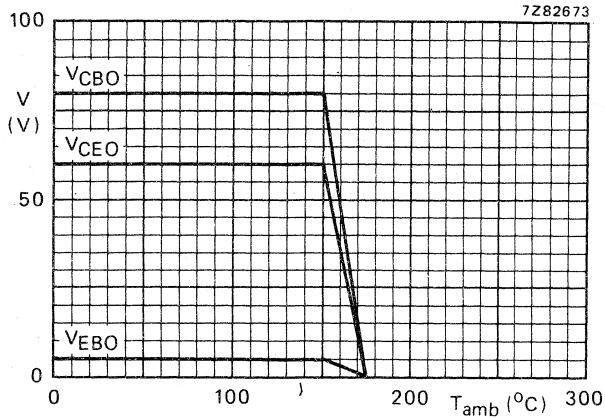


Fig. 2 Voltage derating curves.

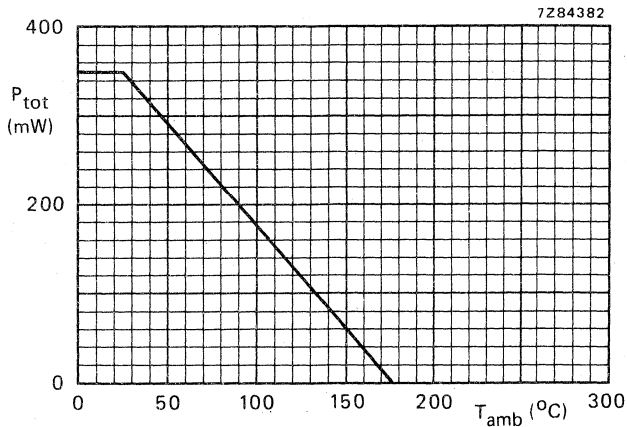


Fig. 3 Power derating curve.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | BCW29 BCW29R | BCW30 BCW30R | |
|---|-----------------|-----------------|-----------------|--------------------|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | 120 260 | 215 500 | |
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 32 | | V ← |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 32 | | V ← |
| Collector current (peak value) | $-I_{CM}$ max. | 200 | | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} max. | 350 | | mW ← |
| Junction temperature | T_j max. | 175 | | $^\circ\text{C}$ ← |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T typ. | 150 | | MHz |
| Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < 10 | | dB |

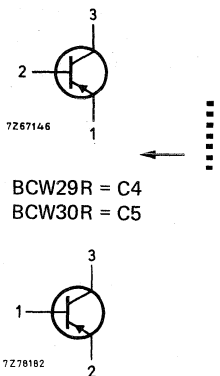
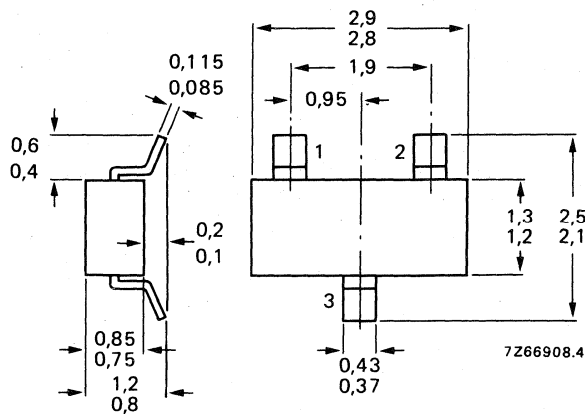
MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BCW29 = C1
BCW30 = C2



See also *Soldering recommendations*.

→ RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

| | | | |
|--|------------|------|----------------|
| Collector-base voltage (open emitter) | $-V_{CB0}$ | max. | 32 V |
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 32 V |
| Collector-emitter voltage (open base) | | | |
| $-I_C = 2$ mA | $-V_{CEO}$ | max. | 32 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 100 mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25$ °C mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 °C |
| Junction temperature | T_j | max. | 175 °C |

→ THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

→ Collector cut-off current

| | | | |
|---|------------|---|------------|
| $I_E = 0; -V_{CB} = 32$ V | $-I_{CBO}$ | < | 100 nA |
| $I_E = 0; -V_{CB} = 32$ V; $T_j = 100$ °C | $-I_{CBO}$ | < | 10 μ A |

Base-emitter voltage

| | | | |
|--------------------------------|-----------|--|---------------|
| $-I_C = 2$ mA; $-V_{CE} = 5$ V | $-V_{BE}$ | | 600 to 750 mV |
|--------------------------------|-----------|--|---------------|

Saturation voltages

| | | | |
|---------------------------------|--------------|------|--------|
| $-I_C = 10$ mA; $-I_B = 0,5$ mA | $-V_{CEsat}$ | typ. | 80 mV |
| | | < | 300 mV |
| | $-V_{BEsat}$ | typ. | 720 mV |
| $-I_C = 50$ mA; $-I_B = 2,5$ mA | $-V_{CEsat}$ | typ. | 150 mV |
| | $-V_{BEsat}$ | typ. | 810 mV |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

h_{FE}

| BCW29 BCW29R | BCW30 BCW30R |
|-----------------|-----------------|
|-----------------|-----------------|

typ. 90

150

$-I_C = 2 mA; -V_{CE} = 5 V$

h_{FE}

> 120

215

< 260

500

Collector-capacitance at $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

C_c

<

7,0

pF

Transition frequency at $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

f_T

typ.

150

MHz

Noise figure at $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

F

<

10

dB

$f = 1 kHz; B = 200 Hz$

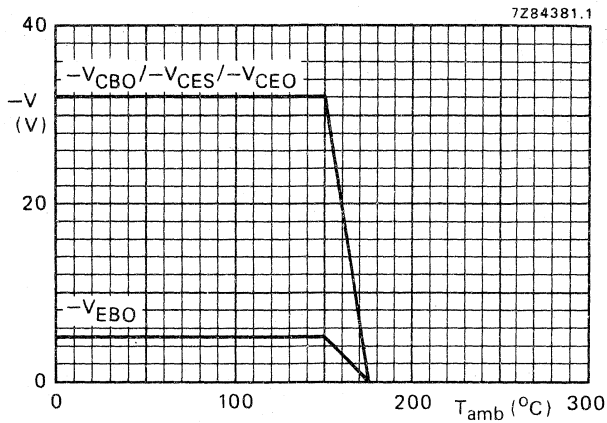


Fig. 2 Voltage derating curves.

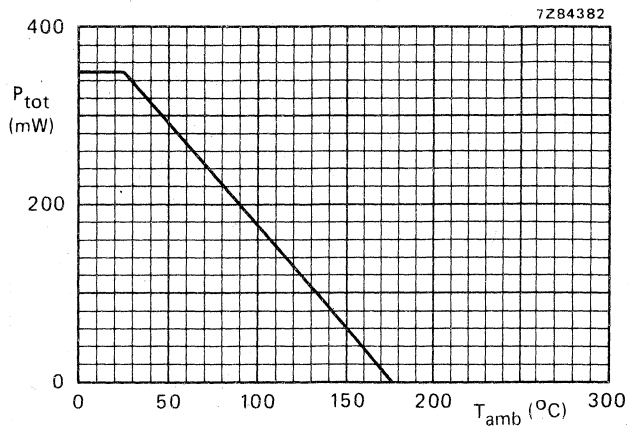


Fig. 3 Power derating curve.

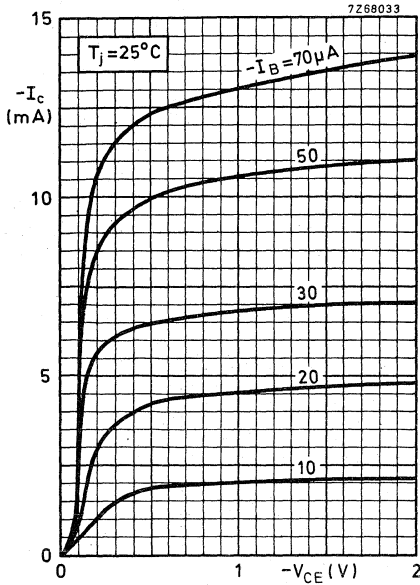


Fig. 4.

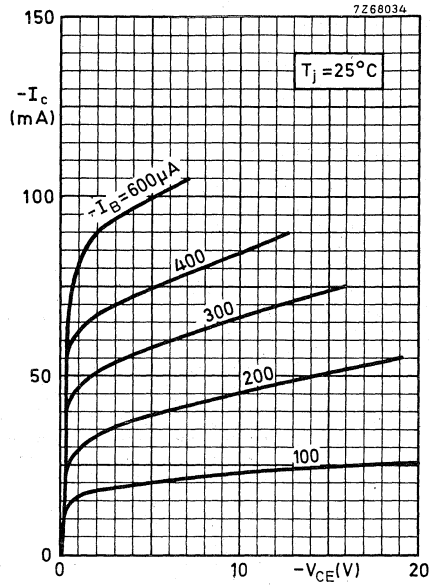


Fig. 5.

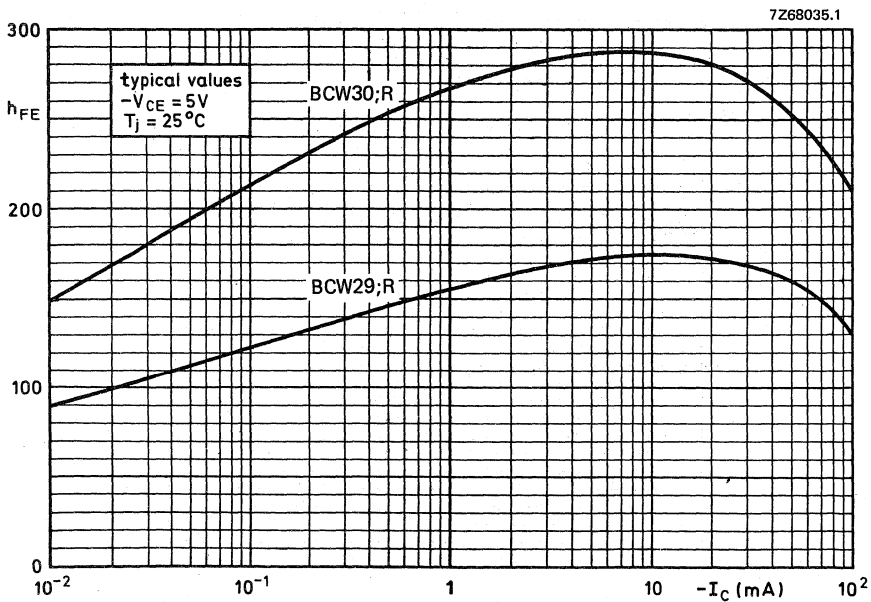


Fig. 6.

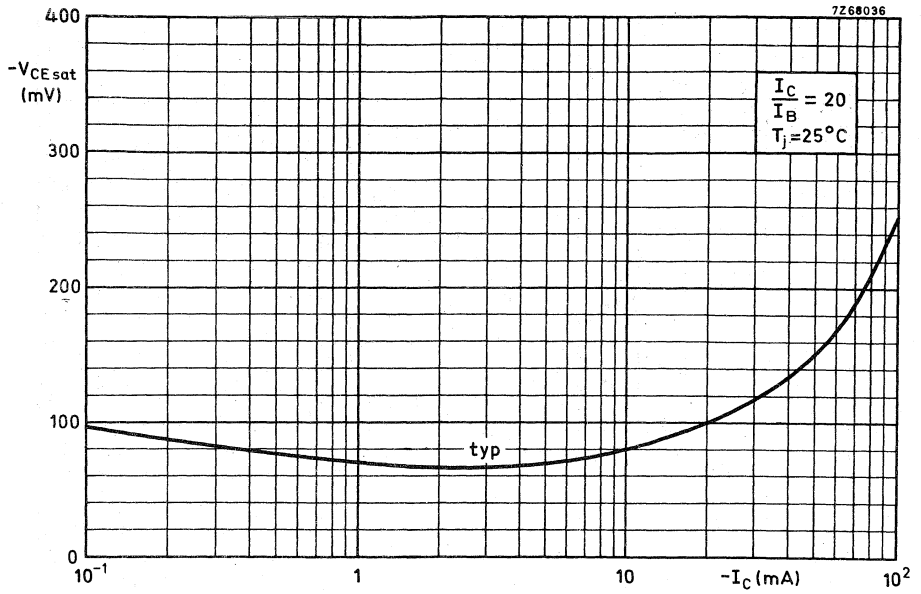


Fig. 7.

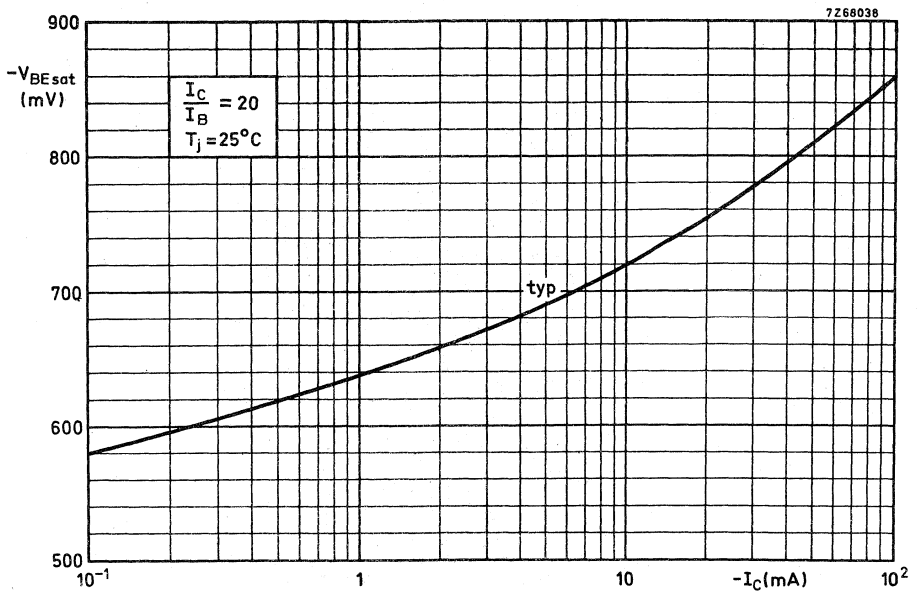


Fig. 8.

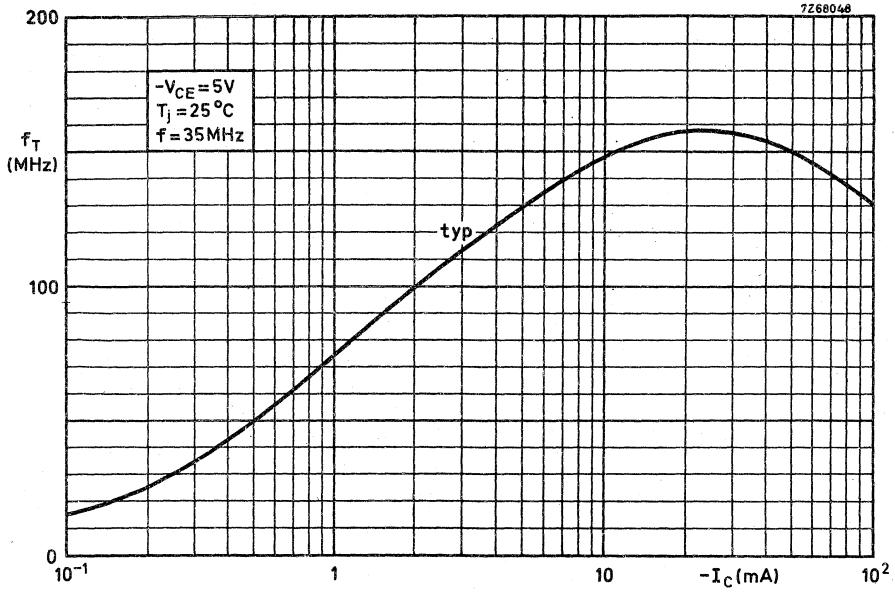


Fig. 9.

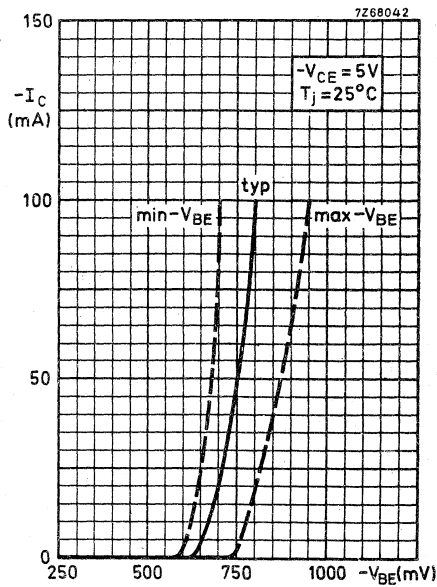


Fig. 10.

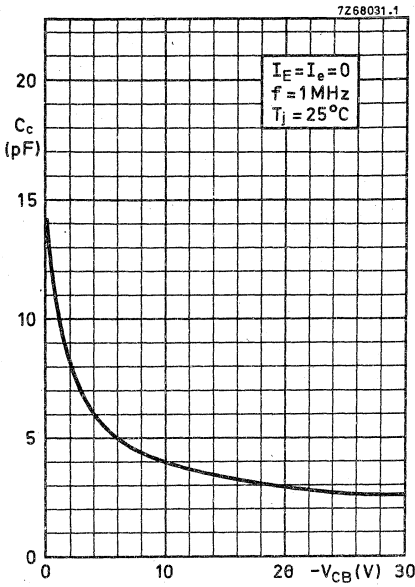


Fig. 11.

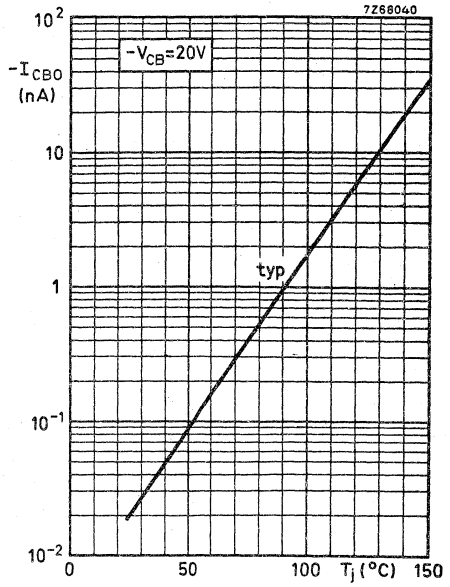


Fig. 12.



SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a microminiature plastic envelope. They are intended for low level general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

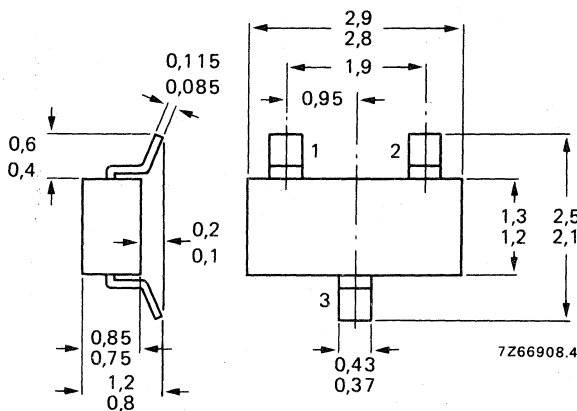
| | | | BCW31 BCW31R | BCW32 BCW32R | BCW33 BCW33R |
|---|-----------|------------|-----------------|-----------------|--------------------|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | $>$ $<$ | 110 220 | 200 450 | 420 800 |
| Collector-base voltage (open emitter) | V_{CBO} | max. | | 32 | V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | | 32 | V |
| Collector current (peak value) | I_{CM} | max. | | 200 | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | | 350 | mW ← |
| Junction temperature | T_j | max. | | 175 | $^\circ\text{C}$ ← |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | f_T | typ. | | 300 | MHz |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | $<$ | | 10 | dB |

MECHANICAL DATA

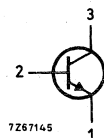
Dimensions in mm

Marking code

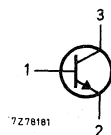
Fig. 1 SOT-23.



BCW31 = D1
BCW32 = D2
BCW33 = D3



BCW31R = D4
BCW32R = D5
BCW32R = D6



See also *Soldering recommendations*.

→ RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

| | | | |
|--|-----------|------|------------------------------|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 32 V |
| Collector-emitter voltage (open base) $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 32 V |
| Emitter-base voltage (open collector) | V_{EB0} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 100 mA |
| Collector current (peak value) | I_{CM} | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

| | | | |
|--|-------------|------|------------------|
| → Collector cut-off current $I_E = 0; V_{CB} = 32 \text{ V}$ | I_{CBO} | < | 100 nA |
| $I_E = 0; V_{CB} = 32 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$ | I_{CBO} | < | 10 μA |
| Base-emitter voltage $I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$ | V_{BE} | | 550 to 700 mV |
| Saturation voltages | V_{CEsat} | typ. | 120 mV |
| $I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$ | | < | 250 mV |
| | V_{BEsat} | typ. | 750 mV |
| $I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$ | V_{CEsat} | typ. | 210 mV |
| | V_{BEsat} | typ. | 850 mV |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

| | | BCW31 BCW31R | BCW32 BCW32R | BCW33 BCW33R |
|---|---------------|-----------------|-----------------|-----------------|
| D.C. current gain | | | | |
| $I_C = 10 \mu A, V_{CE} = 5 V$ | h_{FE} typ. | 90 | 150 | 270 |
| $I_C = 2 mA; V_{CE} = 5 V$ | $h_{FE} >$ | 110 | 200 | 420 |
| | $h_{FE} <$ | 220 | 450 | 800 |
| Collector capacitance at $f = 1 MHz$ $I_E = I_e = 0; V_{CB} = 10 V$ | C_c | < | 4,0 | pF |
| Transition frequency at $f = 35 MHz$ $I_C = 10 mA; V_{CE} = 5 V$ | f_T | typ. | 300 | MHz |
| Noise figure at $R_S = 2 k\Omega$ $I_C = 200 \mu A; V_{CE} = 5 V$ $f = 1 kHz; B = 200 Hz$ | F | < | 10 | dB |

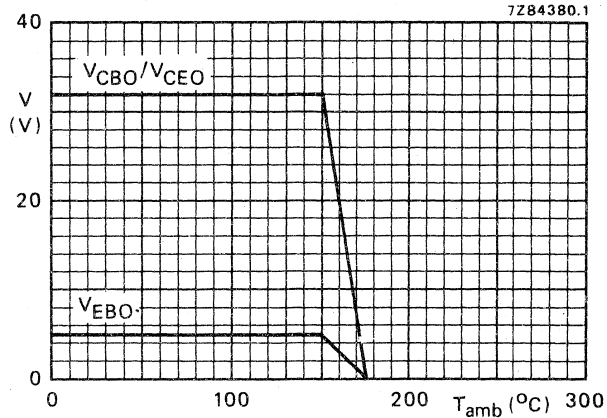


Fig. 2 Voltage derating curves.

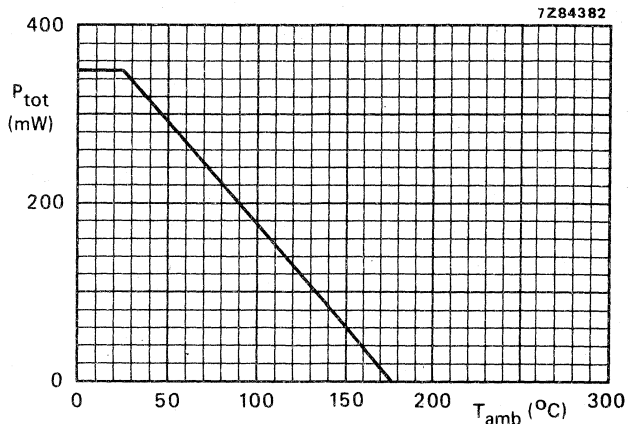


Fig. 3 Power derating curve.

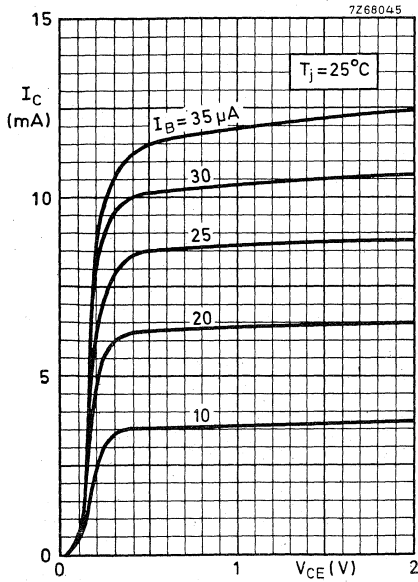


Fig. 4.

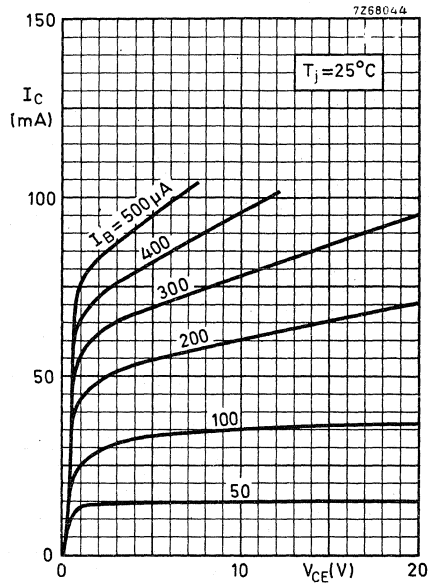


Fig. 5.

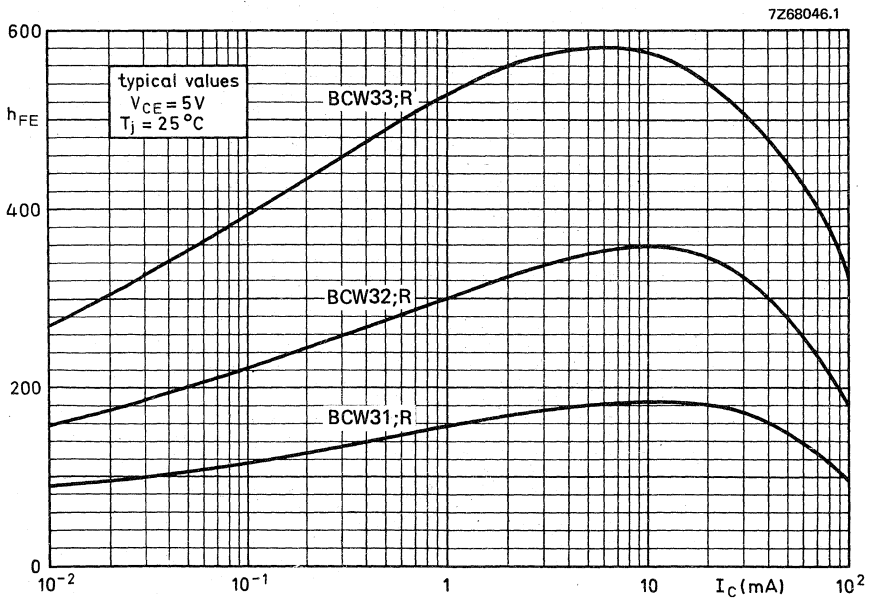


Fig. 6.

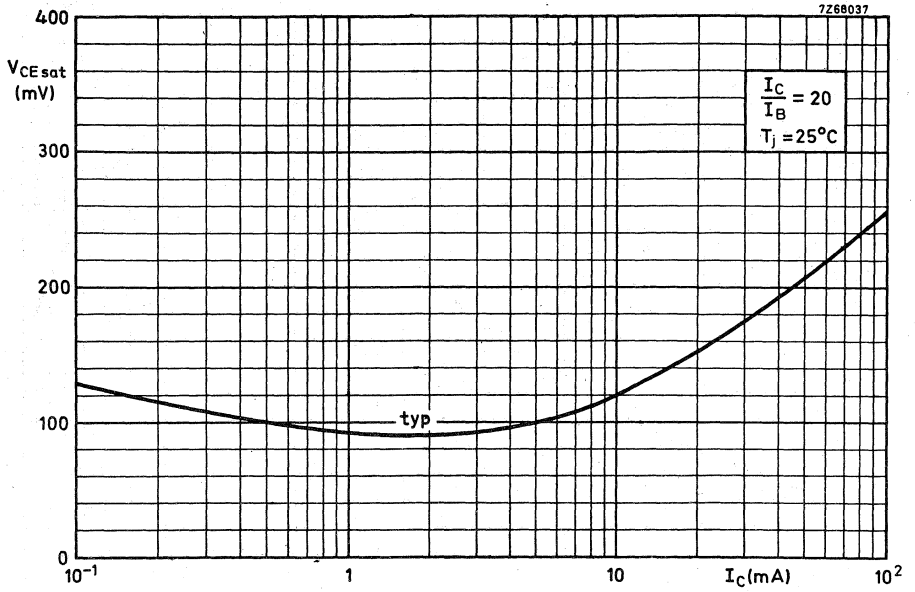


Fig. 7.

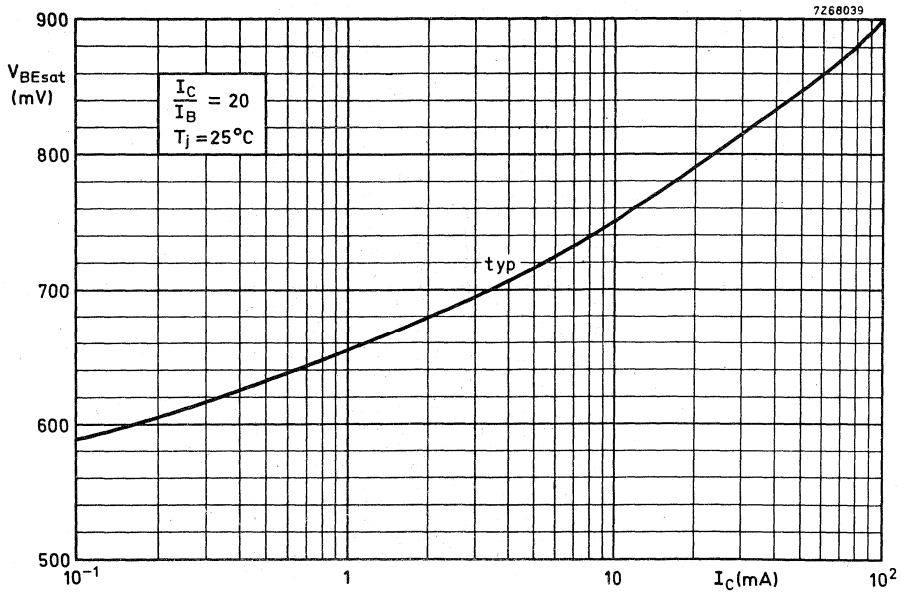


Fig. 8.

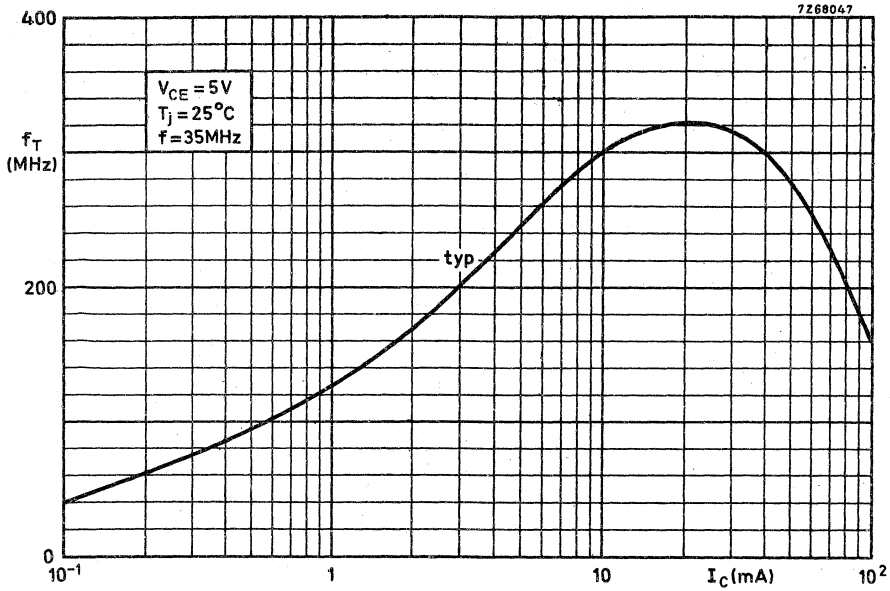


Fig. 9.

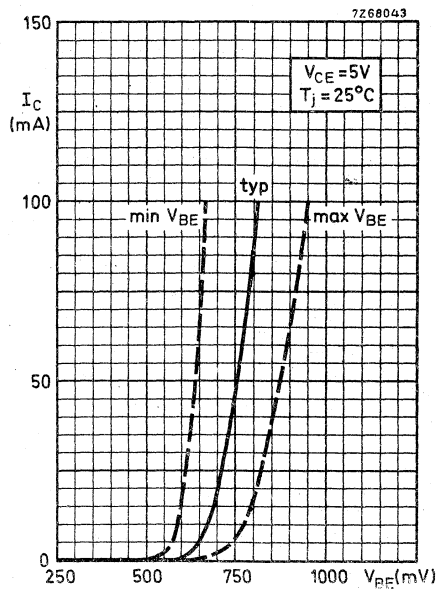


Fig. 10.

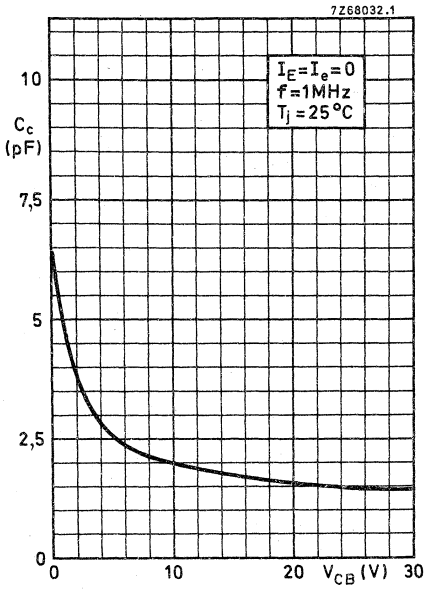


Fig. 11.

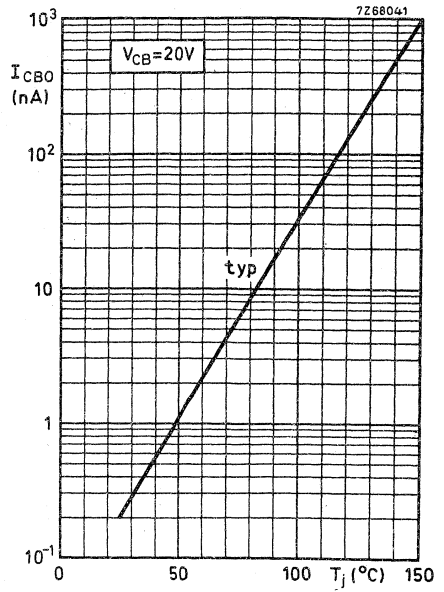


Fig. 12.

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

QUICK REFERENCE DATA

| | | | |
|--|-----------|------|---------|
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} | max. | 32 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 32 V |
| Collector current (d.c.) | I_C | max. | 200 mA |
| Total power dissipation | P_{tot} | max. | 150 mW |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 100$ MHz $V_{CE} = 5$ V; $I_C = 10$ mA | f_T | typ. | 250 MHz |
| Noise figure at $f = 1$ kHz $V_{CE} = 5$ V; $I_C = 200$ μ A; $B = 200$ Hz | F | typ. | 2 dB |

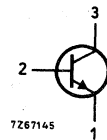
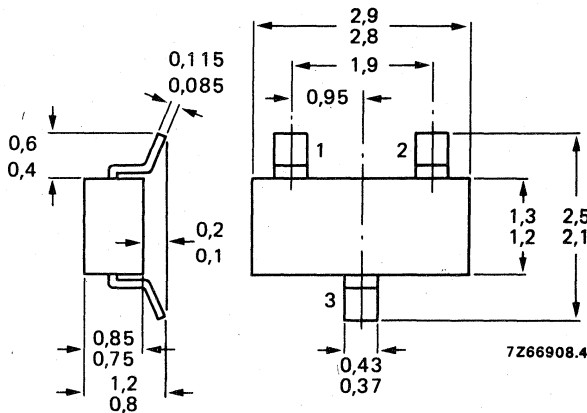
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BCW60A = AA
BCW60B = AB
BCW60C = AC
BCW60D = AD



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|-----------------|
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} | max. | 32 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 32 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 200 mA |
| Base current | I_B | max. | 50 mA |
| Total power dissipation** | P_{tot} | max. | 150 mW |
| Storage temperature | T_{stg} | | -55 to + 125 °C |
| Junction temperature | T_j | max. | 150 °C |

THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25$ °C unless otherwise specified

Collector-emitter cut-off current

$$V_{BE} = 0; V_{CE} = 32\text{ V}$$

$$I_{CES} < 20\text{ nA}$$

$$V_{BE} = 0; V_{CE} = 32\text{ V}; T_{amb} = 150\text{ °C}$$

$$I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; V_{EB} = 4\text{ V}$$

$$I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$\text{at } I_C = 10\text{ mA}; I_B = 0,25\text{ mA}$$

$$V_{CEsat} \quad 0,05\text{ to }0,35\text{ V}$$

$$V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$V_{CEsat} \quad 0,1\text{ to }0,55\text{ V}$$

$$V_{BEsat} \quad 0,7\text{ to }1,05\text{ V}$$

Transition frequency at $f = 100$ MHz ▲

$$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T > 125\text{ MHz}$$

typ. 250 MHz

Collector capacitance at $f = 1$ MHz

$$I_E = I_C = 0; V_{CB} = 10\text{ V}$$

$$C_c < 4,5\text{ pF}$$

Emitter capacitance at $f = 1$ MHz

$$I_C = I_C = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 8\text{ pF}$$

Noise figure at $R_S = 2\text{ k}\Omega$

$$I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}; B = 200\text{ Hz}$$

$$F \text{ typ. } 2\text{ dB}$$

< 6 dB

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

▲ Measured under pulse conditions.

| | | A | B | C | D | |
|--------------------------------|---|---------------|--------------|-----|-----|---------------------|
| D.C. current gain | $V_{CE} = 5 \text{ V}; I_C = 10 \mu\text{A}$ | h_{FE} typ. | 78 | 145 | 220 | 300 |
| | | $h_{FE} >$ | — | 20 | 40 | 100 |
| | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}$ | $h_{FE} >$ | 120 | 180 | 250 | 380 |
| | | h_{FE} typ. | 170 | 250 | 350 | 500 |
| | $V_{CE} = 1 \text{ V}; I_C = 50 \text{ mA}$ | $h_{FE} <$ | 220 | 310 | 460 | 630 |
| | | $h_{FE} >$ | 50 | 70 | 90 | 100 |
| Input impedance | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | $h_{ie} >$ | 1,6 | 2,5 | 3,2 | 4,5 k Ω |
| | | h_{ie} typ. | 2,7 | 3,6 | 4,5 | 7,5 k Ω |
| | | $h_{ie} <$ | 4,5 | 6,0 | 8,5 | 12,0 k Ω |
| | | | | | | |
| Reverse voltage transfer ratio | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | h_{re} typ. | 1,5 | 2 | 2 | 3 10^{-4} |
| | | $h_{re} >$ | 125 | 175 | 250 | 350 |
| Small-signal current gain | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | h_{fe} typ. | 200 | 260 | 330 | 520 |
| | | $h_{fe} <$ | 250 | 350 | 500 | 700 |
| Output admittance | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | h_{oe} typ. | 18 | 24 | 30 | 50 $\mu\text{A/V}$ |
| | | $h_{oe} <$ | 30 | 50 | 60 | 100 $\mu\text{A/V}$ |
| Base-emitter voltage | $V_{CE} = 5 \text{ V}; I_C = 2 \text{ mA}$ | V_{BE} typ. | 0,55 to 0,75 | | | V |
| | | $V_{BE} >$ | 0,65 | | | V |
| | $V_{CE} = 5 \text{ V}; I_C = 10 \mu\text{A}$ | V_{BE} typ. | 0,52 | | | V |
| | | $V_{BE} >$ | 0,78 | | | V |
| | $V_{CE} = 1 \text{ V}; I_C = 50 \text{ mA}$ | V_{BE} typ. | 0,78 | | | V |
| | | $V_{BE} >$ | | | | |

Switching times

$I_{Con} = 10 \text{ mA}$; $I_{Bon} = -I_{Boff} = 1 \text{ mA}$
 $V_{CC} = 10 \text{ V}$; $R_L = 990 \Omega$

turn-on time ($t_d + t_r$)

turn-off time ($t_s + t_f$)

| | | |
|-----------|------|--------|
| t_{on} | typ. | 85 ns |
| | < | 150 ns |
| t_{off} | typ. | 480 ns |
| | < | 800 ns |

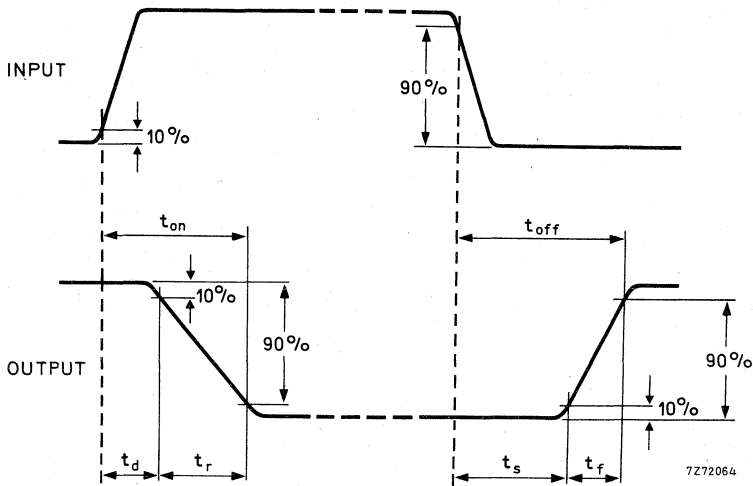


Fig. 2 Switching waveforms.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

QUICK REFERENCE DATA

| | | | |
|--|------------|------|---------|
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 32 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 32 V |
| Collector current (d.c.) | $-I_C$ | max. | 200 mA |
| Total power dissipation | P_{tot} | max. | 150 mW |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 100$ MHz $-V_{CE} = 5$ V; $-I_C = 10$ mA | f_T | typ. | 180 MHz |
| Noise figure at $f = 1$ kHz $-V_{CE} = 5$ V; $-I_C = 200$ μ A | F | typ. | 2 dB |

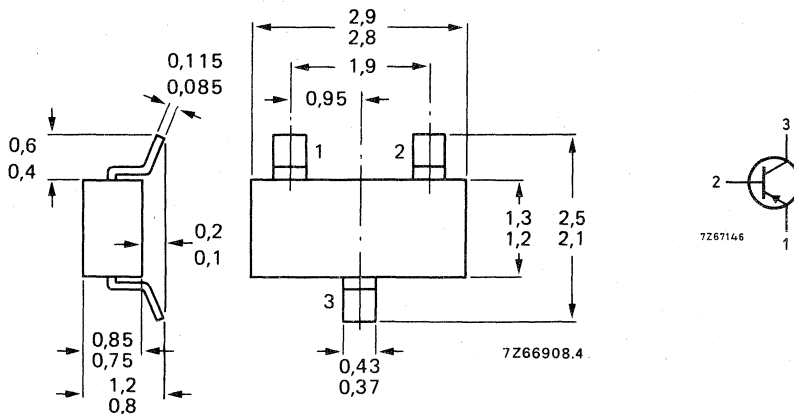
MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BCW61A = BA
BCW61B = BB
BCW61C = BC
BCW61D = BD



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|------------|------|-----------------|
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 32 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 32 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 200 mA |
| Base current | $-I_B$ | max. | 50 mA |
| Total power dissipation** | P_{tot} | max. | 150 mW |
| Storage temperature | T_{stg} | | -55 to + 125 °C |
| Junction temperature | T_j | max. | 150 °C |

THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ °C}$ unless otherwise specified

Collector-emitter cut-off current

$$V_{EB} = 0; -V_{CE} = 32\text{ V}$$

$$-I_{CES} < 20\text{ nA}$$

$$V_{EB} = 0; -V_{CE} = 32\text{ V}; T_{amb} = 150\text{ °C}$$

$$-I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; -V_{EB} = 4\text{ V}$$

$$-I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$-I_C = 10\text{ mA}; -I_B = 0,25\text{ mA}$$

$$-V_{CEsat} \quad 0,06\text{ to }0,25\text{ V}$$

$$-V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$-I_C = 50\text{ mA}; -I_B = 1,25\text{ mA}$$

$$-V_{CEsat} \quad 0,12\text{ to }0,55\text{ V}$$

$$-V_{BEsat} \quad 0,68\text{ to }1,05\text{ V}$$

Transition frequency at $f = 100\text{ MHz}$ ▲

$$-V_{CE} = 5\text{ V}; -I_C = 10\text{ mA}$$

$$f_T \quad \text{typ.} \quad 180\text{ MHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$-V_{CB} = 10\text{ V}; I_E = I_e = 0$$

$$C_C < 6\text{ pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$-V_{EB} = 0,5\text{ V}; I_C = I_c = 0$$

$$C_e \quad \text{typ.} \quad 11\text{ pF}$$

Noise figure at $R_S = 2\text{ k}\Omega$

$$-V_{CE} = 5\text{ V}; -I_C = 200\text{ }\mu\text{A}; B = 200\text{ Hz}$$

$$F \quad \text{typ.} \quad 2\text{ dB}$$

$$< \quad 6\text{ dB}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

▲ Measured under pulse conditions.

| | | A | B | C | D |
|--------------------------------|---|----------------------------------|------|-----|----------------------|
| D.C. current gain | | | | | |
| | $-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$ | h _{FE} typ. 140 | 200 | 270 | 340 |
| | | > — | 30 | 40 | 100 |
| | | > 120 | 180 | 250 | 380 |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$ | h _{FE} typ. 170 | 250 | 350 | 500 |
| | | < 220 | 310 | 460 | 630 |
| | | > 60 | 80 | 100 | 110 |
| | $-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$ | h _{FE} typ. 1,6 | 2,5 | 3,2 | 4,5 kΩ |
| Input impedance | | > 2,7 | 3,6 | 4,5 | 7,5 kΩ |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | h _{ie} typ. 2,7 | 3,6 | 4,5 | 7,5 kΩ |
| | | < 4,5 | 6,0 | 8,5 | 12,0 kΩ |
| Reverse voltage transfer ratio | | h _{re} typ. 1,5 | 2 | 2 | 3 · 10 ⁻⁴ |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | > 125 | 175 | 250 | 350 |
| Small-signal current gain | | h _{fe} typ. 200 | 260 | 330 | 520 |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | < 250 | 350 | 500 | 700 |
| Output admittance | | h _{oe} typ. 18 | 24 | 30 | 50 μA/V |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | < 30 | 50 | 60 | 100 μA/V |
| Base-emitter voltage | | V _{BE} typ. 0,6 to 0,75 | | | V |
| | $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$ | | 0,65 | | V |
| | $-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$ | V _{BE} typ. 0,55 | | | V |
| | $-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$ | V _{BE} typ. 0,72 | | | V |

Switching times

$-I_{Con} = 10 \text{ mA}; -I_{Bon} = I_{Boff} = 1 \text{ mA}$
 $-V_{CC} = 10 \text{ V}; R_L = 990 \Omega$

turn-on time ($t_d + t_r$)

t_{on} typ. 85 ns
 < 150 ns

turn-off time ($t_s + t_f$)

t_{off} typ. 480 ns
 < 800 ns

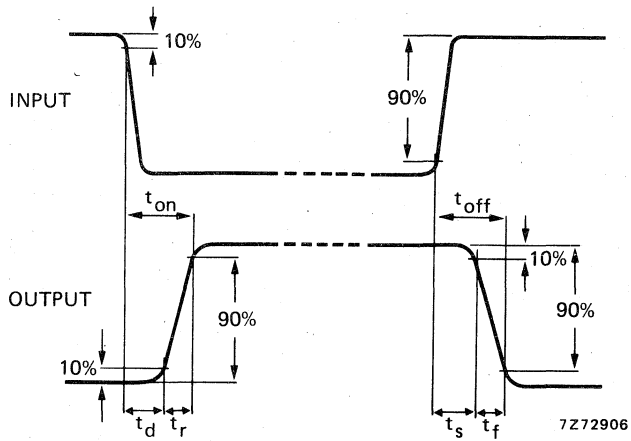


Fig. 2 Switching waveforms.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | BCW69 BCW69R | BCW70 BCW70R | |
|---|-----------------|-----------------|-----------------|------------------|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | > 120 < 260 | 215 500 | |
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | | 50 | V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | | 45 | V |
| Collector current (peak value) | $-I_{CM}$ max. | | 200 | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} max. | | 350 | mW |
| Junction temperature | T_j max. | | 175 | $^\circ\text{C}$ |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T typ. | | 150 | MHz |
| Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 10 | dB |

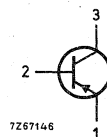
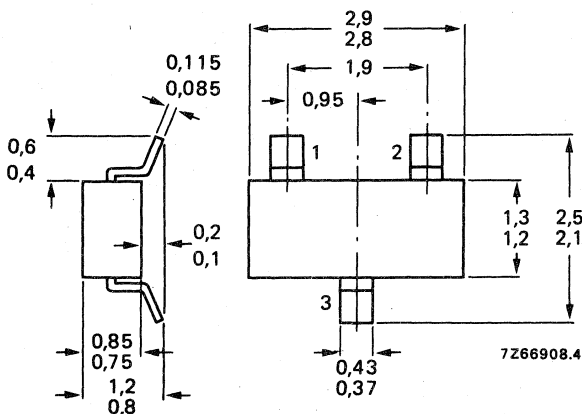
MECHANICAL DATA

Dimensions in mm

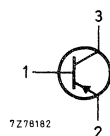
Marking code

Fig. 1 SOT-23.

BCW69 = H1
BCW70 = H2



BCW69R = H4
BCW70R = H5



See also *Soldering recommendations.*

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC134)

| | | | |
|--|------------|------|------------------------------|
| Collector-base voltage (open emitter) see Fig. 2 | $-V_{CB0}$ | max. | 50 V |
| Collector-emitter voltage ($V_{BE} = 0$) see Fig. 2 | $-V_{CES}$ | max. | 50 V |
| Collector-emitter voltage (open base) see Fig. 2 | | | |
| $-I_C = 2 \text{ mA}$ | $-V_{CEO}$ | max. | 45 V |
| Emitter-base voltage (open collector) see Fig. 2 | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 100 mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 20 \text{ V} \quad -I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; -V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C} \quad -I_{CBO} < 10 \text{ } \mu\text{A}$$

Base-emitter voltage

$$-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V} \quad -V_{BE} \quad 600 \text{ to } 750 \text{ mV}$$

Saturation voltages

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{CEsat} \text{ typ. } 80 \text{ mV}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{CEsat} < 300 \text{ mV}$$

$$-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA} \quad -V_{BEsat} \text{ typ. } 720 \text{ mV}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{BEsat} \text{ typ. } 150 \text{ mV}$$

$$-I_C = 50 \text{ mA}; -I_B = 2,5 \text{ mA} \quad -V_{BEsat} \text{ typ. } 810 \text{ mV}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

$-I_C = 2 mA; -V_{CE} = 5 V$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

Transition frequency at $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

Noise figure at $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

| | | BCW69 BCW69R | BCW70 BCW70R |
|----------|------|-----------------|-----------------|
| h_{FE} | typ. | 90 | 150 |
| h_{FE} | > | 120 | 215 |
| h_{FE} | < | 260 | 500 |
| C_c | < | 7,0 | pF |
| f_T | typ. | 150 | MHz |
| F | < | 10 | dB |

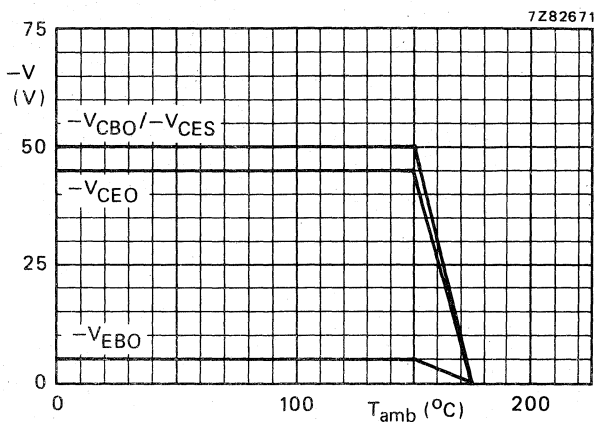


Fig. 2 Voltage derating curve.

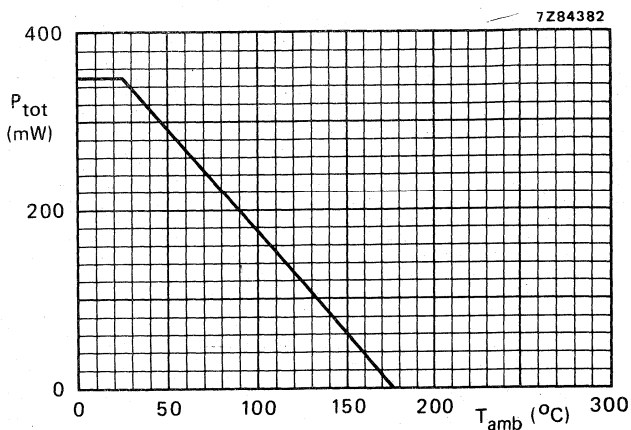


Fig. 3 Power derating curve.

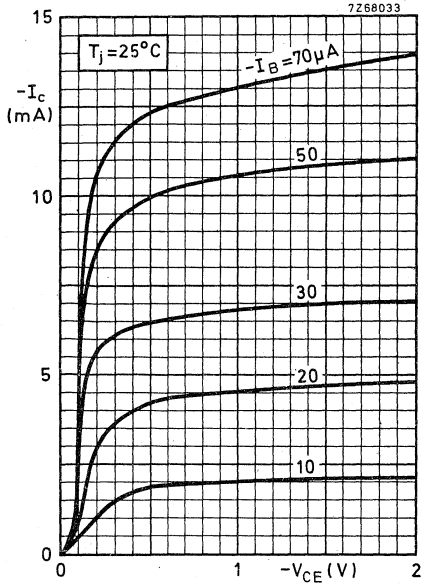


Fig. 4.

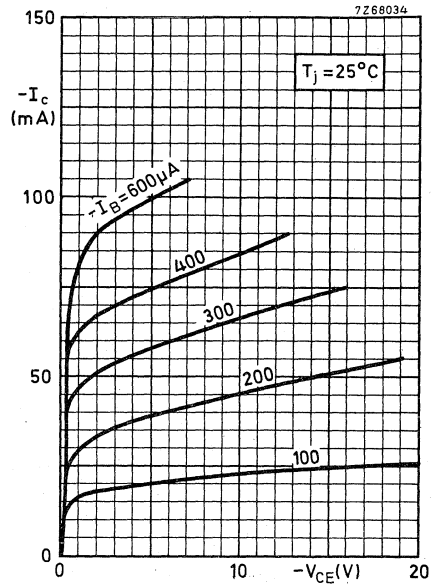


Fig. 5.

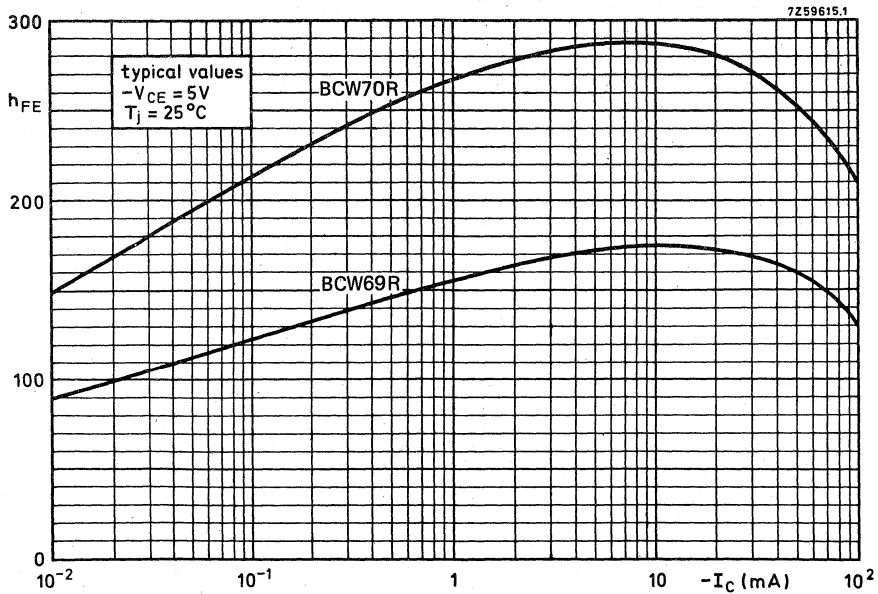


Fig. 6 D.C. current gain.

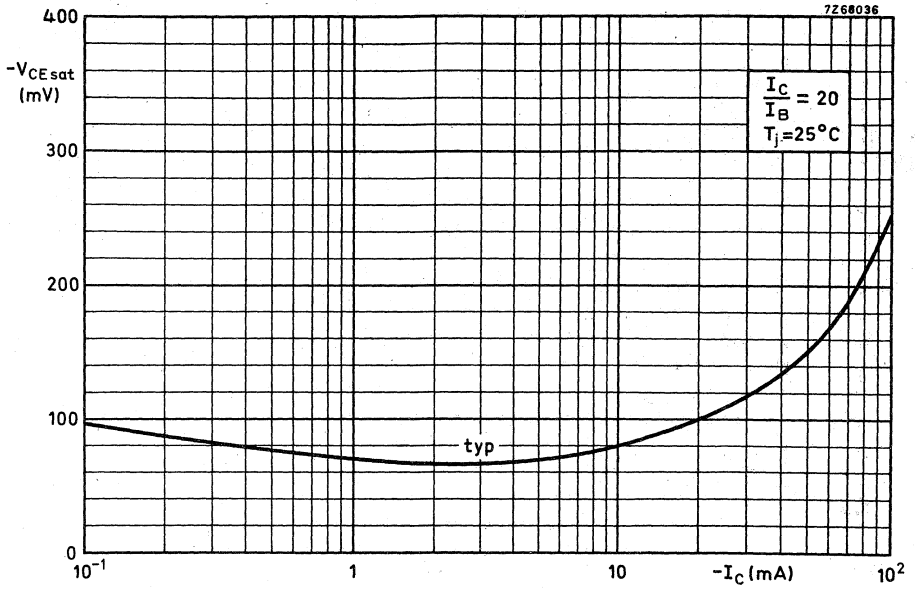


Fig. 7.

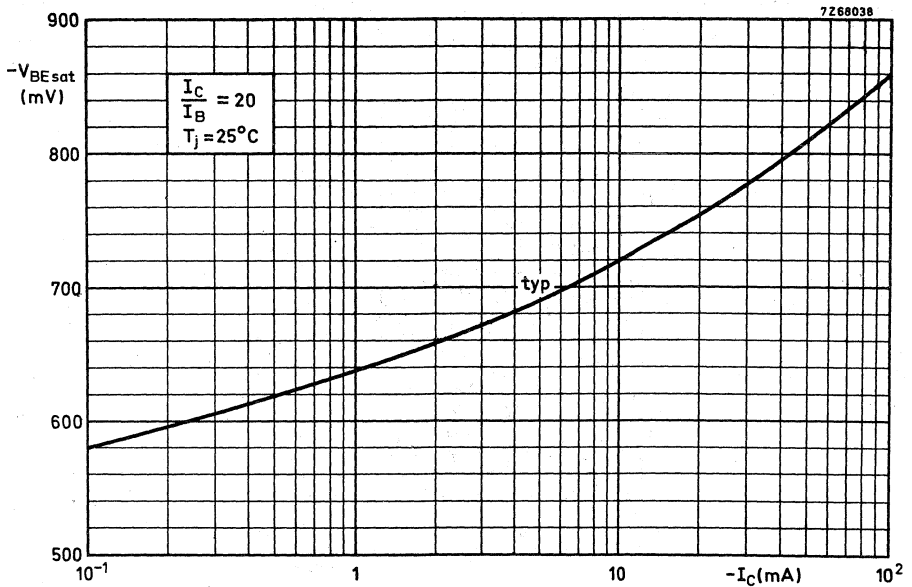


Fig. 8.

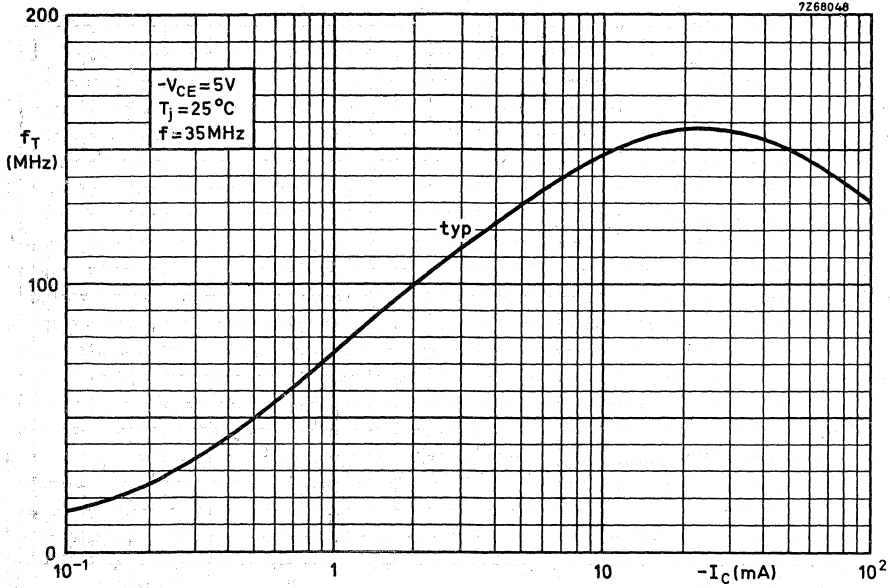


Fig. 9.

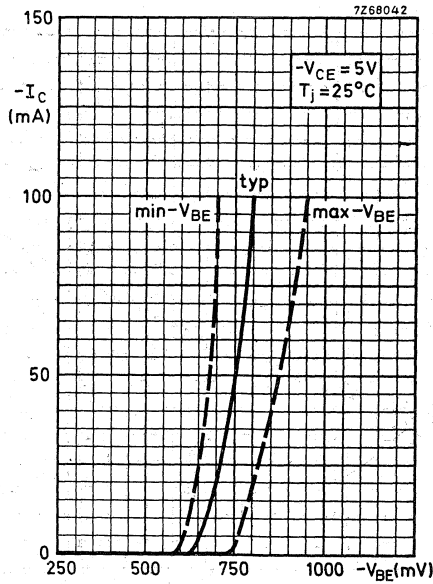


Fig. 10.

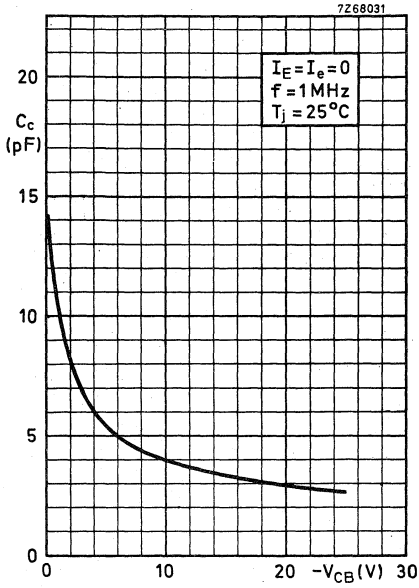


Fig. 11.

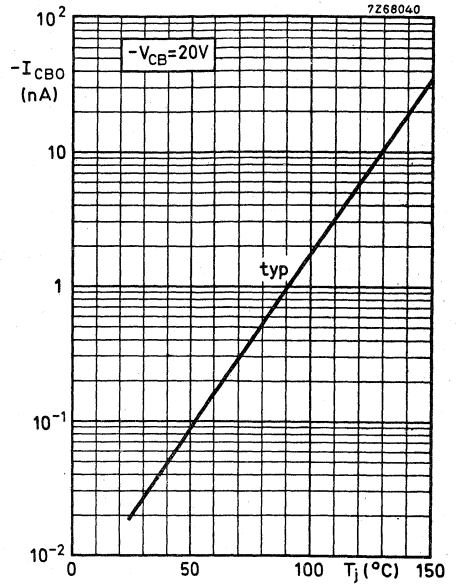


Fig. 12.



SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

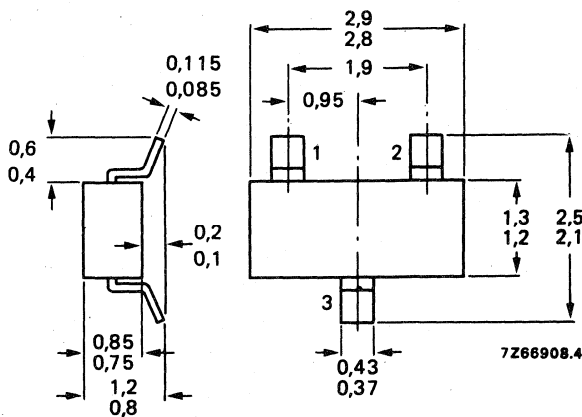
QUICK REFERENCE DATA

| | | BCW71 BCW71R | BCW72 BCW72R | |
|---|-----------|----------------------|-----------------|--------------------|
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | > 110 < 220 | 200 450 | |
| Collector-base voltage (open emitter) | V_{CBO} | max. | 50 | V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 | V |
| Collector current (peak value) | I_{CM} | max. | 200 | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 350 | mW ← |
| Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ ← |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$ | f_T | typ. | 300 | MHz |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 10 | dB |

MECHANICAL DATA

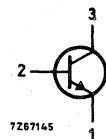
Fig. 1 SOT-23.

Dimensions in mm

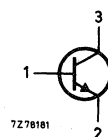


Marking code

BCW71 = K1
BCW72 = K2



BCW71R = K4
BCW72R = K5



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|------------------------------|
| Collector-base voltage (open emitter) see Fig. 2 | V_{CB0} | max. | 50 V |
| Collector-emitter voltage (open base) see Fig. 2 $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 45 V |
| Emitter-base voltage (open collector) see Fig. 2 | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 100 mA |
| Collector current (peak value) | I_{CM} | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20 \text{ V}$$

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

Base emitter voltage

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$V_{BE} \quad 550 \text{ to } 700 \text{ mV}$$

Saturation voltages

$$I_C = 10 \text{ mA}; I_B = 0,5 \text{ mA}$$

$$V_{CEsat} \quad \text{typ. } 120 \text{ mV}$$

$$V_{CEsat} < 250 \text{ mV}$$

$$I_C = 50 \text{ mA}; I_B = 2,5 \text{ mA}$$

$$V_{BEsat} \quad \text{typ. } 750 \text{ mV}$$

$$V_{CEsat} \quad \text{typ. } 210 \text{ mV}$$

$$V_{BEsat} \quad \text{typ. } 850 \text{ mV}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$I_C = 10 \mu A; V_{CE} = 5 V$

$I_C = 2 mA; V_{CE} = 5 V$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; V_{CB} = 10 V$

Transition frequency at $f = 35 MHz$

$I_C = 10 mA; V_{CE} = 5 V$

Noise figure at $R_S = 2 k\Omega$

$I_C = 200 \mu A; V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

| | | BCW71;R | BCW72;R |
|----------|------|---------|---------|
| h_{FE} | typ. | 90 | 150 |
| h_{FE} | > | 110 | 200 |
| h_{FE} | < | 220 | 450 |
| C_c | < | 4,0 | pF |
| f_T | typ. | 300 | MHz |
| F | < | 10 | dB |

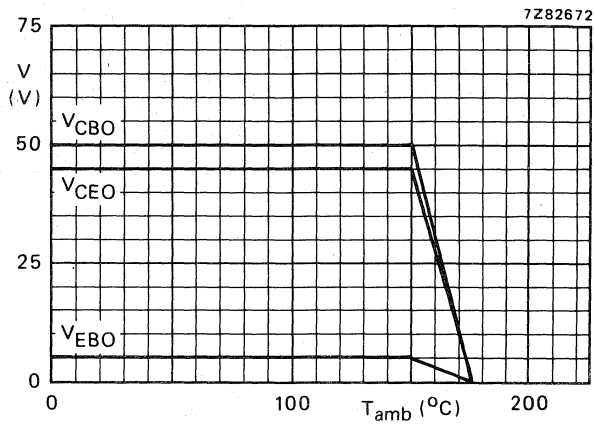


Fig. 2 Voltage derating curves.

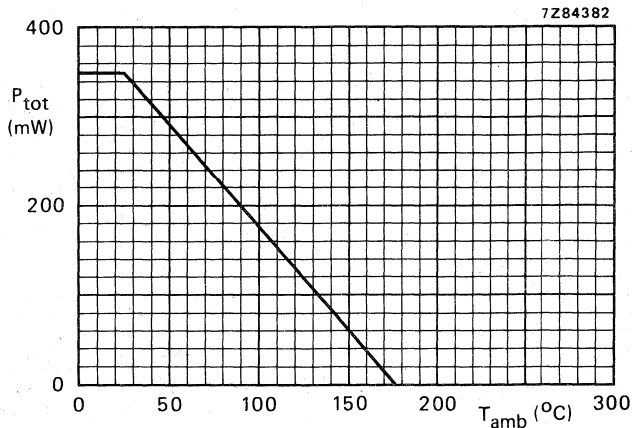


Fig. 3 Power derating curve.

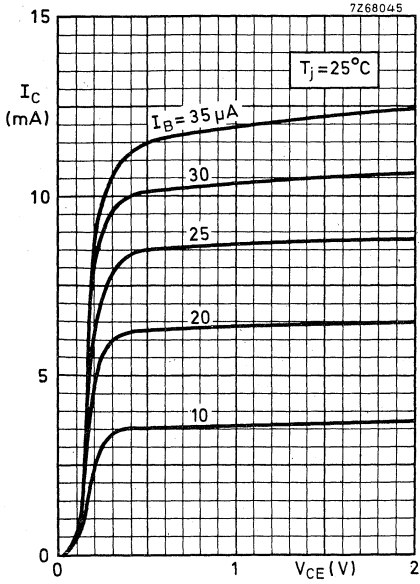


Fig. 4.

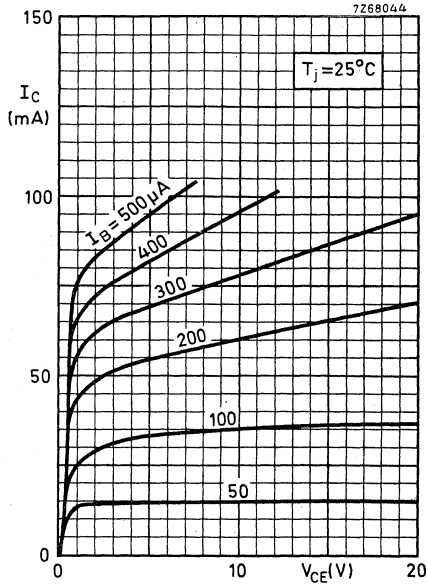


Fig. 5.

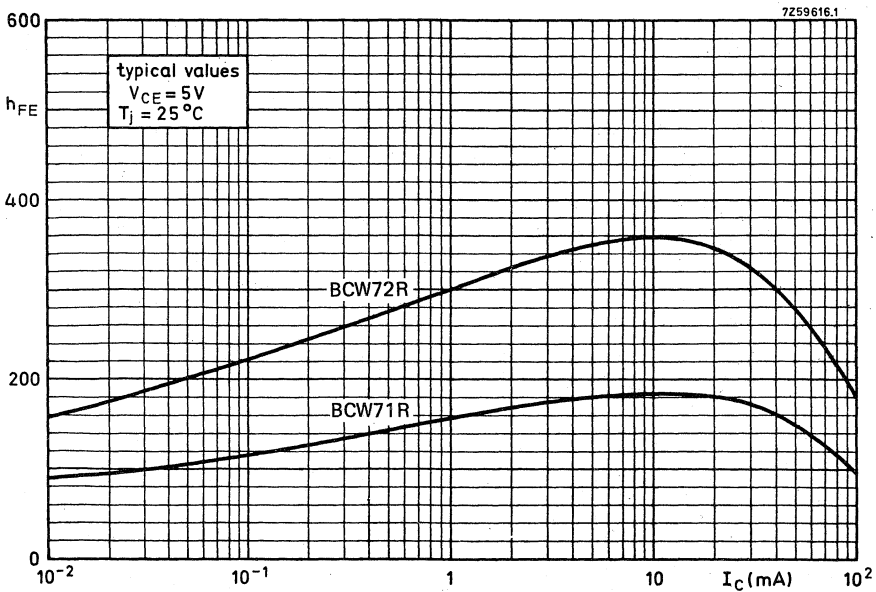


Fig. 6 D.C. current gain.

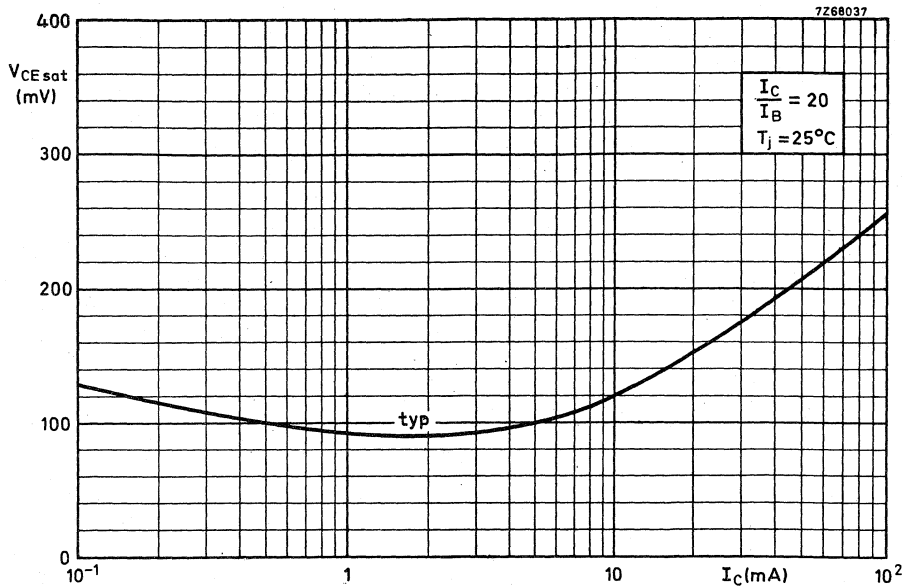


Fig. 7.

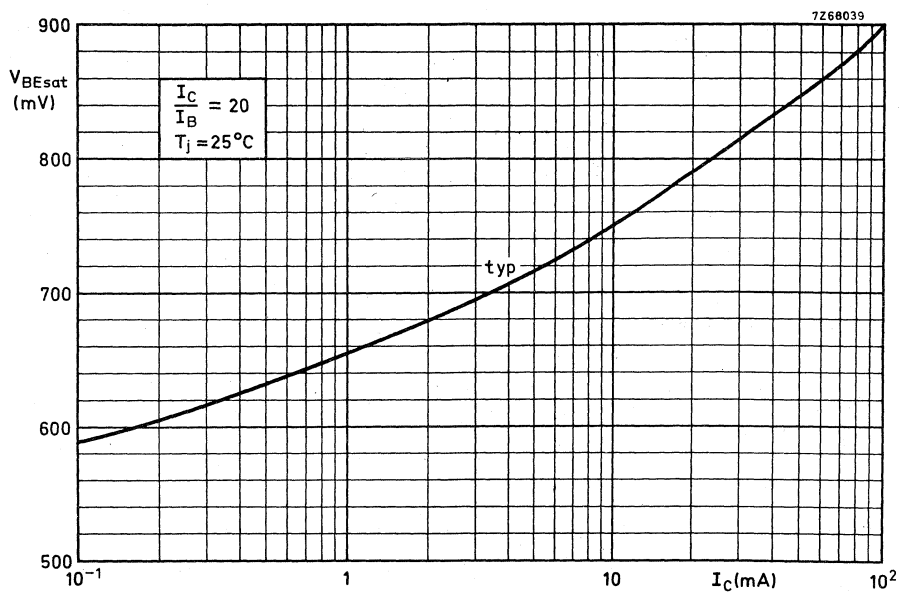


Fig. 8.

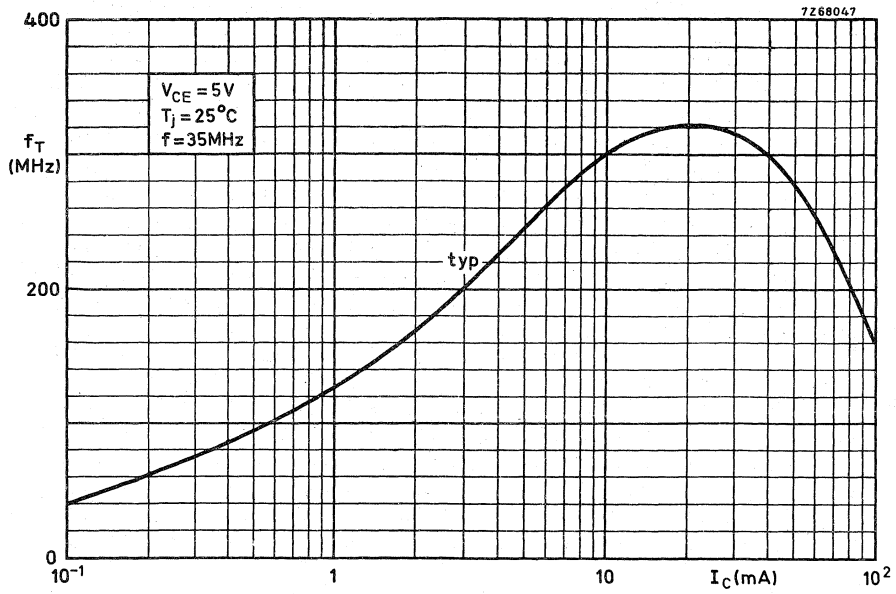


Fig. 9.

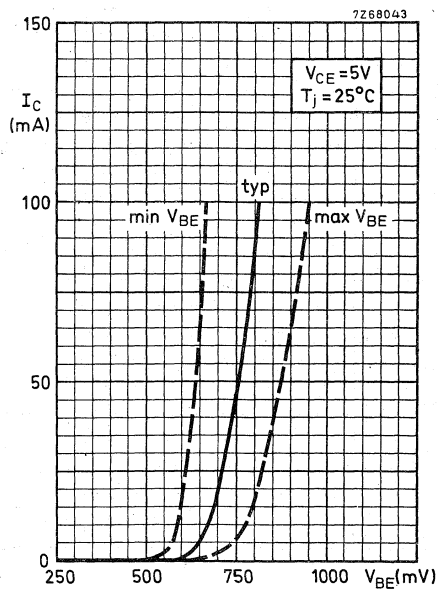


Fig. 10.

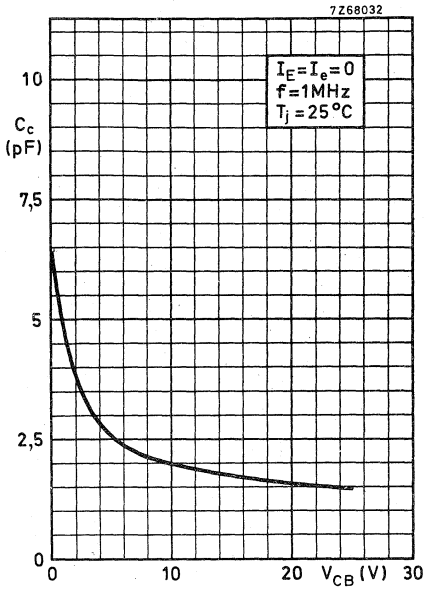


Fig. 11.

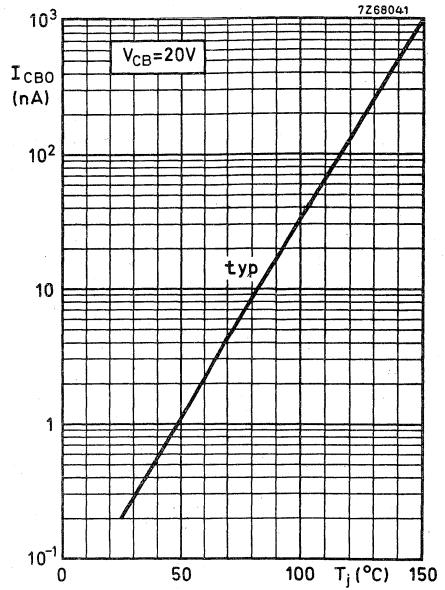


Fig. 12.



SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|---|-----------|------|------------------------|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 50 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 V | |
| Collector current (peak value) | I_{CM} | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | h_{FE} | > | 420 | |
| | | < | 800 | |
| Transition frequency at $f = 35\text{ MHz}$ $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$ | f_T | typ. | 300 MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 10 dB | |

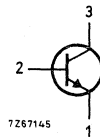
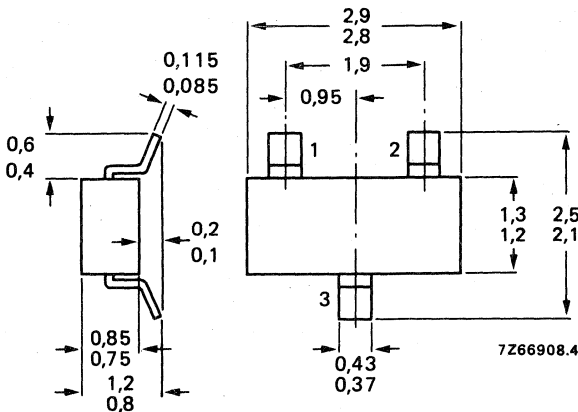
MECHANICAL DATA

Dimensions in mm

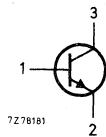
Marking code

Fig. 1 SOT-23.

BCW81 = K3



BCW81R = K31



See also *Soldering recommendations.*

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2

V_{CBO} max. 50 V

Collector-emitter voltage (open base) see Fig. 2

V_{CEO} max. 45 V

$I_C = 2$ mA

Emitter-base voltage (open collector) see Fig. 2

V_{EBO} max. 5 V

Collector current (d.c.)

I_C max. 100 mA

Collector current (peak value)

I_{CM} max. 200 mA

Total power dissipation up to $T_{amb} = 25$ °C mounted on a ceramic substrate of

7 mm x 5 mm x 0,6 mm

P_{tot} max. 350 mW

→ Storage temperature

T_{stg} -65 to + 175 °C

→ Junction temperature

T_j max. 175 °C

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

From junction to tab

$R_{th\ j-t}$ = 50 K/W

From tab to soldering points

$R_{th\ t-s}$ = 260 K/W

From soldering points to ambient**

$R_{th\ s-a}$ = 120 K/W

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$I_E = 0$; $V_{CB} = 20$ V

I_{CBO} < 100 nA

$I_E = 0$; $V_{CB} = 20$ V; $T_j = 100$ °C

I_{CBO} < 10 µA

Base emitter voltage

$I_C = 2$ mA; $V_{CE} = 5$ V

V_{BE} 550 to 700 mV

Saturation voltages

$I_C = 10$ mA; $I_B = 0,5$ mA

V_{CEsat} typ. 120 mV
< 250 mV

$I_C = 50$ mA; $I_B = 2,5$ mA

V_{BEsat} typ. 750 mV

V_{CEsat} typ. 210 mV

V_{BEsat} typ. 850 mV

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}$

$h_{FE} > 420$
 $h_{FE} < 800$

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

$C_c < 4,0 \text{ pF}$

Transition frequency at $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

$f_T \text{ typ. } 300 \text{ MHz}$

Noise figure at $R_S = 2 \text{ k}\Omega$

$I_C = 200 \mu\text{A}; V_{CE} = 5 \text{ V}$

$f = 1 \text{ kHz}; B = 200 \text{ Hz}$

$F < 10 \text{ dB}$

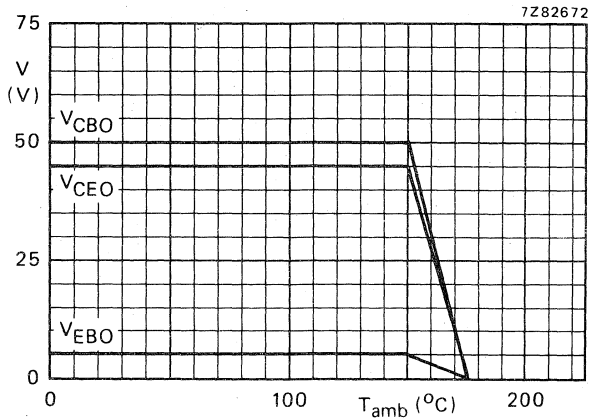


Fig. 2 Voltage derating curves.

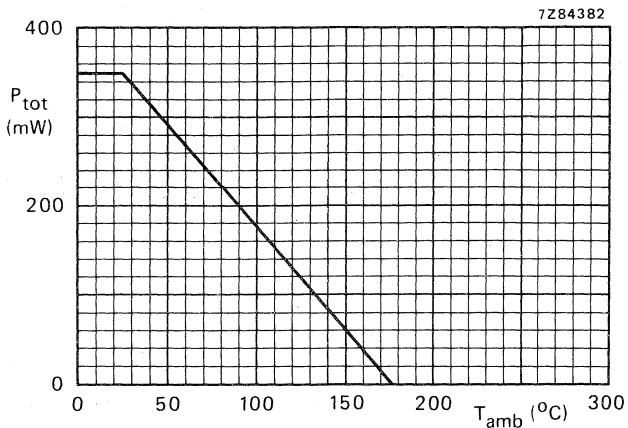


Fig. 3 Power derating curve.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic envelope, intended for low level general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|---|------------|------|------------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 80 V | ← |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 60 V | |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | > | 120 | |
| | | < | 260 | |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T | typ. | 150 MHz | |
| Noise figure at $R_S = 2\text{ k}\Omega$ $-I_C = 200\text{ }\mu\text{A}; -V_{CE} = 5\text{ V};$ $f = 1\text{ kHz}; B = 200\text{ Hz}$ | F | < | 10 dB | |

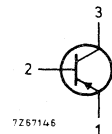
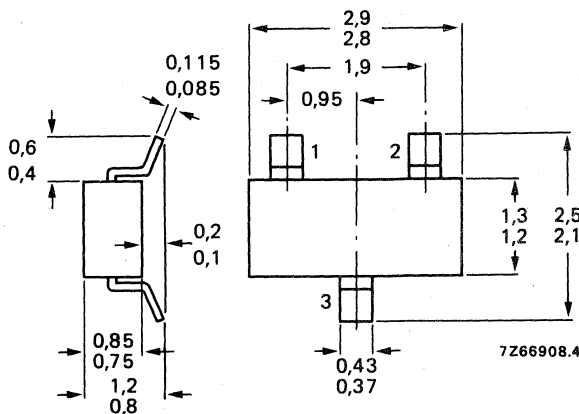
MECHANICAL DATA

Dimensions in mm

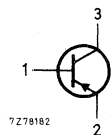
Marking code

Fig. 1 SOT-23.

BCW89 = H3



BCW89R = H31



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|------------|------|-----------------|
| Collector-base voltage (open emitter) see Fig. 2 | $-V_{CBO}$ | max. | 80 V |
| Collector-emitter voltage ($V_{BE} = 0$) see Fig. 2 | $-V_{CES}$ | max. | 60 V |
| Collector-emitter voltage (open base) see Fig. 2 | $-V_{CEO}$ | max. | 60 V |
| $-I_C = 2$ mA | $-V_{EBO}$ | max. | 5 V |
| Emitter-base voltage (open collector) see Fig. 2 | $-I_C$ | max. | 100 mA |
| Collector current (d.c.) | $-I_{CM}$ | max. | 200 mA |
| Collector current (peak value) | | | |
| Total power dissipation up to $T_{amb} = 25$ °C mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to + 175 °C |
| Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 20$ V $-I_{CBO} < 100$ nA

$I_E = 0; -V_{CB} = 20$ V; $T_j = 100$ °C $-I_{CBO} < 10$ μA

Base-emitter voltage

$-I_C = 2$ mA; $-V_{CE} = 5$ V; $T_j = 25$ °C $-V_{BE}$ 600 to 750 mV

Saturation voltages

$-I_C = 10$ mA; $-I_B = 0,5$ mA $-V_{CEsat}$ typ. 80 mV
< 300 mV

$-I_C = 50$ mA; $-I_B = 2,5$ mA $-V_{BEsat}$ typ. 720 mV
 $-V_{CEsat}$ typ. 150 mV
 $-V_{BEsat}$ typ. 810 mV

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain

$-I_C = 10 \mu A; -V_{CE} = 5 V$

h_{FE} typ. 90

$-I_C = 2 mA; -V_{CE} = 5 V$

$h_{FE} > 120$
 $h_{FE} < 260$

Collector capacitance at $f = 1 MHz$

$I_E = I_e = 0; -V_{CB} = 10 V$

$C_c < 7,0 pF$

Transition frequency at $f = 35 MHz$

$-I_C = 10 mA; -V_{CE} = 5 V$

f_T typ. 150 MHz

Noise figure at $R_S = 2 k\Omega$

$-I_C = 200 \mu A; -V_{CE} = 5 V$

$f = 1 kHz; B = 200 Hz$

$F < 10 dB$

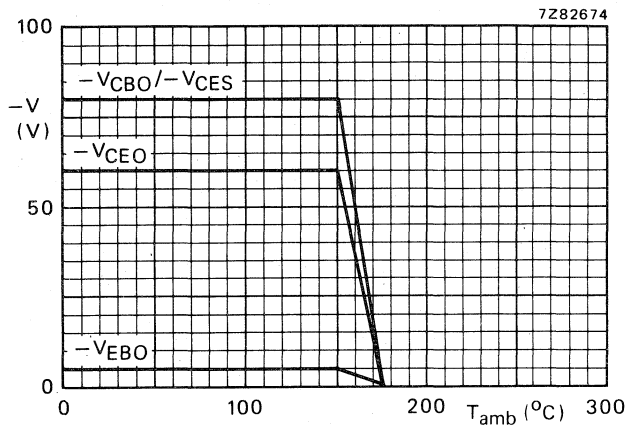


Fig. 2 Voltage derating curves.

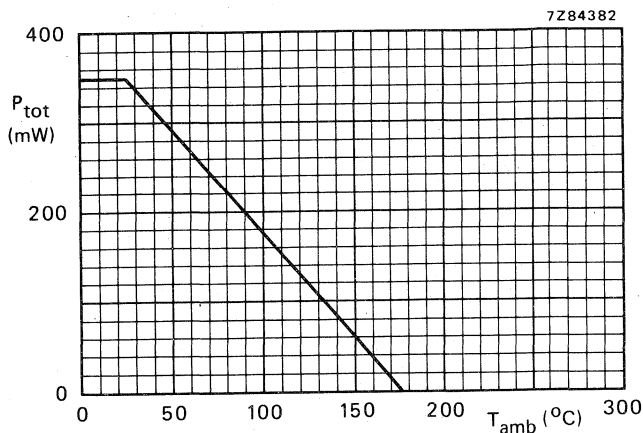


Fig. 3 Power derating curve.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a SOT-23 plastic envelope, intended for application in thick and thin-film circuits. These transistors are intended for general purposes as well as saturated switching and driver applications for industrial service.

N-P-N complements are BCX19; 19R and BCX20; 20R respectively.

QUICK REFERENCE DATA

| | | BCX17 BCX17R | BCX18 BCX18R | |
|--|-----------------|-----------------|-----------------|----------------------|
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ max. | 50 | 30 | V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 45 | 25 | V |
| Collector current (peak value) | $-I_{CM}$ max. | 1000 | | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} max. | 425 | | mW ← |
| Junction temperature | T_j max. | 175 | | $^{\circ}\text{C}$ ← |
| D.C. current gain | h_{FE} | 100 to 600 | | |
| $-I_C = 100\text{ mA}; -V_{CE} = 1\text{ V}$ | | | | |
| Transition frequency | f_T typ. | 100 | | MHz |
| $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}; f = 35\text{ MHz}$ | | | | |

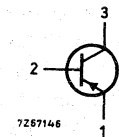
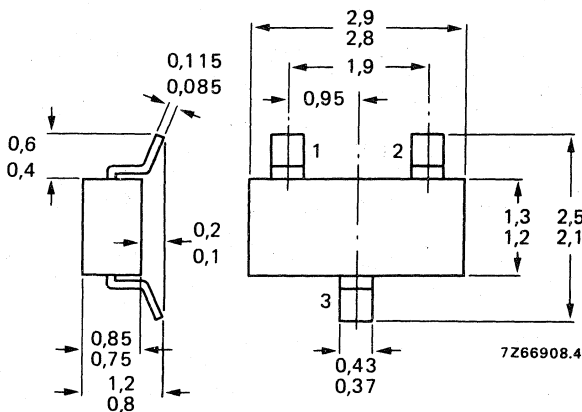
MECHANICAL DATA

Dimensions in mm

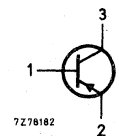
Marking code

Fig. 1 SOT-23.

BCX17 = T1
BCX18 = T2



BCX17R = T4
BCX18R = T5



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | BCX17; R | BCX18; R | |
|--|------------|------|--------------|----------|----|
| Collector-emitter voltage ($V_{BE} = 0$) (see Fig. 2) | $-V_{CES}$ | max. | 50 | 30 | V |
| Collector-emitter voltage (open base) $-I_C = 10$ mA (see Fig. 2) | $-V_{CEO}$ | max. | 45 | 25 | V |
| Emitter-base voltage (open collector) (see Fig. 2) | $-V_{EBO}$ | max. | 5 | 5 | V |
| Collector current (d.c.) | $-I_C$ | max. | 500 | | mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 1000 | | mA |
| Emitter current (peak value) | I_{EM} | max. | 1000 | | mA |
| Base current (d.c.) | $-I_B$ | max. | 100 | | mA |
| Base current (peak value) | $-I_{BM}$ | max. | 200 | | mA |
| → Total power dissipation up to $T_{amb} = 25$ °C* | P_{tot} | max. | 425 | | mW |
| → Storage temperature | T_{stg} | | -65 to + 175 | | °C |
| → Junction temperature | T_j | max. | 175 | | °C |

→ **THERMAL CHARACTERISTICS****

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | | |
|-----------------------------------|--------------|---|-----|-----|
| From junction to tab | $R_{th j-t}$ | = | 30 | K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 | K/W |
| From soldering points to ambient* | $R_{th s-a}$ | = | 60 | K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

| | | | | |
|--|--------------|---|-----|----|
| Collector cut-off current $I_E = 0; -V_{CB} = 20$ V | $-I_{CBO}$ | < | 100 | nA |
| $I_E = 0; -V_{CB} = 20$ V; $T_j = 150$ °C | $-I_{CBO}$ | < | 5 | μA |
| Emitter cut-off current $I_C = 0; -V_{EB} = 5$ V | $-I_{EBO}$ | < | 10 | μA |
| Base-emitter voltage ▲ $-I_C = 500$ mA; $-V_{CE} = 1$ V | $-V_{BE}$ | < | 1,2 | V |
| Saturation voltage $-I_C = 500$ mA; $-I_B = 50$ mA | $-V_{CEsat}$ | < | 620 | mV |

* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,6 mm.

** See *Thermal characteristics* in chapter GENERAL.

▲ $-V_{BE}$ decreases by about 2 mV/°C with increasing temperature.

D.C. current gain

$-I_C = 100 \text{ mA}; -V_{CE} = 1 \text{ V}$

$-I_C = 300 \text{ mA}; -V_{CE} = 1 \text{ V}$

$-I_C = 500 \text{ mA}; -V_{CE} = 1 \text{ V}$

Transition frequency at $f = 35 \text{ MHz}$

$-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$

$h_{FE} \quad 100 \text{ to } 600$

$h_{FE} \quad > \quad 70$

$h_{FE} \quad > \quad 40$

$f_T \quad \text{typ.} \quad 100 \text{ MHz}$

$C_c \quad \text{typ.} \quad 8 \text{ pF}$

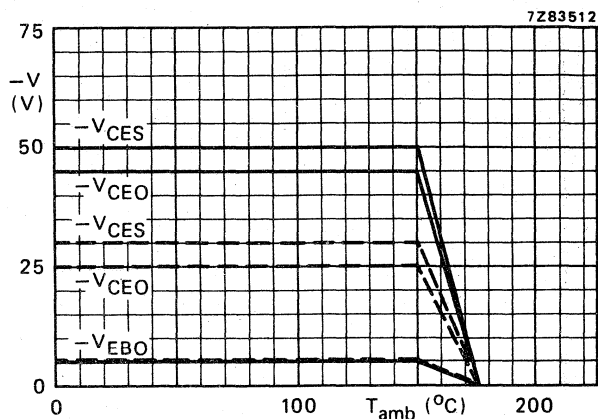


Fig. 2 Voltage derating curves. - - - BCX18; R — BCX17; R.

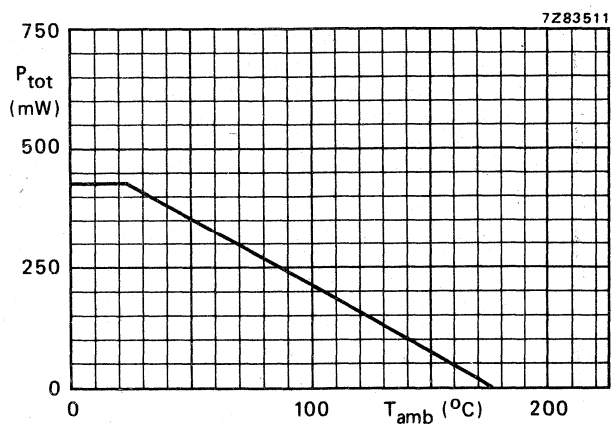


Fig. 3 Power derating curve.

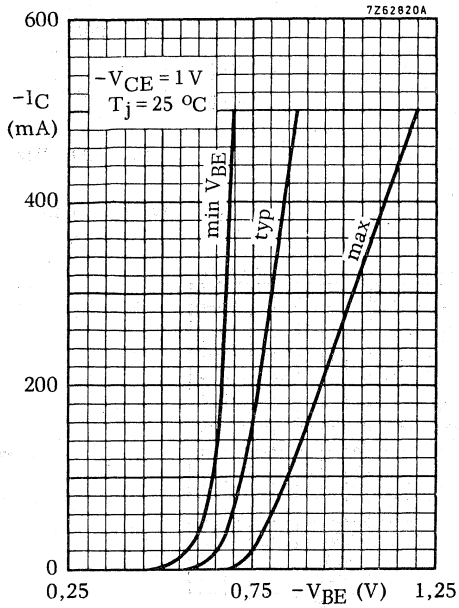


Fig. 4.

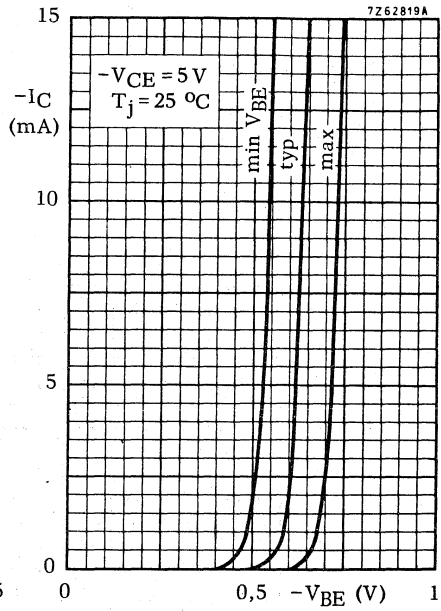


Fig. 5.

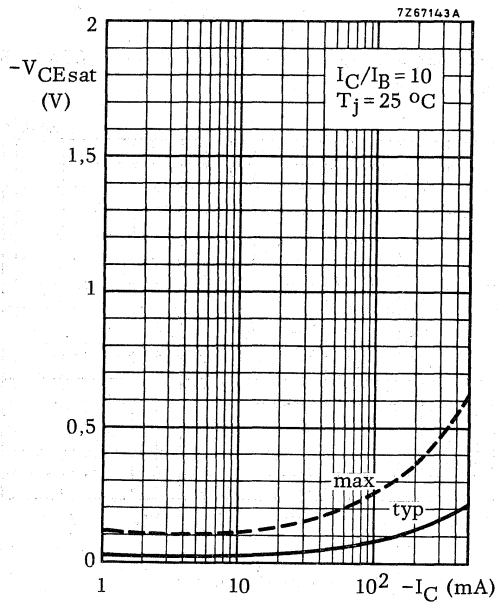


Fig. 6.

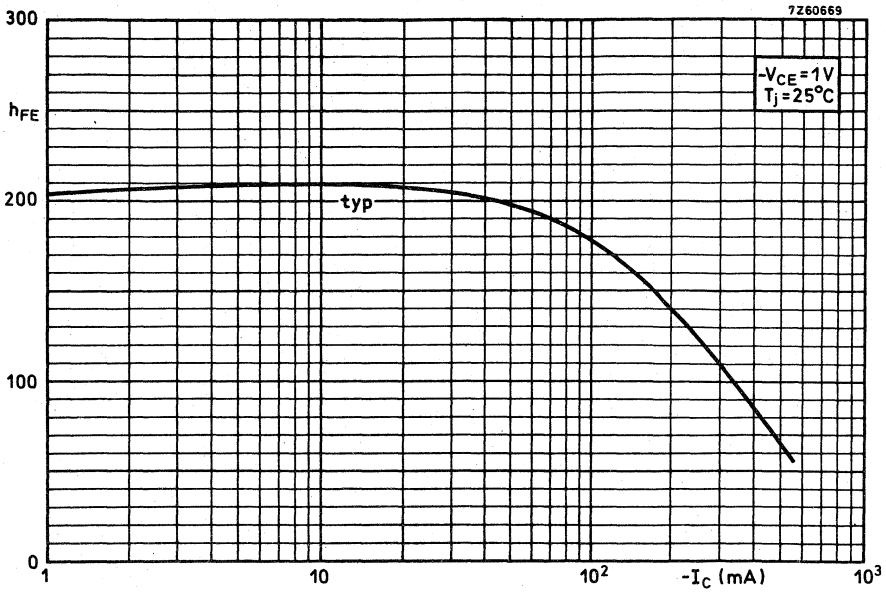


Fig. 7.

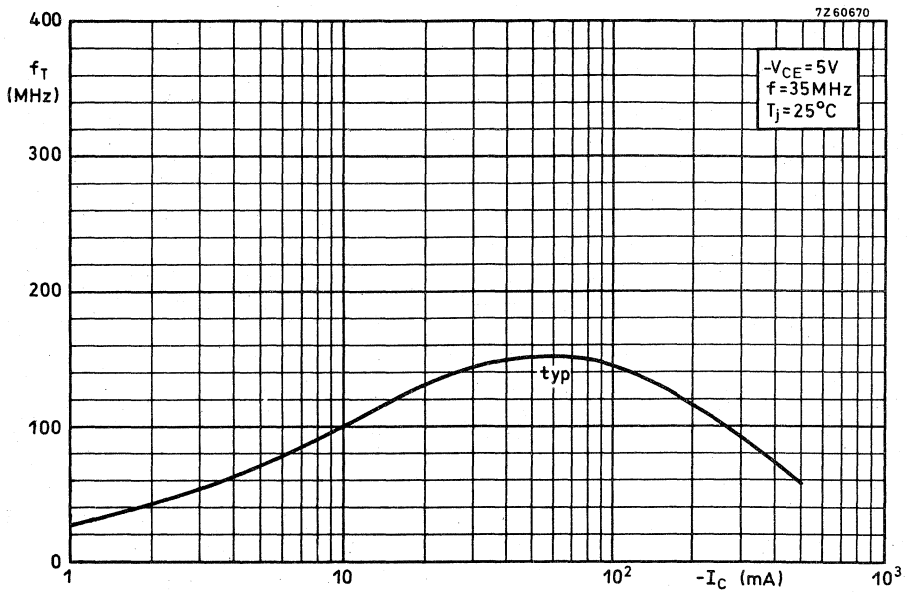


Fig. 8.

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors, in a SOT-23 plastic envelope, intended for application in thick and thin-film circuits. These transistors are intended for general purposes as well as saturated switching and driver applications for industrial service.

P-N-P complements are BCX17; 17R and BCX18; 18R respectively.

QUICK REFERENCE DATA

| | | BCX19; R | | BCX20; R | |
|--|----------------|------------|----|--------------------|---|
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} max. | 50 | 30 | V | |
| Collector-emitter voltage (open base) | V_{CEO} max. | 45 | 25 | V | |
| Collector current (peak value) | I_{CM} max. | 1000 | | mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} max. | 425 | | mW | ← |
| Junction temperature | T_j max. | 175 | | $^{\circ}\text{C}$ | ← |
| D.C. current gain $I_C = 100\text{ mA}; V_{CE} = 1\text{ V}$ | h_{FE} | 100 to 600 | | | |
| Transition frequency $I_C = 10\text{ mA}; V_{CE} = 5\text{ V}; f = 35\text{ MHz}$ | f_T typ. | 200 | | MHz | |

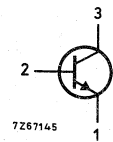
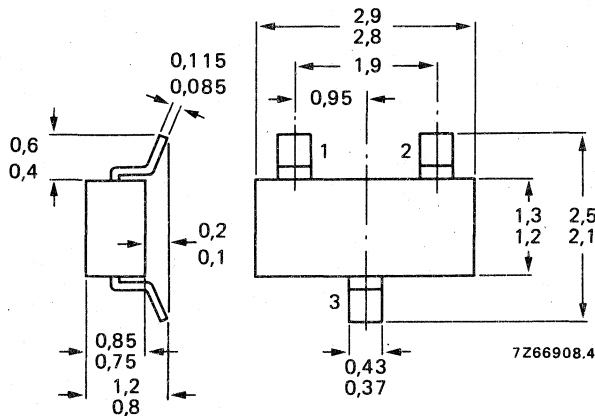
MECHANICAL DATA

Dimensions in mm

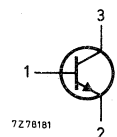
Marking code

Fig. 1 SOT-23.

BCX19 = U1
BCX20 = U2



BCX19R = U4
BCX20R = U5



See also *Soldering recommendations*.

BCX19; R BCX20; R

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | BCX19; R | BCX20; R | |
|---|----------------|--------------|----------|----|
| Collector-emitter voltage ($V_{BE} = 0$) (see Fig. 2) | V_{CES} max. | 50 | 30 | V |
| Collector-emitter voltage (open base) $I_C = 10$ mA (see Fig. 2) | V_{CEO} max. | 45 | 25 | V |
| Emitter-base voltage (open collector) (see Fig. 2) | V_{EBO} max. | 5 | 5 | V |
| Collector current (d.c.) | I_C max. | 500 | | mA |
| Collector current (peak value) | I_{CM} max. | 1000 | | mA |
| Emitter current (peak value) | $-I_{EM}$ max. | 1000 | | mA |
| Base current (d.c.) | I_B max. | 100 | | mA |
| Base current (peak value) | I_{BM} max. | 200 | | mA |
| → Total power dissipation up to $T_{amb} = 25$ °C* | P_{tot} max. | 425 | | mW |
| → Storage temperature | T_{stg} | -65 to + 175 | | °C |
| → Junction temperature | T_j max. | 175 | | °C |

→ THERMAL CHARACTERISTICS**

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-----------------------------------|-----------------|-----|-----|
| From junction to tab | $R_{th\ j-t} =$ | 30 | K/W |
| From tab to soldering points | $R_{th\ t-s} =$ | 260 | K/W |
| From soldering points to ambient* | $R_{th\ s-a} =$ | 60 | K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 20$$
 V

$$I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 150$$
 °C

$$I_{CBO} < 5 \text{ } \mu\text{A}$$

Emitter cut-off current

$$I_C = 0; V_{EB} = 5$$
 V

$$I_{EBO} < 10 \text{ } \mu\text{A}$$

Base emitter voltage ▲

$$I_C = 500 \text{ mA}; V_{CE} = 1$$
 V

$$V_{BE} < 1.2 \text{ V}$$

Saturation voltage

$$I_C = 500 \text{ mA}; I_B = 50$$
 mA

$$V_{CEsat} < 620 \text{ mV}$$

* Mounted on a ceramic substrate of 15 mm x 15 mm x 0,6 mm.

** See *Thermal characteristics* in chapter GENERAL.

▲ V_{BE} decreases by about 2 mV/°C with increasing temperature.

D.C. current gain

$I_C = 100 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 300 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 500 \text{ mA}; V_{CE} = 1 \text{ V}$

Transition frequency at $f = 35 \text{ MHz}$

$I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

h_{FE} 100 to 600

$h_{FE} > 70$

$h_{FE} > 40$

f_T typ. 200 MHz

C_c typ. 5 pF

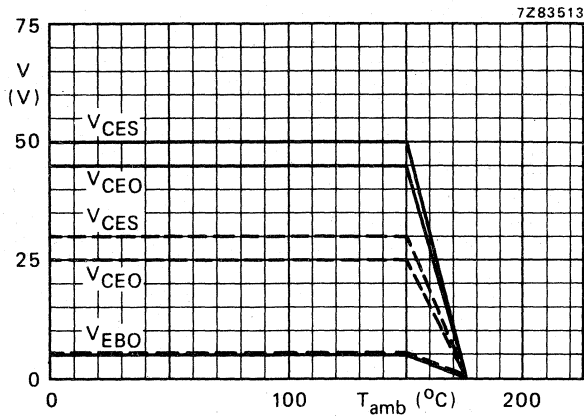


Fig. 2 Voltage derating curves. --- BCX19; R/BCX20; R ———

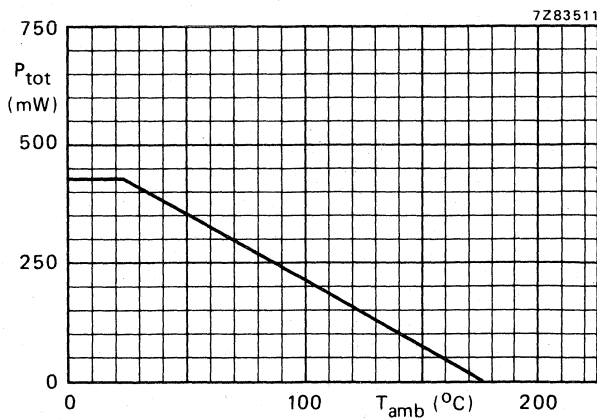


Fig. 3 Power derating curve.

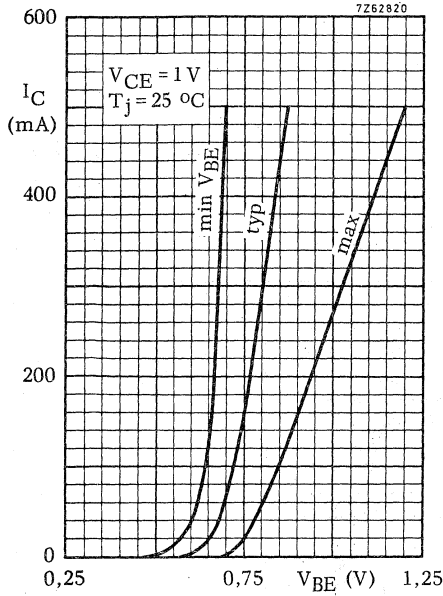


Fig. 4.

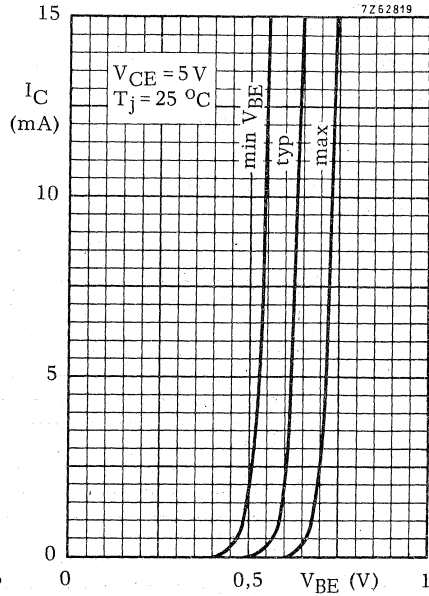


Fig. 5.

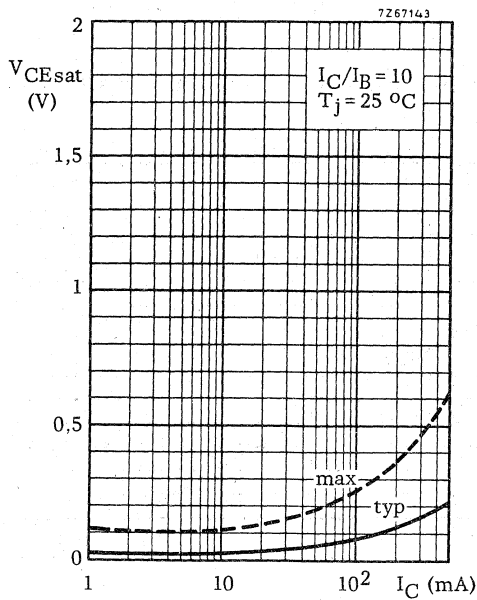


Fig. 6.

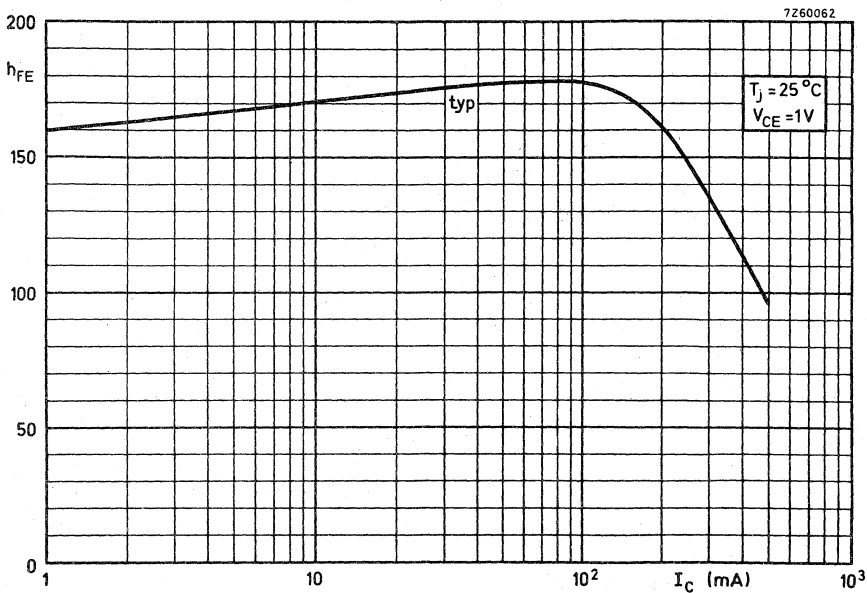


Fig. 7.

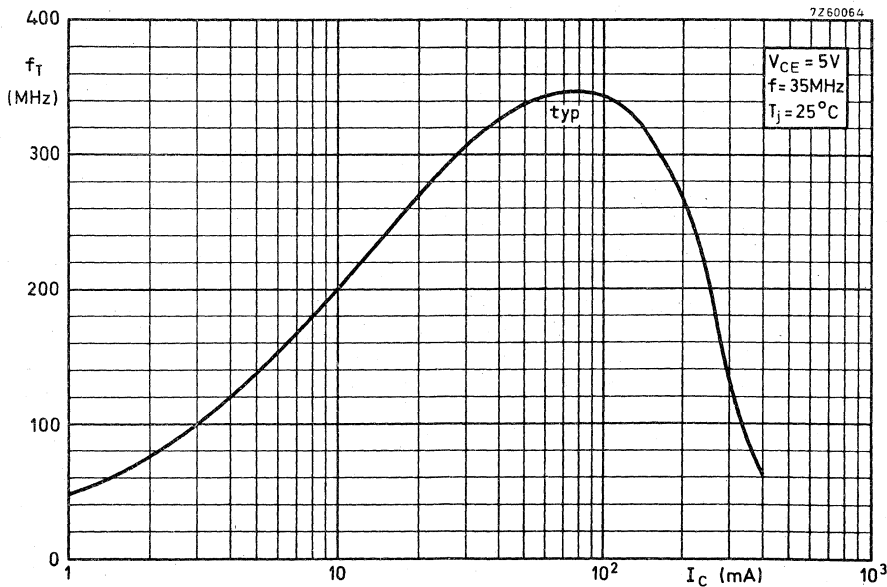


Fig. 8.

SILICON PLANAR EPITAXIAL TRANSISTORS

Medium power p-n-p transistors in a miniature plastic envelope intended for applications in thick and thin-film circuits. These transistors are intended for general purposes as well as for use in driver stages of audio amplifiers.

N-P-N complements are BCX54, BCX55 and BCX56 respectively.

QUICK REFERENCE DATA

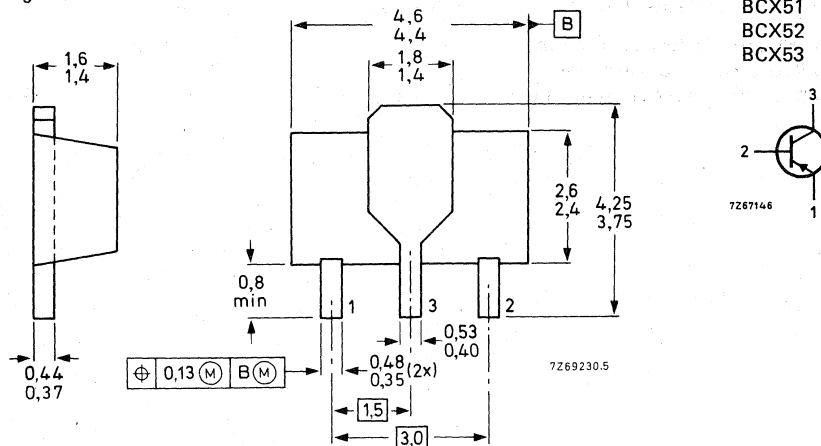
| | | BCX51 | BCX52 | BCX53 |
|---|-----------------|---------------|-----------|----------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 45 | 60 | 100 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 45 | 60 | 80 V |
| Collector-emitter voltage ($R_{BE} = 1 \text{ k}\Omega$) | $-V_{CER}$ max. | 45 | 60 | 100 V |
| Collector current (peak value) | $-I_{CM}$ max. | 1,5 | 1,5 | 1,5 A |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ | P_{tot} max. | 1 | 1 | 1 W |
| Junction temperature | T_j max. | 150 | 150 | 150 $^\circ\text{C}$ |
| D.C. current gain | h_{FE} | > 40 < 250 | 40 160 | 40 160 |
| Transition frequency at $f = 35 \text{ MHz}$ | f_T typ. | 50 | 50 | 50 MHz |

MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.



See also *Soldering recommendations*.

RATINGS Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

| | | BCX51 | BCX52 | BCX53 | |
|--|------------|---------|-------|-------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. 45 | 60 | 100 | V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. 45 | 60 | 80 | V |
| Collector-emitter voltage ($R_{BE} = 1 \text{ k}\Omega$) | $-V_{CER}$ | max. 45 | 60 | 100 | V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. 5 | 5 | 5 | V |

Currents

| | | | | |
|--------------------------------|-----------|------|-----|---|
| Collector current (d. c.) | $-I_C$ | max. | 1,0 | A |
| Collector current (peak value) | $-I_{CM}$ | max. | 1,5 | A |
| Base current (d. c.) | $-I_B$ | max. | 0,1 | A |
| Base current (peak value) | $-I_{BM}$ | max. | 0,2 | A |

Power dissipation

Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$
 mounted on a ceramic substrate
 area = $2,5 \text{ cm}^2$; thickness = $0,7 \text{ mm}$

| | | | |
|-----------|------|-----|---|
| P_{tot} | max. | 1,0 | W |
|-----------|------|-----|---|

Temperatures

| | | | |
|----------------------|-----------|-------------|------------------|
| Storage temperature | T_{stg} | -65 to +150 | $^\circ\text{C}$ |
| Junction temperature | T_j | max. 150 | $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | |
|--|-----------------|-----|--------------------|
| From junction to collector tab | $R_{thj-tab} =$ | 10 | $^\circ\text{C/W}$ |
| From junction to ambient in free air mounted on a ceramic substrate area = $2,5 \text{ cm}^2$; thickness = $0,7 \text{ mm}$ | $R_{thj-a} =$ | 125 | $^\circ\text{C/W}$ |



CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 30\text{ V}$ $-I_{CBO} < 100$ nA

$I_E = 0; -V_{CB} = 30\text{ V}; T_j = 125\text{ }^{\circ}\text{C}$ $-I_{CBO} < 10$ μA

Emitter cut-off current

$I_C = 0; -V_{EB} = 5\text{ V}$ $-I_{EBO} < 10$ μA

Base-emitter voltage

$-I_C = 500\text{ mA}; -V_{CE} = 2\text{ V}$ $-V_{BE} < 1$ V

Saturation voltage

$-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$ $-V_{CEsat} < 0,5$ V

D.C. current gain

$-I_C = 5\text{ mA}; -V_{CE} = 2\text{ V}$ $h_{FE} > 25$ BCX51 BCX52 BCX53

$-I_C = 150\text{ mA}; -V_{CE} = 2\text{ V}$ $h_{FE} > 40$ 40 40

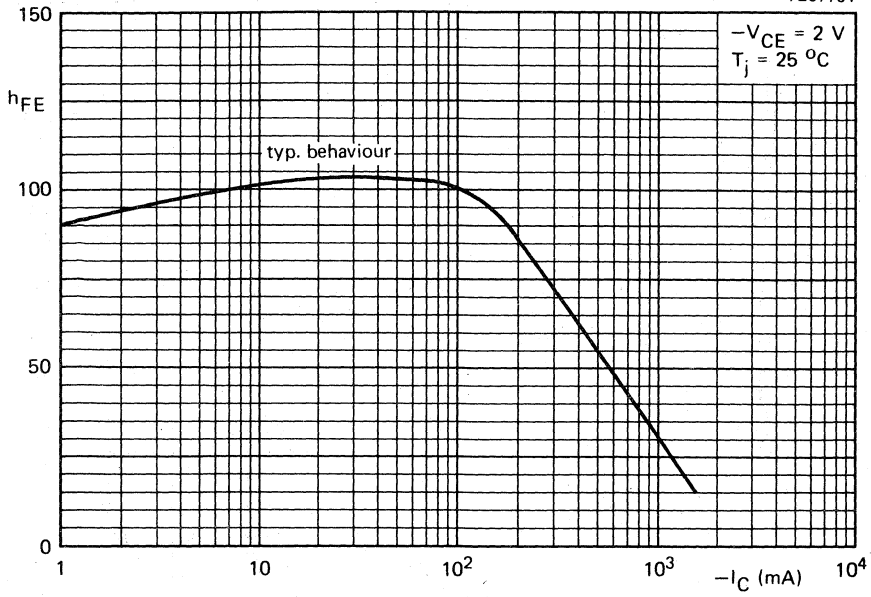
$-I_C = 500\text{ mA}; -V_{CE} = 2\text{ V}$ $h_{FE} < 250$ 160 160

Transition frequency at $f = 35\text{ MHz}$

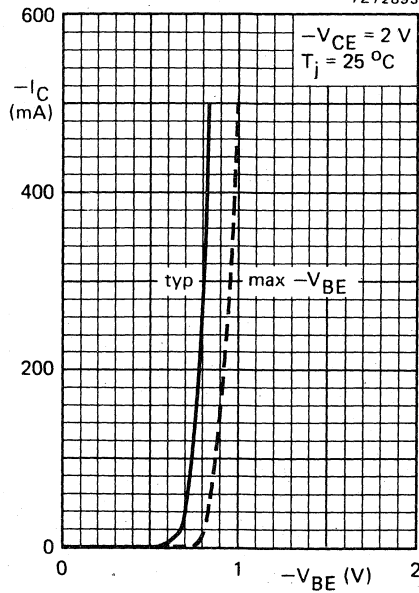
$-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V}$ f_T typ. 50 MHz

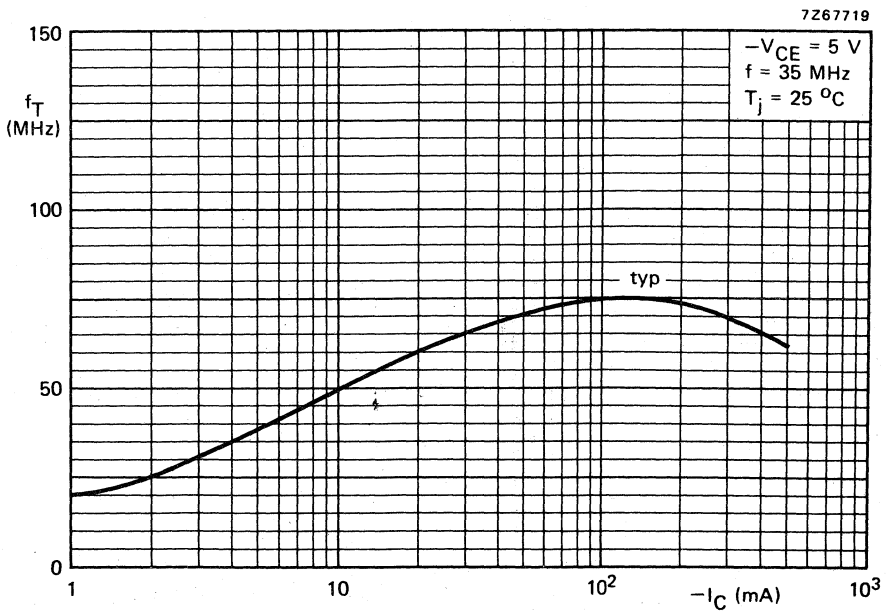
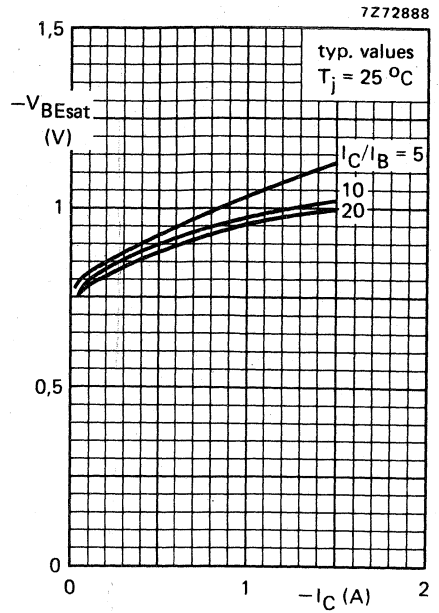
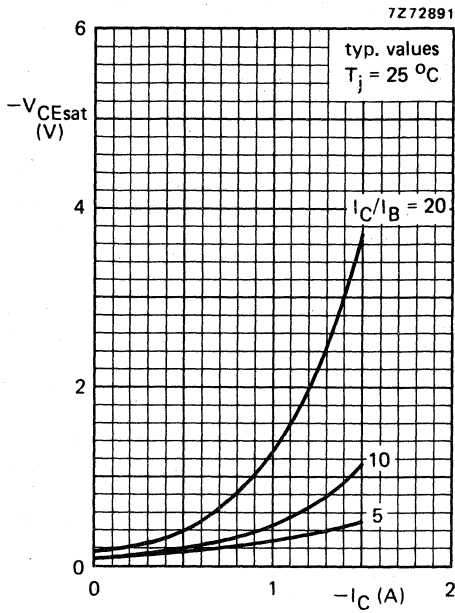


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SILICON PLANAR EPITAXIAL TRANSISTORS

Medium power n-p-n transistors in a miniature plastic envelope intended for applications in thick and thin-film circuits. These transistors are intended for general purposes as well as for use in driver stages of audio amplifiers.

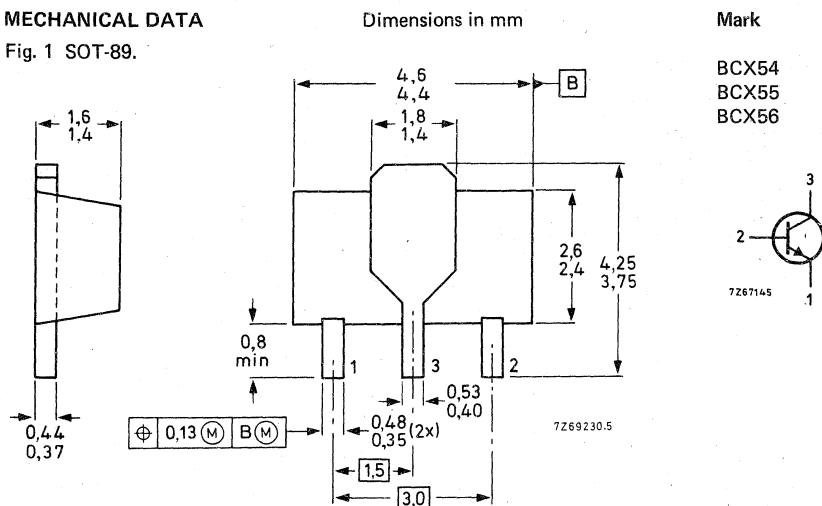
P-N-P complements are BCX51, BCX52 and BCX53 respectively.

QUICK REFERENCE DATA

| | | BCX54 | BCX55 | BCX56 |
|---|----------------|--|-----------|----------------------|
| Collector-base voltage (open emitter) | V_{CBO} max. | 45 | 60 | 100 V |
| Collector-emitter voltage (open base) | V_{CEO} max. | 45 | 60 | 80 V |
| Collector-emitter voltage ($R_{BE} = 1 \text{ k}\Omega$) | V_{CER} max. | 45 | 60 | 100 V |
| Collector current (peak value) | I_{CM} max. | 1,5 | 1,5 | 1,5 A |
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ | P_{tot} max. | 1 | 1 | 1 W |
| Junction temperature | T_j max. | 150 | 150 | 150 $^\circ\text{C}$ |
| D.C. current gain | h_{FE} | > 40 < 250 | 40 160 | 40 160 |
| Transition frequency at $f = 35 \text{ MHz}$ | f_T typ. | 130 | 130 | 130 MHz |
| | | $I_C = 150 \text{ mA}; V_{CE} = 2 \text{ V}$ | | |
| | | $I_C = 10 \text{ mA}; V_{CE} = 5 \text{ V}$ | | |

MECHANICAL DATA

Fig. 1 SOT-89.



See also *Soldering recommendations*.

RATINGS Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

| | | | BCX54 | BCX55 | BCX56 | |
|---|-----------|------|-------|-------|-------|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 45 | 60 | 100 | V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 | 60 | 80 | V |
| Collector-emitter voltage ($R_{BE} = 1\text{ k}\Omega$) | V_{CER} | max. | 45 | 60 | 100 | V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 5 | 5 | 5 | V |

Currents

| | | | | | | |
|--------------------------------|----------|------|--|-----|--|---|
| Collector current (d.c.) | I_C | max. | | 1,0 | | A |
| Collector current (peak value) | I_{CM} | max. | | 1,5 | | A |
| Base current (d.c.) | I_B | max. | | 0,1 | | A |
| Base current (peak value) | I_{BM} | max. | | 0,2 | | A |

Power dissipation

Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$
 mounted on a ceramic substrate
 area = 2,5 cm²; thickness = 0,7 mm

| | | | | | |
|-----------|------|--|-----|--|---|
| P_{tot} | max. | | 1,0 | | W |
|-----------|------|--|-----|--|---|

Temperatures

| | | | | | |
|----------------------|-----------|------|-------------|--|------------------|
| Storage temperature | T_{stg} | | -65 to +150 | | $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 150 | | $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | | | | |
|---|-----------------|---|--|-----|--|--------------------|
| From junction to collector tab | $R_{th\ j-tab}$ | = | | 10 | | $^\circ\text{C/W}$ |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | $R_{th\ j-a}$ | = | | 125 | | $^\circ\text{C/W}$ |



CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 30\text{ V}$

$I_{CBO} < 100\text{ nA}$

$I_E = 0; V_{CB} = 30\text{ V}; T_j = 125\text{ }^{\circ}\text{C}$

$I_{CBO} < 10\text{ }\mu\text{A}$

Emitter cut-off current

$I_C = 0; V_{EB} = 5\text{ V}$

$I_{EBO} < 10\text{ }\mu\text{A}$

Base-emitter voltage

$I_C = 500\text{ mA}; V_{CE} = 2\text{ V}$

$V_{BE} < 1\text{ V}$

Saturation voltage

$I_C = 500\text{ mA}; I_B = 50\text{ mA}$

$V_{CEsat} < 0,5\text{ V}$

D.C. current gain

$I_C = 5\text{ mA}; V_{CE} = 2\text{ V}$

| | BCX54 | BCX55 | BCX56 |
|------------|-------|-------|-------|
| $h_{FE} >$ | 25 | 25 | 25 |
| $h_{FE} >$ | 40 | 40 | 40 |
| $h_{FE} <$ | 250 | 160 | 160 |
| $h_{FE} >$ | 25 | 25 | 25 |

$I_C = 150\text{ mA}; V_{CE} = 2\text{ V}$

$h_{FE} >$ 40

$I_C = 500\text{ mA}; V_{CE} = 2\text{ V}$

$h_{FE} >$ 25

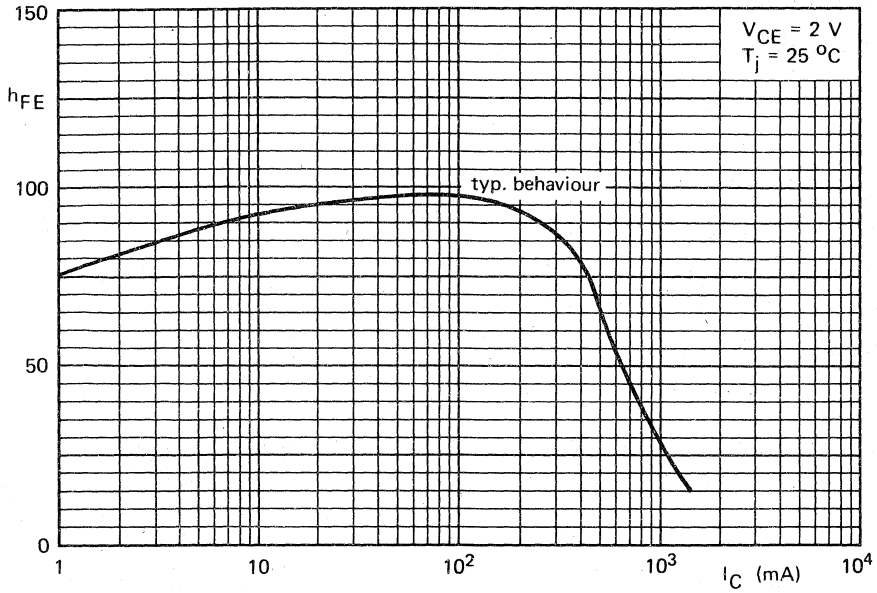
Transition frequency at $f = 35\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

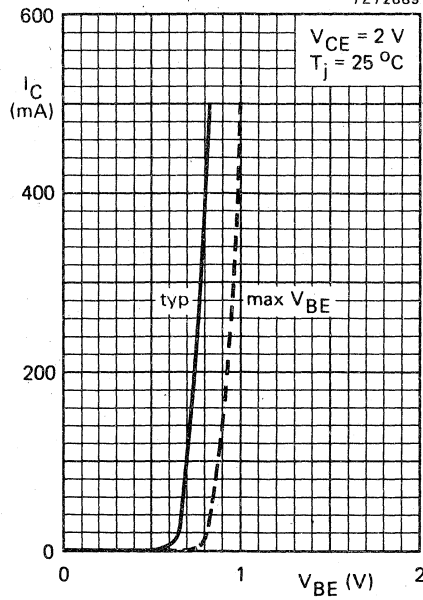
f_T typ. 130 MHz

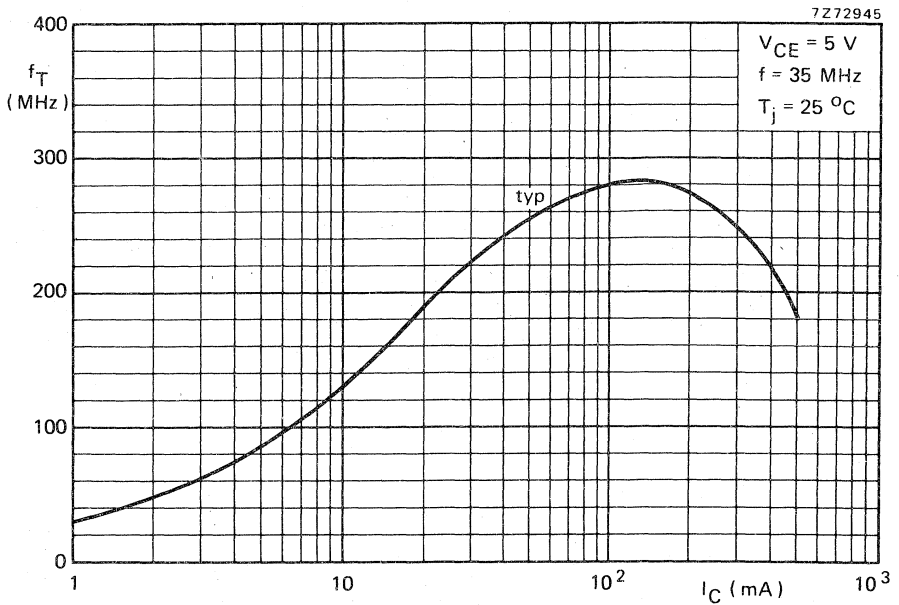
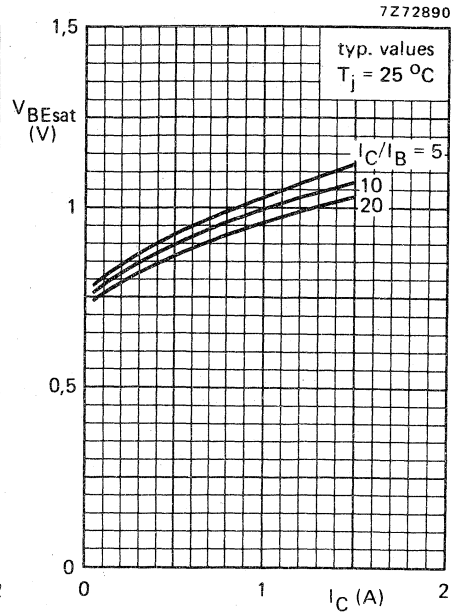
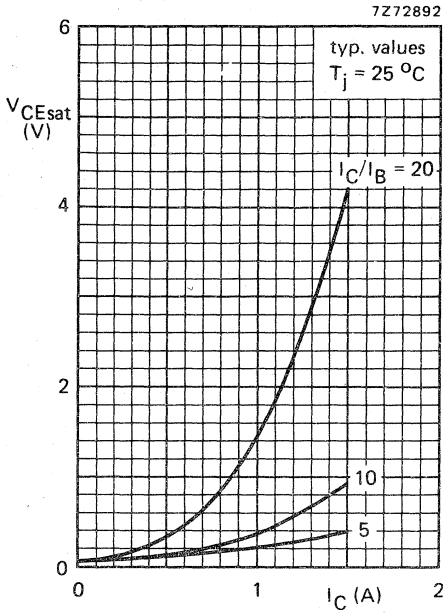


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7Z72889





SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency, purpose applications in hybrid circuits.

QUICK REFERENCE DATA

| | | | |
|---|-----------|------|---------|
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} | max. | 45 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 V |
| Collector current (d.c.) | I_C | max. | 200 mA |
| Total power dissipation | P_{tot} | max. | 150 mW |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 100$ MHz $V_{CE} = 5$ V; $I_C = 10$ mA | f_T | typ. | 250 MHz |
| Noise figure at $f = 1$ kHz $V_{CE} = 5$ V; $I_C = 200 \mu A$; $B = 200$ Hz | F | typ. | 2 dB |

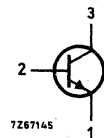
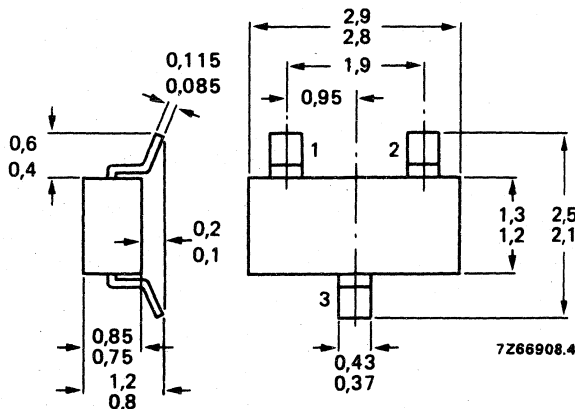
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BCX70G = AG
BCX70H = AH
BCX70J = AJ
BCX70K = AK



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|-----------------|
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} | max. | 45 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 45 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 200 mA |
| Base current | I_B | max. | 50 mA |
| Total power dissipation** | P_{tot} | max. | 150 mW |
| Storage temperature | T_{stg} | | -55 to + 125 °C |
| Junction temperature | T_j | max. | 150 °C |

THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ °C}$ unless otherwise specified

Collector-emitter cut-off current

$$V_{BE} = 0; V_{CE} = 45\text{ V}$$

$$I_{CES} < 20\text{ nA}$$

$$V_{BE} = 0; V_{CE} = 45\text{ V}; T_{amb} = 150\text{ °C}$$

$$I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; V_{EB} = 4\text{ V}$$

$$I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$\text{at } I_C = 10\text{ mA}; I_B = 0,25\text{ mA}$$

$$V_{CEsat} \quad 0,05\text{ to }0,35\text{ V}$$

$$V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$V_{CEsat} \quad 0,1\text{ to }0,55\text{ V}$$

$$V_{BEsat} \quad 0,7\text{ to }1,05\text{ V}$$

$$\text{at } I_C = 50\text{ mA}; I_B = 1,25\text{ mA}$$

Transition frequency at $f = 100\text{ MHz}$ ▲

$$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T > 125\text{ MHz}$$

$$\text{typ. } 250\text{ MHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c < 4,5\text{ pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 8\text{ pF}$$

Noise figure at $R_S = 2\text{ k}\Omega$

$$I_C = 200\text{ }\mu\text{A}; V_{CE} = 5\text{ V}; f = 1\text{ kHz}; B = 200\text{ Hz}$$

$$F \text{ typ. } 2\text{ dB}$$

$$< 6\text{ dB}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

▲ Measured under pulse conditions.

| | | G | H | J | K |
|--|----------------------|--------------|-----|-----|----------------------|
| D.C. current gain $V_{CE} = 5\text{ V}; I_C = 10\ \mu\text{A}$ | h _{FE} typ. | 78 | 145 | 220 | 300 |
| | > | — | 20 | 40 | 100 |
| $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}$ | > | 120 | 180 | 250 | 380 |
| | h _{FE} typ. | 170 | 250 | 350 | 500 |
| $V_{CE} = 1\text{ V}; I_C = 50\text{ mA}$ | < | 220 | 310 | 460 | 630 |
| | h _{FE} > | 50 | 70 | 90 | 100 |
| Input impedance $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$ | > | 1,6 | 2,5 | 3,2 | 4,5 k Ω |
| | h _{ie} typ. | 2,7 | 3,6 | 4,5 | 7,5 k Ω |
| Reverse voltage transfer ratio $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$ | < | 4,5 | 6,0 | 8,5 | 12,0 k Ω |
| | h _{re} typ. | 1,5 | 2 | 2 | 3 · 10 ⁻⁴ |
| Small-signal current gain $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$ | > | 125 | 175 | 250 | 350 |
| | h _{fe} typ. | 200 | 260 | 330 | 520 |
| Output admittance $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}; f = 1\text{ kHz}$ | < | 250 | 350 | 500 | 700 |
| | h _{oe} typ. | 18 | 24 | 30 | 50 $\mu\text{A/V}$ |
| Base-emitter voltage $V_{CE} = 5\text{ V}; I_C = 2\text{ mA}$ | < | 30 | 50 | 60 | 100 $\mu\text{A/V}$ |
| | V _{BE} typ. | 0,55 to 0,75 | | | V |
| $V_{CE} = 5\text{ V}; I_C = 10\ \mu\text{A}$ | V _{BE} typ. | 0,65 | | | V |
| | V _{BE} typ. | 0,52 | | | V |
| $V_{CE} = 1\text{ V}; I_C = 50\text{ mA}$ | V _{BE} typ. | 0,78 | | | V |

Switching times

$I_{Con} = 10 \text{ mA}$; $I_{Bon} = -I_{Boff} = 1 \text{ mA}$
 $V_{CC} = 10 \text{ V}$; $R_L = 990 \Omega$

turn-on time ($t_d + t_r$)

t_{on} typ. 85 ns
 < 150 ns

turn-off time ($t_s + t_f$)

t_{off} typ. 480 ns
 < 800 ns

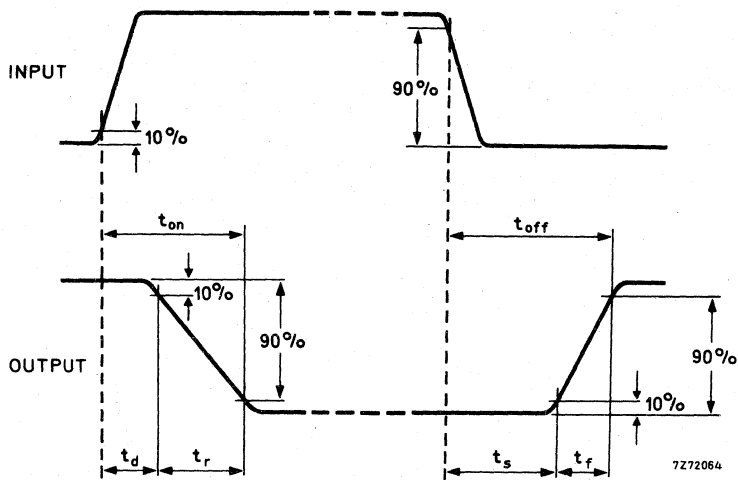


Fig. 2 Switching waveforms.



SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P silicon transistors, in a microminiature plastic envelope, intended for low level, low noise, low frequency purpose applications in hybrid circuits.

QUICK REFERENCE DATA

| | | | |
|--|------------|------|---------|
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 45 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 45 V |
| Collector current (d.c.) | $-I_C$ | max. | 200 mA |
| Total power dissipation | P_{tot} | max. | 150 mW |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 100$ MHz $-V_{CE} = 5$ V; $-I_C = 10$ mA | f_T | typ. | 180 MHz |
| Noise figure at $f = 1$ kHz $-V_{CE} = 5$ V; $-I_C = 200$ μ A | F | typ. | 2 dB |

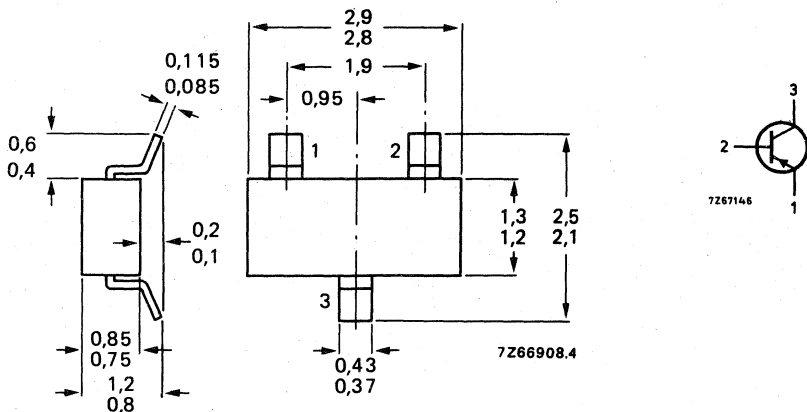
MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BCX71G = BG
BCX71H = BH
BCX71J = BJ
BCX71K = BK



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|------------|------|-----------------|
| Collector-emitter voltage ($V_{BE} = 0$) | $-V_{CES}$ | max. | 45 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 45 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 5 V |
| Collector current (d.c.) | $-I_C$ | max. | 200 mA |
| Base current | $-I_B$ | max. | 50 mA |
| Total power dissipation** | P_{tot} | max. | 150 mW |
| Storage temperature | T_{stg} | | -55 to + 125 °C |
| Junction temperature | T_j | max. | 150 °C |

THERMAL CHARACTERISTICS*

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25$ °C unless otherwise specified

Collector-emitter cut-off current

$$V_{EB} = 0; -V_{CE} = 45\text{ V} \quad -I_{CES} < 20\text{ nA}$$

$$V_{EB} = 0; -V_{CE} = 45\text{ V}; T_{amb} = 150\text{ °C} \quad -I_{CES} < 20\text{ }\mu\text{A}$$

Emitter-base cut-off current

$$I_C = 0; -V_{EB} = 4\text{ V} \quad -I_{EBO} < 20\text{ nA}$$

Saturation voltages

$$-I_C = 10\text{ mA}; -I_B = 0,25\text{ mA} \quad -V_{CEsat} \quad 0,06\text{ to }0,25\text{ V}$$

$$-I_C = 50\text{ mA}; -I_B = 1,25\text{ mA} \quad -V_{BEsat} \quad 0,6\text{ to }0,85\text{ V}$$

$$-V_{CEsat} \quad 0,12\text{ to }0,55\text{ V}$$

$$-V_{BEsat} \quad 0,68\text{ to }1,05\text{ V}$$

Transition frequency at $f = 100$ MHz Δ

$$-V_{CE} = 5\text{ V}; -I_C = 10\text{ mA} \quad f_T \quad \text{typ.} \quad 180\text{ MHz}$$

Collector capacitance at $f = 1$ MHz

$$-V_{CB} = 10\text{ V}; I_E = I_e = 0 \quad C_c < 6\text{ pF}$$

Emitter capacitance at $f = 1$ MHz

$$-V_{EB} = 0,5\text{ V}; I_C = I_c = 0 \quad C_e \quad \text{typ.} \quad 11\text{ pF}$$

Noise figure at $R_S = 2$ k Ω

$$-V_{CE} = 5\text{ V}; -I_C = 200\text{ }\mu\text{A}; B = 200\text{ Hz} \quad F \quad \text{typ.} \quad 2\text{ dB}$$

$$< 6\text{ dB}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Δ Measured under pulse conditions.

| | | A | B | C | D |
|---|---------------|-------------|-----|-----|---------------------|
| D.C. current gain $-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$ | h_{FE} typ. | 140 | 200 | 270 | 340 |
| | > | — | 30 | 40 | 100 |
| $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$ | > | 120 | 180 | 250 | 380 |
| | h_{FE} typ. | 170 | 250 | 350 | 500 |
| $-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$ | < | 220 | 310 | 460 | 630 |
| | h_{FE} > | 60 | 80 | 100 | 110 |
| Input impedance $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | > | 1,6 | 2,5 | 3,2 | 4,5 k Ω |
| | h_{ie} typ. | 2,7 | 3,6 | 4,5 | 7,5 k Ω |
| Reverse voltage transfer ratio $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | < | 4,5 | 6,0 | 8,5 | 12,0 k Ω |
| | h_{re} typ. | 1,5 | 2 | 2 | 3 10^{-4} |
| Small-signal current gain $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | > | 125 | 175 | 250 | 350 |
| | h_{fe} typ. | 200 | 260 | 330 | 520 |
| Output admittance $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}; f = 1 \text{ kHz}$ | < | 250 | 350 | 500 | 700 |
| | h_{oe} typ. | 18 | 24 | 30 | 50 $\mu\text{A/V}$ |
| Base-emitter voltage $-V_{CE} = 5 \text{ V}; -I_C = 2 \text{ mA}$ | < | 30 | 50 | 60 | 100 $\mu\text{A/V}$ |
| | V_{BE} typ. | 0,6 to 0,75 | | | V |
| $-V_{CE} = 5 \text{ V}; -I_C = 10 \mu\text{A}$ | V_{BE} typ. | 0,65 | | | V |
| | V_{BE} typ. | 0,55 | | | V |
| $-V_{CE} = 1 \text{ V}; -I_C = 50 \text{ mA}$ | V_{BE} typ. | 0,72 | | | V |

Switching times

- $I_{Con} = 10 \text{ mA}$; - $I_{Bon} = I_{Boff} = 1 \text{ mA}$
 - $V_{CC} = 10 \text{ V}$; $R_L = 990 \Omega$

turn-on time ($t_d + t_r$)

t_{on} typ. 85 ns
 < 150 ns

turn-off time ($t_s + t_f$)

t_{off} typ. 480 ns
 < 800 ns

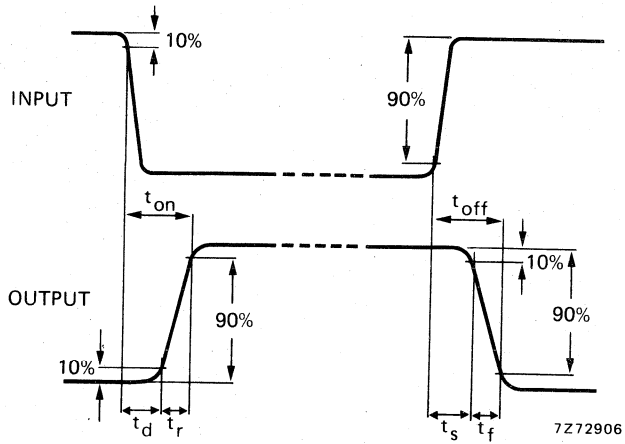


Fig. 2 Switching waveforms.



N-CHANNEL SILICON FIELD-EFFECT TRANSISTORS

Asymmetrical N-channel planar epitaxial junction field-effect transistors in the miniature plastic envelope intended for applications up to the v.h.f. range in hybrid thick and thin-film circuits. Special features are the low feedback capacitance and the low noise figure. These features make the product very suitable for applications such as the r.f. stages in f.m. portables (BF510), car radios (BF511) and mains radios (BF512) or the mixer stage (BF513).

QUICK REFERENCE DATA

| | | | | | | | |
|---|------------|------|-----|-------|-----|-----|------|
| Drain-source voltage | V_{DS} | max. | 20 | V | | | |
| Drain current (d.c. or average) | I_D | max. | 30 | mA | | | |
| Total power dissipation up to $T_{amb} = 40^\circ C$ | P_{tot} | max. | 300 | mW | | | |
| Drain current $V_{DS} = 10 V; V_{GS} = 0$ | I_{DSS} | | | BF510 | 511 | 512 | 513 |
| | | > | 0,7 | 2,5 | 6 | 10 | mA |
| | | < | 3,0 | 7,0 | 12 | 18 | mA |
| Transfer admittance (common source) $V_{DS} = 10 V; V_{GS} = 0; f = 1 \text{ kHz}$ | $ y_{fs} $ | > | 2,5 | 4 | 6 | 7 | mA/V |
| Feedback capacitance $V_{DS} = 10 V; V_{GS} = 0$ | C_{rs} | typ. | 0,3 | 0,3 | — | — | pF |
| $V_{DS} = 10 V; I_D = 5 \text{ mA}$ | C_{rs} | typ. | — | — | 0,3 | 0,3 | pF |
| Noise figure at optimum source admittance $G_S = 1 \text{ mA/V}; -B_S = 3 \text{ mA/V}; f = 100 \text{ MHz}$ | F | typ. | 1,5 | 1,5 | — | — | dB |
| $V_{DS} = 10 V; I_D = 5 \text{ mA}$ | F | typ. | — | — | 1,5 | 1,5 | dB |

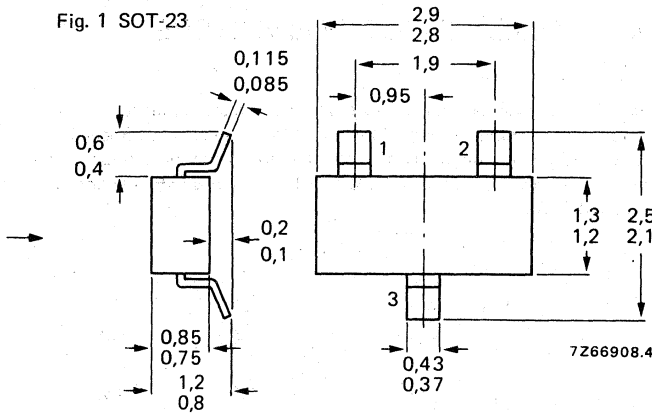
MECHANICAL DATA

SOT-23 (see page 2).

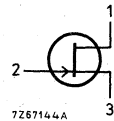
See also *Soldering recommendations*.

MECHANICAL DATA

Fig. 1 SOT-23



Dimensions in mm



Marking code

- BF510 = S6
- BF511 = S7
- BF512 = S8
- BF513 = S9

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|----------------|
| Drain-source voltage see Fig. 4 | V_{DS} | max. | 20 V |
| Drain-gate voltage (open source) see Fig. 4 | V_{DGO} | max. | 20 V |
| Drain current (d.c. or average) | I_D | max. | 30 mA |
| Gate current | $\pm I_G$ | max. | 10 mA |
| → Total power dissipation up to $T_{amb} = 40\text{ °C}^{**}$ | P_{tot} | max. | 300 mW |
| → Storage temperature | T_{stg} | | -65 to +175 °C |
| → Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th\ s-a}$ | = | 120 K/W |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

STATIC CHARACTERISTICS

 $T_{amb} = 25\text{ }^{\circ}\text{C}$

| | | | BF510 | 511 | 512 | 513 |
|--|----------------|------|-------|-----|-----|-------|
| Gate cut-off current $-V_{GS} = 0,2\text{ V}; V_{DS} = 0$ | $-I_{GSS}$ | < | 10 | 10 | 10 | 10 nA |
| Gate-drain breakdown voltage $I_S = 0; -I_D = 10\text{ }\mu\text{A}$ | $-V_{(BR)GDO}$ | > | 20 | 20 | 20 | 20 V |
| Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$ | I_{DSS} | > | 0,7 | 2,5 | 6 | 10 mA |
| | | < | 3,0 | 7,0 | 12 | 18 mA |
| Gate-source cut-off voltage $I_D = 10\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$ | $-V_{(P)GS}$ | typ. | 0,8 | 1,5 | 2,2 | 3 V |

DYNAMIC CHARACTERISTICS

Measuring conditions (common source): $V_{DS} = 10\text{ V}; V_{GS} = 0; T_{amb} = 25\text{ }^{\circ}\text{C}$ for BF510 and BF511
 $V_{DS} = 10\text{ V}; I_D = 5\text{ mA}; T_{amb} = 25\text{ }^{\circ}\text{C}$ for BF512 and BF513

y-parameters (common source)

DEVELOPMENT SAMPLE DATA

| | | | BF510 | 511 | 512 | 513 |
|---|------------|------|-------|-----|-----|---------------------|
| Input capacitance at $f = 1\text{ MHz}$ | C_{is} | < | 5 | 5 | 5 | 5 pF |
| Input conductance at $f = 100\text{ MHz}$ | g_{is} | typ. | 100 | 90 | 60 | 50 $\mu\text{A/V}$ |
| Feedback capacitance at $f = 1\text{ MHz}$ | C_{rs} | typ. | 0,3 | 0,3 | 0,3 | 0,3 pF |
| | | < | 0,4 | 0,4 | 0,4 | 0,4 pF |
| Transfer admittance at $f = 1\text{ kHz}$ $V_{GS} = 0$ instead of $I_D = 5\text{ mA}$ | $ y_{fs} $ | > | 2,5 | 4,0 | 4,0 | 3,5 mA/V |
| | | > | — | — | 6,0 | 7,0 mA/V |
| Transfer admittance at $f = 100\text{ MHz}$ | $ y_{fs} $ | typ. | 3,5 | 5,5 | 5,0 | 5,0 mA/V |
| Output capacitance at $f = 1\text{ MHz}$ | C_{os} | < | 3 | 3 | 3 | 3 pF |
| Output conductance at $f = 1\text{ MHz}$ | g_{os} | < | 60 | 80 | 100 | 120 $\mu\text{A/V}$ |
| Output conductance at $f = 100\text{ MHz}$ | g_{os} | typ. | 35 | 55 | 70 | 90 $\mu\text{A/V}$ |
| Noise figure at optimum source admittance $G_S = 1\text{ mA/V}; -B_S = 3\text{ mA/V};$ $f = 100\text{ MHz}$ | F | typ. | 1,5 | 1,5 | 1,5 | 1,5 dB |

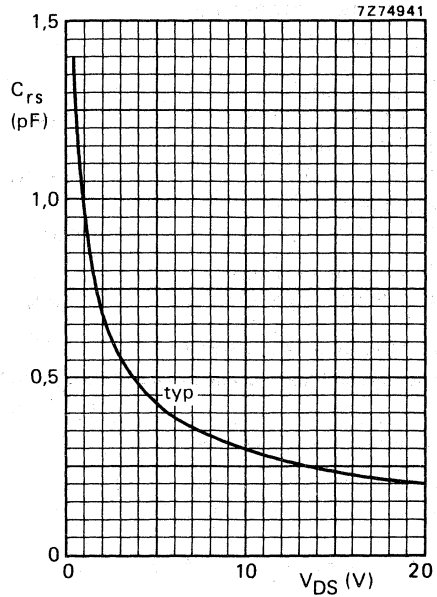


Fig. 2 $V_{GS} = 0$ for BF510 and BF511;
 $I_D = 5$ mA for BF512 and BF513;
 $f = 1$ MHz; $T_{amb} = 25$ °C.

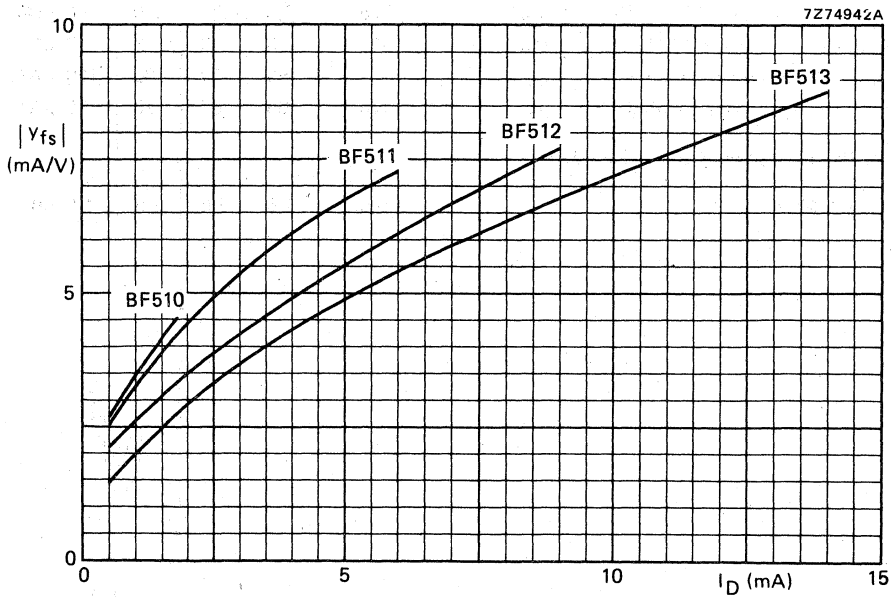


Fig. 3 $V_{DS} = 10$ V; $f = 1$ kHz; $T_{amb} = 25$ °C; typical values.

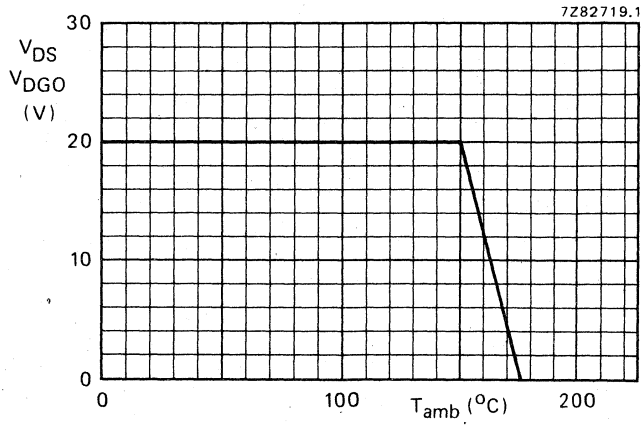


Fig. 4 Voltage derating curve.

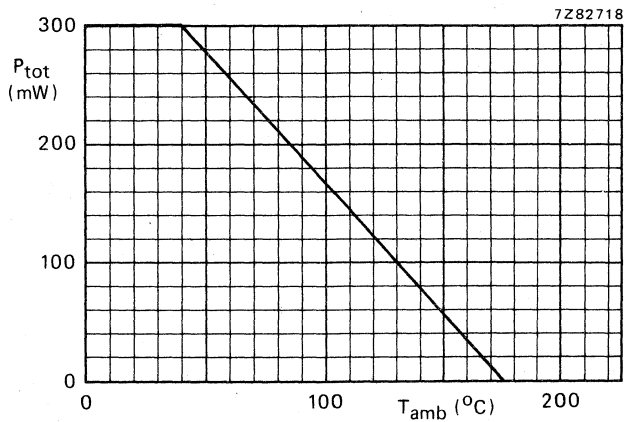


Fig. 5 Power derating curve.



SILICON PLANAR TRANSISTOR

P-N-P transistor in a microminiature plastic envelope. Primarily intended for use as mixer in v.h.f. tuners. Also suitable as r.f. amplifier and oscillator in f.m. tuners.

QUICK REFERENCE DATA

| | | | | |
|--|------------|------|----------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 30 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V | |
| Collector current (d.c.) | $-I_C$ | max. | 25 mA | |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} | max. | 200 mW | ← |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ | ← |
| D.C. current gain | h_{FE} | > | 25 | |
| Transition frequency at $f = 100\text{ MHz}$ | f_T | typ. | 350 MHz | |
| Noise figure at $f = 200\text{ MHz}$ | F | typ. | 5 dB | |

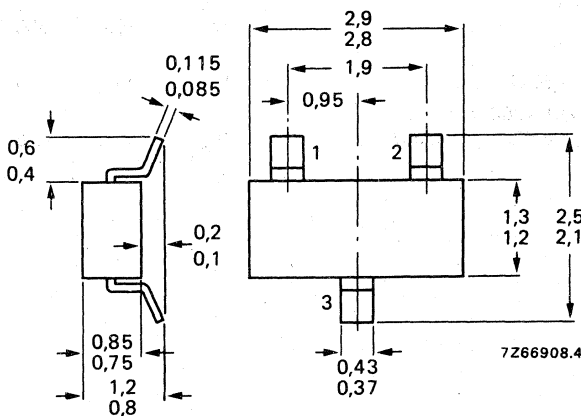
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BF536 = G3



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|-------------------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 30 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 4 V |
| Collector current (d.c.) | $-I_C$ | max. | 25 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to + 150 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$; unless otherwise specified

Collector cut-off current

| | | | |
|----------------------------------|------------|---|-------|
| $I_E = 0; -V_{CB} = 20\text{ V}$ | $-I_{CBO}$ | < | 50 nA |
|----------------------------------|------------|---|-------|

D.C. current gain

| | | | |
|--|----------|---|----|
| $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$ | h_{FE} | > | 25 |
|--|----------|---|----|

Transition frequency at $f = 100\text{ MHz}$

| | | | |
|--|-------|------|---------|
| $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 350 MHz |
|--|-------|------|---------|

Noise figure at $f = 200\text{ MHz}$

| | | | |
|--|---|------|------|
| $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 50\ \Omega$ | F | typ. | 5 dB |
|--|---|------|------|

Transducer gain (common base) at $f = 200\text{ MHz}$

| | | | |
|---|----------|------|---------|
| $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 920\ \Omega$ | G_{tr} | typ. | 17,5 dB |
|---|----------|------|---------|

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

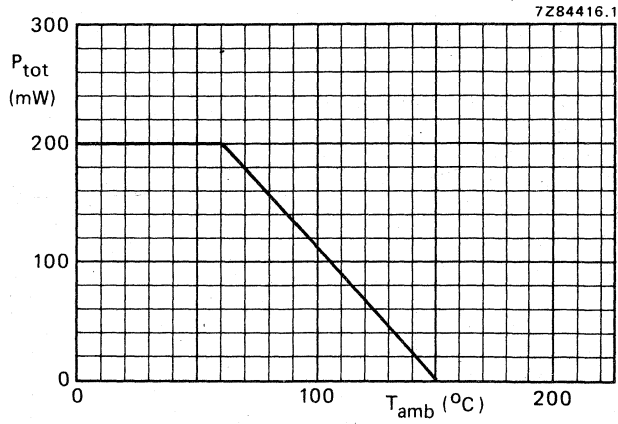


Fig. 2 Power derating curve.



SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor, in a microminiature plastic envelope, intended for applications in thick and thin-film circuits. This transistor is primarily intended for use in i.f. detection applications.

QUICK REFERENCE DATA

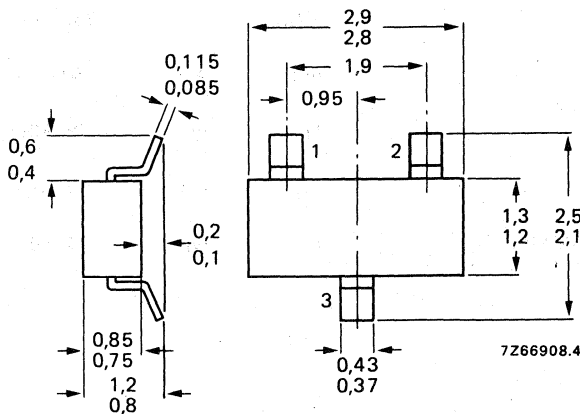
| | | | | |
|--|------------|------|----------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 40 V | |
| Collector current (d.c.) | $-I_C$ | max. | 25 mA | |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} | max. | 200 mW | ← |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ | |
| D.C. current gain at $T_j = 25\text{ }^\circ\text{C}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | h_{FE} | > | 50 | |
| Transition frequency at $f = 100\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | f_T | typ. | 325 MHz | |
| Noise figure at $R_S = 300\text{ }\Omega$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}; f = 100\text{ kHz}$ | F | typ. | 2 dB | |

MECHANICAL DATA

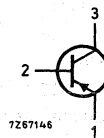
Dimensions in mm

Marking code

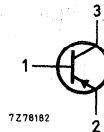
Fig. 1 SOT-23



BF550 = G2



BF550R = G5



See also *Soldering Recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|----------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 40 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 4 V |
| Collector current (d.c.) | $-I_C$ | max. | 25 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ °C}$ ** | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -55 to +150 °C |
| Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ °C}$ unless otherwise specified

| | | | |
|--|------------|------|-------------|
| Collector cut-off current $I_E = 0; -V_{CB} = 30\text{ V}$ | $-I_{CBO}$ | < | 50 nA |
| Emitter cut-off current $I_C = 0; -V_{EB} = 3\text{ V}$ | $-I_{EBO}$ | < | 100 μ A |
| Base-emitter voltage $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | $-V_{BE}$ | typ. | 750 mV |
| D.C. current gain $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | h_{FE} | > | 50 |
| Transition frequency at $f = 100\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | f_T | typ. | 325 MHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}$ | C_{re} | typ. | 0,5 pF |
| Noise figure at $R_S = 300\ \Omega$ $-I_C = 1\text{ mA}; -V_{CE} = 10\text{ V}; f = 100\text{ kHz}$ | F | typ. | 2 dB |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

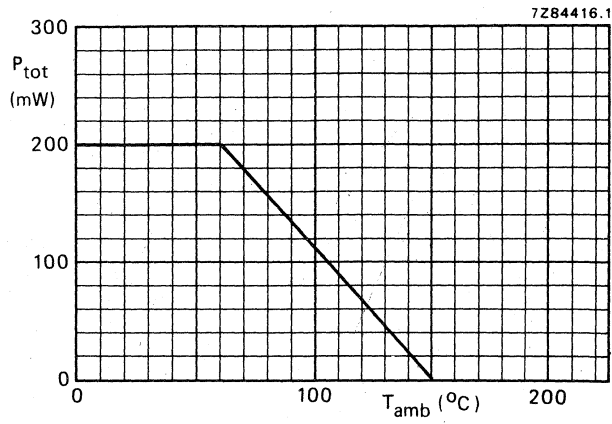


Fig. 2 Power derating curve.

SILICON PLANAR EPITAXIAL TRANSISTOR

P-N-P transistor in a microminiature plastic envelope, intended for applications in thick and thin-film circuits such as self-oscillating mixer in u.h.f. tuners in conjunction with bipolar transistors or with MOS fets.

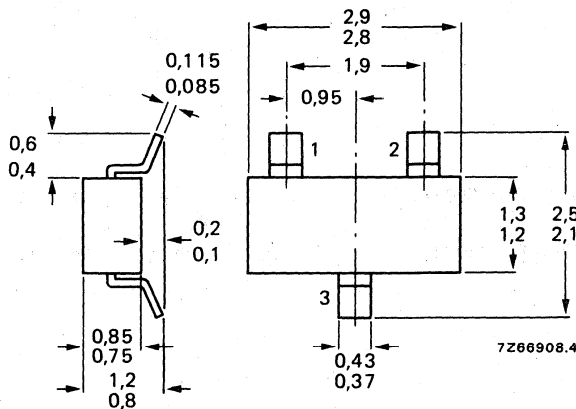
QUICK REFERENCE DATA

| | | | |
|--|------------|------|----------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 35 V |
| Collector current (d.c.) | $-I_C$ | max. | 30 mA |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} | max. | 200 mW |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 100\text{ MHz}$ $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 900 MHz |

MECHANICAL DATA

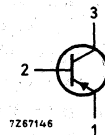
Dimensions in mm

Fig. 1 SOT-23



Marking code

BF569 = G6



See also Soldering Recommendations.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|----------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 35 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 3 V |
| Collector current (d.c.) | $-I_C$ | max. | 30 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to +150 °C |
| Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Collector cut-off current

$$I_E = 0; -V_{CB} = 20\text{ V}$$

$$-I_{CBO} < 100\text{ nA}$$

D.C. current gain

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$$

$$h_{FE} > 25$$

typ. 50

Transition frequency at $f = 100\text{ MHz}$

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$$

$$f_T \text{ typ. } 900\text{ MHz}$$

Feedback capacitance at $f = 1\text{ MHz}$

$$I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$$

$$C_{re} \text{ typ. } 0,33\text{ pF}$$

Noise figure at $f = 800\text{ MHz}$

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 500\ \Omega$$

$$F \text{ typ. } 4,5\text{ dB}$$

Power gain at $f = 800\text{ MHz}$

$$I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; R_S = 60\ \Omega; R_L = 500\ \Omega$$

$$G_{pb} \text{ typ. } 14,5\text{ dB}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

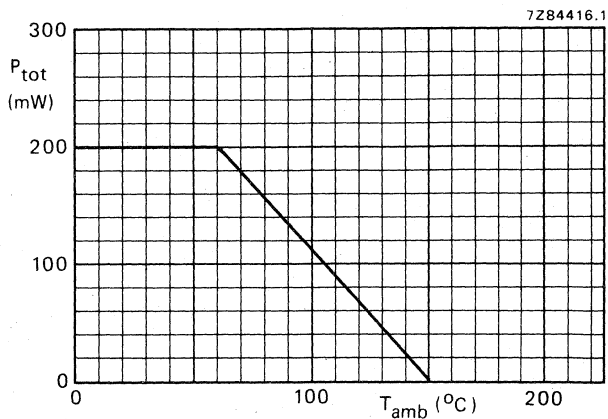


Fig. 2 Power derating curve.

SILICON PLANAR TRANSISTOR

P-N-P transistor in a microminiature envelope primarily intended for u.h.f. applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|---|------------|------|----------------------|---|
| Collector-base voltage (open emitter) | $-V_{CB0}$ | max. | 20 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 20 V | |
| Collector current | $-I_C$ | max. | 25 mA | |
| Total power dissipation up to $T_{amb} = 85\text{ }^\circ\text{C}$ | P_{tot} | max. | 150 mW | ← |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ | ← |
| Transition frequency at $f = 100\text{ MHz}$ $I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 1350 MHz | |
| Transducer gain (common base) $I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega; T_{amb} = 25\text{ }^\circ\text{C}$ | G_{tr} | typ. | 16 dB | |
| Noise figure (common base) $I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega$ | F | typ. | 4,5 dB | |

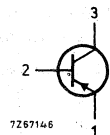
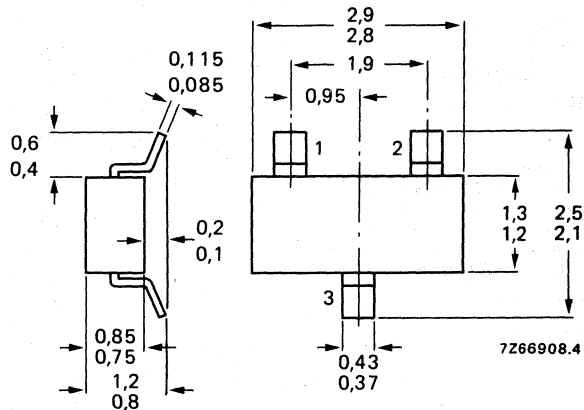
MECHANICAL DATA

Fig. 1 SOT-23.

Dimensions in mm

Marking code

BF579 = G7



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|-----------------|
| Collector-base voltage (open emitter) see Fig. 2 | $-V_{CBO}$ | max. | 20 V |
| Collector-emitter voltage (open base) see Fig. 2 | $-V_{CEO}$ | max. | 20 V |
| Emitter-base voltage (open collector) see Fig. 2 | $-V_{EBO}$ | max. | 3 V |
| Collector current | $-I_C$ | max. | 25 mA |
| Base current (d.c.) | $-I_B$ | max. | 10 mA |
| → Total power dissipation up to $T_{amb} = 85\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 150 mW |
| → Storage temperature | T_{stg} | | -65 to + 150 °C |
| → Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$

Collector cut-off current

$$I_E = 0; -V_{CB} = 15\text{ V} \quad -I_{CBO} < 100\text{ nA}$$

Emitter cut-off current

$$I_C = 0; -V_{EB} = 1\text{ V} \quad -I_{EBO} < 100\text{ nA}$$

D.C. current gain

$$I_C = 10\text{ mA}; -V_{CE} = 10\text{ V} \quad h_{FE} > 20$$

Transition frequency at $f = 100\text{ MHz}$

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V} \quad f_T \text{ typ. } 1350\text{ MHz}$$

Feedback capacitance at $f = 500\text{ kHz}$

$$I_E = 7\text{ mA}; -V_{CB} = 10\text{ V} \quad C_{re} \text{ typ. } 0,46\text{ pF}$$

$$I_E = 0; -V_{CB} = 10\text{ V} \quad C_{rb} \text{ typ. } 160\text{ fF}$$

Transducer gain (common base)

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz} \\ R_S = 60\text{ } \Omega; R_L = 500\text{ } \Omega \quad G_{tr} \text{ typ. } 16\text{ dB}$$

Noise figure (common base)

$$I_E = 10\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz} \\ R_S = 60\text{ } \Omega; R_L = 500\text{ } \Omega \quad F \text{ typ. } 4,5\text{ dB}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

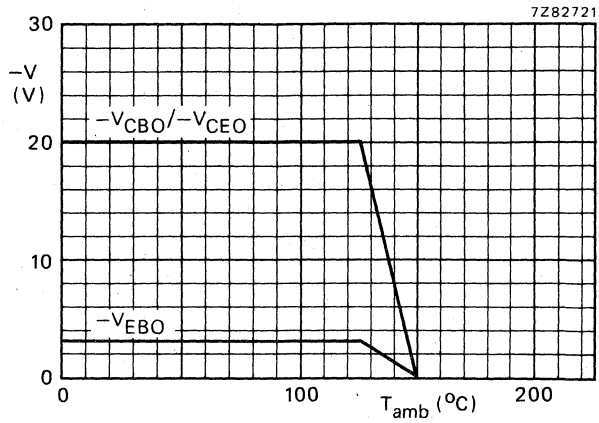


Fig. 2 Voltage derating curves.

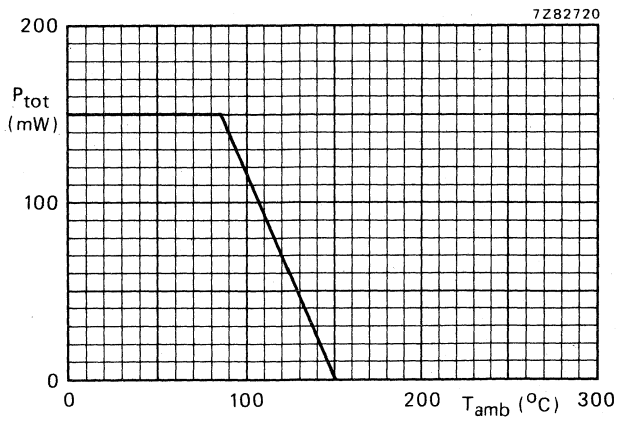


Fig. 3 Power derating curve.

SILICON EPITAXIAL TRANSISTOR

- for video output stages

N-P-N transistor in a miniature plastic envelope intended for application in thick and thin-film circuits. This device is intended for class-B video output stages in colour television receivers.

P-N-P complement is BF623.

QUICK REFERENCE DATA

| | | | |
|--|-----------|------|------------------------|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 250 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 250 V |
| Collector current (peak value) | I_{CM} | max. | 100 mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 1 W |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |
| D.C. current gain | h_{FE} | > | 50 |
| $I_C = 25\text{ mA}; V_{CE} = 20\text{ V}$ | | | |
| Transition frequency at $f = 35\text{ MHz}$ | f_T | > | 60 MHz |
| $I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$ | | | |
| Feedback capacitance at $f = 1\text{ MHz}$ | C_{re} | < | 1,6 pF |
| $I_C = 0; V_{CE} = 30\text{ V}$ | | | |

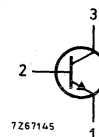
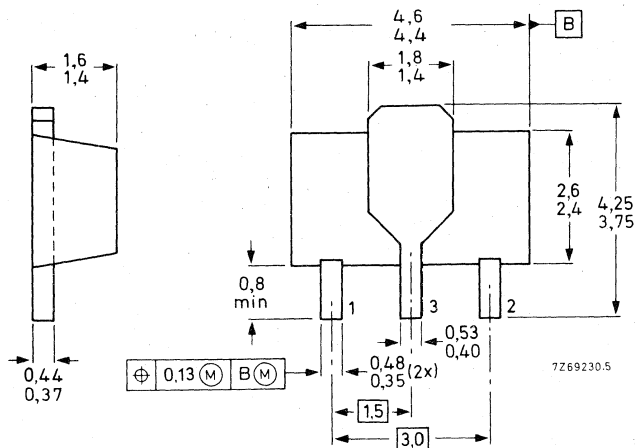
MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.

BF622



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|--------------------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 250 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 250 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 20 mA |
| Collector current (peak value) | I_{CM} | max. | 100 mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | P_{tot} | max. | 1 W |
| Storage temperature | T_{stg} | | -65 to +150 $^{\circ}\text{C}$ |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |

THERMAL RESISTANCE

| | | | |
|---|-----------------|---|---------------------------------|
| From junction to collector tab | $R_{th\ j-tab}$ | = | 25 $^{\circ}\text{C}/\text{W}$ |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | $R_{th\ j-a}$ | = | 125 $^{\circ}\text{C}/\text{W}$ |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 200\text{ V}$$

$$R_{BE} = 10\text{ k}\Omega; V_{CE} = 200\text{ V}; T_j = 150\text{ }^\circ\text{C}$$

$$I_{CBO} < 10\text{ nA}$$

$$I_{CER} < 50\text{ }\mu\text{A}$$

Emitter cut-off current

$$I_C = 0; V_{EB} = 5\text{ V}$$

$$I_{EBO} < 10\text{ }\mu\text{A}$$

Base-emitter voltage

$$I_C = 25\text{ mA}; V_{CE} = 20\text{ V}$$

$$V_{BE} \text{ typ. } 0,73\text{ V}$$

D.C. current gain

$$I_C = 25\text{ mA}; V_{CE} = 20\text{ V}$$

$$h_{FE} > 50$$

High-frequency knee voltage at $T_j = 150\text{ }^\circ\text{C}$ *

$$I_C = 25\text{ mA}$$

$$V_{CEK} \text{ typ. } 20\text{ V}$$

Transition frequency at $f = 35\text{ MHz}$

$$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$$

$$f_T > 60\text{ MHz}$$

Feedback capacitance at $f = 1\text{ MHz}$

$$I_C = 0; V_{CE} = 30\text{ V}$$

$$C_{re} < 1,6\text{ pF}$$

Feedback time constant at $f = 10,7\text{ MHz}$ **

$$I_C = 10\text{ mA}; V_{CE} = 20\text{ V}$$

$$r_{bb'}C_{b'c} < 70\text{ ps}$$

* The high-frequency knee voltage of a transistor is that value of the collector-emitter voltage at which the small-signal gain, measured in a practical circuit, has dropped to 80% of the gain at $V_{CE} = 50\text{ V}$. A further reduction of the collector-emitter voltage results in a rapid increase of the distortion of the signal.

** $r_{bb'}C_{b'c} = \frac{|h_{rb}|}{\omega}$

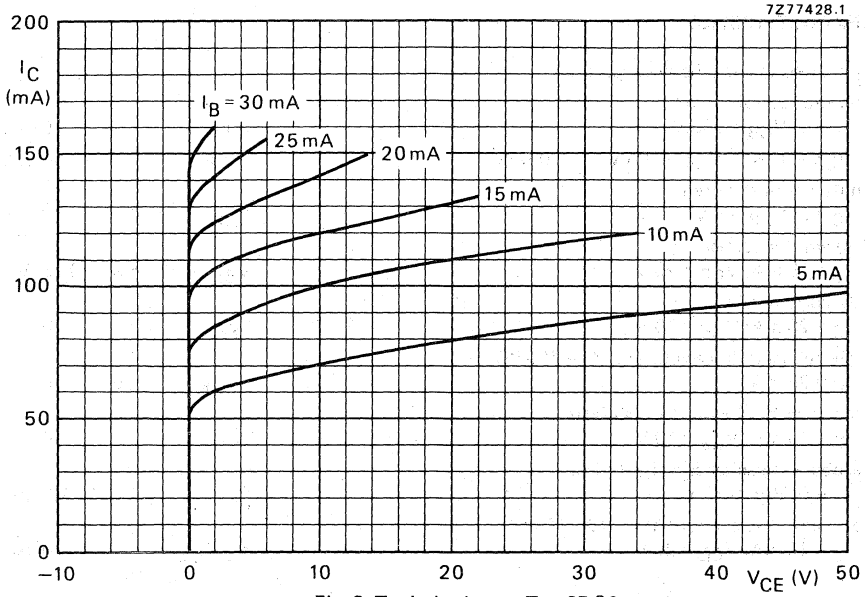


Fig. 2 Typical values at $T_j = 25^\circ\text{C}$.

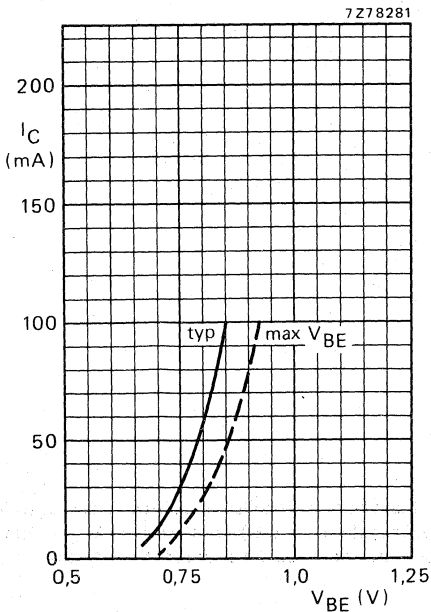


Fig. 3 $V_{CE} = 20\text{ V}$; $T_j = 25^\circ\text{C}$.

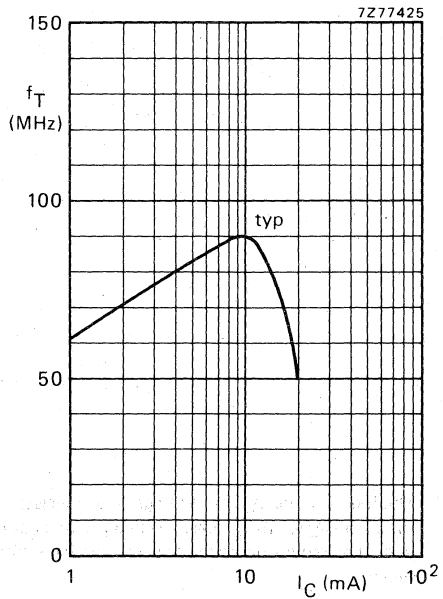


Fig. 4 $V_{CE} = 10\text{ V}$; $T_j = 25^\circ\text{C}$; $f = 35\text{ MHz}$.

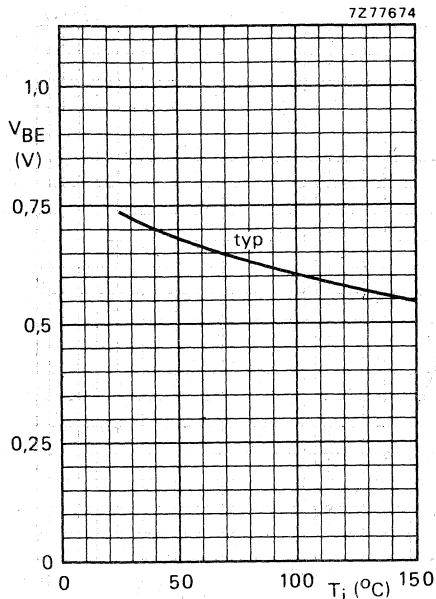


Fig. 5 $I_C = 25$ mA; $V_{CE} = 20$ V.

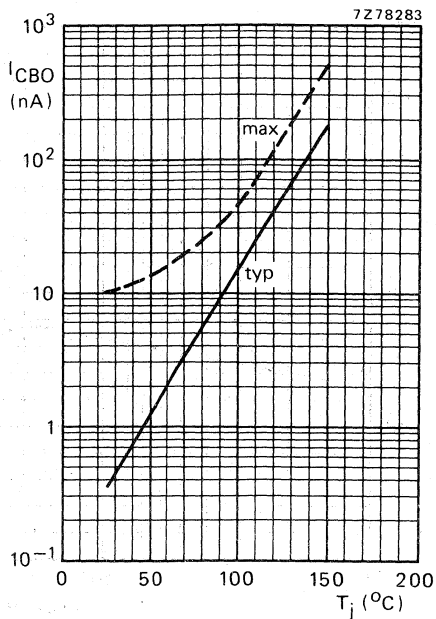


Fig. 6 $V_{CB} = 200$ V.

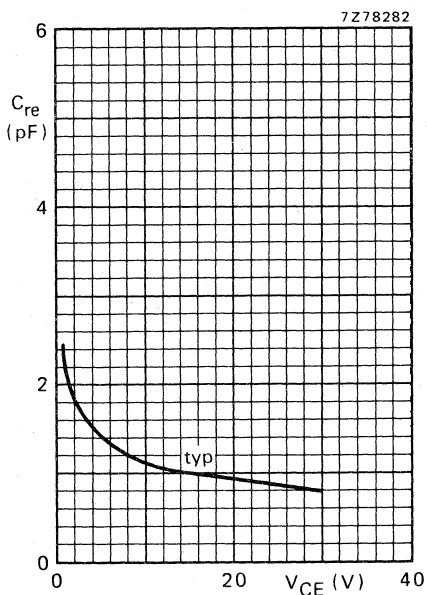


Fig. 7 $I_C = 0$; $f = 1$ MHz; $T_j = 25$ °C.

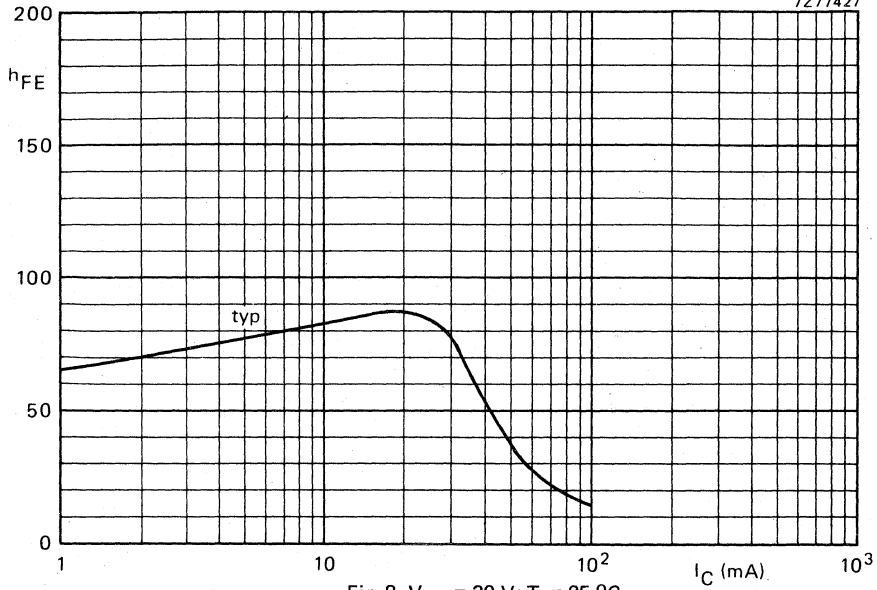


Fig. 8 $V_{CE} = 20$ V; $T_j = 25$ °C.



SILICON EPITAXIAL TRANSISTOR

- for video output stages

P-N-P transistor in a miniature plastic envelope intended for application in thick and thin-film circuits. This device is intended for class-B video output stages in colour television receivers.

N-P-N complement is BF622.

QUICK REFERENCE DATA

| | | | |
|--|------------|------|------------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 250 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 250 V |
| Collector current (peak value) | $-I_{CM}$ | max. | 100 mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 1 W |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |
| D.C. current gain | h_{FE} | > | 50 |
| $-I_C = 25\text{ mA}; -V_{CE} = 20\text{ V}$ | | | |
| Transition frequency at $f = 35\text{ MHz}$ | f_T | > | 60 MHz |
| $-I_C = 10\text{ mA}; -V_{CE} = 10\text{ V}$ | | | |
| Feedback capacitance at $f = 1\text{ MHz}$ | C_{re} | < | 1,6 pF |
| $I_C = 0; -V_{CE} = 30\text{ V}$ | | | |

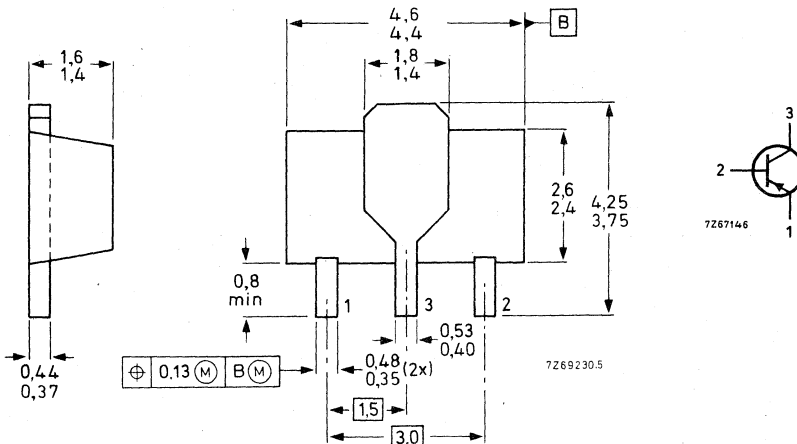
MECHANICAL DATA

Dimensions in mm.

Mark

Fig. 1 SOT-89.

BF623



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-------------------|-------------|--------|
| Collector-base voltage (open emitter) | -V _{CBO} | max. | 250 V |
| Collector-emitter voltage (open base) | -V _{CEO} | max. | 250 V |
| Emitter-base voltage (open collector) | -V _{EBO} | max. | 5 V |
| Collector current (d.c.) | -I _C | max. | 20 mA |
| Collector current (peak value) | -I _{CM} | max. | 100 mA |
| Total power dissipation up to T _{amb} = 25 °C mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | | | |
| Storage temperature | P _{tot} | max. | 1 W |
| Junction temperature | T _{stg} | -65 to +150 | °C |
| | T _j | max. | 150 °C |

THERMAL RESISTANCE

| | | | |
|---|-----------------------|---|----------|
| From junction to collector tab | R _{th j-tab} | = | 25 °C/W |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | R _{th j-a} | = | 125 °C/W |



CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; -V_{CB} = 200\text{ V}$

$-I_{CBO} < 10\text{ nA}$

$R_{BE} = 10\text{ k}\Omega; -V_{CE} = 200\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$-I_{CER} < 50\text{ }\mu\text{A}$

Emitter cut-off current

$I_C = 0; -V_{EB} = 5\text{ V}$

$-I_{EBO} < 10\text{ }\mu\text{A}$

Base-emitter voltage

$-I_C = 25\text{ mA}; -V_{CE} = 20\text{ V}$

$-V_{BE}$ typ. $0,75\text{ V}$

D.C. current gain

$-I_C = 25\text{ mA}; -V_{CE} = 20\text{ V}$

$h_{FE} > 50$

High-frequency knee voltage at $T_j = 150\text{ }^\circ\text{C}^*$

$-I_C = 25\text{ mA}$

$-V_{CEK}$ typ. 20 V

Transition frequency at $f = 35\text{ MHz}$

$-I_C = 10\text{ mA}; -V_{CE} = 10\text{ V}$

$f_T > 60\text{ MHz}$

Feedback capacitance at $f = 1\text{ MHz}$

$I_C = 0; -V_{CE} = 30\text{ V}$

$C_{re} < 1,6\text{ pF}$

Feedback time constant at $f = 10,7\text{ MHz}^{**}$

$-I_C = 10\text{ mA}; -V_{CE} = 20\text{ V}$

$r_{bb'}C_{b'c} < 70\text{ ps}$

* The high-frequency knee voltage of a transistor is that value of the collector-emitter voltage at which the small-signal gain, measured in a practical circuit, has dropped to 80% of the gain at $-V_{CE} = 50\text{ V}$. A further reduction of the collector-emitter voltage results in a rapid increase of the distortion of the signal.

** $r_{bb'}C_{b'c} = \frac{|h_{rb}|}{\omega}$

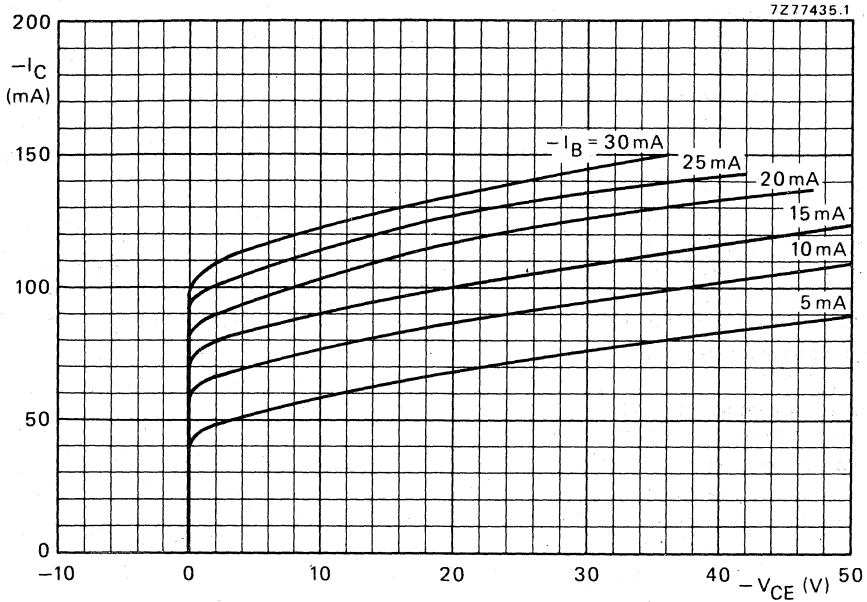


Fig. 2 Typical values at $T_j = 25^\circ\text{C}$.

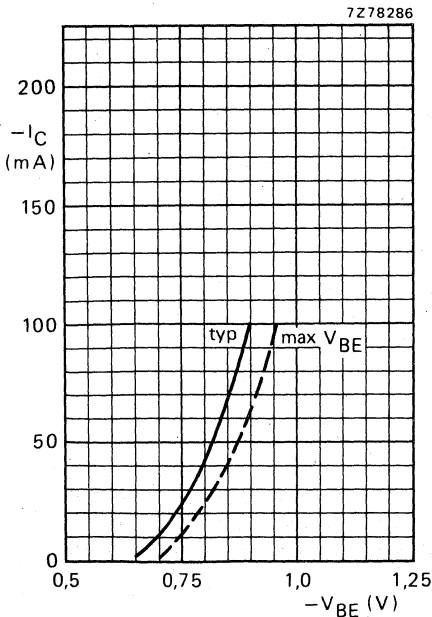


Fig. 3 $-V_{CE} = 20$ V; $T_j = 25^\circ\text{C}$.

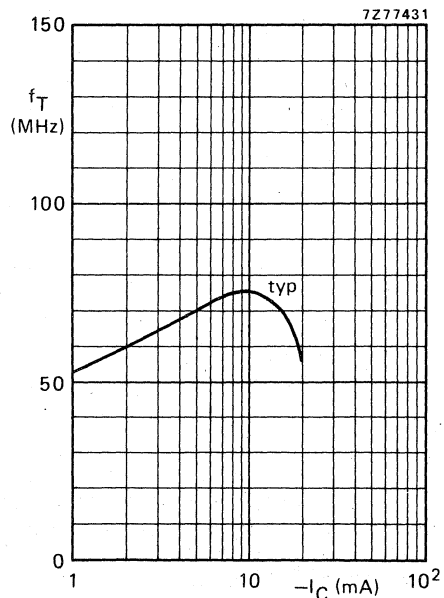


Fig. 4 $-V_{CE} = 10$ V; $T_j = 25^\circ\text{C}$; $f = 35$ MHz.

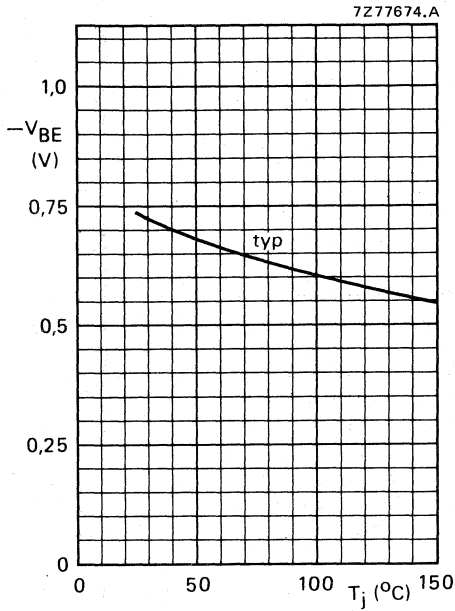


Fig. 5 $-I_C = 25$ mA; $-V_{CE} = 20$ V.

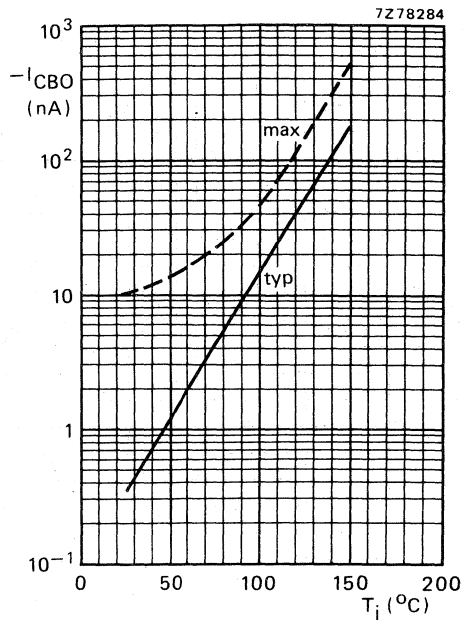


Fig. 6 $-V_{CB} = 200$ V.

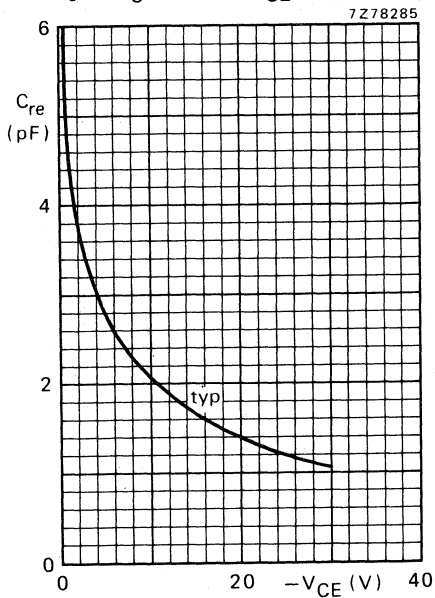


Fig. 7 $I_C = 0$; $f = 1$ MHz; $T_j = 25$ $^{\circ}C$.

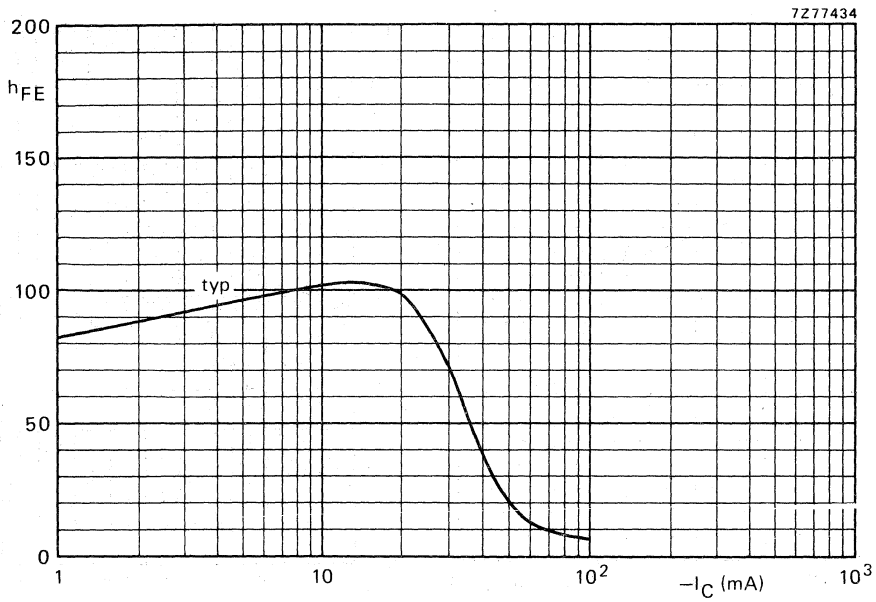


Fig. 8 $-V_{CE} = 20$ V; $T_j = 25$ °C.



SILICON PLANAR TRANSISTOR

P-N-P transistor, in a microminiature plastic envelope; intended for use as oscillator in v.h.f. tuners with extended frequency range and/or in conjunction with MOS-FETs in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|------------|------|------------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V |
| Collector current (peak value) | $-I_{CM}$ | max. | 25 mA |
| Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 200 mW |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |
| Transition frequency at $f = 100\text{ MHz}$ $I_E = 5\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 650 MHz |

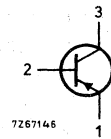
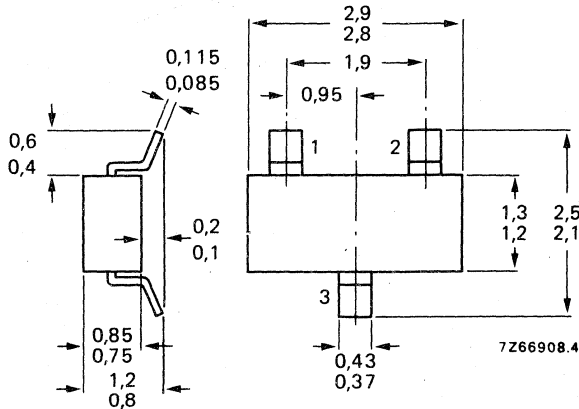
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BF660 = G8



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|---------------------------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 40 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 4 V |
| Collector current (peak value) | $-I_{CM}$ | max. | 25 mA |
| Base current (d.c.) | $-I_B$ | max. | 10 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to $+150\text{ }^\circ\text{C}$ |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$

Collector cut-off current

| | | | |
|----------------------------------|------------|---|-------|
| $I_E = 0; -V_{CB} = 20\text{ V}$ | $-I_{CBO}$ | < | 50 nA |
|----------------------------------|------------|---|-------|

D.C. current gain

| | | | |
|--|----------|---|----|
| $I_E = 3\text{ mA}; -V_{CE} = 10\text{ V}$ | h_{FE} | > | 30 |
|--|----------|---|----|

Transition frequency at $f = 100\text{ MHz}$

| | | | |
|--|-------|------|---------|
| $I_E = 5\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 650 MHz |
|--|-------|------|---------|

Feedback capacitance at $f = 1\text{ MHz}$

| | | | |
|--|----------|------|---------|
| $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$ | C_{re} | typ. | 0,65 pF |
|--|----------|------|---------|

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

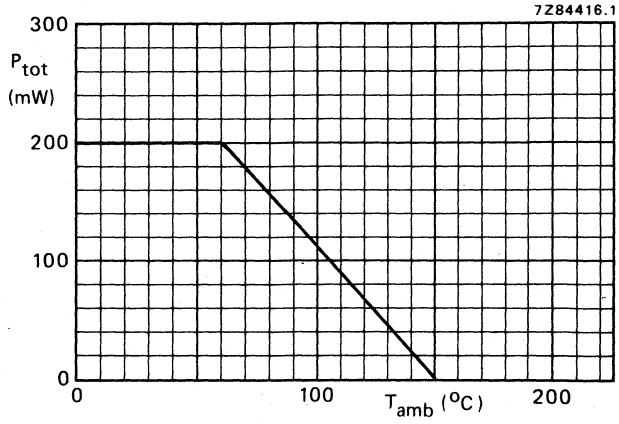


Fig. 2 Power derating curve.



SILICON PLANAR TRANSISTOR

P-N-P transistor in a microminiature plastic envelope, primarily intended for application as gain controlled amplifier e.g. in v.h.f. and u.h.f. television tuners in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|--|------------|------|----------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 30 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V | |
| Collector current (d.c.) | $-I_C$ | max. | 20 mA | |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} | max. | 200 mW | ← |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ | |
| Transition frequency at $f = 100\text{ MHz}$ $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 900 MHz | |
| Transducer gain (common base) $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega$ | G_{tr} | typ. | 13 dB | |
| Noise figure (common base) $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\ \Omega; R_L = 500\ \Omega$ | F | typ. | 4 dB | |

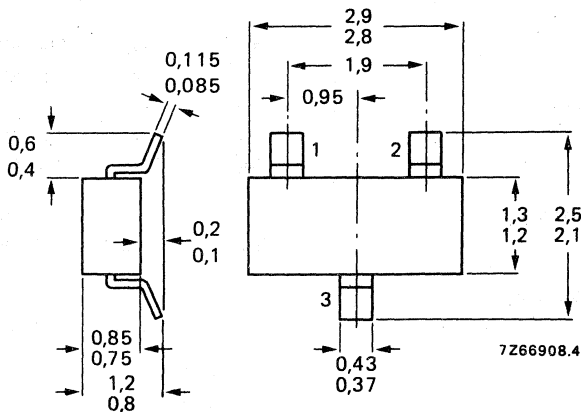
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BF767 = G9



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 30 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 30 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 3 V |
| Collector current (d.c.) | $-I_C$ | max. | 20 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ }^{\circ}\text{C}^{**}$ | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to $+150\text{ }^{\circ}\text{C}$ |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$; unless otherwise specified

Collector cut-off current

| | | | |
|----------------------------------|------------|---|--------|
| $I_E = 0; -V_{CB} = 15\text{ V}$ | $-I_{CBO}$ | < | 100 nA |
|----------------------------------|------------|---|--------|

D.C. current gain

| | | | |
|---|----------|------|----|
| $-I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$ | h_{FE} | > | 15 |
| | | typ. | 60 |

| | | | |
|--|----------|---|----|
| $-I_E = 7\text{ mA}; -V_{CB} = 4\text{ V}$ | h_{FE} | > | 10 |
|--|----------|---|----|

Transition frequency at $f = 100\text{ MHz}$

| | | | |
|--|-------|------|---------|
| $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}$ | f_T | typ. | 900 MHz |
|--|-------|------|---------|

| | | | |
|---|-------|------|--------|
| $I_E = 7\text{ mA}; -V_{CB} = 5\text{ V}$ | f_T | typ. | 90 MHz |
|---|-------|------|--------|

Feedback capacitance at $f = 500\text{ kHz}$

| | | | |
|--|----------|------|--------|
| $I_E = 1\text{ mA}; -V_{CB} = 10\text{ V}$ | C_{re} | typ. | 0,3 pF |
|--|----------|------|--------|

| | | | |
|----------------------------------|----------|------|--------|
| $I_E = 0; -V_{CB} = 10\text{ V}$ | C_{rb} | typ. | 160 fF |
|----------------------------------|----------|------|--------|

Transducer gain (common base)

| | | | |
|---|----------|------|-------|
| $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\text{ }\Omega; R_L = 500\text{ }\Omega$ | G_{tr} | typ. | 13 dB |
|---|----------|------|-------|

Noise figure (common base)

| | | | |
|---|-----|------|------|
| $I_E = 3\text{ mA}; -V_{CB} = 10\text{ V}; f = 800\text{ MHz}$ $R_S = 60\text{ }\Omega; R_L = 500\text{ }\Omega$ | F | typ. | 4 dB |
|---|-----|------|------|

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.



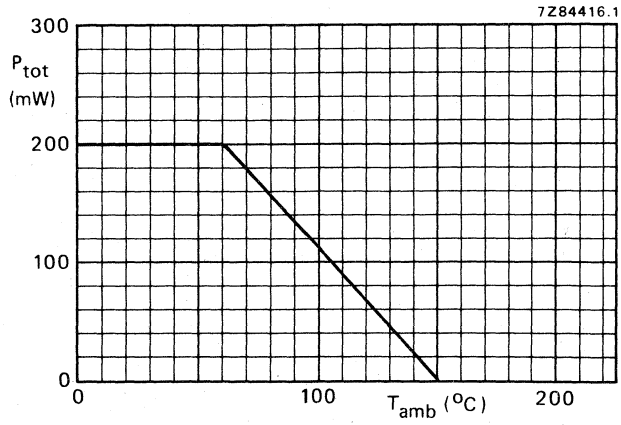


Fig. 2 Power derating curve.



RATINGS Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

| | | | | |
|---|------------|------|----|------|
| Collector-base voltage (open emitter; peak value) | V_{CBOM} | max. | 40 | V |
| Collector-emitter voltage ($R_{BE} \leq 50 \Omega$; peak value) | V_{CERM} | max. | 40 | V 1) |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 25 | V 1) |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2 | V |

Currents

| | | | | |
|---|----------|------|-----|----|
| Collector current (d.c.) | I_C | max. | 150 | mA |
| Collector current (peak value; $f > 1$ MHz) | I_{CM} | max. | 300 | mA |

Power dissipation

| | | | | |
|--|-----------|------|---|---|
| Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | P_{tot} | max. | 1 | W |
|--|-----------|------|---|---|

Temperatures

| | | | |
|----------------------|-----------|-------------|------------------|
| Storage temperature | T_{stg} | -65 to +150 | $^\circ\text{C}$ |
| Junction temperature | T_j | max. 150 | $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | | |
|---|---------------|---|-----|----------------------|
| From junction to collector tab | $R_{thj-tab}$ | = | 30 | $^\circ\text{C/W}$ ← |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | R_{thj-a} | = | 125 | $^\circ\text{C/W}$ |

1) $I_C = 10$ mA.

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20\text{ V}; T_j = 150\text{ }^\circ\text{C}$

$I_{CBO} < 20\text{ }\mu\text{A}$

Saturation voltage

$I_C = 100\text{ mA}; I_B = 10\text{ mA}$

$V_{CEsat} < 0,5\text{ V}$

D.C. current gain

$I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

$I_C = 150\text{ mA}; V_{CE} = 5\text{ V}$

$h_{FE} > 25$

Transition frequency at $f = 500\text{ MHz}$ ¹⁾

$I_C = 150\text{ mA}; V_{CE} = 15\text{ V}$

$f_T \text{ typ. } 1,2\text{ GHz}$

Collector capacitance at $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 15\text{ V}$

$C_c < 4\text{ pF}$

Feedback capacitance at $f = 1\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 15\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$

$C_{re} \text{ typ. } 1,9\text{ pF}$

Max. unilateral power gain (s_{re} assumed to be zero)

$$GUM \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 60\text{ mA}; V_{CE} = 15\text{ V}; T_{amb} = 25\text{ }^\circ\text{C};$

$f = 200\text{ MHz}$

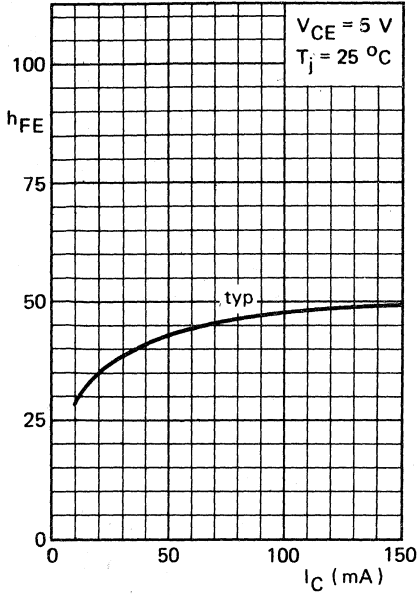
$f = 800\text{ MHz}$

$GUM \text{ typ. } 16\text{ dB}$

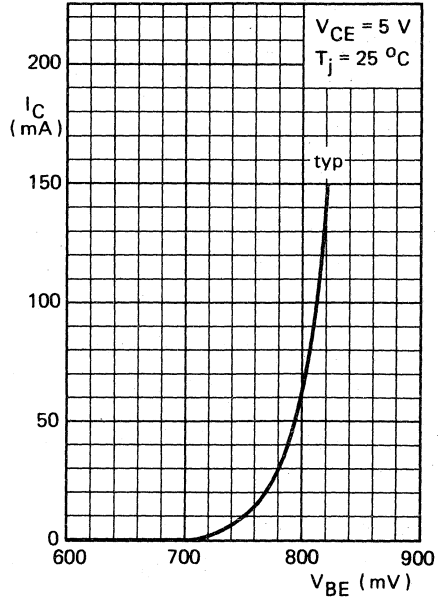
$GUM \text{ typ. } 6,5\text{ dB}$

¹⁾ Measured under pulse conditions.

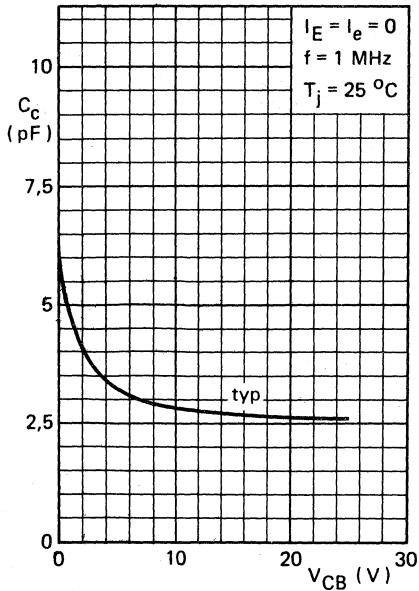
7Z72947



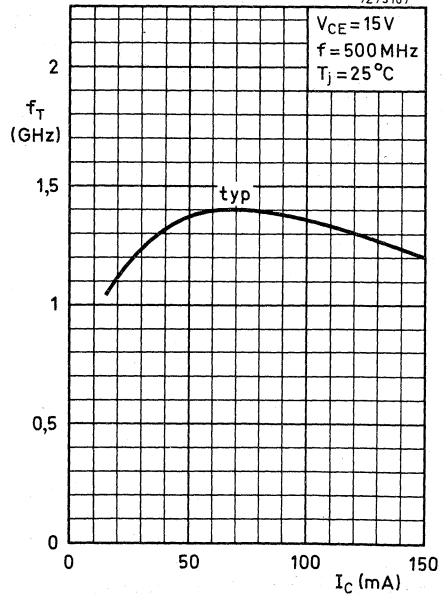
7Z72950



7Z72948



7Z73167



SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a miniature plastic envelope intended for application in thick and thin-film circuits. It is primarily intended for MATV purposes.

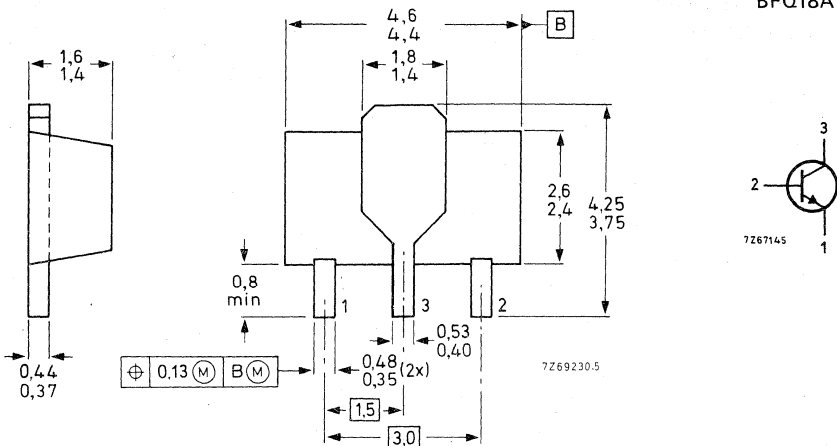
QUICK REFERENCE DATA

| | | | |
|---|-----------|------|---------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 25 V |
| Collector-emitter voltage (open base) | V_{CE0} | max. | 15 V |
| Collector current (d.c.) | I_C | max. | 150 mA |
| Total power dissipation up to $T_{amb} = 25\text{ °C}$ | P_{tot} | max. | 1 W |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 500\text{ MHz}$ $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$ | f_T | typ. | 3,6 GHz |
| Feedback capacitance at $f = 10,7\text{ MHz}$ $I_C = 0; V_{CE} = 10\text{ V}$ | C_{re} | typ. | 1,2 pF |
| Intermodulation distortion $I_C = 80\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega$ measured at $f_{(p+q-r)} = 793,25\text{ MHz}$ | d_{im} | < | -60 dB |

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-89.



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|------------------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 25 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 15 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2 V |
| Collector current (d.c.) | I_C | max. | 150 mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ * | P_{tot} | max. | 1 W |
| Storage temperature | T_{stg} | | -65 to +150 $^\circ\text{C}$ |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | |
|--|-----------------|---|------------------------|
| From junction to collector tab | $R_{th\ j-tab}$ | = | 25 $^\circ\text{C/W}$ |
| From junction to ambient in free air * | $R_{th\ j-a}$ | = | 125 $^\circ\text{C/W}$ |

CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$ unless otherwise specified

D.C. current gain **

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$

$h_{FE} > 25$

$I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$

$h_{FE} > 25$

Transition frequency at $f = 500\text{ MHz}$ **

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$

f_T typ. 3,2 GHz

$I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$

f_T typ. 3,6 GHz

Collector capacitance at $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$

C_c typ. 2,0 pF

Emitter capacitance at $f = 1\text{ MHz}$

$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$

C_e typ. 11 pF

Feedback capacitance at $f = 10,7\text{ MHz}$

$I_C = 0; V_{CE} = 10\text{ V}$

C_{re} typ. 1,2 pF

* The device mounted on a ceramic substrate area = 2,5 cm²; thickness = 0,7 mm.

** Measured under pulse conditions.

Intermodulation distortion (see Fig. 2)

$$I_C = 80 \text{ mA}; V_{CE} = 10 \text{ V}; R_L = 75 \Omega$$

$$V_p = V_o = 700 \text{ mV at } f_p = 795,25 \text{ MHz}$$

$$V_q = V_o - 6 \text{ dB at } f_q = 803,25 \text{ MHz}$$

$$V_r = V_o - 6 \text{ dB at } f_r = 805,25 \text{ MHz}$$

$$\text{Measured at } f_{(p+q-r)} = 793,25 \text{ MHz}$$

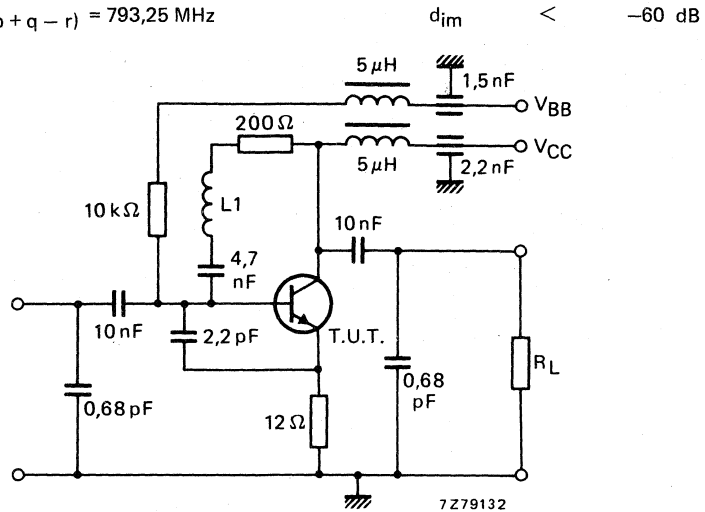


Fig. 2 MATV-test circuit (40–860 MHz).

SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a miniature plastic envelope intended for application in thick- and thin-film circuits.

It is primarily intended for use in u.h.f. and microwave amplifiers such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc.

The transistor features very low intermodulation distortion and high power gain. Thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

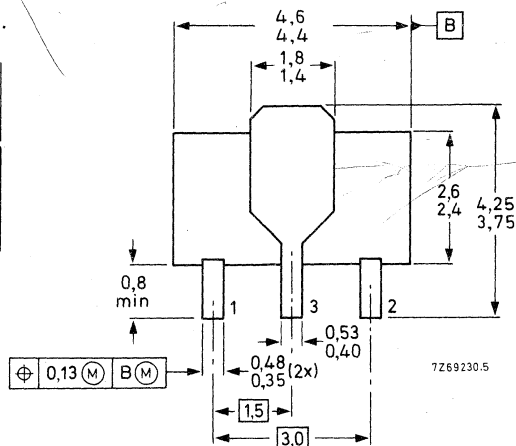
| QUICK REFERENCE DATA | | | |
|--|-----------|------|----------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 20 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 15 V |
| Collector current (d. c.) | I_C | max. | 75 mA |
| Total power dissipation up to $T_{amb} = 87,5 \text{ }^\circ\text{C}$ | P_{tot} | max. | 500 mW |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 500 \text{ MHz}$ $I_C = 50 \text{ mA}; V_{CE} = 10 \text{ V}$ | f_T | typ. | 5 GHz |
| Feedback capacitance at $f = 1 \text{ MHz}$ $I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}$ | C_{re} | typ. | 1,3 pF |
| Noise figure at optimum source impedance $I_C = 50 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$ | F | typ. | 3,3 dB |

MECHANICAL DATA

Fig. 1 SOT-89.

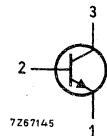


Dimensions in mm



Mark

BFQ19



See also Soldering recommendations.

RATINGS Limiting values in accordance with the Absolute Maximum System (IEC134)

Voltages

| | | | | |
|---------------------------------------|-----------|------|-----|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 20 | V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 15 | V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 3,0 | V |

Currents

| | | | | |
|---|----------|------|-----|----|
| Collector current (d. c.) | I_C | max. | 75 | mA |
| Collector current (peak value); $f > 1$ MHz | I_{CM} | max. | 150 | mA |

Power dissipation

| | | | | |
|--|-----------|------|-----|----|
| Total power dissipation up to $T_{amb} = 87,5$ °C mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | P_{tot} | max. | 500 | mW |
|--|-----------|------|-----|----|

Temperatures

| | | | |
|----------------------|-----------|-------------|----|
| Storage temperature | T_{stg} | -65 to +150 | °C |
| Junction temperature | T_j | max. 150 | °C |

THERMAL RESISTANCE

| | | | |
|---|-----------------|-----|------|
| From junction to collector tab | $R_{thj-tab} =$ | 40 | °C/W |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | $R_{thj-a} =$ | 125 | °C/W |



CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 10\text{ V}$ $I_{CBO} < 100\text{ nA}$

D. C. current gain 1)

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$ $h_{FE} > 25$
typ. 50

$I_C = 75\text{ mA}; V_{CE} = 10\text{ V}$ $h_{FE} > 25$
typ. 52

Transition frequency at $f = 500\text{ MHz}$ 1)

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$ $f_T > 4,0\text{ GHz}$
typ. 5,0 GHz

$I_C = 75\text{ mA}; V_{CE} = 10\text{ V}$ $f_T > 4,4\text{ GHz}$
typ. 5,5 GHz

Collector capacitance at $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$ C_c typ. 1,6 pF

Emitter capacitance at $f = 1\text{ MHz}$

$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$ C_e typ. 5,0 pF

Feedback capacitance at $f = 1\text{ MHz}$

$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$ C_{re} typ. 1,3 pF

Noise figure at optimum source impedance

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ F typ. 3,3 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ }^\circ\text{C};$

$f = 200\text{ MHz}$

$f = 500\text{ MHz}$

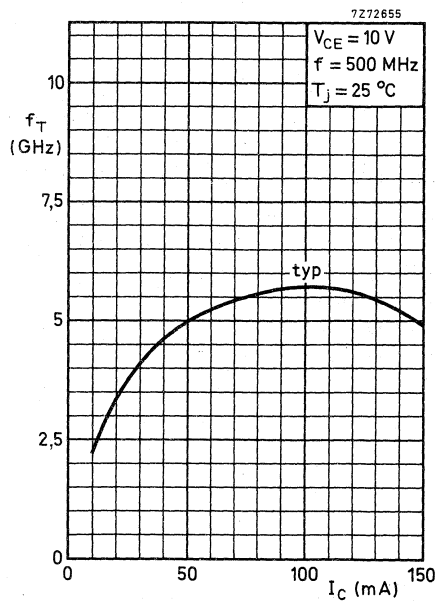
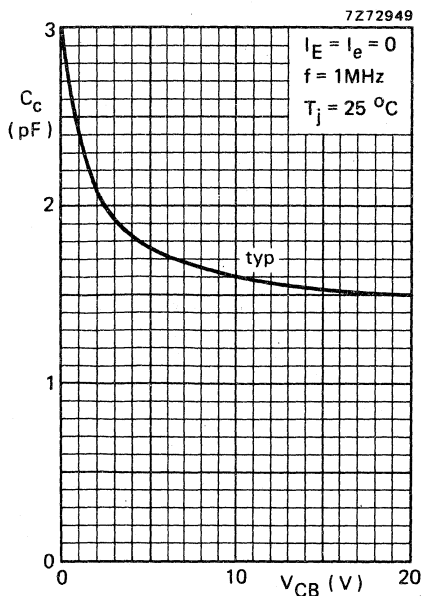
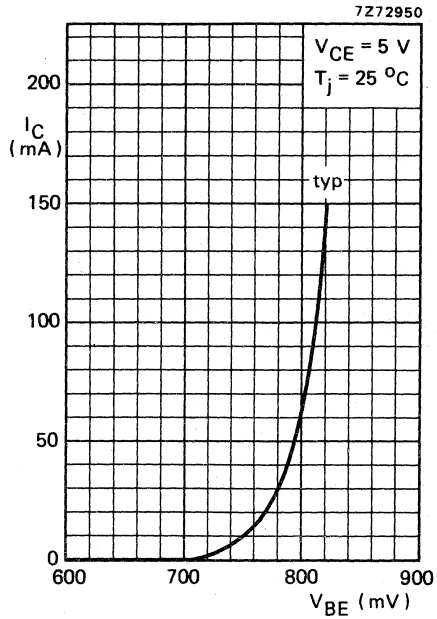
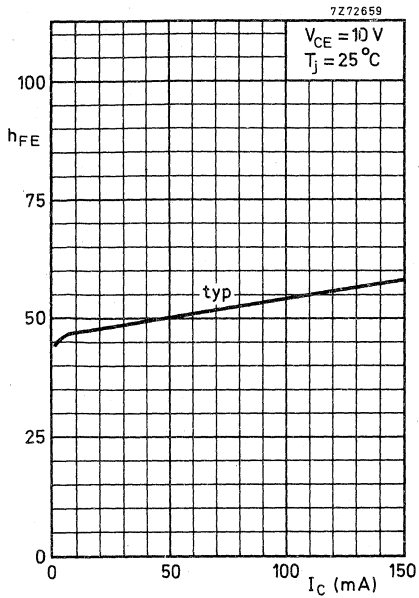
$f = 800\text{ MHz}$

G_{UM} typ. 18,5 dB

G_{UM} typ. 11,5 dB

G_{UM} typ. 7,5 dB

1) Measured under pulse conditions.



N-CHANNEL SILICON FIELD-EFFECT TRANSISTORS

Planar epitaxial junction field effect transistor in a microminiature plastic envelope. It is intended for low level general purpose amplifiers in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|--|--------------|------|--------------|--------------|
| Drain-source voltage | $\pm V_{DS}$ | max. | 25 | V |
| Gate-source voltage (open drain) | $-V_{GSO}$ | max. | 25 | V |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 250 | mW |
| | | | BFR30 | BFR31 |
| Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$ | I_{DSS} | $>$ | 4 | 1 mA |
| | | $<$ | 10 | 5 mA |
| Transfer admittance (common source) $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}; f = 1\text{ kHz}$ | $ Y_{fs} $ | $>$ | 1,0 | 1,5 mA/V |
| | | $<$ | 4,0 | 4,5 mA/V |

MECHANICAL DATA

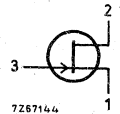
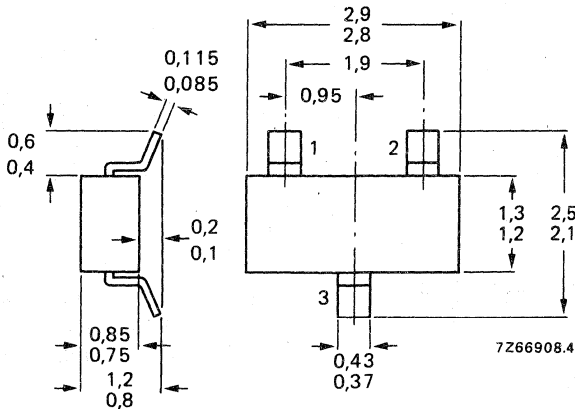
Fig. 1 SOT-23.

Dimensions in mm

Marking code

BFR30 = M1

BFR31 = M2



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | | |
|---|--------------|------|--------------|------------------|
| Drain-source voltage see Fig. 2 | $\pm V_{DS}$ | max. | 25 | V |
| Drain-gate voltage (open source) see Fig. 2 | V_{DGO} | max. | 25 | V |
| Gate-source voltage (open drain) see Fig. 2 | $-V_{GSO}$ | max. | 25 | V |
| Drain current | I_D | max. | 10 | mA |
| Gate current | I_G | max. | 5 | mA |
| → Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 250 | mW |
| → Storage temperature | T_{stg} | | -65 to + 175 | $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | | |
|------------------------------------|---------------|---|-----|-----|
| From junction to tab | $R_{th\ j-t}$ | = | 60 | K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 | K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 | K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| | | | BFR30 | BFR31 | |
|---|--------------|---|-------|-------|------------------------|
| Gate cut-off current | | | | | |
| $-V_{GS} = 10\text{ V}; V_{DS} = 0$ | $-I_{GSS}$ | < | 0,2 | 0,2 | nA |
| Drain current | | | | | |
| $V_{DS} = 10\text{ V}; V_{GS} = 0$ | I_{DSS} | > | 4 | 1 | mA |
| | | < | 10 | 5 | mA |
| Gate-source voltage | | | | | |
| $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$ | $-V_{GS}$ | > | 0,7 | 0 | V |
| | | < | 3,0 | 1,3 | V |
| $I_D = 50\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$ | $-V_{GS}$ | < | 4,0 | 2,0 | V |
| Gate-source cut-off voltage | | | | | |
| $I_D = 0,5\text{ nA}; V_{DS} = 10\text{ V}$ | $-V_{(P)GS}$ | < | 5 | 2,5 | V |
| y parameters | | | | | |
| Transfer admittance at $f = 1\text{ kHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | | | | | |
| $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$ | $ y_{fs} $ | > | 1,0 | 1,5 | mA/V |
| | | < | 4,0 | 4,5 | mA/V |
| $I_D = 200\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$ | $ y_{fs} $ | > | 0,5 | 0,75 | mA/V |
| Output admittance at $f = 1\text{ kHz}$ | | | | | |
| $I_D = 1\text{ mA}; V_{DS} = 10\text{ V}$ | $ y_{os} $ | < | 40 | 25 | $\mu\text{A}/\text{V}$ |
| $I_D = 200\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$ | $ y_{os} $ | < | 20 | 15 | $\mu\text{A}/\text{V}$ |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

y parameters (continued)

| | | BFR30 | BFR31 | |
|--|----------|-------|-------|---------------|
| Input capacitance at $f = 1 \text{ MHz}$ | | | | |
| $I_D = 1 \text{ mA}; V_{DS} = 10 \text{ V}$ | C_{is} | < 4 | 4 | pF |
| $I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$ | C_{is} | < 4 | 4 | pF |
| Feedback capacitance at $f = 1 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$ | | | | |
| $I_D = 1 \text{ mA}; V_{DS} = 10 \text{ V}$ | C_{rs} | < 1,5 | 1,5 | pF |
| $I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$ | C_{rs} | < 1,5 | 1,5 | pF |
| Equivalent noise voltage | | | | |
| $I_D = 200 \mu\text{A}; V_{DS} = 10 \text{ V}$ | V_n | < 0,5 | 0,5 | μV |
| $B = 0,6 \text{ to } 100 \text{ Hz}$ | | | | |

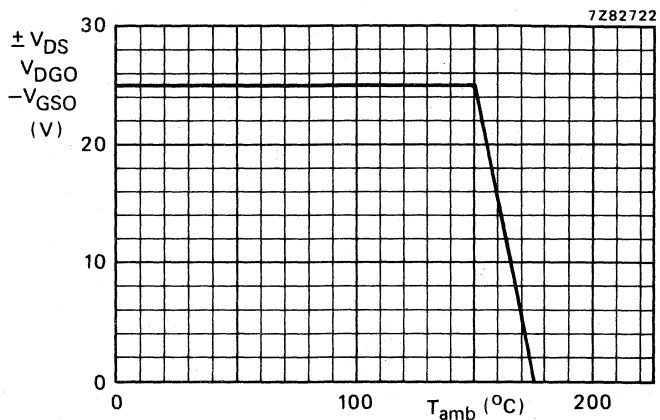


Fig. 2 Voltage derating curve.

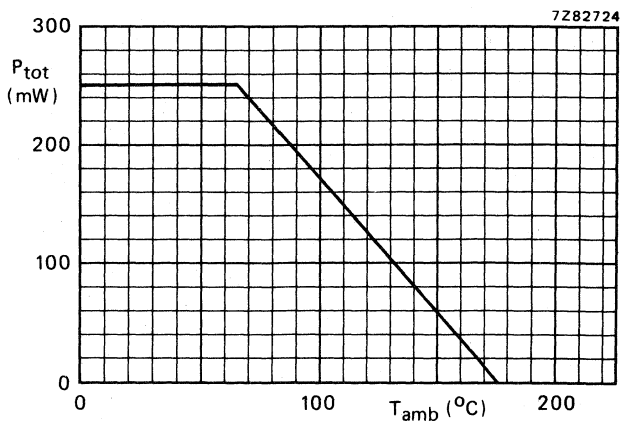
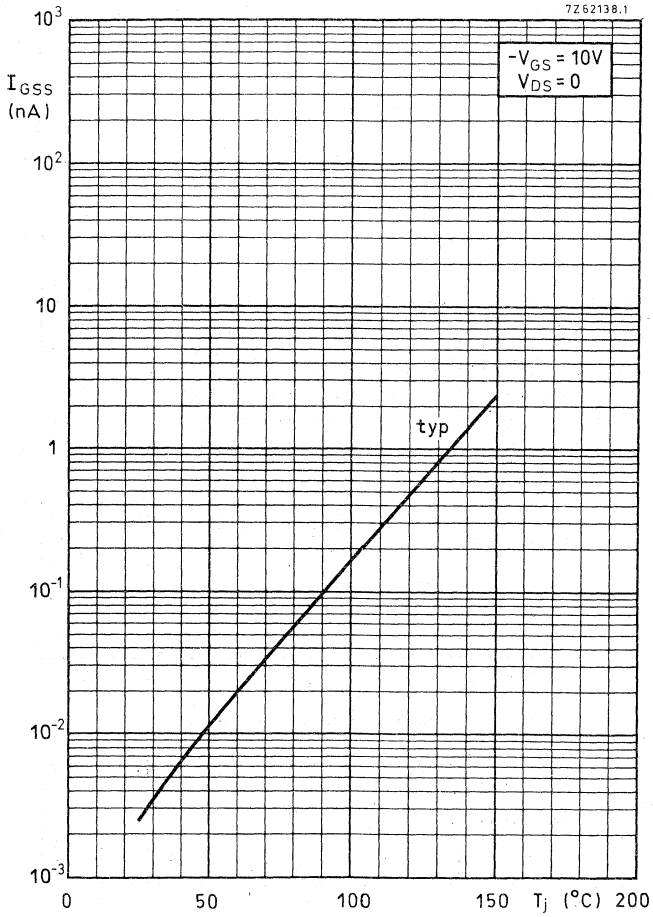
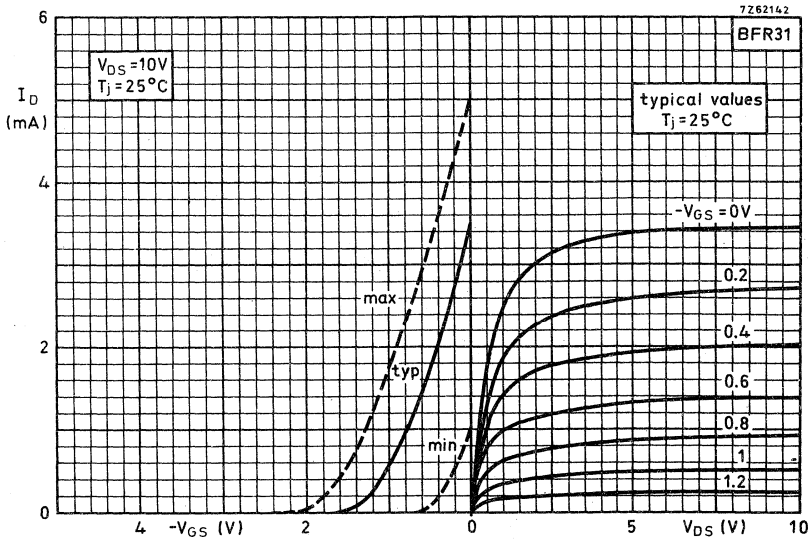
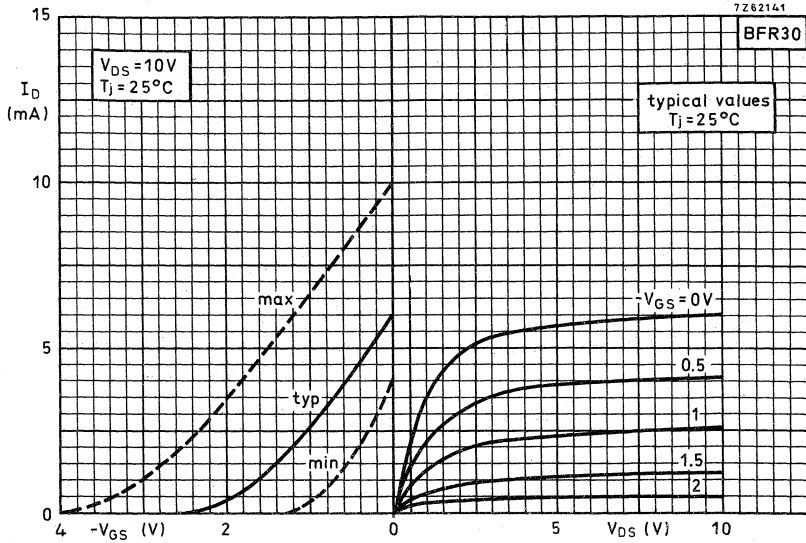
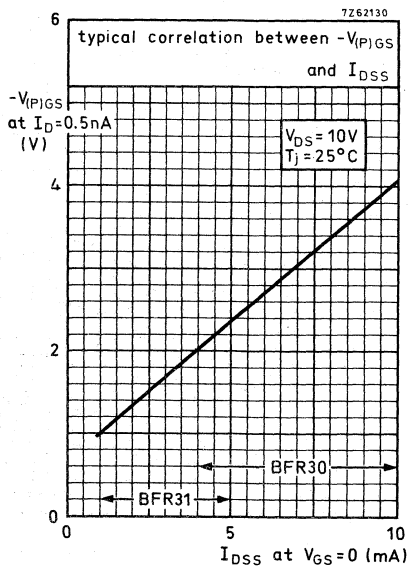
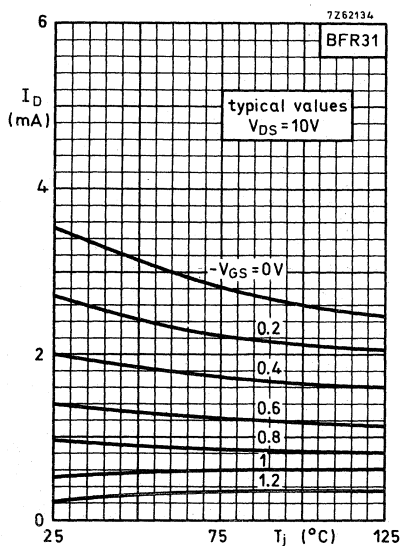
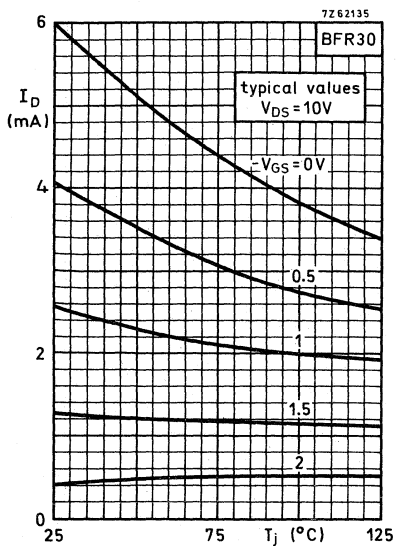


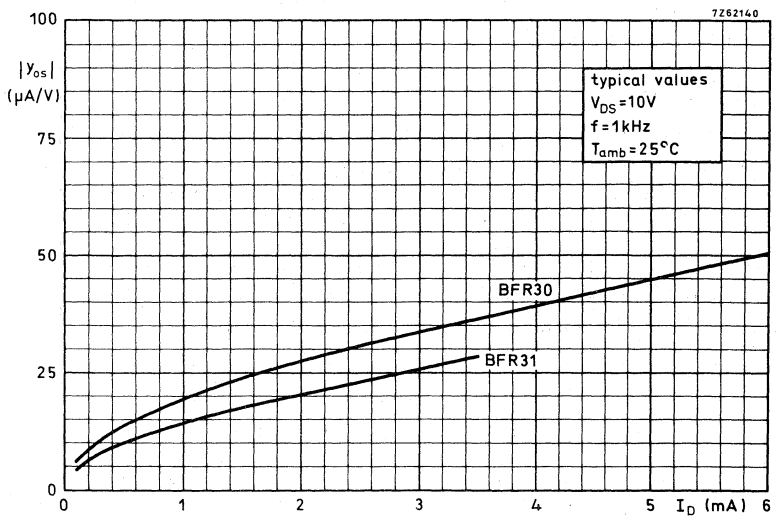
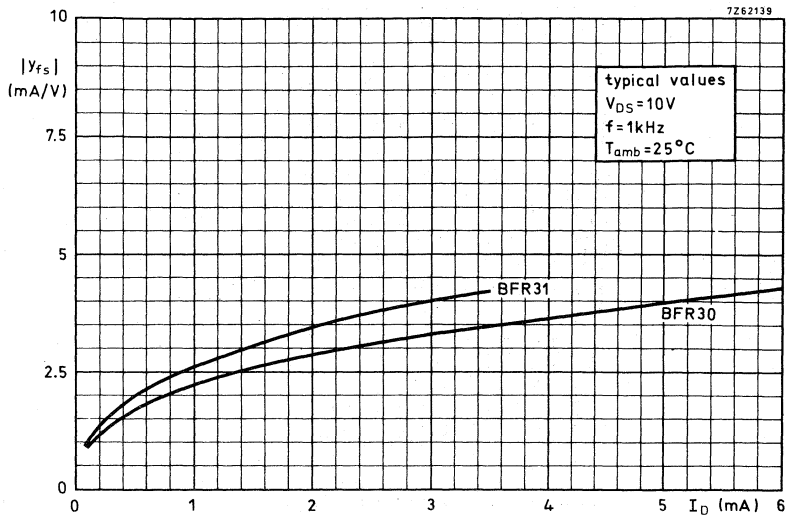
Fig. 3 Power derating curve.

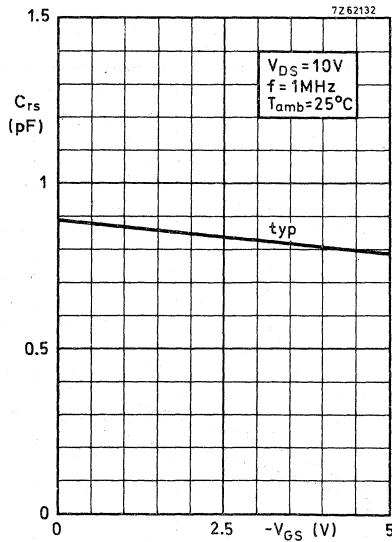
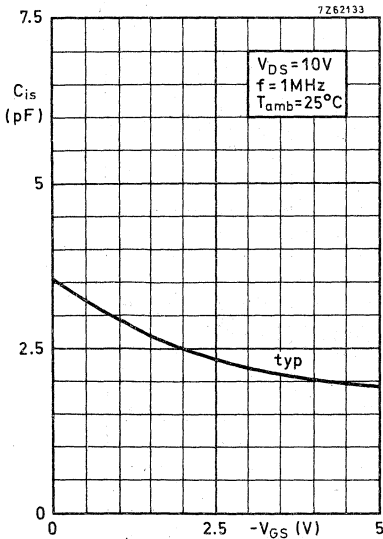
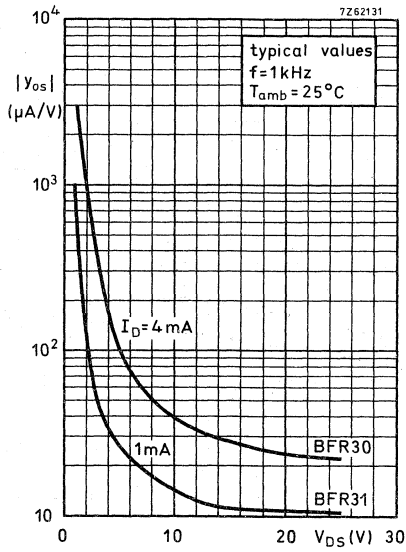


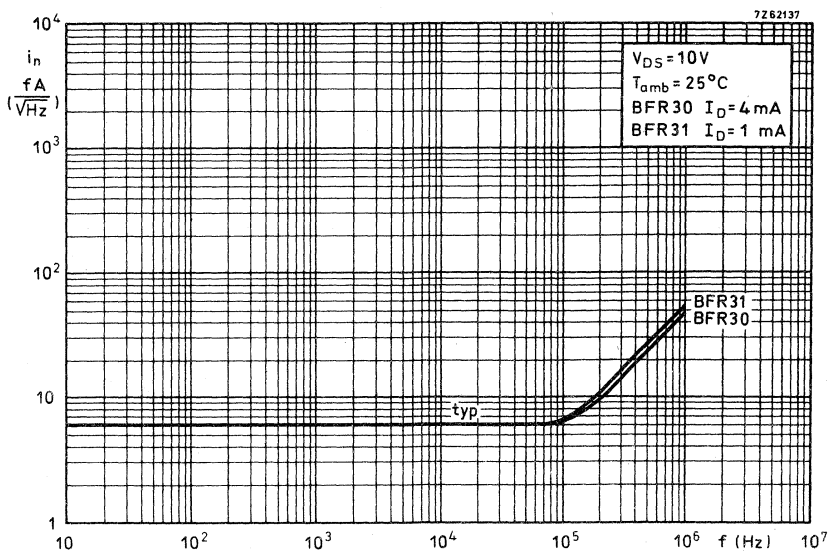
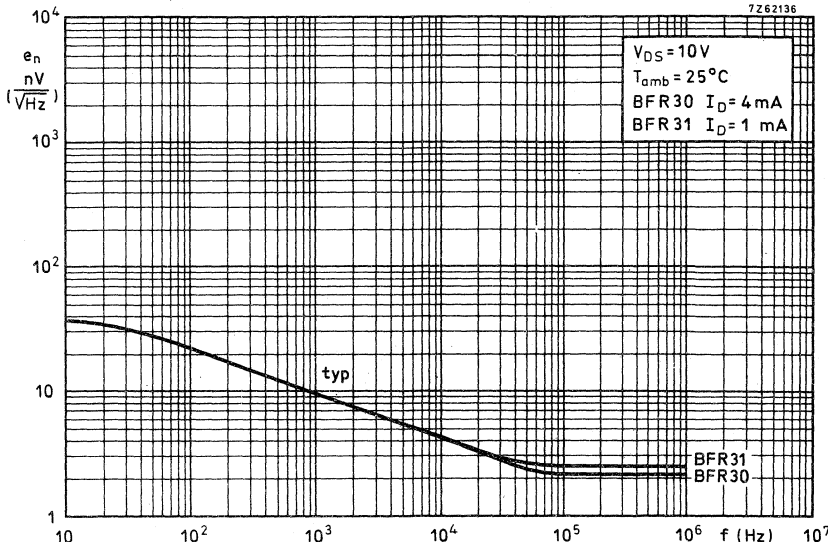


BFR30; BFR31









SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N multi-emitter transistor in a microminiature plastic envelope intended for application in thick and thin-film circuits. The transistor has very low intermodulation distortion and very high power gain. It is primarily intended for:

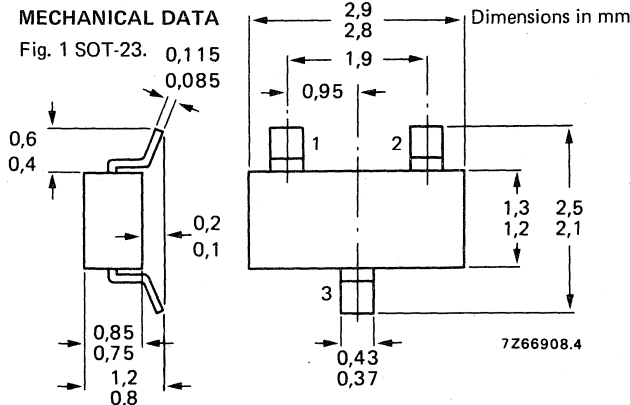
- Wideband vertical amplifiers in high speed oscilloscopes.
- Television distribution amplifiers.

QUICK REFERENCE DATA

| | | | | |
|--|-----------|------|---------|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 18 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 10 V | |
| Collector current (peak value; $f > 1$ MHz) | I_{CM} | max. | 100 mA | |
| Total power dissipation up to $T_{amb} = 65$ °C | P_{tot} | max. | 250 mW | ← |
| Junction temperature | T_j | max. | 175 °C | ← |
| Feedback capacitance at $f = 1$ MHz $I_C = 2$ mA; $V_{CE} = 5$ V; $T_{amb} = 25$ °C | $-C_{re}$ | typ. | 0,9 pF | |
| Transition frequency at $f = 500$ MHz $I_C = 25$ mA; $V_{CE} = 5$ V | f_T | typ. | 2,0 GHz | |
| Max. unilateral power gain (see page 3) $I_C = 30$ mA; $V_{CE} = 5$ V; $f = 200$ MHz; $T_{amb} = 25$ °C $I_C = 30$ mA; $V_{CE} = 5$ V; $f = 800$ MHz; $T_{amb} = 25$ °C | G_{UM} | typ. | 22 dB | |
| | G_{UM} | typ. | 10,5 dB | |
| Intermodulation distortion at $T_{amb} = 25$ °C $I_C = 30$ mA; $V_{CE} = 5$ V; $R_L = 37,5$ Ω $V_o = 100$ mV at $f_p = 183$ MHz $V_o = 100$ mV at $f_q = 200$ MHz measured at $f(2q-p) = 217$ MHz | d_{im} | typ. | -60 dB | |

MECHANICAL DATA

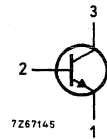
Fig. 1 SOT-23.



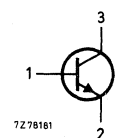
See also *Soldering recommendations*.

Marking code

BFR53 = N1



BFR53R = N4



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|----------------|
| Collector-base voltage (open emitter) see Fig. 3 | V_{CB0} | max. | 18 V |
| Collector-emitter voltage (open base) see Fig. 3 | V_{CE0} | max. | 10 V |
| Emitter-base voltage (open collector) see Fig. 3 | V_{EB0} | max. | 2,5 V |
| Collector current (d.c.) | I_C | max. | 50 mA |
| Collector current (peak value: $f > 1$ MHz) | I_{CM} | max. | 100 mA |
| Total power dissipation up to $T_{amb} = 65$ °C** | P_{tot} | max. | 250 mW |
| Storage temperature | T_{stg} | | -65 to +175 °C |
| Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10 \text{ V}$$

| | | |
|-----------|---|-------|
| I_{CBO} | < | 50 nA |
|-----------|---|-------|

D.C. current gain Δ

$$I_C = 25 \text{ mA}; V_{CE} = 5 \text{ V}$$

| | | |
|----------|---|----|
| h_{FE} | > | 25 |
|----------|---|----|

$$I_C = 50 \text{ mA}; V_{CE} = 5 \text{ V}$$

| | | |
|----------|---|----|
| h_{FE} | > | 25 |
|----------|---|----|

Transition frequency at $f = 500$ MHz Δ

$$I_C = 25 \text{ mA}; V_{CE} = 5 \text{ V}$$

| | | |
|-------|------|---------|
| f_T | typ. | 2,0 GHz |
|-------|------|---------|

Collector capacitance at $f = 1$ MHz

$$I_E = I_e = 0; V_{CB} = 5 \text{ V}$$

| | | |
|-------|------|--------|
| C_c | typ. | 0,9 pF |
|-------|------|--------|

Emitter capacitance at $f = 1$ MHz

$$I_C = I_c = 0; V_{EB} = 0,5 \text{ V}$$

| | | |
|-------|------|--------|
| C_e | typ. | 1,5 pF |
|-------|------|--------|

Feedback capacitance at $f = 1$ MHz

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; T_{amb} = 25$$
 °C

| | | |
|-----------|------|--------|
| $-C_{re}$ | typ. | 0,9 pF |
|-----------|------|--------|

Δ Measured under pulse conditions.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Noise figure at $f = 500 \text{ MHz}$ [▲]

$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}$

$G_S = 20 \text{ mA/V}; B_S$ is tuned

F < 5 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; f = 200 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

G_{UM} typ. 22 dB

$I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; f = 800 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

G_{UM} typ. 10,5 dB

Intermodulation distortion [▲]

$I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; R_L = 37,5 \text{ } \Omega$

$V_o = 100 \text{ mV}$ at $f_p = 183 \text{ MHz}$

$V_o = 100 \text{ mV}$ at $f_q = 200 \text{ MHz}$

Measured at $f(2q - p) = 217 \text{ MHz}$

d_{im} typ. -60 dB

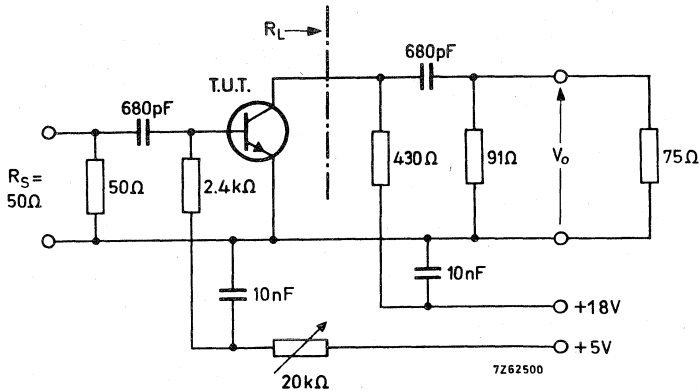


Fig. 2 Test circuit.

[▲] Crystal mounted in a BFW30 envelope.

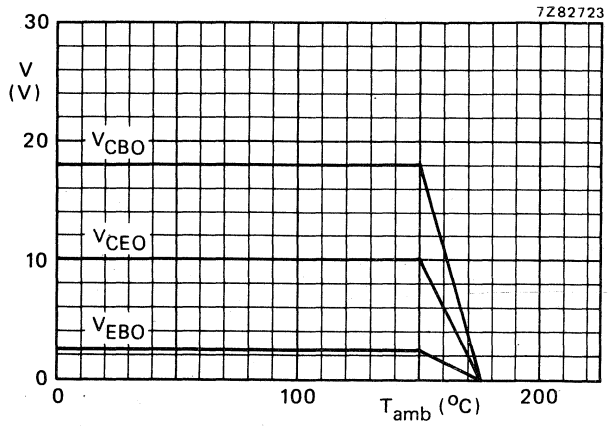


Fig. 3 Voltage derating curves.

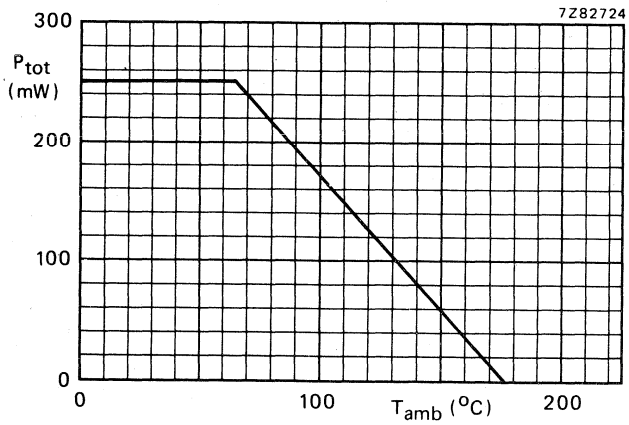
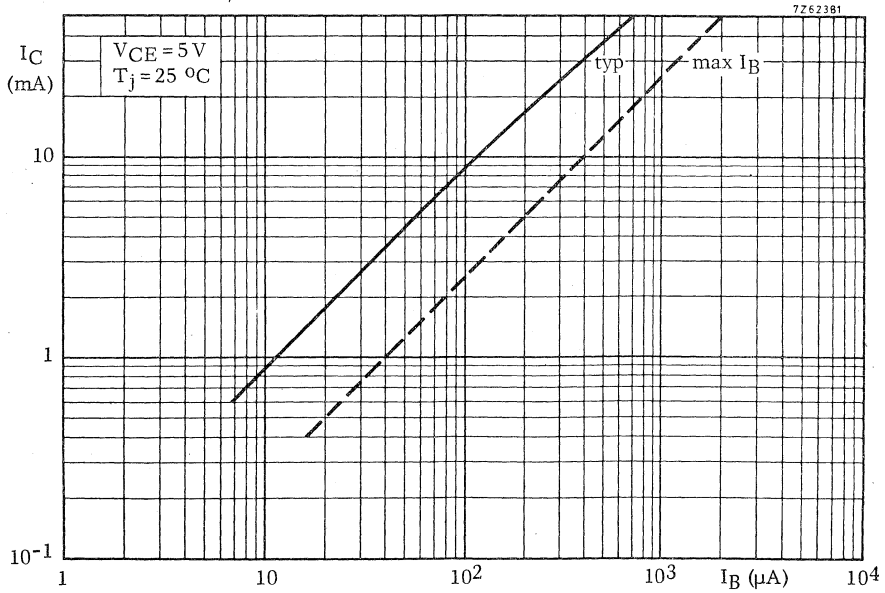
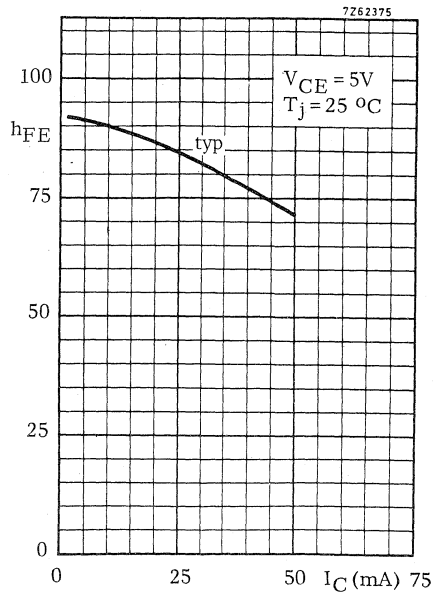
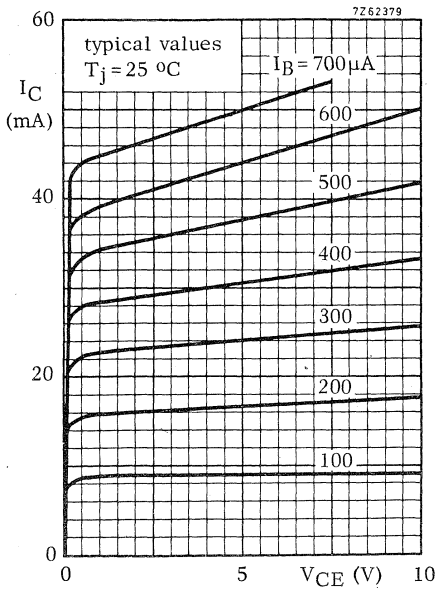
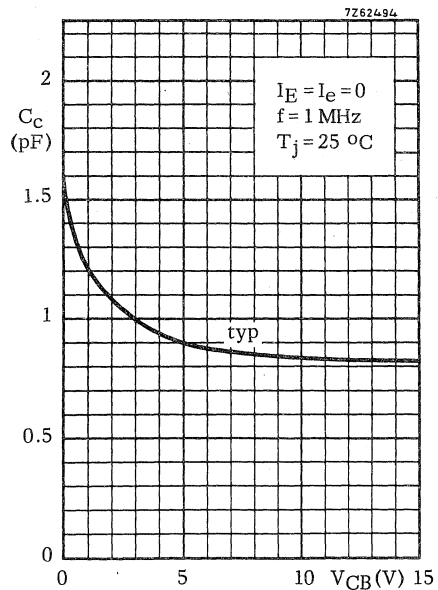
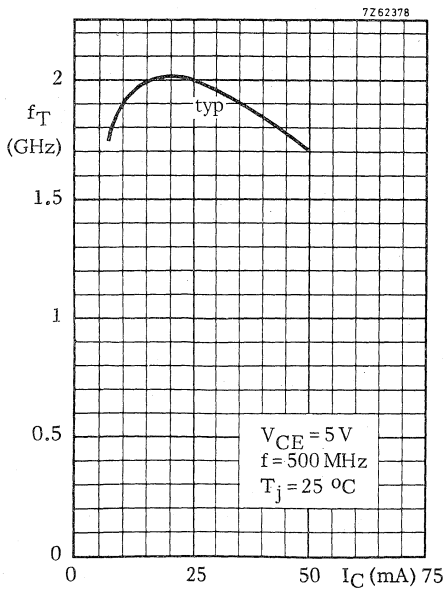
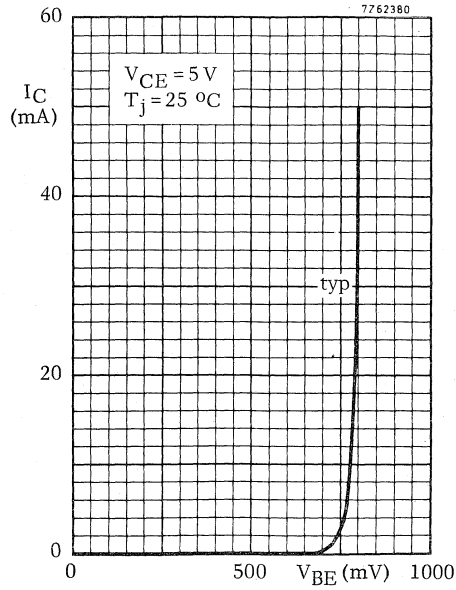


Fig. 4 Power derating curve.



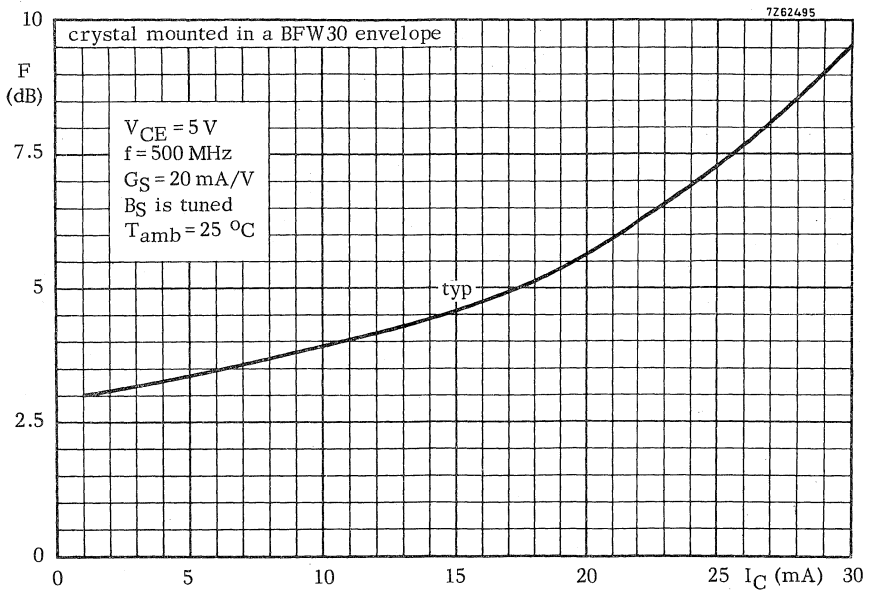
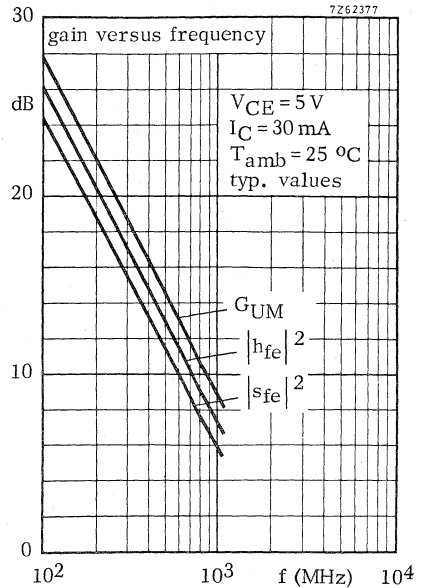
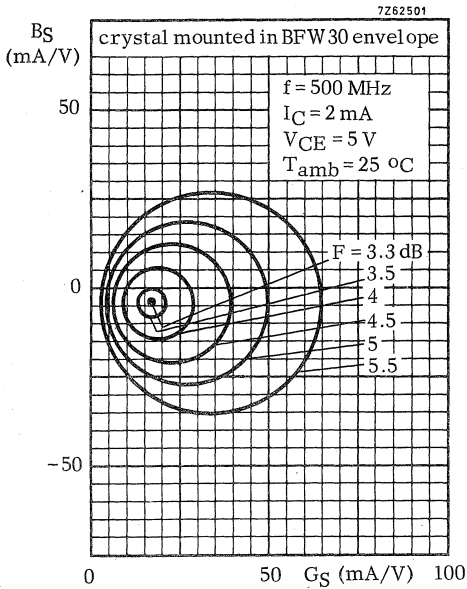




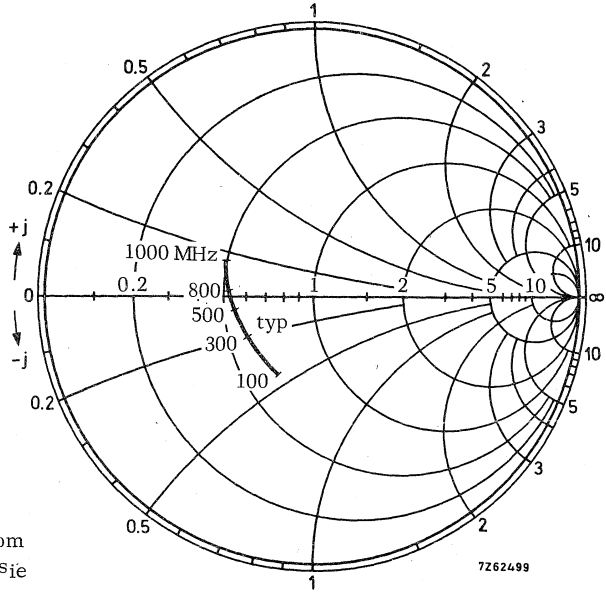
0000000000
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circles of constant noise figure

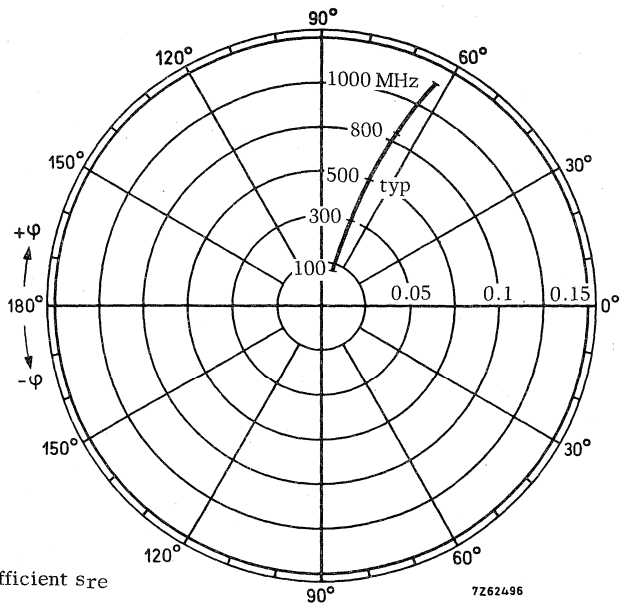


$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



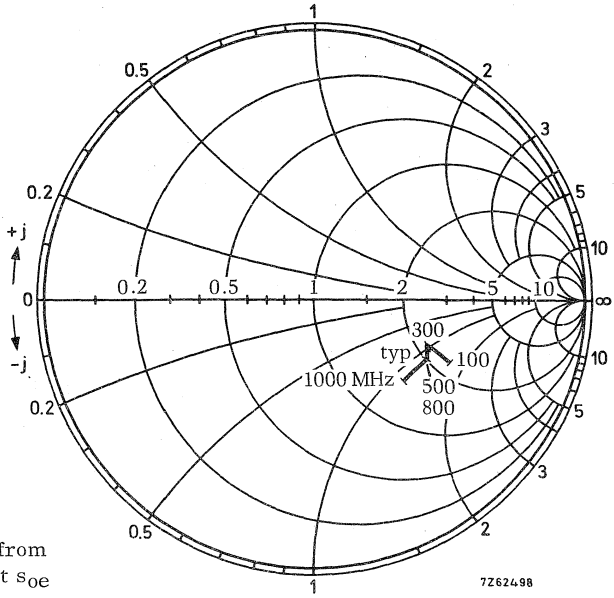
Input impedance derived from
input reflection coefficient s_{ie}
coordinates in ohm x 50

$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



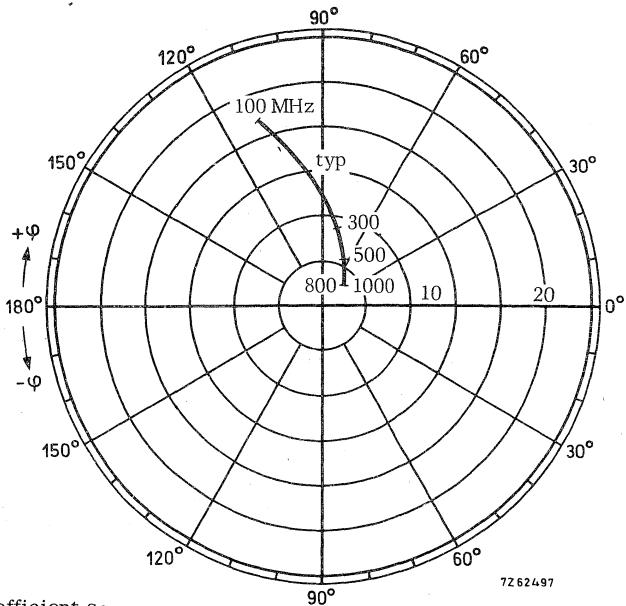
Reverse transmission coefficient s_{re}

$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



Output impedance derived from output reflection coefficient s_{oe} coordinates in ohm x 50

$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



Forward transmission coefficient s_{fe}

SILICON PLANAR EPITAXIAL TRANSISTORS

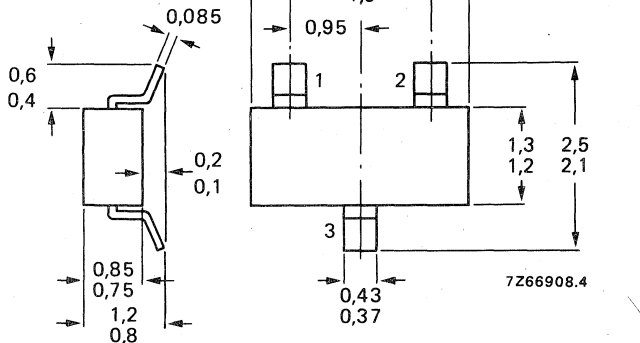
N-P-N transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc. The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

QUICK REFERENCE DATA

| | | | |
|---|-----------|------|--------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 20 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 15 V |
| Collector current (d.c.) | I_C | max. | 25 mA |
| Total power dissipation up to $T_{amb} = 60\text{ °C}$ | P_{tot} | max. | 200 mW |
| Junction temperature | T_j | max. | 150 °C |
| Transition frequency at $f = 500\text{ MHz}$ $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$ | f_T | typ. | 5 GHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ °C}$ | C_{re} | typ. | 0,7 pF |
| Noise figure at optimum source impedance $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | F | typ. | 2,4 dB |
| Max. unilateral power gain (see page 3) $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | G_{UM} | typ. | 18 dB |
| Intermodulation distortion at $T_{amb} = 25\text{ °C}$ $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $V_O = 150\text{ mV}$ $f(p+q-r) = 493,25\text{ MHz}$ (see page 4) | d_{im} | typ. | -60 dB |

MECHANICAL DATA

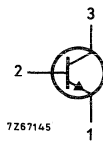
Fig. 1 SOT-23. 0,115



See also *Soldering recommendations*.

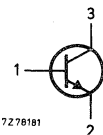
Marking code

BFR92 = P1



7267145

BFR92R = P4



7278181

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|----------------|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 20 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 15 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2,0 V |
| Collector current (d.c.) | I_C | max. | 25 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ °C}$ ** | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to +150 °C |
| Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain [▲]

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$h_{FE} > \begin{matrix} 25 \\ \text{typ. } 50 \end{matrix}$$

Transition frequency at $f = 500\text{ MHz}$ [▲]

$$I_C = 14\text{ mA}; V_{CE} = 10\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,75\text{ pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 0,8\text{ pF}$$

Feedback capacitance at $f = 1\text{ MHz}$

$$I_C = 2\text{ mA}; V_{CE} = 10\text{ V}; T_{amb} = 25\text{ °C}$$

$$C_{re} \text{ typ. } 0,7\text{ pF}$$

[▲] Measured under pulse conditions.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Noise figure at optimum source impedance *

$I_C = 2 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

F typ. 2,4 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$I_C = 14 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

G_{UM} typ. 18 dB

Intermodulation distortion at $T_{amb} = 25 \text{ }^\circ\text{C}$

$I_C = 14 \text{ mA}; V_{CE} = 10 \text{ V}; R_L = 75 \text{ } \Omega; \text{V.S.W.R.} < 2$

$V_p = V_o = 150 \text{ mV}$ at $f_p = 495,25 \text{ MHz}$

$V_q = V_o - 6 \text{ dB}$ at $f_q = 503,25 \text{ MHz}$

$V_r = V_o - 6 \text{ dB}$ at $f_r = 505,25 \text{ MHz}$

Measured at $f(p + q - r) = 493,25 \text{ MHz}$

d_{im} typ. -60 dB

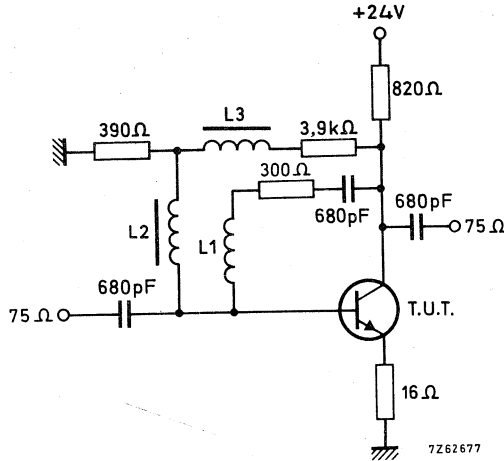


Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35 mm); winding pitch 1 mm; int. dia. 4 mm
L2 = L3 = 5 μH (code number: 3122 108 20150)

* Crystal mounted in a BFR90 envelope.

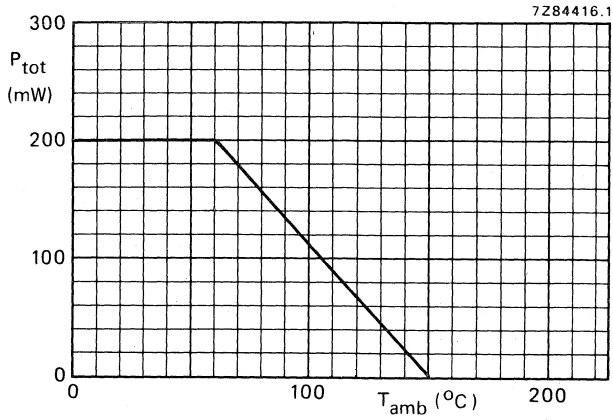
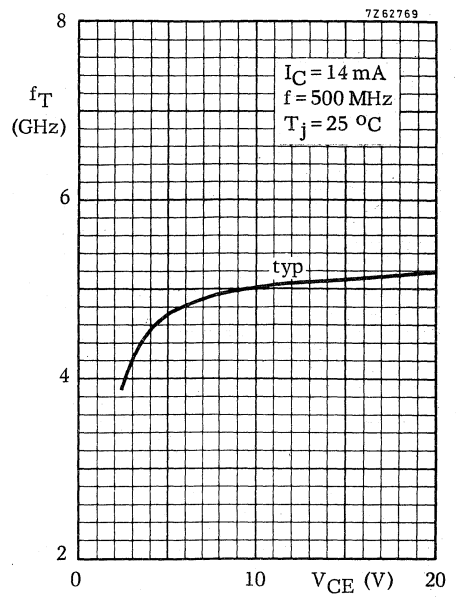
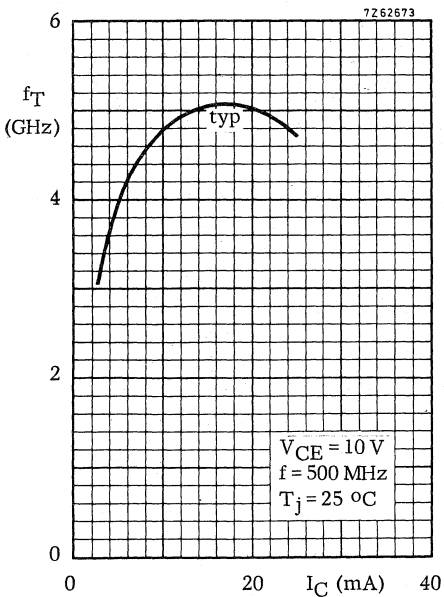
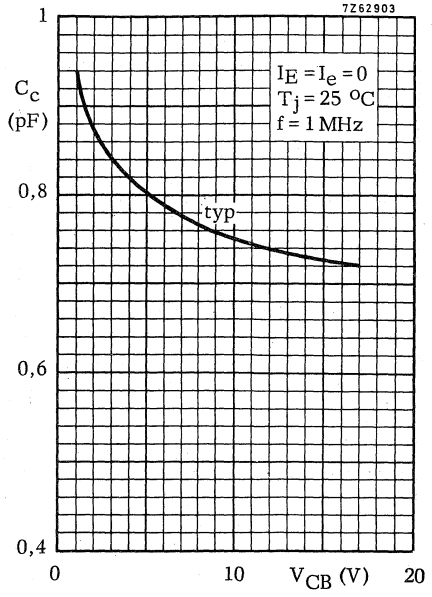
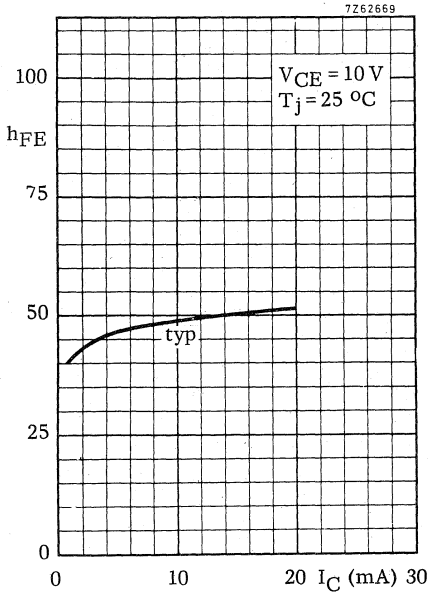
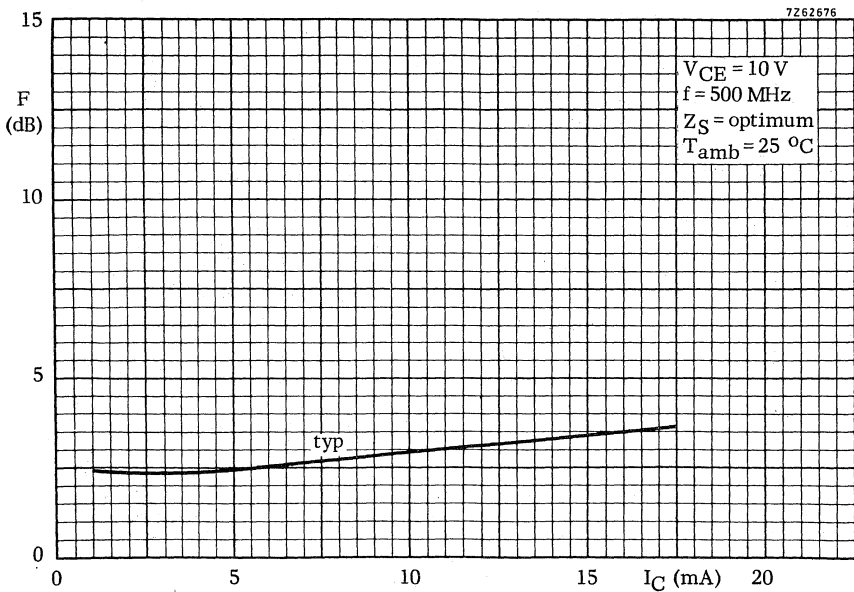
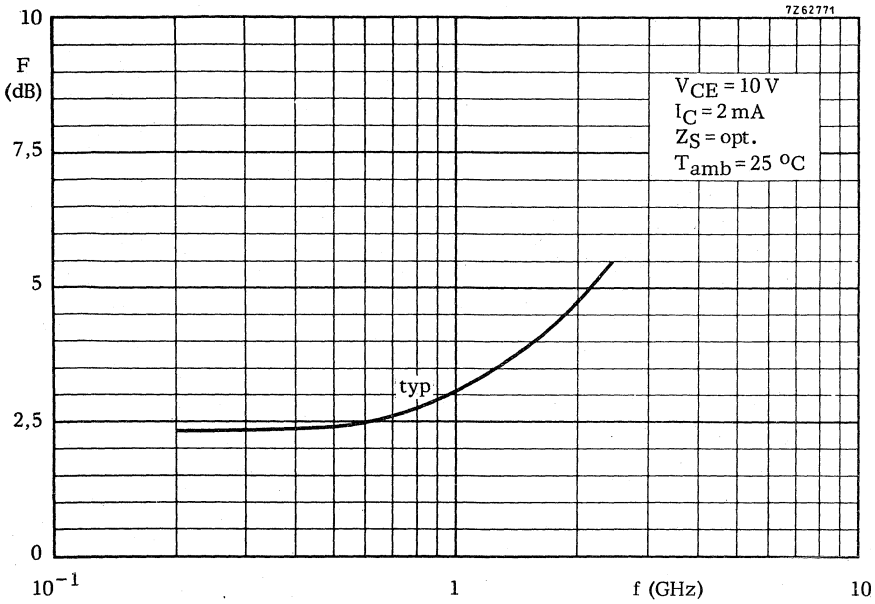
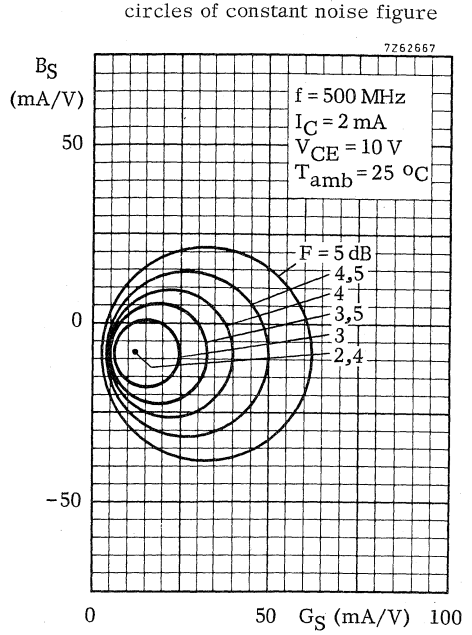
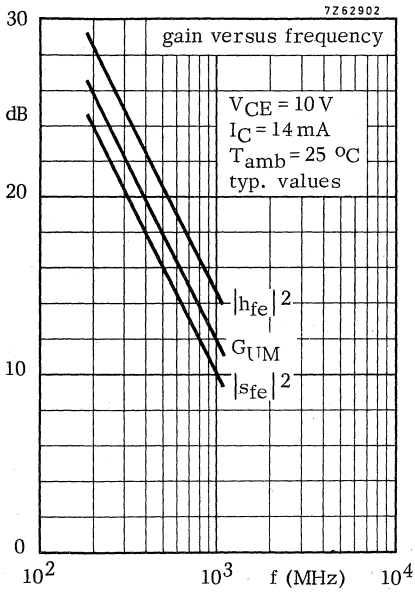


Fig. 3 Power derating curve.

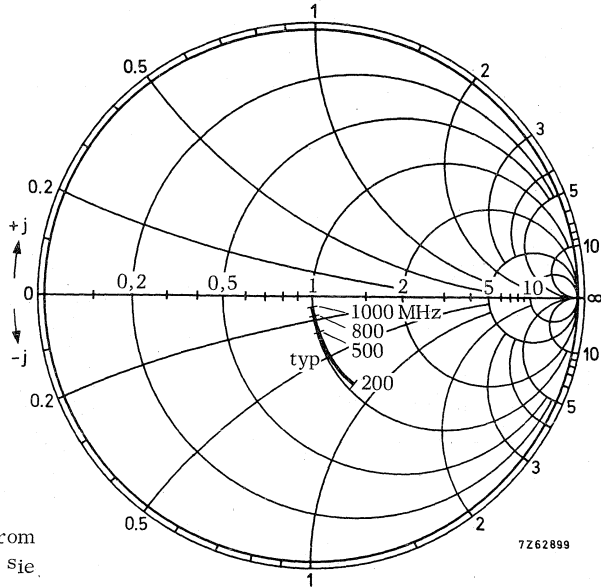






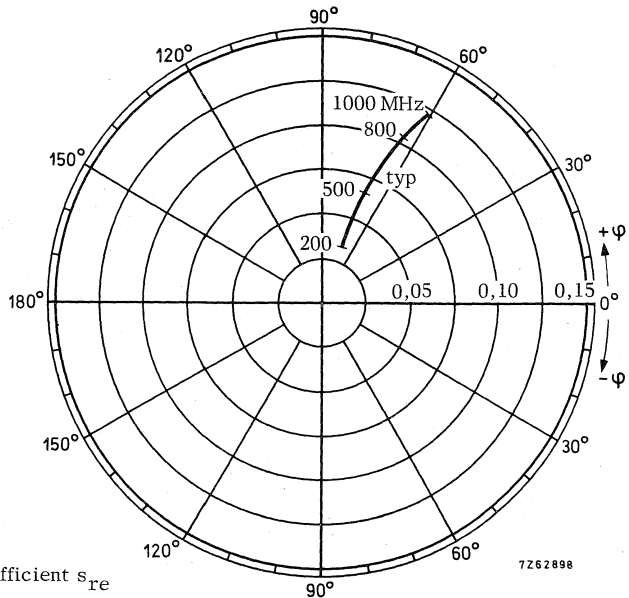


$V_{CE} = 10\text{ V}$
 $I_C = 14\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



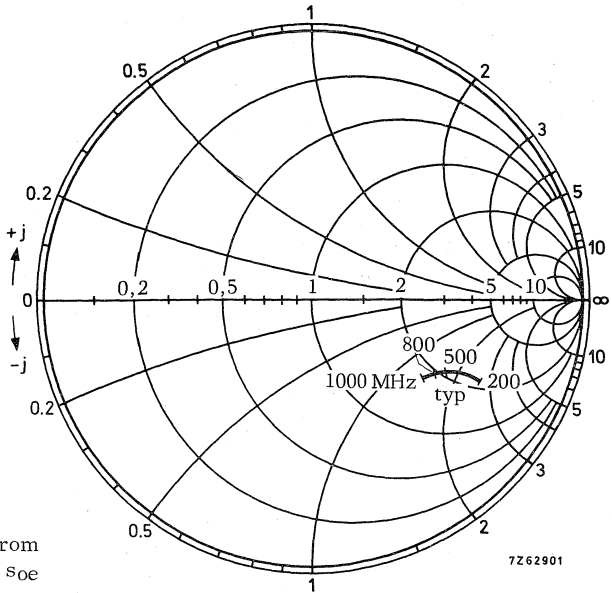
Input impedance derived from
input reflection coefficient s_{ie}
coordinates in ohm x 50

$V_{CE} = 10\text{ V}$
 $I_C = 14\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$

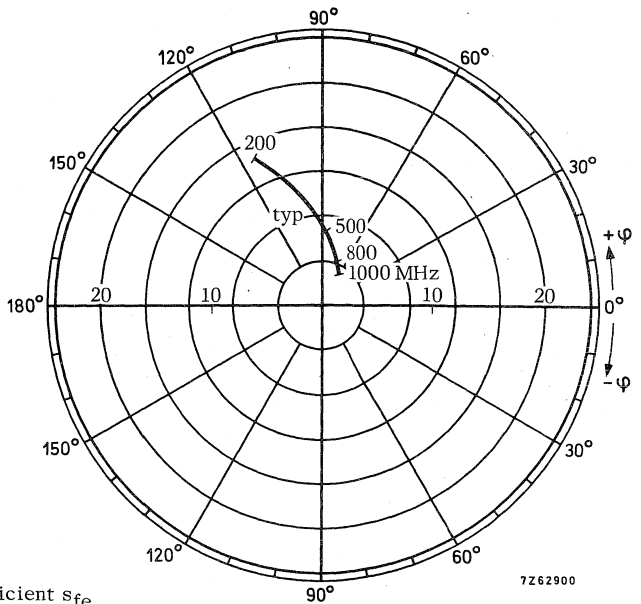


Reverse transmission coefficient s_{re}

$V_{CE} = 10 \text{ V}$
 $I_C = 14 \text{ mA}$
 $T_{amb} = 25 \text{ }^\circ\text{C}$



$V_{CE} = 10 \text{ V}$
 $I_C = 14 \text{ mA}$
 $T_{amb} = 25 \text{ }^\circ\text{C}$



SILICON PLANAR EPITAXIAL TRANSISTORS

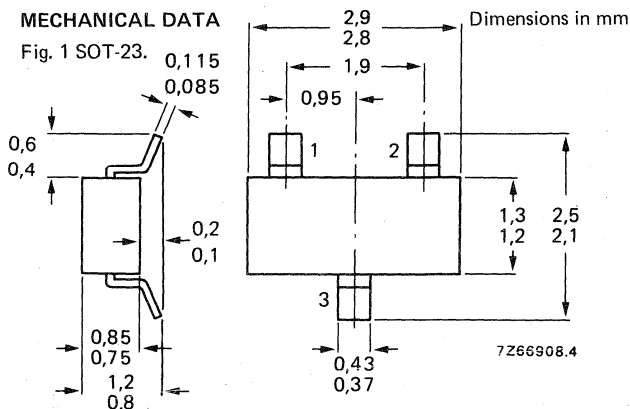
N-P-N transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers etc. The transistor features very low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

QUICK REFERENCE DATA

| | | | |
|---|-----------------|------|----------------------|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 15 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 12 V |
| Collector current (d.c.) | I_C | max. | 35 mA |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} | max. | 200 mW |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 500\text{ MHz}$ $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$ | f_T | typ. | 5 GHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | C_{re} | typ. | 0,8 pF |
| Noise figure at optimum source impedance $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | F | typ. | 1,9 dB |
| Max. unilateral power gain (see page 3) $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | G _{UM} | typ. | 16,5 dB |
| Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $R_L = 75\text{ }\Omega$; $V_o = 300\text{ mV}$ $f_{(p+q-r)} = 493,25\text{ MHz}$ (see page 4) | d_{im} | typ. | -60 dB |

MECHANICAL DATA

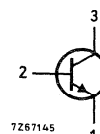
Fig. 1 SOT-23.



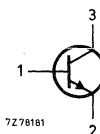
See also *Soldering recommendations*.

Marking code

BFR93 = R1



BFR93R = R4



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|----------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 15 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 12 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2,0 V |
| Collector current (d.c.) | I_C | max. | 35 mA |
| → Total power dissipation up to $T_{amb} = 60\text{ °C}^{**}$ | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to +150 °C |
| Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10\text{ V}$$

$$I_{CBO} < 50\text{ nA}$$

D.C. current gain [▲]

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \text{typ. } 25$$

Transition frequency at $f = 500\text{ MHz}$ [▲]

$$I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,7\text{ pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 1,8\text{ pF}$$

Feedback capacitance at $f = 1\text{ MHz}$

$$I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; T_{amb} = 25\text{ °C}$$

$$C_{re} \text{ typ. } 0,8\text{ pF}$$

▲ Measured under pulse conditions.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Noise figure at optimum source impedance *

 $I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

F typ. 1,9 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

 $I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

GUM typ. 16,5 dB

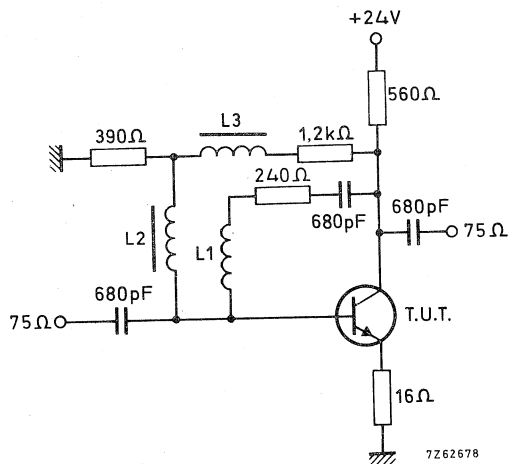
Intermodulation distortion at $T_{amb} = 25 \text{ }^\circ\text{C}$ * $I_C = 30 \text{ mA}; V_{CE} = 5 \text{ V}; R_L = 75 \text{ } \Omega; \text{V.S.W.R.} < 2$ $V_p = V_o = 300 \text{ mV}$ at $f_p = 495,25 \text{ MHz}$ $V_q = V_o - 6 \text{ dB}$ at $f_q = 503,25 \text{ MHz}$ $V_r = V_o - 6 \text{ dB}$ at $f_r = 505,25 \text{ MHz}$ Measured at $f(p + q - r) = 493,25 \text{ MHz}$ d_{im} typ. -60 dB

Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35); winding pitch 1 mm; int. dia. 4 mm
 L2 and L3 5 μH (code number: 3122 108 20150)

* Crystal mounted in a BFR91 envelope.

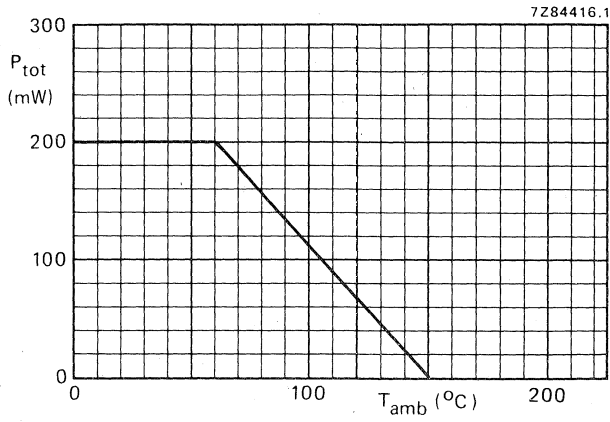
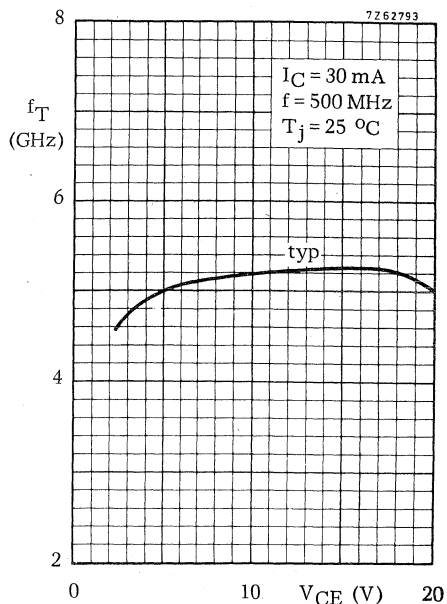
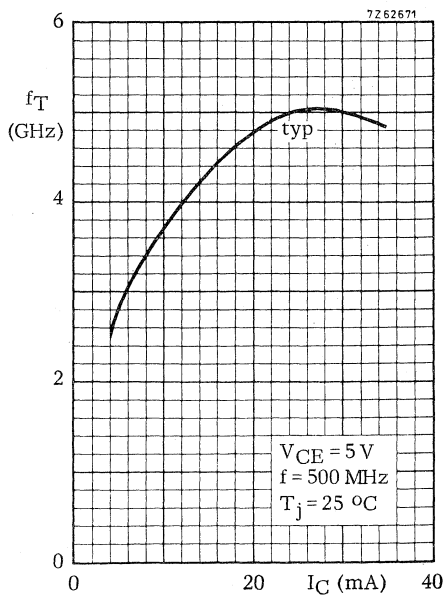
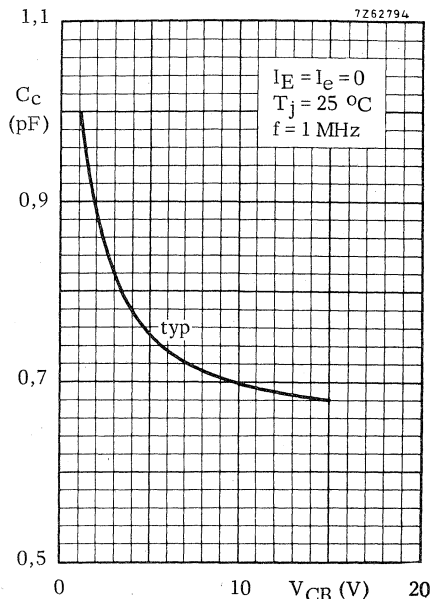
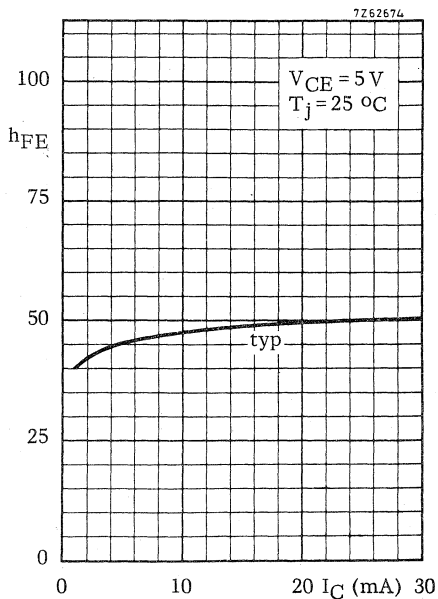
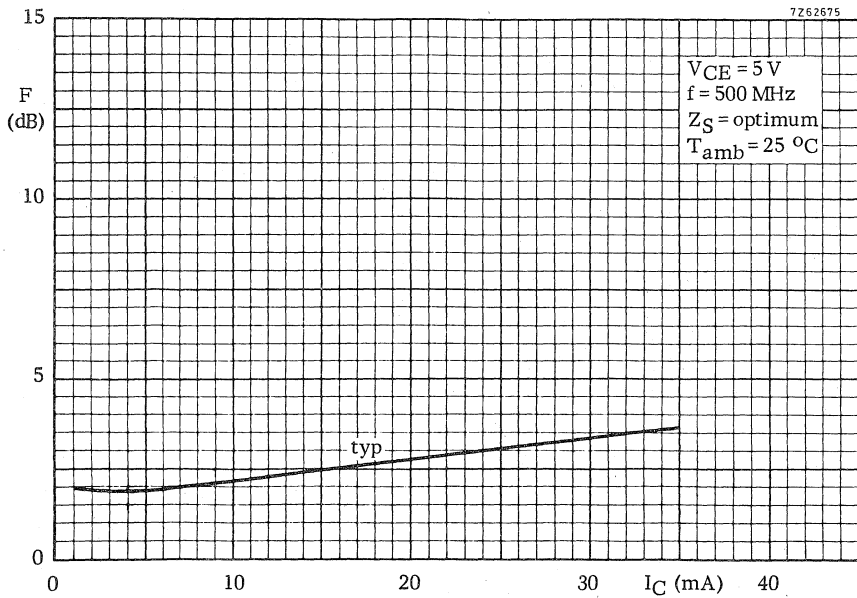
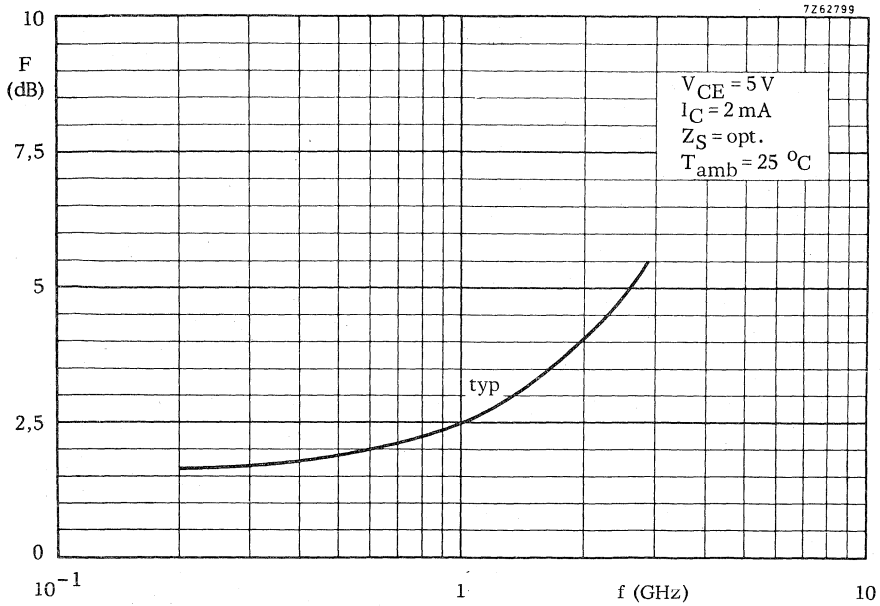
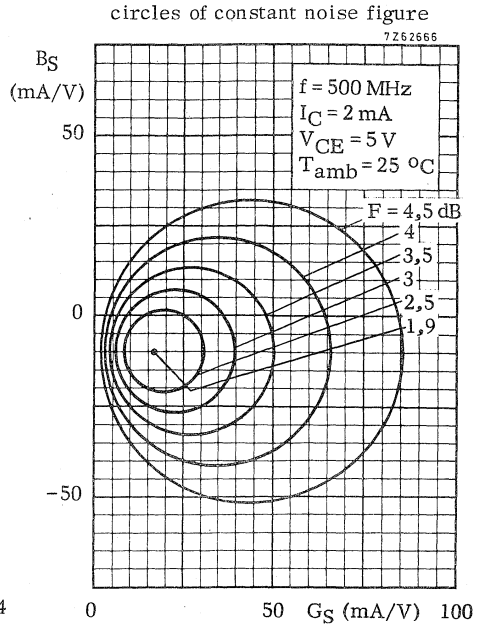
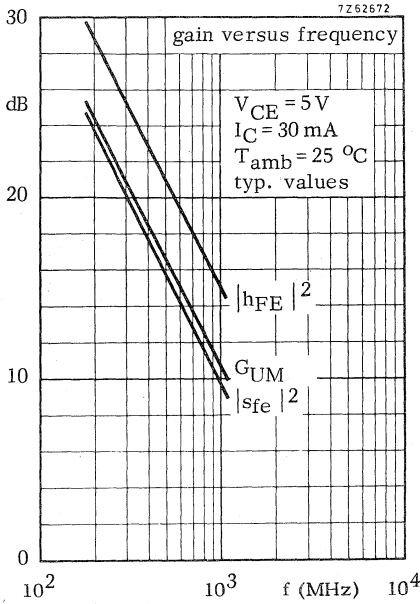


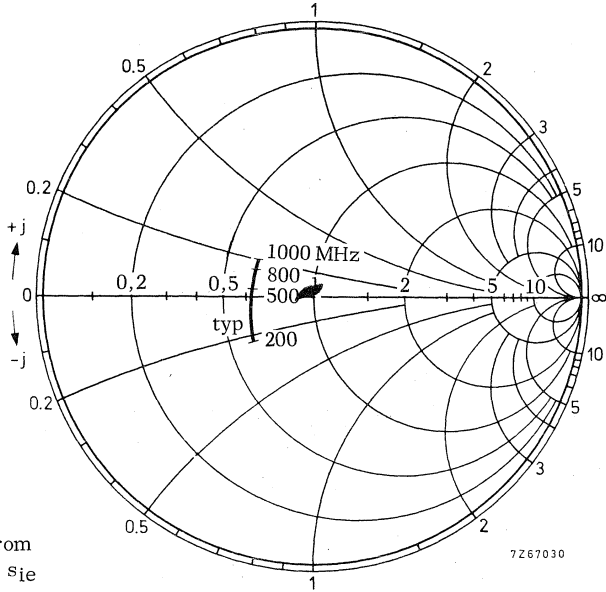
Fig. 3 Power derating curve.





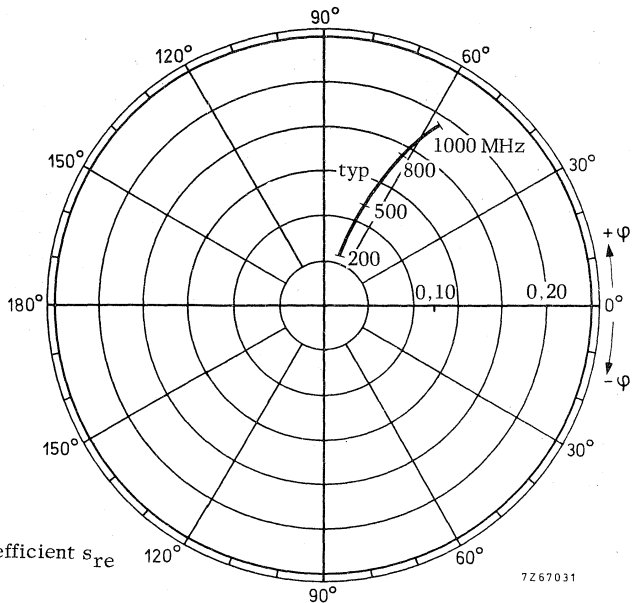


$V_{CE} = 5 \text{ V}$
 $I_C = 30 \text{ mA}$
 $T_{amb} = 25 \text{ }^\circ\text{C}$



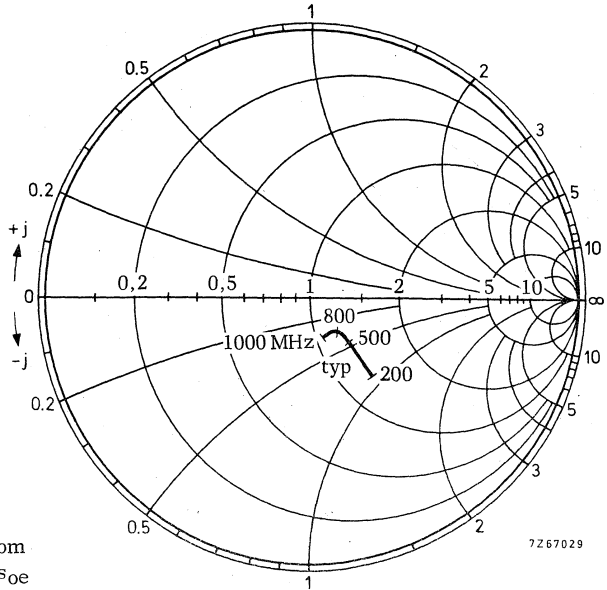
Input impedance derived from
input reflection coefficient s_{ie}
coordinates in ohm x 50

$V_{CE} = 5 \text{ V}$
 $I_C = 30 \text{ mA}$
 $T_{amb} = 25 \text{ }^\circ\text{C}$

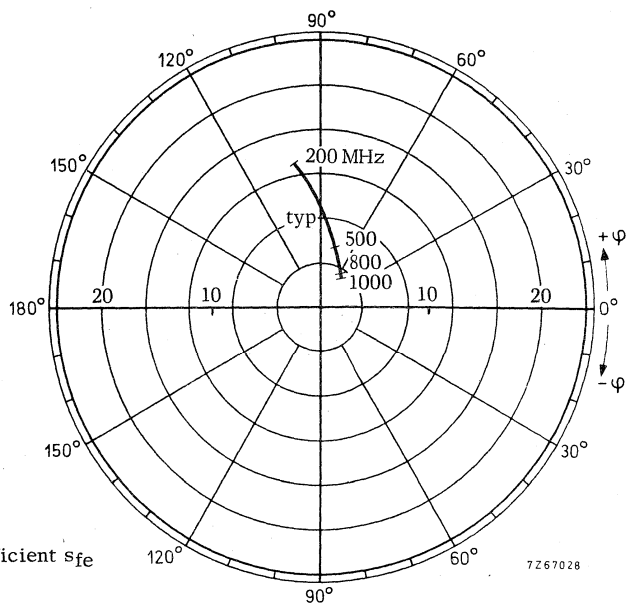


Reverse transmission coefficient s_{re}

$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



$V_{CE} = 5\text{ V}$
 $I_C = 30\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor in a microminiature plastic envelope. It is intended for a wide range of v.h.f. and u.h.f. applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|--|-----------------|------------------------|---|
| Collector-base voltage (open emitter; peak value) | V_{CBOM} max. | 25 V | |
| Collector-emitter voltage (open base) | V_{CEO} max. | 15 V | |
| Collector current (peak value) | I_{CM} max. | 50 mA | |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} max. | 250 mW | ← |
| Junction temperature | T_j max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain $I_C = 2\text{ mA}; V_{CE} = 1\text{ V}$ | h_{FE} | 20 to 150 | |
| Transition frequency $I_C = 25\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ | f_T typ. | 1,3 GHz | |
| Noise figure $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; R_S = 50\text{ }\Omega; f = 500\text{ MHz}$ | F typ. | 4,5 dB | |

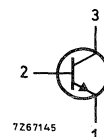
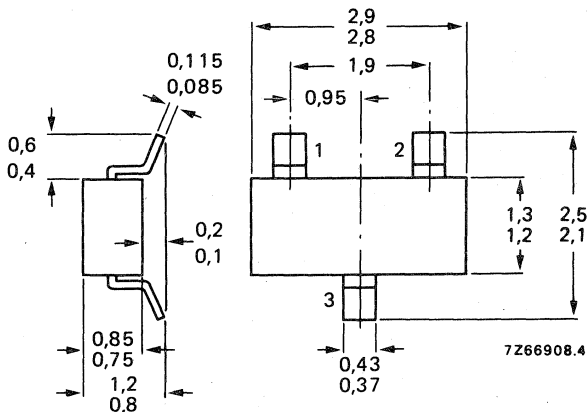
MECHANICAL DATA

Fig. 1 SOT-23.

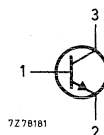
Dimensions in mm

Marking code

BFS17 = E1



BFS17R = E4



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|------------|------|------------------------------|
| Collector-base voltage (open emitter; peak value) | V_{CBOM} | max. | 25 V |
| Collector-emitter voltage (open base) $I_C = 10 \text{ mA}$ | V_{CEO} | max. | 15 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2,5 V |
| Collector current (d.c.) | I_C | max. | 25 mA |
| Collector current (peak value) | I_{CM} | max. | 50 mA |
| → Total power dissipation up to $T_{amb} = 65 \text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 250 mW |
| → Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10 \text{ V}$$

$$I_{CBO} < 10 \text{ nA}$$

$$I_E = 0; V_{CB} = 10 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$$

$$I_{CBO} < 10 \text{ } \mu\text{A}$$

D.C. current gain

$$I_C = 2 \text{ mA}; V_{CE} = 1 \text{ V}$$

$$h_{FE} \quad 20 \text{ to } 150$$

$$I_C = 25 \text{ mA}; V_{CE} = 1 \text{ V}$$

$$h_{FE} > 20$$

Transition frequency

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}$$

$$f_T \quad \text{typ.} \quad 1,0 \text{ GHz}$$

$$I_C = 25 \text{ mA}; V_{CE} = 5 \text{ V}; f = 500 \text{ MHz}$$

$$f_T \quad \text{typ.} \quad 1,3 \text{ GHz}$$

Collector capacitance at $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10 \text{ V}$$

$$C_c < 1,5 \text{ pF}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Emitter capacitance at $f = 1 \text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5 \text{ V}$$

$$C_e < 2,0 \text{ pF}$$

Feedback capacitance at $f = 1 \text{ MHz}$

$$I_C = 1 \text{ mA}; V_{CE} = 5 \text{ V}$$

$$-C_{re} \text{ typ. } 0,65 \text{ pF}$$

Noise figure*

$$I_C = 2 \text{ mA}; V_{CE} = 5 \text{ V};$$

$$f = 500 \text{ MHz}; R_S = 50 \Omega$$

$$F \text{ typ. } 4,5 \text{ dB}$$

Intermodulation distortion

$$I_C = 10 \text{ mA}; V_{CE} = 6 \text{ V}; R_L = 37,5 \Omega; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$V_o = 100 \text{ mV at } f_p = 183 \text{ MHz}$$

$$V_o = 100 \text{ mV at } f_q = 200 \text{ MHz}$$

$$\text{measured at } f_{(2q-p)} = 217 \text{ MHz}$$

$$d_{im} \text{ typ. } -45 \text{ dB}$$

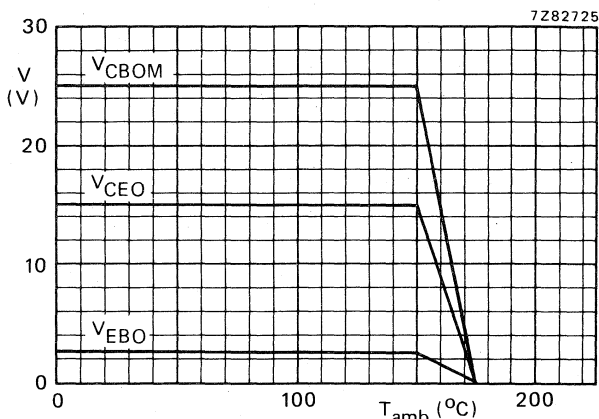


Fig. 2 Voltage derating curve.

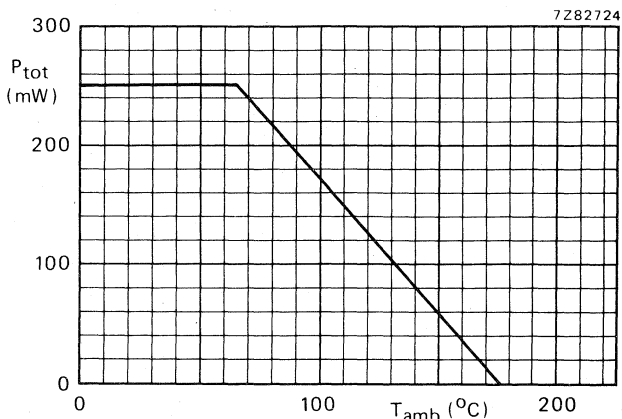
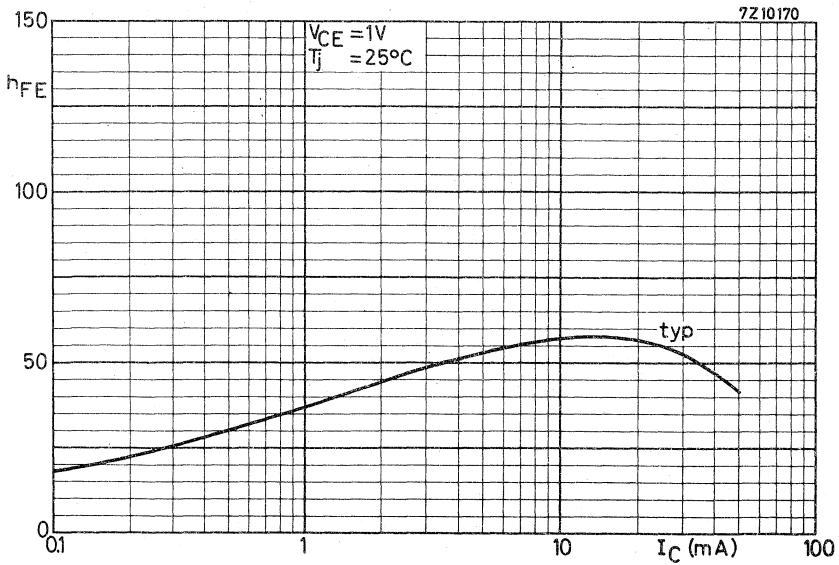
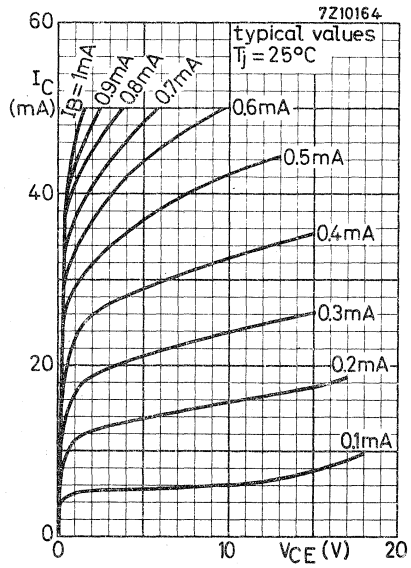
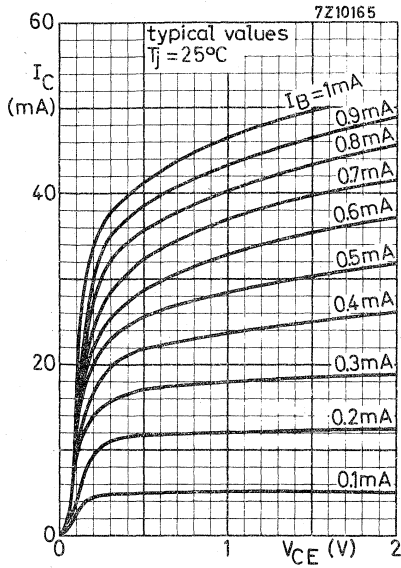
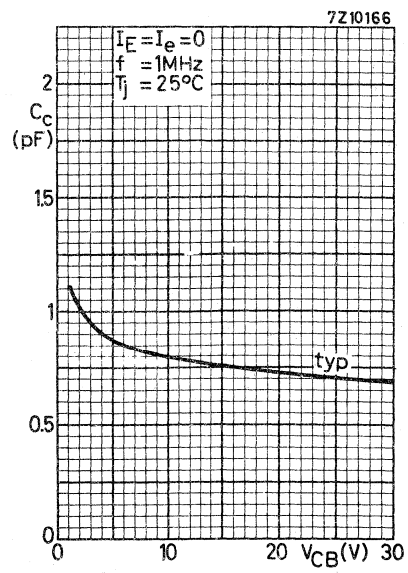
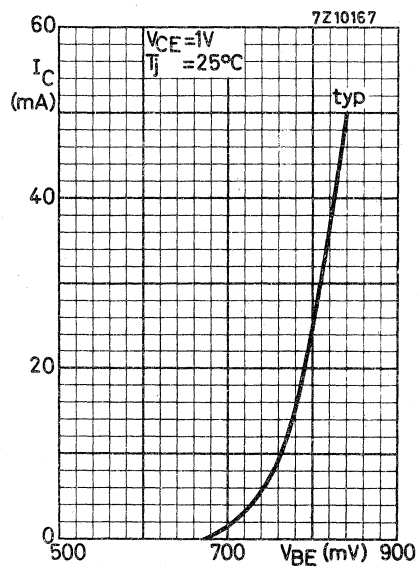
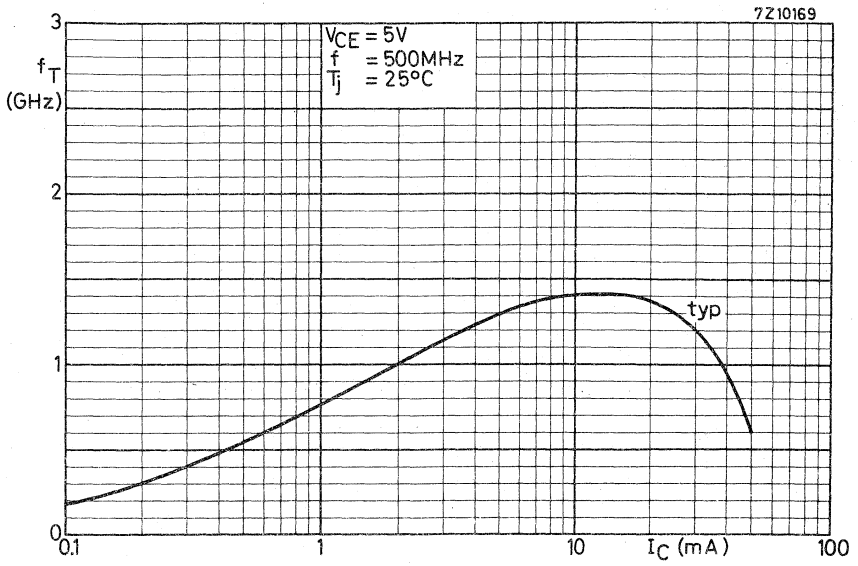
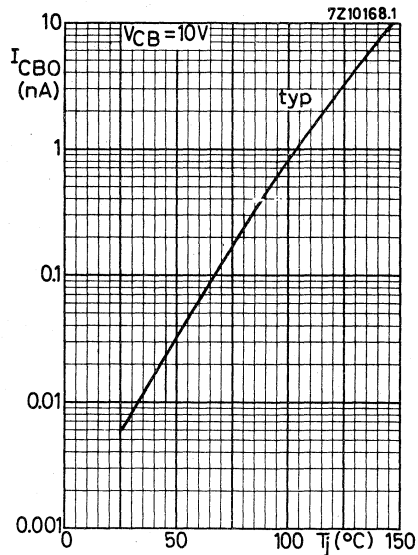
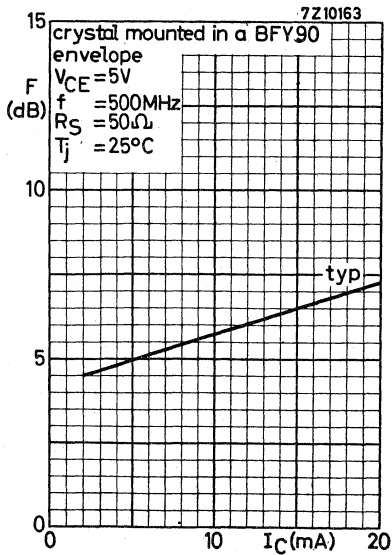
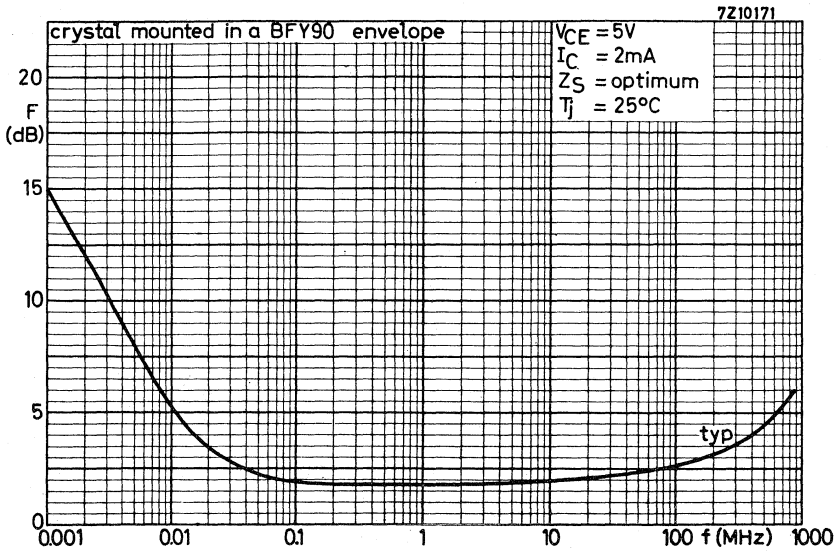


Fig. 3 Power derating curve.

* Crystal mounted in a BFY90 envelope.







SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in a microminiature plastic envelope. They are intended for general purpose and h.f. applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | | |
|---|-----------|------|-----------------|------------------|-----|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 30 | V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 20 | V | |
| Collector current (d.c.) | I_C | max. | 30 | mA | |
| Total power dissipation up to $T_{amb} = 65^\circ\text{C}$ | P_{tot} | max. | 250 | mW | ← |
| Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ | ← |
| D.C. current gain $I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$ | h_{FE} | | BFS18 BFS18R | BFS19 BFS19R | |
| Transition frequency at $f = 100\text{ MHz}$ $I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$ | f_T | typ. | 35 to 125 | 65 to 225 | |
| Noise figure at $f = 100\text{ MHz}$ $I_C = 1\text{ mA}; V_{CE} = 10\text{ V}; G_S = 10\text{ m}\Omega^{-1}$ | F | typ. | 200 | 260 | MHz |
| | | | 4 | | dB |

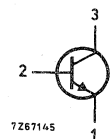
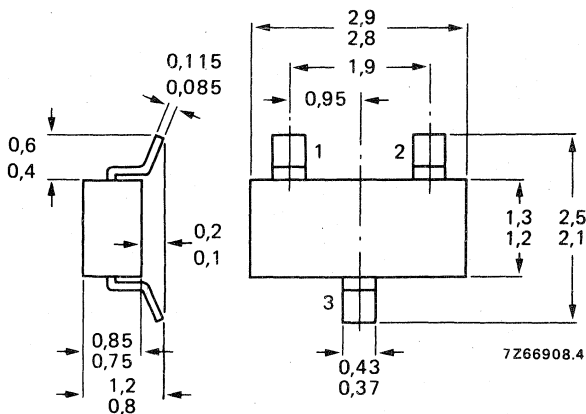
MECHANICAL DATA

Fig. 1 SOT-23.

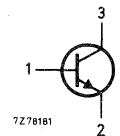
Dimensions in mm

Marking code

BFS18 = F1
BFS19 = F2



BFS18R = F4
BFS19R = F5



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | | |
|--|-----------|------|--------------|------------------|
| Collector-base voltage (open emitter) See Fig. 2 | V_{CBO} | max. | 30 | V |
| Collector-emitter voltage (open base) See Fig. 2 $I_C = 2 \text{ mA}$ | V_{CEO} | max. | 20 | V |
| Emitter-base voltage (open collector) See Fig. 2 | V_{EBO} | max. | 5 | V |
| Collector current (d.c.) | I_C | max. | 30 | mA |
| Collector current (peak value) | I_{CM} | max. | 30 | mA |
| → Total power dissipation up to $T_{amb} = 65 \text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 250 | mW |
| → Storage temperature | T_{stg} | | -65 to + 175 | $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 | $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | | |
|------------------------------------|--------------|---|-----|-----|
| From junction to tab | $R_{th j-t}$ | = | 60 | K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 | K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 | K/W |

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20 \text{ V}$ $I_{CBO} < 100 \text{ nA}$

$I_E = 0; V_{CB} = 20 \text{ V}; T_j = 100 \text{ }^\circ\text{C}$ $I_{CBO} < 10 \text{ } \mu\text{A}$

Base-emitter voltage

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$ $V_{BE} = 0,65 \text{ to } 0,74 \text{ V}$

D.C. current gain

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$ h_{FE}

| | | | |
|-----------------|-----------|-----------------|-----------|
| BFS18 BFS18R | 35 to 125 | BFS19 BFS19R | 65 to 225 |
|-----------------|-----------|-----------------|-----------|

Transition frequency at $f = 100 \text{ MHz}$

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$ f_T typ.

| | | |
|-----|-----|-----|
| 200 | 260 | MHz |
|-----|-----|-----|

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$ C_c typ.

| | |
|---|----|
| 1 | pF |
|---|----|

Feedback capacitance at $f = 1 \text{ MHz}$

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$ $-C_{re}$ typ.

| | |
|------|----|
| 0,85 | pF |
|------|----|

Noise figure Δ

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V};$
 $G_S = 10 \text{ m}\Omega^{-1}; f = 100 \text{ MHz}$ F typ.

| | |
|---|----|
| 4 | dB |
|---|----|

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Δ Crystal mounted in a BF115 envelope.

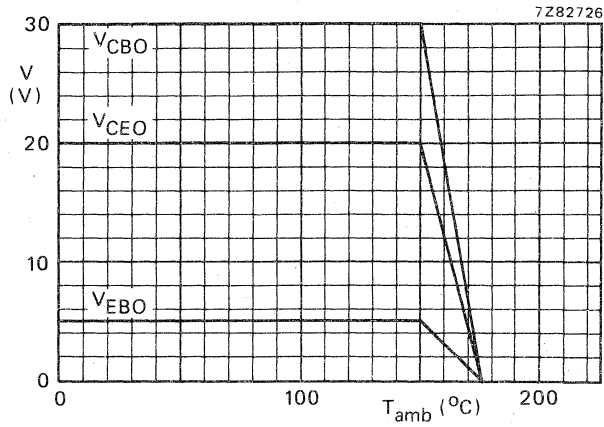


Fig. 2 Voltage derating curves.

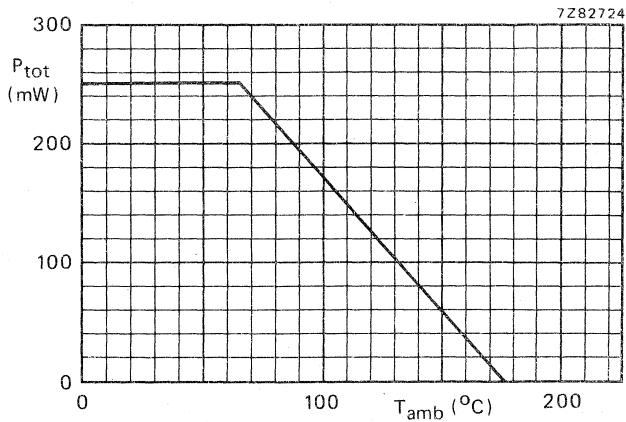
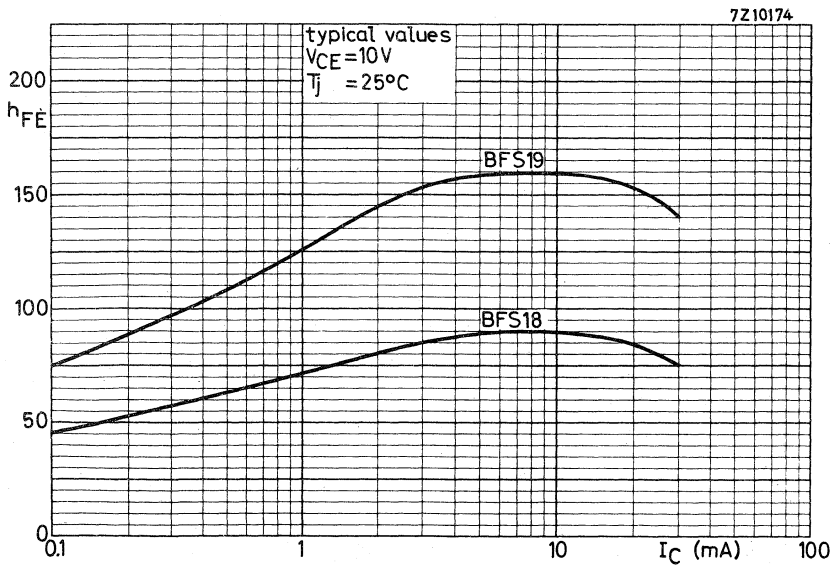
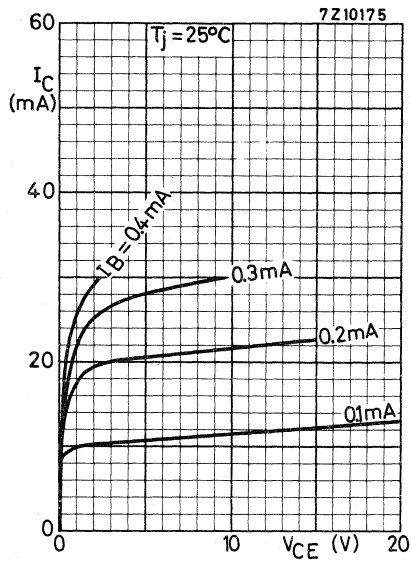
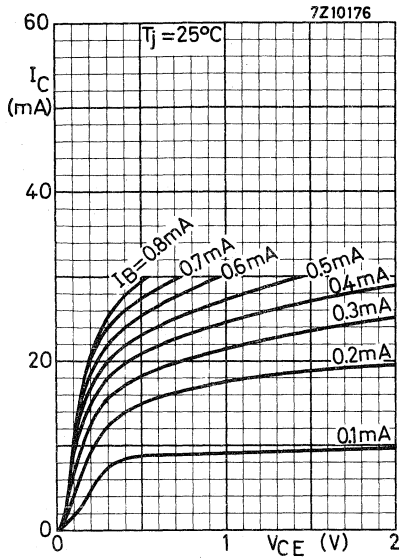
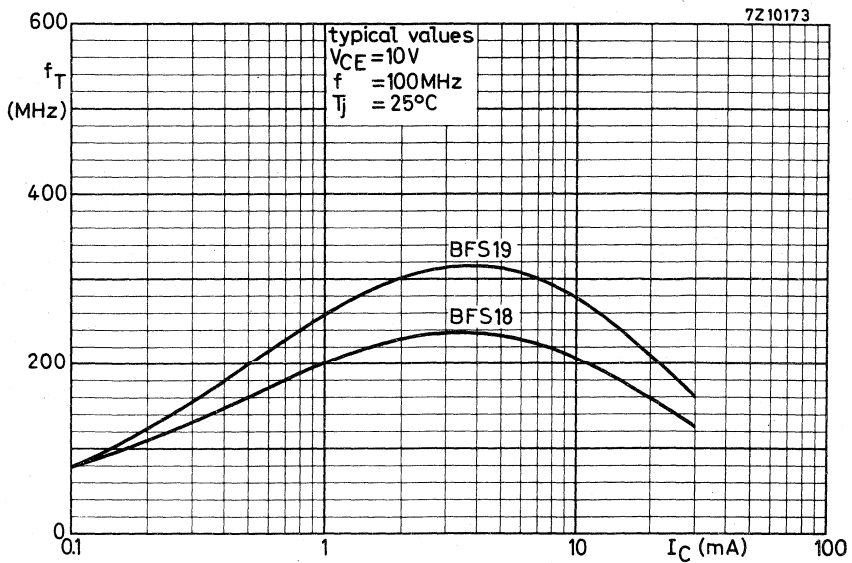
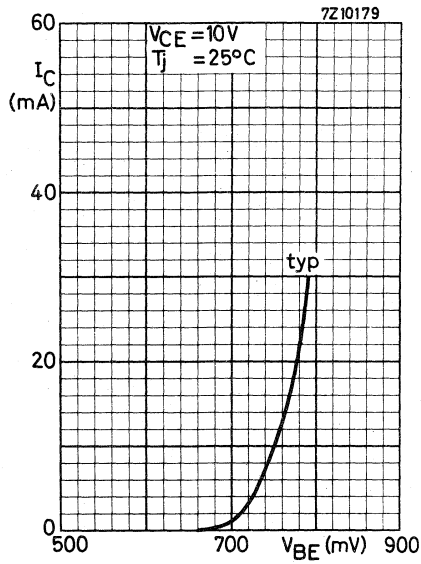


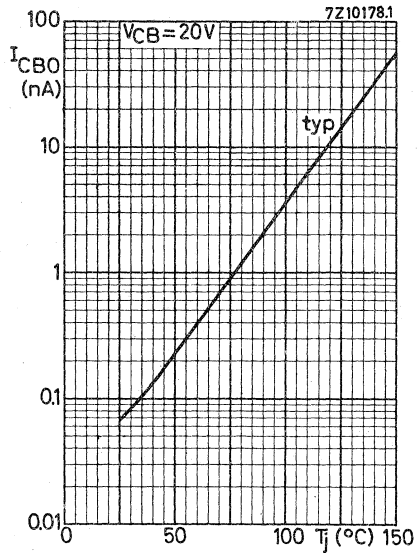
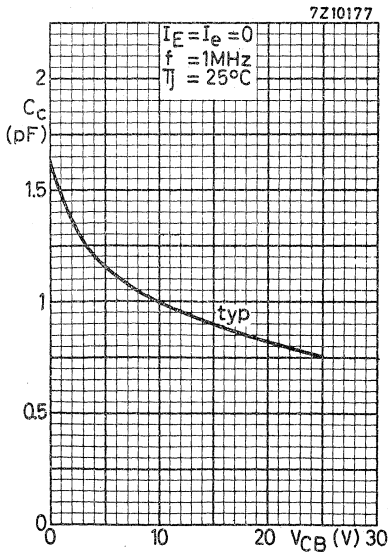
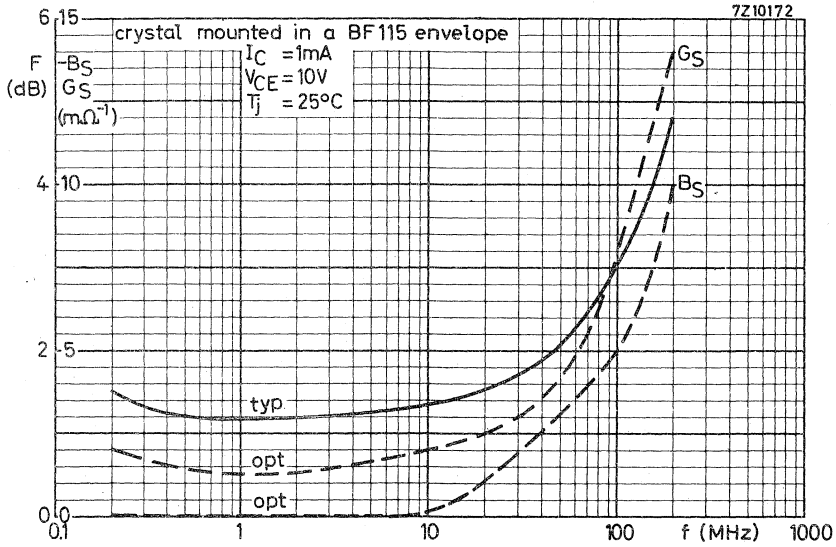
Fig. 3 Power derating curve.

BFS18
BFS19

Typical behaviour of collector current versus collector-emitter voltage







SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistor in a microminiature plastic envelope. It has a very low feedback capacitance and is intended for i.f. and v.h.f. applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|--|-----------|------|----------------------|---|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 30 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 20 V | |
| Collector current (d.c.) | I_C | max. | 25 mA | |
| Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}$ | P_{tot} | max. | 250 mW | ← |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ | ← |
| D.C. current gain | h_{FE} | > | 40 | |
| Transition frequency at $f = 100\text{ MHz}$ | f_T | typ. | 450 MHz | |
| Feedback capacitance at $f = 1\text{ MHz}$ | C_{re} | typ. | 350 fF | |
| $I_C = 7\text{ mA}; V_{CE} = 10\text{ V}$ | | | | |
| $I_C = 5\text{ mA}; V_{CE} = 5\text{ V}$ | | | | |
| $I_C = 1\text{ mA}; V_{CE} = 10\text{ V}$ | | | | |

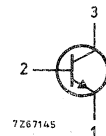
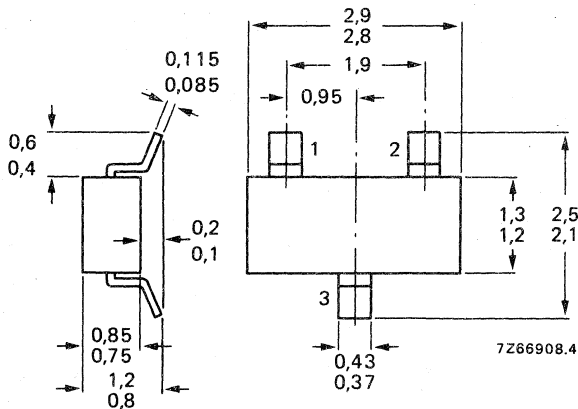
MECHANICAL DATA

Dimensions in mm

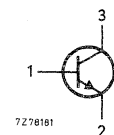
Marking code

Fig. 1 SOT-23.

BFS20 = G1



BFS20R = G4



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2

V_{CBO} max. 30 V

Collector-emitter voltage (open base) see Fig. 2

V_{CEO} max. 20 V

$I_C = 2$ mA

V_{EBO} max. 4 V

Emitter-base voltage (open collector) see Fig. 2

I_C max. 25 mA

Collector current (d.c.)

I_{CM} max. 25 mA

Collector current (peak value)

P_{tot} max. 250 mW

→ Total power dissipation up to $T_{amb} = 65$ °C**

T_{stg} -65 to +175 °C

→ Storage temperature

T_j max. 175 °C

→ Junction temperature

→ **THERMAL CHARACTERISTICS ***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

From junction to tab

$R_{th\ j-t} = 60$ K/W

From tab to soldering points

$R_{th\ t-s} = 260$ K/W

From soldering points to ambient **

$R_{th\ s-a} = 120$ K/W

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 20$ V

$I_{CBO} < 100$ nA

$I_E = 0; V_{CB} = 20$ V; $T_j = 100$ °C

$I_{CBO} < 10$ μA

Base-emitter voltage

$I_C = 7$ mA; $V_{CE} = 10$ V

V_{BE} typ. 740 mV
< 900 mV

D.C. current gain

$I_C = 7$ mA; $V_{CE} = 10$ V

$h_{FE} >$ typ. 40
85

Transition frequency at $f = 100$ MHz

$I_C = 5$ mA; $V_{CE} = 10$ V

$f_T >$ typ. 275 MHz
450 MHz

Collector capacitance at $f = 1$ MHz

$I_E = I_e = 0; V_{CB} = 10$ V

C_c typ. 0,8 pF

Feedback capacitance at $f = 1$ MHz

$I_C = 1$ mA; $V_{CE} = 10$ V

$-C_{re}$ typ. 350 fF

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

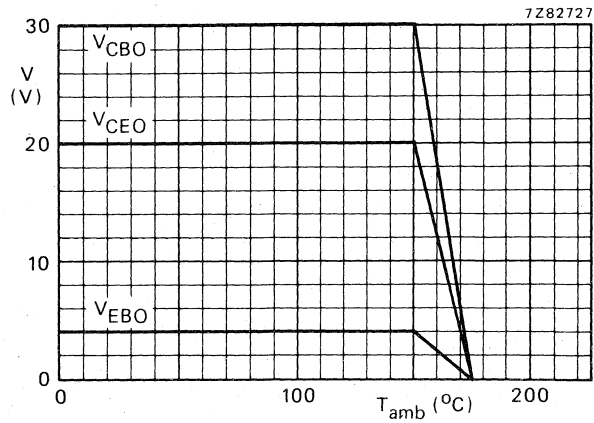


Fig. 2 Voltage derating curves.

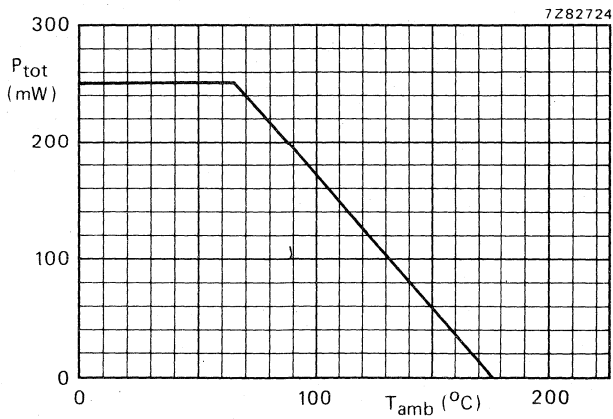
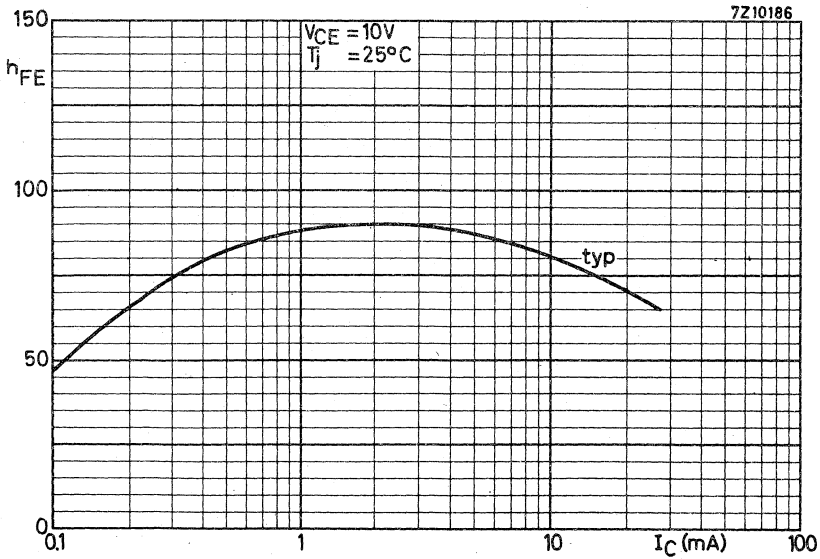
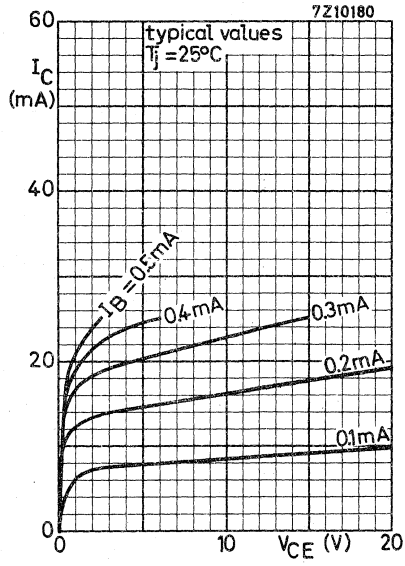
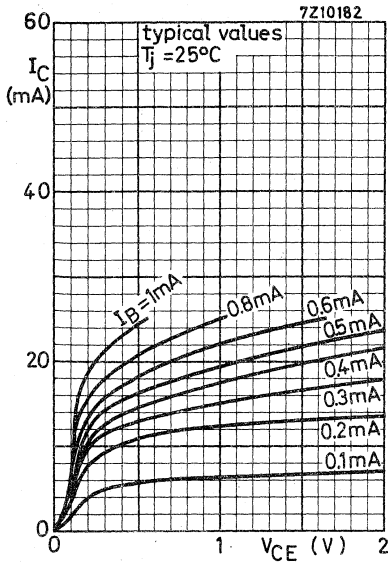
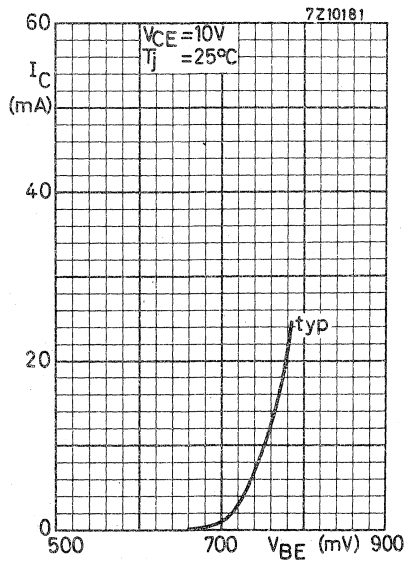
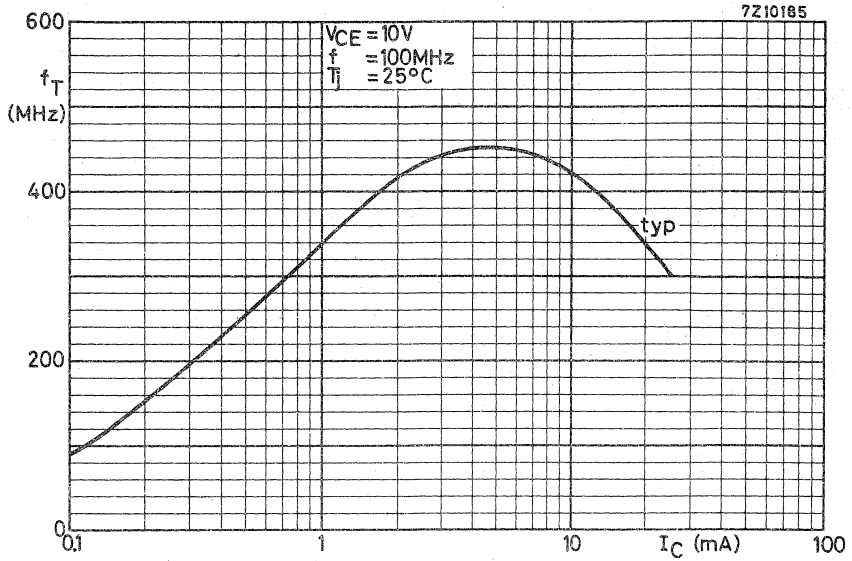
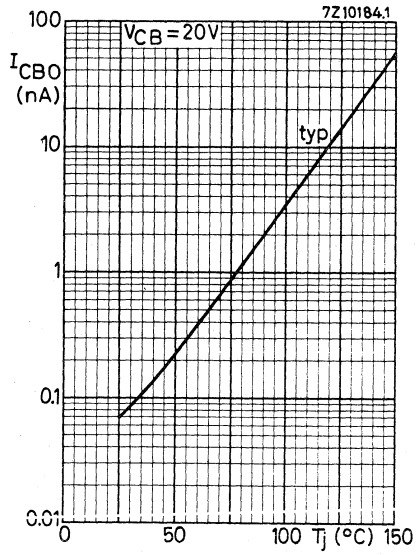
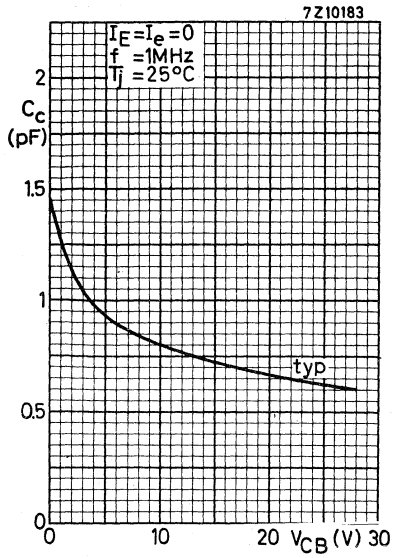


Fig. 3 Power derating curve.







SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistor in a microminiature plastic envelope, primarily intended for use in u.h.f. low power amplifiers in thick and thin-film circuits, such as in pocket phones, paging systems, etc. The transistor features low current consumption (100 μ A – 1 mA); thanks to its high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

QUICK REFERENCE DATA

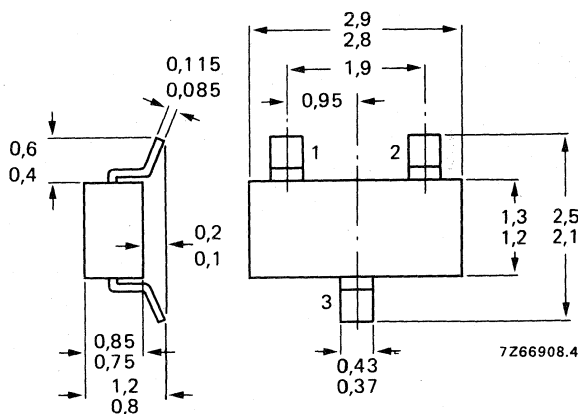
| | | | |
|--|-----------|------|----------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 8 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 2,5 mA |
| Total power dissipation up to $T_{amb} = 125\text{ }^\circ\text{C}$ | P_{tot} | max. | 50 mW |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 500\text{ MHz}$ $I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$ | f_T | typ. | 2,3 GHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $I_C = 1\text{ mA}; V_{CE} = 1\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$ | C_{re} | < | 0,45 pF |
| Noise figure at optimum source impedance $I_C = 1\text{ mA}; V_{CE} = 1\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | F | typ. | 3,8 dB |
| Max. unilateral power gain (see page 3) $I_C = 1\text{ mA}; V_{CE} = 1\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | GUM | typ. | 18 dB |

MECHANICAL DATA

Dimensions in mm

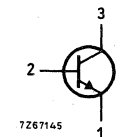
Marking code

Fig. 1 SOT-23.



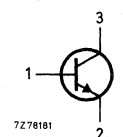
7Z67145

BFT25 = V1



7Z78181

BFT25R = V4



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|-----------|------|-----------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 8 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 5 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 2 V |
| Collector current (d.c.) | I_C | max. | 2,5 mA |
| Collector current (peak value; $f > 1$ MHz) | I_{CM} | max. | 5,0 mA |
| Total power dissipation up to $T_{amb} = 125$ °C** | P_{tot} | max. | 50 mW |
| Storage temperature | T_{stg} | | -65 to + 150 °C |
| Junction temperature | T_j | max. | 150 °C |

THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 5\text{ V}$$

| | | |
|-----------|---|-------|
| I_{CBO} | < | 50 nA |
|-----------|---|-------|

D.C. current gain Δ

$$I_C = 10\ \mu\text{A}; V_{CE} = 1\text{ V}$$

| | | |
|----------|------|----|
| h_{FE} | < | 20 |
| | typ. | 30 |

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

| | | |
|----------|------|----|
| h_{FE} | < | 20 |
| | typ. | 40 |

Saturation voltages

$$I_C = 10\ \mu\text{A}; I_B = 1\ \mu\text{A}$$

| | | |
|-------------|---|--------|
| V_{CEsat} | < | 200 mV |
| V_{BEsat} | < | 750 mV |

$$I_C = 1\text{ mA}; I_B = 0,1\text{ mA}$$

| | | |
|-------------|---|--------|
| V_{CEsat} | < | 175 mV |
| V_{BEsat} | < | 900 mV |

Transition frequency at $f = 500$ MHz Δ

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

| | | |
|-------|------|---------|
| f_T | > | 1,2 GHz |
| | typ. | 2,3 GHz |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Δ Measured under pulse conditions.

Collector capacitance at $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 0,5 \text{ V}$$

$$C_c < 0,6 \text{ pF}$$

Emitter capacitance at $f = 1 \text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0$$

$$C_e < 0,5 \text{ pF}$$

Feedback capacitance at $f = 1 \text{ MHz}$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$C_{re} < 0,45 \text{ pF}$$

Noise figure at optimum source impedance

$$I_C = 0,1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$F \text{ typ. } 5,5 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$F \text{ typ. } 3,8 \text{ dB}$$

Maximum unilateral power gain (s_{re} assumed to be zero)

$$G_{UM} \text{ (in dB)} = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 200 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 25 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 500 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 18 \text{ dB}$$

$$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; f = 800 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$$

$$G_{UM} \text{ typ. } 12 \text{ dB}$$

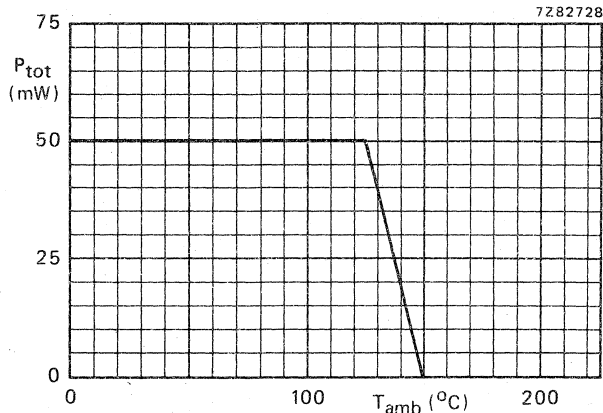
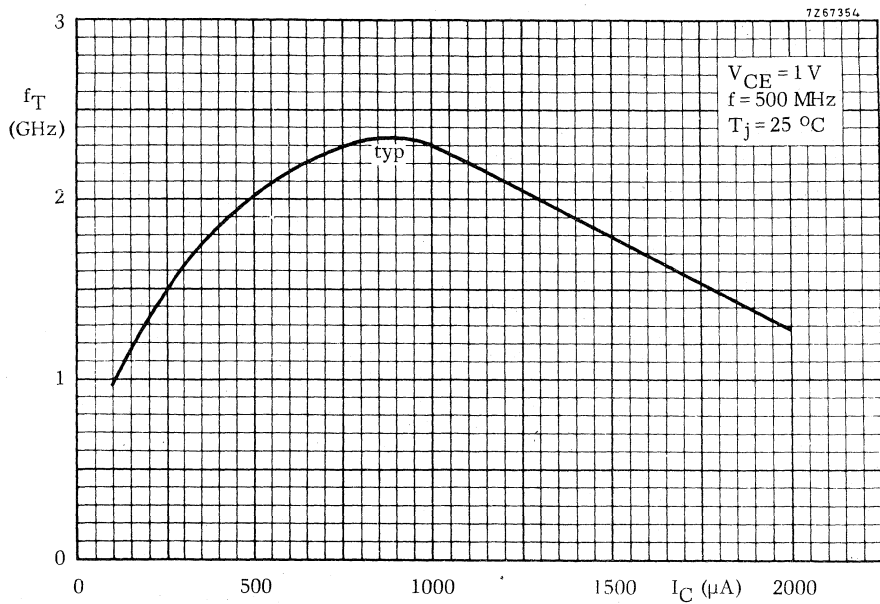
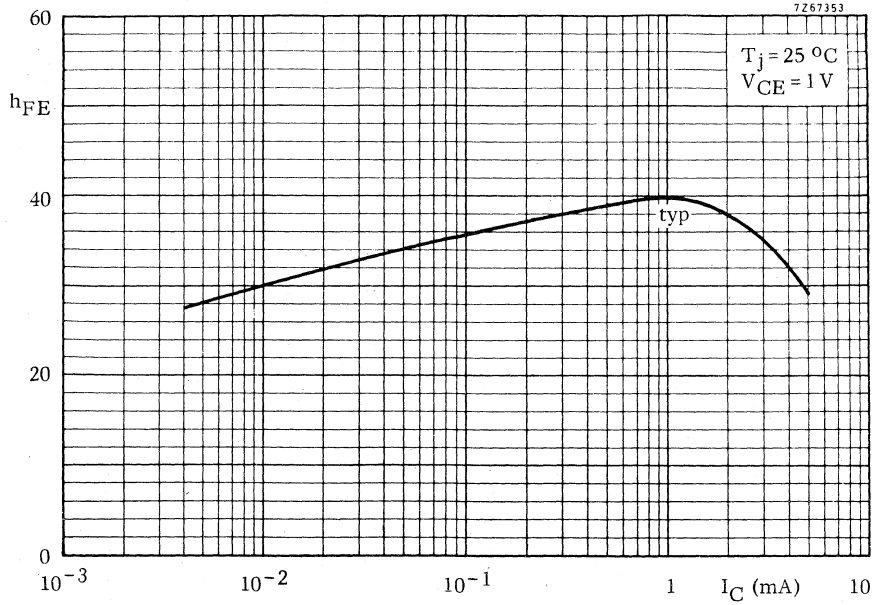
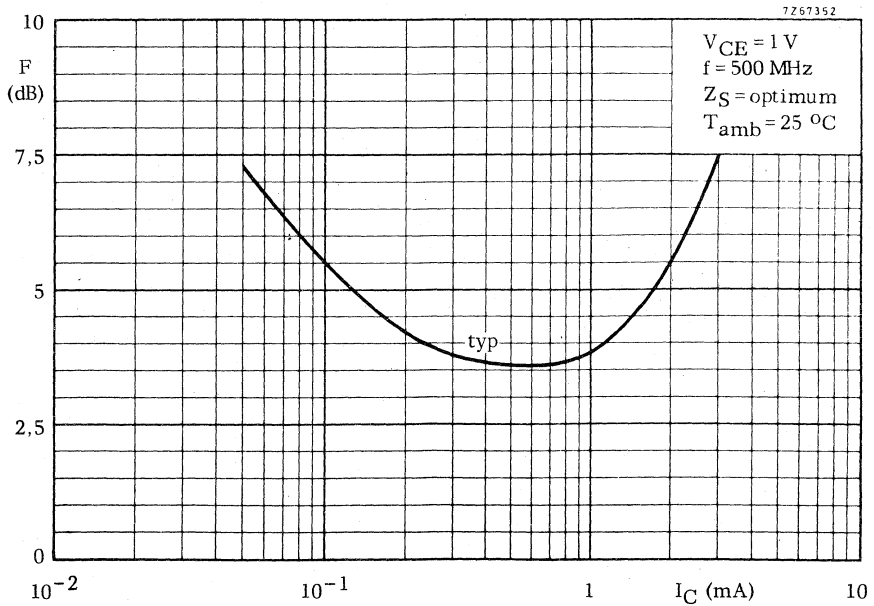
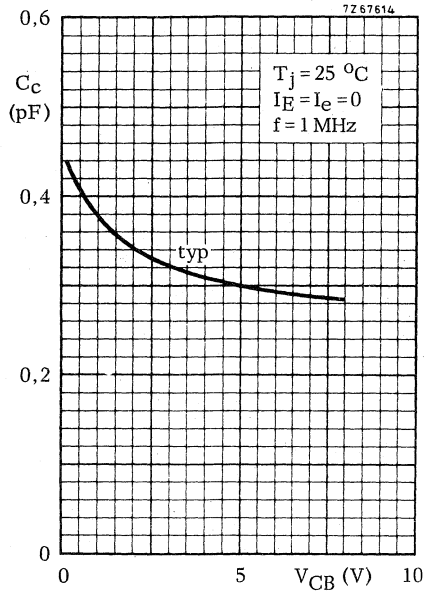
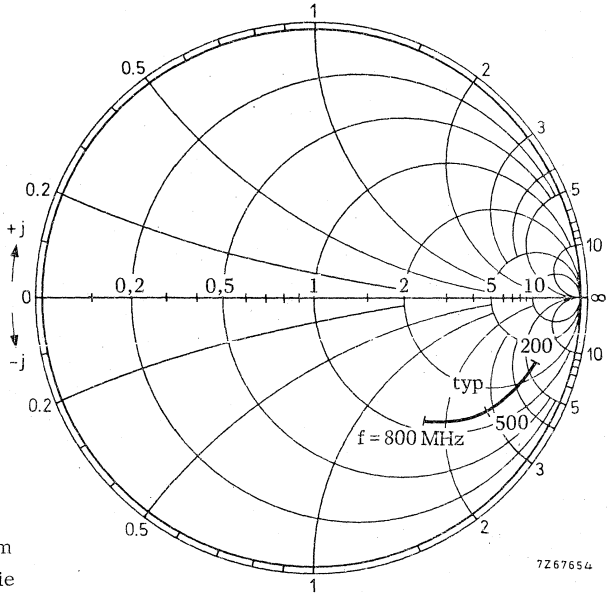


Fig. 2 Power derating curve.



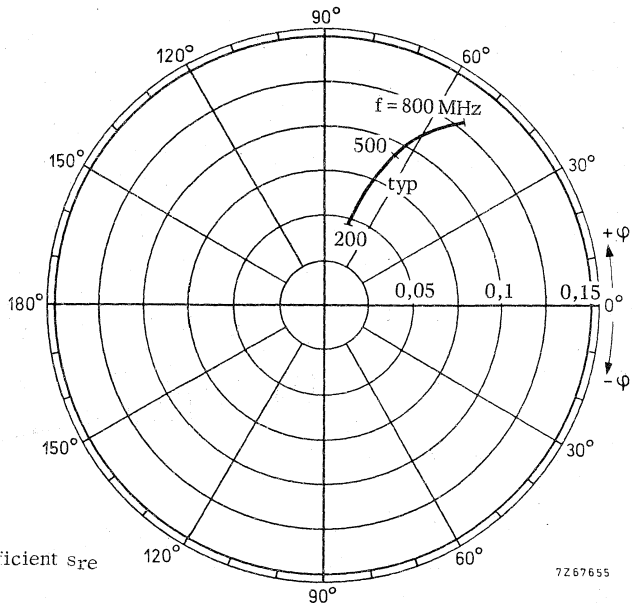


$V_{CE} = 1\text{ V}$
 $I_C = 1\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



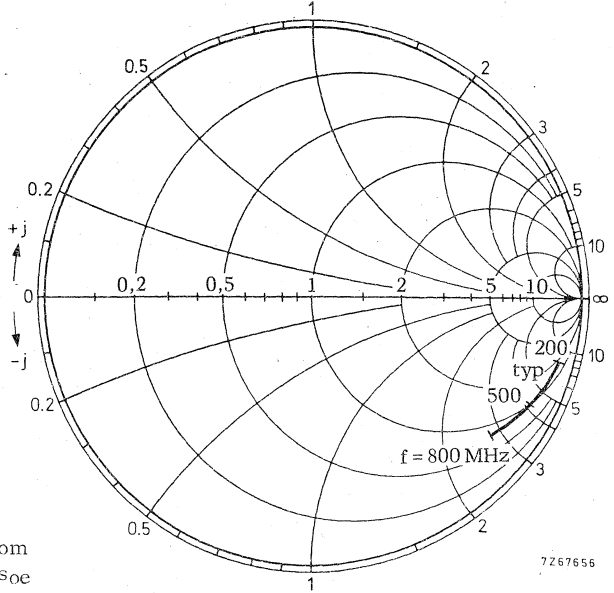
Input impedance derived from
input reflection coefficient s_{ie}
coordinates in ohm x 50

$V_{CE} = 1\text{ V}$
 $I_C = 1\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



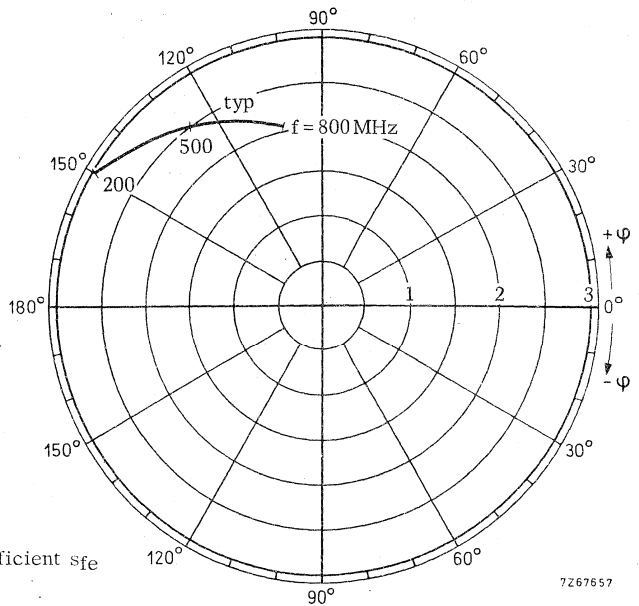
Reverse transmission coefficient s_{re}

$V_{CE} = 1\text{ V}$
 $I_C = 1\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



Output impedance derived from
 output reflection coefficient s_{oe}
 coordinates in ohm x 50

$V_{CE} = 1\text{ V}$
 $I_C = 1\text{ mA}$
 $T_{amb} = 25\text{ }^\circ\text{C}$



Forward transmission coefficient s_{fe}

N-CHANNEL SILICON FET

N-channel silicon epitaxial planar junction field-effect transistor in a microminiature plastic envelope. The transistor is intended for low level general purpose amplifiers in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | |
|---|--------------|------|-------------------|
| Drain-source voltage | $\pm V_{DS}$ | max. | 25 V |
| Gate-source voltage (open drain) | $-V_{GSO}$ | max. | 25 V |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 250 mW |
| Drain current $V_{DS} = 10\text{ V}; V_{GS} = 0$ | I_{DSS} | > | 0,2 mA |
| | | < | 1,5 mA |
| Transfer admittance (common source) $I_D = 0,2\text{ mA}; V_{DS} = 10\text{ V}; f = 1\text{ kHz}$ | $ y_{fs} $ | > | 0,5 mA/V |
| | | < | 0,5 μV |
| Equivalent noise voltage $V_{DS} = 10\text{ V}; I_D = 200\text{ }\mu\text{A}; B = 0,6\text{ to }100\text{ Hz}$ | V_n | < | 0,5 μV |

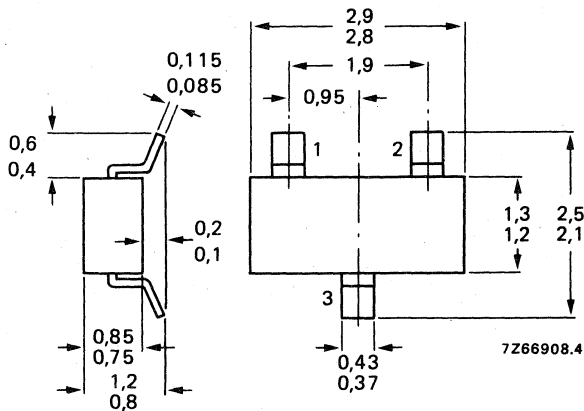
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BFT46 = M3



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|--------------|------|------------------------------|
| Drain-source voltage | $\pm V_{DS}$ | max. | 25 V |
| Drain-gate voltage (open source) | V_{DGO} | max. | 25 V |
| Gate-source voltage (open drain) | $-V_{GSO}$ | max. | 25 V |
| Drain current | I_D | max. | 10 mA |
| Gate current | I_G | max. | 5 mA |
| → Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}$ ** | P_{tot} | max. | 250 mW |
| → Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a} = \frac{T_j - T_{amb}}{P}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| | | | |
|---|------------|---|---------------------------|
| Gate cut-off current $-V_{GS} = 10\text{ V}; V_{DS} = 0$ | $-I_{GSS}$ | < | 0,2 nA |
| Drain current ** $V_{DS} = 10\text{ V}; V_{GS} = 0$ | I_{DSS} | > | 0,2 mA |
| Gate-source voltage $I_D = 50\text{ }\mu\text{A}; V_{DS} = 10\text{ V}$ | $-V_{GS}$ | > | 0,1 V |
| Gate-source cut-off voltage $I_D = 0,5\text{ nA}; V_{DS} = 10\text{ V}$ | $-V_{GS}$ | < | 1,0 V |
| Y parameters at $f = 1\text{ kHz};$ $V_{DS} = 10\text{ V}; V_{GS} = 0; T_{amb} = 25\text{ }^\circ\text{C}$ | $-V(P)GS$ | < | 1,2 V |
| Transfer admittance | $ y_{fs} $ | > | 1,0 mA/V |
| Output admittance $V_{DS} = 10\text{ V}; I_D = 200\text{ }\mu\text{A};$ | $ y_{os} $ | < | 10 $\mu\text{A}/\text{V}$ |
| Transfer admittance | $ y_{fs} $ | > | 0,5 mA/V |
| Output admittance | $ y_{os} $ | < | 5 $\mu\text{A}/\text{V}$ |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Input capacitance at $f = 1 \text{ MHz}$;

$V_{DS} = 10 \text{ V}$; $V_{GS} = 0$; $T_{amb} = 25 \text{ }^\circ\text{C}$

$C_{is} < 5 \text{ pF}$

Feedback capacitance at $f = 1 \text{ MHz}$;

$V_{DS} = 10 \text{ V}$; $V_{GS} = 0$; $T_{amb} = 25 \text{ }^\circ\text{C}$

$C_{rs} < 1,5 \text{ pF}$

Equivalent noise voltage

$V_{DS} = 10 \text{ V}$; $I_D = 200 \text{ } \mu\text{A}$; $T_{amb} = 25 \text{ }^\circ\text{C}$

$B = 0,6 \text{ to } 100 \text{ Hz}$

$V_n < 0,5 \text{ } \mu\text{V}$

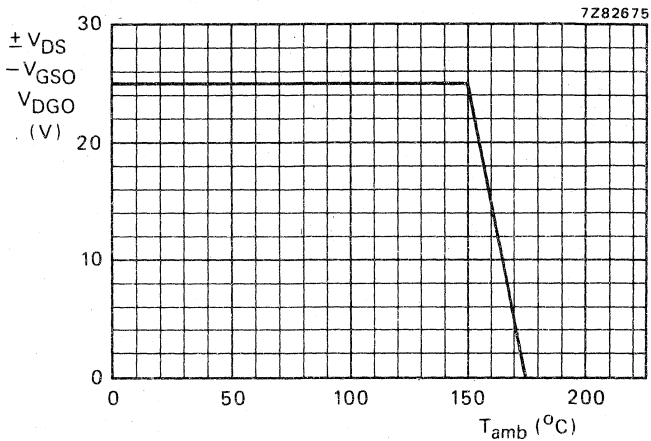


Fig. 2 Voltage derating curve.

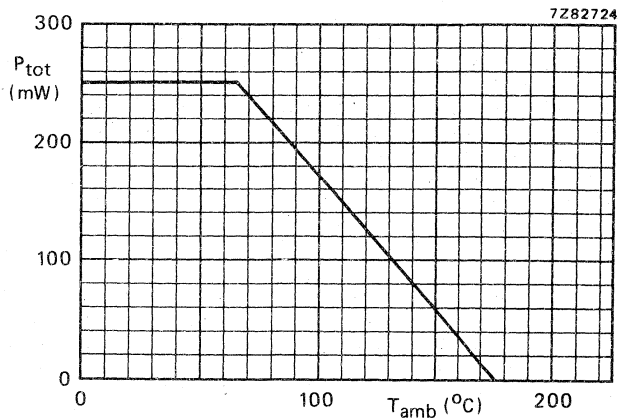


Fig. 3 Power derating curve.

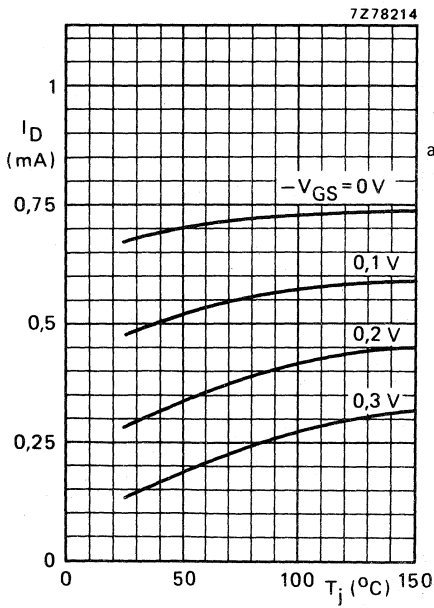
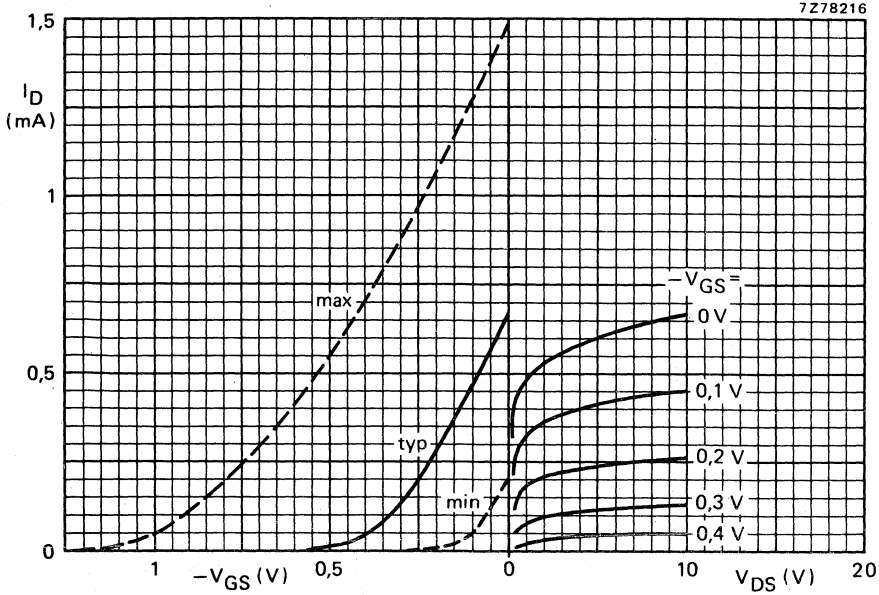


Fig. 5 Typical values. $V_{DS} = 10 \text{ V}$.

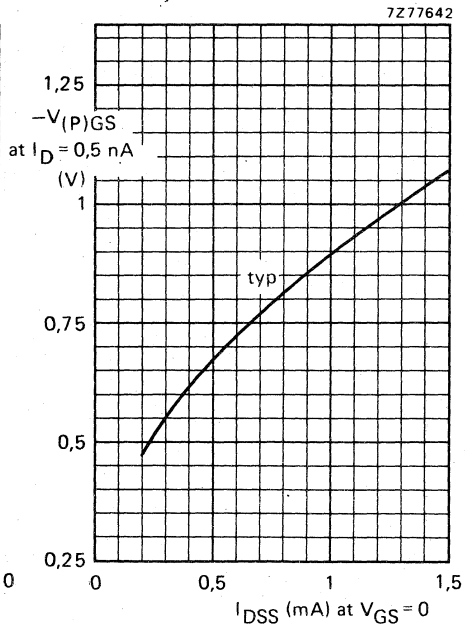


Fig. 6 Correlation between $-V_{(P)GS}$ and I_{DSS} . $V_{DS} = 10 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$.

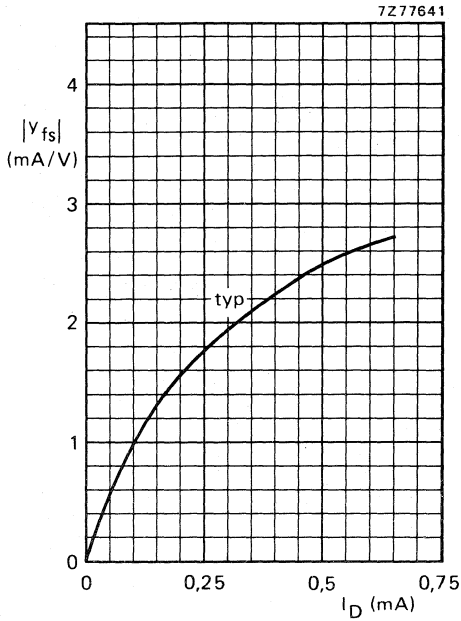


Fig. 7.

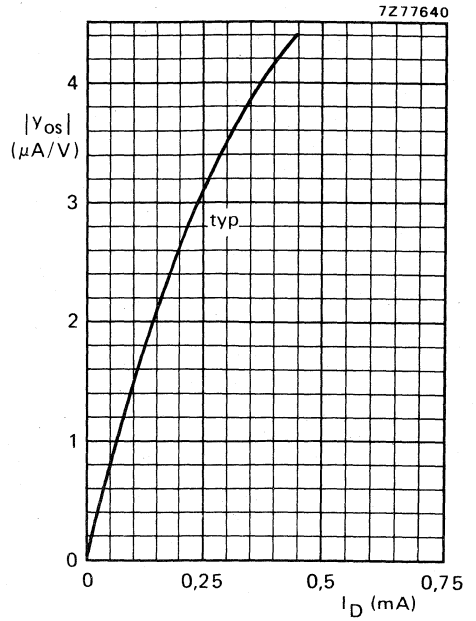


Fig. 8.

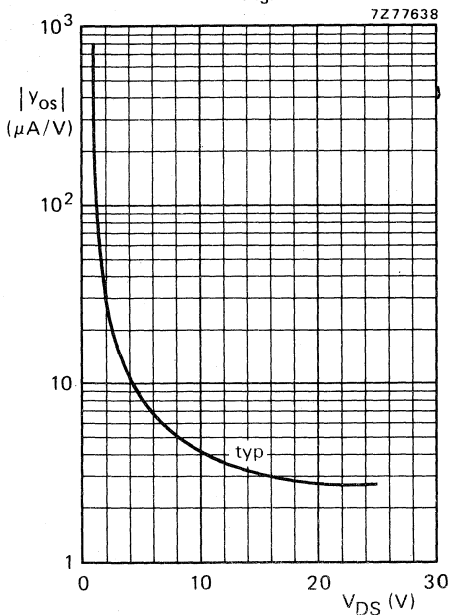


Fig. 9.

Fig. 7 $|y_{fs}|$ versus I_D .
 $V_{DS} = 10$ V; $f = 1$ kHz; $T_{amb} = 25$ °C.

Fig. 8 $|y_{os}|$ versus I_D .
 $V_{DS} = 10$ V; $f = 1$ kHz; $T_{amb} = 25$ °C.

Fig. 9 $|y_{os}|$ versus V_{DS} .
 $I_D = 0,4$ mA; $f = 1$ kHz; $T_{amb} = 25$ °C.

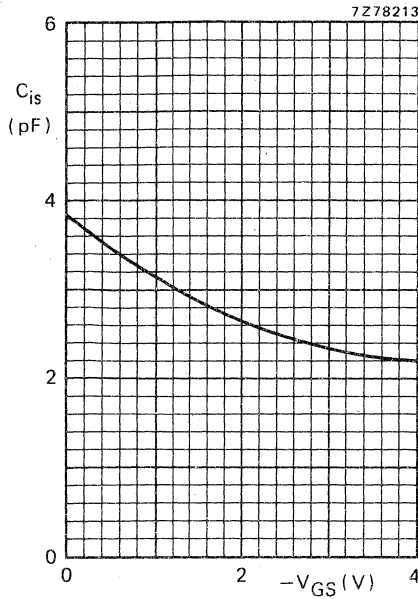


Fig. 10.

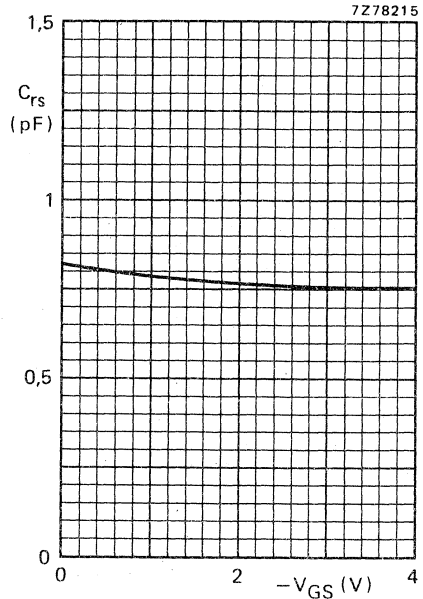


Fig. 11.

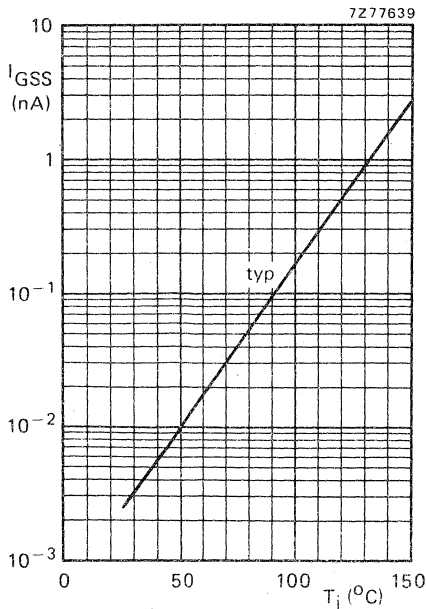


Fig. 12.

Fig. 10 Typical values.
 $V_{DS} = 10$ V, $T_{amb} = 25$ °C.

Fig. 11 Typical values.
 $V_{DS} = 10$ V, $T_{amb} = 25$ °C.

Fig. 12 I_{GSS} versus T_j .
 $-V_{GS} = 10$ V; $V_{DS} = 0$.

UNCLASSIFIED
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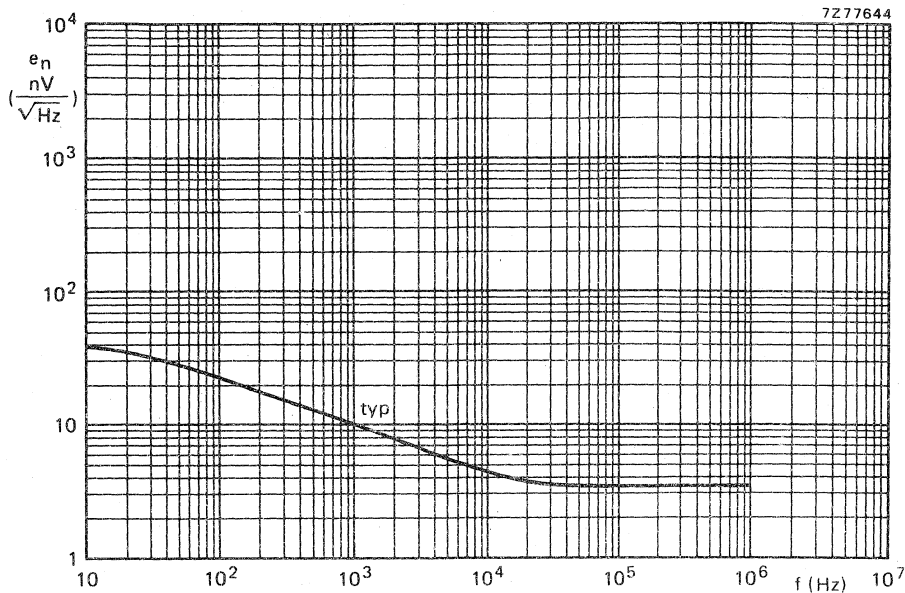


Fig. 13 $V_{DS} = 10 V$; $I_D = 0,2 mA$; $T_{amb} = 25 ^\circ C$.

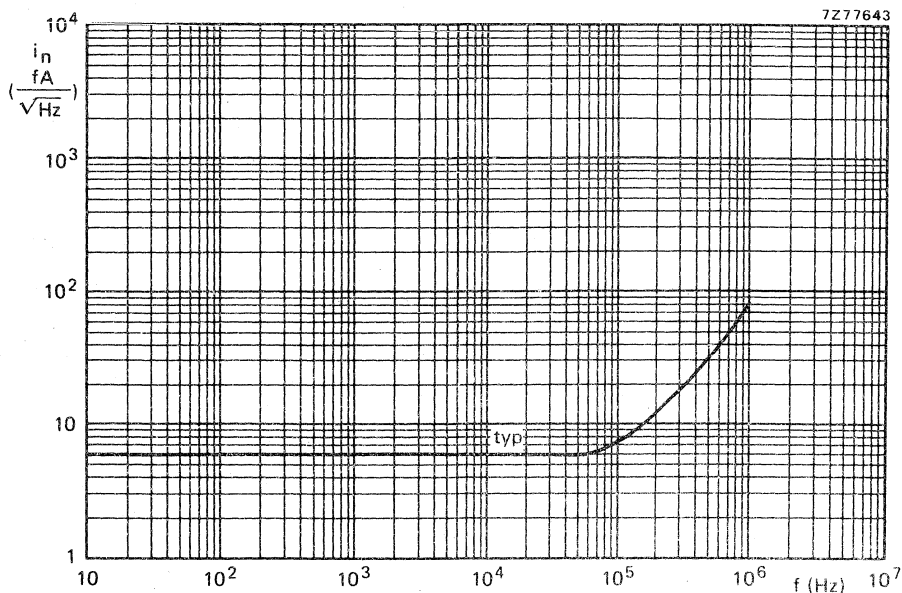


Fig. 14 $V_{DS} = 10 V$; $I_D = 0,2 mA$; $T_{amb} = 25 ^\circ C$.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers, etc.

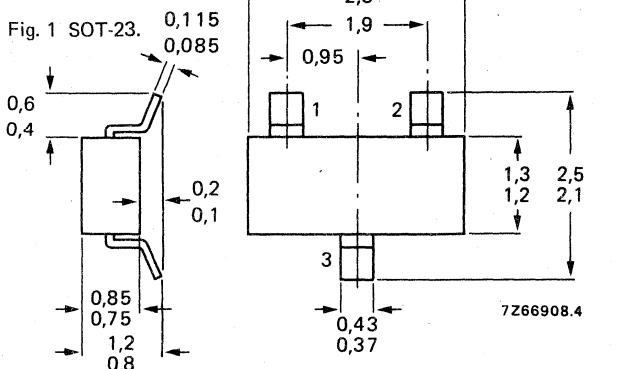
The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

This type is complementary to BFR92.

QUICK REFERENCE DATA

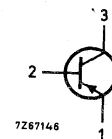
| | | |
|--|-----------------|----------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 20 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 15 V |
| Collector current (d.c.) | $-I_C$ max. | 25 mA |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} max. | 200 mW |
| Junction temperature | T_j max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 500\text{ MHz}$ $-I_C = 14\text{ mA}$; $-V_{CE} = 10\text{ V}$ | f_T typ. | 5 GHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 2\text{ mA}$; $-V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | C_{re} typ. | 0,7 pF |
| Noise figure at optimum source impedance $-I_C = 2\text{ mA}$; $-V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | F typ. | 2,7 dB |
| Max. unilateral power gain (see page 3) $-I_C = 14\text{ mA}$; $-V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | G_{UM} typ. | 18 dB |
| Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $-I_C = 14\text{ mA}$; $-V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $V_o = 150\text{ mV}$ $f_{(p+q-r)} = 493,25\text{ MHz}$ (see page 3) | d_{im} typ. | -60 dB |

MECHANICAL DATA

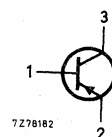


Marking code

BFT92 = W1



BFT92R = W4



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|----------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 20 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 15 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | 2,0 V |
| Collector current (d.c.) | $-I_C$ | max. | 25 mA |
| Collector current (peak value; $f > 1$ MHz) | $-I_{CM}$ | max. | 35 mA |
| → Total power dissipation up to $T_{amb} = 60^\circ\text{C}$ ** | P_{tot} | max. | 200 mW |
| Storage temperature | T_{stg} | | -65 to +150 °C |
| Junction temperature | T_j | max. | 150 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|-------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient ** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 10 \text{ V}$$

$$-I_{CBO} < 50 \text{ nA}$$

D.C. current gain *

$$-I_C = 14 \text{ mA}; -V_{CE} = 10 \text{ V}$$

$$h_{FE} > \begin{matrix} 20 \\ \text{typ.} \\ 50 \end{matrix}$$

Transition frequency at $f = 500$ MHz ▲

$$-I_C = 14 \text{ mA}; -V_{CE} = 10 \text{ V}$$

$$f_T \text{ typ. } 5 \text{ GHz}$$

Collector capacitance at $f = 1$ MHz

$$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$$

$$C_c \text{ typ. } 0,75 \text{ pF}$$

Emitter capacitance at $f = 1$ MHz

$$I_C = I_c = 0; -V_{EB} = 0,5 \text{ V}$$

$$C_e \text{ typ. } 0,8 \text{ pF}$$

▲ Measured under pulse conditions.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

CHARACTERISTICS (continued)

 $T_{amb} = 25\text{ }^{\circ}\text{C}$ Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}$ C_{re} typ. 0,7 pF

Noise figure at optimum source impedance *

 $-I_C = 2\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}$

F typ. 2,7 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM}(\text{in dB}) = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

 $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ G_{UM} typ. 18 dB

Intermodulation distortion *

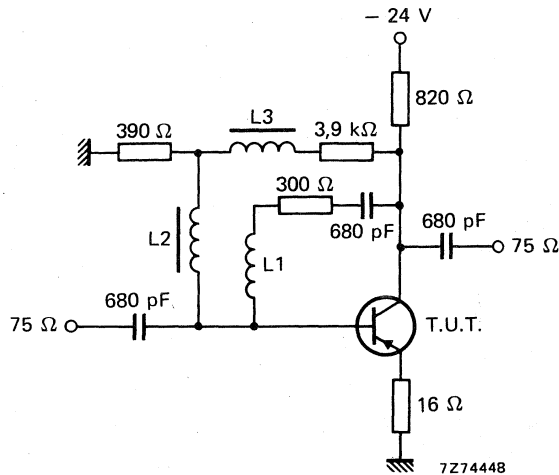
 $-I_C = 14\text{ mA}; -V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; \text{VSWR} < 2$ $V_p = V_o = 150\text{ mV}$ at $f_p = 495,25\text{ MHz}$ $V_q = V_o - 6\text{ dB}$ at $f_q = 503,25\text{ MHz}$ $V_r = V_o - 6\text{ dB}$ at $f_r = 505,25\text{ MHz}$ Measured at $f_{(p+q-r)} = 493,25\text{ MHz}$ d_{im} typ. -60 dB

Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35 mm); winding pitch 1 mm; int. dia. 4 mm.

L2 = L3 = 5 μH (catalogue number: 3122 108 20150).

* Crystal mounted in SOT-37 envelope.

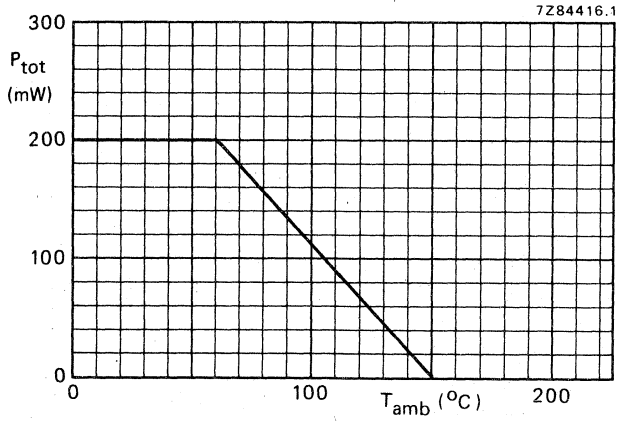


Fig. 3 Power derating curve.



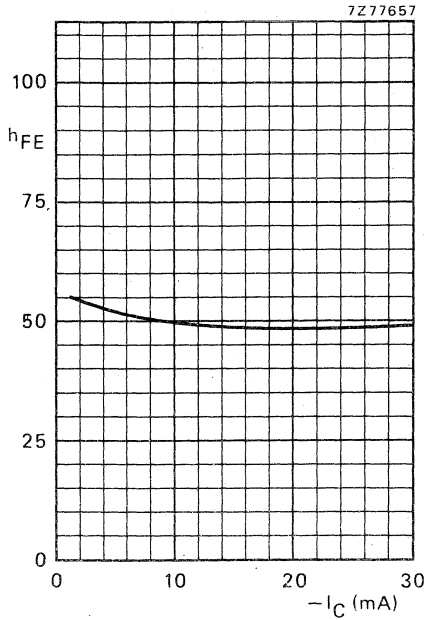


Fig. 4 $-V_{CE} = 10$ V; $T_j = 25$ °C.

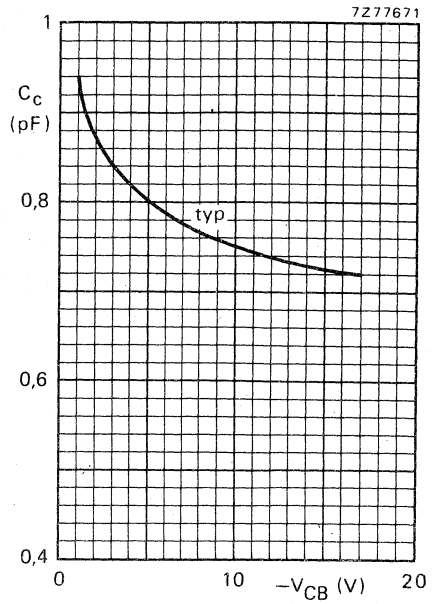


Fig. 5 $I_E = I_e = 0$; $T_j = 25$ °C; $f = 1$ MHz.

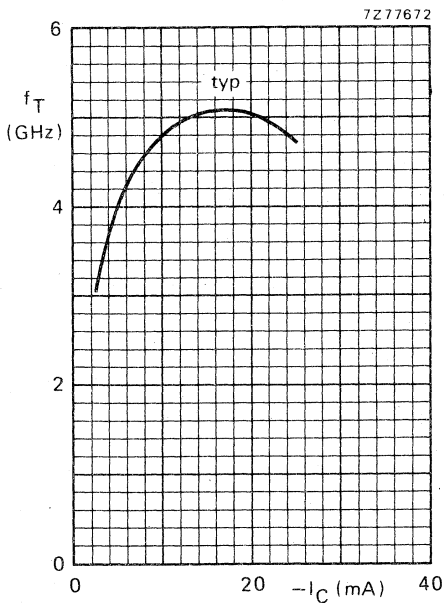


Fig. 6 $-V_{CE} = 10$ V; $f = 500$ MHz; $T_j = 25$ °C.



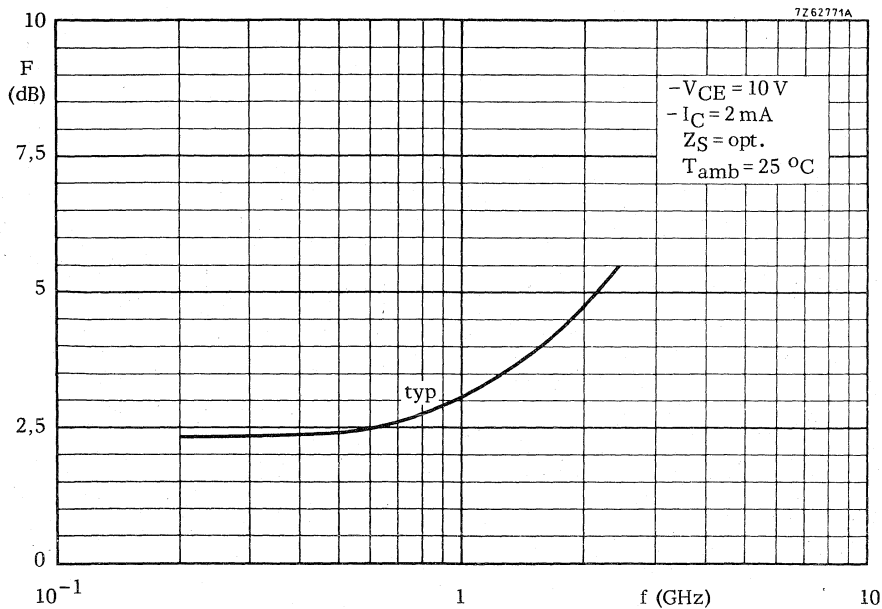


Fig. 7.

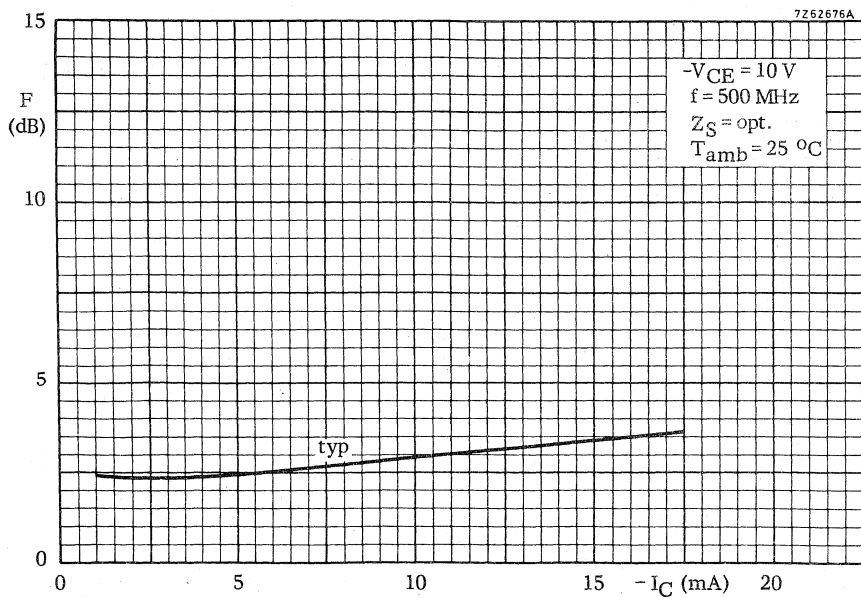


Fig. 8.

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistor in a microminiature plastic envelope. It is primarily intended for use in u.h.f. and microwave amplifiers in thick and thin-film circuits, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers, etc.

The transistor features low intermodulation distortion and high power gain; thanks to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

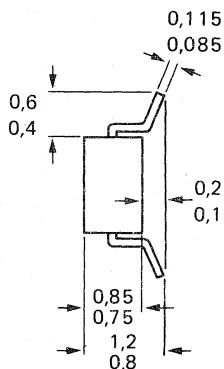
This type is complementary to BFR93.

QUICK REFERENCE DATA

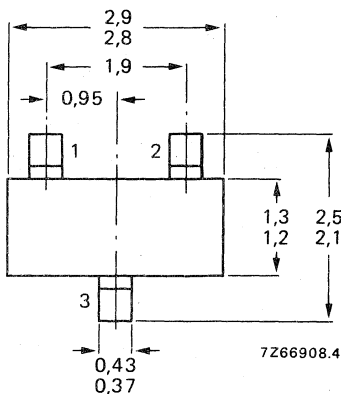
| | | |
|--|-----------------|----------------------|
| Collector-base voltage (open emitter) | $-V_{CB0}$ max. | 15 V |
| Collector-emitter voltage (open base) | $-V_{CE0}$ max. | 12 V |
| Collector current (d.c.) | $-I_C$ max. | 35 mA |
| Total power dissipation up to $T_{amb} = 60\text{ }^\circ\text{C}$ | P_{tot} max. | 200 mW |
| Junction temperature | T_j max. | 150 $^\circ\text{C}$ |
| Transition frequency at $f = 500\text{ MHz}$ $-I_C = 30\text{ mA}$; $-V_{CE} = 5\text{ V}$ | f_T typ. | 5 GHz |
| Feedback capacitance at $f = 1\text{ MHz}$ $-I_C = 2\text{ mA}$; $-V_{CE} = 5\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | C_{re} typ. | 1,0 pF |
| Noise figure at optimum source impedance $-I_C = 2\text{ mA}$; $-V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | F typ. | 2,4 dB |
| Max. unilateral power gain (see page 3) $-I_C = 30\text{ mA}$; $-V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | GUM typ. | 16,5 dB |
| Intermodulation distortion at $T_{amb} = 25\text{ }^\circ\text{C}$ $-I_C = 30\text{ mA}$; $-V_{CE} = 5\text{ V}$; $R_L = 75\text{ }\Omega$; $V_o = 300\text{ mV}$ $f(p + q - r) = 493,25\text{ MHz}$ (see page 3) | d_{im} typ. | -60 dB |

MECHANICAL DATA

Fig. 1 SOT-23.

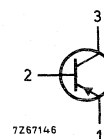


Dimensions in mm

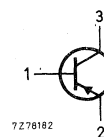


Marking code

BFT93 = X1



BFT93R = X4



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | |
|--|-----------------|----------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 15 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 12 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ max. | 2,0 V |
| Collector current (d.c.) | $-I_C$ max. | 35 mA |
| Collector current (peak value; $f > 1$ MHz) | $-I_{CM}$ max. | 50 mA |
| → Total power dissipation up to $T_{amb} = 60$ °C ** | P_{tot} max. | 200 mW |
| Storage temperature | T_{stg} | -65 to +150 °C |
| Junction temperature | T_j max. | 150 °C |

→ **THERMAL CHARACTERISTICS ***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | |
|-------------------------------------|-----------------|---------|
| From junction to tab | $R_{th\ j-t}$ = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ = | 260 K/W |
| From soldering points to ambient ** | $R_{th\ s-a}$ = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 5\text{ V}$$

$$-I_{CBO} < 50\text{ nA}$$

D.C. current gain *

$$-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 20 \\ \text{typ. } 50 \end{matrix}$$

Transition frequency at $f = 500$ MHz ▲

$$-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}$$

$$f_T \text{ typ. } 5\text{ GHz}$$

Collector capacitance at $f = 1$ MHz

$$I_E = I_e = 0; -V_{CB} = 10\text{ V}$$

$$C_c \text{ typ. } 0,95\text{ pF}$$

Emitter capacitance at $f = 1$ MHz

$$I_C = I_c = 0; -V_{EB} = 0,5\text{ V}$$

$$C_e \text{ typ. } 1,8\text{ pF}$$

▲ Measured under pulse conditions.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

CHARACTERISTICS (continued)

$T_{amb} = 25\text{ }^{\circ}\text{C}$

Feedback capacitance at $f = 1\text{ MHz}$

$-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}$

C_{re} typ. 1,0 pF

Noise figure at optimum source impedance *

$-I_C = 2\text{ mA}; -V_{CE} = 5\text{ V}; f = 500\text{ MHz}$

F typ. 2,4 dB

Max. unilateral power gain (s_{re} assumed to be zero)

$$G_{UM}(\text{in dB}) = 10 \log \frac{|s_{fe}|^2}{(1 - |s_{ie}|^2)(1 - |s_{oe}|^2)}$$

$-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}; f = 500\text{ MHz}$

G_{UM} typ. 16,5 dB

Intermodulation distortion *

$-I_C = 30\text{ mA}; -V_{CE} = 5\text{ V}; R_L = 75\text{ }\Omega; \text{VSWR} < 2$

$V_p = V_o = 300\text{ mV}$ at $f_p = 495,25\text{ MHz}$

$V_q = V_o - 6\text{ dB}$ at $f_q = 503,25\text{ MHz}$

$V_r = V_o - 6\text{ dB}$ at $f_r = 505,25\text{ MHz}$

Measured at $f_{(p+q-r)} = 493,25\text{ MHz}$

dim typ. -60 dB

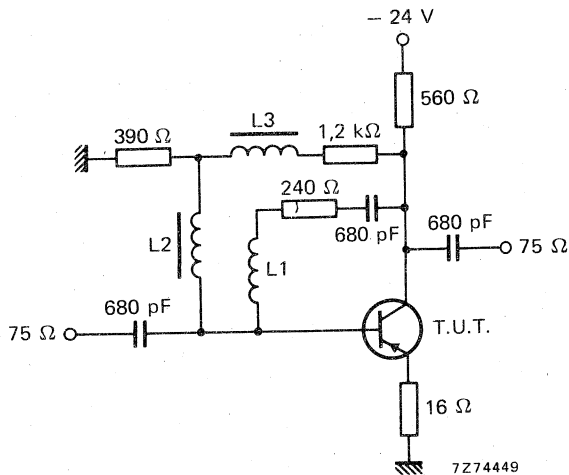


Fig. 2 Intermodulation test circuit.

L1 = 4 turns Cu wire (0,35); winding pitch 1 mm; int. dia. 4 mm.
L2 and L3 = 5 μH (catalogue number: 3122 108 20150).

* Crystal mounted in SOT-37 envelope.

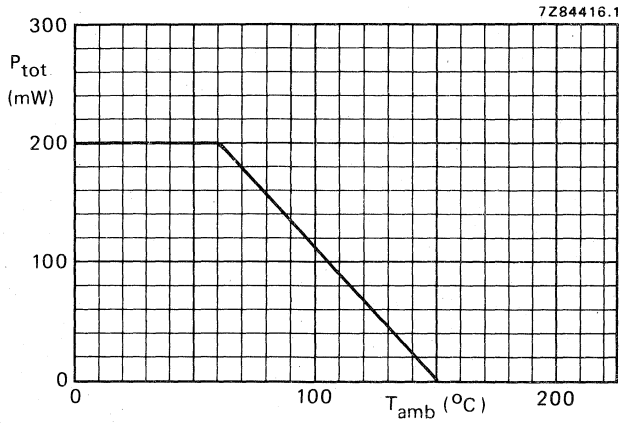


Fig. 3 Power derating curve.



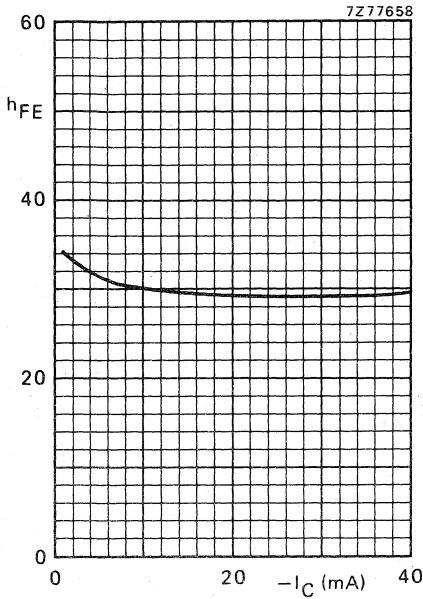


Fig. 4 $-V_{CE} = 5$ V; $T_j = 25$ °C.

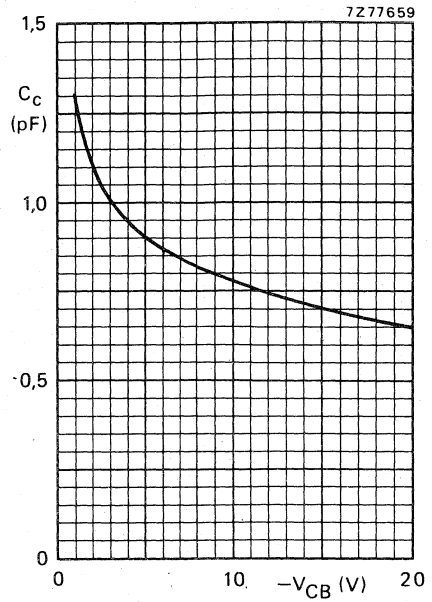


Fig. 5 $I_E = I_e = 0$; $T_j = 25$ °C; $f = 1$ MHz.

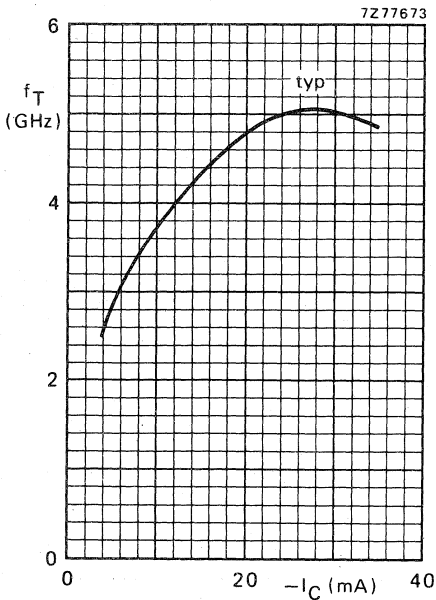


Fig. 6 $-V_{CE} = 5$ V; $T_j = 25$ °C; $f = 500$ MHz.

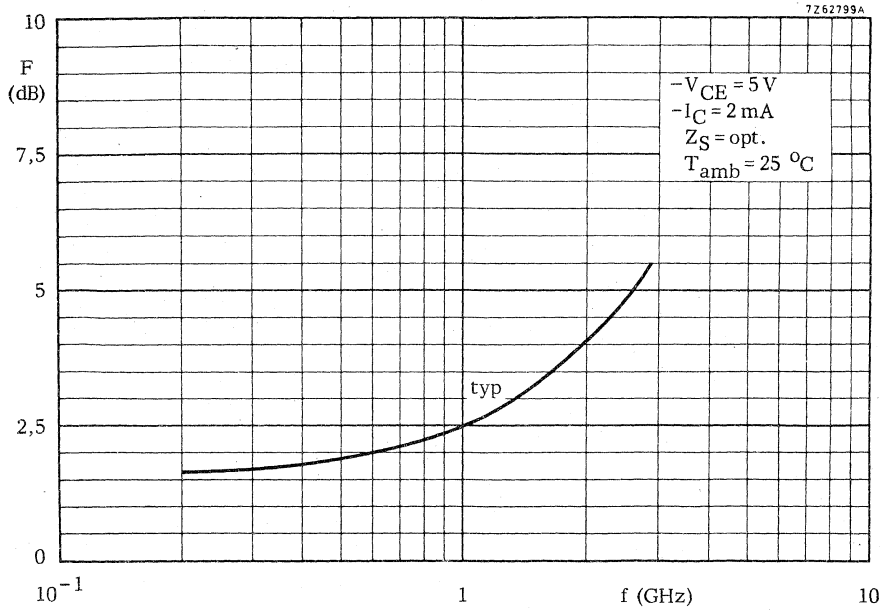


Fig. 7.

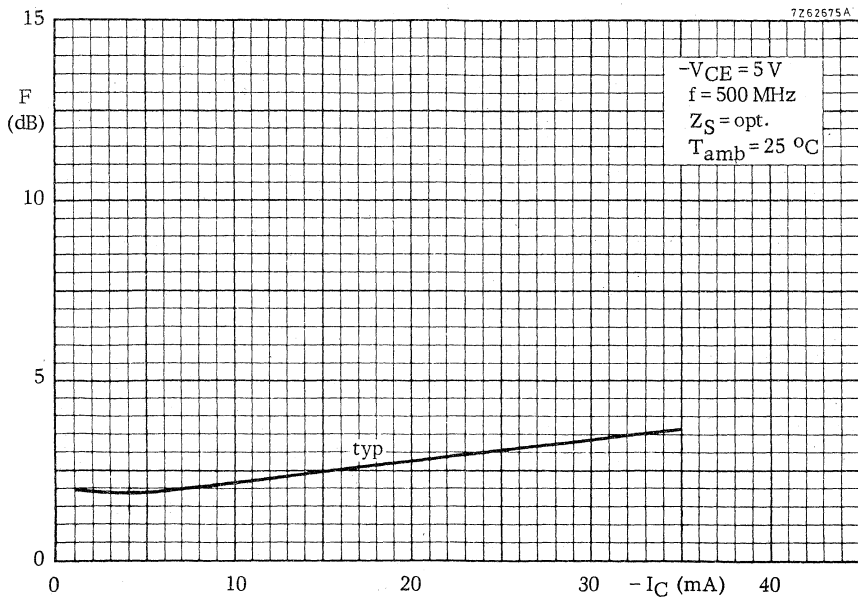


Fig. 8.

PROGRAMMABLE UNIJUNCTION TRANSISTOR

Planar p-n-p-n trigger device in a microminiature plastic envelope intended for applications in thick and thin-film circuits. It is intended for use in switching applications such as motor control, oscillators, relay replacement, timers, pulse shaper, trigger device etc.

QUICK REFERENCE DATA

| | | | |
|--|----------|------|------------------------|
| Gate-anode voltage | V_{GA} | max. | 70 V |
| Anode current (d.c.) up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | I_A | max. | 175 mA ← |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |
| Peak point current $V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$ | I_p | < | 5 μA |
| Valley point current $V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$ | I_V | > | 30 μA |

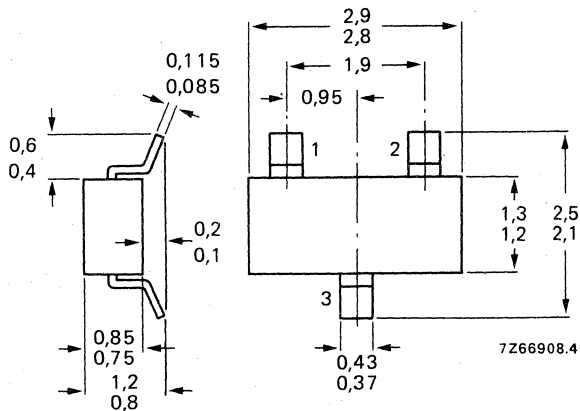
MECHANICAL DATA

Dimensions in mm

Marking code

Fig. 1 SOT-23.

BRY61 = A5



See also *Soldering Recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-------------------|------|--------------------------------|
| Gate-anode voltage | V_{GA} | max. | 70 V |
| → Anode current (d.c.) up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | I_A | max. | 175 mA |
| Repetitive peak anode current $t = 10\text{ }\mu\text{s}; \delta = 0,01$ | I_{ARM} | max. | 2,5 A |
| Non-repetitive peak anode current $t = 10\text{ }\mu\text{s}; T_j = 150\text{ }^{\circ}\text{C}$ | I_{ASM} | max. | 3 A |
| Rate of rise of anode current up to $I_A = 2,5\text{ A}$ | $\frac{dI_A}{dt}$ | max. | 20 A/ μs |
| Storage temperature | T_{stg} | | -65 to +150 $^{\circ}\text{C}$ |
| Junction temperature | T_j | max. | 150 $^{\circ}\text{C}$ |
| → Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}^{**}$ | P_{tot} | max. | 275 mW |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Peak point current (see Figs 2, 3 and 4)

$$V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$$

$$V_S = 10\text{ V}; R_G = 1\text{ M}\Omega$$

| | | |
|-------|---|-----------------|
| I_p | < | 5 μA |
| I_p | < | 1 μA |

Valley point current (see also Figs 2, 3 and 4)

$$V_S = 10\text{ V}; R_G = 10\text{ k}\Omega$$

$$V_S = 10\text{ V}; R_G = 1\text{ M}\Omega$$

| | | |
|-------|---|------------------|
| I_v | > | 30 μA |
| I_v | < | 50 μA |

Offset voltage (see Fig. 12)

$$I_A = 0 \text{ (for } V_p \text{ see Fig. 2; for } V_S \text{ see Fig. 4)}$$

$$V_{offset} = V_p - V_S \quad V$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.



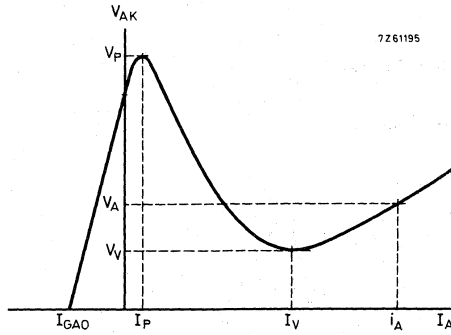


Fig. 2 See also Fig. 11.

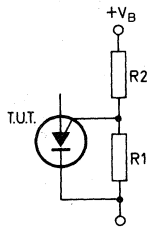


Fig. 3 BRY61 with "program" resistors R_1 and R_2 .

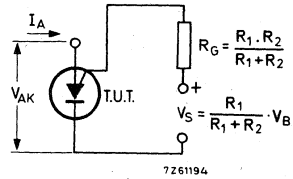


Fig. 4 Equivalent test circuit for characteristics testing.

Gate-anode leakage current (Fig. 5a)

$$I_K = 0; V_{GA} = 70 \text{ V}$$

$$I_{GAO} < 10 \text{ nA}$$

Gate-cathode leakage current (Fig. 5b)

$$V_{AK} = 0; V_{GK} = 70 \text{ V}$$

$$I_{GKS} < 100 \text{ nA}$$

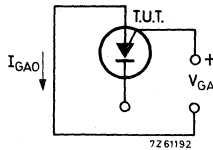


Fig. 5a.

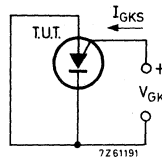


Fig. 5b.

Anode voltage

$I_A = 100 \text{ mA}$

$I_A = 180 \text{ mA}$

Peak output voltage

$V_{AA} = 20 \text{ V}; C = 200 \text{ nF}$ (see Fig. 12)

Rise time

$V_{AA} = 20 \text{ V}; C = 10 \text{ nF}$ (see Fig. 12)

$V_A < 1,4 \text{ V}$

$V_A < 1,6 \text{ V}$

$V_{OM} > 6 \text{ V}$

$t_r < 80 \text{ ns}$

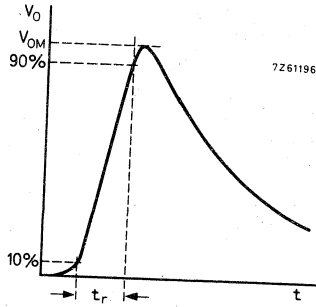


Fig. 6 Output voltage waveform.

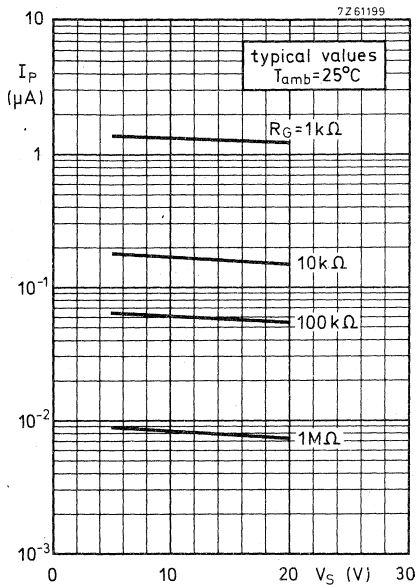


Fig. 8.

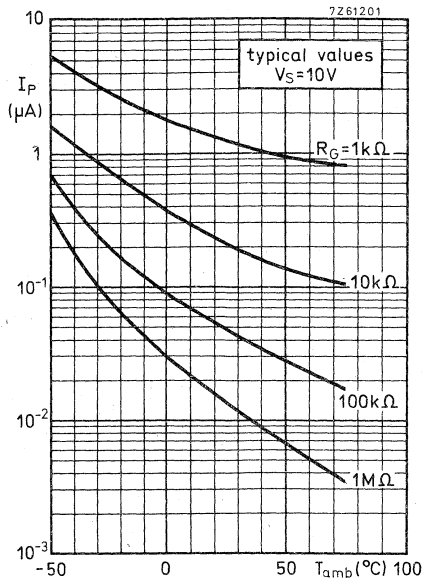


Fig. 9.

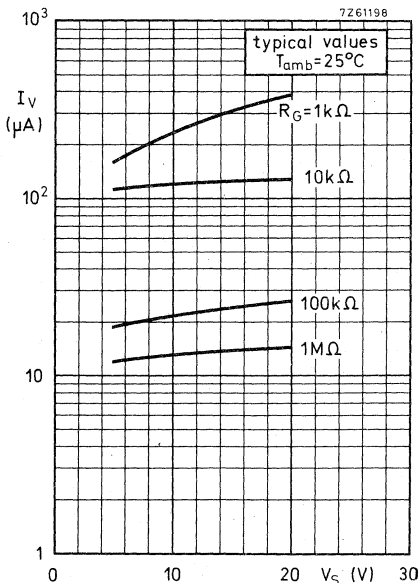


Fig. 10.

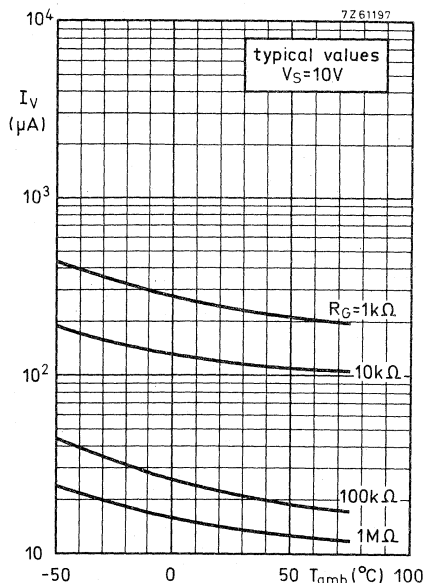


Fig. 11.

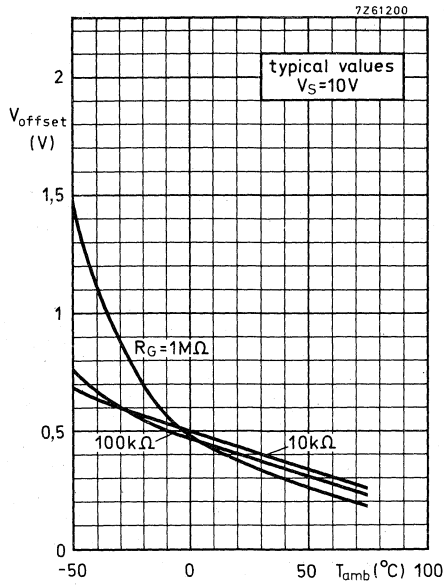


Fig. 12.

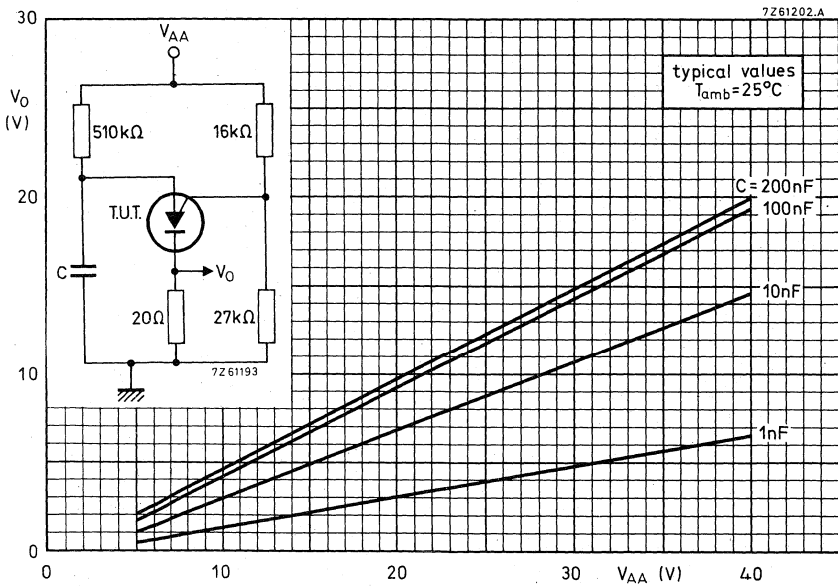


Fig. 13.

SILICON LOW-POWER SWITCHING TRANSISTORS

P-N-P silicon transistor in a microminiature plastic envelope. It is intended for high-speed, saturated switching applications for industrial service in thick and thin-film circuits.

QUICK REFERENCE DATA

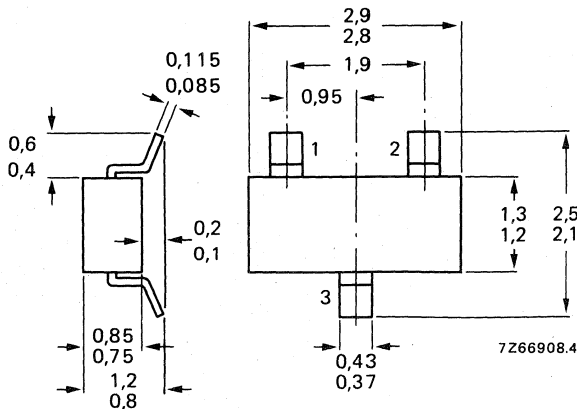
| | | | |
|--|-----------------|------------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 15 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 15 V | |
| Collector current (peak value) | $-I_{CM}$ max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} max. | 250 mW | ← |
| Junction temperature | T_j max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain | | | |
| $-I_C = 10\text{ mA}; -V_{CE} = 1\text{ V}$ | h_{FE} | > 30 | |
| $-I_C = 50\text{ mA}; -V_{CE} = 1\text{ V}$ | h_{FE} | 30 to 120 | |
| Transition frequency at $f = 500\text{ MHz}$ | | | |
| $-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$ | f_T | > 1,5 GHz | |
| Turn-off time | | | |
| $-I_{Con} = 30\text{ mA}; -I_{Bon} = +I_{Boff} = 3,0\text{ mA}$ | t_{off} | < 30 ns | |

MECHANICAL DATA

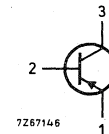
Dimensions in mm

Marking code

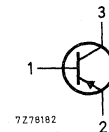
Fig. 1 SOT-23.



BSR12 = B5



BSR12R = B8



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|------------|------|------------------------------|
| Collector-base voltage (open emitter) See Fig. 3 | $-V_{CBO}$ | max. | 15 V |
| Collector-emitter voltage (open base) See Fig. 3 | $-V_{CEO}$ | max. | 15 V |
| Emitter-base voltage (open collector) See Fig. 3 | $-V_{EBO}$ | max. | 3 V |
| Collector current (d.c.) | $-I_C$ | max. | 100 mA |
| Collector current (peak value) | $-I_{CM}$ | max. | 200 mA |
| → Total power dissipation up to $T_{amb} = 65\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 250 mW |
| → Storage temperature | T_{stg} | | -65 to +175 $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

| | | | |
|---|------------|---|-----------------|
| $I_E = 0; -V_{CB} = 10\text{ V}$ | $-I_{CBO}$ | < | 50 nA |
| $I_E = 0; -V_{CB} = 10\text{ V}; T_{amb} = 125\text{ }^\circ\text{C}$ | $-I_{CBO}$ | < | 5 μA |
| $V_{BE} = 0; -V_{CE} = 10\text{ V}$ | $-I_{CES}$ | < | 50 nA |

Breakdown voltages

| | | | |
|--|----------------|---|------|
| $I_E = 0; -I_C = 10\text{ }\mu\text{A}$ | $-V_{(BR)CBO}$ | > | 15 V |
| $V_{BE} = 0; -I_C = 10\text{ }\mu\text{A}$ | $-V_{(BR)CES}$ | > | 15 V |
| $I_C = 0; -I_E = 100\text{ }\mu\text{A}$ | $-V_{(BR)EBO}$ | > | 3 V |

Collector-emitter sustaining voltage

| | | | |
|--------------------------------|-----------------------|---|------|
| $I_B = 0; -I_C = 10\text{ mA}$ | $-V_{CEO\text{sust}}$ | > | 15 V |
|--------------------------------|-----------------------|---|------|

Saturation voltages▲

| | | | |
|---|---------------------|---|----------------|
| $-I_C = 10\text{ mA}; -I_B = 1\text{ mA}$ | $-V_{CE\text{sat}}$ | < | 130 mV |
| | $-V_{BE\text{sat}}$ | | 725 to 920 mV |
| $-I_C = 50\text{ mA}; -I_B = 5\text{ mA}$ | $-V_{CE\text{sat}}$ | < | 190 mV |
| | $-V_{BE\text{sat}}$ | | 800 to 1150 mV |
| $-I_C = 100\text{ mA}; -I_B = 10\text{ mA}$ | $-V_{CE\text{sat}}$ | < | 450 mV |
| | $-V_{BE\text{sat}}$ | | 900 to 1500 mV |

▲ Measured under pulse conditions; $t_p = 300\text{ }\mu\text{s}; \delta = 0,01$.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

D.C. current gain *

- I_C = 1 mA; -V_{CE} = 1 V
- I_C = 10 mA; -V_{CE} = 1 V
- I_C = 50 mA; -V_{CE} = 1 V
- I_C = 50 mA; -V_{CE} = 1 V; T_{amb} = 55 °C
- I_C = 100 mA; -V_{CE} = 1 V

| | | |
|-----------------|---|-----------|
| h _{FE} | > | 30 |
| h _{FE} | > | 30 |
| h _{FE} | > | 30 to 120 |
| h _{FE} | > | 30 |
| h _{FE} | > | 20 |

Transition frequency at f = 500 MHz

- I_C = 50 mA; -V_{CE} = 10 V

| | | |
|----------------|---|---------|
| f _T | > | 1,5 GHz |
|----------------|---|---------|

Collector capacitance

- I_E = I_e = 0; -V_{CB} = 5 V

| | | |
|----------------|---|--------|
| C _c | < | 4,5 pF |
|----------------|---|--------|

Emitter capacitance

- I_C = I_c = 0; -V_{EB} = 0,5 V

| | | |
|----------------|---|--------|
| C _e | < | 6,0 pF |
|----------------|---|--------|

Switching times

Turn-on time

| | | |
|-----------------|---|-------|
| t _{on} | < | 20 ns |
|-----------------|---|-------|

Turn-off time

| | | |
|------------------|---|-------|
| t _{off} | < | 30 ns |
|------------------|---|-------|

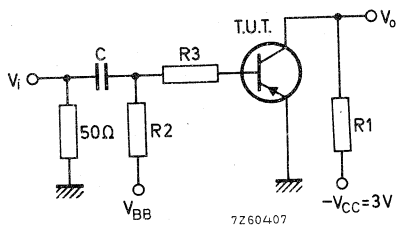


Fig. 2 Test circuit switching times.

Pulse generator

- Pulse duration t_p = 400 ns
- Rise time t_r < 1 ns
- Output impedance Z_o = 50 Ω

Sampling scope

- Rise time t_r < 1 ns
- Input impedance Z_i = 100 kΩ

| | V _i V | V _{BB} V | R1 Ω | R2 kΩ | R3 kΩ | -I _{Con} mA | -I _{Bon} mA | I _{Boff} mA | C μF |
|------------------|---------------------|----------------------|---------|----------|----------|-------------------------|-------------------------|-------------------------|---------|
| t _{on} | -6,85 | 0 | 94 | 1,0 | 2,0 | 30 | 3,0 | - | 0,1 |
| t _{off} | 11,7 | -9,85 | 94 | 1,0 | 2,0 | 30 | 3,0 | 3,0 | 0,1 |

* Measured under pulse conditions; t_p = 300 μs; δ = 0,01.

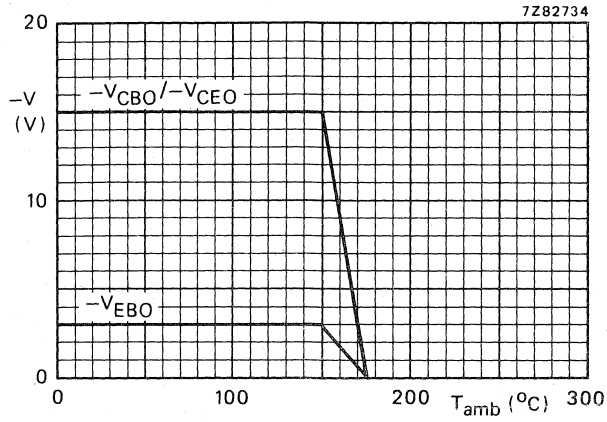


Fig. 3 Voltage derating curves.

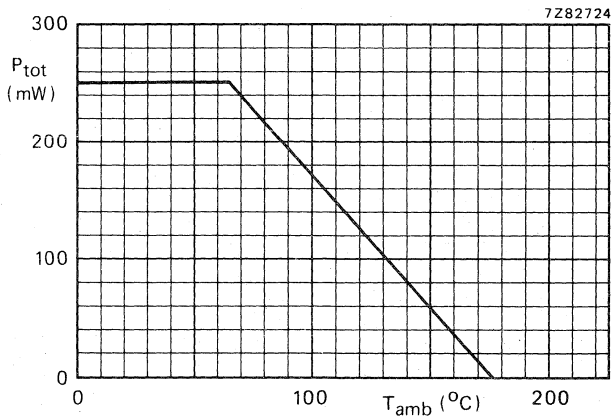


Fig. 4 Power derating curve.

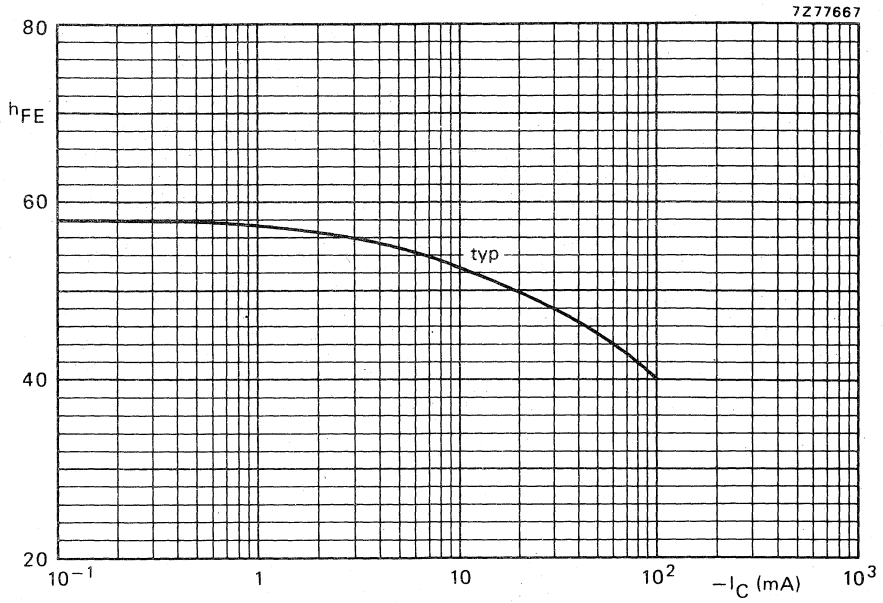


Fig. 5 $-V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$.

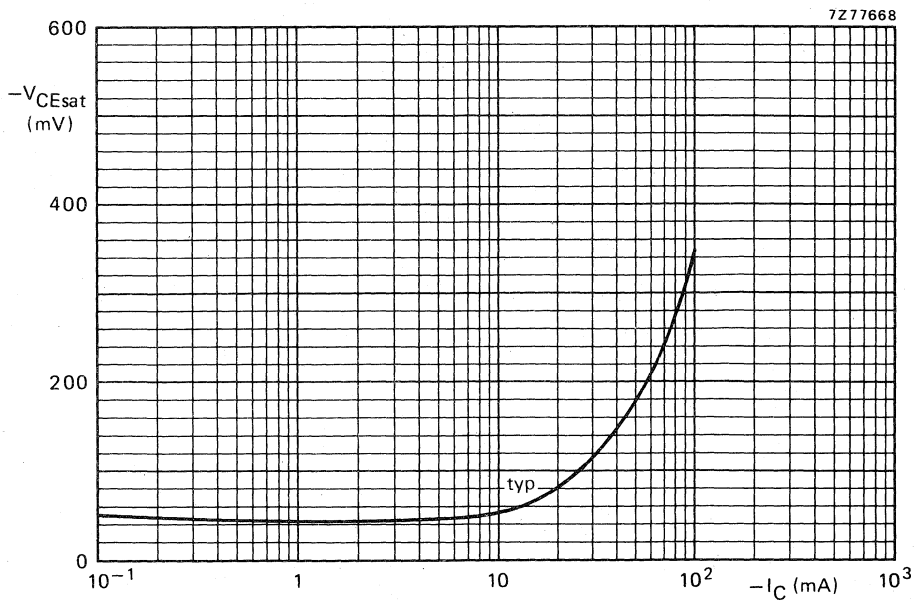


Fig. 6 V_{CEsat} as a function of I_C at $I_C/I_B = 10$.

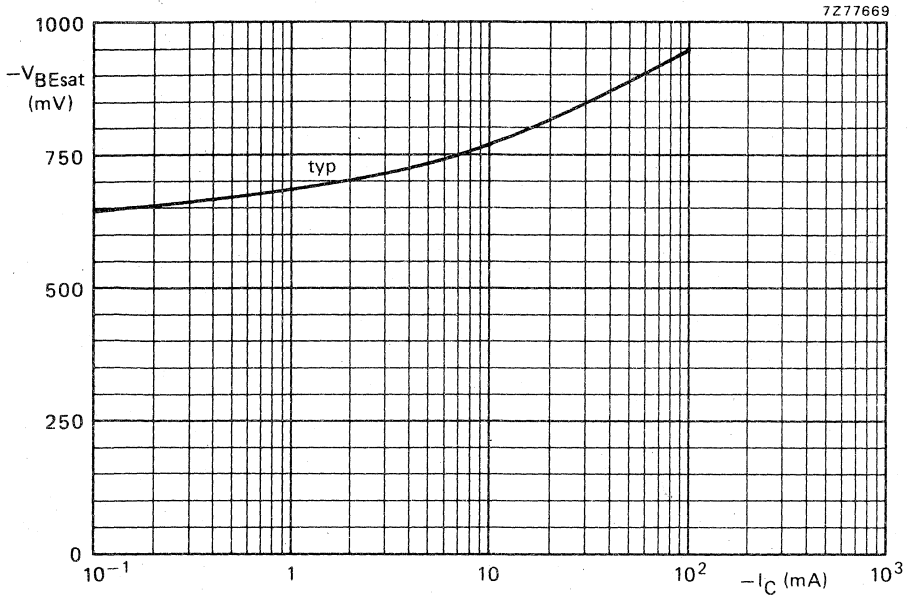


Fig. 7 V_{BEsat} as a function of I_C at $I_C/I_B = 10$.

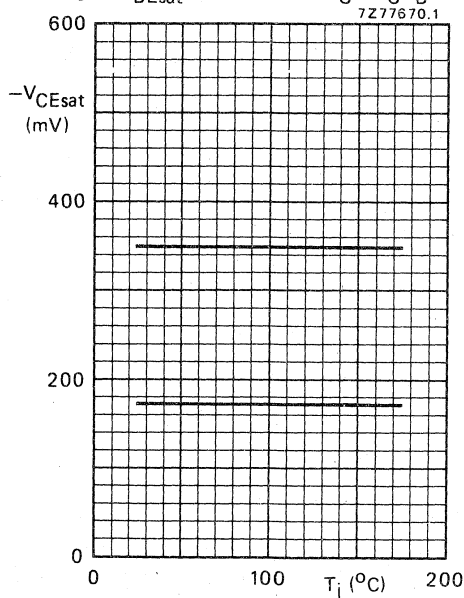


Fig. 8 V_{CEsat} as a function of T_j ; typical values.

Upper graph at $I_C = 100$ mA; $I_B = 10$ mA. Lower graph at $I_C = 50$ mA and $I_B = 5$ mA.

DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BSR13;R
BSR14;R

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N silicon transistors, in a microminiature plastic envelope intended for switching and linear applications in thick and thin-film circuits.

QUICK REFERENCE DATA

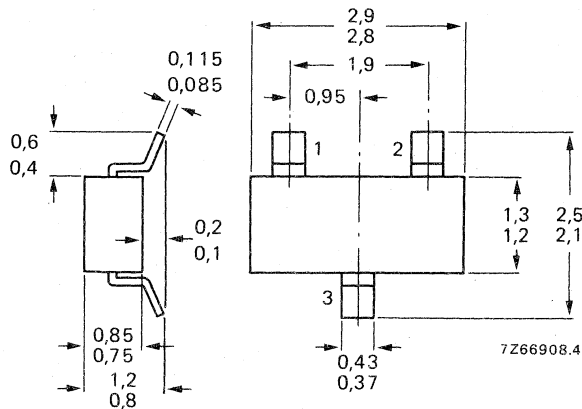
| | | BSR13;R | BSR14;R | |
|--|-----------|------------|---------|--------------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. 60 | 75 | V |
| Collector-emitter voltage (open base) | V_{CEO} | max. 30 | 40 | V |
| Emitter-base voltage (open collector) | V_{EBO} | max. 5 | 6 | V |
| Collector current (d.c.) | I_C | max. 800 | | mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. 425 | | mW ← |
| Junction temperature | T_j | max. 175 | | $^\circ\text{C}$ ← |
| D.C. current gain | | 100 to 300 | | |
| $I_C = 150\text{ mA}; V_{CE} = 10\text{ V}$ | h_{FE} | > 30 | 40 | |
| $I_C = 500\text{ mA}; V_{CE} = 10\text{ V}$ | h_{FE} | | | |
| Transition frequency at $f = 100\text{ MHz}$ | | | | |
| $I_C = 20\text{ mA}; V_{CE} = 20\text{ V}$ | f_T | > 250 | 300 | MHz |

MECHANICAL DATA

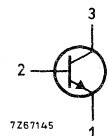
Dimensions in mm

Marking code

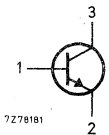
Fig. 1 SOT-23.



BSR13 = U7
BSR14 = U8



BSR13R = U71
BSR14R = U81



See also Soldering recommendations.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | BSR13; R | BSR14; R | |
|--|----------------|-------------|----------|------------------|
| Collector-base voltage (open emitter) see Fig. 4 | V_{CBO} max. | 60 | 75 | V |
| Collector-emitter voltage (open base) see Fig. 4 | V_{CEO} max. | 30 | 40 | V |
| Emitter-base voltage (open collector) see Fig. 4 | V_{EBO} max. | 5 | 6 | V |
| Collector current (d.c.) | I_C max. | 800 | | mA |
| Total power dissipation** | P_{tot} max. | 425 | | mW |
| → up to $T_{amb} = 25\text{ }^\circ\text{C}$ | T_{stg} | -65 to +175 | | $^\circ\text{C}$ |
| → Storage temperature | T_j max. | 175 | | $^\circ\text{C}$ |
| → Junction temperature | | | | |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|-----------------|-----|-----|
| From junction to tab | $R_{th\ j-t} =$ | 30 | K/W |
| From tab to soldering points | $R_{th\ t-s} =$ | 260 | K/W |
| From soldering points to ambient** | $R_{th\ s-a} =$ | 60 | K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| | | BSR13; R | BSR14; R | |
|--|---------------|----------|------------|---------------|
| Collector cut-off current | | | | |
| $I_E = 0; V_{CB} = 50\text{ V}$ | $I_{CBO} <$ | 30 | — | nA |
| $I_E = 0; V_{CB} = 60\text{ V}$ | $I_{CBO} <$ | — | 10 | nA |
| $I_E = 0; V_{CB} = 50\text{ V}; T_j = 150\text{ }^\circ\text{C}$ | $I_{CBO} <$ | 10 | — | μA |
| $I_E = 0; V_{CB} = 60\text{ V}; T_j = 150\text{ }^\circ\text{C}$ | $I_{CBO} <$ | — | 10 | μA |
| $V_{EB} = 3\text{ V}; V_{CE} = 60\text{ V}$ | $I_{CEX} <$ | — | 10 | nA |
| Base current | | | | |
| with reverse biased emitter junction | | | | |
| $V_{EB} = 3\text{ V}; V_{CE} = 60\text{ V}$ | $I_{BEX} <$ | — | 20 | nA |
| Emitter cut-off current | | | | |
| $I_C = 0; V_{EB} = 3\text{ V}$ | $I_{EBO} <$ | 30 | 15 | nA |
| Saturation voltages Δ | | | | |
| $I_C = 150\text{ mA}; I_B = 15\text{ mA}$ | $V_{CEsat} <$ | 400 | 300 | mV |
| | $V_{BEsat} <$ | 1300 | — | mV |
| | $V_{BEsat} <$ | — | 0,6 to 1,2 | V |
| | $V_{CEsat} <$ | 1600 | 1000 | mV |
| $I_C = 500\text{ mA}; I_B = 50\text{ mA}$ | $V_{BEsat} <$ | 2600 | 2000 | mV |

* See *Thermal characteristics* in chapter GENERAL.

** Device mounted on a ceramic substrate of 15 mm x 15 mm x 0,6 mm.

▲ Measured under pulsed conditions to avoid excessive dissipation $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0,02$.

D.C. current gain *

$I_C = 0,1 \text{ mA}; V_{CE} = 10 \text{ V}$

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$

$I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$

$I_C = 150 \text{ mA}; V_{CE} = 10 \text{ V}$

$I_C = 150 \text{ mA}; V_{CE} = 1 \text{ V}$

$I_C = 500 \text{ mA}; V_{CE} = 10 \text{ V}$ BSR13; R

$I_C = 500 \text{ mA}; V_{CE} = 10 \text{ V}$ BSR14; R

| | |
|----------|------------|
| h_{FE} | > 35 |
| h_{FE} | > 50 |
| h_{FE} | > 75 |
| h_{FE} | 100 to 300 |
| h_{FE} | > 50 |
| h_{FE} | > 30 |
| h_{FE} | > 40 |

Transition frequency at $f = 100 \text{ MHz}$

$I_C = 20 \text{ mA}; V_{CE} = 20 \text{ V}$ BSR13; R

$I_C = 20 \text{ mA}; V_{CE} = 20 \text{ V}$ BSR14; R

| | | |
|-------|-------|-----|
| f_T | > 250 | MHz |
| f_T | > 300 | MHz |

Collector capacitance at $f = 1 \text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10 \text{ V}$

| | | |
|-------|-----|----|
| C_C | < 8 | pF |
|-------|-----|----|

h parameters (common emitter) at $f = 1 \text{ kHz}$

$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}$

input impedance

reverse voltage transfer ratio

small signal current gain

output admittance

$I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}$

input impedance

reverse voltage transfer ratio

small signal current gain

output admittance

| | | |
|----------|---------------------|------------------|
| | | BSR14;R |
| h_{ie} | 2 to 8 | k Ω |
| h_{re} | < $8 \cdot 10^{-4}$ | |
| h_{fe} | 50 to 300 | |
| h_{oe} | 5 to 35 | $\mu\Omega^{-1}$ |
| | | |
| h_{ie} | 0,25 to 1,25 | k Ω |
| h_{re} | < $4 \cdot 10^{-4}$ | |
| h_{fe} | 75 to 375 | |
| h_{oe} | 25 to 200 | $\mu\Omega^{-1}$ |

DEVELOPMENT SAMPLE DATA

* Measured under pulsed conditions to avoid excessive dissipation; pulse duration $t_p \leq 300 \mu\text{s}$;
duty factor $\delta \leq 0,02$.

Switching times (between 10% and 90% levels)

Turn-on time switched to $I_C = 150 \text{ mA}$ (see Fig. 2)

delay time

rise time

Turn-off time switched from $I_C = 150 \text{ mA}$ (see Fig. 3)

storage time

fall time

| BSR14;R | |
|---------|----------|
| t_d | < 10 ns |
| t_r | < 25 ns |
| t_s | < 225 ns |
| t_f | < 60 ns |

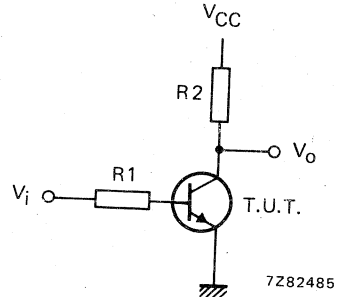
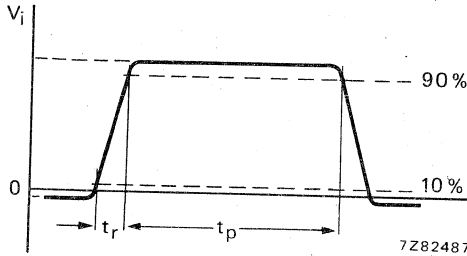


Fig. 2 Waveform and test circuit delay and rise time.

$V_i = -0,5 \text{ to } +9,9 \text{ V}$; $V_{CC} = 30 \text{ V}$; $R_1 = 619 \Omega$; $R_2 = 200 \Omega$.

Pulse generator:

| | |
|----------------|---------------------------|
| pulse duration | $t_p \leq 200 \text{ ns}$ |
| rise time | $t_r \leq 2 \text{ ns}$ |
| duty factor | $\delta = 2\%$ |

Oscilloscope:

| | |
|-------------------|-----------------------------|
| input impedance | $Z_i > 100 \text{ k}\Omega$ |
| input capacitance | $C_i < 12 \text{ pF}$ |
| rise time | $t_r < 5 \text{ ns}$ |

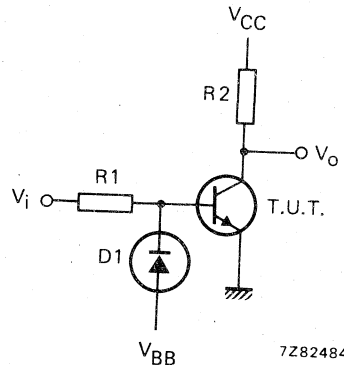
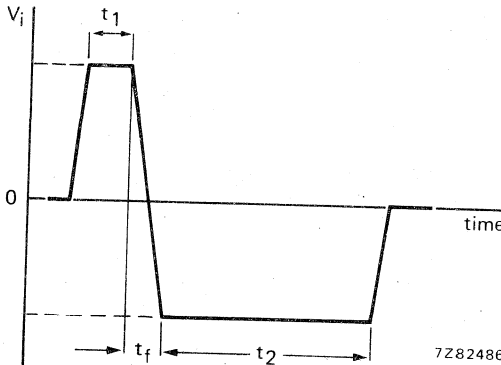


Fig. 3 Waveform and test circuit storage and fall time.

$V_i = -13,8 \text{ to } +16,2 \text{ V}$; $V_{CC} = 30 \text{ V}$; $-V_{BB} = 3 \text{ V}$; $R_1 = 1 \text{ k}\Omega$; $R_2 = 200 \Omega$.

Pulse generator:

| | |
|------------|-------------------------|
| fall time | $t_f < 5 \text{ ns}$ |
| pulse time | $t_1 = 100 \mu\text{s}$ |
| | $t_2 = 500 \mu\text{s}$ |

Oscilloscope:

| | |
|-------------------|-----------------------------|
| input impedance | $Z_i > 100 \text{ k}\Omega$ |
| input capacitance | $C_i < 12 \text{ pF}$ |
| rise time | $t_r < 5 \text{ ns}$ |

DEVELOPMENT SAMPLE DATA

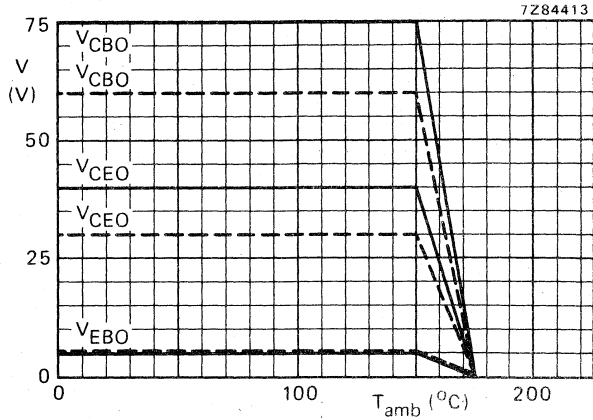


Fig. 4 Voltage derating curve.
--- BSR13; R — BSR14; R.

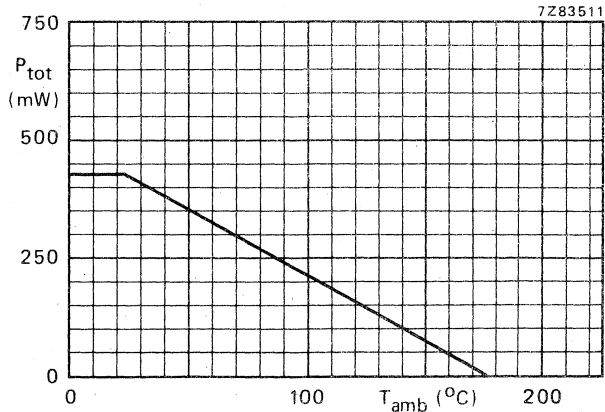


Fig. 5 Power derating curve.

DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not necessarily imply that the device will go into regular production.

BSR15; R
BSR16; R

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P silicon transistors, in a microminiature plastic envelope, intended for medium power switching and general purpose amplifier applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | BSR15; R | | BSR16; R | |
|--|------------|----------|-----|----------|--------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 60 | 60 | V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 40 | 60 | V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ | max. | | 5 | V |
| Collector current (d.c.) | $-I_C$ | max. | 600 | | mA ← |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 425 | | mW ← |
| Junction temperature | T_j | max. | 175 | | $^\circ\text{C}$ ← |
| D.C. current gain | | | | | |
| $-I_C = 500\text{ mA}; -V_{CE} = 10\text{ V}$ | h_{FE} | > | 30 | 50 | |
| Turn-off switching time | | | | | |
| $-I_{Con} = 150\text{ mA}; -I_{Bon} = I_{Boff} = 15\text{ mA}$ | t_{off} | > | 100 | | ns |
| Transition frequency at $f = 100\text{ MHz}$ | | | | | |
| $-I_C = 50\text{ mA}; -V_{CE} = 20\text{ V}$ | f_T | > | 200 | | MHz |

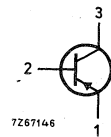
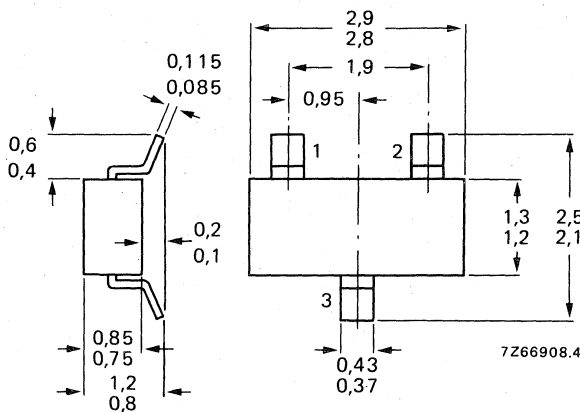
MECHANICAL DATA

Dimensions in mm

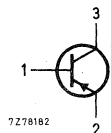
Marking code

Fig. 1 SOT-23.

BSR15 = T7
BSR16 = T8



BSR15R = T71
BSR16R = T81



See also Soldering recommendations.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | BSR15; R | BSR16; R | |
|---|-----------------|--------------|----------|------------------|
| Collector-base voltage (open emitter) See Figs 5 and 6 | $-V_{CBO}$ max. | 60 | 60 | V |
| Collector-emitter voltage (open base) See Figs 5 and 6 | $-V_{CEO}$ max. | 40 | 60 | V |
| Emitter-base voltage (open collector) See Figs 5 and 6 | $-V_{EBO}$ max. | 5 | 5 | V |
| Collector current (d.c.) | $-I_C$ max. | 600 | | mA |
| → Power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$ | P_{tot} max. | 425 | | mW |
| → Storage temperature | T_{stg} | -65 to + 175 | | $^\circ\text{C}$ |
| → Junction temperature | T_j max. | 175 | | $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|-----------------|-----|-----|
| From junction to tab | $R_{th\ j-t}$ = | 30 | K/W |
| From tab to soldering points | $R_{th\ t-s}$ = | 260 | K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ = | 60 | K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| | | BSR15; R | BSR16; R | |
|---|----------------|----------|----------|---------------|
| Collector cut-off current | | | | |
| $I_E = 0; -V_{CB} = 50\text{ V}$ | $-I_{CBO} <$ | 20 | 10 | nA |
| $I_E = 0; -V_{CB} = 50\text{ V}; T_j = 150\text{ }^\circ\text{C}$ | $-I_{CBO} <$ | 20 | 10 | μA |
| $-V_{EB} = 0,5\text{ V}; -V_{CE} = 30\text{ V}$ | $-I_{CEX} <$ | 50 | | nA |
| Base current | | | | |
| with reverse biased emitter junction | | | | |
| $-V_{EB} = 3\text{ V}; -V_{CE} = 30\text{ V}$ | $-I_{BEX} <$ | 50 | | nA |
| Saturation voltages ▲ | | | | |
| $-I_C = 150\text{ mA}; -I_B = 15\text{ mA}$ | $-V_{CEsat} <$ | 0,4 | | V |
| | $-V_{BEsat} <$ | 1,3 | | V |
| | $-V_{CEsat} <$ | 1,6 | | V |
| $-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$ | $-V_{BEsat} <$ | 2,6 | | V |

* See *Thermal characteristics* in chapter GENERAL.

** Device mounted on a ceramic substrate of 15 mm x 15 mm x 0,6 mm.

▲ Measured under pulsed conditions to avoid excessive dissipation pulse duration $t_p \leq 300\text{ }\mu\text{s}$; duty factor $\delta \leq 0,02$.

DEVELOPMENT SAMPLE DATA

D.C. current gain *

- I_C = 0,1 mA; -V_{CE} = 10 V
- I_C = 1 mA; -V_{CE} = 10 V
- I_C = 10 mA; -V_{CE} = 10 V
- I_C = 150 mA; -V_{CE} = 10 V
- I_C = 500 mA; -V_{CE} = 10 V

| | BSR15; R | BSR16; R |
|-------------------|------------|----------|
| h _{FE} > | 35 | 75 |
| h _{FE} > | 50 | 100 |
| h _{FE} > | 75 | 100 |
| h _{FE} | 100 to 300 | |
| h _{FE} > | 30 | 50 |

Transition frequency at f = 100 MHz

- I_C = 50 mA; -V_{CE} = 20 V; T_{amb} = 25 °C

| | | |
|------------------|-----|-----|
| f _T > | 200 | MHz |
|------------------|-----|-----|

Collector capacitance at f = 1 MHz

- I_E = I_e = 0; -V_{CB} = 10 V

| | | |
|------------------|---|----|
| C _c < | 8 | pF |
|------------------|---|----|

Emitter capacitance at f = 1 MHz

- I_C = I_c = 0; -V_{EB} = 2 V

| | | |
|------------------|----|----|
| C _e < | 30 | pF |
|------------------|----|----|

Switching times (between 10% and 90% levels)

Turn-on time when switched to

- I_C = 150 mA; -I_B = 15 mA; (see Fig. 3)
- delay time
- rise time
- turn-on time (t_d + t_r)

| | | |
|-------------------|----|----|
| t _d < | 10 | ns |
| t _r < | 40 | ns |
| t _{on} < | 45 | ns |

Turn-off time when switched from

- I_C = 150 mA; -I_B = 15 mA
- to cut-off with +I_{BM} = 15 mA (see Fig. 4)
- storage time
- fall time
- turn-off time (t_s + t_f)

| | | |
|--------------------|-----|----|
| t _s < | 80 | ns |
| t _f < | 30 | ns |
| t _{off} < | 100 | ns |

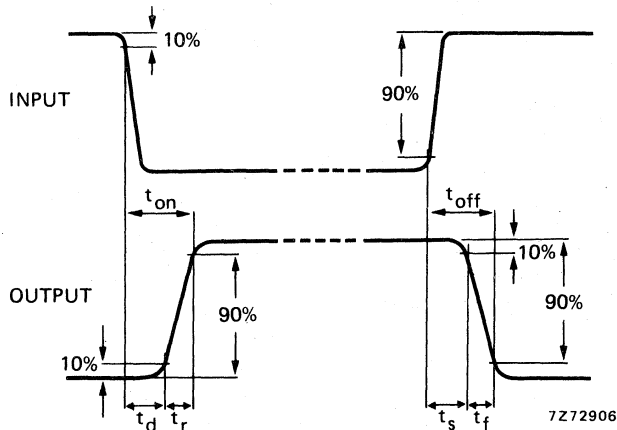


Fig. 2 Switching time waveforms.

* Measured under pulsed conditions to avoid excessive dissipation; pulse duration t_p ≤ 300 μs; duty factor δ ≤ 0,02.

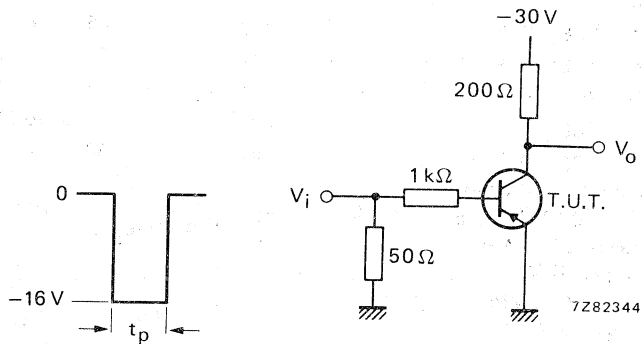


Fig. 3 Turn-on switching time test circuit.

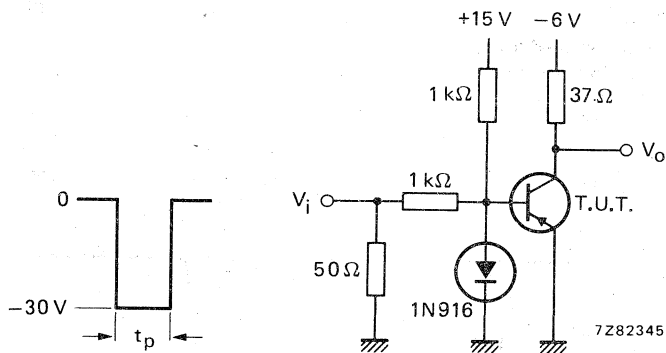


Fig. 4 Turn-off switching time test circuit.

Input pulse generator:
Fig. 3 and Fig. 4

| | | | | |
|------------------|-------|--------|-----|------------|
| frequency | f | = | 150 | Hz |
| pulse duration | t_p | = | 200 | ns |
| rise time | t_r | \leq | 2 | ns |
| output impedance | Z_o | = | 50 | Ω |
| rise time | t_r | \leq | 5 | ns |
| input impedance | Z_i | = | 10 | M Ω |

Output oscilloscope:
Fig. 3 and Fig. 4

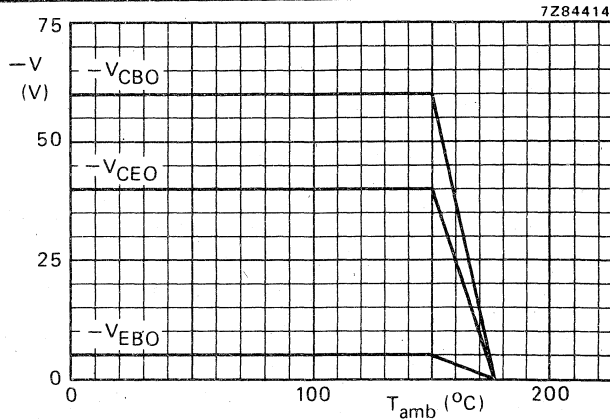


Fig. 5 Voltage derating curves BSR15; R.

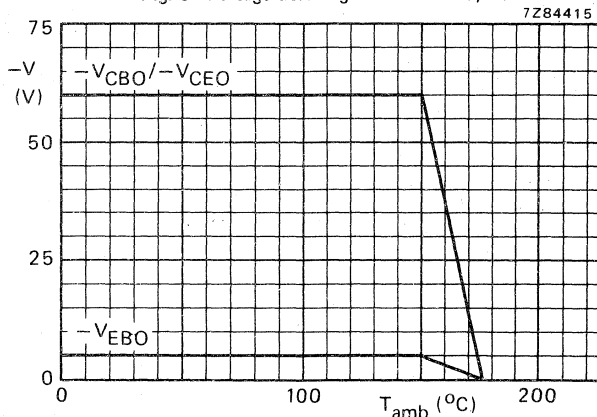


Fig. 6 Voltage derating curves BSR16; R.

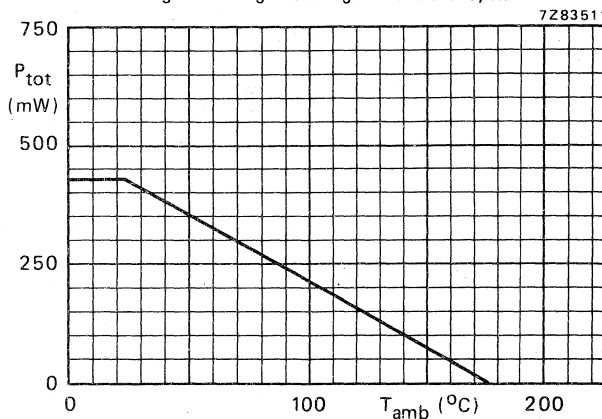


Fig. 7 Power derating curve BSR15; R/BSR16; R.

DEVELOPMENT SAMPLE DATA

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N silicon transistor in a microminiature plastic envelope intended for switching and linear applications in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|--|-----------|------|----------------------|---|
| Collector-base voltage (open emitter) | V_{CB0} | max. | 60 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 40 V | |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 6 V | |
| Collector current (d.c.) | I_C | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ | ← |
| D.C. current gain | | | | |
| $I_C = 50\text{ mA}; V_{CE} = 1\text{ V}$ | h_{FE} | > | 60 | |
| $I_C = 100\text{ mA}; V_{CE} = 1\text{ V}$ | h_{FE} | > | 15 | |
| Transition frequency at $f = 100\text{ MHz}$ | | | | |
| $I_C = 10\text{ mA}; V_{CE} = 20\text{ V}$ | f_T | > | 300 MHz | |

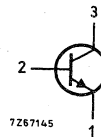
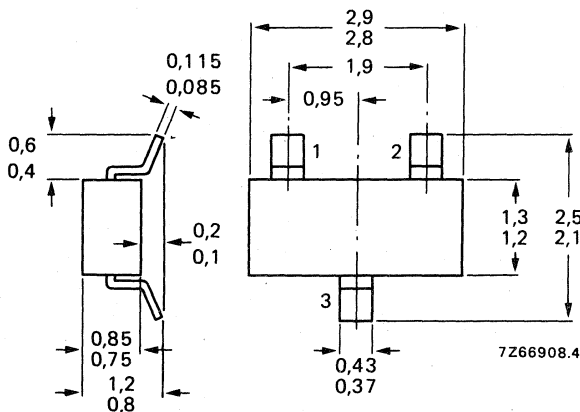
MECHANICAL DATA

Dimensions in mm

Marking code

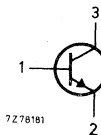
Fig. 1 SOT-23.

BSR17 = U9



7267145

BSR17R = U91



7278181

See also Soldering recommendations.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|-------------------------------|
| Collector-base voltage (open emitter) See Fig. 4 | V_{CBO} | max. | 60 V |
| Collector-emitter voltage (open base) See Fig. 4 | V_{CEO} | max. | 40 V |
| Emitter base voltage (open collector) See Fig. 4 | V_{EBO} | max. | 6 V |
| Collector current (d.c.) | I_C | max. | 200 mA |
| → Power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}^{**}$ | P_{tot} | max. | 350 mW |
| → Storage temperature | T_{stg} | | -65 to + 175 $^\circ\text{C}$ |
| → Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

→ **THERMAL CHARACTERISTICS***

$$T_j = P_x (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Collector cut-off current

$$I_E = 0; V_{CB} = 30\text{ V}; T_j = 150\text{ }^\circ\text{C}$$

$$V_{EB} = 3\text{ V}; V_{CE} = 30\text{ V}$$

| | | |
|-----------|---|-----------------|
| I_{CBO} | < | 5 μA |
| I_{CEX} | < | 50 nA |

Base current

with reverse biased emitter junction

$$V_{EB} = 3\text{ V}; V_{CE} = 30\text{ V}$$

| | | |
|-----------|---|-------|
| I_{BEX} | < | 50 nA |
|-----------|---|-------|

Saturation voltages^Δ

$$I_C = 10\text{ mA}; I_B = 1\text{ mA}$$

| | | |
|-------------|---|---------------|
| V_{CEsat} | < | 200 mV |
| V_{BEsat} | | 650 to 850 mV |
| V_{CEsat} | < | 300 mV |
| V_{BEsat} | < | 950 mV |

$$I_C = 50\text{ mA}; I_B = 5\text{ mA}$$

D.C. current gain^Δ

$$I_C = 0,1\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 50\text{ mA}; V_{CE} = 1\text{ V}$$

$$I_C = 100\text{ mA}; V_{CE} = 1\text{ V}$$

| | | |
|-----|---|------------|
| hFE | > | 40 |
| hFE | > | 70 |
| hFE | | 100 to 300 |
| hFE | > | 60 |
| hFE | > | 15 |

Transition frequency at $f = 100\text{ MHz}$

$$I_C = 10\text{ mA}; V_{CE} = 20\text{ V}$$

| | | |
|-------|---|---------|
| f_T | > | 300 MHz |
|-------|---|---------|

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_C = 0; V_{CB} = 5\text{ V}$$

| | | |
|-------|---|------|
| C_c | < | 4 pF |
|-------|---|------|

^Δ Measured under pulsed conditions; pulse duration $t_p \leq 300\text{ }\mu\text{s}$; duty factor $\delta \leq 0,02$.

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Emitter capacitance at $f = 1$ MHz
 $I_C = I_c = 0; V_{EB} = 0,5$ V

$$C_e < 8 \text{ pF}$$

Switching times (between 10% and 90% levels)

Turn on time switched to
 $I_C = 10 \text{ mA}; I_B = 1 \text{ mA}; V_{EB} = 0,5$ V
 delay time
 rise time

$$t_d < 35 \text{ ns}$$

$$t_r < 35 \text{ ns}$$

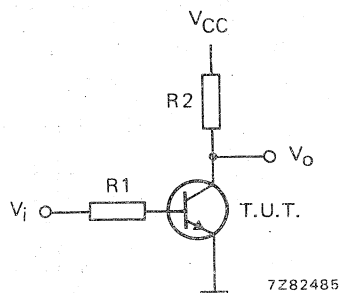
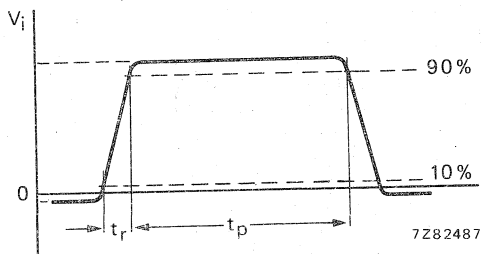


Fig. 2 Delay and rise time equivalent circuit.

$V_i = -0,5$ to $+10,6$ V; $V_{CC} = 3$ V; $R_1 = 10 \text{ k}\Omega$; $R_2 = 275 \Omega$;
 total shunt capacitance of test jig and connectors = $C_s \leq 4 \text{ pF}$.
 Pulse generator: pulse duration 300 ns; fall time < 1 ns; duty factor 2%.

Turn off time switched from
 $I_C = 10 \text{ mA}; I_{Bon} = -I_{Boff} = 1 \text{ mA}$
 storage time
 fall time

$$t_s < 200 \text{ ns}$$

$$t_f < 50 \text{ ns}$$

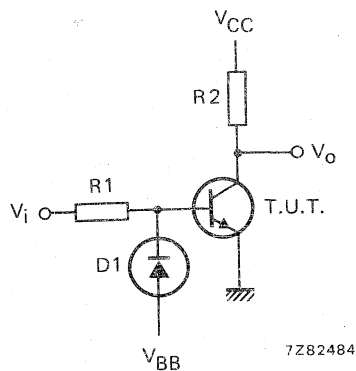
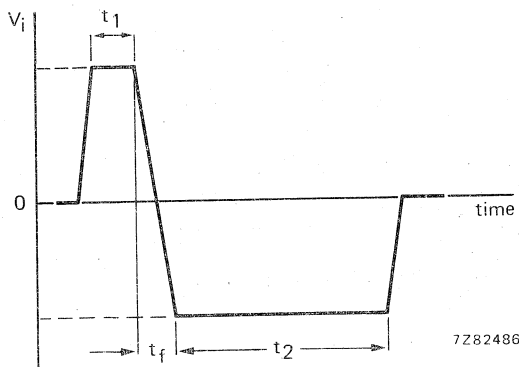


Fig. 3 Storage and fall time equivalent test circuit.

$V_i = -9,1$ to $+10,9$ V; $V_{CC} = 3$ V; $V_{BB} = 0$ V (ground); $R_1 = 10 \text{ k}\Omega$; $R_2 = 275 \Omega$;
 total shunt capacitance of test jig and connectors = $C_s \leq 4 \text{ pF}$.
 Pulse generator: pulse duration $t_1 = 10$ to $500 \mu\text{s}$; fall time $t_f < 1$ ns; duty factor $\delta = 2\%$.

h parameters (common emitter)

$I_C = 1 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $f = 1 \text{ kHz}$

input impedance

reverse voltage transfer ratio

small signal current gain

output admittance

h_{ie}

h_{re}

h_{fe}

h_{oe}

1 to 10 $k\Omega$

0,5 to 8 10^{-4}

100 to 400

1 to 40 $\mu A/V$

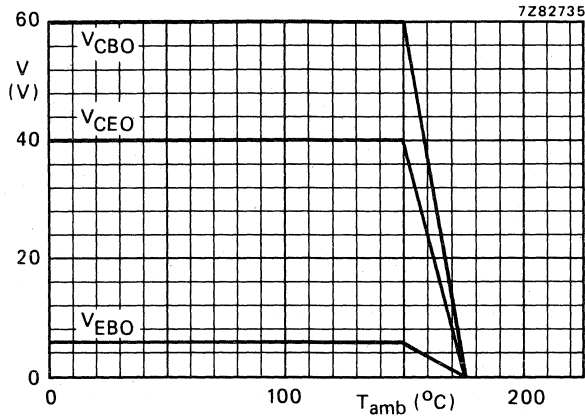


Fig. 4 Voltage derating curves.

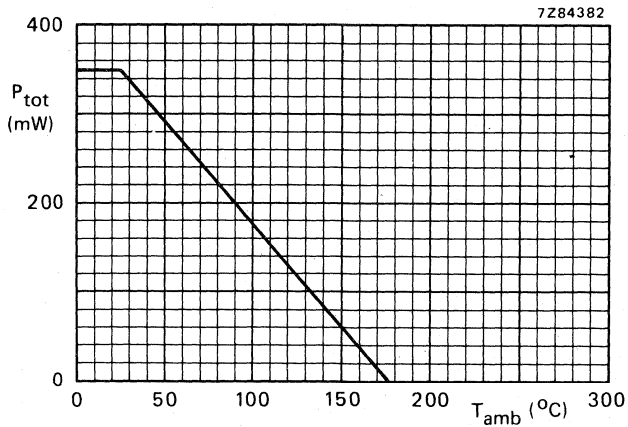


Fig. 5 Power derating curve.

DEVELOPMENT SAMPLE DATA

This information is derived from development samples made available for evaluation. It does not form part of our data handbook system and does not necessarily imply that the device will go into production

BSR30 to 33

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors in miniature plastic envelopes intended for application in thick and thin-film circuits. They are intended for use in telephony and general industrial applications.

QUICK REFERENCE DATA

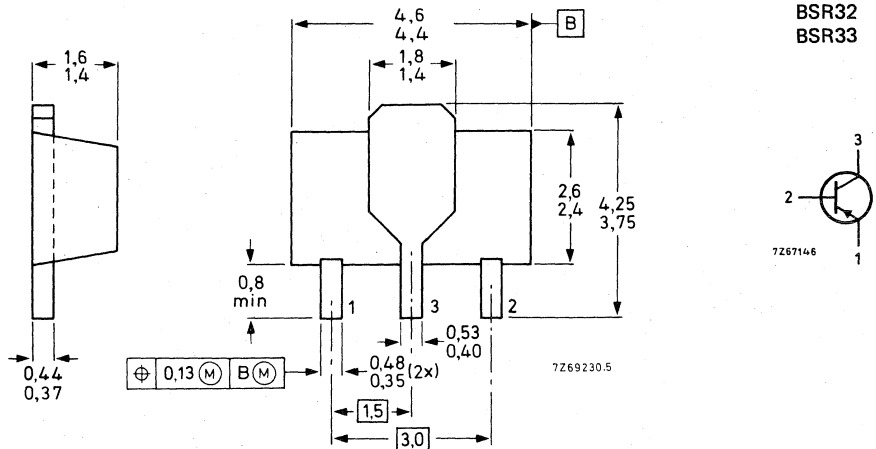
| | | BSR30 | BSR31 | BSR32 | BSR33 |
|--|-----------------|---------|-------|-------|----------------------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 70 | 70 | 90 | 90 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 60 | 60 | 80 | 80 V |
| Collector current (d.c.) | $-I_C$ max. | 1 | 1 | 1 | 1 A |
| Total power dissipation up to $T_{amb} = 25^\circ\text{C}$ | P_{tot} max. | 1 | 1 | 1 | 1 W |
| Junction temperature | T_j max. | 150 | 150 | 150 | 150 $^\circ\text{C}$ |
| D.C. current gain | | | | | |
| $-I_C = 100\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | > 40 | 100 | 40 | 100 |
| | | < 120 | 300 | 120 | 300 |
| Transition frequency at $f = 35\text{ MHz}$ | | | | | |
| $-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$ | f_T | > 100 | 100 | 100 | 100 MHz |

MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.



See also *Soldering recommendations.*

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

| | | BSR30 | BSR31 | BSR32 | BSR33 |
|---------------------------------------|-----------------|-------|-------|-------|-------|
| Collector-base voltage (open emitter) | $-V_{CBO}$ max. | 70 | 70 | 90 | 90 V |
| Collector-emitter voltage (open base) | $-V_{CEO}$ max. | 60 | 60 | 80 | 80 V |
| Emitter-base voltage (open collector) | $-V_{EBO}$ max. | 5 | 5 | 5 | 5 V |

Currents

| | | | | | |
|--------------------------|-------------|--|--|-----|---|
| Collector current (d.c.) | $-I_C$ max. | | | 1 | A |
| Base current (d.c.) | $-I_B$ max. | | | 0,1 | A |

Power dissipation

| | | | | | |
|---|----------------|--|--|---|---|
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | P_{tot} max. | | | 1 | W |
|---|----------------|--|--|---|---|

Temperatures

| | | | | | |
|----------------------|------------|--|--|-------------|------------------|
| Storage temperature | T_{stg} | | | -65 to +150 | $^\circ\text{C}$ |
| Junction temperature | T_j max. | | | 150 | $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | | | |
|---|-------------------|--|--|-----|--------------------|
| From junction to collector tab | $R_{th\ j-tab}$ = | | | 10 | $^\circ\text{C/W}$ |
| From junction to ambient in free air mounted on a ceramic substrate area = 2,5 cm ² ; thickness = 0,7 mm | $R_{th\ j-a}$ = | | | 125 | $^\circ\text{C/W}$ |

CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 60\text{ V}$$

$$-I_{CBO} < \begin{matrix} 100 \\ 50 \end{matrix} \quad \begin{matrix} \text{nA} \\ \mu\text{A} \end{matrix}$$

$$I_E = 0; -V_{CB} = 60\text{ V}; T_j = 150\text{ }^{\circ}\text{C}$$

$$-I_{CBO} < \begin{matrix} 100 \\ 50 \end{matrix} \quad \begin{matrix} \text{nA} \\ \mu\text{A} \end{matrix}$$

Breakdown voltages

$$I_B = 0; -I_C = 10\text{ mA}$$

$$-V_{(BR)CEO} > \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$V_{BE} = 0; -I_C = 10\text{ }\mu\text{A}$$

$$-V_{(BR)CES} > \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$I_C = 0; -I_E = 10\text{ }\mu\text{A}$$

$$-V_{(BR)EBO} > \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 60 \\ 70 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} 80 \\ 90 \\ 5 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

Saturation voltages *

$$-I_C = 150\text{ mA}; -I_B = 15\text{ mA}$$

$$-V_{CEsat} < \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$-V_{BEsat} < \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$-I_C = 500\text{ mA}; -I_B = 50\text{ mA}$$

$$-V_{CEsat} < \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$-V_{BEsat} < \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} 0,25 \\ 1,0 \\ 0,5 \\ 1,2 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

D.C. current gain *

$$-I_C = 100\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$-I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

$$-I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} 10 \\ 40 \\ 120 \\ 30 \end{matrix} \quad \begin{matrix} 30 \\ 100 \\ 300 \\ 50 \end{matrix} \quad \begin{matrix} \text{V} \\ \text{V} \\ \text{V} \\ \text{V} \end{matrix}$$

Transition frequency at $f = 35\text{ MHz}$

$$-I_C = 50\text{ mA}; -V_{CE} = 10\text{ V}$$

$$f_T > \begin{matrix} 100 \end{matrix} \quad \text{MHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_c = 0; -V_{CB} = 10\text{ V}$$

$$C_c < \begin{matrix} 20 \end{matrix} \quad \text{pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_c = 0; -V_{EB} = 0,5\text{ V}$$

$$C_e < \begin{matrix} 120 \end{matrix} \quad \text{pF}$$

Switching times see page 4

DEVELOPMENT SAMPLE DATA

* Measured under pulse conditions: $t_p = 300\text{ }\mu\text{s}$; $\delta < 0,01$.

CHARACTERISTICS (continued)

$T_{amb} = 25\text{ }^{\circ}\text{C}$

Switching times

$-I_{Con} = 100\text{ mA}; -I_{Boff} = +I_{Boff} = 5\text{ mA}$

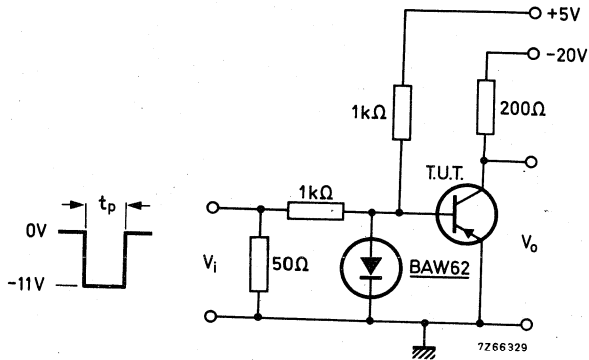
Turn-on time

$t_{on} < 500\text{ ns}$

Turn-off time

$t_{off} < 650\text{ ns}$

Test circuit



Pulse generator:

Pulse duration $t_p = 10\text{ }\mu\text{s}$
 Rise time $t_r \leq 15\text{ ns}$
 Fall time $t_f \leq 15\text{ ns}$
 Source impedance $Z_S = 50\text{ }\Omega$

Oscilloscope:

Rise time $t_r \leq 15\text{ ns}$
 Input impedance $Z_I \geq 100\text{ k}\Omega$

SILICON PLANAR EPITAXIAL TRANSISTORS

N-P-N transistors in miniature plastic envelopes intended for application in thick and thin-film circuits. They are intended for use in telephony and general industrial applications.

QUICK REFERENCE DATA

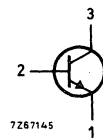
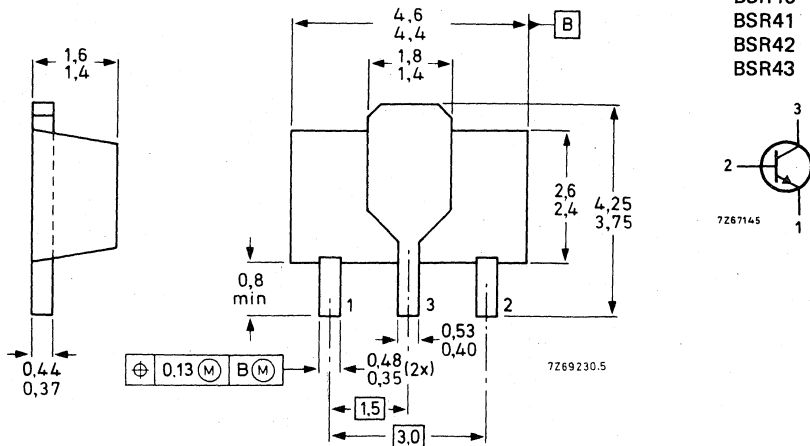
| | | BSR40 | BSR41 | BSR42 | BSR43 |
|--|----------------|-------|-------|-------|----------------------|
| Collector-base voltage (open emitter) | V_{CBO} max. | 70 | 70 | 90 | 90 V |
| Collector-emitter voltage (open base) | V_{CEO} max. | 60 | 60 | 80 | 80 V |
| Collector current (d.c.) | I_C max. | 1 | 1 | 1 | 1 A |
| Total power dissipation up to $T_{amb} = 25^\circ\text{C}$ | P_{tot} max. | 1 | 1 | 1 | 1 W |
| Junction temperature | T_j max. | 150 | 150 | 150 | 150 $^\circ\text{C}$ |
| D.C. current gain | h_{FE} | > 40 | 100 | 40 | 100 |
| $I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$ | | < 120 | 300 | 120 | 300 |
| Transition frequency at $f = 35\text{ MHz}$ | f_T | > 100 | 100 | 100 | 100 MHz |
| $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$ | | | | | |

MECHANICAL DATA

Dimensions in mm

Mark

Fig. 1 SOT-89.



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

| | | BSR40 | BSR41 | BSR42 | BSR43 |
|---------------------------------------|----------------|-------|-------|-------|-------|
| Collector-base voltage (open emitter) | V_{CBO} max. | 70 | 70 | 90 | 90 V |
| Collector-emitter voltage (open base) | V_{CEO} max. | 60 | 60 | 80 | 80 V |
| Emitter-base voltage (open collector) | V_{EBO} max. | 5 | 5 | 5 | 5 V |

Currents

| | | | | | |
|--------------------------|------------|--|--|-----|---|
| Collector current (d.c.) | I_C max. | | | 1 | A |
| Base current (d.c.) | I_B max. | | | 0,1 | A |

Power dissipation

| | | | | | |
|--|----------------|--|--|---|---|
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ mounted on a ceramic substrate area = $2,5\text{ cm}^2$; thickness = $0,7\text{ mm}$ | P_{tot} max. | | | 1 | W |
|--|----------------|--|--|---|---|

Temperatures

| | | | | | |
|----------------------|------------|--|-------------|--|------------------|
| Storage temperature | T_{stg} | | -65 to +150 | | $^\circ\text{C}$ |
| Junction temperature | T_j max. | | 150 | | $^\circ\text{C}$ |

THERMAL RESISTANCE

| | | | | | |
|--|-------------------|--|-----|--|--------------------|
| From junction to collector tab | $R_{th\ j-tab}$ = | | 10 | | $^\circ\text{C/W}$ |
| From junction to ambient in free air mounted on a ceramic substrate area = $2,5\text{ cm}^2$; thickness = $0,7\text{ mm}$ | $R_{th\ j-a}$ = | | 125 | | $^\circ\text{C/W}$ |

CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 60\text{ V}$$

$$I_{CBO} < \begin{matrix} 100 \\ 50 \end{matrix} \begin{matrix} \text{nA} \\ \mu\text{A} \end{matrix}$$

$$I_E = 0; V_{CB} = 60\text{ V}; T_j = 150\text{ }^{\circ}\text{C}$$

$$I_{CBO} < \begin{matrix} 100 \\ 50 \end{matrix} \begin{matrix} \text{nA} \\ \mu\text{A} \end{matrix}$$

Breakdown voltages

$$I_B = 0; I_C = 10\text{ mA}$$

$$V_{(BR)CEO} > \begin{matrix} 60 & 60 & 80 & 80 \end{matrix} \text{ V}$$

$$V_{BE} = 0; I_C = 10\text{ }\mu\text{A}$$

$$V_{(BR)CES} > \begin{matrix} 70 & 70 & 90 & 90 \end{matrix} \text{ V}$$

$$I_C = 0; I_E = 10\text{ }\mu\text{A}$$

$$V_{(BR)EBO} > \begin{matrix} 5 & 5 & 5 & 5 \end{matrix} \text{ V}$$

Saturation voltages *

$$I_C = 150\text{ mA}; I_B = 15\text{ mA}$$

$$V_{CEsat} < \begin{matrix} 0,25 & 0,25 & 0,25 & 0,25 \end{matrix} \text{ V}$$

$$V_{BEsat} < \begin{matrix} 1,0 & 1,0 & 1,0 & 1,0 \end{matrix} \text{ V}$$

$$I_C = 500\text{ mA}; I_B = 50\text{ mA}$$

$$V_{CEsat} < \begin{matrix} 0,5 & 0,5 & 0,5 & 0,5 \end{matrix} \text{ V}$$

$$V_{BEsat} < \begin{matrix} 1,2 & 1,2 & 1,2 & 1,2 \end{matrix} \text{ V}$$

D.C. current gain *

$$I_C = 100\text{ }\mu\text{A}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 10 & 30 & 10 & 30 \end{matrix}$$

$$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} > \begin{matrix} 40 & 100 & 40 & 100 \end{matrix}$$

$$I_C = 500\text{ mA}; V_{CE} = 5\text{ V}$$

$$h_{FE} < \begin{matrix} 120 & 300 & 120 & 300 \end{matrix}$$

$$h_{FE} > \begin{matrix} 30 & 50 & 30 & 50 \end{matrix}$$

Transition frequency at $f = 35\text{ MHz}$

$$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$$

$$f_T > \begin{matrix} 100 \end{matrix} \text{ MHz}$$

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 10\text{ V}$$

$$C_c < \begin{matrix} 12 \end{matrix} \text{ pF}$$

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 0,5\text{ V}$$

$$C_e < \begin{matrix} 90 \end{matrix} \text{ pF}$$

Switching times see page 4

* Measured under pulse conditions: $t_p = 300\text{ }\mu\text{s}$; $\delta < 0,01$.

CHARACTERISTICS (continued)

$T_{amb} = 25\text{ }^{\circ}\text{C}$

Switching times

$I_{Con} = 100\text{ mA}; I_{Bon} = -I_{Boff} = 5\text{ mA}$

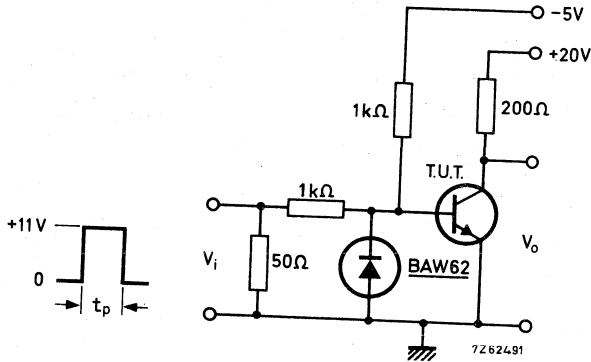
Turn-on time

Turn-off time

Test circuit

$t_{on} < 250\text{ ns}$

$t_{off} < 1000\text{ ns}$



Pulse generator:

Pulse duration $t_p = 10\text{ }\mu\text{s}$
 Rise time $t_r \leq 15\text{ ns}$
 Fall time $t_f \leq 15\text{ ns}$
 Source impedance $Z_S = 50\text{ }\Omega$

Oscilloscope:

Rise time $t_r \leq 15\text{ ns}$
 Input impedance $Z_I \geq 100\text{ k}\Omega$

N-CHANNEL FETS

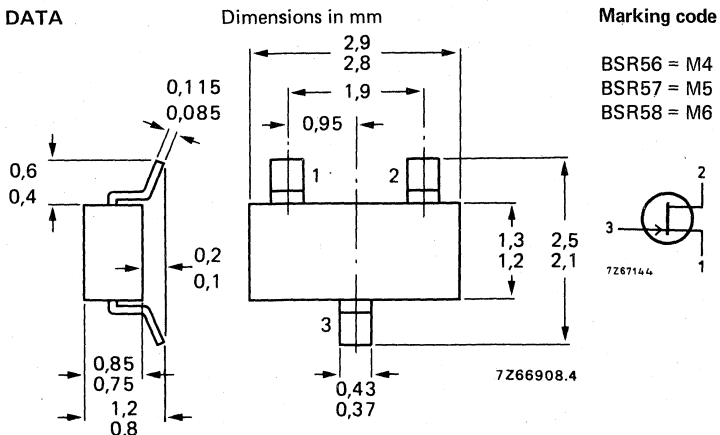
Silicon n-channel depletion type junction field-effect transistors in a plastic microminiature envelope intended for application in thick and thin-film circuits. The transistors are intended for low-power, chopper or switching applications in industrial service.

QUICK REFERENCE DATA

| | | BSR56 | BSR57 | BSR58 |
|--|--------------|----------|-------|-------------|
| Drain-source voltage | $\pm V_{DS}$ | max. 40 | 40 | 40 V |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} | max. 250 | 250 | 250 mW ← |
| Drain current $V_{DS} = 15\text{ V}; V_{GS} = 0$ | I_{DSS} | > 50 | 20 | 8 mA |
| | | < - | 100 | 80 mA |
| Gate-source cut-off voltage $V_{DS} = 15\text{ V}; I_D = 0,5\text{ nA}$ | $-V_{(P)GS}$ | > 4 | 2 | 0,8 V |
| | | < 10 | 6 | 4 V |
| Drain-source resistance (on) at $f = 1\text{ kHz}$ $I_D = 0; V_{GS} = 0$ | $r_{ds\ on}$ | < 25 | 40 | 60 Ω |
| | | | | |
| Feedback capacitance at $f = 1\text{ MHz}$ $-V_{GS} = 10\text{ V}; V_{DS} = 0$ | C_{rs} | < 5 | 5 | 5 pF |
| | | | | |
| Turn-off time $V_{DD} = 10\text{ V}; V_{GS} = 0$ $I_D = 20\text{ mA}; -V_{GSM} = 10\text{ V}$ $I_D = 10\text{ mA}; -V_{GSM} = 6\text{ V}$ $I_D = 5\text{ mA}; -V_{GSM} = 4\text{ V}$ | t_{off} | < 25 | - | - ns |
| | t_{off} | < - | 50 | - ns |
| | t_{off} | < - | - | 100 ns |
| | t_{off} | < - | - | - |

MECHANICAL DATA

Fig. 1 SOT-23.



See also *Soldering Recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|--|--------------|------|-----------------|
| Drain-source voltage (See Fig. 4) | $\pm V_{DS}$ | max. | 40 V |
| Drain-gate voltage (See Fig. 4) | V_{DGO} | max. | 40 V |
| Gate-source voltage (See Fig. 4) | $-V_{GSO}$ | max. | 40 V |
| Forward gate current | I_{GF} | max. | 50 mA |
| → Total power dissipation up to $T_{amb} = 65^\circ C$ | P_{tot} | max. | 250 mW |
| → Storage temperature | T_{stg} | | -55 to + 175 °C |
| → Junction temperature | T_j | max. | 175 °C |

→ **THERMAL CHARACTERISTICS***

$$T_j = P (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

From junction to tab

From tab to soldering points

From soldering points to ambient**

| | | |
|--------------|---|---------|
| $R_{th j-t}$ | = | 60 K/W |
| $R_{th t-s}$ | = | 260 K/W |
| $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_{amb} = 25^\circ C$ unless otherwise specified

Gate-source cut-off current

$$V_{DS} = 0 V; -V_{GS} = 20 V$$

$$-I_{GSS} < 1 \text{ nA}$$

Drain cut-off current

$$V_{DS} = 15 V; -V_{GS} = 10 V$$

$$I_{DSX} < 1 \text{ nA}$$

| | BSR56 | BSR57 | BSR58 |
|--|-------|-------|-------|
|--|-------|-------|-------|

Drain current Δ

$$V_{DS} = 15 V; V_{GS} = 0$$

| | | | | |
|-----------|---|----|-----|-------|
| I_{DSS} | > | 50 | 20 | 8 mA |
| | < | - | 100 | 80 mA |

Gate-source breakdown voltage

$$-I_G = 1 \mu A; V_{DS} = 0$$

$$-V_{(BR)GSS} > 40 \text{ V}$$

Gate-source cut-off voltage

$$I_D = 0,5 \text{ nA}; V_{DS} = 15 V$$

$$-V_{(P)GS} > 4 \text{ V}$$

Drain-source voltage (on)

$$I_D = 20 \text{ mA}; V_{GS} = 0$$

$$V_{DSon} < 750 \text{ mV}$$

$$I_D = 10 \text{ mA}; V_{GS} = 0$$

$$V_{DSon} < 500 \text{ mV}$$

$$I_D = 5 \text{ mA}; V_{GS} = 0$$

$$V_{DSon} < 400 \text{ mV}$$

Drain-source resistance (on) at $f = 1 \text{ kHz}$

$$I_D = 0; V_{GS} = 0$$

$$r_{ds on} < 25 \text{ } \Omega$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Δ Measured under pulsed conditions; $t_p = 100 \text{ ms}$; $\delta \leq 0,1$.

Switching times*

$V_{DD} = 10\text{ V}; V_{GS} = 0$
Conditions I_D and $-V_{GSM}$

Delay time
Rise time
Turn-off time

I_D
 $-V_{GSM}$
 t_d
 t_r
 t_{off}

| | BSR56 | BSR57 | BSR58 |
|------------|-------|-------|--------|
| I_D | = 20 | 10 | 5 mA |
| $-V_{GSM}$ | = 10 | 6 | 4 V |
| t_d | < 6 | 6 | 10 ns |
| t_r | < 3 | 4 | 10 ns |
| t_{off} | < 25 | 50 | 100 ns |

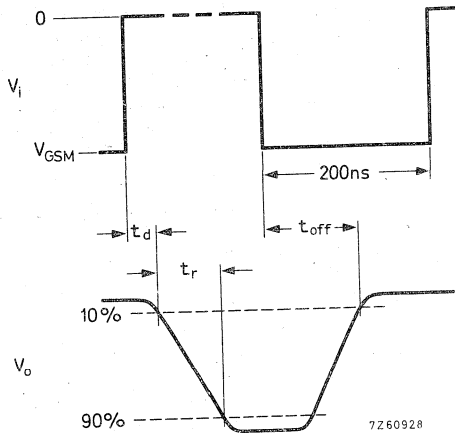


Fig. 2 Switching times waveforms.

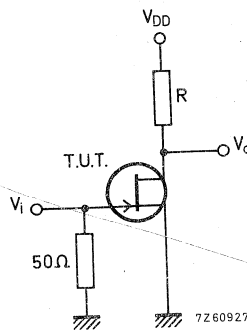


Fig. 3 Test circuit.

BSR56; $R = 464\ \Omega$
BSR57; $R = 953\ \Omega$
BSR58; $R = 1910\ \Omega$

Pulse generator

$t_r = t_f \leq 1\text{ ns}$
 $\delta = 0,02$
 $Z_o = 50\ \Omega$

Oscilloscope

$t_r \leq 0,75\text{ ns}$
 $R_i \geq 1\text{ M}\Omega$
 $C_i \leq 2,5\text{ pF}$

* Switching times measured on devices in SOT-18 envelope.

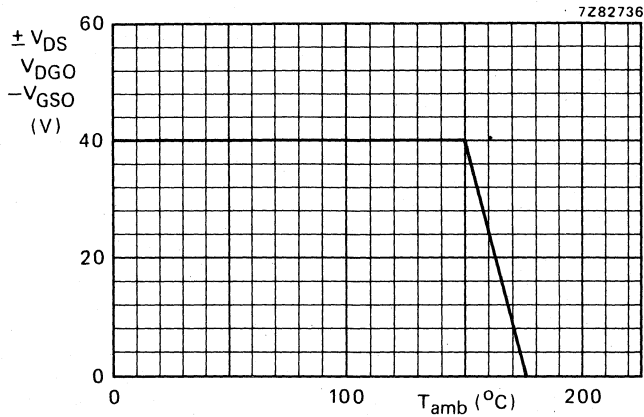


Fig. 4 Voltage derating curve.

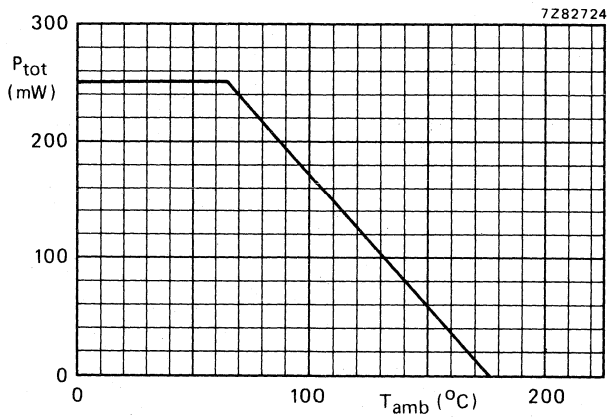


Fig. 5 Power derating curve.

HIGH VOLTAGE P-N-P TRANSISTORS

Silicon planar epitaxial transistor in a microminiature plastic envelope intended for application in thick and thin-film circuits. This transistor is intended for high voltage general purpose and switching applications.

QUICK REFERENCE DATA

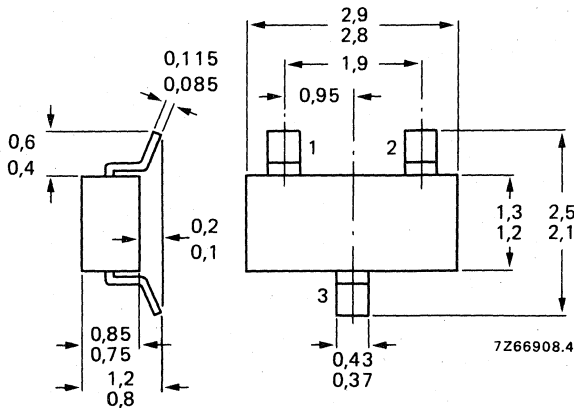
| | | | | |
|--|------------|------|------------------------|---|
| Collector-base voltage (open emitter) | $-V_{CBO}$ | max. | 110 V | |
| Collector-emitter voltage (open base) | $-V_{CEO}$ | max. | 100 V | |
| Collector current (peak value) | $-I_{CM}$ | max. | 100 mA | |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 350 mW | ← |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $-I_C = 25\text{ mA}; -V_{CE} = 5\text{ V}$ | h_{FE} | > | 30 | |
| Transition frequency at $f = 35\text{ MHz}$ $-I_C = 25\text{ mA}; -V_{CE} = 5\text{ V}$ | f_T | > | 50 MHz | |
| | | typ. | 85 MHz | |

MECHANICAL DATA

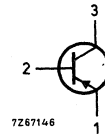
Dimensions in mm

Marking code

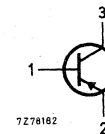
Fig. 1 SOT-23.



BSS63 = T3



BSS63R = T6



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 6

$$-I_C = 10 \mu A$$

$$-V_{CBO} \text{ max. } 110 \text{ V}$$

Collector-emitter voltage (open base) see Fig. 6

$$-I_C = 100 \mu A$$

$$-V_{CEO} \text{ max. } 100 \text{ V}$$

Emitter-base voltage (open collector) see Fig. 6

$$-I_E = 10 \mu A$$

$$-V_{EBO} \text{ max. } 6 \text{ V}$$

Collector current (d.c.)

$$-I_C \text{ max. } 100 \text{ mA}$$

Collector current (peak value)

$$-I_{CM} \text{ max. } 100 \text{ mA}$$

Base current (peak value)

$$-I_{BM} \text{ max. } 100 \text{ mA}$$

→ Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}$ **

$$P_{tot} \text{ max. } 350 \text{ mW}$$

→ Storage temperature

$$T_{stg} \text{ } -65 \text{ to } +175 \text{ }^\circ\text{C}$$

→ Junction temperature

$$T_j \text{ max. } 175 \text{ }^\circ\text{C}$$

→ **THERMAL CHARACTERISTICS ***

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

From junction to tab

$$R_{th j-t} = 50 \text{ K/W}$$

From tab to soldering points

$$R_{th t-s} = 260 \text{ K/W}$$

From soldering points to ambient **

$$R_{th s-a} = 120 \text{ K/W}$$

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 90 \text{ V}$$

$$-I_{CBO} < 100 \text{ nA}$$

$$I_E = 0; -V_{CB} = 90 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$$

$$-I_{CBO} < 50 \mu A$$

Emitter cut-off current

$$I_C = 0; -V_{EB} = 6 \text{ V}$$

$$-I_{EBO} < 200 \text{ nA}$$

Saturation voltage

$$-I_C = 25 \text{ mA}; -I_B = 2,5 \text{ mA}$$

$$-V_{CEsat} < 250 \text{ mV}$$

$$-V_{BEsat} < 900 \text{ mV}$$

D.C. current gain

$$-I_C = 10 \text{ mA}; -V_{CE} = 1 \text{ V}$$

$$h_{FE} > 30$$

$$-I_C = 25 \text{ mA}; -V_{CE} = 1 \text{ V}$$

$$h_{FE} > 30$$

Collector capacitance at $f = 1 \text{ MHz}$

$$I_E = I_e = 0; -V_{CB} = 10 \text{ V}$$

$$C_c \text{ typ. } 3 \text{ pF}$$

Transition frequency at $f = 35 \text{ MHz}$

$$-I_C = 25 \text{ mA}; -V_{CE} = 5 \text{ V}$$

$$f_T > 50 \text{ MHz}$$

$$\text{typ. } 85 \text{ MHz}$$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

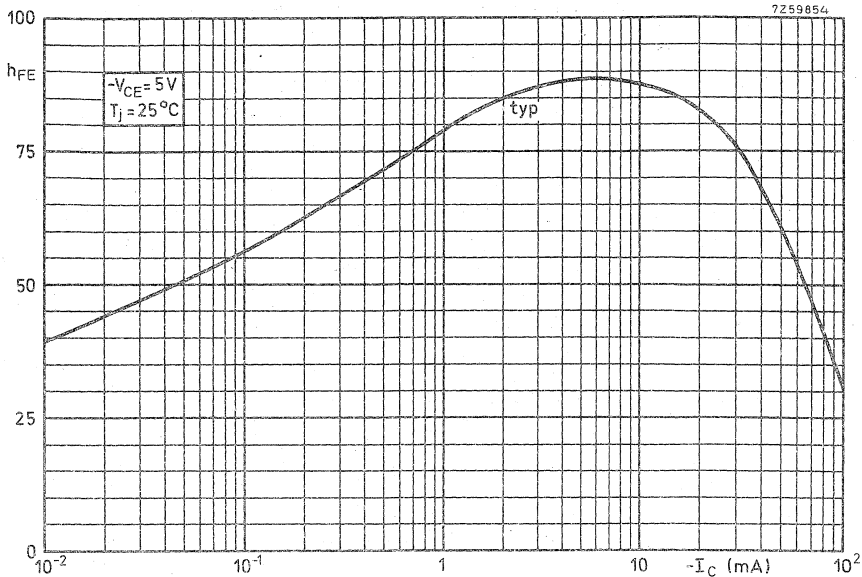


Fig. 2.

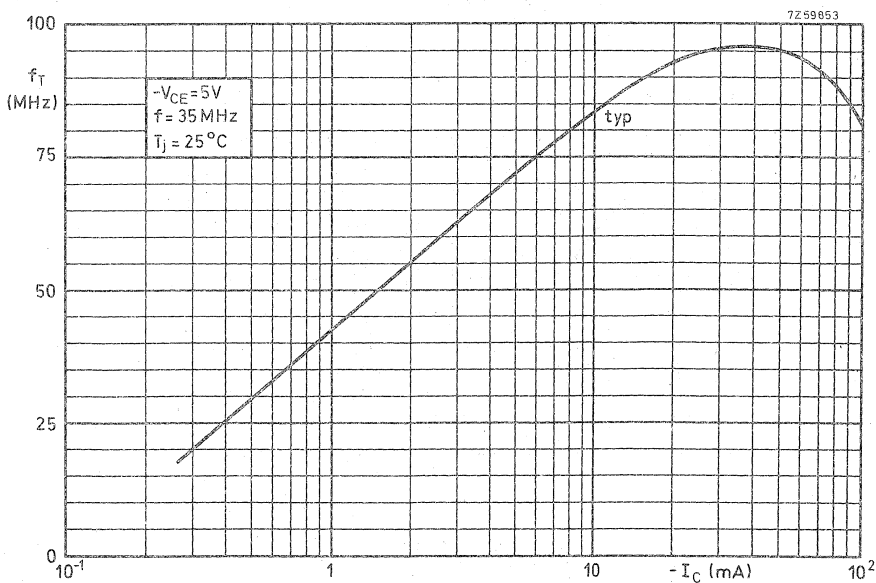


Fig. 3.

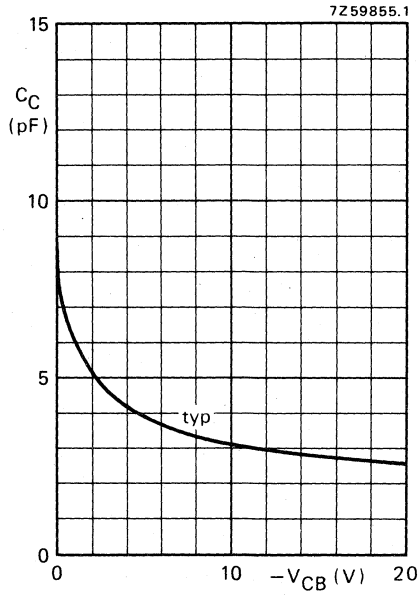


Fig. 4 Typical values collector capacitance as a function of collector-base voltage.
 $I_E = I_e = 0$; $T_j = 25^\circ\text{C}$; $f = 1\text{ MHz}$.

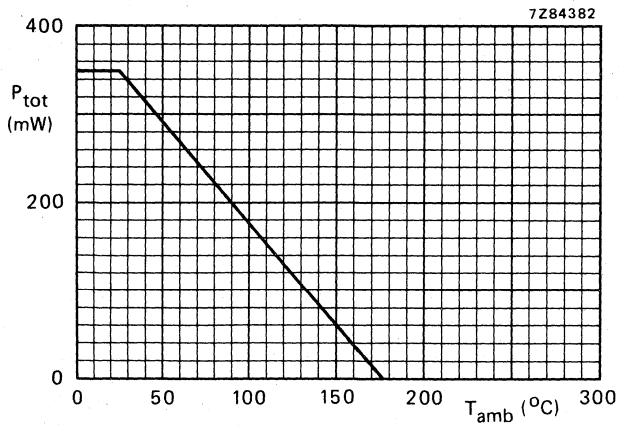


Fig. 5 Power derating curve.

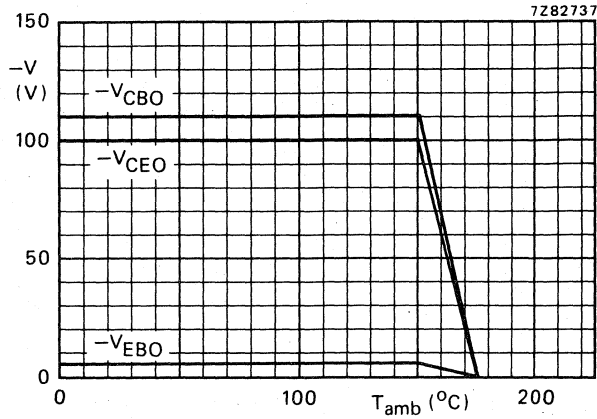


Fig. 6 Voltage derating curves.

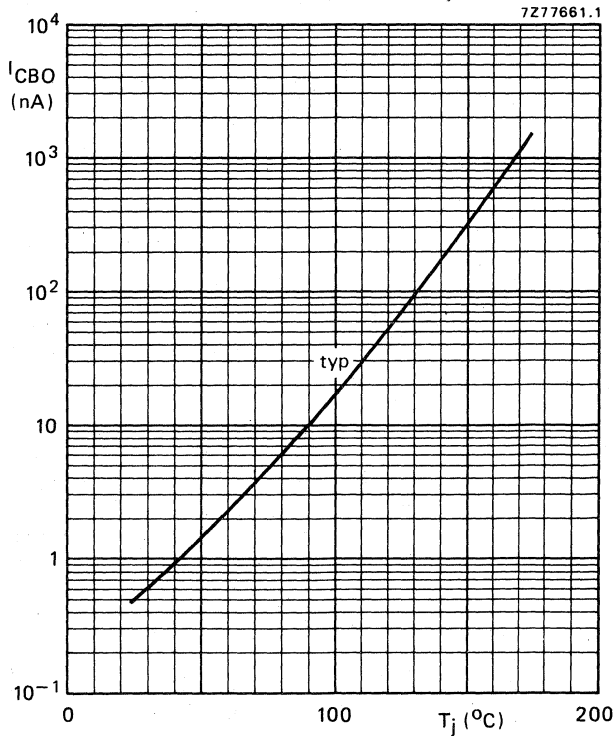


Fig. 7 Typical values collector-base currents as a function of the junction temperature at a collector-base voltage of 90 V.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter) see Fig. 2

$I_C = 100 \mu A$

$V_{CB0} \text{ max. } 120 \text{ V}$

Collector-emitter voltage (open base) see Fig. 2

$I_C = 4 \text{ mA}$

$V_{CEO} \text{ max. } 80 \text{ V}$

Emitter-base voltage (open collector) see Fig. 2

$I_E = 100 \mu A$

$V_{EBO} \text{ max. } 5 \text{ V}$

Collector current

(d.c. or averaged over any 20 ms period)

$I_C \text{ max. } 100 \text{ mA}$

Collector current (peak value)

$I_{CM} \text{ max. } 250 \text{ mA}$

Base current (peak value)

$I_{BM} \text{ max. } 100 \text{ mA}$

→ Total power dissipation up to $T_{amb} = 25 \text{ }^\circ\text{C}^{**}$

$P_{tot} \text{ max. } 350 \text{ mW}$

→ Storage temperature

$T_{stg} -65 \text{ to } +175 \text{ }^\circ\text{C}$

→ Junction temperature

$T_j \text{ max. } 175 \text{ }^\circ\text{C}$

→ **THERMAL CHARACTERISTICS ***

$T_j = P \times (R_{thj-t} + R_{tht-s} + R_{ths-a}) + T_{amb}$

Thermal resistance

From junction to tab

$R_{thj-t} = 50 \text{ K/W}$

From tab to soldering points

$R_{tht-s} = 260 \text{ K/W}$

From soldering points to ambient **

$R_{ths-a} = 120 \text{ K/W}$

CHARACTERISTICS

$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified

Collector cut-off current

$I_E = 0; V_{CB} = 90 \text{ V}$

$I_{CBO} < 100 \text{ nA}$

$I_E = 0; V_{CB} = 90 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$

$I_{CBO} < 50 \mu A$

Emitter cut-off current

$I_C = 0; V_{EB} = 5 \text{ V}$

$I_{EBO} \text{ typ. } 0,5 \text{ nA}$

Saturation voltages

$I_C = 4 \text{ mA}; I_B = 400 \mu A$

$I_{EBO} < 200 \text{ nA}$

$I_C = 50 \text{ mA}; I_B = 15 \text{ mA}$

$V_{CEsat} < 150 \text{ mV}$

$V_{BEsat} < 1200 \text{ mV}$

$V_{CEsat} < 200 \text{ mV}$

D.C. current gain

$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}$

$h_{FE} \text{ typ. } 60$

$I_C = 10 \text{ mA}; V_{CE} = 1 \text{ V}$

$h_{FE} > 20$

$I_C = 20 \text{ mA}; V_{CE} = 1 \text{ V}$

$h_{FE} \text{ typ. } 80$

$h_{FE} \text{ typ. } 55$

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Transition frequency at $f = 35$ MHz

$I_C = 4$ mA; $V_{CE} = 10$ V

| | | |
|-------|------|---------|
| f_T | > | 60 MHz |
| | typ. | 100 MHz |

Collector capacitance at $f = 1$ MHz

$I_E = I_e = 0$; $V_{CB} = 10$ V

| | | |
|-------|------|------|
| C_c | typ. | 3 pF |
| | < | 5 pF |

Turn-off switching time

$I_{Con} = 15$ mA; $I_{Bon} = -I_{Boff} = 1$ mA

| | | |
|-----------|---|-----------|
| t_{off} | < | 1 μ s |
|-----------|---|-----------|

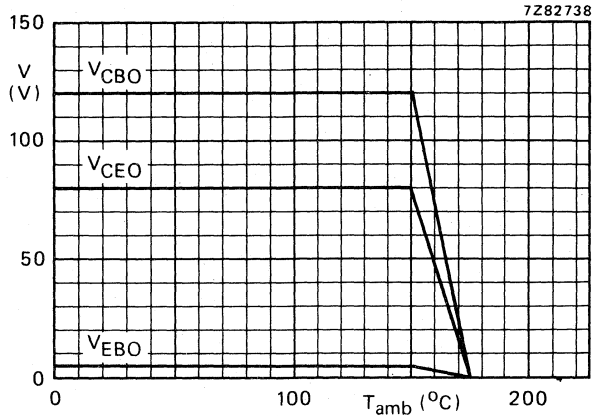


Fig. 2 Voltage derating curves.

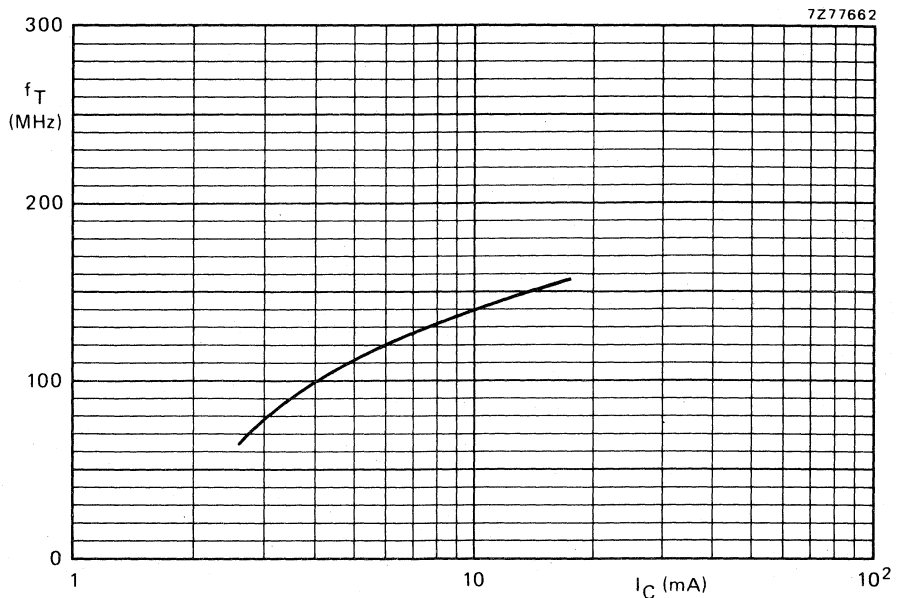


Fig. 3 Typical values transition frequency. $V_{CE} = 10$ V; $f = 35$ MHz; $T_j = 25$ °C.

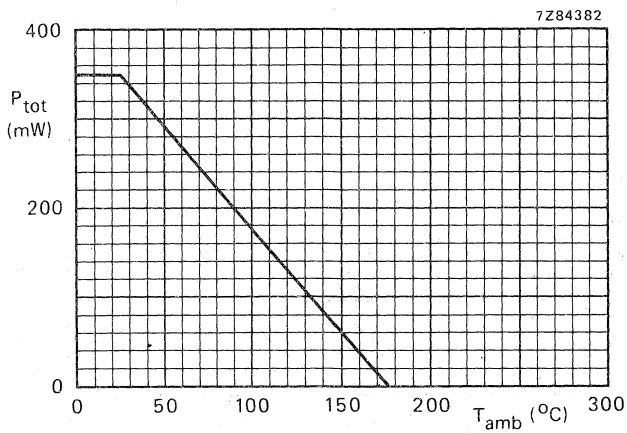


Fig. 4 Power derating curve.

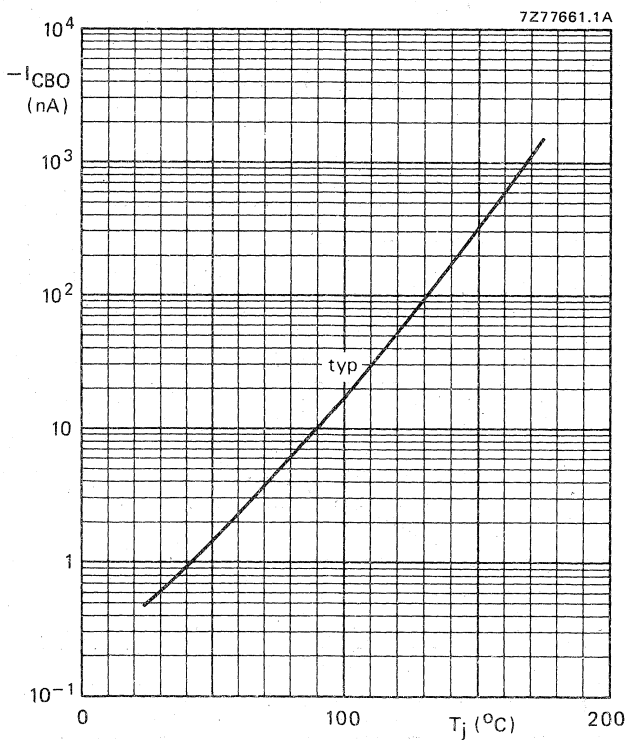


Fig. 5 Typical values collector-base current as a function of the junction temperature at a collector-base voltage of -90 V.

SILICON PLANAR EPITAXIAL TRANSISTORS

• High-speed switching

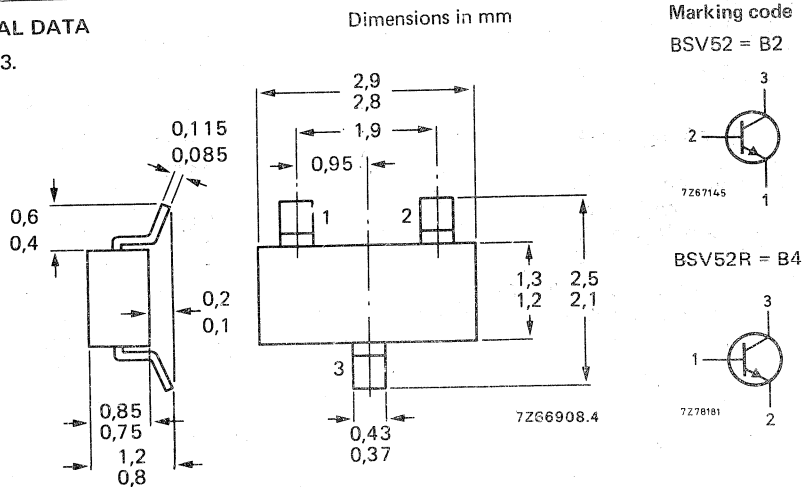
N-P-N transistor in a microminiature plastic envelope. It is intended for very high-speed saturated switching in thick and thin-film circuits.

QUICK REFERENCE DATA

| | | | | |
|--|-----------|------|------------------------|---|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 20 V | |
| Collector-emitter voltage ($V_{BE} = 0$) | V_{CES} | max. | 20 V | |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 12 V | |
| Collector current (peak value) | I_{CM} | max. | 200 mA | |
| Total power dissipation up to $T_{amb} = 65\text{ }^{\circ}\text{C}$ | P_{tot} | max. | 250 mW | ← |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ | ← |
| D.C. current gain | h_{FE} | | 40 to 120 | |
| $I_C = 10\text{ mA}; V_{CE} = 1\text{ V}$ | h_{FE} | > | 25 | |
| $I_C = 50\text{ mA}; V_{CE} = 1\text{ V}$ | | | | |
| Transition frequency at $f = 100\text{ MHz}$ | f_T | > | 400 MHz | |
| $I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$ | | typ. | 500 MHz | |
| Storage time | t_s | < | 13 ns | |
| $I_C = I_B = -I_{BM} = 10\text{ mA}$ | | | | |

MECHANICAL DATA

Fig. 1 SOT-23.



See also *Soldering recommendations*.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|-----------------|
| Collector-base voltage (open emitter) See Fig. 4 | V_{CBO} | max. | 20 V |
| Collector-emitter voltage ($V_{BE} = 0$) See Fig. 4 | V_{CES} | max. | 20 V |
| Collector-emitter voltage (open base) $I_C = 10$ mA (see Fig. 4) | V_{CEO} | max. | 12 V |
| Emitter-base voltage (open collector) See Fig. 4 | V_{EBO} | max. | 5 V |
| Collector current (d.c.) | I_C | max. | 100 mA |
| Collector current (peak value) | I_{CM} | max. | 200 mA |
| Total power dissipation up to $T_{amb} = 65$ °C ** | P_{tot} | max. | 250 mW |
| Storage temperature | T_{stg} | | -65 to + 175 °C |
| Junction temperature | T_j | max. | 175 °C |

THERMAL CHARACTERISTICS*

$$T_j = P_x (R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|--------------|---|---------|
| From junction to tab | $R_{th j-t}$ | = | 60 K/W |
| From tab to soldering points | $R_{th t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25$ °C unless otherwise specified

Collector cut-off current

$$I_E = 0; V_{CB} = 10$$
 V

$$I_E = 0; V_{CB} = 10$$
 V; $T_j = 125$ °C

| | | |
|-----------|---|-----------|
| I_{CBO} | < | 100 nA |
| I_{CBO} | < | 5 μ A |

Saturation voltages

$$I_C = 10$$
 mA; $I_B = 300$ μ A

| | | |
|-------------|---|---------------|
| V_{CEsat} | < | 300 mV |
| V_{CEsat} | < | 250 mV |
| V_{BEsat} | | 700 to 850 mV |

$$I_C = 10$$
 mA; $I_B = 1$ mA

| | | |
|-------------|---|---------|
| V_{CEsat} | < | 400 mV |
| V_{BEsat} | < | 1200 mV |

$$I_C = 50$$
 mA; $I_B = 5$ mA

D.C. current gain

$$I_C = 1$$
 mA; $V_{CE} = 1$ V

$$I_C = 10$$
 mA; $V_{CE} = 1$ V

$$I_C = 50$$
 mA; $V_{CE} = 1$ V

| | | |
|----------|---|-----------|
| h_{FE} | > | 25 |
| h_{FE} | | 40 to 120 |
| h_{FE} | > | 25 |

Transition frequency at $f = 100$ MHz

$$I_C = 10$$
 mA; $V_{CE} = 10$ V

| | | |
|-------|------|---------|
| f_T | > | 400 MHz |
| | typ. | 500 MHz |

* See *Thermal characteristics* in chapter GENERAL.

** Mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

Collector capacitance at $f = 1 \text{ MHz}$

$$I_E = I_e = 0; V_{CB} = 5 \text{ V}$$

$$C_c < 4 \text{ pF}$$

Emitter capacitance at $f = 1 \text{ MHz}$

$$I_C = I_c = 0; V_{EB} = 1 \text{ V}$$

$$C_e < 4,5 \text{ pF}$$

Switching times

Storage time $I_C = I_B = -I_{BM} = 10 \text{ mA}$

$$t_s < 13 \text{ ns}$$

Turn on time when switched from

$$-V_{BE} = 1,5 \text{ V to } I_C = 10 \text{ mA; } I_B = 3 \text{ mA}$$

$$t_{on} < 12 \text{ ns}$$

Turn off time when switched from

$$I_C = 10 \text{ mA; } I_B = 3 \text{ mA}$$

to cut-off with $-I_{BM} = 1,5 \text{ mA}$

$$t_{off} < 18 \text{ ns}$$

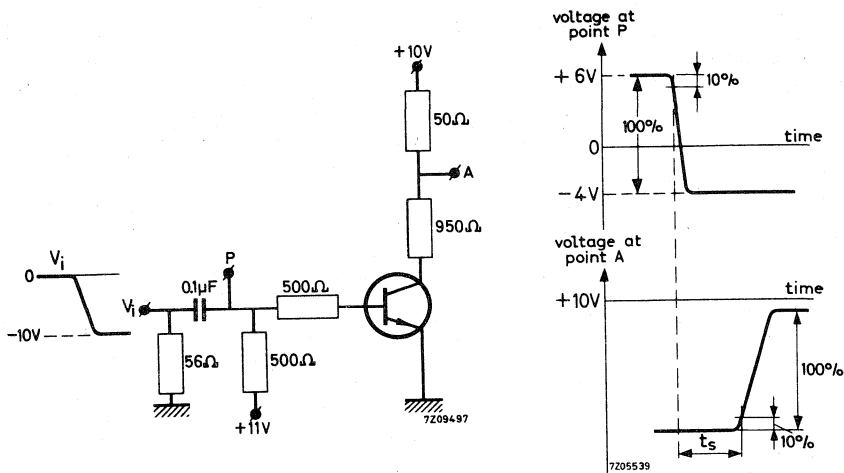


Fig. 2 Test circuit and waveform storage time.

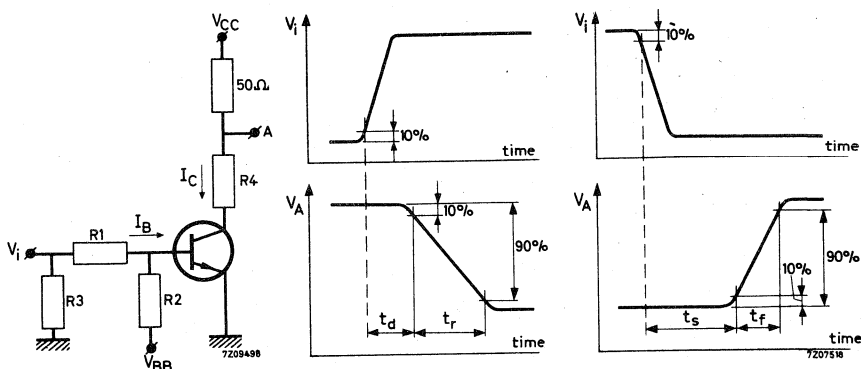


Fig. 3 Test circuit and waveforms turn on and turn off time.

Pulse generator:

Rise time $t_r < 1 \text{ ns}$
 Pulse duration $t > 300 \text{ ns}$
 Duty cycle $\delta < 0,02$
 Source impedance $R_S = 50 \Omega$

Oscilloscope:

Input impedance $R_i = 50 \Omega$
 Rise time $t_r < 1 \text{ ns}$

| I_C mA | I_B mA | $-I_{BM}$ mA | V_{CC} V | $R_1; R_2$ k Ω | R_3 Ω | R_4 Ω | turn on time | | | turn off time | |
|-------------|-------------|-----------------|---------------|--------------------------|-------------------|-------------------|----------------|----------------|------------|---------------|-------------|
| | | | | | | | $-V_{BB}$ V | $-V_{BE}$ V | V_i V | V_{BB} V | $-V_i$ V |
| 10 | 3 | 1,5 | 3 | 3,3 | 50 | 220 | 3,0 | 1,5 | 15 | 12,0 | 15 |

$-I_{BM}$ is the reverse current that can flow during switching off. The indicated $-I_{BM}$ is determined and limited by the applied cut-off voltage and series resistance.

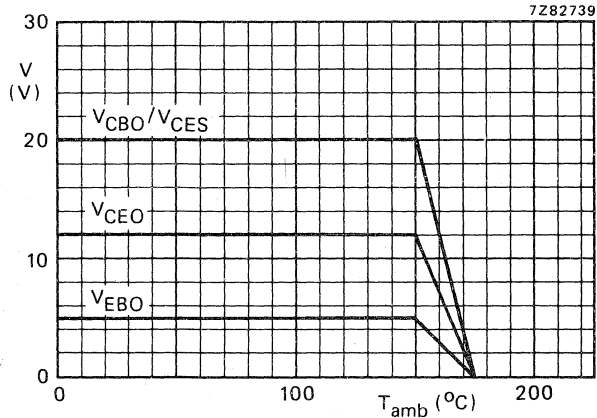


Fig. 4 Voltage derating curves.

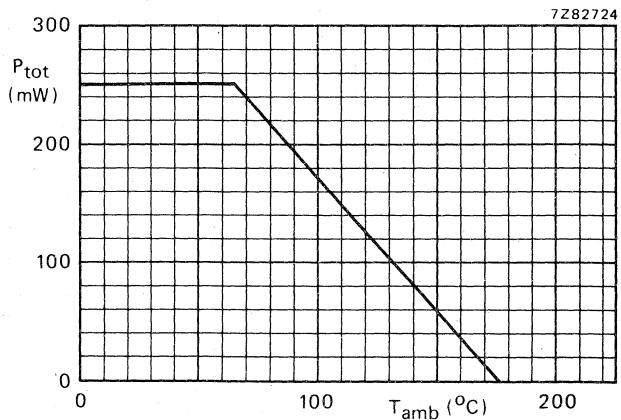
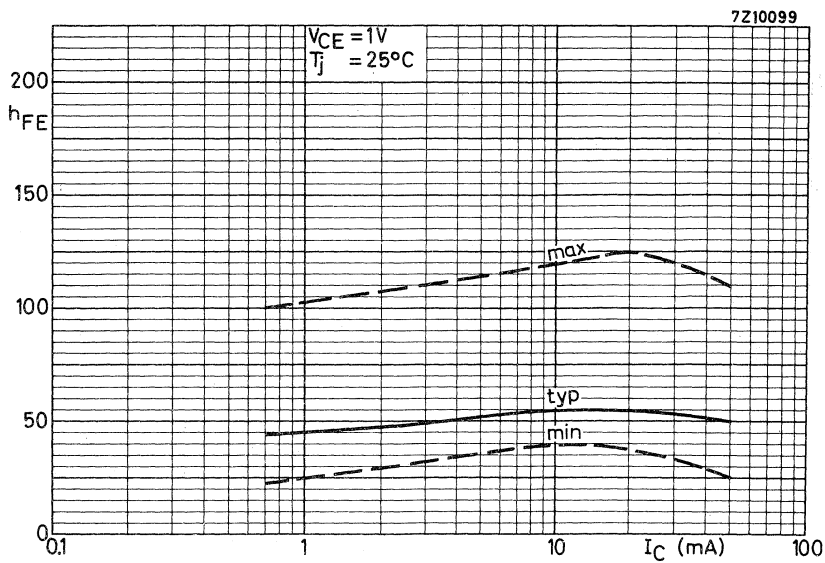
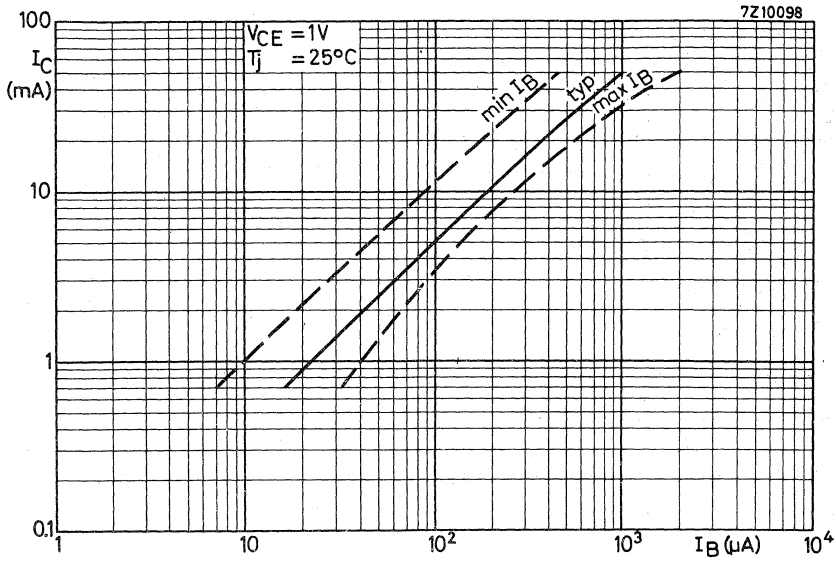
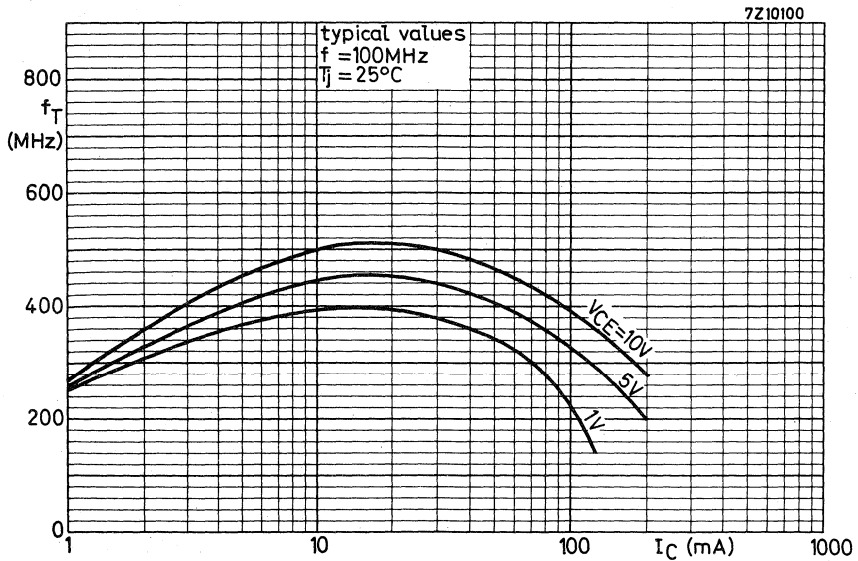
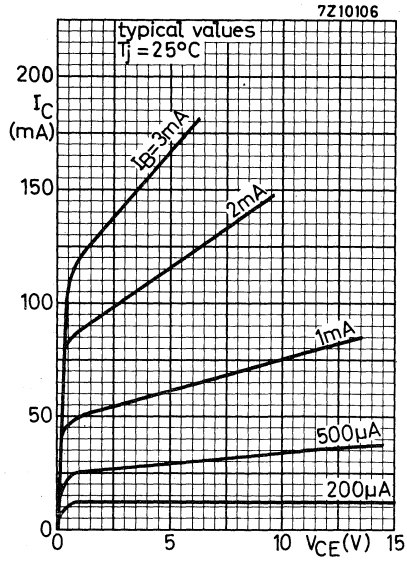
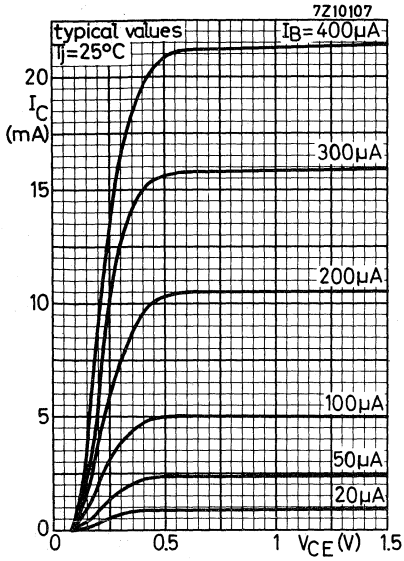
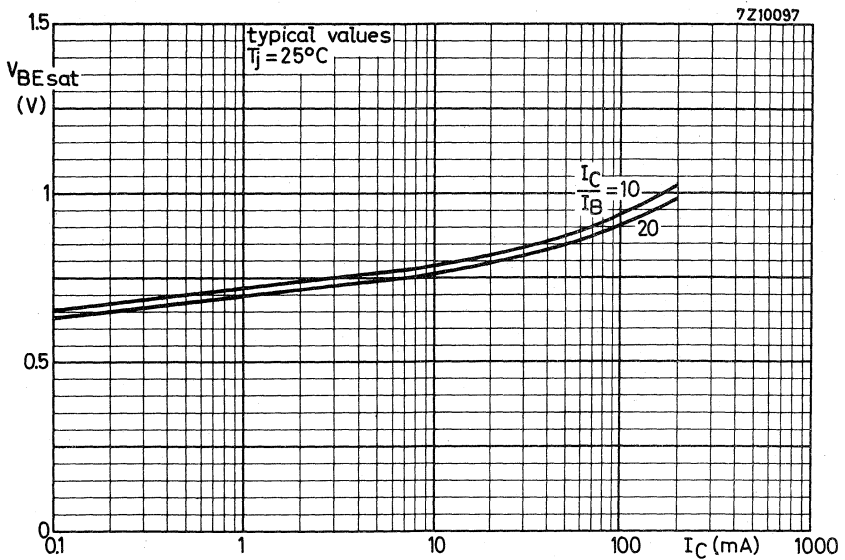
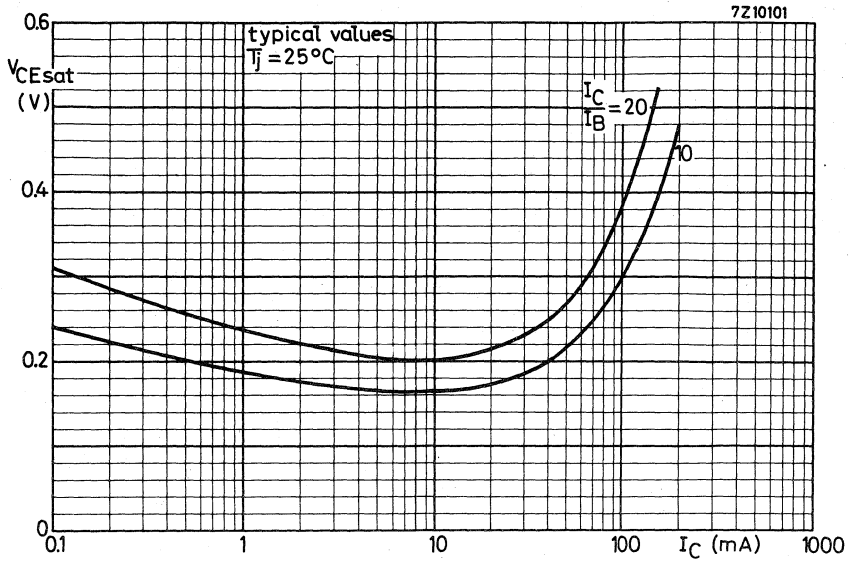
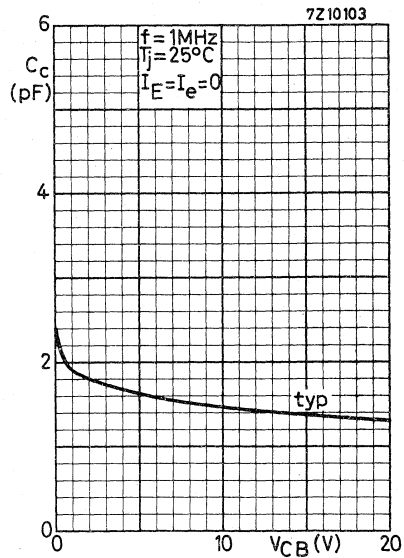
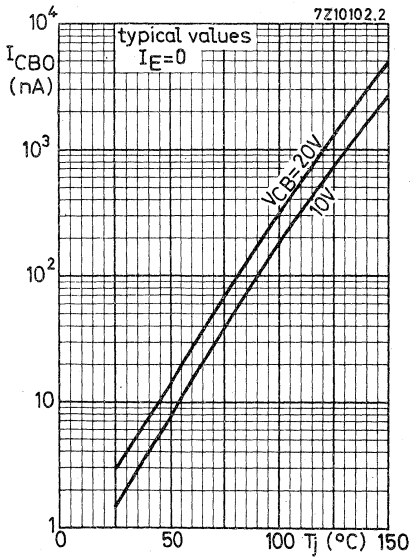
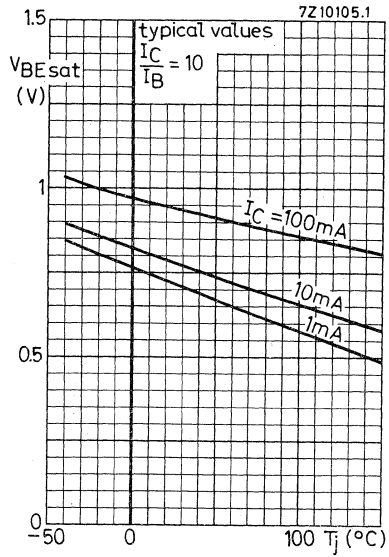
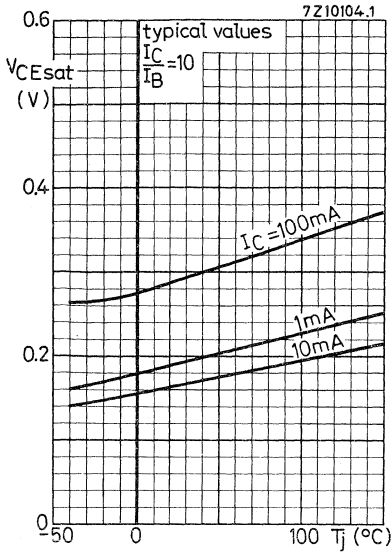


Fig. 5 Power derating curve.









SILICON PLANAR VOLTAGE REGULATOR DIODES

Silicon planar voltage regulator diodes, in a SOT-89 plastic envelope, intended for stabilization applications in thick and thin-film circuits.

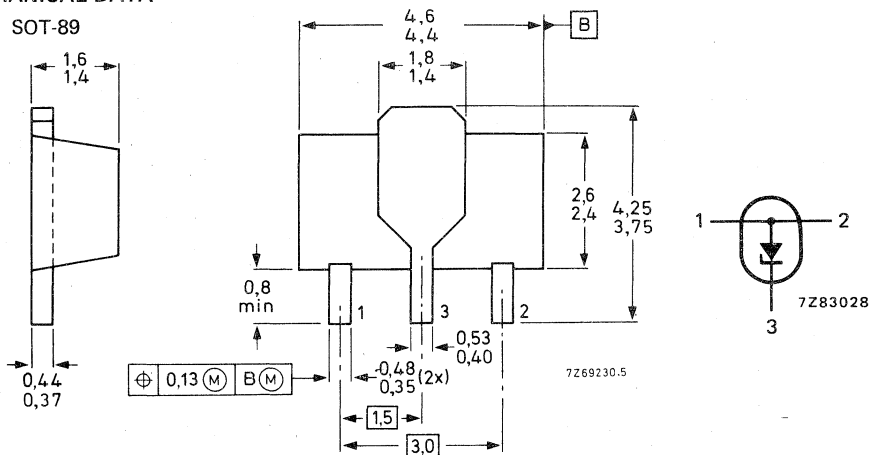
The series covers the normalized range of nominal working voltages from 5,1 V to 75 V with a tolerance of $\pm 5\%$ (international standard E24).

QUICK REFERENCE DATA

| | | | |
|--|-----------|------|----------------------|
| Working voltage range | V_Z | nom. | 5,1 to 75 V |
| Working voltage tolerance (E24) | | | $\pm 5\%$ |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 1 W |
| Junction temperature | T_j | max. | 150 $^\circ\text{C}$ |

MECHANICAL DATA

Fig. 1 SOT-89



Marking code:

BZX78-C5V1 = 5Z1
 C5V6 = 5Z6
 C6V2 = 6Z2
 C6V8 = 6Z8
 C7V5 = 7Z5
 C8V2 = 8Z2
 C9V1 = 9Z1
 C10 = 10Z
 C11 = 11Z

BZX78-C12 = 12Z
 C13 = 13Z
 C15 = 15Z
 C16 = 16Z
 C18 = 18Z
 C20 = 20Z
 C22 = 22Z
 C24 = 24Z
 C27 = 27Z
 C30 = 30Z

BZX78-C33 = 33Z
 C36 = 36Z
 C39 = 39Z
 C43 = 43Z
 C47 = 47Z
 C51 = 51Z
 C56 = 56Z
 C62 = 62Z
 C68 = 68Z
 C75 = 75Z

See also *Soldering recommendations* in Handbook Microminiatures.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | |
|---|-----------|---------------------------|
| Working current (d.c.) | I_Z | limited by $P_{tot\ max}$ |
| Repetitive peak working current | I_{ZRM} | limited by $P_{ZRM\ max}$ |
| Repetitive peak forward current | I_{FRM} | max. 400 mA |
| Total power dissipation * up to $T_{amb} = 25\ ^\circ C$ | P_{tot} | max. 1 W |
| Repetitive peak reverse power dissipation * up to $T_{amb} = 145\ ^\circ C$; $t_p = 100\ \mu s$; $\delta = 0,001$ | P_{ZRM} | max. 7,5 W |
| Non-repetitive peak reverse power dissipation * $T_j = 25\ ^\circ C$ prior to surge; $t_p = 100\ \mu s$ (see Fig. 7) | P_{ZSM} | max. 100 W |
| Storage temperature | T_{stg} | -65 to +150 $^\circ C$ |
| Junction temperature | T_j | max. 150 $^\circ C$ |

THERMAL RESISTANCE (see also Fig. 6)

| | | |
|--|-------------------|---------|
| From junction to collector tab | $R_{th\ j-tab} =$ | 10 K/W |
| From junction to ambient in free air * | $R_{th\ j-a} =$ | 125 K/W |

CHARACTERISTICS

$T_j = 25\ ^\circ C$

Forward voltage at $I_F = 0,2\ A$

$$V_F < 1\ V$$

Reverse current

| | | | |
|------------|-----------------------|--------------------|------------------|
| BZX78-C5V1 | } $V_R = 2\ V$ | $I_R < 10\ \mu A$ | |
| C5V6 | | | $I_R < 5\ \mu A$ |
| C6V2 | | | $I_R < 3\ \mu A$ |
| C6V8 | } $V_R = 3\ V$ | $I_R < 1,5\ \mu A$ | |
| C7V5 | | $I_R < 0,6\ \mu A$ | |
| C8V2 | | $I_R < 0,4\ \mu A$ | |
| C9V1 | $V_R = 5\ V$ | $I_R < 0,3\ \mu A$ | |
| C10 to C75 | $V_R = 2/3\ V_{Znom}$ | $I_R < 0,2\ \mu A$ | |

| | |
|---------|--------------|
| $I_R <$ | $10\ \mu A$ |
| $I_R <$ | $5\ \mu A$ |
| $I_R <$ | $3\ \mu A$ |
| $I_R <$ | $1,5\ \mu A$ |
| $I_R <$ | $0,6\ \mu A$ |
| $I_R <$ | $0,4\ \mu A$ |
| $I_R <$ | $0,3\ \mu A$ |
| $I_R <$ | $0,2\ \mu A$ |

* Device mounted on a ceramic substrate: area = 2,5 cm²; thickness = 0,7 mm.

CHARACTERISTICS (continued)

 $T_j = 25^\circ\text{C}$

| BZX78- | Working voltage V_Z (V) | | Temperature coefficient S_Z (mV/K) | | | Differential resistance r_{diff} (Ω) | | Diode capacitance C_D (pF) at $f = 1$ MHz | |
|------------------|------------------------------|------|---|------|------|---|------|--|------|
| | at $I_Z = 50$ mA | | at $I_Z = 50$ mA | | | at $I_Z = 50$ mA | | $V_R = 0$ | |
| | min. | max. | min. | typ. | max. | typ. | max. | typ. | max. |
| C5V1 | 4,8 | 5,4 | -1,5 | 0 | 1,5 | 4 | 10 | 200 | 250 |
| C5V6 | 5,2 | 6,0 | -0,2 | 1,5 | 2,5 | 2 | 5 | 180 | 225 |
| C6V2 | 5,8 | 6,6 | 1,5 | 2,4 | 3,3 | 1,5 | 3 | 350 | 400 |
| | at $I_Z = 20$ mA | | at $I_Z = 20$ mA | | | at $I_Z = 20$ mA | | | |
| C6V8 | 6,4 | 7,2 | 2,2 | 3,1 | 3,9 | 1 | 3 | 300 | 350 |
| C7V5 | 7,0 | 7,9 | 2,8 | 3,8 | 4,7 | 1 | 3 | 270 | 310 |
| C8V2 | 7,7 | 8,7 | 3,5 | 4,5 | 5,5 | 1,5 | 4 | 250 | 280 |
| C9V1 | 8,5 | 9,6 | 4,3 | 5,4 | 6,5 | 2 | 4 | 210 | 250 |
| C10 | 9,4 | 10,6 | 5,2 | 6,3 | 7,5 | 2 | 5 | 190 | 230 |
| C11 | 10,4 | 11,6 | 6,2 | 7,4 | 8,6 | 3 | 5 | 170 | 220 |
| C12 | 11,4 | 12,7 | 7,2 | 8,4 | 9,8 | 3 | 6 | 165 | 200 |
| C13 | 12,4 | 14,1 | 8,2 | 9,4 | 11,2 | 3 | 7 | 165 | 200 |
| C15 | 13,8 | 15,6 | 9,6 | 11,4 | 12,8 | 4 | 10 | 160 | 190 |
| | at $I_Z = 10$ mA | | at $I_Z = 10$ mA | | | at $I_Z = 10$ mA | | | |
| C16 | 15,3 | 17,1 | 11,1 | 12,5 | 14,4 | 4 | 10 | 140 | 180 |
| C18 | 16,8 | 19,1 | 12,6 | 14,5 | 16,6 | 5 | 15 | 120 | 160 |
| C20 | 18,8 | 21,2 | 14,6 | 16,6 | 18,8 | 5 | 15 | 110 | 150 |
| C22 | 20,8 | 23,3 | 16,6 | 18,6 | 20,9 | 5 | 20 | 100 | 135 |
| C24 | 22,8 | 25,6 | 18,6 | 20,7 | 23,4 | 6 | 20 | 95 | 130 |
| C27 | 25,1 | 28,9 | 21,0 | 23,8 | 26,8 | 7 | 25 | 90 | 120 |
| C30 | 28 | 32 | 23,8 | 26,9 | 30,6 | 8 | 25 | 80 | 110 |
| C33 | 31 | 35 | 26,6 | 30,0 | 34,2 | 10 | 30 | 75 | 95 |
| C36 | 34 | 38 | 29,6 | 33,4 | 38,0 | 10 | 35 | 70 | 90 |
| | at $I_Z = 5$ mA | | at $I_Z = 5$ mA | | | at $I_Z = 5$ mA | | | |
| C39 | 37 | 41 | 32,6 | 37,0 | 41,6 | 15 | 40 | 65 | 80 |
| C43 | 40 | 46 | 36,0 | 41,6 | 47,6 | 15 | 50 | 62 | 75 |
| C47 | 44 | 50 | 40,4 | 46,1 | 52,6 | 20 | 60 | 60 | 75 |
| C51 | 48 | 54 | 44,6 | 51,0 | 57,6 | 30 | 70 | 55 | 70 |
| C56 | 52 | 60 | 49,2 | 56,6 | 64,8 | 35 | 80 | 52 | 65 |
| C62 | 58 | 66 | 56,0 | 63,4 | 72,0 | 40 | 90 | 50 | 60 |
| C68 | 64 | 72 | 62,4 | 70,4 | 79,2 | 45 | 110 | 46 | 58 |
| C75 | 70 | 79 | 69,2 | 78,4 | 88,0 | 45 | 125 | 44 | 55 |



CHARACTERISTICS (continued)

$T_j = 25\text{ }^\circ\text{C}$

| | Working voltage | | | Differential resistance | | Working voltage | | | Differential resistance | |
|-------------|------------------------|------|------|-------------------------|------|--------------------------|------|------|--------------------------|------|
| | V_Z (V) | | | r_{diff} (Ω) | | V_Z (V) | | | r_{diff} (Ω) | |
| | at $I_Z = 1\text{ mA}$ | | | at $I_Z = 1\text{ mA}$ | | at $I_Z = 100\text{ mA}$ | | | at $I_Z = 100\text{ mA}$ | |
| BZX78-..... | min. | nom. | max. | typ. | max. | min. | nom. | max. | typ. | max. |
| C5V1 | 3,3 | 3,8 | 4,3 | 425 | 500 | 4,9 | 5,2 | 5,5 | 1,2 | 2,5 |
| C5V6 | 4,1 | 5,3 | 5,8 | 400 | 500 | 5,3 | 5,7 | 6,1 | 1,0 | 2,0 |
| C6V2 | 5,6 | 6,0 | 6,5 | 40 | 200 | 5,9 | 6,3 | 6,7 | 0,8 | 2,0 |
| C6V8 | 6,3 | 6,7 | 7,1 | 40 | 120 | 6,5 | 6,9 | 7,3 | 0,6 | 2,0 |
| C7V5 | 6,9 | 7,4 | 7,8 | 20 | 100 | 7,1 | 7,6 | 8,0 | 0,5 | 1,5 |
| C8V2 | 7,6 | 8,1 | 8,6 | 20 | 100 | 7,8 | 8,3 | 8,8 | 0,5 | 1,5 |
| C9V1 | 8,4 | 9,0 | 9,6 | 25 | 100 | 8,6 | 9,2 | 9,8 | 0,8 | 2,0 |
| C10 | 9,3 | 9,9 | 10,5 | 30 | 120 | 9,5 | 10,1 | 10,8 | 0,8 | 2,0 |
| C11 | 10,3 | 10,9 | 11,5 | 30 | 120 | 10,5 | 11,1 | 11,8 | 0,8 | 2,0 |
| C12 | 11,2 | 11,9 | 12,6 | 30 | 150 | 11,5 | 12,1 | 12,9 | 1,0 | 2,0 |
| C13 | 12,2 | 12,9 | 14,0 | 30 | 150 | 12,5 | 13,1 | 14,3 | 1,2 | 2,5 |
| C15 | 13,6 | 14,9 | 15,4 | 30 | 150 | 13,9 | 15,1 | 15,8 | 1,2 | 2,5 |
| | at $I_Z = 1\text{ mA}$ | | | at $I_Z = 1\text{ mA}$ | | at $I_Z = 50\text{ mA}$ | | | at $I_Z = 50\text{ mA}$ | |
| C16 | 15,2 | 15,9 | 17,0 | 30 | 150 | 15,4 | 16,1 | 17,3 | 1,2 | 3,0 |
| C18 | 16,7 | 17,9 | 19,0 | 30 | 150 | 16,9 | 18,1 | 19,3 | 2,0 | 5,0 |
| C20 | 18,7 | 19,9 | 21,1 | 30 | 150 | 19,0 | 20,2 | 21,5 | 2,5 | 6,0 |
| C22 | 20,7 | 21,9 | 23,2 | 30 | 150 | 21,0 | 22,2 | 23,7 | 2,5 | 6,0 |
| C24 | 22,6 | 23,9 | 25,5 | 30 | 150 | 23,0 | 24,2 | 26,0 | 3,0 | 8,0 |
| C27 | 24,9 | 26,9 | 28,8 | 30 | 150 | 25,3 | 27,2 | 29,2 | 4,0 | 8,0 |
| C30 | 27,8 | 29,9 | 31,9 | 30 | 150 | 28,2 | 30,2 | 32,5 | 4,0 | 8,0 |
| C33 | 29,8 | 32,9 | 34,9 | 30 | 150 | 31,2 | 33,3 | 35,5 | 5,0 | 10 |
| C36 | 33,8 | 35,9 | 37,9 | 30 | 150 | 34,2 | 36,3 | 38,5 | 5,0 | 10 |
| C39 | 36,8 | 38,9 | 40,9 | 40 | 150 | 37,5 | 39,5 | 42,0 | 6,0 | 12 |
| C43 | 39,8 | 42,9 | 45,9 | 50 | 150 | 40,5 | 43,5 | 47,0 | 8 | 15 |
| C47 | 43,8 | 46,9 | 49,9 | 55 | 200 | 44,5 | 47,5 | 51,0 | 10 | 20 |
| C51 | 47,8 | 50,9 | 53,8 | 60 | 200 | 48,5 | 51,8 | 55,5 | 12 | 25 |
| C56 | 51,8 | 55,9 | 59,8 | 60 | 200 | 52,5 | 56,8 | 61,5 | 15 | 30 |
| C62 | 57,6 | 61,8 | 65,8 | 70 | 200 | 58,5 | 62,8 | 67,5 | 16 | 30 |
| C68 | 63,5 | 67,6 | 71,7 | 80 | 225 | 65,0 | 69,0 | 74,0 | 18 | 35 |
| C75 | 69,3 | 74,5 | 78,6 | 100 | 250 | 73,0 | 77,5 | 84,0 | 20 | 35 |

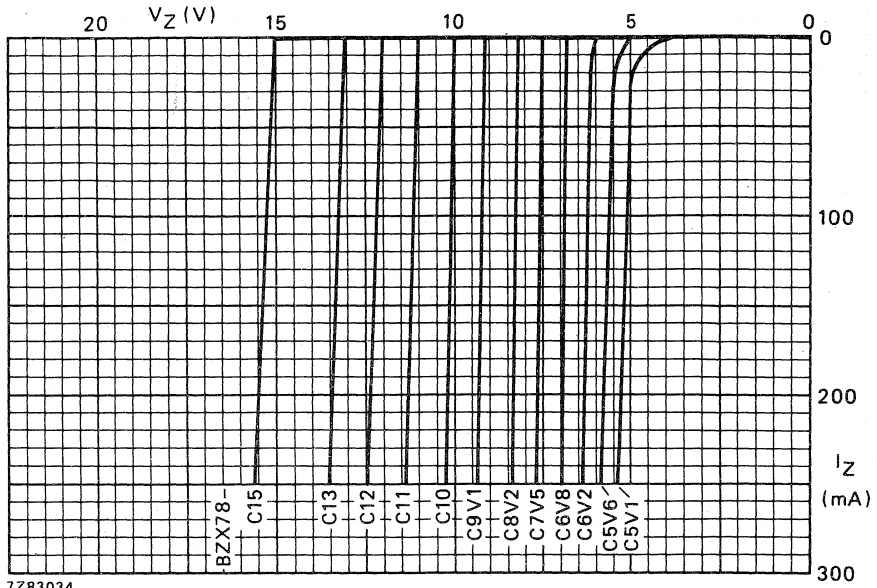


Fig. 2 Dynamic characteristics BZX78-C5V1 to C15; typical values at $T_j = 25^\circ\text{C}$.

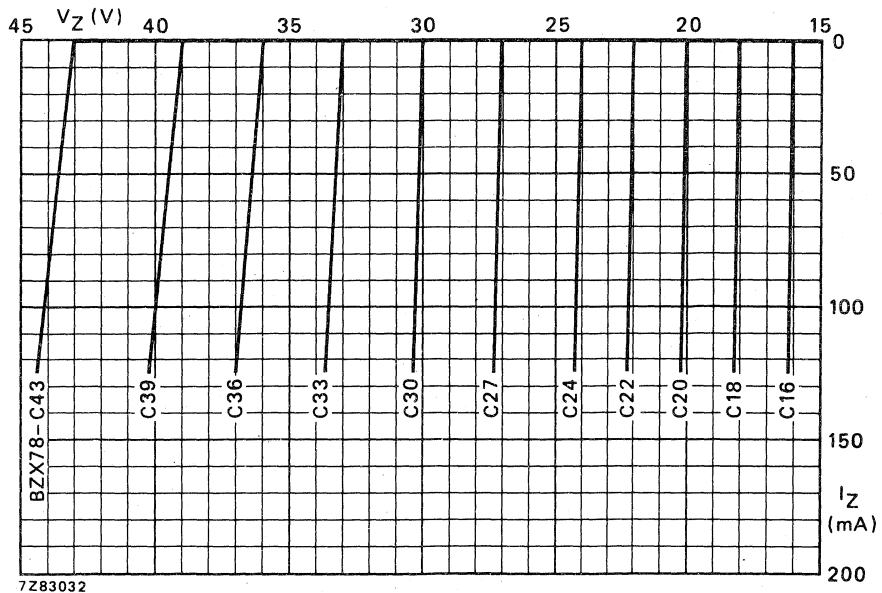


Fig. 3 Dynamic characteristics BZX78-C16 to C43. Typical values at $T_j = 25^\circ\text{C}$.

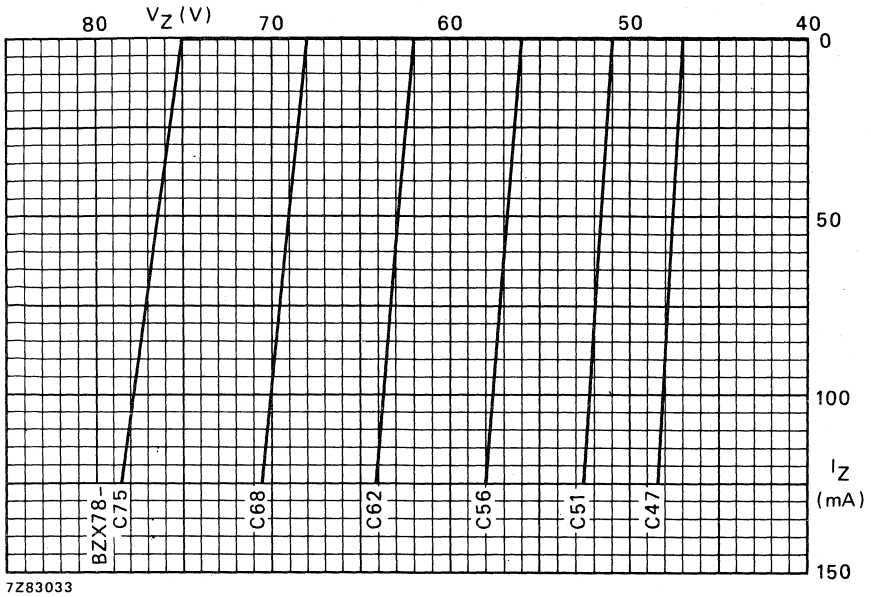


Fig. 4 Dynamic characteristics BZX78-C47 to C75. Typical values at $T_j = 25\text{ }^\circ\text{C}$.

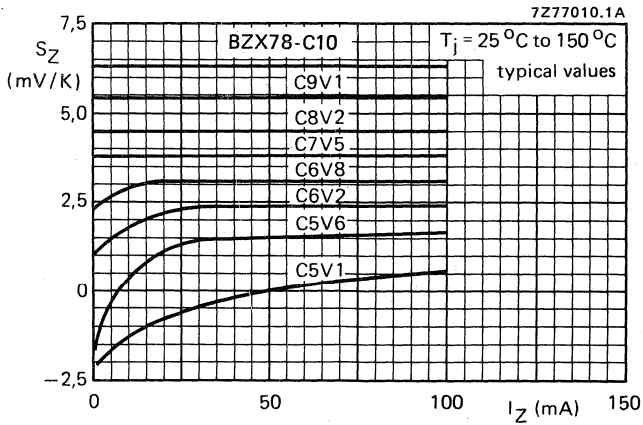


Fig. 5 Temperature coefficient as a function of working current.

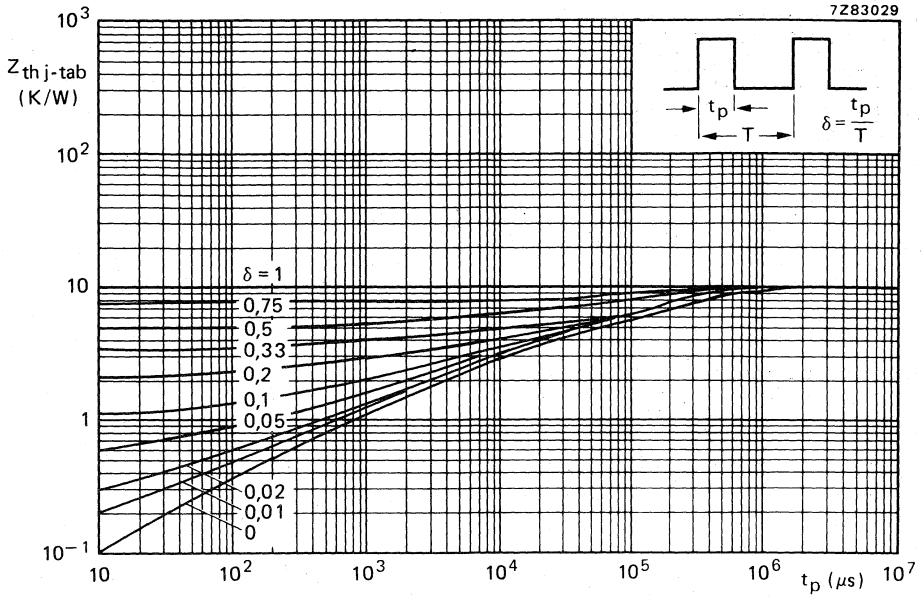


Fig. 6 Pulse power rating chart of BZX78 on a ceramic substrate.

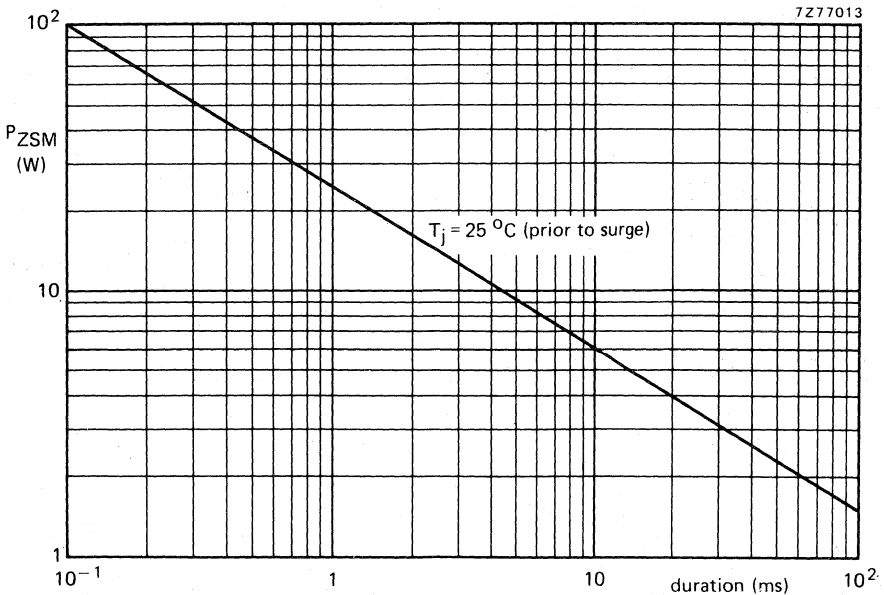


Fig. 7 Non-repetitive peak reverse power dissipation as a function of pulse duration.

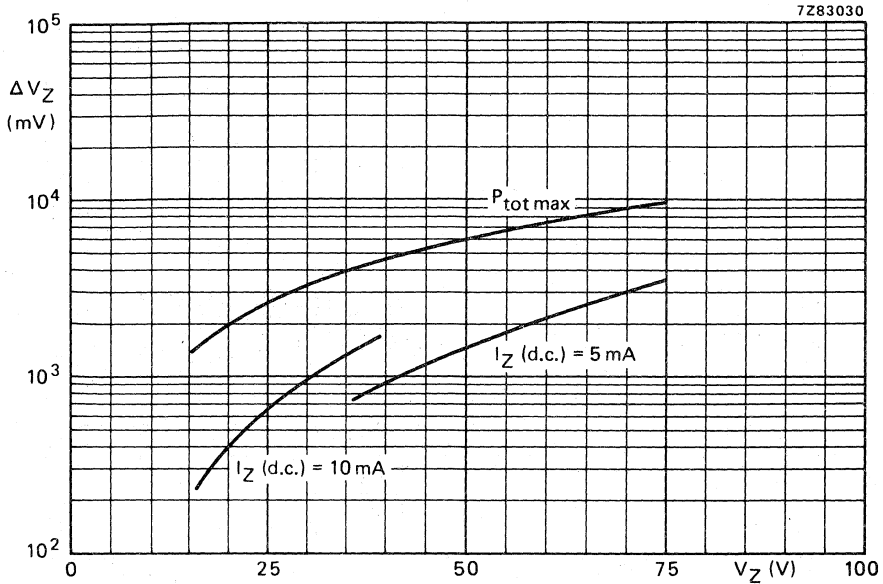


Fig. 8 Typical values at $T_{amb} = 25\ ^\circ C$; device mounted on a ceramic substrate area = $2,5\ cm^2$; thickness = $0,7\ mm$.

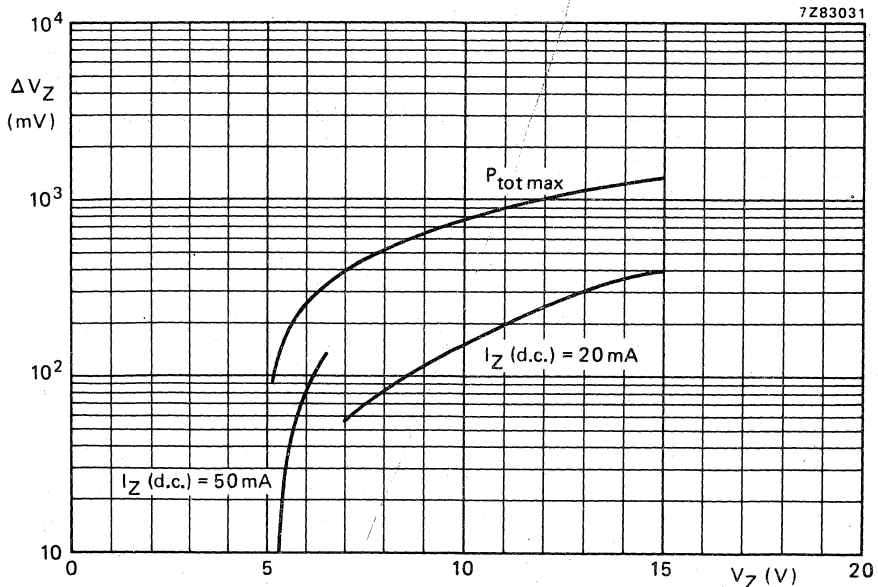


Fig. 9 Typical values at $T_{amb} = 25\ ^\circ C$; device mounted on a ceramic substrate area = $2,5\ cm^2$; thickness = $0,7\ mm$.

SILICON PLANAR VOLTAGE REGULATOR DIODES

Low power general purpose voltage regulator diodes in a microminiature plastic envelope intended for application in thick and thin-film circuits. The series covers the normalized range of nominal working voltages from 2,4 V to 75 V with a working voltage tolerance of $\pm 5\%$.

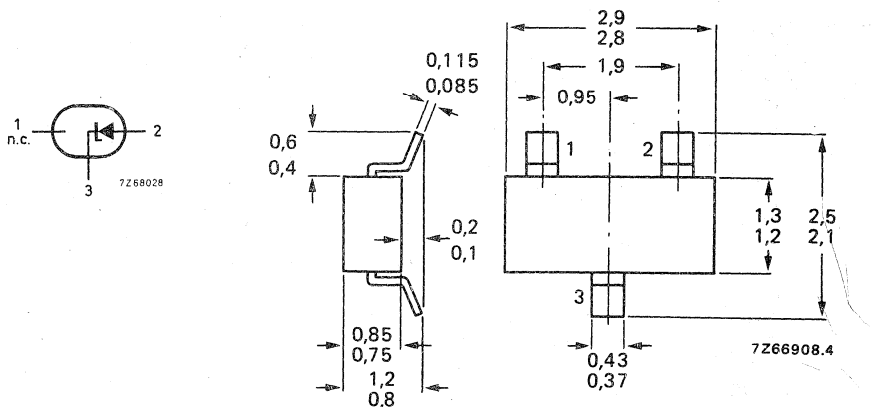
QUICK REFERENCE DATA

| | | | |
|--|-----------|------|----------------------|
| Working voltage range | V_Z | nom. | 2,4 to 75 V |
| Working voltage tolerance | | | $\pm 5\%$ |
| Total power dissipation up to $T_{amb} = 25\text{ }^\circ\text{C}$ | P_{tot} | max. | 350 mW |
| Junction temperature | T_j | max. | 175 $^\circ\text{C}$ |

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-23.



See also *Soldering recommendations*.

Marking code

| | | | |
|------------------|-----------------|----------------|-----------------|
| BZX84-C2V4 = Z11 | BZX84-C5V6 = Z3 | BZX84-C13 = Y3 | BZX84-C33 = Y12 |
| C2V7 = Z12 | C6V2 = Z4 | C15 = Y4 | C36 = Y13 |
| C3V0 = Z13 | C6V8 = Z5 | C16 = Y5 | C39 = Y14 |
| C3V3 = Z14 | C7V5 = Z6 | C18 = Y6 | C43 = Y15 |
| C3V6 = Z15 | C8V2 = Z7 | C20 = Y7 | C47 = Y16 |
| C3V9 = Z16 | C9V1 = Z8 | C22 = Y8 | C51 = Y17 |
| C4V3 = Z17 | C10 = Z9 | C24 = Y9 | C56 = Y18 |
| C4V7 = Z1 | C11 = Y1 | C27 = Y10 | C62 = Y19 |
| C5V1 = Z2 | C12 = Y2 | C30 = Y11 | C68 = Y20 |
| | | | C75 = Y21 |

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---|-----------|------|---------------------------------|
| Repetitive peak forward current | I_{FRM} | max. | 250 mA |
| Repetitive peak working current | I_{ZRM} | max. | 250 mA |
| Total power dissipation up to $T_{amb} = 25\text{ }^{\circ}\text{C}^{**}$ | P_{tot} | max. | 350 mW |
| Storage temperature | T_{stg} | | -65 to + 175 $^{\circ}\text{C}$ |
| Junction temperature | T_j | max. | 175 $^{\circ}\text{C}$ |

THERMAL CHARACTERISTICS*

$$T_j = P \times (R_{th\ j-t} + R_{th\ t-s} + R_{th\ s-a}) + T_{amb}$$

Thermal resistance

| | | | |
|------------------------------------|---------------|---|---------|
| From junction to tab | $R_{th\ j-t}$ | = | 50 K/W |
| From tab to soldering points | $R_{th\ t-s}$ | = | 260 K/W |
| From soldering points to ambient** | $R_{th\ s-a}$ | = | 120 K/W |

CHARACTERISTICS

$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Forward voltage

$$I_F = 10\text{ mA}$$

Reverse current

| | | | | |
|------------|-----------------------------|-------|---|------------------|
| BZX84-C2V4 | $V_R = 1\text{ V}$ | I_R | < | 0,9 V |
| C2V7 | $V_R = 1\text{ V}$ | I_R | < | 50 μA |
| C3V0 | $V_R = 1\text{ V}$ | I_R | < | 20 μA |
| C3V3 | $V_R = 1\text{ V}$ | I_R | < | 10 μA |
| C3V6 | $V_R = 1\text{ V}$ | I_R | < | 5 μA |
| C3V9 | $V_R = 1\text{ V}$ | I_R | < | 5 μA |
| C4V3 | $V_R = 1\text{ V}$ | I_R | < | 3 μA |
| C4V7 | $V_R = 2\text{ V}$ | I_R | < | 3 μA |
| C5V1 | $V_R = 2\text{ V}$ | I_R | < | 3 μA |
| C5V6 | $V_R = 2\text{ V}$ | I_R | < | 2 μA |
| C6V2 | $V_R = 4\text{ V}$ | I_R | < | 1 μA |
| C6V8 | $V_R = 4\text{ V}$ | I_R | < | 3 μA |
| C7V5 | $V_R = 5\text{ V}$ | I_R | < | 2 μA |
| C8V2 | $V_R = 5\text{ V}$ | I_R | < | 1 μA |
| C9V1 | $V_R = 6\text{ V}$ | I_R | < | 700 nA |
| C10 | $V_R = 7\text{ V}$ | I_R | < | 500 nA |
| C11 | $V_R = 8\text{ V}$ | I_R | < | 200 nA |
| C12 | $V_R = 8\text{ V}$ | I_R | < | 100 nA |
| C13 | $V_R = 8\text{ V}$ | I_R | < | 100 nA |
| C15 to C75 | $V_R = 0,7\text{ }V_{Znom}$ | I_R | < | 100 nA |
| | | I_R | < | 50 nA |

* See *Thermal characteristics* in chapter GENERAL.

** Device mounted on a ceramic substrate of 7 mm x 5 mm x 0,6 mm.

| BZX84.... | working voltage | | differential resistance | | temperature coefficient | | | diode capacitance | |
|-----------|-----------------------|------|-------------------------|------|--------------------------|------|------|-------------------------|------|
| | V_Z (V) | | r_{diff} (Ω) | | S_Z (mV/ $^{\circ}$ C) | | | C_d (pF); $f = 1$ MHz | |
| | at $I_{Ztest} = 5$ mA | | at $I_{Ztest} = 5$ mA | | at $I_{Ztest} = 5$ mA | | | $V_R = 0$ | |
| | min. | max. | typ. | max. | min. | typ. | max. | typ. | max. |
| C2V4 | 2,2 | 2,6 | 70 | 100 | -3,5 | -1,6 | 0 | 375 | 450 |
| C2V7 | 2,5 | 2,9 | 75 | 100 | -3,5 | -2,0 | 0 | 350 | 450 |
| C3V0 | 2,8 | 3,2 | 80 | 95 | -3,5 | -2,1 | 0 | 350 | 450 |
| C3V3 | 3,1 | 3,5 | 85 | 95 | -3,5 | -2,4 | 0 | 325 | 450 |
| C3V6 | 3,4 | 3,8 | 85 | 90 | -3,5 | -2,4 | 0 | 300 | 450 |
| C3V9 | 3,7 | 4,1 | 85 | 90 | -3,5 | -2,5 | 0 | 300 | 450 |
| C4V3 | 4,0 | 4,6 | 80 | 90 | -3,5 | -2,5 | 0 | 275 | 450 |
| C4V7 | 4,4 | 5,0 | 50 | 80 | -3,5 | -1,4 | 0,2 | 130 | 180 |
| C5V1 | 4,8 | 5,4 | 40 | 60 | -2,7 | -0,8 | 1,2 | 110 | 160 |
| C5V6 | 5,2 | 6,0 | 15 | 40 | -2,0 | 1,2 | 2,5 | 95 | 140 |
| C6V2 | 5,8 | 6,6 | 6 | 10 | 0,4 | 2,3 | 3,7 | 90 | 130 |
| C6V8 | 6,4 | 7,2 | 6 | 15 | 1,2 | 3,0 | 4,5 | 85 | 110 |
| C7V5 | 7,0 | 7,9 | 6 | 15 | 2,5 | 4,0 | 5,3 | 80 | 100 |
| C8V2 | 7,7 | 8,7 | 6 | 15 | 3,2 | 4,6 | 6,2 | 75 | 95 |
| C9V1 | 8,5 | 9,6 | 6 | 15 | 3,8 | 5,5 | 7,0 | 70 | 90 |
| C10 | 9,4 | 10,6 | 8 | 20 | 4,5 | 6,4 | 8,0 | 70 | 90 |
| C11 | 10,4 | 11,6 | 10 | 20 | 5,4 | 7,4 | 9,0 | 65 | 85 |
| C12 | 11,4 | 12,7 | 10 | 25 | 6,0 | 8,4 | 10,0 | 65 | 85 |
| C13 | 12,4 | 14,1 | 10 | 30 | 7,0 | 9,4 | 11,0 | 60 | 80 |
| C15 | 13,8 | 15,6 | 10 | 30 | 9,2 | 11,4 | 13,0 | 55 | 75 |
| C16 | 15,3 | 17,1 | 10 | 40 | 10,4 | 12,4 | 14,0 | 52 | 75 |
| C18 | 16,8 | 19,1 | 10 | 45 | 12,4 | 14,4 | 16,0 | 47 | 70 |
| C20 | 18,8 | 21,2 | 15 | 55 | 14,4 | 16,4 | 18,0 | 36 | 60 |
| C22 | 20,8 | 23,3 | 20 | 55 | 16,4 | 18,4 | 20,0 | 34 | 60 |
| C24 | 22,8 | 25,6 | 25 | 70 | 18,4 | 20,4 | 22,0 | 33 | 55 |
| | at $I_Z = 2$ mA | | at $I_Z = 2$ mA | | at $I_Z = 2$ mA | | | typ. | max. |
| | min. | max. | typ. | max. | min. | typ. | max. | | |
| C27 | 25,1 | 28,9 | 25 | 80 | 21,4 | 23,4 | 25,3 | 30 | 50 |
| C30 | 28,0 | 32,0 | 30 | 80 | 24,4 | 26,6 | 29,4 | 27 | 50 |
| C33 | 31,0 | 35,0 | 35 | 80 | 27,4 | 29,7 | 33,4 | 25 | 45 |
| C36 | 34,0 | 38,0 | 35 | 90 | 30,4 | 33,0 | 37,4 | 23 | 45 |
| C39 | 37,0 | 41,0 | 40 | 130 | 33,4 | 36,4 | 41,2 | 21 | 45 |
| C43 | 40,0 | 46,0 | 45 | 150 | 37,6 | 41,2 | 46,6 | 21 | 40 |
| C47 | 44,0 | 50,0 | 50 | 170 | 42,0 | 46,1 | 51,8 | 19 | 40 |
| C51 | 48,0 | 54,0 | 60 | 180 | 46,6 | 51,0 | 57,2 | 19 | 40 |
| C56 | 52,0 | 60,0 | 70 | 200 | 52,2 | 57,0 | 63,8 | 18 | 40 |
| C62 | 58,0 | 66,0 | 80 | 215 | 58,8 | 64,4 | 71,6 | 17 | 35 |
| C68 | 64,0 | 72,0 | 90 | 240 | 65,6 | 71,7 | 79,8 | 17 | 35 |
| C75 | 70,0 | 79,0 | 95 | 255 | 73,4 | 80,2 | 88,6 | 16,5 | 35 |

BZX84 SERIES

| BZX84.... | working voltage | | | differential resistance | | working voltage | | | differential resistance | |
|-----------|-------------------|------|------|-------------------------|------|------------------|------|------|-------------------------|------|
| | V_Z (V) | | | r_{diff} (Ω) | | V_Z (V) | | | r_{diff} (Ω) | |
| | at $I_Z = 1$ mA | | | at $I_Z = 1$ mA | | at $I_Z = 20$ mA | | | at $I_Z = 20$ mA | |
| | min. | nom. | max. | typ. | max. | min. | nom. | max. | typ. | max. |
| C2V4 | 1,7 | 1,9 | 2,1 | 275 | 600 | 2,6 | 2,9 | 3,2 | 25 | 50 |
| C2V7 | 1,9 | 2,2 | 2,4 | 300 | 600 | 3,0 | 3,3 | 3,6 | 25 | 50 |
| C3V0 | 2,1 | 2,4 | 2,7 | 325 | 600 | 3,3 | 3,6 | 3,9 | 25 | 50 |
| C3V3 | 2,3 | 2,6 | 2,9 | 350 | 600 | 3,6 | 3,9 | 4,2 | 20 | 40 |
| C3V6 | 2,7 | 3,0 | 3,3 | 375 | 600 | 3,9 | 4,2 | 4,5 | 20 | 40 |
| C3V9 | 2,9 | 3,2 | 3,5 | 400 | 600 | 4,1 | 4,4 | 4,7 | 15 | 30 |
| C4V3 | 3,3 | 3,6 | 4,0 | 410 | 600 | 4,4 | 4,7 | 5,1 | 15 | 30 |
| C4V7 | 3,7 | 4,2 | 4,7 | 425 | 500 | 4,5 | 5,0 | 5,4 | 8 | 15 |
| C5V1 | 4,2 | 4,7 | 5,3 | 400 | 480 | 5,0 | 5,4 | 5,9 | 6 | 15 |
| C5V6 | 4,8 | 5,4 | 6,0 | 80 | 400 | 5,2 | 5,7 | 6,3 | 4 | 10 |
| C6V2 | 5,6 | 6,1 | 6,6 | 40 | 150 | 5,8 | 6,3 | 6,8 | 3 | 6 |
| C6V8 | 6,3 | 6,7 | 7,2 | 30 | 80 | 6,4 | 6,9 | 7,4 | 2,5 | 6 |
| C7V5 | 6,9 | 7,4 | 7,9 | 30 | 80 | 7,0 | 7,6 | 8,0 | 2,5 | 6 |
| C8V2 | 7,6 | 8,1 | 8,7 | 40 | 80 | 7,7 | 8,3 | 8,8 | 3 | 6 |
| C9V1 | 8,4 | 9,0 | 9,6 | 40 | 100 | 8,5 | 9,2 | 9,7 | 4 | 8 |
| C10 | 9,3 | 9,9 | 10,6 | 50 | 150 | 9,4 | 10,1 | 10,7 | 4 | 10 |
| C11 | 10,2 | 10,9 | 11,6 | 50 | 150 | 10,4 | 11,1 | 11,8 | 5 | 10 |
| C12 | 11,2 | 11,9 | 12,7 | 50 | 150 | 11,4 | 12,1 | 12,9 | 5 | 10 |
| C13 | 12,3 | 12,9 | 14,0 | 50 | 170 | 12,5 | 13,1 | 14,2 | 5 | 15 |
| C15 | 13,7 | 14,9 | 15,5 | 50 | 200 | 13,9 | 15,1 | 15,7 | 6 | 20 |
| C16 | 15,2 | 15,9 | 17,0 | 50 | 200 | 15,4 | 16,1 | 17,2 | 6 | 20 |
| C18 | 16,7 | 17,9 | 19,0 | 50 | 225 | 16,9 | 18,1 | 19,2 | 6 | 20 |
| C20 | 18,7 | 19,9 | 21,1 | 60 | 225 | 18,9 | 20,1 | 21,4 | 7 | 20 |
| C22 | 20,7 | 21,9 | 23,2 | 60 | 250 | 20,9 | 22,1 | 23,4 | 7 | 25 |
| C24 | 22,7 | 23,9 | 25,5 | 60 | 250 | 22,9 | 24,1 | 25,7 | 7 | 25 |
| | at $I_Z = 0,1$ mA | | | at $I_Z = 0,5$ mA | | at $I_Z = 10$ mA | | | at $I_Z = 10$ mA | |
| | min. | nom. | max. | typ. | max. | min. | nom. | max. | typ. | max. |
| C27 | 25,0 | 26,9 | 28,9 | 65 | 300 | 25,2 | 27,1 | 29,3 | 10 | 45 |
| C30 | 27,8 | 29,9 | 32,0 | 70 | 300 | 28,1 | 30,1 | 32,4 | 15 | 50 |
| C33 | 30,8 | 32,9 | 35,0 | 75 | 325 | 31,1 | 33,1 | 35,4 | 20 | 55 |
| C36 | 33,8 | 35,9 | 38,0 | 80 | 350 | 34,1 | 36,1 | 38,4 | 25 | 60 |
| C39 | 36,7 | 38,9 | 41,0 | 80 | 350 | 37,1 | 39,1 | 41,5 | 25 | 70 |
| C43 | 39,7 | 42,9 | 46,0 | 85 | 375 | 40,1 | 43,1 | 46,5 | 25 | 80 |
| C47 | 43,7 | 46,8 | 50,0 | 85 | 375 | 44,1 | 47,1 | 50,5 | 30 | 90 |
| C51 | 47,6 | 50,8 | 54,0 | 90 | 400 | 48,1 | 51,1 | 54,6 | 35 | 100 |
| C56 | 51,5 | 55,7 | 60,0 | 100 | 425 | 52,1 | 56,1 | 60,8 | 45 | 110 |
| C62 | 57,4 | 61,7 | 66,0 | 120 | 450 | 58,2 | 62,1 | 67,0 | 60 | 120 |
| C68 | 63,4 | 67,7 | 72,0 | 150 | 475 | 64,2 | 68,2 | 73,2 | 75 | 130 |
| C75 | 69,4 | 74,7 | 79,0 | 170 | 500 | 70,3 | 75,3 | 80,2 | 90 | 140 |

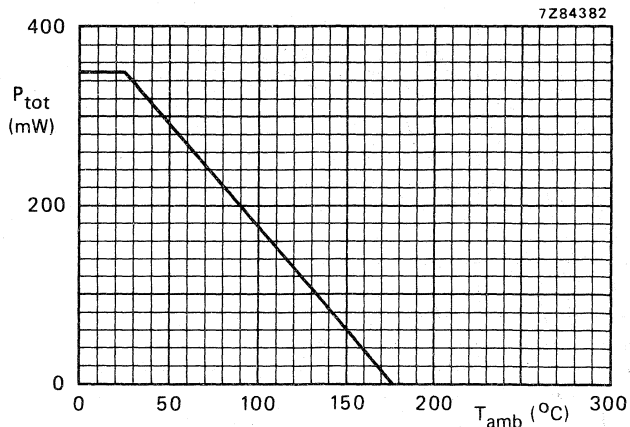


Fig. 2 Power derating curve.

Model for calculating the static working voltage ($V_{Z\ stat}$).

This model can be derived from $V_{Z\ stat} = V_{Z\ dyn} + \Delta V_Z$ of which $V_{Z\ dyn}$ is given in the tables on pages 3 and 4 and can be derived from the typical dynamic characteristic curves on pages 6 and 7.

$\Delta V_Z = \Delta T \times S_Z$. For S_Z see tables and graphs S_Z versus T_j .

$\Delta T = P_{tot} \times R_{th\ j-a} = I_Z \times V_{Z\ dyn} \times R_{th\ j-a}$.

Following $\Delta V_Z = I_Z \times V_{Z\ dyn} \times R_{th\ j-a} \times S_Z$ and the model will be:

$$V_{Z\ stat} = V_{Z\ dyn} + I_Z \times V_{Z\ dyn} \times R_{th\ j-a} \times S_Z$$

Calculating example

BZX84-C24 mounted on a ceramic substrate of 7 x 5 x 0,6 mm; at $I_Z = 7$ mA.

$$\begin{aligned} V_{Z\ stat} &= 24 + \left(\frac{7}{1000} \times 24 \times \frac{430}{1000} \times 20,3 \right) \\ &= 24 + 1,47 = 25,47 \text{ V.} \end{aligned}$$

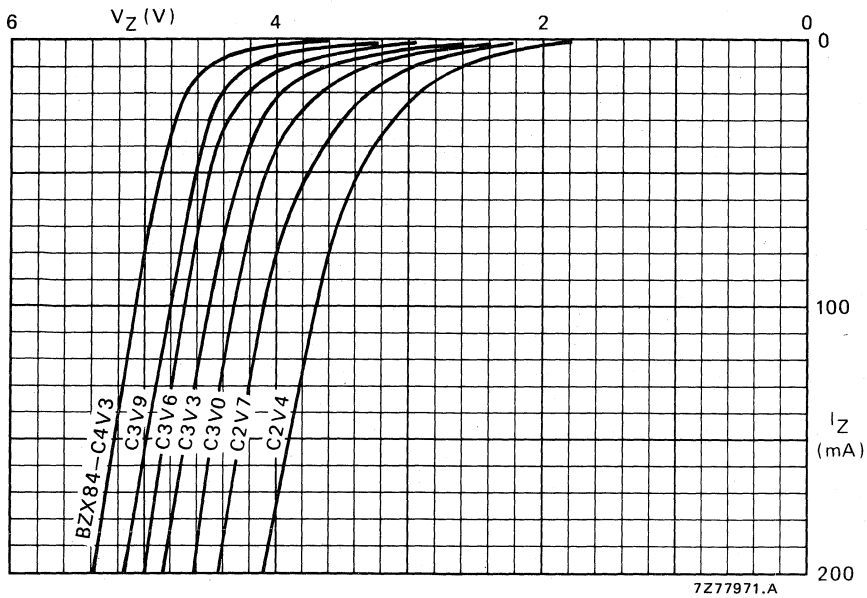


Fig. 3 Dynamic characteristics; typical values; $T_j = 25^\circ\text{C}$.

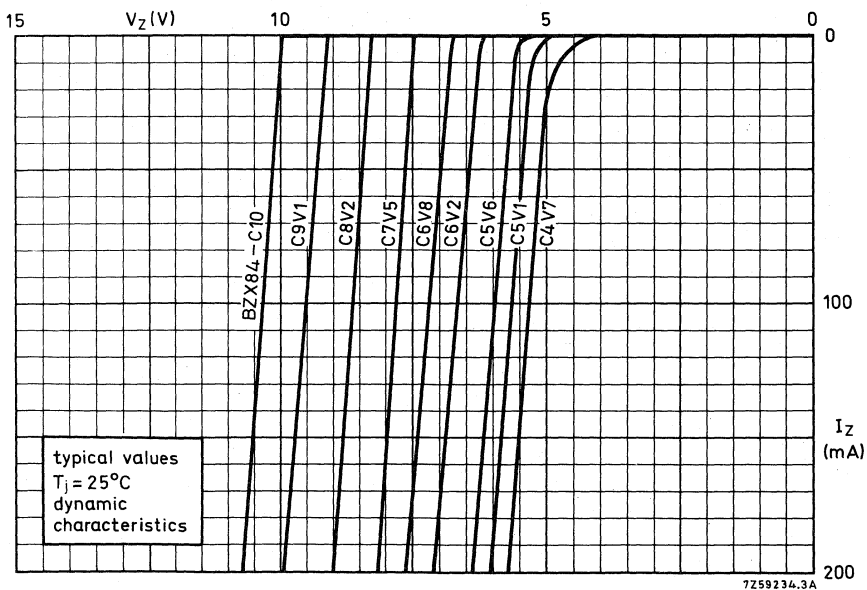


Fig. 4 Dynamic characteristics; typical values; $T_j = 25^\circ\text{C}$.

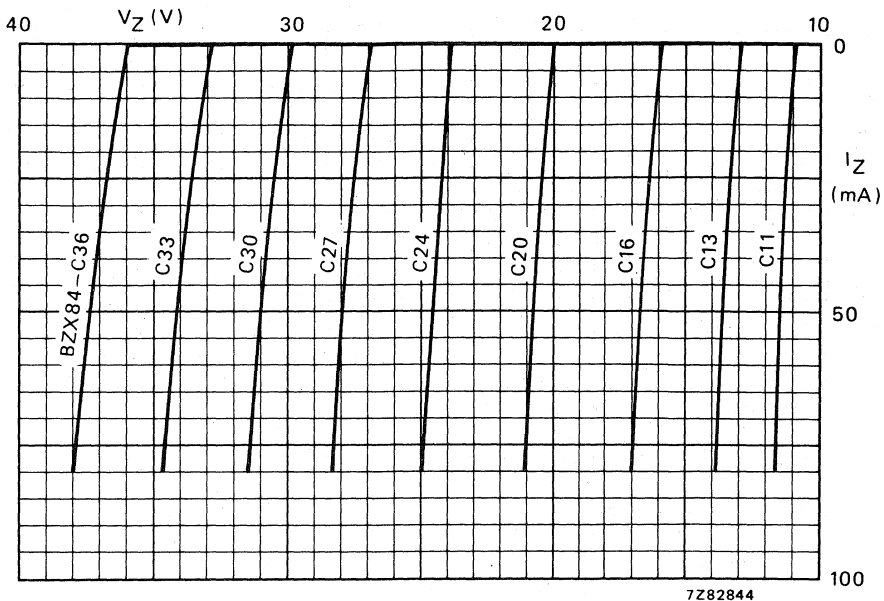


Fig. 5 Dynamic characteristics; typical values; $T_j = 25^\circ\text{C}$.

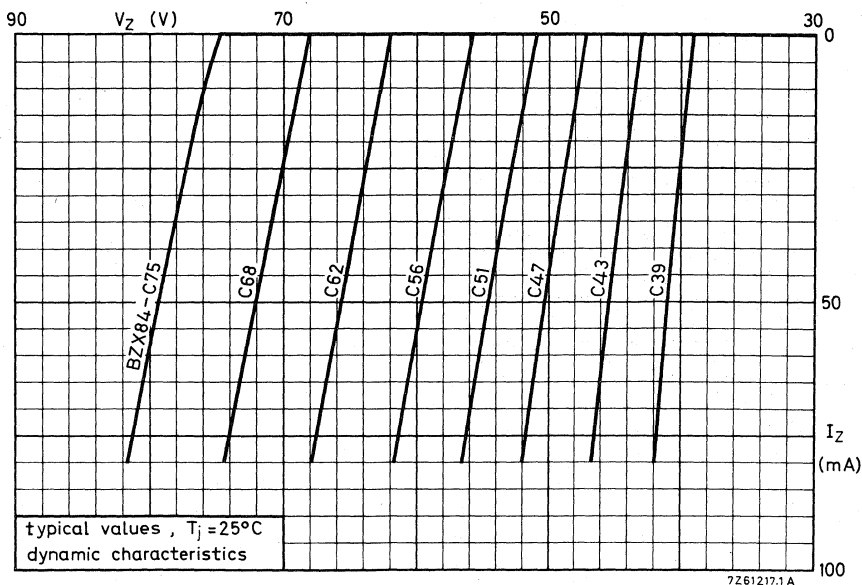


Fig. 6 Dynamic characteristics; typical values; $T_j = 25^\circ\text{C}$.

BZX84 SERIES

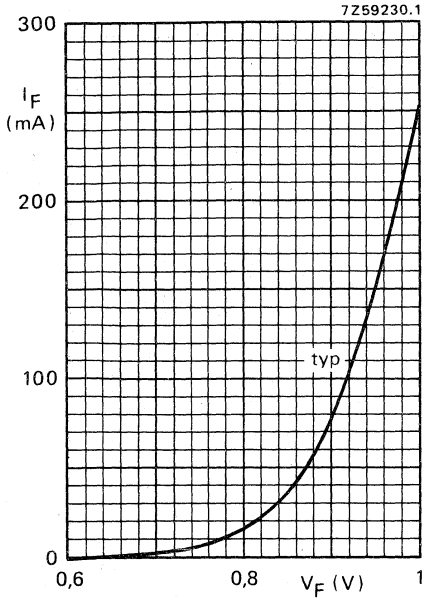


Fig. 7 Typical values at $T_j = 25\text{ }^\circ\text{C}$.

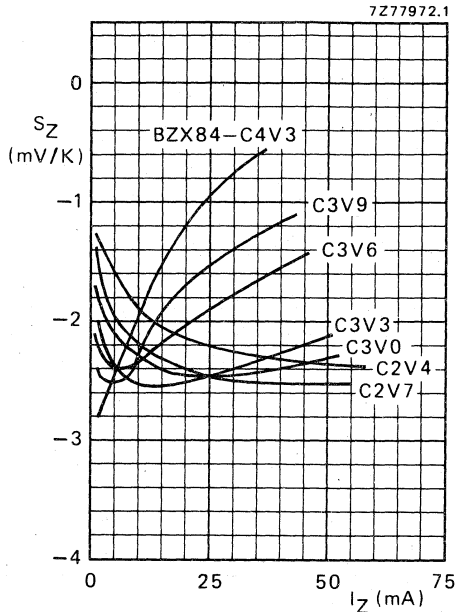


Fig. 8 Typical values; $T_j = 25\text{ to }175\text{ }^\circ\text{C}$.

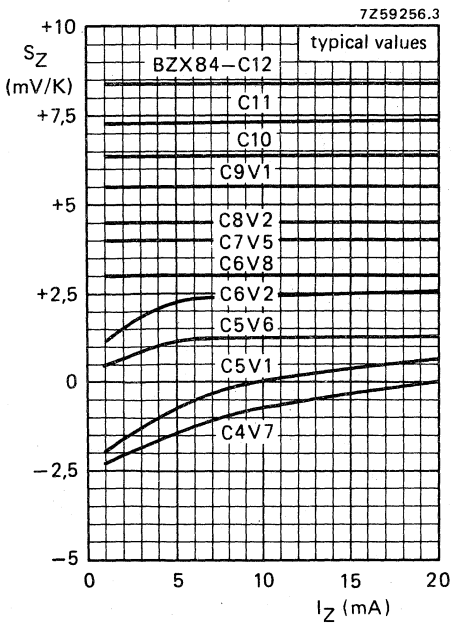


Fig. 9 Typical values; $T_j = 25\text{ to }175\text{ }^\circ\text{C}$.

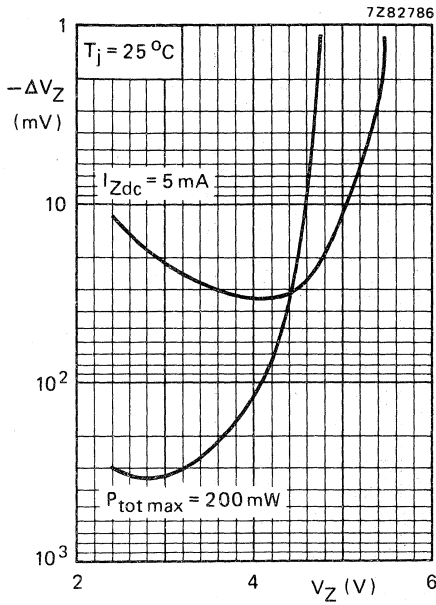


Fig. 10.

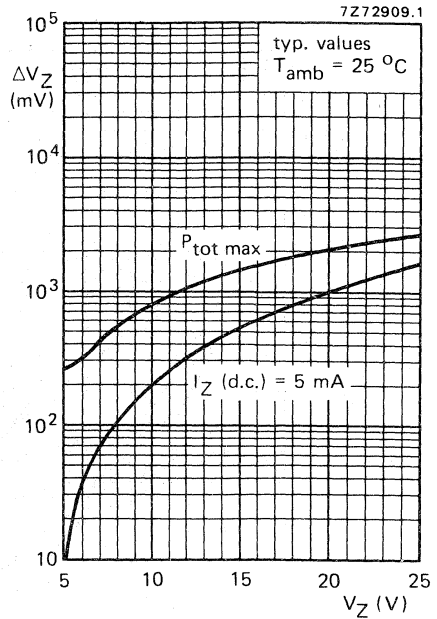


Fig. 11.

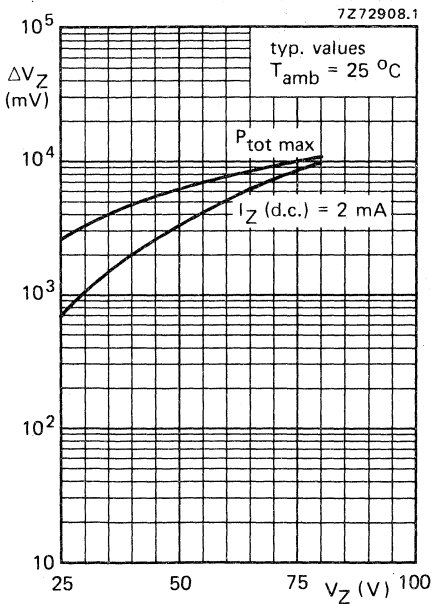


Fig. 12.

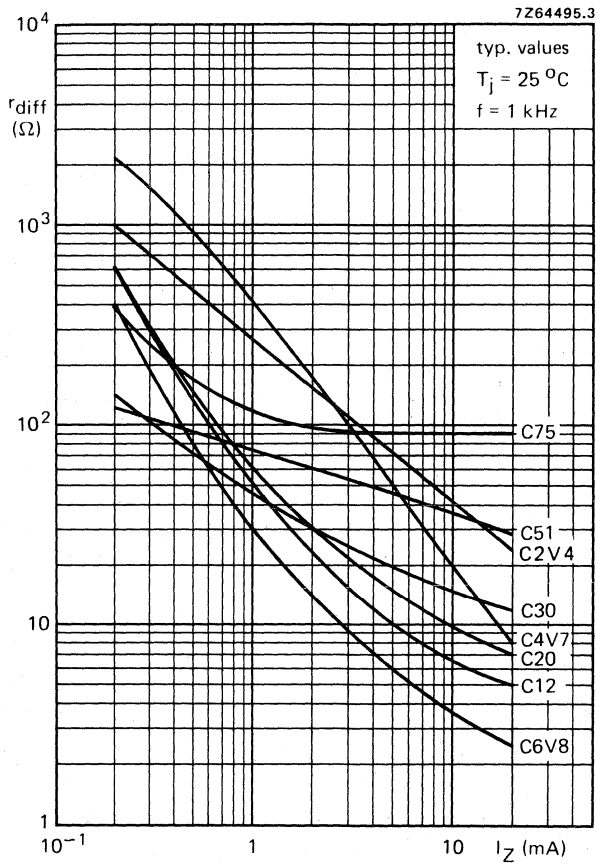


Fig. 13.



MICROMINIATURE SEMICONDUCTORS FOR HYBRID CIRCUITS

SELECTION GUIDE

TYPE NUMBER SURVEY

GENERAL

SOLDERING RECOMMENDATIONS
THERMAL CHARACTERISTICS

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